

Power Supply Circuits

Voltage References, Voltage Regulators, PWM Controllers, Supervisors, Switches, Optoisolators, and Special Functions

Data Book

Power Supply Circuits Data Book

Voltage References, Voltage Regulators, PWM Controllers, Supervisors, Switches, Optoisolators, and Special Functions







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INTRODUCTION

The Texas Instruments 1996 Power Supply Circuits Data Book has been created to showcase our growing line of analog components for power-supply designs. Featured in this data book are most of the components previously found in the 1992 Linear Circuits Data Book, Volume 3, the many new and exciting power supply products introduced since then, and other components useful for power-supply designs.

This new data book is more than a collection of data sheets; it is a tool for locating the best power supply components for a successful design effort. It has been completely restructured to help you quickly find the devices best suited to your application.

A complete **alphanumeric index** at the beginning of the book makes finding specifications for known part numbers simple. You no longer have to search through chapter indexes when you don't know a device function.

The **new device index** includes a description to highlight TI's newest devices. These products include new families of PMOS high-side switches and personal computer memory card international association (PCMCIA) power distribution switches, extremely low dropout (LDO) voltage regulators, advanced pulse-width-molulation (PWM) controllers, and integrated power supply building blocks. Product-preview data sheets are included for devices not completely released when this book was printed. Contact your local TI sales office for complete data sheets and product availability.

Redesigned **product selection guides** give a condensed view of parametric information, organized to help you choose the devices that most closely fit your needs. Key specifications and/or features are presented for easy comparison.

An extensive **glossary** is provided for reference, defining and clarifying terms used by Texas Instruments and the semiconductor industry that might be new or unfamiliar.

The data sheets have been organized into several chapters by product function.

- Voltage references
- Voltage regulators
- PWM controllers and dc-to-dc converters
- Supply voltage supervisors
- PMOS and PCMCIA power distribution switches
- Optoisolators
- Building blocks and special functions

Each chapter has its own table of contents that includes descriptions of the devices, which makes finding a specific device much easier to find.

For convenience, a chapter for **optoisolators** is included in the **1996 Power Supply Circuits Data Book**. This eliminates the need to flip back and forth between two data books for your total power-supply solution.

In section 9 of this data book there is a collection of **application notes**. Texas Instruments is committed to providing designers with detailed application notes for our newest power-supply components. This section represents the beginning of this effort. These applications are fully tested and, in some cases, evaluation boards may be available (contact your local TI sales office). More applications notes will be available from the factory soon.

The last section of this data book contains complete **mechanical specifications** for all packages used with Texas Instruments power supply circuits. This includes the latest innovations in surface-mount power packages. Designers of space-critical systems may want to investigate new products offered in SOT-23 (DBV suffix), power TSSOP (PWP suffix), and the PowerFlex[™] (KTD, KTG, and KTP suffixes) packages.

While this data book offers design and specification data only for power-supply products, complete technical data for any TI semiconductor product is available from your nearest TI Field Sales Office, local authorized TI distributor, or by writing directly to:

Texas Instruments Incorporated LITERATURE RESPONSE CENTER P.O. Box 809066 DALLAS, TEXAS 75380-9066

or telephone the TI Literature Response number: 1-800-477-8924.

We sincerely believe the new 1996 Power Supply Circuits Data Book will be a valuable addition to your collection of technical literature.

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fixed output voltage series pass regulators

DEVICE	V _O (V) NOM	I _O (mA) MAX	TOL (%)	lq (mA) TYP	V _{DO} (V) TYP-MAX	V _I max (V)	LDO	SHUT DOWN	svst	• тд	DESCRIPTION
POSITIVE OU	POSITIVE OUTPUT VOLTAGE										
TPS7233		250	2	155 μΑ	0.14 0.18	10	X	Х		-40°C to 125°C	Very low dropout PMOS
TPS7333	3.3	250	2	340 μΑ	0.044 - 0.06	10	Х	Х	X	-40°C to 125°C	Lowest dropout PMOS with SVS
TLV2217-33	3.3	500	1	19	0.4 - 0.5	12	Х			0°C to 125°C	Low dropout pnp
TPS7133		500	2	285 μΑ	0.047 - 0.060	10	X	Х		-40°C to 125°C	Lowest droput PMOS
TPS7248		250	2	155 μΑ	0.09 - 0.1	10	Х	Х		-40°C to 125°C	Very low dropout PMOS
TPS7348	4.85	250	2	340 μΑ	0.028 - 0.037	10	Х	Х	Х	-40°C to 125°C	Lowest dropout PMOS with SVS
TL75LP48	4.65	300	2	4	0.12 - 0.2	23	X	Х		-40°C to 125°C	Low dropout pnp
TPS7148		500	2	285 μΑ	0.03 - 0.037	10	Х	Х		-40°C to 125°C	Lowest dropout PMOS
μ A 78L05A		100	5	380	2.5 – 3	20				-40°C to 125°C	General purpose, low current
μ A 78L05		100	10	3.8	2-3	20				-40°C to 125°C	General purpose, low current
TL750L05			4	- 10	0.2 - 0.6	26	Х			-40°C to 150°C	Low dropout pnp, low current
TL751L05	* * .	150	4	10	0.2 - 0.6	26	Х	Х		-40°C to 150°C	Low dropout pnp, low current, shutdown
LM2930-5			10	18	0.32 - 0.6	26	Х			-40°C to 150°C	3-terminal low-dropout pnp
TPS7250		250	2	155 μΑ	0.76 - 0.85	10	Х	Х		-40°C to 125°C	Very low dropout PMOS
TPS7350	5	250	. 2	340 μΑ	0.27 - 0.035	10	Х	Х	Х	-40°C to 125°C	Lowest dropout PMOS with SVS
TL75LP05	5	300	2	4	0.12 – 0.2	23	Х	Х		-40°C to 125°C	Low dropout pnp
TPS7150		500	2	285 μΑ	0.27 - 0.033	10	Х	Х		-40°C to 125°C	Lowest dropout PMOS
μ A 78M05		300	5	4.5	2-3	25				0°C to 125°C	General purpose, medium current
TL750M05		750	1	60	0.5 – 0.6	26	Х			-40°C to 125°C	Low dropout pnp, high current
TL751M05		750	1	60	0.5 – 0.6	26	Х	Х		-40°C to 125°C	Low dropout pnp, high current, shutdown
TL780-05		1500	1	5	2-3	25				0°C to 125°C	High current, upgrade for μA7805
μΑ7805		1300	10	4.2	2-3	25				-40°C to 125°C	General purpose, high current
μΑ78L06A		100	5	3.9	2.5 – 3	20				0°C to 125°C	General purpose, low current
μ A78L 06	6	100	10	3.9	2.5 – 3	20				0°C to 125°C	General purpose, low current
μΑ78Μ06	l o	500	5	4.5	2-3	25				0°C to 125°C	General purpose, medium current
μΑ7806		1500	10	4.3	2-3	25				0°C to 125°C	General purpose, high current

SELECTION GUIDE LINEAR VOLTAGE REGULATORS

[†] Supply-voltage supervisor

fixed output voltage series pass regulators (continued)

DEVICE	V _O (V) NOM	IO (mA) MAX	TOL (%)	lq (mA) TYP	V _{DO} (V) TYP-MAX	V _I max (V)	LDO	SHUT	svst	TA	DESCRIPTION
POSITIVE OUTPUT VOLTAGE (CONTINUED)											
μΑ78L08A		100	5	4	2.5 – 3	23				0°C to 125°C	General purpose, low current
μA78L08	1. '	100	10	4	2.5 – 3	23				0°C to 125°C	General purpose, low current
TL750L08	1		4	10	0.2 – 0.7	26	X			-40°C to 150°C	Low dropout pnp, low current
TL751L08	1 '	150	4	10	0.2 – 0.7	26	X	Х	14.5	-40°C to 150°C	Low dropout pnp, low current, shutdown
LM2930-8		<u> </u>	10	18	0.32 - 0.6	26	X			-40°C to 150°C	3-terminal low-dropout pnp
TL75LP08	1 ° '	300	2	4	0.12 - 0.2	23	Х	Х		-40°C to 125°C	Low dropout pnp
μΑ78Μ08	1 '	500	5	4.6	2.5 – 3	25				0°C to 125°C	General purpose, medium current
TL750M08	1 '	750	1	60	0.5 - 0.7	26	,X			-40°C to 125°C	Low dropout pnp, high current
TL751M08	1 '	750	1	60	0.5 – 0.7	26	Х	Х		-40°C to 125°C	Low dropout pnp, high current, shutdow
μΑ7808	1 '	1500	10	4.3	2.5 – 3	25				0°C to 125°C	General purpose, high current
μΑ7885	8.5	1500	10	4.3	2-3	25				0°C to 125°C	General purpose, high current
μΑ78L08A	1	100	5	4.1	2.5 – 3	24				0°C to 125°C	General purpose, low current
μ A 78L09	9	100	10	4.1	2.5 – 3	24		1.		0°C to 125°C	General purpose, low current
μΑ78M09	1	500	5	4.6	2.5 – 3	26				0°C to 125°C	General purpose, medium current
μΑ78L10A	1	100	5	4.2	2.5 – 3	25				0°C to 125°C	General purpose, low current
μΑ78L10	1 '	100	10	4.2	2.5 – 3	25				0°C to 125°C	General purpose, low current
TL750L10	1	150	4	10	0.2 – 0.8	26	Х			-40°C to 150°C	Low dropout pnp, low current
TL751L10	1 '	150	4	10	0.2 - 0.8	26	Х	Х		-40°C to 150°C	Low dropout pnp, low current, shutdow
TL75LP10	10	300	2	4	0.12 – 0.2	23	Х	Х		-40°C to 125°C	Low dropout pnp
μΑ78M10	1 7	500	- 5	4.6	2.5 – 3	28				0°C to 125°C	General purpose, medium current
TL750M10	1	750	1	60	0.5 – 0.8	26	Х			-40°C to 125°C	Low dropout pnp, high current
TL751M10	1	750	1	60	0.5 – 0.8	26	Х	X		-40°C to 125°C	Low dropout pnp, high current, shutdow
μΑ810	1 '	1500	10	4.3	2.5 – 3	28				0°C to 125°C	General purpose, high current

[†] Supply-voltage supervisor

fixed output voltage series pass regulators (continued)

DEVICE	V _O (V) NOM	I _O (mA) MAX	TOL (%)	lq (mA) TYP	V _{DO} (V) TYP-MAX	V _I max (V)	LDO	SHUT	svst	TA	DESCRIPTION
POSITIVE OUTPUT VOLTAGE (CONTINUED)											
μΑ78L12A		100	5	4.3	2.5 – 3	27				-40°C to 125°C	General purpose, low current
μ A78L12		100	10	4.3	2.5 – 3	27				-40°C to 125°C	General purpose, low current
TL750L12		150	4	10	0.2 – 0.9	26	Х			-40°C to 150°C	Low dropout pnp, low current
TL751L12		150	4	10	0.2 – 0.9	26	Х	Х		-40°C to 150°C	Low dropout pnp, low current, shutdown
TL75LP12	12	300	2	4	0.12 - 0.2	23	Х	Х		-40°C to 125°C	Low dropout pnp
μA78M12	12	500	5	4.8	2.5 – 3	30				0°C to 125°C	General purpose, medium current
TL750M12		750	1	60	0.9 – 0.9	26	Х			-40°C to 125°C	Low dropout pnp, high current
TL751M12		750	1	60	0.9 – 0.9	- 26	Х			-40°C to 125°C	Low dropout pnp, high current, shutdown
TL780-12		1500	1	5.5	2.5 – 3	30				0°C to 125°C	High current, upgrade for µA7812
μΑ7812		1500	10	4.3	2.5 – 3	30				-40°C to 125°C	General purpose, high current
μΑ78L15A		100	5	4.6	2.5 – 3	30				0°C to 125°C	General purpose, low current
μA78L15		100	10	4.6	2.5 – 3	30				0°C to 125°C	General purpose, low current
μA78M15	15	500	5	4.8	2.5 – 3	30				0°C to 125°C	General purpose, medium current
TL780-15			1	5.5	2.5 – 3	30				0°C to 125°C	High current, upgrade for μA7815
μΑ7815		1500	10	4.4	2.5 – 3	30				0°C to 125°C	General purpose, high current
μΑ7818	18		10	4.5	3 – 3	33		,		0°C to 125°C	General purpose, high current
μ A 78M20	20	500	5	4.9	3-3	35				0°C to 125°C	General purpose, medium current
μA78M24	24	300	5	5	3-3	38				0°C to 125°C	General purpose, medium current
μΑ7824	24	1500	10	4.6	3-3	38				0°C to 125°C	General purpose, high current

[†] Supply-voltage supervisor

fixed output voltage series pass regulators (continued)

DEVICE	V _O (V) NOM	IO (mA) MAX	TOL (%)	lq (mA) TYP	V _{DO} (V) TYP-MAX	V _I max (V)	LDO	SHUT	svst	TA	DESCRIPTION
NEGATIVE OUTPUT VOLTAGE											
MC79L05A		100	5	5	2-3	-20				0°C to 125°C	Negative low current
MC79L05	-5	100	10	10	2 – 3	-20				0°C to 125°C	Negative low current
μΑ79Μ05		500	- 5	1	2-3	-25				0°C to 125°C	Negative general purpose, medium current
μΑ79Μ06	-6	500	5	1	2-3	-25				0°C to 125°C	Negative general purpose, medium current
μΑ79Μ08	-8	500	5	1	2.5 – 3	-25		1.		0°C to 125°C	Negative general purpose, medium current
MC79L12A		100	5	5	2.5 – 3	-27				0°C to 125°C	Negative low current
MC79L12	-12	100	10	10	2.5 – 3	-27				0°C to 125°C	Negative low current
μA79M12		500	5	1.5	2.5 – 3	-30				0°C to 125°C	Negative general purpose, medium current
MC79L15A		100	5	5	2.5 – 3	-30				0°C to 125°C	Negative low current
MC79L15	-15	100	10	10	2.5 – 3	-30				0°C to 125°C	Negative low current
μ A 79M15		500	5	1.5	2.5 – 3	-30				0°C to 125°C	Negative general purpose, medium current
μΑ79M20	-20	500	5	1.5	3-3	-35				0°C to 125°C	Negative general purpose, medium current
μ A 79M24	-24	500	5	1.5	3-3	-38				0°C to 125°C	Negative general purpose, medium current

[†] Supply-voltage supervisor

adjustable series pass regulators

DEVICE	V _O (V) MIN-MAX	I _O (mA) MAX	TOL (%)	lq (mA) TYP	V _{DO} (V) TYP-MAX	V _I max (V)	LDO	SHUT	svst	TA	DESCRIPTION
TL317	1.2 – 32	100	4	1.5	2.5 – 3	35				0°C to 125°C	General purpose low current adjustable
TPS7201	1.2 - 9.75	250	3	155 μΑ	0.16-0.27	10	Х	Х		-40°C to 125°C	Very low dropout PMOS adjustable
TPS7301	1.2 – 9.75	250	3	340 μΑ	0.052-0.085	10	Х	Х	Х	-40°C to 125°C	Lowest dropout PMOS with SVS
TPS7101	1.2 – 9.75	500	3	285 μΑ	0.052-0.085	10	X »	X		-40°C to 125°C	Lowest dropout PMOS adjustable
TL783	1.2 – 125	700	6	15	10 – 15	125				0°C to 125°C	High voltage high current adjustable

[†] Supply-voltage supervisor

adjustable shunt regulators

1							·
DEVICE	V _{ref} (V)	I _Z (mA) MIN-MAX	V _O (V) MIN-MAX	TOL (%)	V _I max · (V)	TEMP CO (ppm/°C) TYP	DESCRIPTION
TLV431	1.24	0.1 – 15	V _{ref} – 6	1	6	46	Low voltage adjustable shunt reference
TL1431	2.5	1 – 100	V _{ref} - 36	0.40	36	30	Precision adjustable shunt reference
TL431	2.5	1 – 100	V _{ref} - 36	2	36	30	Adjustable shunt reference
TL431A	2.5	1 – 100	V _{ref} - 36	1	36	30	Precision adjustable shunt reference
TL430	2.75	2 – 100	V _{ref} - 30	9	30	120	Adjustable shunt reference

SELECTION GUIDE LINEAR VOLTAGE REGULATORS

voltage references

DEVICE	V _{ref} (V)	TOL (%)	Izmin (μ A)	Izmax (mA)	DESCRIPTION
LT1004-1.2		0.30	10	20	Micropower precision reference
LM385B-1.2	1.2	1	10	20	Micropower reference
LM385-1.2		2	10	20	Micropower reference (LM185/285 temperature grades also available)
LT1004-2.5		0.80	20	20	Micropower precision reference
LM336B-2.5		01	400	10	Precision voltage reference (LM236 temperature grade also available)
LM385B-2.5	2.5	1.5	20	20	Micropower precision reference
LT1009	2.5	2	400	20	Voltage reference
LM385-2.5		3	20	20	Micropower reference (LM185/285 temperature grades also available)
LM336-2.5		4	400	10	Voltage reference (LM236 temperature grade also available)

supply voltage supervisors

DEVICE	V _t (V)	TOL (%)	ICC (mA) MAX	V _I min (V)	ovs‡	PROGRAMMABLE TIME DELAY	COMPLEMENTARY OUTPUTS	DESCRIPTION
TL7702A	pgm†	2	3	3.60		х	X	Single SVS with programmable undervoltage threshold and reset time delay
TL7702B	-pgm†	2	3	1		x	×	Single SVS with programmable undervoltage threshold and reset time delay
TLC7705	4.55	1.5	25 μΑ	- 1		х	X	Single micropower SVS (5 V) with programmable time delay and push-pull outputs
TL7705A	4.55	2	3	3.60		Х	х	Single SVS for 5 V systems with programmable time delay
TL7705B	4.55	2	3	1		X	Х	Single SVS for 5 V systems with programmable time delay
TL7757	4.55	3	40 μΑ	1				3-terminal SVS for 5 V systems
TL7759	4.55	3	40 μΑ	- 1			Х	4-terminal SVS for 5 V systems
TL7770-5	4.55	1	5	1	х	х	x	Dual SVS, 5 V and programmable with programmable time delay
TL7709A	7.60	2	3	3.60		Х	Х	Single SVS for 9 V systems with programmable time delay
TL7712A	10.80	2	3	3.60		Х	Х	Single SVS for 12 V systems with programmable time delay
TL7770-12	10.90	1	5	1	x	x	x	Dual SVS, 12 V and programmable with programmable time delay
TL7715A	13.50	2	3	3.60		X	Х	Single SVS for 15 V systems with programmable time delay
TL7770-15	13.64	1	5	1	х	х	Х	Dual SVS, 15 V and programmable with programmable time delay

[†] Programmable using external resistor divider. ‡ Overvoltage sense (programmable)

switching power supply controllers

									OUTI	PUTS									
								МС	DE	TY	PE								
CONTROL TOPOLOGY	V _{IN} RANGE (VDC)	OUTPUT CURRENT (mA)	MAX FREQUENCY (KH2)	REFERENCE VOLTAGE (V)	VREF TOLERANCE (%)	SHUTDOWN	OPERATING/STANDBY CURRENT (mA)	DEAD TIME CONTROL	MAX DUTY CYCLE (%)	SINGLED ENDED	FIXED PUSH-PULL	SINGLE SWITCH OUTPUTS	TOTEM POLE	PROGRAMMABLE OUTPUTS	UNDERVOLTAGE LOCKOUT	ON-BOARD AMPLIFIERS	CURRENT-SENSE AMPLIFIERS	PULSE-BY-PULSE Isense	DEVICES
	7-40	200	300	5	5		6/NA	Υ	90	Υ	Υ	Υ		Υ		2	_		TL494, 494M
	8-40	100	1000	5	4	Υ	?/8	Ν	90	_	Υ	Υ				1	- 1		SG2524
	740	200	300	5	1		12.4/9	Υ	90	Υ	Υ	Υ	_	Υ	Υ	2	_		TL594
Voltage-Mode PWM	7-40	±250	300	5	1		15/NA	Υ	90	Υ	Υ	_	Υ	Υ	Υ	2	_		TL598, 598M
Voltage-Wode F VVIVI	3.6-50	20	500	2.5	4		1.7/1.3	Y	100	Υ	1	Υ	-		Υ	2	_		TL1451A
	3.6-20	±40	2000	1.25	2.5		3.5/3.1	Y	100	Υ	-	_	Υ		Υ	2	_		TL1454
	3.6-40	20	400	1	5		1.1/1	Υ	100	Υ	_	Υ	_		Υ	1	_		TL5001
	9.5-40	150		7.15	5		2.3/NA	N		Υ	_	Υ	<u> </u>			1	1	Υ	μΑ723
	5-12	225	170	1.23	4	Υ	1.2/0.003	N	_	Υ	-	Υ				1 .	1	Υ	TPS6734
Current-Mode PWM	30†	±200	500	5	1		11/NA	Ν	97	Υ		_	Υ		Υ	1	1	Υ	UC284X
	30†	±200	500	5	2		11/NA	N.	97	Υ		<u> </u>	Υ		Υ	1	1	Υ	UC384X
Fixed	1.1-20	1200	40	‡	10	3	_	N	_	Υ	_	Υ	_			1	_		TL496C
On-Time	1.1-35	500	40	1.26	5		0.8/NA	N	_	Υ		Υ	_			1			TL499A
V-Mode	4.5-12	500	50	1.2	5	Υ	11/6	Ν	_	Υ	_	Υ	_			1	1		TL497A

SELECTION GUIDE
SWITCHING POWER SUPPLY CONTROLLERS

[†] Low-level voltage varies with UVLO value. ‡ Fixed 9-V output.

optoisolators

DEVICE	VISO (PEAK) (kV)	LED VF [†] (MAX) (V)	VCE (SAT) (MAX) (V)	RISE TIME (TYP) (μs)	FALL TIME (TYP) (μs)	BASE CONNECTION	CTR (MIN) (%)	PACKAGE
4N25	2.5	1.5	0.5	2‡	2‡	Yes	20	6 Pin DIP
4N26	1.5	1.5	0.5	2‡	2‡	Yes	20	6 Pin DIP
4N27	1.5	1.5	0.5	2‡	2‡	Yes	10	6 Pin DIP
4N28	0.5	1.5	0.5	2‡	2‡	Yes	10	6 Pin DIP
4N35	3.5	1.5	0.3	10	10	Yes	100	6 Pin DIP
4N36	2.5	1.5	0.3	10	10	Yes	100	6 Pin DIP
4N37	1.5	1.5	0.3	10	10	Yes	100	6 Pin DIP
6N135	3	1.7	0.4	1	0.7	Yes	7	8 Pin DIP
6N136	3	1.7	0.4	0.6	0.6	Yes	19	8 Pin DIP
HCPL4502	3	1.7	0.4	0.6	0.6	No	19	8 Pin DIP
MCT2	1.5	1.5	0.4	5‡	5‡	Yes	20	6 Pin DIP
MCT2E	3.5	1.5	0.4	5‡	5‡	Yes	20	6 Pin DIP
TIL191	3.5	1.4	0.4	6	6	No	20	4 Pin DIP
TIL191A	3.5	1.4	0.4	6	6	No	50	4 Pin DIP
TIL191B	3.5	1.4	0.4	6	6	No	100	4 Pin DIP
TIL192	3.5	1.4	0.4	6	6	No	20	8 Pin DIP
TIL192A	3.5	1.4	0.4	6	6	No	50	8 Pin DIP
TIL192B	3.5	1.4	0.4	6	6	No	100	8 Pin DIP
TIL193	3.5	1.4	0.4	6	6	No	20	16 Pin DIP
TIL193A	3.5	1.4	0.4	6	6	No	50	16 Pin DIP
TIL193B	3.5	1.4	0.4	6	6	No	100	16 Pin DIP

[†] At 10 mA ‡ Phototransistor operation

SELECTION GUIDE OPTOISOLATORS

optoisolators with triac output

DEVICE	VISO (PEAK) (kV)	LED VF (MAX)	IFT (MAX) (mA)	dv/dt (TYP) (V/μs)	VTM (MAX) (V)	VDRM (V)	PACKAGE
MOC3009	7.5	1.5	30	12	3	250	6 Pin DIP
MOC3010	7.5	1.5	15	12	-3	250	6 Pin DIP
MOC3011	7.5	1.5	10	12	3	250	6 Pin DIP
MOC3012	7.5	1.5	5	12	3	250	6 Pin DIP
MOC3020	7.5	1.5	30	100	3	400	6 Pin DIP
MOC3021	7.5	1.5	15	100	3	400	6 Pin DIP
MOC3022	7.5	1.5	10	100	3	400	6 Pin DIP
MOC3023	7.5	1.5	5	100	3	400	6 Pin DIP
TIL3009	3.5	1.5	30	12	3	250	6 Pin DIP
TIL3010	3.5	1.5	15	12	3	250	6 Pin DIP
TIL3011	3.5	1.5	10	12	3	250	6 Pin DIP
TIL3012	3.5	1.5	5	12	3	250	6 Pin DIP
TIL3020	3.5	1.5	. 30	100	3	400	6 Pin DIP
TIL3021	3.5	1.5	. 15	100	- 3	400	6 Pin DIP
TIL3022	3.5	1.5	10	100	3	400	6 Pin DIP
TIL3023	3.5	1.5	5	100	3	400	6 Pin DIP

SERIES REGULATORS

Bias Current

The operating current of the device; the difference between input and output current. This current is usually the current that flows in the ground or reference terminal of the regulator and may be load dependent. Also referred to as quiescent current.

Current-Limit Sense Voltage

A voltage proportional to the load current that controls the current-limit circuitry.

Dropout Voltage

The input-to-output differential voltage at which the circuit ceases to regulate against further reductions in input voltage.

Feedback Sense Voltage

A voltage proportional to the output voltage that controls the regulator.

Input Regulation (Line Regulation)

The change in output voltage due to a change in input voltage, often expressed as a percentage of the output voltage.

Low Dropout Regulator (LDO)

A voltage regulator that can operate with an input-to-output differential voltage that is lower than the typical series regulator (approximately 2 V). Operation at lower differential voltages allows for the use of lower voltage inputs and better efficiency.

Output Noise Voltage

The RMS output voltage with constant output current and constant input voltage, often expressed as a percentage of the output voltage. Output noise voltage is always specified over a given range of frequencies.

Output Impedance

The ratio of the change in output voltage to the change in output current during normal operation. A lower value indicates better regulation of the output voltage. Output impedance is a function of frequency; at f=0, this becomes output resistance.

Output Regulation (Load Regulation)

The change in output voltage due to a change in load current, often expressed as a percentage of the output voltage.

Output Voltage Change With Temperature

The change in the output voltage due to a change in temperature, often expressed in parts per million per °C.

Output Voltage Long-Time Drift

The change in output voltage over a given long period of time, such as 100 hours or one year.



GLOSSARY VOLTAGE REGULATOR TERMS AND DEFINITIONS

Peak Output Current

The maximum output current that can be obtained from the regulator due to the limits of the circuitry within the regulator.

Reference Voltage

The voltage (usually fixed) that is compared with the feedback voltage to control the regulator. The output tolerance of the regulator is determined primarily by the tolerance of this voltage.

Ripple Rejection

The ratio of the peak-to-peak input ripple voltage to the peak-to-peak output ripple voltage, usually expressed in dB. This is the reciprocal of ripple sensitivity. Ripple rejection is a function of frequency and typically decreases as frequency increases.

Ripple Sensitivity

The ratio of the peak-to-peak output ripple voltage to the peak-to-peak input ripple voltage usually expressed in dB. This is the reciprocal of ripple rejection.

Series Regulator

A circuit that regulates the output voltage by controlling the impedance of an active device, operating in a linear mode, in series with the output.

Short-Circuit Output Current

The output current of the regulator with the output shorted to ground.

Standby Current

The input current drawn by a regulator, with a shutdown or enable terminal, when the output voltage is disabled and with no reference voltage load.

Temperature Coefficient of Output Voltage (∞V_{IO})

The average value of the ratio of the change in output voltage to the change in temperature over the total temperature range, often expressed as parts per million per °C.



SHUNT REGULATORS

Anode

The terminal of the regulator from which load current flows when the regulator is biased for regulation.

Cathode

The terminal of the regulator that sinks external load current when the regulator is biased for regulation.

Dynamic Impedance (Z_{KA})

The ratio of a change in voltage across the regulator to the corresponding change in current through the regulator when biased for regulation. This is a function of frequency; at f=0, this becomes dynamic resistance.

Noise Voltage (V_n)

The RMS output voltage with constant output current and constant input voltage, often expressed as a percentage of the output voltage. Output noise voltage is always specified over a given range of frequencies.

Reference Input Voltage (V_{ref}) (of an adjustable shunt regulator)

The voltage at the reference input terminal with respect to the anode terminal.

Regulator Current (I_Z)

The allowable range of dc current through the regulator when it is biased for regulation.

Regulator Voltage (V₇)

The dc voltage from cathode to anode of the regulator.

Shunt Regulator

A device that has a voltage-current characteristic similar to that of a voltage-regulator diode. The device controls the output voltage by sinking excess current, flowing through a series resistance, away from the load. It is normally biased to operate in a region of low differential resistance (corresponding to the breakdown region of a regulator diode) that varies so as to control the voltage across the device to a constant value.

Temperature Coefficient of Reference Voltage (∝V_{ref})

The ratio of the average change in reference voltage to the change in temperature over the total temperature range. This value can be stated in parts per million per °C (ppm/°C) or as a percentage of the reference voltage.

SWITCHING REGULATORS

Bode Plot

A design aid used to visualize a transfer function consisting of a logarithmic horizontal scale for frequency and a linear vertical scale for gain in dB or phase in degrees.

Charge Pump

A converter topology that uses the transfer of charge through one or more capacitors to generate an output voltage that is higher than the input voltage.

CSA

Canadian Standards Association, an independent organization that establishes and tests safety standards for electronic systems and components in Canada.

Compensation Network

The components connected around the error amplifier of a switching regulator which tailor the frequency response of the control loop. The compensation network reduces phase shift around the control loop so as to achieve sufficient phase margin for stability.

Conditionally Stable

Description of a control loop that has a phase shift of 360° at some frequency less than the unity-gain frequency, but has a phase shift of less than 360° at unity gain. This loop oscillates when the gain is reduced to unity at the frequency where the phase shift is 360°. A reduction in gain is possible at startup, under abnormal load conditions, or as the components age.

Continuous Mode

A conduction mode in which current in the inductor or transformer of the converter flows during the entire cycle.

Converter (dc-dc)

A network of reactive components and switching elements that transforms power from one dc voltage level to another. The circuit may or may not provide isolation from the input to the output.

Crossover Frequency

The frequency at which the loop response of the regulator drops to unity gain (0 dB). Also known as the unity-gain bandwidth of the converter or unity-gain frequency. This frequency determines the response time for transient recovery.

Cross Regulation

The change in output voltage of one output of a multiple output power supply caused by a load change on another output; usually expressed in percent.

Crow Bar Circuit

A protection circuit the prevents excessive output voltage from reaching the load by shorting the output to ground. Typically, a crow bar circuit employs an semiconductor-controller rectifier (SCR) to short the output to ground and a series fuse to break the circuit before the regulator is damaged.



Current-Mode PWM Control

A PWM control technique consisting of two feedback loops; an inner loop that senses the inductor current and an outer loop that senses the output voltage and is used as a reference for the inner loop control. Current-mode control improves the stability of the control loop of many converter topologies, and provides various other benefits such as pulse-by-pulse current limiting.

Dead Time

A fixed, load-independent off-time between output pulses of a switching regulator, sometimes referred to as blanking time. Dead time control is employed to limit the maximum duty cycle of a converter to prevent damage caused by such occurrences as crossover conduction.

Discontinuous Mode

A conduction mode in which current in the inductor or transformer of the converter drops to zero and remains at zero for a finite period of time during each cycle.

Duty Cycle

The ratio of on-time of the switching element to the operating period of this element.

Dynamic Response (Transient Response)

Output voltage change that occurs in response to a step change in load current or line voltage.

Efficiency

Ratio of the total output power divided by the total input power of a power supply, usually expressed as a percentage and measured at full-rated load current and at nominal input voltage.

ESL

Equivalent Series Inductance, the parasitic inductance in series with the ideal capacitance within a real capacitor.

ESR

Equivalent Series Resistance, the parasitic resistance in series with the ideal capacitance within a real capacitor, originating from the lead resistance, terminal losses, etc.

Faraday Shield

An electrostatic shield within transformers that reduces both coupling capacitance between windings and output common-mode noise. This shield is placed between the primary and secondary windings.

(Input Voltage) Feedforward Compensation

A technique to increase the loop response to supply voltage changes by controlling the ramp level as a function of the input voltage.



GLOSSARY VOLTAGE REGULATOR TERMS AND DEFINITIONS

Gain Margin

The amount that loop gain is reduced below zero dB at the frequency where there is exactly 360° of phase shift around the control loop. This is the amount of gain that would need to be added to the loop in order for it to oscillate.

Holdup Time

The period of time that a power supply output voltage remains within its specified operating conditions after loss of input power.

Input Transient (Line Transient)

A voltage spike or step change in the input of a power supply.

Inverter

A type of switching converter that accepts dc input power and changes it to ac power.

Line Transient

See input transient.

Load Regulation

The dc change in output voltage caused by a change in output load, often express as a percentage of the nominal output voltage.

Loop Response

The frequency response of the regulator, often expressed as a Bode plot. The total loop response is the small-signal, open-loop transfer function around the control loop and is determined by the total gain and the phase shift of the output filter, output sensing network, error amplifier (with its compensation network), and the power modulator stage.

Off-Line Power Supply

A power supply that operates directly from the ac mains. The input voltage is rectified and filtered to a high dc voltage before any isolation transformer.

Output Regulation

See load regulation.

Overcurrent Protection

A protection circuit that prevents damage to the regulator by sensing an overcurrent condition and limiting excessive current flow or shutting down the regulator.

Overvoltage

A condition in which the output voltage magnitude is greater than the maximum specified limit. For both positive and negative regulators, the voltage is farther away from zero.



Output Impedance

The ratio of the change in output voltage to the change in output current during normal operation. A lower value indicates better regulation of the output voltage. Output impedance is a function of frequency; at f=0, this becomes output resistance.

Parallel Operation

A multiple output switching configuration in which two or more output stages supply power to the same load simultaneously. This configuration is used when one supply cannot meet the power demands of the load or for redundancy in case of failure of one supply.

Phase Margin

The difference between the phase shift around the control loop at the unity gain frequency and 360°. When the phase shift is less than 360°, the phase margin is positive. Generally, at least 45° of phase margin is needed to ensure stability over manufacturing variations and to reduce overshoot.

Pole

A point where the open-loop transfer function of the control loop asymptotically approaches infinity as a result of a term in the denominator approaching zero. A frequency breakpoint of the loop response that causes 20 dB per decade reduction in gain and a shift of 90° in phase margin.

Post Regulator

A circuit on the output of the power supply that improves the output regulation and/or reduces ripple or noise.

Power Factor Correction (PFC)

A design technique the changes the input current waveform of a power supply from a pulsed waveform (the result of charging the input capacitor) to a sinusoidal waveform that reduces EMI injected into the source. Power factor is proportional to the percentage of time during the cycle that current flows in the input. A power factor of 1 indicates a sine wave input, while a value less than 1 indicates the presence of harmonic current in the input circuit.

Power Good Signal

A signal generated within a power supply to indicate that the output of the supply is operating within its specified tolerances.

Power Modulator Stage

The section of the regulator that processes the power from one dc level to another dc level. This includes the comparator that converts the error signal to pulse width information, the power switch, and the transformer/inductor.

Power Modulator Gain

The small-signal gain of the power modulator stage. Because the modulator is a switched circuit, state-space averaging techniques are required to derive its gain, but the gain can be approximated as the maximum change in output voltage divided by the maximum change in ramp voltage, usually expressed in dB.



GLOSSARY VOLTAGE REGULATOR TERMS AND DEFINITIONS

Pulse-Width-Modulation (PWM) Control

A switching regulator technique in which regulation is accomplished by changing the duty cycle of the power switch.

Push-Pull Operation

A dual output switching configuration in which two power switches conduct alternately.

Ramp

The output voltage of the oscillator stage of a voltage-mode controller that is compared to the error signal in the comparator to generate the duty cycle control signal. The peak-to-peak level of the ramp determines the gain of the modulator stage.

Remote Sensing

A design technique to reduce output-voltage error induced by the impedance of the output-load cables by including the load cables within the feedback loop. This is done by connecting separate voltage sensing cables at the load that do not carry any load current.

Resonant Mode

A control technique that regulates the output by controlling the operating frequency while turning off the power switch when the current through it (ZCS) or the voltage across it (ZVS) is zero.

Right-Half-Plane Zero

A frequency breakpoint of the loop response that causes the gain to rise 20 dB per decade but causes the phase to fall 90°. This phenomenon is present in continuous-mode boost and flyback converters and is extremely difficult to compensate for.

Single-Ended Operation

A single output switching configuration.

Soft Start

A protection circuit that prevents current surges during power up and protects against false signals that might be generated by the control circuit when power is applied.

SMPS

Switch-mode power supply. Any of a class of power converters that control the output voltage by switching the input voltage.

Synchronous Rectification

A design technique to increase converter efficiency by reducing the conduction losses in the commutation rectifier of a converter. This is typically done by replacing the diode with a transistor that is turned on when the rectifier would be expected to conduct.



Temperature Coefficient

The average change in a parameter, such as output voltage, per degree of temperature change, usually expressed as a percentage over the specified temperature range or ppm/°C.

Transient Recovery Time

The time required for the output of a power supply to settle back into its specified tolerance range after a step change in load current or line voltage. This is also called settling time.

Transient Response

The response of the converter to step changes in load or line variations.

TUV

Technischer Uberwachungs-Verin, a German organization approved for testing products to VDE standards.

UL

Underwriters Laboratories, the U.S. independent organization that conducts safety testing of products to established standards.

Unconditionally Stable

Description of a control loop that generally does not oscillate under any line/load conditions or when the loop gain is reduced. An unconditionally stable loop has less than 360° of phase shift for all frequencies less than or equal to unity-gain frequency.

Undervoltage

A condition in which the output voltage magnitude is less than the minimum specified limit. For both positive and negative regulators, the voltage is closer to zero.

Undervoltage Lockout (UVLO)

A protection circuit that prevents switching outputs from turning on until a certain supply voltage threshold is reached so as to prevent excessive dissipation on the switches and possible damage to the circuit.

Variable Frequency Control

A switching regulation technique in which a fixed output on-time or off-time is maintained. Regulation is accomplished by changing the output frequency to vary the duty cycle.

VDE

Verband Deutscher Elektrotechniker, the German organization that sets standards for product safety and noise emissions and also tests and certifies products to those standards.

Voltage-Mode Control

A PWM control technique consisting of a single feedback loop that controls the output voltage by comparing it to a fixed reference voltage.



GLOSSARY VOLTAGE REGULATOR TERMS AND DEFINITIONS

Zero

A point where the open-loop transfer function of the control loop approaches zero as a result of a term in the numerator approaching zero. A frequency breakpoint of the loop response where the gain rises 20 dB per decade and a 90° rise in the phase margin.



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LM185-1.2, LM285-1.2, LM385-1.2, LM385B-1.2, LM385Y-1.2 MICROPOWER VOLTAGE REFERENCES

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Operating Current Range

- LM185 . . . 10 μA to 20 mA

– LM285 . . . 10 μ A to 20 mA

– LM385 . . . 15 μ A to 20 mA

– LM385B \dots 15 μ A to 20 mA

• 1% and 2% Initial Voltage Tolerance

• Reference Impedance

- LM185 . . . 0.6 Ω Max at 25°C

- LM385 . . . 1 Ω Max at 25°C

- All Devices . . . 1.5 Ω Max Over Full

- Temperature Range

Very Low Power Consumption

Applications:

- Portable Meter References

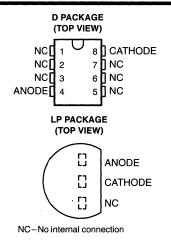
- Portable Test Instruments

- Battery-Operated Systems

- Current-Loop Instrumentation

- Panel Meters

 Designed to be Interchangeable With National LM185-1.2, LM285-1.2, and LM385-1.2



symbol

ANODE _____ CATHODE

description

These micropower two-terminal band-gap voltage references operate over a 10-µA to 20-mA current range and feature exceptionally low dynamic impedance and good temperature stability. On-chip trimming provides tight voltage tolerance. The LM185-1.2 series band-gap reference has low noise and long-term stability.

The LM185-1.2 series design makes the devices exceptionally tolerant of capacitive loading and thus easier to use in most reference applications. The wide dynamic operating temperature range accommodates varying current supplies with excellent regulation.

The extremely low-power drain of the LM185-1.2 series makes them useful for micropower circuitry. These voltage references can be used to make portable meters, regulators, or general-purpose analog circuitry with battery life approaching shelf life. The wide operating current range allows them to replace older references with tighter-tolerance parts.

The LM185-1.2 is characterized for operation over the full military temperature range of -55° C to 125° C. The LM285-1.2 is characterized for operation from -40° C to 85° C. The LM385-1.2 and LM385B-1.2 are characterized for operation from 0° C to 70° C.

AVAILABLE OPTIONS

	V-	PACKAGED I	CHIP FORM	
TA	V _Z TOLERANCE	SMALL OUTLINE (D)	PLASTIC (LP)	(Y)
0°C to 70°C	2%	LM385D-1.2	LM385LP-1.2	
0 0 10 70 0	1%	LM385BD-1.2	LM385BLP-1.2	LM385Y-1.2
-40°C to 85°C	1%	LM285D-1.2	LM285LP-1.2	LIVI385 1-1.2
-55°C to 125°C	1%	LM185D-1.2	LM185LP-1.2	

† For ordering purposes, the decimal point in the part number must be replaced with a hyphen (i.e., show the -1.2 suffix as "-1-2").

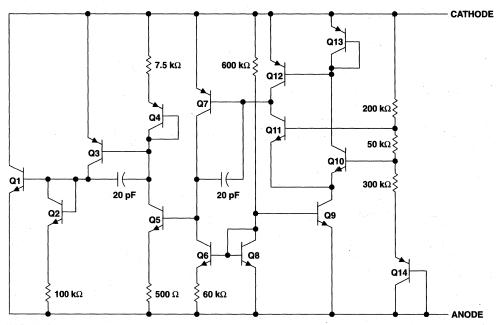
The D package is available taped and reeled. Add the suffix R to the device type (e.g., LM385DR-1-2). The chip form is tested at $T_A = 25$ °C.



LM185-1.2, LM285-1.2, LM385-1.2, LM385B-1.2, LM385Y-1.2 MICROPOWER VOLTAGE REFERENCES

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schematic



NOTE A: Component values shown are nominal.

absolute maximum ratings over operating free-air temperature range†

Reverse current, I _R	
Forward current, I _F	
Operating free-air temperature range, T _A : LM185-1.2	–55°C to 125°C
LM285-1.2	–40°C to 85°C
LM385-1.2, LM385B-1.	.2 0°C to 70°C
Storage temperature range, T _{stg}	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

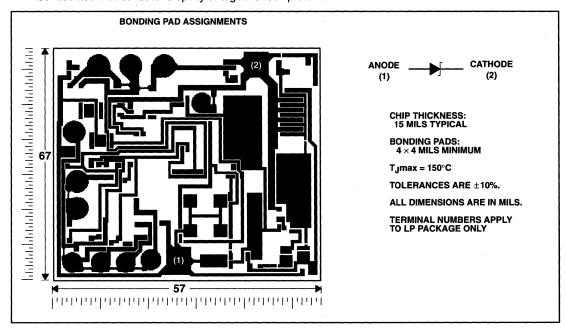
		MIN	MAX	UNIT
Reference current, IZ		0.01	20	mA
	LM185-1.2	-55	125	
Operating free-air temperature range, TA	LM285-1.2	-40	85	∘c °
	LM385-1.2, LM385B-1.2	0	70	

LM185-1.2, LM285-1.2, LM385-1.2, LM385B-1.2, LM385Y-1.2 MICROPOWER VOLTAGE REFERENCES

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LM385Y-1.2 chip information

This chip, when properly assembled, displays characteristics similar to the LM385-1.2 (see electrical tables). Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



electrical characteristics at specified free-air temperature

	PARAMETER	TEST CONDITIONS	T _A †	_	LM185-1.2 LM285-1.2		LM385-1.2		LM385B-1.2			UNIT	
	er en	CONDITIONS		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
٧z	Reference voltage	I _Z =I min to 20 mA [‡]	25°C	1.223	1.235	1.247	1.21	1.235	1.26	1.223	1.235	1.247	V
ανΖ	Average temperature coefficient of reference voltage§	IZ=I min to 20 mA‡	25°C		±20			±20			±20		ppm/°C
	I min to 1 m 0 t	25°C			1			1			1		
1	Change in reference veltage with current	IZ = I min to 1 mA‡	Full range			1.5	ž.		1.5			1.5	mv l
ΔVZ	Change in reference voltage with current	I _Z = 1 mA to 20 mA	25°C			12			20			20	""
		IZ= I IIIA to 20 IIIA	Full range			30			. 30			30	
$\Delta V_Z/\Delta t$	Long-term change in reference voltage	I _Z = 100 μA	25°C		±20			±20			±20		ppm/khr
Izmin	Minimum reference current		Full range		8	10		8	15		8	15	μΑ
	D-fimpedance	I _Z = 100 μA,	25°C		0.2	0.6		0.4	1 /		0.4	1	Ω
z _Z	Reference impedance	f = 25 Hz	Full range			1.5			1.5			1.5	
Vn	Broadband noise voltage	$I_Z = 100 \mu A$, f = 10 Hz to 10 kHz	25°C		60			60			60		μV

LM185-1.2, LM285-1.2, LM385-1.2, LM385Y-1.2 MICROPOWER VOLTAGE REFERENCES

[†] Full range is -55°C to 125°C for the LM185-1.2, -40°C to 85°C for the LM285-1.2, and 0°C to 70°C for the LM385-1.2 and LM385B-1.2.
‡ I min = 10 μA for the LM185-1.2 and LM285-1.2. I_{min} = 15 μA for the LM385-1.2 and LM385B-1.2.
§ The average temperature coefficient of reference voltage is defined as the total change in reference voltage divided by the specified temperature range.

LM185-1.2, LM285-1.2, LM385-1.2, LM385B-1.2, LM385Y-1.2 MICROPOWER VOLTAGE REFERENCES

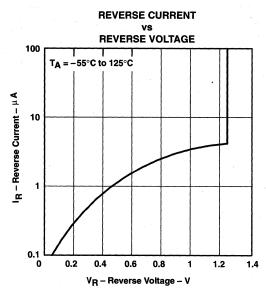
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electrical characteristics, $T_A = 25$ °C

	PARAMETER	TEST CONDITIONS	LM385Y-1.2			UNIT
	PARAMETER	TEST CONDITIONS			MAX	UNII
٧z	Reference voltage	$I_Z = 15 \mu\text{A} \text{ to } 20 \text{mA}$	1.21	1.235	1.26	V
αVZ	Average temperature coefficient of reference voltage†	$I_Z = 15 \mu\text{A} \text{ to } 20 \text{mA}$		±20		ppm/°C
	Change in reference veltage with august	$I_Z = 15 \mu A$ to 1 mA			1	
ΔV_Z	Change in reference voltage with current	$I_Z = 1$ mA to 20 mA			20	mV
ΔV <u>Z</u> /Δt	Long-term change in reference voltage	I _Z = 100 μA		±20		ppm/khr
IZmin	Minimum reference current			8	15	μА
z _Z	Reference impedance	I _Z = 100 μA		0.4	1	Ω
٧n	Broadband noise voltage	I _Z = 100 μA, f = 10 Hz to 10 kHz		60		μV

[†] The average temperature coefficient of reference voltage is defined as the total change in reference voltage divided by the specified temperature range.

TYPICAL CHARACTERISTICS[†]



REFERENCE VOLTAGE CHANGE
VS
REVERSE CURRENT

16

TA = -55°C to 125°C

12

4

0.01

0.1

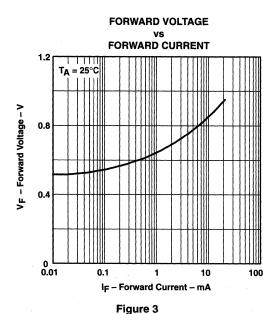
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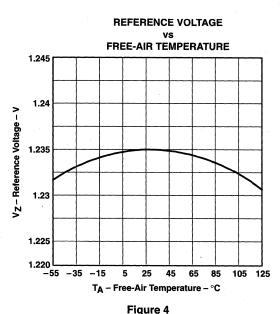
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Figure 1



IR - Reverse Current - mA





[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

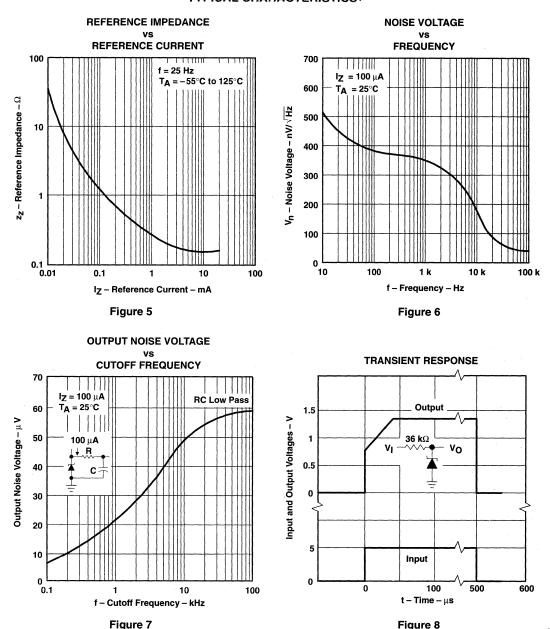


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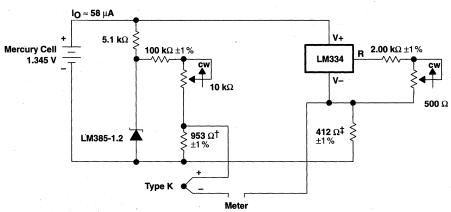
TYPICAL CHARACTERISTICS[†]



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



APPLICATION INFORMATION



 $^{^{\}dagger}$ Adjust for 11.15 mV at 25°C across 953 Ω

Figure 9. Thermocouple Cold-Junction Compensator

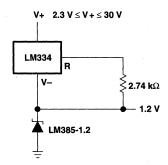


Figure 10. Operation Over a Wide Supply Range

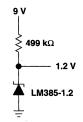


Figure 11. Reference From a 9-V Battery

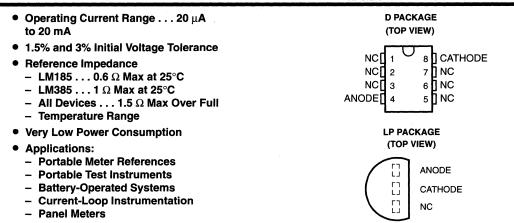
 $[\]ddagger$ Adjust for 12.17 mV at 25°C across 412 Ω

LM185-2.5, LM285-2.5, LM385Y-2.5, LM385B-2.5, LM385Y-2.5 MICROPOWER VOLTAGE REFERENCES

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NC-No internal connection

- CATHODE



symbol

ANODE -

description

LM385-2.5

Designed to be Interchangeable With

National LM185-2.5, LM285-2.5, and

These micropower two-terminal band-gap voltage references operate over a 20-µA to 20-mA current range and feature exceptionally low dynamic impedance and good temperature stability. On-chip trimming provides tight

voltage tolerance. The LM185-2.5 series band-gap reference has low noise and long-term stability.

The LM185-2.5 series design makes these devices exceptionally tolerant of capacitive loading and thus easier to use in most reference applications. The wide dynamic operating temperature range accommodates varying current supplies with excellent regulation.

The extremely low power drain of the LM185-2.5 series makes them useful for micropower circuitry. These voltage references can make portable meters, regulators, or general-purpose analog circuitry with battery life approaching shelf life. The wide operating current range allows them to replace older references with tighter tolerance parts.

The LM385-2.5 and LM385B-2.5 are characterized for operation from 0° C to 70° C. The LM285-2.5 is characterized for operation from -40° C to 85° C. The LM185-2.5 is characterized for operation over the full military temperature range of -55° C to 125° C.

AVAILABLE OPTIONS

	V ₇	PACKAGED I	PACKAGED DEVICEST					
TA	TOLERANCE SMALL OUTLINE (D)		PLASTIC (LP)	CHIP FORM (Y)				
000 +- 7000	3%	LM385D-2.5	LM385LP-2.5					
0°C to 70°C	1.5%	LM385BD-2.5	LM385BLP-2.5	LM385Y-2.5				
-40°C to 85°C	1.5%	LM285D-2.5	LM285LP-2.5	LIVIOUS 1-2.5				
-55°C to 125°C	1.5%	LM185D-2.5	LM185LP-2.5					

† For ordering purposes, the decimal point in the part number must be replaced with a hyphen (i.e., show the -2.5 suffix as "-2-5").

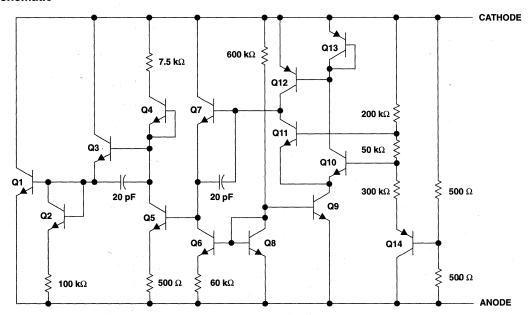
The D package is available taped and reeled. Add the suffix R to the device type (e.g., LM385DR-2-5).



LM185-2.5, LM285-2.5, LM385-2.5, LM385B-2.5, LM385Y-2.5 MICROPOWER VOLTAGE REFERENCES

SLVS023D - JANUARY 1989 - REVISED AUGUST 1995

schematic



NOTE A: All component values shown are nominal.

absolute maximum ratings over operating free-air temperature range†

Reverse current, I _R	
Forward current, I _F	10 mA
Operating free-air temperature range, T _A : LM185-2.5	55°C to 125°C
LM285-2.5	
LM385-2.5, LM385B-2.5	0°C to 70°C
Storage temperature range, T _{Sto}	. −65°C to 150°C
Storage temperature range, T _{stg} Lead temperature 1,6 mm (1/16 inch) from cases for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

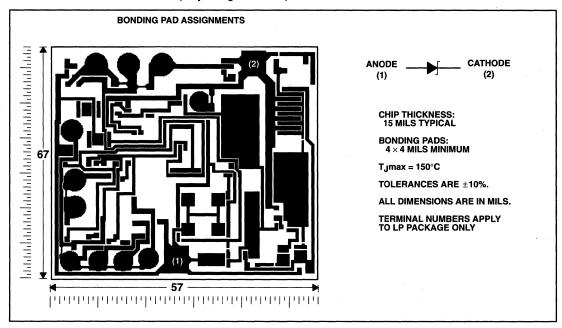
		MIN	MAX	UNIT
Reference current, IZ		0.02	20	mA
	LM185-2.5	-55	125	
Operating free-air temperature range, TA	LM285-2.5	-40	85	°C ·
	LM385-2.5, LM385B-2.5	0	70	

LM185-2.5, LM285-2.5, LM385-2.5, LM385B-2.5, LM385Y-2.5 MICROPOWER VOLTAGE REFERENCES

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LM385Y-2.5 chip information

This chip, when properly assembled, displays characteristics similar to the LM385-2.5 (see electrical tables). Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



electrical characteristics at specified free-air temperature

	PARAMETER	TEST CONDITIONS	TAT	LM185-2.5 LM285-2.5		L	LM385-2.5		LN	//385B-2	5	UNIT	
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
٧z	Reference voltage	$I_Z = 20 \mu A \text{ to } 20 \text{ mA}$	25°C	2.462	2.5	2.538	2.425	2.5	2.575	2.462	2.5	2.538	٧
ανΖ	Average temperature coefficient of reference voltage ‡	$I_Z = 20 \mu A \text{ to } 20 \text{ mA}$	25°C		±20			±20			±20		ppm/°C
	Change in reference voltage with current	I _Z = 20 μA to 1 mA	25°C			1			2			2	
1			Full range			1.5			2			2] mv
ΔVZ		I _Z = 1 μA to 20 mA	25°C			10			20			20] """
			Full range			30			30			30	
$\Delta V_Z/\Delta t$	Long-term change in reference voltage	l _Z = 100 μA	25°C		±20			±20			±20		ppm/khr
IZ(min)	Minimum reference current		Full range		8	20		8	20		8	20	μА
	Peterana impedance	1- 100 114	25°C		0.2	0.6	$\int_{}^{}$	0.4	1 '		0.4	1	Ω
ZZ	Reference impedance	I _Z = 100 μA	Full range			1.5			1.5			1.5	5.2
v _n	Broadband noise voltage	I _Z = 100 μA, f = 10 Hz to 10 kHz	25°C		120			120			120		μV

LM185-2.5, LM285-2.5, LM385Y-2.5 MICROPOWER VOLTAGE REFERENCES

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[†] Full range is 0°C to 70°C for the LM385-2.5 and LM385B-2.5, -40°C to 85°C for the LM285-2.5, and -55°C to 125°C for the LM185-2.5.
‡ The average temperature coefficient of reference voltage is defined as the total change in reference voltage divided by the specified temperature range.

LM185-2.5, LM285-2.5, LM385-2.5, LM385B-2.5, LM385Y-2.5 MICROPOWER VOLTAGE REFERENCES

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electrical characteristics at $T_A = 25$ °C

	PARAMETER	TEST CONDITIONS	LN	UNIT		
	FARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNII
٧z	Reference voltage	I _Z = 20 μA to 20 mA	2.462	2.5	2.575	٧
ανΖ	Average temperature coefficient of reference voltage †	$I_Z = 20 \mu\text{A} \text{ to } 20 \text{mA}$		±20		ppm/°C
ΔV <u>Z</u> /Δt	Long-term change in reference voltage	I _Z = 100 μA		±20		ppm/khr
z _Z	Reference impedance	I _Z = 100 μA		0.4	1	Ω
Vn	Broadband noise voltage	$I_Z = 100 \mu A$, f = 10 Hz to 10 kHz		120		μ۷

[†] The average temperature coefficient of reference voltage is defined as the total change in reference voltage divided by the specified temperature range.

TYPICAL CHARACTERISTICS†

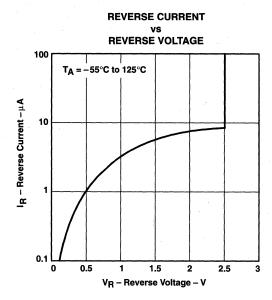


Figure 1

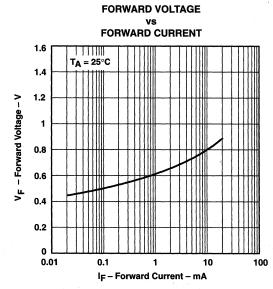


Figure 3

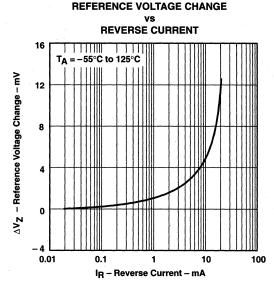


Figure 2

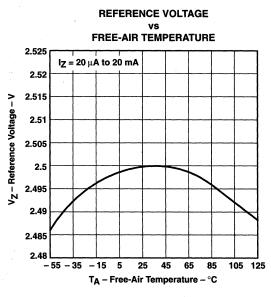
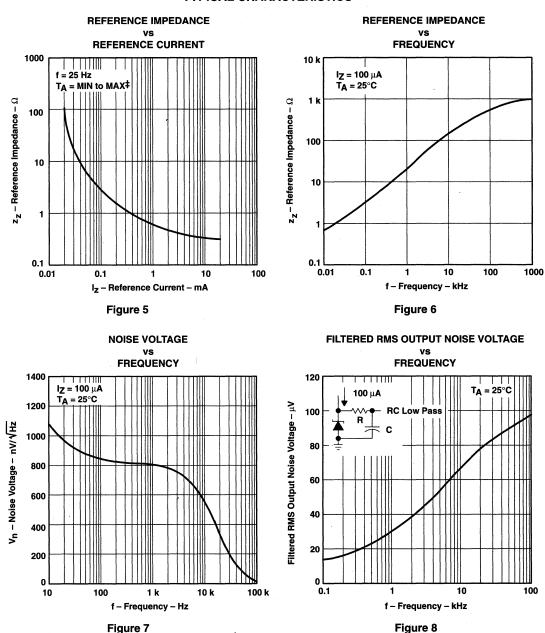


Figure 4

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS[†]



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

[‡] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



LM185-2.5, LM285-2.5, LM385-2.5, LM385B-2.5, LM385Y-2.5 MICROPOWER VOLTAGE REFERENCES

SLVS023D - JANUARY 1989 - REVISED AUGUST 1995

TYPICAL CHARACTERISTICS†

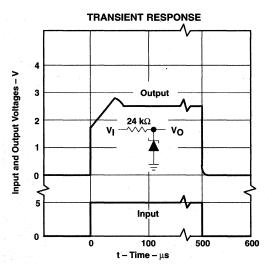


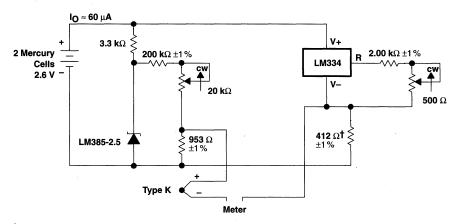
Figure 9

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

LM185-2.5, LM285-2.5, LM385-2.5, LM385B-2.5, LM385Y-2.5 MICROPOWER VOLTAGE REFERENCES

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APPLICATION INFORMATION



†Adjust for 12.17 mV at 25°C across 412 Ω

Figure 10. Thermocouple Cold-Junction Compensator

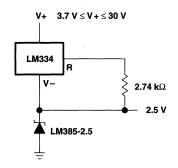


Figure 11. Operation Over a Wide Supply Range

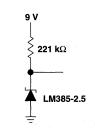


Figure 12. Reference From a 9-V Battery

LM236-2.5, LM336-2.5, LM336Y-2.5 2.5-V INTEGRATED REFERENCE CIRCUITS

SLVS063A - NOVEMBER 1988 - REVISED AUGUST 1995

Low Temperature Coefficient

 Wide Operating Current . . . 400 μA to 10 mA

- 0.27-Ω Dynamic Impedance
- ±1% Tolerance Available
- Specified Temperature Stability
- Easily Trimmed for Minimum Temperature Drift
- Fast Turn-On
- Three-Lead Transistor Package

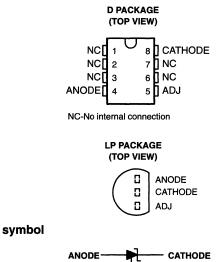
description

The LM236-2.5 and LM336-2.5 integrated circuits are precision 2.5-V shunt regulator diodes. These monolithic references operate as low temperature coefficient 2.5-V zeners with a 0.2- Ω dynamic impedance. A third terminal provided on the circuit allows the reference voltage and temperature coefficient to be easily trimmed.

The series are useful as precision 2.5-V low-voltage references (V₇) for digital voltmeters,

power supplies, or operational amplifier circuitry. The 2.5-V voltage reference makes it convenient to obtain a stable reference from 5-V logic supplies. Since the series operate as shunt regulators, they can be used as either positive or negative voltage references.

The LM236-2.5 is characterized for operation from -25° C to 85° C. The LM336-2.5 is characterized for operation from 0° C to 70° C.



ADJ

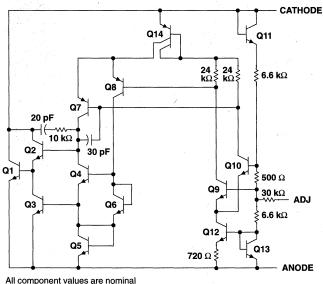
AVAILABLE OPTIONS

	PACKAGED	CHIP FORM		
TA	SMALL OUTLINE (D)	PLASTIC (LP)	(Y)	
0°C to 70°C	LM336D-2.5	LM336LP-2.5	LM336Y-2.5	
-25°C to 85°C	LM236D-2.5	LM236LP-2.5		

The D package is available taped and reeled. Add the suffix R to the device type (i.e., LM336DR-2.5).

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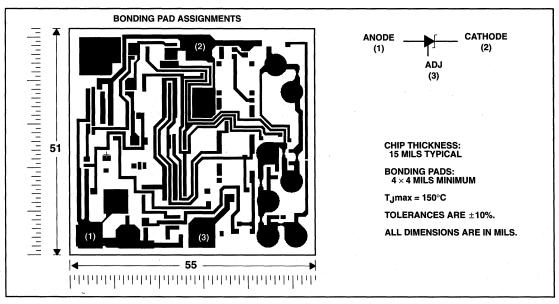
schematic diagram



All component values are nominal

LM336Y-2.5 chip information

This chip, when properly assembled, displays characteristics similar to the LM336-2.5 (see electrical tables). Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



LM236-2.5, LM336-2.5, LM336Y-2.5 2.5-V INTEGRATED REFERENCE CIRCUITS

SLVS063A - NOVEMBER 1988 - REVISED AUGUST 1995

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Reverse current, I _R	
Forward current, I _F	10 m/
Operating free-air temperature range, T _A : LM236-2.5	25°C to 85°C
LM336-2.5	0°C to 70°C
Storage temperature range, T _{stq}	-65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds: D or LP nackage	260°€

electrical characteristics at specified free-air temperature (unless otherwise noted)

l .	PARAMETER		TEST CONDITIONS		LM236-2.5			LM336-2.5			UNIT	
PARAMETER		TEST CONDITIONS		T _A ‡	MIN	TYP	MAX	MIN	TYP	MAX	UNIT	
.,	V _Z Reference voltage	D-(I= 1 mA	LM236, LM336	25°C	2.44	2.49	2.54	2.39	2.49	2.59	V
٧Z		I _Z = 1 mA	LM236A, LM336B	25°C	2.465	2.49	2.515	2.44	2.49	2.54	ı v	
ΔV _{Z(ΔT)}	Change in reference voltage with temperature§	V _Z adjusted	V _Z adjusted to 2.490 V, I _Z = 1 mA			3.5	9		1.8	6	mV	
41/	Change in reference	1- 4004	to 10 mA	25°C		2.6	6		2.6	10	mV	
$\Delta V_{Z(\Delta I)}$	voltage with current	1Ζ = 400 μΑ	Z = 400 μA to 10 mA			3	10		3	12	l IIIV	
$\Delta V_{Z(\Delta t)}$	Long-term change in reference voltage	IZ = 1 mA		25°C		20			20		ppm/khr	
_	Reference impedance			25°C		0.2	0.6		0.2	1		
z_Z		$I_Z = 1 \text{ mA}, f = 1 \text{ kHz}$	Full range		0.4	1		0.4	1.4	Ω		

Full range is -25°C to 85°C for the LM236-2.5 and 0°C to 70°C for the LM336-2.5.

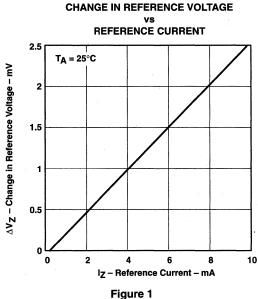
electrical characteristics, T_A = 25°C

	PARAMETER	TEST CONDITIONS	LN	UNIT		
	FARAMETER	TEST CONDITIONS	MIN	TYP	MAX	Oldi
٧z	Reference voltage	IZ = 1 mA	2.39	2.49	2.59	٧
$\Delta V_{Z(\Delta I)}$	Change in reference voltage with current	$I_Z = 400 \mu\text{A} \text{ to } 10 \text{mA}$		2.6	10	mV
$\Delta V_{Z(\Delta t)}$	Long-term change in reference voltage	I _Z = 1 mA		20		ppm/khr
z_Z	Reference impedance	$I_Z = 1 \text{ mA}, f = 1 \text{ kHz}$		0.2	1	Ω

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[§] Temperature stability (change in reference voltage with temperature) for these devices is ensured by design. Design limits are specified over the indicated temperature and supply voltage ranges. These limits are not used to calculate outgoing quality levels.

TYPICAL CHARACTERISTICS



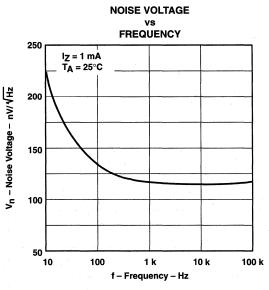


Figure 2

REFERENCE IMPEDANCE **FREQUENCY** 100 Iz = 1 mA $T_A = -55^{\circ}C \text{ to } 125^{\circ}C$

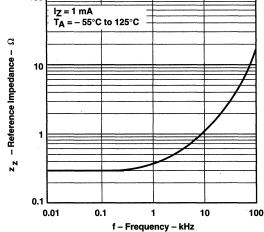


Figure 3

APPLICATION INFORMATION

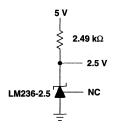
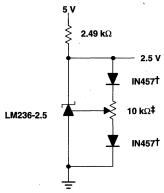


Figure 3. 2.5-V Reference



† Any silicon signal diode ‡ Adjust to 2.49 V

Figure 4. 2.5-V Reference With Minimum Temperature Coefficient

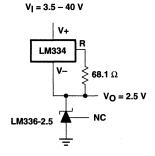


Figure 5. Wide Input Range Reference

LT1004C-1.2, LT1004C-2.5, LT1004M-1.2 LT1004M-2.5, LT1004Y-1.2, LT1004Y-2.5 MICROPOWER INTEGRATED VOLTAGE REFERENCES

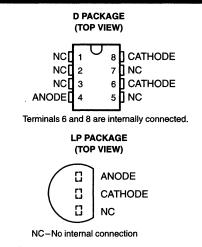
SLVS022D - JANUARY 1989 - REVISED AUGUST 1995

- Initial Accuracy
 ±4 mV for LT1004-1.2
 ±20 mV for LT1004-2.5
- Micropower Operation
- Operates up to 20 mA
- Very Low Reference Impedance
- Applications:

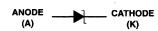
Portable Meter Reference Portable Test Instruments Battery-Operated Systems Current-Loop Instrumentation

description

The LT1004 micropower voltage reference is a two-terminal band-gap reference diode designed to provide high accuracy and excellent temperature characteristics at very low operating currents. Optimizing the key parameters in the design, processing, and testing of the device results in specifications previously attainable only with selected units.



symbol



The LT1004 is a terminal-for-terminal replacement for the LM185 series of references with improved specifications. The LT1004 is an excellent device for use in systems in which accuracy was previously attained at the expense of power consumption and trimming.

The LT1004C is characterized for operation from 0° C to 70° C. The LT1004M is characterized for operation over the full military temperature range of -55° C to 125° C.

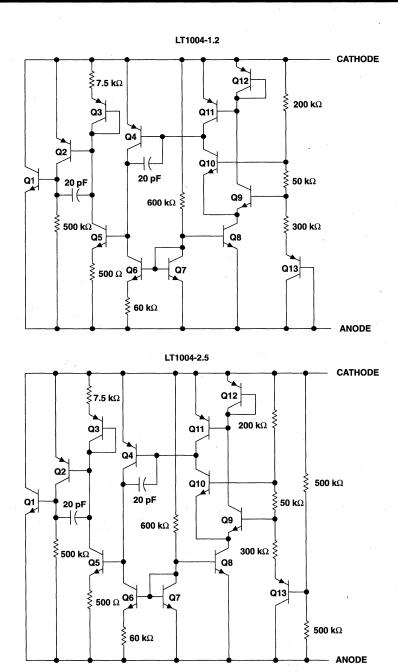
AVAILABLE OPTIONS†

		CHIP FORM		
TA	V _Z TYP	SMALL-OUTLINE (D)	(Y)	
0°C to 70°C	1.2 V	LT1004CD-1.2	LT1004CLP-1.2	LT1004Y-1.2
0 0 10 70 0	2.5 V	LT1004CD-2.5	LT1004CLP-2.5	LT1004Y-2.5
-55°C to 125°C	1.2 V	LT1004MD-1.2	LT1004MLP-1.2	
-55 C 10 125 C	2.5 V	LT1004MD-2.5	LT1004MLP-2.5	_

[†] For ordering purposes, the decimal point in the part number must be replaced with a hyphen (i.e., show the -1.2 suffix as -1-2 and the -2.5 suffix as -2-5).

[‡]The packages are available taped and reeled. Add the R suffix to the device type (i.e., LT1004CDR).

schematic

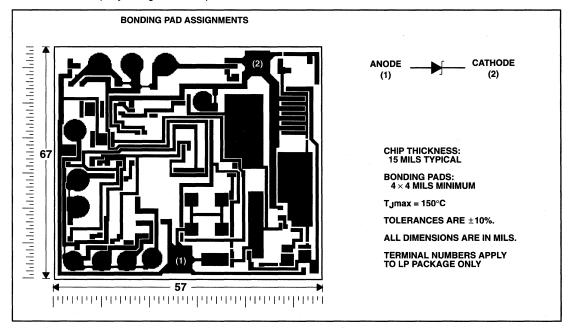


NOTE A: All component values shown are nominal.



LT1004Y-1.2 and LT1004Y-2.5 chip information

This chip, when properly assembled, displays characteristics similar to the LT1004C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



LT1004C-1.2, LT1004C-2.5, LT1004M-1.2 LT1004M-2.5, LT1004Y-1.2, LT1004Y-2.5 MICROPOWER INTEGRATED VOLTAGE REFERENCES

SLVS022D - JANUARY 1989 - REVISED AUGUST 1995

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Reverse current, I _R	30 mA
	10 mA
	0°C to 70°C
	–55°C to 125°C
Storage temperature range, T _{stq}	
Lead temperature 1.6 mm (1/16 inch) from case for	10 seconds 260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

electrical characteristics at specified free-air temperature

PARAMETER		TEST	T _A ‡		LT1004-1.2			LT1004-2.5				
		CONDITIONS			MIN	TYP	MAX	MIN	TYP	MAX	UNIT	
		I _Z = 100 μA	25°C		1.231	1.235	1.239	2.48	2.5	2.52		
V_{Z}	Reference voltage		Full	LT1004C	1.225		1.245	2.47		2.53	-	
			range	LT1004M	1.22	4	1.245	2.46		2.535		
Average temperature		I _Z = 10 μA	0500		1	20					/°C	
αVZ	coefficient of reference voltage§	I _Z = 20 μA	25°C				100		20		ppm/°C	
		I _Z = I _Z min to 1 mA	2	25°C			1			1	1 1.5 mV	
	Change in reference voltage with current		Ful	l range			1.5			1.5		
		I _Z = 1 mA to 20 mA	25°C Full range				10			10	''' '	
							20			20		
ΔVZ/Δt	Long term change in reference voltage	I _Z = 100 μA	2	25°C		20			20		ppm/khr	
IZmin	Minimum reference current		Full range			8	10		12	. 20	μΑ	
	Defenses investors	l _Z = 100 μA	25°C Full range			0.2	0.6		0.2	0.6		
z _Z	Reference impedance						1.5			1.5	Ω	
V _n	Broadband noise voltage	I _Z = 100 μA, f = 10 Hz to 10 kHz	25°C			60			120		μV	

[‡] Full range is 0°C to 70°C for the LT1004C and -55°C to 125°C for the LT1004M.

electrical characteristics, $T_{\Delta} = 25^{\circ}C$

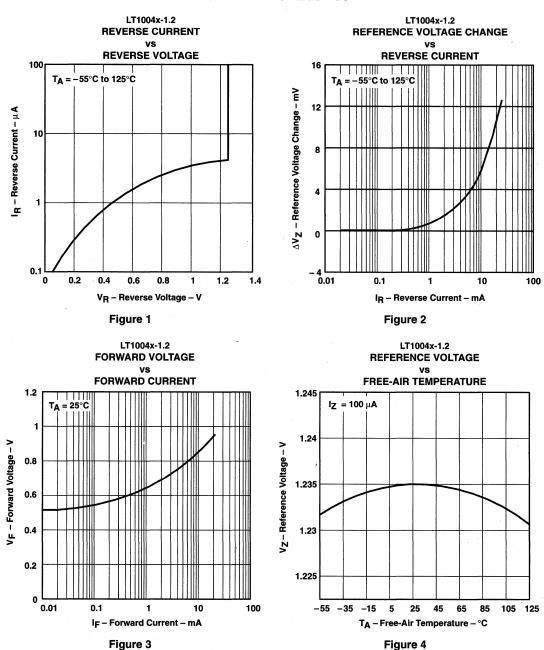
PARAMETER		TEST	LT1004Y-1.2			LT1004Y-2.5			LINUT
		CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
٧z	Reference voltage	I _Z = 100 μA	1.231	1.235	1.239	2.48	2.5	2.52	٧
Average temperature coefficient of reference voltage‡	I _Z = 10 μA	1	20						
	voltage‡	I _Z = 20 μA					20		ppm/°C
ΔVZ/Δt	Long-term change in reference voltage	I _Z = 100 μA		20			20		ppm/khr
Izmin.	Minimum reference current			. 8			12		μΑ
ZZ	Reference impedance	I _Z = 100 μA		0.2	0.6		0.2	0.6	Ω
V _n	Broadband noise voltage	I _Z = 100 μA, f = 10 Hz to 10 kHz		60	-		120		μV

[§] The average temperature coefficient of reference voltage is defined as the total change in reference voltage divided by the specified temperature range.



[§] The average temperature coefficient of reference voltage is defined as the total change in reference voltage divided by the specified temperature range.

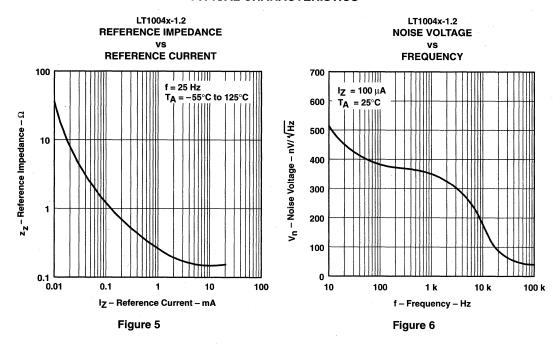
TYPICAL CHARACTERISTICS[†]



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS†



TL1004x-1.2
FILTERED OUTPUT NOISE VOLTAGE
vs
CUTOFF FREQUENCY

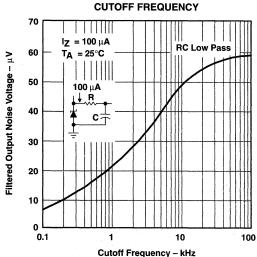
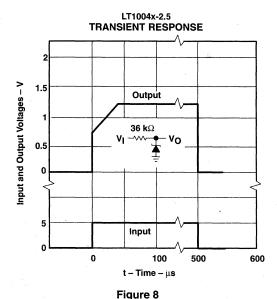
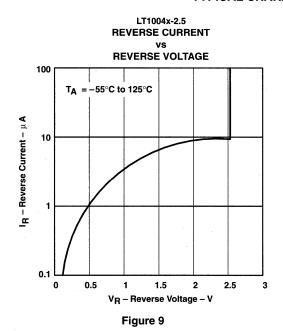


Figure 7



†Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS[†]



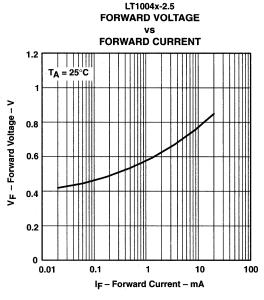
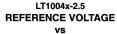


Figure 10



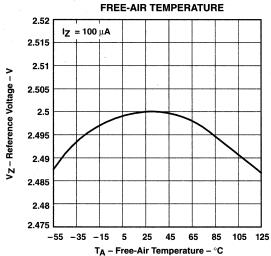
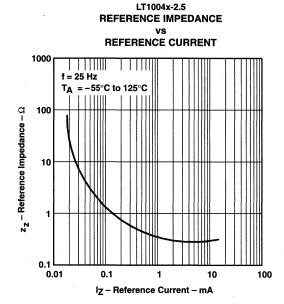


Figure 11

†Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



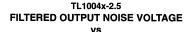
TYPICAL CHARACTERISTICS†

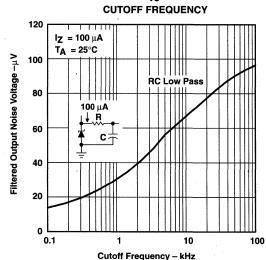


LT1004x-2.5 **NOISE VOLTAGE** vs **FREQUENCY** 1400 $I_Z = 100 \mu A$ 1200 = 25°C V_n − Noise Voltage − nV/VHz 1000 800 600 400 200 0 10 100 1 k 100 k 10 k f - Frequency - Hz

Figure 12

Figure 13





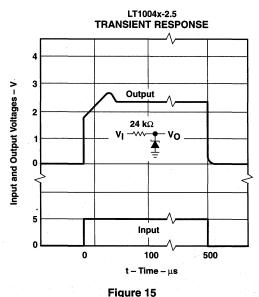
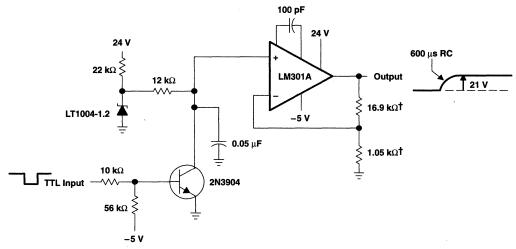


Figure 14

†Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



APPLICATION INFORMATION



† 1% metal-film resistors

Figure 16. V_{I(PP)} Generator for EPROMs (No Trim Required)

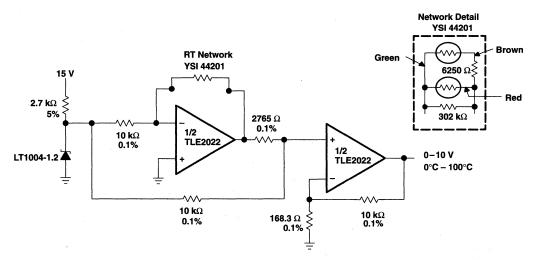


Figure 17. 0°C to 100°C Linear Output Thermometer

APPLICATION INFORMATION

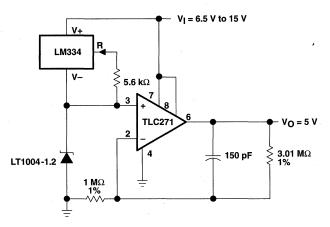
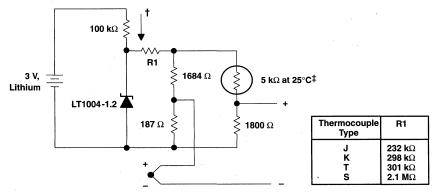


Figure 18. Micropower 5-V Reference



Figure 19. Low-Noise Reference

Figure 20. Micropower Reference From 9-V Battery



[†] Quiescent current ≅ 15 μA

NOTE A: This application compensates within $\pm 1^{\circ}$ C from 0°C to 60°C.

Figure 21. Micropower Cold-Junction Compensation for Thermocouples



[‡] Yellow Springs Inst. Co., Part #44007

APPLICATION INFORMATION

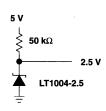


Figure 22. 2.5-V Reference

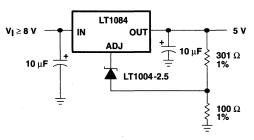
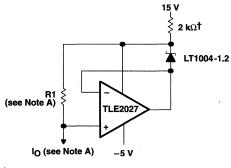


Figure 23. High-Stability 5-V Regulator



† May be increased for small output currents

NOTE A: R1
$$\approx \frac{2 \text{ V}}{\text{I}_{O} + 10 \,\mu\text{A}}$$
, I_O = $\frac{1.235 \,\text{V}}{\text{R1}}$

Figure 24. Ground-Referenced Current Source

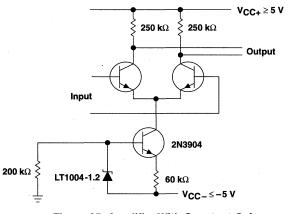
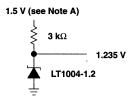


Figure 25. Amplifier With Constant Gain Over Temperature



NOTE A: Output regulates down to 1.285 V for $I_O = 0$.

Figure 26. 1.2-V Reference From 1.5-V Battery

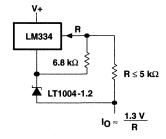
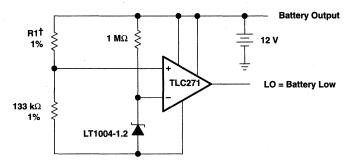


Figure 27. Terminal Current Source With Low Temperature Coefficient

APPLICATION INFORMATION



 \dagger R1 sets trip point, 60.4 k Ω per cell for 1.8 V per cell

Figure 28. Lead-Acid Low-Battery Voltage Detector

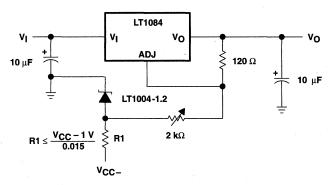


Figure 29. Variable Voltage Supply

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- Excellent Temperature Stability
- Initial Tolerance . . . 0.2% Max
- Dynamic Impedance . . . 0.6 Ω Max
- Wide Operating Current Range
- Directly Interchangeable With LM136
- Needs No Adjustment for Minimum Temperature Coefficient
- Surface-Mount 3-Lead Package

description

The LT1009 reference circuit is a precision-trimmed 2.5-V shunt regulator featuring low dynamic impedance and a wide operating current range. A maximum initial tolerance of ± 5 mV is available in the FK, JG, or LP package and ± 10 mV in the D or PK package. The reference tolerance is achieved by on-chip trimming, which minimizes the initial voltage tolerance and the temperature coefficient α_{VZ} .

Even though the LT1009 needs no adjustments, a third terminal (ADJ) allows the reference voltage to be adjusted $\pm 5\%$ to eliminate system errors. In many applications, the LT1009 can be used as a terminal-for-terminal replacement for the LM136-2.5, which eliminates the external trim network.

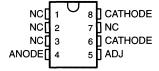
The uses of the LT1009 include a 5-V system reference, an 8-bit ADC and DAC reference, and a power supply monitor. The LT1009 can also be used in applications such as digital voltmeters and current-loop measurement and control systems.

The LT1009C is characterized for operation from 0°C to 70°C. The LT1009I is characterized for operation from -40°C to 85°C. The LT1009M is characterized for operation over the full military temperature range of -55°C to 125°C.

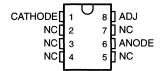
logic symbol



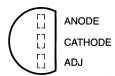
D PACKAGE (TOP VIEW)



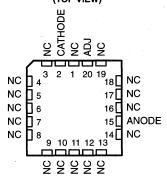
JG PACKAGE (TOP VIEW)



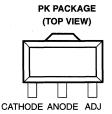
LP PACKAGE (TOP VIEW)



FK PACKAGE (TOP VIEW)



NC-No internal connection

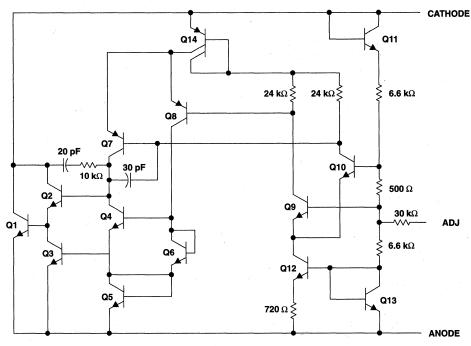


PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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schematic



All component values shown are nominal.

AVAILABLE OPTIONS

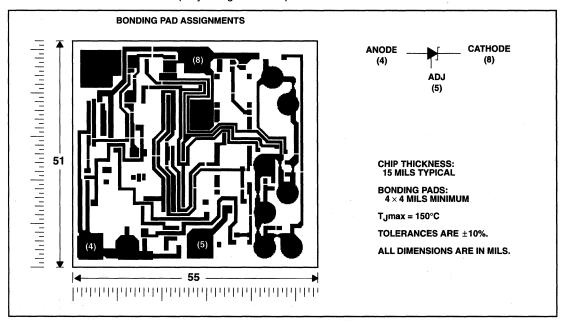
	PACKAGED DEVICES					CHIP		
TA	SMALL CHIP CERAMI OUTLINE CARRIER DIP (D) (FK) (JG)			PLASTIC CYLINDRICAL (LP)	FORM (Y)			
0°C to 70°C	LT1009CD	_	_	LT1009CLP	LT1009CPK			
-40°C to 85°C	LT1009ID			LT1009ILP		LT1009Y		
-55°C to 125°C		LT1009MFK	LT1009MJG	_	_			

The D and LP packages are available taped and reeled. Add R suffix to device type (e.g., LT1009CDR). PK device is only available taped and reeled. No R suffix is required.

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LT1009Y chip information

This chip, when properly assembled, displays characteristics similar to the LT1009C (see electrical tables). Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



absolute maximum ratings over operating free-air temperature range†

Reverse current, I _R	
Continuous total power dissipation	
Operating free-air temperature range, T _A : LT1009C	
LT1009I	40°C to 85°C
	–55°C to 125°C
Storage temperature range, T _{stq}	65°C to 150°C
Case temperature for 60 seconds, T _C : FK package	
Lead temperature 1,6 mm (1/16 inch) from case for 10 se	econds: D, LP, and PK packages 260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 se	econds: JG package 300°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.



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DISSIPATION RATING TABLE 1 - FREE-AIR TEMPERATURE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C ·	464 mW	377 mW	
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
LP	775 mW	6.2 mW/°C	496 mW	403 mW	
PK	500 mW	4.0 mW/°C	320 mW		

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE

PACKAGE	T _C ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _C = 25°C	T _C = 70°C POWER RATING
PK	3125 mW	25 mW/°C	2000 mW

electrical characteristics at specified free-air temperature

			T COMPLETIONS	LT10090	>	- 1	T1009		L	T1009N	Λ			
PARAMETER		IES	T CONDITIONS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
			FK, JG, LP package	25°C	2.495	2.5	2.505	2.495	2.5	2.505	2.495	2.5	2.505	
,,_	D-ference voltage	- 1 m^	D, PK package	25-0	2.49	2.5	2.51	2.49	2.5	2.51				l v l
Vz	Reference voltage	$I_Z = 1 \text{ mA}$	FK, JG, LP package	Full range	2.491		2.509	2.48		2.52	2.46		2.535	"
<u> </u>	<u> </u>		D, PK package	rull range	2.485		2.515	2.475		2.525				
٧ _F	Forward voltage	IF = 2 mA		25°C	0.4		1	0.4		1	0.4		1	·V
		$I_Z = 1 \text{ mA},$	$V_{ADJ} = GND \text{ to } V_Z$		125			125						
Adjustment rang	Adjustment range	I _Z = 1 mA, V _{ADJ} = 0.6	S V to V _Z – 0.6 V	25°C	45			45			15			mV
	Change in reference voltage with temperature		FK, JG, LP package	Eull ronge			4			15			15*	* mv
Δ VZ(temp)		D, PK p	D, PK package	Full range			5			15				IIIV
	Average temperature			0°C to 70°C	1 -	15	25							
ανΖ	coefficient of			-40°C to 85°C					20					ppm/°C
	reference voltage‡			-55°C to 125°C								25	35	
41/-	Change in reference	l ₇ = 400 μA	A to 10 mA	25°C		2.6	10		2.6	6		2.6	6	mV
ΔVZ	voltage with current	1Ζ = 400 μΛ	TO TO THA	Full range			12			10			10	HIV
$\Delta V_{Z}/\Delta t$	Long-term change in reference voltage	I _Z = 1 mA	- 1	25°C		20			20			20		ppm/khr
	D-farance impedance	- 1 mA		25°C		0.3	1		0.3	1		0.3	0.6*	
z _Z	Reference impedance	I _Z = 1 mA		Full range		-	1.4			1.4			1*	Ω

^{*} On products compliant to MIL-STD-883, Class B, this parameter is not production tested.
† Full range is 0°C to 70°C for the LT1009C, -40°C to 85°C for the LT1009I, and -55°C to 125°C for the LT1009M.

[‡] The average temperature coefficient of reference voltage is defined as the total change in reference voltage divided by the specified temperature range.

LT1009, LT1009Y 2.5-V INTEGRATED REFERENCE CIRCUITS

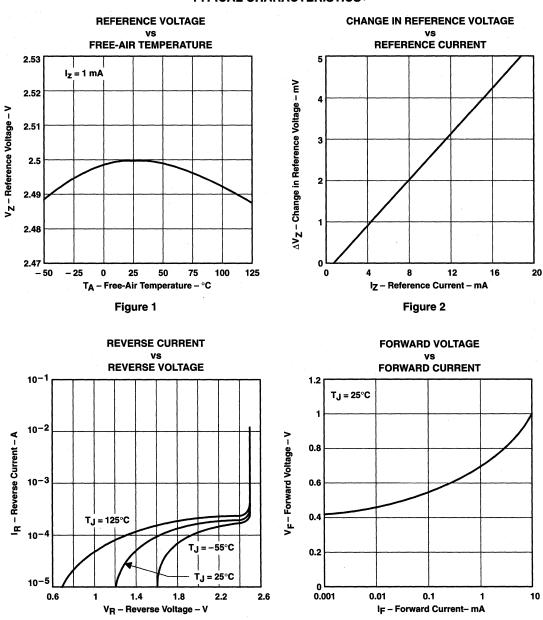
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electrical characteristics at $T_A = 25^{\circ}C$

	DADAMETED	TEST CONDITIONS	L	T1009Y	,	UNIT
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{Z}	Reference voltage	I _Z = 1 mA	2.49	2.5	2.51	٧
٧ _F	Forward voltage	IF = 2 mA	0.4		1	٧
	Adjustment songe	$I_Z = 1 \text{ mA}, V_{ADJ} = \text{GND to } V_Z$	125			mV
	Adjustment range	$I_Z = 1 \text{ mA}$, $V_{ADJ} = 0.6 \text{ V to } V_Z - 0.6 \text{ V}$	45			1111
ΔVZ(temp)	Change in reference voltage with temperature			2.5		mV
αVZ	Average temperature coefficient of reference voltage t			15		ppm/°C
ΔVZ	Change in reference voltage with current	I _Z = 400 μA to 10 mA		2.6		mV
$\Delta V_{Z}/\Delta t$	Long-term change in reference voltage	I _Z = 1 mA		20		ppm/khr
z _z	Reference impedance	I _Z = 1 mA		0.3	1	Ω

[†] The average temperature coefficient of reference voltage is defined as the total change in reference voltage divided by the specified temperature range.

TYPICAL CHARACTERISTICS†



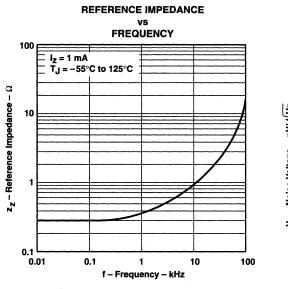
† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 3



Figure 4

TYPICAL CHARACTERISTICS



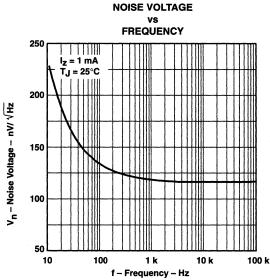


Figure 5

Figure 6

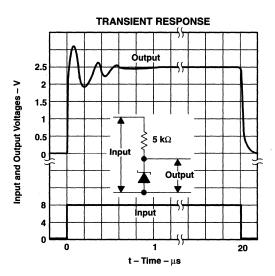
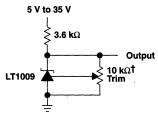


Figure 7



†This does not affect temperature coefficient. It provides $\pm 5\%$ trim range.

Figure 8. 2.5-V Reference

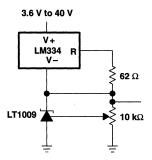


Figure 9. Adjustable Reference With Wide Supply Range

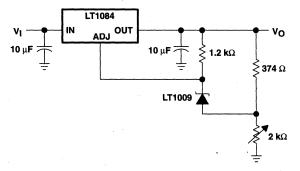


Figure 10. Power Regulator With Low Temperature Coefficient

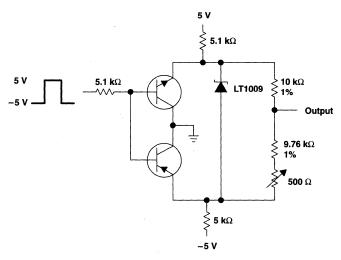


Figure 11. Switchable ± 1.25 -V Bipolar Reference

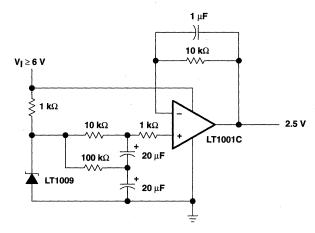


Figure 12. Low-Noise 2.5-V Buffered Reference

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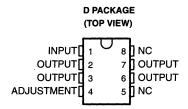
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- Output Voltage Range Adjustable From 1.2 V to 32 V When Used With an External Resistor Divider
- Output Current Capability of 100 mA
- Input Regulation Typically 0.01% Per Input-Voltage Change
- Output Regulation Typically 0.5%
- Ripple Rejection Typically 80 dB

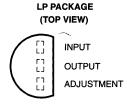
description

The TL317C is an adjustable 3-terminal positive-voltage regulator capable of supplying 100 mA over an output-voltage range of 1.2 V to 32 V. It is exceptionally easy to use and requires only two external resistors to set the output voltage.

In addition to higher performance than fixed regulators, this regulator offers full overload protection available only in integrated circuits. Included on the chip are current-limiting and



NOTE: OUTPUT terminals are all internally connected.



NC-No internal connection

thermal-overload protection. All overload protection circuitry remains fully functional even when ADJUSTMENT is disconnected. Normally, no capacitors are needed unless the device is situated far from the input filter capacitors, in which case an input bypass is needed. An optional output capacitor can be added to improve transient response. ADJUSTMENT can be bypassed to achieve very high ripple rejection, which is difficult to achieve with standard 3-terminal regulators.

In addition to replacing fixed regulators, the TL317C regulator is useful in a wide variety of other applications. Since the regulator is floating and sees only the input-to-output differential voltage, supplies of several hundred volts can be regulated as long as the maximum input-to-output differential is not exceeded. Its primary application is that of a programmable output regulator, but by connecting a fixed resistor between ADJUSTMENT and OUTPUT, this device can be used as a precision current regulator. Supplies with electronic shutdown can be achieved by clamping ADJUSTMENT to ground, programming the output to 1.2 V where most loads draw little current.

The TL317C is characterized for operation from 0° C to 125°C. The TL317Q is characterized for operation from -40° C to 125°C.

AVAILABLE OPTIONS

	PACKAGED	CHIP FORM	
TA	SMALL OUTLINE PLASTIC (D) (LP)		(Y)
0°C to 125°C	TL317CD	TL317CLP	TL317Y
-40°C to 125°C	TL317QD	TL317QLP	_

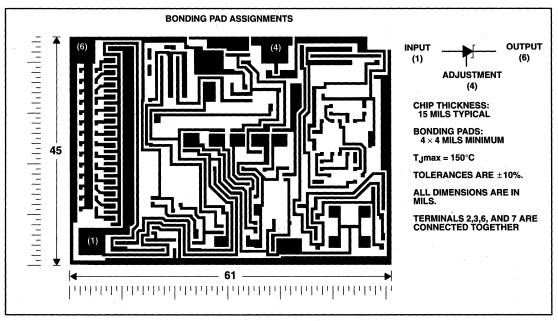
The D and LP packages are available taped and reeled. Add R suffix to device type (e.g., TL317DR).

TL317C, TL317Y 3-TERMINAL ADJUSTABLE REGULATORS

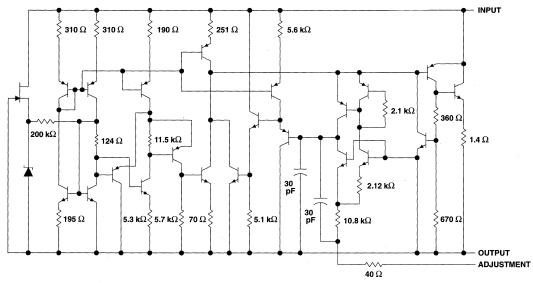
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TL317Y chip information

This chip, when properly assembled, displays characteristics similar to the TL317C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



schematic



NOTE A. All component values shown are nominal.

absolute maximum ratings over operating temperature range (unless otherwise noted)†

Input-to-output differential voltage, V _I – V _O	
Continuous total power dissipation	. See Dissipation Rating Tables 1 and 2
Operating free-air, case, TA, or virtual-junction temperature range, T	J: C Version 0°C to 150°C
	Q Version40°C to 150°C
Storage temperature range, T _{stq}	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE 1 - FREE-AIR TEMPERATURE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	145 mW
LP†	775 mW	6.2 mW/°C	155 mW

[†] The LP package dissipation rating is based on thermal resistance measured in still air with the device mounted in an Augat socket. The bottom of the package is 10 mm (0.375 in.) above the socket.

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE

PACKAGE	T _C ≤ 25°C POWER RATING	DERATING FACTOR	DERATE ABOVE T _C	T _C = 125°C POWER RATING
D	1600 mW	29.6 mW/°C	96°C	742 mW
LP	1600 mW	28.6 mW/°C	94°C	713 mW



TL317C, TL317Y 3-TERMINAL ADJUSTABLE REGULATORS

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recommended operating conditions

	MIN	MAX	UNIT
Input-to-output voltage differential, V _I – V _O		35	٧
Output current, IO	2.5	100	mA
Operating virtual-junction temperature, TJ	0	125	°C

electrical characteristics over recommended operating virtual-junction temperature range (unless otherwise noted)

DADAMETED	7507.00	TL31					
PARAMETER	IESI COI	NDITIONST	MIN	TYP	10 2.5 100 5	UNIT	
hamada and hamada and hamada and hamada	V V 5V4-05V	T _J = 25°C		0.01	0.02	%V	
Input voltage regulation (see Note 1)	$V_1 - V_0 = 5 \text{ V to } 35 \text{ V}$	I _O = 2.5 mA to 100 mA		0.02	10 2.5	%V	
,	V _O = 10 V,	f = 120 Hz		65			
Ripple regulation	V _O = 10 V, 10-μF capacitor between .	ADJUSTMENT and ground				dB	
Output voltage regulation	V _I = 5 V to 35 V, I _O = 2.5 mA to 100 mA,	V _O ≤ 5 V		25		mV	
	$T_J = 25^{\circ}C$	V _O ≥ 5 V		5		mV/V	
	V _I = 5 V to 35 V,	V _O ≤ 5 V		50		mV	
	I _O = 2.5 mA to 100 mA	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$		mV/V			
Output voltage change with temperature	T _J = 0°C to 125°C			10		mV/V	
Output voltage long-term drift (see Note 2)	After 1000 hours at T _J = 1	25°C and V _I – V _O = 35 V		3	10	mV/V	
Output noise voltage	f = 10 Hz to 10 kHz,	T _J = 25°C		30		μV/V	
Minimum output current to maintain regulation	V _I – V _O = 35 V			1.5	2.5	mA	
Peak output current	V _I – V _O ≤ 35 V		100	200		mA	
ADJUSTMENT current				50	100	μΑ	
Change in ADJUSTMENT current	$V_I - V_O = 2.5 \text{ V to } 35 \text{ V},$	I _O = 2.5 mA to 100 mA		0.2	5	μΑ	
Reference voltage (output to ADJUSTMENT)	V _I − V _O = 5 V to 35 V, P ≤ rated dissipation	I _O = 2.5 mA to 100 mA,	1.2	1.25	1.3	٧	

Tunless otherwise noted, these specifications apply for the following test conditions: $V_1 - V_0 = 5$ V and $I_0 = 40$ mA. Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible. All characteristics are measured with a 0.1- μ F capacitor across the input and a 1- μ F capacitor across the output.

NOTES: 1. Input voltage regulation is expressed here as the percentage change in output voltage per 1-V change at the input

Since long-term drift cannot be measured on the individual devices prior to shipment, this specification is not intended to be a guarantee or warranty. It is an engineering estimate of the average drift to be expected from lot to lot.

TL317C, TL317Y 3-TERMINAL ADJUSTABLE REGULATORS

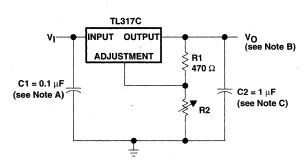
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electrical characteristics over recommended operating conditions, $T_J = 25^{\circ}C$ (unless otherwise noted)

DADAMETED	7507.001	DITIONST	T	L317Y		UNIT
PARAMETER	IESI CON	IDITIONST	MIN	TYP	MAX	ONIT
Input voltage regulation (see Note 1)	$V_I - V_O = 5 \text{ V to } 35 \text{ V}$			0.01		%V
	V _O = 10 V,		65			
Ripple regulation	V _O = 10 V, 10-μF capacitor between A	DJUSTMENT and ground	80			dB
Outrout voltage regulation	L- 05 4 100 4	V _O ≤ 5 V		25		mV
Output voltage regulation	I _O = 2.5 mA to 100 mA	V _O ≥ 5 V		5		mV/V
Output noise voltage	f = 10 Hz to 10 kHz,			30		μV/V
Minimum output current to maintain regulation	V _I – V _O = 35 V			1.5		mA
Peak output current	V _I V _O ≤ 35 V			200		mA
ADJUSTMENT current				50		μΑ
Change in ADJUSTMENT current	$V_I - V_O = 2.5 \text{ V to } 35 \text{ V},$	I _O = 2.5 mA to 100 mA		0.2		μΑ
Reference voltage (output to ADJUSTMENT)	$V_I - V_O = 5 \text{ V to } 35 \text{ V},$ P \le rated dissipation	I _O = 2.5 mA to 100 mA,		1.25		٧

[†] Unless otherwise noted, these specifications apply for the following test conditions: V_I – V_O = 5 V and I_O = 40 mA. Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible. All characteristics are measured with a 0.1-μF capacitor across the input and a 1-μF capacitor across the output.

NOTE 1: Input voltage regulation is expressed here as the percentage change in output voltage per 1-V change at the input



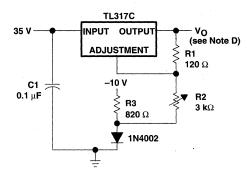
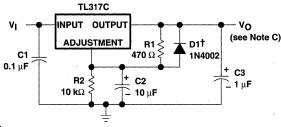


Figure 1. Adjustable Voltage Regulator

Figure 2. 0-V to 30-V Regulator Circuit



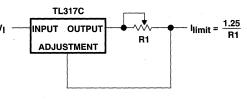


Figure 4. Precision Current-Limiter Circuit

†D1 discharges C2 if output is shorted to ground.

Figure 3. Regulator Circuit With Improved Ripple Rejection

NOTES: A. Use of an input bypass capacitor is recommended if regulator is far from the filter capacitors

- B. Output voltage is calculated from the equation: $V_O = V_{ref} \left(1 + \frac{R2}{R1} \right)$ where: V_{ref} equals the difference between OUTPUT and ADJUSTMENT voltages (= 1.25 V).
- C. Use of an output capacitor improves transient response but is optional.
- D. Output voltage is calculated from the equation: $V_O = V_{ref} \left(1 + \frac{R2 + R3}{R1} \right) 10 \text{ V}$ where: V_{ref} equals the difference between OUTPUT and ADJUSTMENT voltages (\approx 1.25 V).

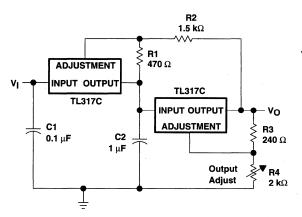


Figure 5. Tracking Preregulator Circuit

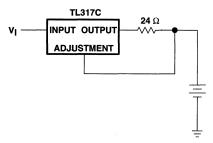


Figure 7. 50-mA Constant-Current Battery Charger Circuit

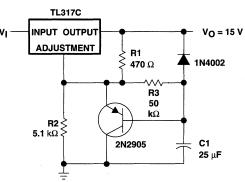


Figure 6. Slow-Turn-On 15-V Regulator Circuit

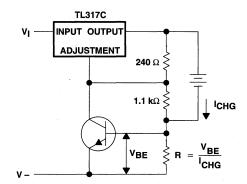
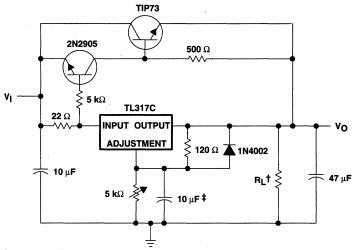


Figure 8. Current-Limited 6-V Charger



[†] Minimum load current is 30 mA.

Figure 9. High-Current Adjustable Regulator

[‡] Optional capacitor improves ripple rejection

TL430C, TL430I, TL430Y ADJUSTABLE SHUNT REGULATORS

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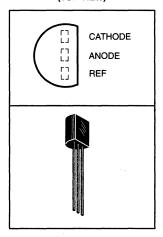
- Temperature Compensated
- Programmable Output Voltage
- Low Output Resistance
- Low Output Noise
- Sink Capability to 100 mA

description

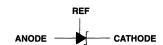
The TL430 is a 3-terminal adjustable shunt regulator featuring excellent temperature stability, wide operating current range, and low output noise. The output voltage may be set by two external resistors to any desired value between 3 V and 30 V. The TL430 can replace zener diodes in many applications providing improved performance

The TL430C is characterized for operation from 0° C to 70° C. The TL430I is characterized for operation from -40° C to 85° C.

LP PACKAGE (TOP VIEW)



symbol

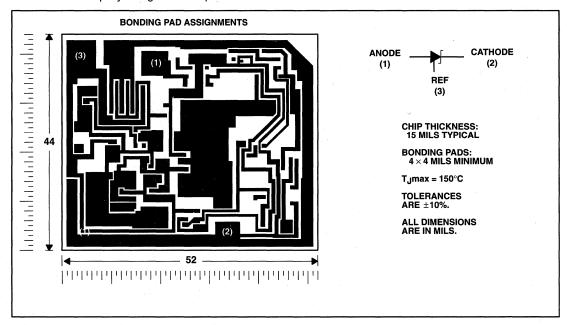


AVAILABLE OPTIONS

TA	PACKAGED DEVICES† PLASTIC (LP)	CHIP FORM (Y)
0°C to 70°C	TL430CLP	TL430Y
-40°C to 85°C	TL430ILP	_

TL430Y chip information

This chip, when properly assembled, displays characteristics similar to the TL430C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Regulator voltage (see Note 1)	30 V
Continuous regulator current	
Continuous total power dissipation at (or below) T _A = 25°C (see Note 2)	
Operating free-air temperature range, T _A : TL430C	0°C to 70°C
TL430I	40°C to 85°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to the anode terminal.

2. For operation above 25°C free-air temperature, derate at 6.2 mW/°C.

recommended operating conditions

		MIN	MAX	UNIT
Regulator voltage, VZ		V _{ref}	30	٧
Regulator current, IZ		2	100	mA
Operating free-air temperature range, TA	TL430C	0	70	°C
Coperating nee-all temperature range, 14	TL430I	-40	85	



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electrical characteristics over recommended operating conditions, $T_A = 25^{\circ}C$ (unless otherwise noted)

	DADAMETED	TEST	TEGT COMP	ITIONS		TL4300	2		TL430		
	PARAMETER	FIGURE	TEST COND	TEST CONDITIONS		TYP	MAX	MIN	TYP	MAX	UNIT
V _{I(ref)}	Reference input voltage	1	$V_Z = V_{I(ref)}$	I _Z = 10 mA	2.5	2.75	3	2.6	2.75	2.9	V
αV _{I(ref)}	Temperature coefficient of reference input voltage	1	Vz = V _{I(ref)} , T _A = full range†	$I_Z = 10 \text{ mA},$		120			120	200	ppm/°C
I _{I(ref)}	Reference input current	2	I _Z = 10 mA, R2 = ∞	$R1 = 10 \text{ k}\Omega$,		3	10		3	10	μА
IZK	Regulator current near lower knee of regulation range	1	V _Z = V _{I(ref)}			0.5	2		0.5	2	mA
1	Regulator current at maximum	1	$V_Z = V_{I(ref)}$		50			50			
^I ZK	limit of regulation range	2	$V_Z = 5 \text{ V to } 30 \text{ V},$	See Note 3	100			100			mA
rz	Differential regulator resistance (see Note 4)	1	$V_Z = V_{I(ref)},$ $\Delta I_Z = (52 - 2) \text{ mA}$			1.5	3		1.5	3	Ω
				V _Z = 3 V		50			50		
V _n	Noise voltage	2	f = 0.1 Hz to 10 Hz	V _Z = 12 V		200			200		μV
				V _Z = 30 V	T .	650			650		ĺ

† Full temperature range is 0°C to 70°C for the TL430C and -40°C to 85°C for the TL430I.

NOTES: 3. The average power dissipation, $V_Z \bullet I_Z \bullet$ duty cycle, must not exceed the maximum continuous rating in any 10-ms interval.

4. The regulator resistance for $V_Z > V_{I(ref)}$, r_Z , is given by:

$$r_{Z}' = r_{Z} \left(1 + \frac{R1}{R2}\right)$$

electrical characteristics over recommended operating conditions, T_A = 25°C (unless otherwise noted)

	(ref) Reference input current Regulator current near lower knee of regulation range Regulator current at maximum limit of regulation range	TEST	TECT COMP	ITIONS		<i>'</i>	UNIT		
	PARAMETER	FIGURE	TEST COND	ITIONS	MIN	TYP	MAX	ONII	
V _{I(ref)}	Reference input voltage	1	$V_Z = V_{I(ref)}$	$I_Z = 10 \text{ mA}$	2.5	2.75	3	٧	
l(ref)	Reference input current	2	I _Z = 10 mA, R2 = ∞	$R1 = 10 \text{ k}\Omega$,		3	10	μА	
^l zĸ	Regulator current near lower knee of regulation range	1	Vz = V _{I(ref)}			0.5	2	mA	
l=u	Regulator current at maximum limit of regulation	1	$V_Z = V_{I(ref)}$		50			mA	
lzĸ	range	2	$V_Z = 5 \text{ V to } 30 \text{ V},$	See Note 3	100			IIIA	
rz	Differential regulator resistance (see Note 4)	1	$V_Z = V_{I(ref)}, \dots$ $\Delta I_Z = (52 - 2) \text{ mA}$			1.5	3	Ω	
				V _Z = 3 V		50			
V _n	Noise voltage	2	f = 0.1 Hz to 10 Hz	V _Z = 12 V		200		μV	
		l		V _Z = 30 V		650			

NOTES: 3. The average power dissipation, $V_Z \bullet I_Z \bullet$ duty cycle, must not exceed the maximum continuous rating in any 10-ms interval.

4. The regulator resistance for $V_Z > V_{I(ref)}$, r_{Z^*} is given by:

$$r_{z}' = r_{z} \left(1 + \frac{R1}{R2} \right)$$

PARAMETER MEASUREMENT INFORMATION

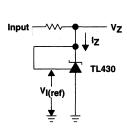


Figure 1. Test Circuit for $V_Z = V_{I(ref)}$

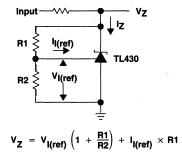


Figure 2. Test Circuit for $V_Z > V_{I(ref)}$

TYPICAL CHARACTERISTICS

SMALL-SIGNAL REGULATOR IMPEDANCE

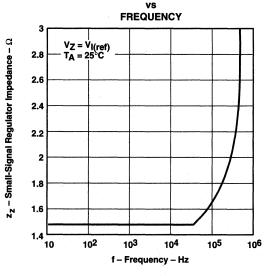


Figure 3

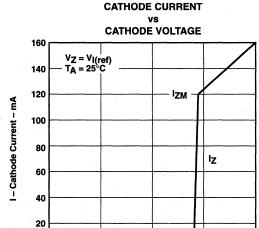


Figure 4

2

V - Cathode Voltage - V

0

0

IZK

3

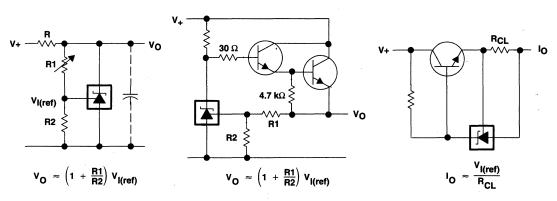


Figure 5. Shunt Regulator

Figure 6. Series Regulator

Figure 7. Current Limiter

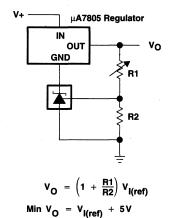


Figure 8. Output Control of a 3-Terminal Fixed Regulator

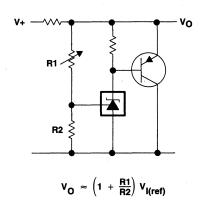


Figure 9. Higher-Current Applications

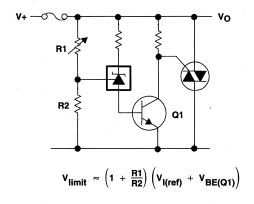


Figure 10. Crowbar

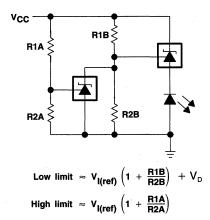


Figure 11. V_{CC} Monitor

TL431C, TL431AC, TL431I, TL431AI, TL431M, TL431Y ADJUSTABLE PRECISION SHUNT REGULATORS

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- Equivalent Full-Range Temperature Coefficient . . . 30 ppm/°C
- 0.2-Ω Typical Output Impedance
- Sink-Current Capability . . . 1 mA to 100 mA
- Low Output Noise
- Adjustable Output Voltage . . . V_{I(ref)} to 36 V
- Available in a Wide Range of High-Density **Packaging Options:**
 - Small Outline (D)
 - TO-226AA (LP)
 - SOT-89 (PK)

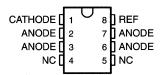
description

The TL431 and TL431A are 3-terminal adjustable shunt regulators with specified thermal stability over applicable automotive, commercial, and military temperature ranges. The output voltage can be set to any value between Vi(ref) (approximately 2.5 V) and 36 V with two external resistors (see Figure 16). These devices have a typical output impedance of 0.2 Ω . Active output circuitry provides a very sharp turn-on characteristic, making these devices excellent replacements for zener diodes in many applications, such as on-board regulation, adjustable power supplies, and switching power supplies.

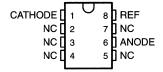
The TL431 is offered in a wide variety of highdensity packaging options that includes an SOT-89-type package (suffix PK).

The TL431C and TL431AC are characterized for operation from 0°C to 70°C, and the TL431I and TL431Al are characterized for operation from -40°C to 85°C. The TL431M is characterized for operation over the full military temperature range of -55°C to 125°C.

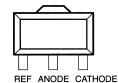
D OR PW PACKAGE (TOP VIEW)



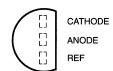
JG OR P PACKAGE (TOP VIEW)



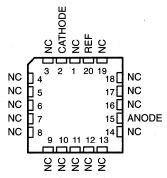
PK PACKAGE (TOP VIEW)



LP PACKAGE (TOP VIEW)



FK PACKAGE (TOP VIEW)



NC-No internal connection

TL431C, TL431AC, TL431I, TL431AI, TL431M, TL431Y ADJUSTABLE PRECISION SHUNT REGULATORS

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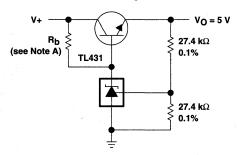
AVAILABLE OPTIONS

	PACKAGED DEVICES										
TA	SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	TO-226AA (LP)	PLASTIC DIP (P)	SOT-89 (PK)	SHRINK SMALL OUTLINE (PW)	CHIP FORM (Y)			
0°C to 70°C	TL431CD TL431ACD			TL431CLP TL431ACLP	TL431CP TL431ACP	TL431CPK	TL431CPW				
-40°C to 85°C	TL431ID TL431AID			TL431ILP TL431AILP	TL431IP TL431AIP	TL431IPK		TL431Y			
-55°C to 125°C		TL431MFK	TL431MJG								

The D and LP packages are available taped and reeled. Add R suffix to device type (e.g., TL431CDR). The PK package is only available taped and reeled (no R suffix required). Chip forms are tested at $T_A = 25^{\circ}C$.

application schematic

5-V Precision Regulator

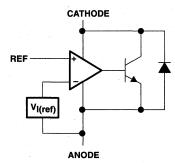


NOTE A: R_b should provide cathode current \geq 1-mA to the TL431.

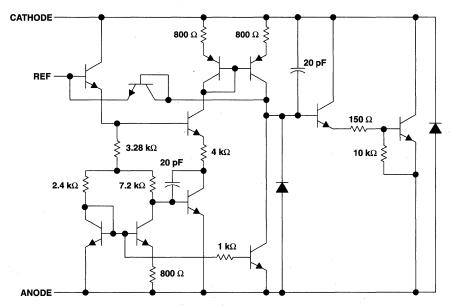
symbol

REF ANODE CATHODE

functional block diagram



equivalent schematic



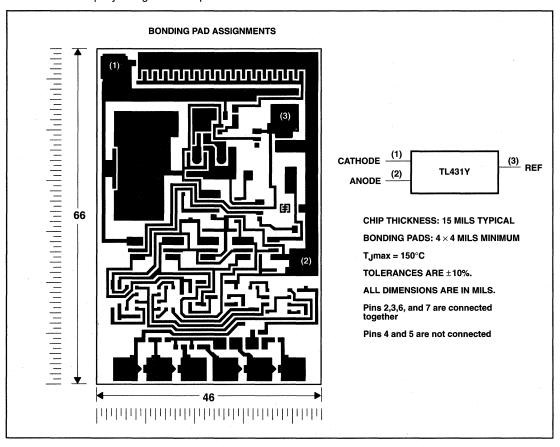
NOTE A: All component values are nominal.

TL431C, TL431AC, TL431I, TL431AI, TL431M, TL431Y ADJUSTABLE PRECISION SHUNT REGULATORS

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TL431Y chip information

This chip, when properly assembled, displays characteristics similar to the TL431C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



TL431C, TL431AC, TL431I, TL431AI, TL431M, TL431Y ADJUSTABLE PRECISION SHUNT REGULATORS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Cathode voltage, V _{KA} (see Note 1)		37	٧
Continuous cathode current range, IKA			Α
Reference input current range		–50 μA to 10 m	Α
Continuous total power dissipation		. See Dissipation Rating Tables 1 and	2
Operating free-air temperature range, TA:	C-suffix	0°C to 70°	С
	I-suffix	–40°C to 85°	С
	M-suffix	–55°C to 125°	С
Storage temperature range, T _{stg}			С
Case temperature for 60 seconds: FK pack			
Lead temperature 1,6 mm (1/16 inch) from	case for 10 seconds: D, I	P, or PW package 260°	С
Lead temperature 1,6 mm (1/16 inch) from	case for 60 seconds: JG,	LP, or PK package 300°	С

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Voltage values are with respect to the anode terminal unless otherwise noted.

DISSIPATION RATING TABLE 1 – FREE-AIR TEMPERATURE

PACKAGE	T _A = 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW	-
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
LP	775 mW	6.2 mW/°C	496 mW	403 mW	_
P	1000 mW	8.0 mW/°C	640 mW	520 mW	
PK	500 mW	4.0 mW/°C	320 mW	260 mW	n, <u>-</u>
PW	525 mW	4.2 mW/°C	336 mW	. <u></u>	

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE

PACKAGE	T _C = 25°C	DERATING FACTOR	T _C = 70°C	T _C = 85°C
	POWER RATING	ABOVE T _C = 25°C	POWER RATING	POWER RATING
PK	3125 mW	25 mW/°C	2000 mW	1625 mW

recommended operating conditions

	MIN	MAX	UNIT
Cathode voltage, V _{KA}	V _{I(ref)}	36	٧
Cathode current, IKA	1	100	mA

electrical characteristics over recommended operating conditions, T_A = 25°C (unless otherwise noted)

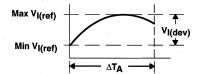
	DADAMETED	TEST	7507	CONDITIONS		TL431C			TL431I			TL431M		
PARAMETER		CIRCUIT	IESI	TEST CONDITIONS		TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
V _{I(ref)}	Reference input voltage	1	V _{KA} = V _{I(ref)} ,	I _{KA} = 10 mA	2440	2495	2550	2440	2495	2550	2400	2495	2600	mV
V _{I(dev)}	Deviation of reference input voltage over full temperature range ‡	1	V _{KA} = V _{I(ref)} , T _A = Full range	I _{KA} = 10 mA,		4	17		5	30		22		mV
ΔV _{I(ref)}	Ratio of change in refer-		10 1	$\Delta V_{KA} = 10 \text{ V} - V_{I(ref)}$		-1.4	-2.7		-1.4	-2.7		-1.4	-3	mV
ΔVKA	ence input voltage to the change in cathode voltage	2	I _{KA} = 10 mA	$\Delta V_{KA} = 36 \text{ V} - 10 \text{ V}$	1.	-1	-2		-1	-2		-1	-2.3	V
I(ref)	Reference input current	2	I _{KA} = 10 mA,	R1 = 10 kΩ, R2 = ∞		2	4		. 2	4		2	8*	μΑ
l(dev)	Deviation of reference input current over full temperature range ‡	2	I _{KA} = 10 mA, T _A = Full range	R1 = 10 kΩ, R2 = ∞,		0.4	1.2		0.8	2.5		1		μА
I _{min}	Minimum cathode current for regulation	1	V _{KA} = V _{I(ref)}			0.4	1		0.4	1		0.4	1.5	m/
loff	Off-state cathode current	3	V _{KA} = 36 V,	V _{I(ref)} = 0		0.1	1		0.1	1		0.1	3	μA
IzKAI	Dynamic impedance§	1	$I_{KA} = 1 \text{ mA to } 1$ $V_{KA} = V_{I/ref}$			0.2	0.5		0.2	0.5		0.2	0.9*	Ω

* On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

† Full temperature range is 0°C to 70°C for the TL431C, -40°C to 85°C for the TL431I, and -55°C to 125°C for the TL431M.

‡ The deviation parameters V_{refl(dev)} and I_{refl(dev)} are defined as the differences between the maximum and minimum values obtained over the rated temperature range. The average full-range temperature coefficient of the reference input voltage, α_{V[(ref)}, is defined as:

$$|\alpha_{VI(ref)}| \; \left(\frac{ppm}{^{\circ}C}\right) = \frac{\left(\frac{V_{I(dev)}}{V_{I(ref)} \; at \; 25^{\circ}C}\right) \times \; 10^{6} }{^{\Delta T}A}$$



PRECISION

where ΔT_A is the rated operating free-air temperature range of the device.

αVI((ref) can be positive or negative depending on whether minimum VI((ref) or maximum VI((ref), respectively, occurs at the lower temperature. Example: Max VI((ref) = 2496 mV at 30°C, Min VI((ref) = 2492 mV at 0°C, VI((ref) = 2495 mV at 25°C, ΔΤ_A = 70°C for TL431C

$$|\alpha_{\text{VI(ref)}}| = \frac{\left(\frac{4 \text{ mV}}{2495 \text{ mV}}\right) \times 10^6}{70^{\circ}\text{C}} \approx 23 \text{ ppm/}^{\circ}\text{C}$$

Because minimum V_{I(ref)} occurs at the lower temperature, the coefficient is positive.

§ The dynamic impedance is defined as:
$$|z_{KA}| = \frac{\Delta V_{KA}}{\Delta I_{KA}}$$

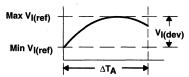
When the device is operating with two external resistors (see Figure 2), the total dynamic impedance of the circuit is given by: $|z'| = \frac{\Delta V}{\Delta I} \approx |z_{KA}| \left(1 + \frac{R1}{R2}\right)$

PARAMETER		TEST	TEST CONDITIONS		TL431AC			TL431AI			
		CIRCUIT			MIN	MIN TYP	MAX	MIN TYP	MAX	UNIT	
V _{I(ref)}	Reference input voltage	1	$V_{KA} = V_{I(ref)}$	I _{KA} = 10 mA	2470	2495	2520	2470	2495	2520	m۷
V _{I(dev)}	Deviation of reference input voltage over full temperature range ‡	1	VKA = V _{I(ref)} , T _A = Full range	I _{KA} = 10 mA,		4	15		5	25	mV
ΔV _{I(ref)}	Ratio of change in reference input voltage to the	2	lice = 10 mA	$\Delta V_{KA} = 10 V - V_{I(ref)}$		-1.4	-2.7		-1.4	-2.7	mV
ΔνκΑ	change in cathode voltage	4	I _{KA} = 10 mA	$\Delta V_{KA} = 36 \text{ V} - 10 \text{ V}$		-1	-2		-1	-2	V
I(ref)	Reference input current	2	I _{KA} = 10 mA,	R1 = 10 k Ω , R2 = ∞		2	4		2	4	μА
I _I (dev)	Deviation of reference input current over full temperature range ‡	2	I _{KA} = 10 mA, T _A = Full range	R1 = 10 kΩ, R2 = ∞,		0.8	1.2		0.8	2.5	μА
I _{min}	Minimum cathode current for regulation	1	V _{KA} = V _{I(ref)}			0.4	0.6		0.4	0.7	mA
loff	Off-state cathode current	3	V _{KA} = 36 V,	V _{I(ref)} = 0		0.1	0.5		0.1	0.5	μА
Iz _{ka} l	Dynamic impedance §	1	$V_{KA} = V_{I(ref)}$, $I_{KA} = 1$ mA to $f \le 1$ kHz	100 mA,		0.2	0.5		0.2	0.5	Ω

†Full temperature range is 0°C to 70°C for the TL431AC and -40°C to 85°C for the TL431AI.

‡ The deviation parameters V_{refl(dev)} and I_{refl(dev)} are defined as the differences between the maximum and minimum values obtained over the rated temperature range. The average full-range temperature coefficient of the reference input voltage, $\alpha_{V|(ref)}$, is defined as:

$$|\alpha_{VI(ref)}| \left(\frac{ppm}{{}^{\circ}C}\right) = \frac{\left(\frac{V_{I(dev)}}{V_{I(ref)} \text{ at } 25{}^{\circ}C}\right) \times 10^{6}}{\Delta T_{A}}$$



where ΔT_A is the rated operating free-air temperature range of the device.

αν(I(ref) can be positive or negative depending on whether minimum V_{I(ref)} or maximum V_{I(ref)}, respectively, occurs at the lower temperature. Example: Max V_{I(ref)} = 2496 mV at 30°C, Min V_{I(ref)} = 2492 mV at 0°C, V_{I(ref)} = 2495 mV at 25°C, ΔT_A = 70°C for TL431AC

$$|\alpha_{\text{VI(ref)}}| = \frac{\left(\frac{4 \text{ mV}}{2495 \text{ mV}}\right) \times 10^6}{70^{\circ}\text{C}} \approx 23 \text{ ppm/}^{\circ}\text{C}$$

Because minimum V_{I(ref)} occurs at the lower temperature, the coefficient is positive.

§ The dynamic impedance is defined as: $|z_{KA}| = \frac{\Delta V_{KA}}{\Delta I_{KA}}$

When the device is operating with two external resistors (see Figure 2), the total dynamic impedance of the circuit is given by: $|z'| = \frac{\Delta V}{\Delta I} \approx |z_{KA}| \left(1 + \frac{R1}{R2}\right)$

ADJUSTABLE PRECISION SHUNT REGULATORS

TL431C, TL431AC, TL431I, TL431AI, TL431M, TL431Y ADJUSTABLE PRECISION SHUNT REGULATORS

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electrical characteristics over recommended operating conditions, $T_A = 25$ °C (unless otherwise noted)

PARAMETER		TEST	TERT	TL431	UNIT		
		CIRCUIT	TEST CONDITIONS		MIN TYP	MAX	ONII
V _{I(ref)}	Reference input voltage	1	$V_{KA} = V_{I(ref)}$	I _{KA} = 10 mA	249	5	mV
ΔV _{I(ref)}	Ratio of change in reference input voltage to the change in cathode voltage	2	I _{KA} = 10 mA	$\Delta V_{KA} = 10 \text{ V} - V_{I(ref)}$	-1.4	ļ .	mV V
ΔV _{I(ref)} ΔV _K A				$\Delta V_{KA} = 36 \text{ V} - 10 \text{ V}$	Ī		
I _{I(ref)}	Reference input current	2	I _{KA} = 10 mA,	R1 = 10 kΩ, R2 = ∞	-	2	μΑ
I _{min}	Minimum cathode current for regulation	1	VKA = V _{I(ref)}		0.4	1	mA
loff	Off-state cathode current	3	V _{KA} = 36 V,	V _{I(ref)} = 0	0.		μΑ
IzKAI	Dynamic impedance†	1	$V_{KA} = V_{I(ref)},$ $f \le 1 \text{ kHz}$	$I_{KA} = 1$ mA to 100 mA,	0.2	2	Ω

[†] The dynamic impedance is defined as: $|z_{ka}| = \frac{\Delta V_{KA}}{\Delta I_{KA}}$

When the device is operating with two external resistors (see Figure 2), the total dynamic impedance of the circuit is given by:

$$|z'| = \frac{\Delta V}{\Delta I} \approx |z_{KA}| \left(1 + \frac{R1}{R2}\right)$$

PARAMETER MEASUREMENT INFORMATION

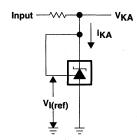


Figure 1. Test Circuit for $V_{KA} = V_{I(ref)}$

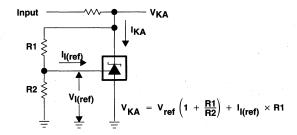


Figure 2. Test Circuit for $V_{KA} > V_{I(ref)}$

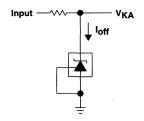


Figure 3. Test Circuit for Ioff

TL431C, TL431AC, TL431I, TL431AI, TL431M, TL431Y ADJUSTABLE PRECISION SHUNT REGULATORS

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TYPICAL CHARACTERISTICS

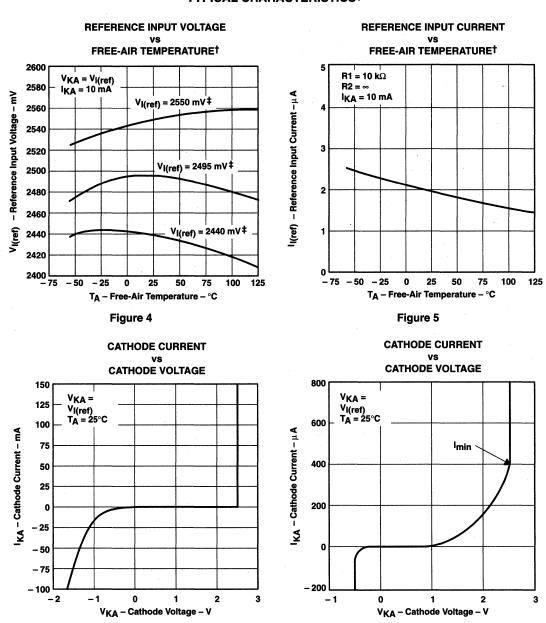
Table of Graphs

			FIGURE
V _{I(ref)}	Reference input voltage	vs Free-air temperature	4
I(ref)	Reference input current	vs Free-air temperature	5
IKA	Cathode current	vs Cathode voltage	6, 7
loff	Off-state cathode current	vs Free-air temperature	8
ΔV _{I(ref)}	Change in reference voltage to change in cathode voltage	vs Free-air temperature	9
Vn	Equivalent input noise voltage	vs Frequency over a 10-second time-period	10, 11
Ay	Small-signal voltage amplification	vs Frequency	12
IzKAI	Reference impedance	vs Frequency	13
	Pulse response		14
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TYPICAL CHARACTERISTICS†



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 6

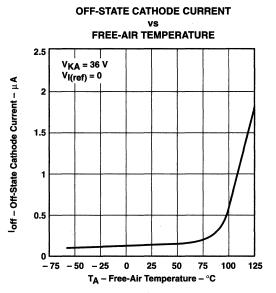


Figure 7

[‡] Data is for devices having the indicated value of $V_{I(ref)}$ at $I_{KA} = 10$ mA, $T_A = 25$ °C.

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TYPICAL CHARACTERISTICS†



RATIO OF DELTA REFERENCE VOLTAGE TO DELTA CATHODE VOLTAGE

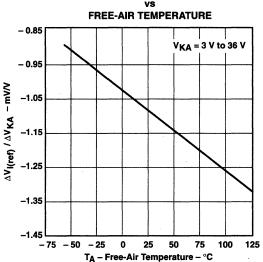


Figure 8 Figure 9

EQUIVALENT INPUT NOISE VOLTAGE

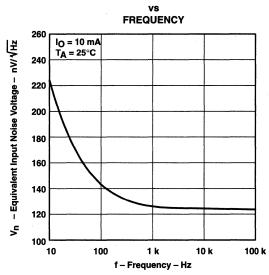


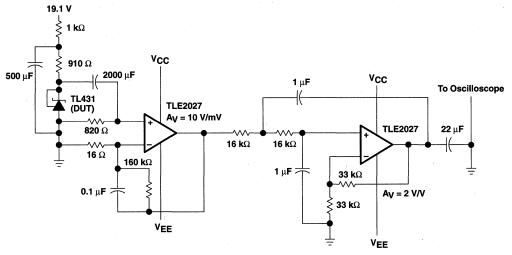
Figure 10

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS

EQUIVALENT INPUT NOISE VOLTAGE OVER A 10-SECOND PERIOD V_{n} - Equivalent Input Noise Voltage - μV -2 -3 f = 0.1 to 10 Hz I_{KA} = 10 mA TA = 25°C 7 2 3 5 6 8: 9 t - Time - s



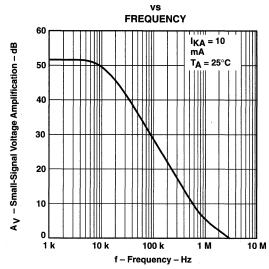
TEST CIRCUIT FOR EQUIVALENT INPUT NOISE VOLTAGE

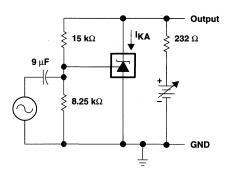
Figure 11

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TYPICAL CHARACTERISTICS

SMALL-SIGNAL VOLTAGE AMPLIFICATION

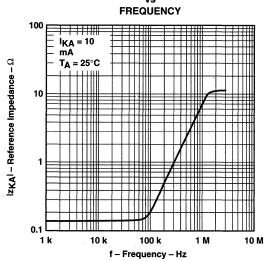


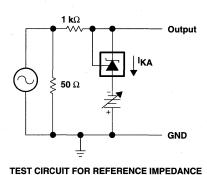


TEST CIRCUIT FOR VOLTAGE AMPLIFICATION

Figure 12

REFERENCE IMPEDANCE vs

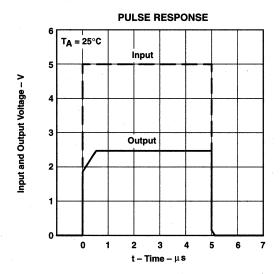


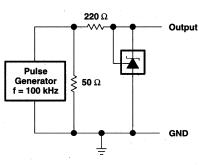


M

Figure 13

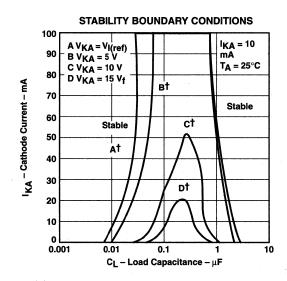
TYPICAL CHARACTERISTICS

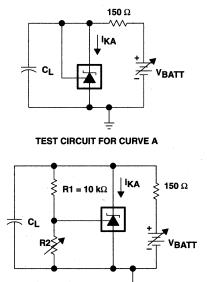




TEST CIRCUIT FOR PULSE RESPONSE

Figure 14





TEST CIRCUIT FOR CURVES B, C, AND D

Figure 15

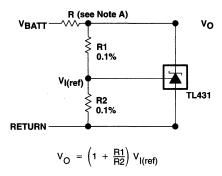
[†] The areas under the curves represent conditions that may cause the device to oscillate. For curves B, C, and D, R2 and V+ were adjusted to establish the initial V_{KA} and I_{KA} conditions with C_L = 0. V_{BATT} and C_L were then adjusted to determine the ranges of stability.



TL431C, TL431AC, TL431I, TL431AI, TL431M, TL431Y ADJUSTABLE PRECISION SHUNT REGULATORS

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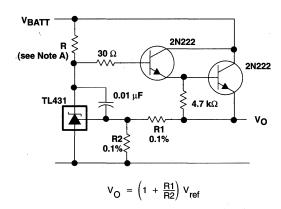


NOTE A: R should provide cathode current ≥ 1-mA to the TL431 at minimum V_{BATT}.

 V_{BATT} V_{O} $V_{O} \approx 2 V$ $V_{Off} \approx V_{BATT}$ $V_{th} \approx 2.5 V$ GND

Figure 17. Single-Supply Comparator With Temperature-Compensated Threshold

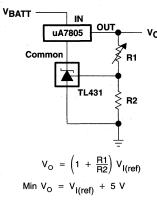
Figure 16. Shunt Regulator



NOTE A: R should provide cathode current ≥ 1-mA to the TL431 at minimum VBATT.

Figure 18. Precision High-Current Series Regulator

APPLICATION INFORMATION



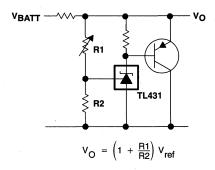
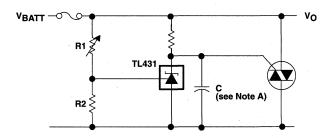


Figure 20. High-Current Shunt Regulator

Figure 19. Output Control of a Three-Terminal Fixed Regulator



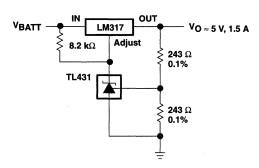
NOTE A: Refer to the stability boundary conditions in Figure 15 to determine allowable values for C.

Figure 21. Crowbar Circuit

TL431C, TL431AC, TL431I, TL431AI, TL431M, TL431Y ADJUSTABLE PRECISION SHUNT REGULATORS

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APPLICATION INFORMATION



VBATT VO \approx 5 V (see Note A) $\begin{array}{c} R_b \\ \hline \\ 11.431 \\ \hline \\ 27.4 \text{ k} \\ \hline \\ 27.4 \text{ k} \\ \hline \\ 0.1\% \\ \end{array}$

Figure 22. Precision 5-V, 1.5-A Regulator

NOTE A. R_b should provide cathode current \geq 1-mA to the TL431.

Figure 23. Efficient 5-V Precision Regulator

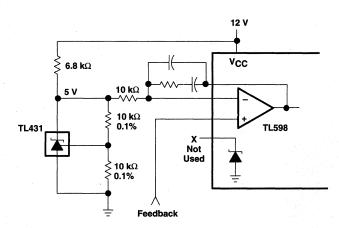
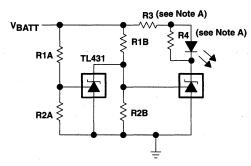


Figure 24. PWM Converter With Reference

APPLICATION INFORMATION



Low Limit =
$$\left(1 + \frac{R1B}{R2B}\right) V_{I(ref)}$$

High Limit =
$$\left(1 + \frac{R1A}{R2A}\right) V_{I(ref)}$$

LED on when

Low Limit $< V_{BATT} < High Limit$

NOTE A: R3 and R4 are selected to provide the desired LED intensity and cathode current ≥ 1 mA to the TL431 at the available V_{BATT}.

Figure 25. Voltage Monitor

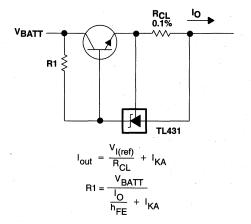


Figure 27. Precision Current Limiter

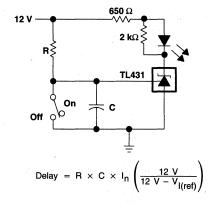


Figure 26. Delay Timer

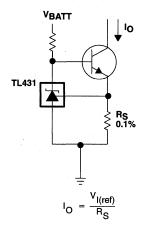


Figure 28. Precision Constant-Current Sink

PW PACKAGE

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- Very Low-Dropout Voltage . . . Less Than 400 mV at 300 mA
- Standby Mode Reduces Current to a Maximum of 150 μA
- Output Regulated to Within ±2% Over Full Temperature Range
- Packaged in Thin Shrink Small-Outline Package
- Only 10-μF Load Capacitor Required to Maintain Regulation at I_O = 300 mA

description

The TL75LPxxQ devices are low-dropout voltage regulators specifically targeted for use in portable applications. These devices generate fixed output voltages at loads of up to 300 mA with only 400-mV dropout over the full temperature range.

Low-dropout voltage regulators are commonly used in battery-powered systems such as analog and digital cellular phones. The TL75LPxx family of regulators feature a TTL/CMOS-compatible enable terminal, which can be used to switch the device into standby mode. This feature reduces power consumption when the instrument is not active. Less that 150 μA is required when the unit is disabled.

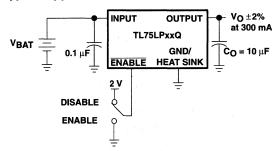
A concern in many new designs is conservation of board space and overall reduction in equipment size. The thin shrink small-outline package (TSSOP) minimizes board area and reduces GND/HEAT SINK 1 20 NC
GND/HEAT SINK 2 19 NC
GND/HEAT SINK 3 18 NC
NC 4 17 NC
NC 5 16 NC

GND/HEAT SINK – These terminals have an internal connection to ground and must be grounded.

NC – No internal connection

†The PW package is only available in left-end taped and reeled (order device TL75LPxxQPWLE).

typical application schematic



component height. This package has a maximum height of less than 1.1 mm (compared to the 1.75 mm of a standard 8-pin SO package) and dimensions of only 6.5 mm by 4.4 mm.

All low-dropout regulators require an external capacitor at the output to maintain regulation and stability. To further reduce board area and cost, the TL75LPxx devices are designed to require a minimum capacitor of only 10 μ F. This is 1/10 the typical value used by many other low-dropout regulators. To simplify the task of choosing a suitable capacitor, TI has included in this datasheet a list of recommended capacitors for use with these devices.

The TL75LPxxQ devices are characterized for operation over $T_{.l} = -40$ °C to 125°C.

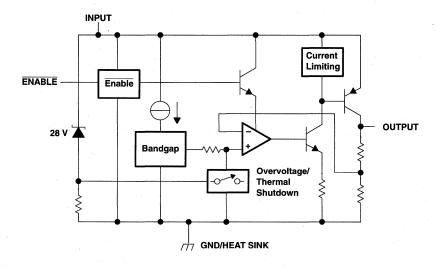
AVAILABLE OPTIONS

		٧o		PACKAGED DEVICES	CHIP FORM
TJ			(Y)		
	4.75	4.85	4.95	TL75LP48QPWLE	TL75LP48Y
	4.9	5	5.1	TL75LP05QPWLE	TL75LP05Y
-40°C to 125°C	7.84	8	8.16	TL75LP08QPWLE	TL75LP08Y
	9.8	10	10.2	TL75LP10QPWLE	TL75LP10Y
	11.76	12	12.24	TL75LP12QPWLE	TL75LP12Y

The PW package is available only in tape and reel. Chip forms are tested at 25°C.

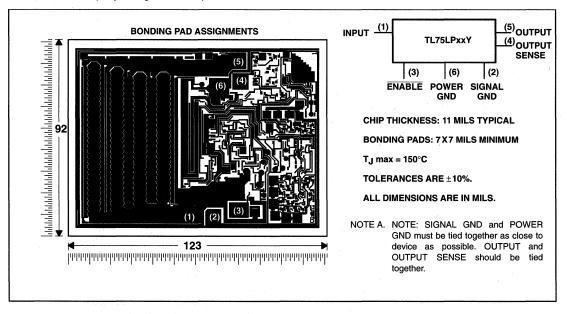


functional block diagram



TL75LPxxY chip information

This chip, when properly assembled, displays characteristics similar to the TL75LPxx. Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} , (See Note 1)	25 V
Output current, I _O	
Operating virtual junction temperature range, T _J	55°C to 150°C
Continuous total power dissipation (see Note 2)	See Dissipation Rating Table
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to network terminal ground.

2. Refer to Figures 1 and 2 to avoid exceeding the design maximum virtual junction temperature; these ratings should not be exceeded. Due to variation in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

DISSIPATION RATING TABLE

PACKAGE	POWER RATING AT	T ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T = 25°C	T = 70°C POWER RATING	T = 85°C POWER RATING	T = 125°C POWER RATING
	TA	828 mW	6.62 mW/°C	530 mW	431 mW	166 mW
PW	TC	4032 mW	32.2 mW/°C	2583 mW	2100 mW	812 mW
	Tp‡	2475 mW	19.8 mW/°C	1584 mW	1287 mW	495 mW

[‡] Re. Ip is the thermal resistance between the junction and the device pin. To determine the virtual junction temperature (T,j) relative to the device pin temperature, the following calculations should be used: $T_J = P_D \times R_{\theta J} p + T_P$, where P_D is the internal power dissipation of the device and T_P is the device pin temperature at the point of contact to the printed wiring board. The ReJP for the TL75LPxx series is 50.5°C/W.

MAXIMUM CONTINUOUS DISSIPATION

FREE-AIR TEMPERATURE

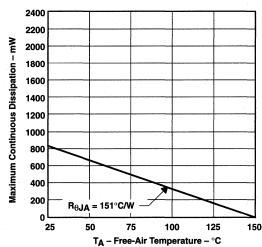


Figure 1

MAXIMUM CONTINUOUS DISSIPATION

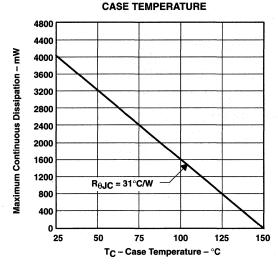


Figure 2

TL75LPxxQ SERIES TL75LPxxY SERIES LOW-DROPOUT VOLTAGE REGULATORS

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recommended operating conditions

		MIN	MAX	UNIT
	TL75LP48	5.15	23.0	
	TL75LP05	5.3	23.0	
Input voltage, V _I	TL75LP08	8.4	23.0	V
	TL75LP10	10.4	23.0	
	TL75LP12	12.5	23.0	
High-level input voltage, ENABLE, VIH		2.0	15.0	V
Low-level input voltage, ENABLE, V _{IL}		0	0.8	V
Output current range, IO		5	300	mA
Operating virtual junction temperature range, TJ		-40	125	°C

<u>electrical</u> characteristics over operating virtual junction temperature range, $V_I = 10 \text{ V}$, $I_O = 300 \text{ mA}$, <u>ENABLE</u> = 0 V (unless otherwise noted)

DADAMETED		TL75LP48Q			
PARAMETER	TEST CONDITIONS†	MIN TYP	MAX	UNIT	
Output voltage	V _I = 5.35 V to 10 V	4.75	4.85	4.95	٧
Input voltage regulation	V _I = 5.35 V to 10 V, T _J = 25°C	٠.	10	25	mV
Ripple rejection	$V_{J} = 5.6 \text{ V to } 15.6 \text{ V}, f = 120 \text{ Hz}, T_{J} = 25^{\circ}\text{C}$	50	55		dB
Output voltage regulation	I _O = 5 mA to 300 mA, T _J = 25°C		12	30	mV
	I _O = 100 mA		0.12	0.2	
Dropout voltage	I _O = 200 mA		0.17	0.3	٧
	I _O = 300 mA		0.22	0.4	
Output noise voltage	f = 10 Hz to 100 kHz, T _J = 25°C		500		μV
	I _O = 10 mA		2.5	4	
Diagrams 4	I _O = 100 mA		4	10	
Bias current	I _O = 200 mA		6	20	mA
	I _O = 300 mA		9	30	
High-level input current, ENABLE	ENABLE = 0.8 V		7	25	μА
Low-level input current, ENABLE	ENABLE = 2 V		0.05	6	μА
Standby current	ENABLE = 2 V		100	150	μА

[†] Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.

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<u>electrical</u> characteristics over operating virtual junction temperature range, $V_I = 10 \text{ V}$, $I_O = 300 \text{ mA}$, <u>ENABLE</u> = 0 V (unless otherwise noted)

DADAMETED		TL75LP05Q			
PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNIT
Output voltage	V _I = 5.5 V to 10 V	4.9	5	5.1	V
Input voltage regulation	V _I = 5.5 V to 10 V, T _J = 25°C		10	25	mV
Ripple rejection	V _I = 6 V to 16 V, f = 120 Hz, T _J = 25°C	50	55	,	dB
Output voltage regulation	I _O = 5 mA to 300 mA, T _J = 25°C		12	30	mV
Dropout voltage	I _O = 100 mA		0.12	0.2	
	I _O = 200 mA		0.17	0.3	٧
	I _O = 300 mA		0.22	0.4	
Output noise voltage	f = 10 Hz to 100 kHz, T _J = 25°C		500		μV
	I _O = 10 mA		2.5	4	
out voltage regulation opple rejection utput voltage regulation oppout voltage utput noise voltage as current gh-level input current, ENABLE w-level input current, ENABLE	I _O = 100 mA		4	10	mA ·
bias current	I _O = 200 mA		6	20	mA
	I _O = 300 mA		9	30	
High-level input current, ENABLE	ENABLE = 0.8 V		7	25	μА
Low-level input current, ENABLE	ENABLE = 2 V		0.05	6	μА
Standby current	ENABLE = 2 V		100	150	μА

[†] Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.

electrical characteristics over operating virtual junction temperature range, $V_I = 10 \text{ V}$, $I_O = 300 \text{ mA}$, ENABLE = 0 V (unless otherwise noted)

DADAMETED		TL	75LP08	Q	UNIT
PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	
Output voltage	V _I = 8.6 V to 15 V	7.84	8	8.16	٧
Input voltage regulation	V _I = 8.6 V to 15 V, T _J = 25°C		12	40	mV
Ripple rejection	$V_{J} = 9 \text{ V to } 19 \text{ V}, \qquad f = 120 \text{ Hz}, T_{J} = 25^{\circ}\text{C}$	50	55		dB
Output voltage regulation	I _O = 5 mA to 300 mA, T _J = 25°C		12	40	mV
	I _O = 100 mA		0.12	0.2	
Dropout voltage	I _O = 200 mA		0.17	0.3	٧
	I _O = 300 mA		0.22	0.4	
Output noise voltage	f = 10 Hz to 100 kHz, T _J = 25°C		500		μV
	I _O = 10 mA		2.5	4	
Bias current	$I_0 = 100 \text{ mA}$		4	10	mA
Bias current	I _O = 200 mA		6	20	mA
	I _O = 300 mA		9	30	
High-level input current, ENABLE	ENABLE = 0.8 V		7	25	μΑ
Low-level input current, ENABLE	ENABLE = 2 V		0.05	6	μΑ
Standby current	ENABLE = 2 V		100	150	μA

[†] Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-µF capacitor across the input and a 10-µF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.



TL75LPxxQ SERIES TL75LPxxY SERIES LOW-DROPOUT VOLTAGE REGULATORS

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<u>electrical</u> characteristics over operating virtual junction temperature range, $V_I = 14 \text{ V}$, $I_O = 300 \text{ mA}$, ENABLE = 0 V (unless otherwise noted)

DADAMETER		TL75LP10Q			UNIT
PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNII
Output voltage	V _I = 10.6 V to 17 V	9.8	10	10.2	٧
Input voltage regulation	V _I = 10.6 V to 17 V, T _J = 25°C		15	43	mV
Ripple rejection	V _I = 11 V to 21 V, f = 120 Hz, T _J = 25°C	50	55		dB
Output voltage regulation	I _O = 5 mA to 300 mA, T _J = 25°C		15	50	mV
	I _O = 100 mA		0.12	0.2	
Dropout voltage	I _O = 200 mA		0.17	0.3	, V
	I _O = 300 mA		0.22	0.4	
Output noise voltage	f = 10 Hz to 100 kHz, T _J = 25°C		1000		μV
	I _O = 10 mA		2.5	4	
Bias current	I _O = 100 mA		4	10	mA
Dias current	I _O = 200 mA		6	20	· IIIA
	I _O = 300 mA		9	30	
High-level input current, ENABLE	ENABLE = 0.8 V		7	25	μΑ
Low-level input current, ENABLE	ENABLE = 2 V		0.05	6	μА
Standby current	ENABLE = 2 V		100	150	μA

[†] Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-µF capacitor across the input and a 10-µF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.

electrical characteristics over operating virtual junction temperature range, $V_I = 14 \text{ V}$, $I_O = 300 \text{ mA}$, ENABLE = 0 V (unless otherwise noted)

PARAMETER		TL	75LP12	Q	
	TEST CONDITIONS†	MIN	TYP	MAX	UNIT
Output voltage	V _I = 12.7 V to 18 V	11.76	12	12.24	٧
Input voltage regulation	V _I = 12.7 V to 18 V, T _J = 25°C		15	43	mV
Ripple rejection	V _I = 13 V to 23 V, f = 120 Hz, T _J = 25°C	50	55		dB
Output voltage regulation	I _O = 5 mA to 300 mA, T _J = 25°C		15	60	mV
	I _O = 100 mA		0.12	0.2	
Dropout voltage	I _O = 200 mA	-	0.17	0.3	٧
	I _O = 300 mA		0.22	0.4	
Output noise voltage	f = 10 Hz to 100 kHz, T _J = 25°C		1000		μV
	I _O = 10 mA		2.5	4	
Di	I _O = 100 mA		. 4	10	3
Bias current	I _O = 200 mA		6	20	mA
	I _O = 300 mA		9	30	
High-level input current, ENABLE	ENABLE = 0.8 V		7	25	μΑ
Low-level input current, ENABLE	ENABLE = 2 V		0.05	6	μА
Standby current	ENABLE = 2 V		100	150	μA

[†] Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-µF capacitor across the input and a 10-µF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.



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electrical characteristics at $V_1 = 10 \text{ V}$, $I_Q = 300 \text{ mA}$, $\overline{\text{ENABLE}} = 0 \text{ V}$, $T_J = 25 ^{\circ}\text{C}$ (unless otherwise noted)

DADAMETER		TL75LF	UNIT	
PARAMETER	TEST CONDITIONS†	MIN TYP 4.85 10 55 12 0.22 500	P MAX	CIVIT
Output voltage		4.8	15	V
Input voltage regulation		1	0	mV
Ripple rejection	f = 120 Hz	5	i5	dB
Output voltage regulation		1	2	mV
Dropout voltage		0.2	22	V
Output noise voltage	f = 10 Hz to 100 kHz	50	0	μV
Bias current			9	mA
High-level input current, ENABLE	ENABLE = 0.8 V		7	μА
Low-level input current, ENABLE	ENABLE = 2 V	• 0.0	15	μΑ
Standby current	ENABLE = 2 V	10	00	μА

[†] Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-µF capacitor across the input and a 10-µF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.

electrical characteristics at $V_1 = 10 \text{ V}$, $I_0 = 300 \text{ mA}$, $\overline{\text{ENABLE}} = 0 \text{ V}$, $T_J = 25 ^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER		TL	UNIT		
PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	CINIT
Output voltage			5	-	V
Input voltage regulation			10		mV
Ripple rejection	f = 120 Hz		55		dB
Output voltage regulation			12		mV
Dropout voltage			0.22	11.00	V
Output noise voltage	f = 10 Hz to 100 kHz		500		μV
Bias current			9		mA
High-level input current, ENABLE	ENABLE = 0.8 V		7		μΑ
Low-level input current, ENABLE	ENABLE = 2 V		0.05		μА
Standby current	ENABLE = 2 V		100		μА

The Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.

TL75LPxxQ SERIES TL75LPxxY SERIES LOW-DROPOUT VOLTAGE REGULATORS

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electrical characteristics at $V_I = 10 \text{ V}$, $I_O = 300 \text{ mA}$, $\overline{\text{ENABLE}} = 0 \text{ V}$, $T_J = 25 ^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED		TL75L	UNIT	
PARAMETER	TEST CONDITIONS†	MIN T	YP MA	C UNII
Output voltage			8	V
Input voltage regulation			12	mV
Ripple rejection	f = 120 Hz		55	dB
Output voltage regulation			12	mV
Dropout voltage		0	.22	V
Output noise voltage	f = 10 Hz to 100 kHz		600	μV
Bias current			9	mA
High-level input current, ENABLE	ENABLE = 0.8 V	:	7	μА
Low-level input current, ENABLE	ENABLE = 2 V	0	.05	μА
Standby current	ENABLE = 2 V		00	μΑ

[†] Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.

electrical characteristics at $V_I = 14 \text{ V}$, $I_O = 300 \text{ mA}$, $\overline{\text{ENABLE}} = 0 \text{ V}$, $T_J = 25 ^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER		TL	UNIT		
PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNII
Output voltage			10		V
Input voltage regulation			15		:.ıV
Ripple rejection	f = 120 Hz		55		dB
Output voltage regulation			15		mV
Dropout voltage			0.22		V
Output noise voltage	f = 10 Hz to 100 kHz		1000		μV
Bias current			9		mA
High-level input current, ENABLE	ENABLE = 0.8 V		7		μА
Low-level input current, ENABLE	ENABLE = 2 V		0.05		μΑ
Standby current	ENABLE = 2 V		100		μΑ

[†] Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.

TL75LPxxQ SERIES TL75LPxxY SERIES LOW-DROPOUT VOLTAGE REGULATORS

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electrical characteristics at $V_I = 14 \text{ V}$, $I_O = 300 \text{ mA}$, $\overline{\text{ENABLE}} = 0 \text{ V}$, $T_J = 25 ^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER		TL75LP12Y			UNIT
PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNII
Output voltage		11.76	12	12.24	٧
Input voltage regulation			15	43	mV
Ripple rejection	f = 120 Hz		55		dB
Output voltage regulation			12	60	mV
Dropout voltage			0.22	0.4	٧
Output noise voltage	f = 10 Hz to 100 kHz		500		μV
Bias current			9	30	mA
High-level input current, ENABLE	ENABLE = 0.8 V		7	25	μА
Low-level input current, ENABLE	ENABLE = 2 V		0.05	6	μΑ
Standby current	ENABLE = 2 V		100	150	μΑ

[†] Pulse-testing techniques maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor with equivalent series resistance within the guidelines shown in Figures 3 and 4 on the output. All measurements are taken with a tantalum electrolytic capacitor. Although not normally recommended, an aluminum electrolytic capacitor can be used. Attention must be given its ESR value, particularly at low temperatures.

PARAMETER MEASUREMENT INFORMATION

The TL75LPxx series are low-dropout voltage regulators. This means that the capacitance is important to the performance of the regulator because it is a vital part of the control loop. The capacitor value and the equivalent series resistance (ESR) both affect the control loop and must be defined for the load range and the temperature range. Figures 3 and 4 can establish the capacitance value and ESR range for optimum regulator performance.

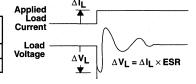
Figure 3 shows the recommended range of ESR, measured at 120 Hz, for a given load with a $10-\mu F$ capacitor on the output. In addition, it shows a maximum ESR limit of 2Ω and a load-dependent minimum ESR limit.

For applications with varying loads, the lightest load condition should be chosen since it is the worst case. Figure 4 shows the relationship of the reciprocal of ESR to the square root of the capacitance with a minimum capacitance limit of 10 μ F and a maximum ESR limit of 2 Ω . Figure 4 establishes the amount that the minimum ESR limit of Figure 3 can be adjusted for different capacitor values. For example, when the minimum load needed is 200 mA, Figure 3 suggests an ESR range of 0.8 Ω to 2 Ω for 10 μ F. Figure 4 shows that changing the capacitor from 10 μ F to 400 μ F can change the ESR minimum by greater than 3/0.5 (or 6). Therefore, the new minimum ESR value is 0.8/6 (or 0.13 Ω). This now allows an ESR range of 0.13 Ω to 2 Ω . This expanded ESR range is achieved by using a larger capacitor at the output. For better stability in low-current applications, it is recommended that a small resistance be placed in series with the capacitor (see Table 1) so that the ESR better approximates those in Figures 3 and 4.

Table 1. Compensations for Increased Stability at Low Currents

MANUFACTURER	CAPACITANCE	ESR TYP	PART NUMBER	ADDITIONAL RESISTANCE
AVX	15 μF	0.9 Ω	TAJB156M010S	1 Ω
KEMET	33 μF	0.6 Ω	T491D336M010AS	0.5 Ω

OUTPUT CAPACITOR
EQUIVALENT SERIES RESISTANCE



OUTPUT CAPACITOR

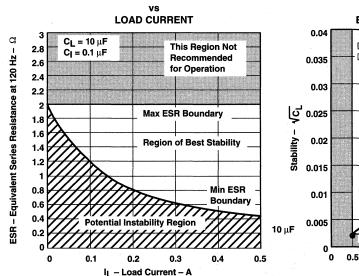


Figure 3

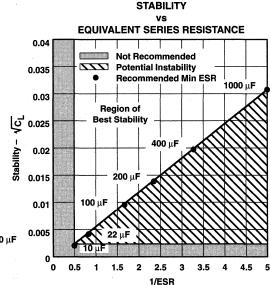


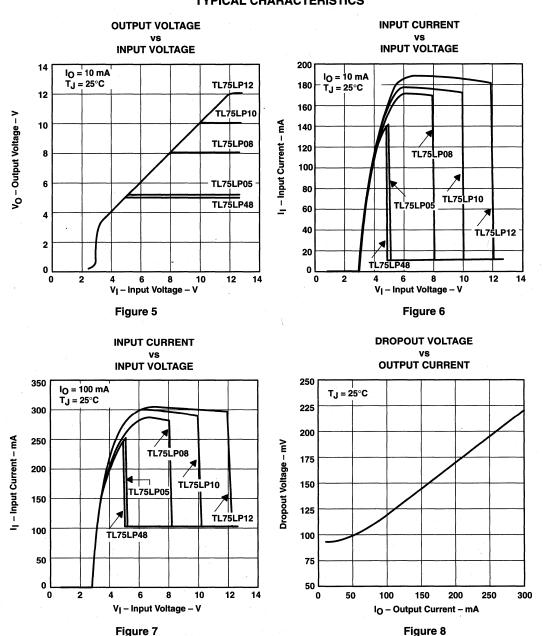
Figure 4

TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
Output voltage		vs Input voltage	5
Input current	I _O = 10 mA	vs Input voltage	6
Input current	I _O = 100 mA	vs Input voltage	7
Dropout voltage		vs Output current	8
Quiescent current		vs Output current	9
Short-circuit protection conditions	output voltage	vs Output current	10
Load transient response			11
Line transient response			12

TYPICAL CHARACTERISTICS





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TYPICAL CHARACTERISTICS

Vo - Output Voltage - V

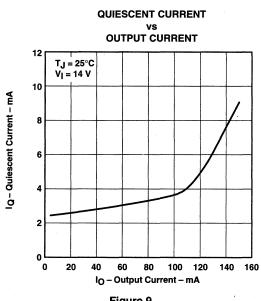


Figure 9

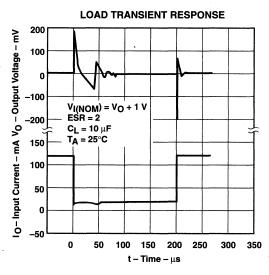


Figure 11

TL75LP05 SHORT-CIRCUIT PROTECTION CONDITIONS **OUTPUT VOLTAGE**



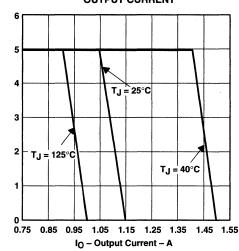


Figure 10

LINE TRANSIENT RESPONSE

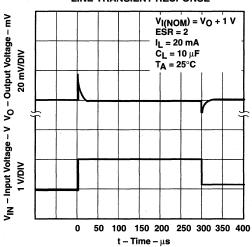


Figure 12

TL750L, TL751L SERIES TL751L05M, TL751L12M, TL750LxxY LOW-DROPOUT VOLTAGE REGULATORS

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- Very Low Dropout Voltage, Less Than 0.6 V at 150 mA
- Very Low Quiescent Current
- TTL- and CMOS-Compatible Enable on TL751L Series, TL751L05M, and TL751L12M
- 60-V Load-Dump Protection

- Reverse Transient Protection to -50 V
- Internal Thermal Overload Protection
- Overvoltage Protection
- Internal Overcurrent Limiting Circuitry
- Less Than 500-μA Disable (TL751L Series, TL75L05M, and TL75L12M)

description

The TL750L and TL751L series and the TL751L05M and TL751L12M are low-dropout positive voltage regulators specifically designed for battery-powered systems. These devices incorporate overvoltage and current-limiting protection circuitry along with internal reverse-battery protection circuitry to protect both itself and the regulated system. Both the series and the TL751L05M and TL751L12M are fully protected against 60-V load-dump and reverse-battery conditions. Extremely low quiescent current during full-load conditions makes these devices ideal for standby power systems.

The TL750L series of fixed-output voltage regulators offer 5-V, 8-V, 10-V, and 12-V options. They are available in TO-226AA (formerly TO-92) (LP) packages, TO-220AB (KC) packages, 8-pin small-outline plastic packages (D), and 8-pin plastic dual-in-line packages (P).

The TL751L series of fixed-output voltage regulators offer 5-V, 8-V, 10-V, and 12-V options with the addition of an enable input. The enable input, when taken high, places the regulator output in a high-impedance state. This gives the designer complete control over power up, power down, or emergency shut down. This series is offered in the 8-pin small-outline plastic package and the 8-pin plastic dual-in-line package.

The TL751L05M and TL751L12M fixed-output voltage regulators also offer 5-V and 12-V options with an enable input. The enable input, when taken high, places the regulator output in a high-impedance state. This gives the designer complete control over power up, power down, or emergency shut down. The TL751LxM is offered in the FK and JG package.

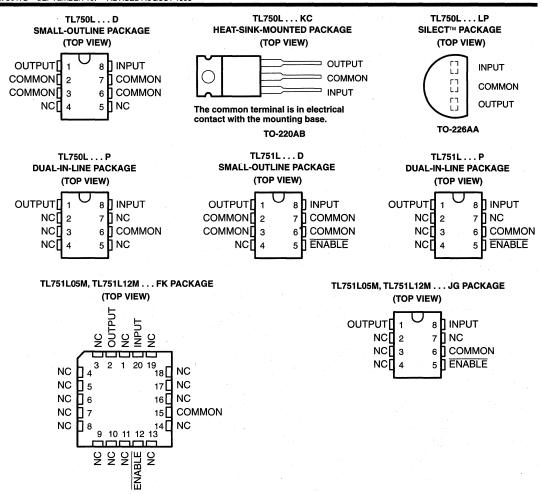
AVAILABLE OPTIONS

				PACKAGE	DEVICES			CHIP
TA	V _O typ AT 25°C	SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	TO-220AB (KC)	TO-226AA (LP)	CERAMIC FLATPACK (P)	FORM (Y)
	5V	TL750L05CD TL751L05CD			TL750L05CKC	TL750L05CLP	TL750L05CP TL751L05CP	TL750L05Y
0°C to	8V	TL750L08CD TL751L08CD		_	TL750L08CKC	TL750L08CLP	TL750L08CP TL751L08CP	TL750L08Y
125°C	10V	TL750L10CD TL751L10CD	, -	-	TL750L10CKC	TL750L10CLP	TL750L10CP TL751L10CP	TL750L10Y
	12V	TL750L12CD TL751L12CD			TL750L12CKC	TL750L12CLP	TL750L12CP TL751L12CP	TL750L12Y
	5V	TL750L05QD TL751L05QD	-	_	TL750L05QKC	TL750L05QLP	TL750L05QP TL751L05QP	_
-40°C to	8V	TL750L08QD TL751L08QD	_		TL750L08QKC	TL750L08QLP	TL750L08QP TL751L08QP	_
125°C	10V	TL750L10QD TL751L10QD		-	TL750L10QKC	TL750L10QLP	TL750L10QP TL751L10QP	
	12V	TL750L12QD TL751L12QD	_	_	TL750L12QKC	TL750L12QLP	TL750L12QP TL751L12QP	. —
−55°C to	5V		TL751L05MFK	TL751L05MJG				
125°C	12V		TL751L12MFK	TL751L12MJG				_



TL750L, TL751L SERIES TL751L05M, TL751L12M, TL750LxxY LOW-DROPOUT VOLTAGE REGULATORS

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NC-No internal connection

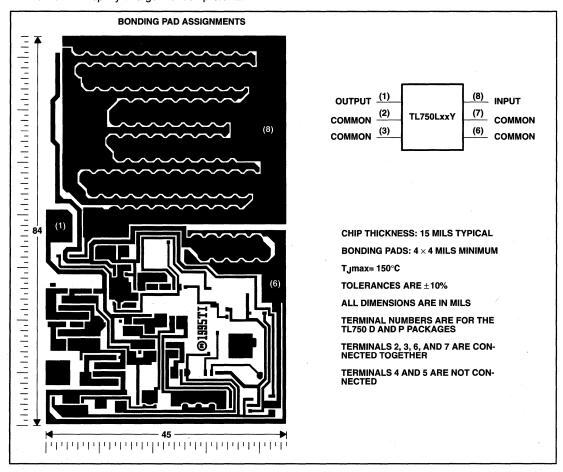
ACTUAL DEVICE COMPONENT COUNT					
Transistors	20				
JFET	2				
Diodes	5				
Resistors	16				

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TL750LxxY chip information

These chips, when properly assembled, display characteristics similar to the TL750LxxC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



TL750L, TL751L SERIES TL751L05M, TL751L12M, TL750LxxY LOW-DROPOUT VOLTAGE REGULATORS

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absolute maximum ratings over operating junction temperature range (unless otherwise noted)

	TL750L	TL751L TL751L_M	UNIT
Continuous input voltage	26	26	V
Transient input voltage, T _A = 25°C (see Note 1)	60	60	٧
Continuous reverse input voltage	-15	-15	V
Transient reverse input voltage: t ≤ 100 ms	-50	-50	٧
Continuous total power dissipation	See Dissipation	on Rating Table	
Operating virtual junction temperature range, TJ	-40 to 150	-40 to 150	°C
Storage temperature range, T _{Stg}	-65 to 150	-65 to 150	°C
Lead temperature 1,6 mm (1/16 inch) for 10 seconds	260	260	°C

NOTE 1: The transient input voltage rating applies for the waveform described in Figure 1.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	825 mW	6.6 mW/°C	528 mW	429 mW
FK	1375 mW	11.0 mW/°C	880 mW	715 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW
KC	2000 mW	15.2 mW/°C	1316 mW	1088 mW
LP	775 mW	6.2 mW/°C	496 mW	403 mW
Р	1000 mW	8.0 mW/°C	640 mW	520 mW

recommended operating conditions over recommended operating junction temperature range (unless otherwise noted)

	(MIN	MAX	UNITS
		TL75_L05 and TL751L05M	. 6	26	
Input voltage, V _I		TL75_L08	9	26	v
	•	TL75_L10	11	26	l v
		TL75_L12 and TL751L12M	13	26	
High-level ENABLE input voltage, VIH		TL751L and TL751L_M	2	15	٧
L. L. LENARIE L. V. T	T _A = 25°C	 TL751L and TL751L_M	-0.3	0.8	V
Low-level ENABLE input voltage, V _{IL} †	T _A = Full range	TL751L and TL751L_M	-0.15	0.8	· V
Output current range, IO		TL75_L and TL751L_M	0	150	mA
		 TL75_L_C	0	125	
Operating virtual junction temperature, TJ		TL75_L_Q	-40	125	°C .
		TL751L_M	-55	125	

[†] The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for ENABLE voltage levels and temperature only.

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electrical characteristics, $V_I = 14 \text{ V}$, $I_O = 10 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	7	TEST CONDITIONS‡				TL750L05, TL751L05 TL751L05M			
				MIN	TYP	MAX			
0	V _I = 6 V to 26 V	I _O = 0 to 150 mA	T _J = 25°C	4.80	5	5.2	v		
Output voltage		T _J = T _J min to 125°C	4.75		5.25	\ \			
Input regulation voltage	V _I = 9 V to 16 V				. 5	10	\/		
	V _I = 6 V to 26 V				6	30	mV		
Ripple rejection	$V_1 = 8 \text{ V to } 18 \text{ V},$	f = 120 Hz		60*	65		dB		
Output regulation voltage	I _O = 5 mA to 150 mA				20	50	mV		
Dropout voltono	I _O = 10 mA					0.2	V		
Dropout voltage	I _O = 150 mA					0.6	\ \		
Output noise voltage	f = 10 Hz to 100 kHz				500		μV		
	I _O = 150 mA				10	12			
Input bias current	$V_{I} = 6 \text{ V to } 26 \text{ V},$	I _O = 10 mA,	T _J = T _J min to 125°C		1	2	mA		
	ENABLE > 2 V					0.5			

^{*}On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

PARAMETER	_	TEST CONDITIONS [‡]			TL750L08, TL751L08		
FANAMETER					TYP	MAX	UNIT
Output voltage	V. 0.V to 00.V	IV = 9 V to 26 V O = 0 to 150 mA	T _J = 25°C	7.68	8	8.32	V
	V = 9 V 10 20 V		T _J = T _J min to 125°C	7.6		8.4	V
Input regulation valtage	V _I = 10 V to 17 V				10	20	
Input regulation voltage	V _I = 9 V to 26 V				25	50	mV
Ripple rejection	V _I = 11 V to 21 V,	f = 120 Hz		60*	65		dB
Output regulation voltage	I _O = 5 mA to 150 mA				40	80	mV
Dranautualtaga	I _O = 10 mA					0.2	V
Dropout voltage	I _O = 150 mA					0.6	V
Output noise voltage	f = 10 Hz to 100 kHz				500		μV
Input bias current	I _O = 150 mA				10	12	
	V _I = 9 V to 26 V,	V _I = 9 V to 26 V, I _O = 10 mA, T _J = T _J min to 125°C			1	2	mA
	ENABLE > 2 V					0.5	

^{*}On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

[‡] Pulse-testing techniques are used to maintain the junction temperature as closes to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor, with equivalent series resistance of less than 1 Ω across the output.

[‡] Pulse-testing techniques are used to maintain the junction temperature as closes to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor, with equivalent series resistance of less than 1 Ω across the output.

TL750L, TL751L SERIES TL751L05M, TL751L12M, TL750LxxY LOW-DROPOUT VOLTAGE REGULATORS

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electrical characteristics, $V_I = 14 \text{ V}$, $I_O = 10 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED		TEST CONDITIONS‡			TL750L10, TL751L10		
PARAMETER					TYP	MAX	UNIT
Output voltage	V _I = 11 V to 26 V	I _O = 0 to 150 mA	T _J = 25°C	9.6	10	10.4	V
	V = 11 V 10 26 V	10 = 0 to 150 my	T _J = T _J min to 125°C	9.5		10.5	V
Innut regulation valtage	V _I = 12 V to 19 V				10	25	mV
Input regulation voltage	V _I = 11 V to 26 V				30	60	1117
Ripple rejection	V _I = 12 V to 22 V,	f = 120 Hz		60	65		dB
Output regulation voltage	I _O = 5 mA to 150 mA				50	100	mV
December	I _O = 10 mA					0.2	V
Dropout voltage	I _O = 150 mA					0.6	V
Output noise voltage	f = 10 Hz to 100 kHz				700		μV
Input bias current	I _O = 150 mA				10	12	4.
	$V_{\parallel} = 11 \text{ V to } 26 \text{ V},$	l _O = 10 mA,	T _J = T _J min to 125°C		. 1	2	mA
	ENABLE > 2 V					0.5	0.5

[†] Pulse-testing techniques are used to maintain the junction temperature as closes to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a $0.1-\mu F$ capacitor across the input and a $10-\mu F$ capacitor, with equivalent series resistance of less than 1 Ω across the output.

PARAMETER	TEST CONDITIONS			TL750L12, TL751L12 TL751L12M			UNIT
				MIN	TYP	MAX 12.48 12.6 30 40 120 0.2 0.6	
Output valtage	V _I = 13 V to 26 V	I- 040 150 A	T _J = 25°C	11.52	12	12.48	V
Output voltage	VI = 13 V 10 20 V 10 =	$I_0 = 0 \text{ to } 150 \text{ mA}$	T _J = T _J min to 125°C	11.4		12.6	V
land resultation veltage	V _I = 14 V to 19 V				15	30	\/
Input regulation voltage	V _I = 13 V to 26 V				20	20 40	mV
Ripple rejection	V _I = 13 V to 23 V,	f = 120 Hz		50*	55		dB
Output regulation voltage	I _O = 5 mA to 150 mA				50	120	mV
Dropout voltoge	I _O = 10 mA					0.2	V
Dropout voltage	IO = 150 mA					MAX 12.48 12.6 30 40 120 0.2 0.6	٧
Output noise voltage	f = 10 Hz to 100 kHz				700		μV
	I _O = 150 mA				10	12	
Input bias current	V _I = 13 V to 26 V,	I _O = 10 mA,	T _J = T _J min to 125°C		1	2	mA
	ENABLE > 2 V					0.5	

^{*}On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

[†] Pulse-testing techniques are used to maintain the junction temperature as closes to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-µF capacitor across the input and a 10-µF capacitor, with equivalent series resistance of less than 1 Ω across the output.

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electrical characteristics V_I = 14 V, I_O = 10 mA, T_J = 25°C (unless otherwise noted)

DADAMETED	TEGT COMPLICATED	TL750L05Y	LINUT	
PARAMETER	TEST CONDITIONS‡	MIN TYP MAX	UNIT	
Output voltage	V _I = 6 V to 26 V I _O = 0 to 150 mA	5	V	
land Annual Asian walks as	V _I = 9 V to 16 V	5	mV	
Input regulation voltage	V _I = 6 V to 26 V	6		
Ripple rejection	V _I = 8 V to 18 V, f = 120 Hz	65	dB	
Output regulation voltage	I _O = 5 mA to 150 mA	20	mV	
Output noise voltage	f = 10 Hz to 100 kHz	500	μV	
Input bias current	I _O = 150 mA	10	mA	
Input bias current	$V_1 = 6 \text{ V to } 26 \text{ V}, I_0 = 10 \text{ mA}$	1	'''^	

[†] Pulse-testing techniques are used to maintain the junction temperature as closes to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor, with equivalent series resistance of less than 1 Ω across the output.

DADAMETED	TEST CONDITIONS			TL750L08Y		
PARAMETER				TYP	MAX	UNIT
Output voltage	V _I = 9 V to 26 V	I _O = 0 to 150 mA		8		٧
land to a substitute of the su	V _I = 10 V to 17 V		10			mV
Input regulation voltage	V _I = 9 V to 26 V			25		mv
Ripple rejection	V _I = 11 V to 21 V,	f = 120 Hz		65		dB
Output regulation voltage	I _O = 5 mA to 150 mA			40		mV
Output noise voltage	f = 10 Hz to 100 kHz			500		μV
Input bias current	I _O = 150 mA			10		mA
Imput bias current	$V_1 = 9 \text{ V to } 26 \text{ V},$	I _O = 10 mA		1		. 1116

[‡] Pulse-testing techniques are used to maintain the junction temperature as closes to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor, with equivalent series resistance of less than 1 Ω across the output.

TL750L, TL751L SERIES TL751L05M, TL751L12M, TL750LxxY LOW-DROPOUT VOLTAGE REGULATORS

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electrical characteristics, $V_I = 14 \text{ V}$, $I_O = 10 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEST CONDITIONS	TL750L10Y	UNIT
PARAMETER	TEST CONDITIONS+	MIN TYP MAX	UNII
Output voltage	V _I = 11 V to 26 V I _O = 0 to 150 m	nA 10	V
I	V _I = 12 V to 19 V	10	mV
Input regulation voltage	V _I = 11 V to 26 V	30	mv
Ripple rejection	V _I = 12 V to 22 V, f = 120 Hz	65	dB
Output regulation voltage	I _O = 5 mA to 150 mA	50	mV
Output noise voltage	f = 10 Hz to 100 kHz	700	μV
Input bias current	I _O = 150 mA	10	mA
	$V_I = 11 \text{ V to } 26 \text{ V}, \qquad I_O = 10 \text{ mA}$	1	1

[†] Pulse-testing techniques are used to maintain the junction temperature as closes to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor, with equivalent series resistance of less than 1 Ω across the output.

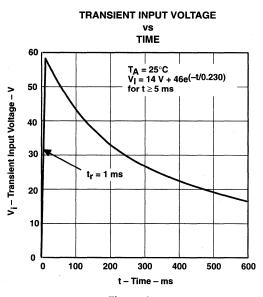
DADAMPTOD	TEGT COME	TEST CONDITIONS			TL750L12Y			
PARAMETER	TEST COND				MAX	UNIT		
Output voltage	V _I = 13 V to 26 V	l _O = 0 to 150 mA		12		V		
Innut was dation walters	V _I = 14 V to 19 V			15				
Input regulation voltage	V _I = 13 V to 26 V			20		mV		
Ripple rejection	V _I = 13 V to 23 V,	f = 120 Hz		55		dB		
Output regulation voltage	I _O = 5 mA to 150 mA			50		- mV		
Output noise voltage	f = 10 Hz to 100 kHz			700		μV		
Input bias current	I _O = 150 mA		10		e.	mA		
input bias current	$V_1 = 13 \text{ V to } 26 \text{ V},$	l _O = 10 mA		1] '''A		

[†] Pulse-testing techniques are used to maintain the junction temperature as closes to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF capacitor, with equivalent series resistance of less than 1 Ω across the output.



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TYPICAL CHARACTERISTICS

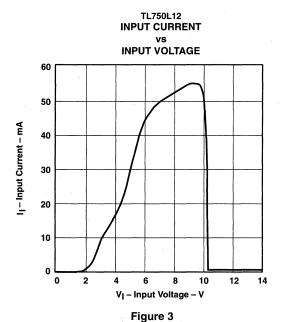


TL750L05
INPUT CURRENT
vs
INPUT VOLTAGE

40
35
30
25
20
0 1 2 3 4 5 6
V_I – Input Voltage – V

Figure 1

Figure 2





TL750M, TL751M SERIES LOW-DROPOUT VOLTAGE REGULATORS

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- Very Low Dropout Voltage, Less Than 0.6 V at 750 mA
- Low Quiescent Current
- TTL- and CMOS-Compatible Enable on TL751M Series
- 60-V Load-Dump Protection
- Overvoltage Protection
- Internal Thermal Overload Protection
- Internal Overcurrent Limiting Circuitry

description

The TL750M and TL751M series are low-dropout positive voltage regulators specifically designed for battery-powered systems. The TL750M and TL751M incorporate on-board overvoltage and current-limit protection circuitry to protect both themselves and the regulated system. Both series are fully protected against 60-V load-dump and reverse battery conditions. Extremely low quiescent current, even during full-load conditions, makes the TL750M and TL751M series ideal for standby power systems.

The TL750M series of fixed-output voltage regulators offer 5-V, 8-V, 10-V, and 12-V options available in 3-lead KC (TO-220AB) and KTE plastic packages.

The TL751M series of fixed-output voltage regulators also offer 5-V, 8-V, 10-V, and 12-V options with the addition of an enable input. The enable input gives the designer complete control over power up, allowing sequential power up or emergency shutdown. When taken high, the enable input places the regulator output in a high-impedance state. It is completely TTL- and CMOS-compatible. The TL751M series is offered in 5-lead KC and KTG plastic packages.

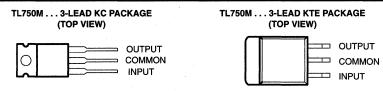
The TL750MxxC and TL751MxxC are characterized for operation from 0°C to 125°C virtual junction temperature, and the TL750MxxQ and TL751MxxQ series are characterized for operation from –40°C to 125°C virtual junction temperature.

AVAILABLE OPTIONS

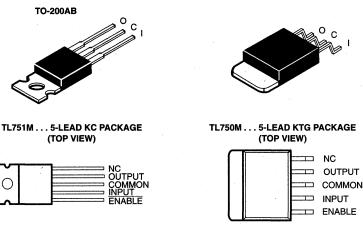
	PACKAGED DEVICES							
TJ	V _O TYP (V)	HEAT-SINK MOUNTED (3-PIN) (KC)	HEAT-SINK MOUNTED (5-PIN) (KC)	PLASTIC FLANGE-MOUNT (KTE)	PLASTIC FLANGE-MOUNT (KTG)	CHIP FORM (Y)		
	5	TL750M05CKC	TL751M05CKC	TL750M05CKTG	TL751M05CKTG	TL750M05Y		
000 +- 10500	8	TL750M08CKC	TL751M08CKC	TL750M08CKTG	TL751M08CKTG	TL750M08Y		
0°C to 125°C	10	TL750M10CKC	TL751M10CKC	TL750M10CKTG	TL751M10CKTG	TL750M10Y		
	12	TL750M12CKC	TL751M12CKC	TL750M12CKTG	TL751M12CKTG	TL750M12Y		
	5	TL750M05QKC	TL751M05QKC	TL750M05QKTG	TL751M05QKTG			
-40°C to 125°C	8	TL750M08QKC	TL751M08QKC	TL750M08QKTG	TL751M08QKTG			
-40 C to 125 C	. 10	TL750M10QKC	TL751M10QKC	TL750M10QKTG	TL751M10QKTG	· —		
	12	TL750M12QKC	TL751M12QKC	TL750M12QKTG	TL751M12QKTG			

TL750M, TL751M SERIES LOW-DROPOUT VOLTAGE REGULATORS

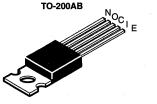
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NOTE A: The common terminal is in electrical contact with the mounting base.



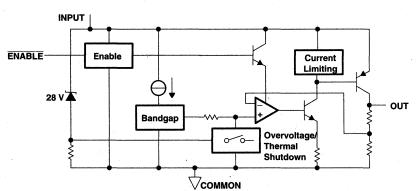
NOTE A: The common terminal is in electrical contact with the mounting base.



NC - No internal connection



TL751Mxx functional block diagram



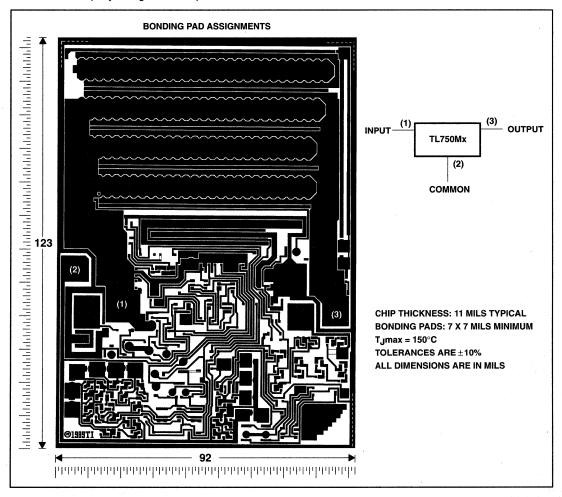
ACTUAL DEVICE COMPONENT COUNT					
Transistors	46				
Diodes	14				
Resistors	44				
Capacitors	4				
JFET	1				
Tunnels (emitter R)	2				



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TL750MxxY chip information

This chip, when properly assembled, displays characteristics similar to the TL750MxxC. Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



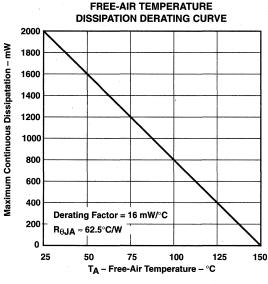
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absolute maximum ratings over virtual junction temperature range (unless otherwise noted)†

Continuous input voltage
Transient input voltage (see Figure 5) 60 V
Continuous reverse input voltage
Transient reverse input voltage: t = 100 ms
Continuous total power dissipation at (or below) 25°C free-air temperature (see Note 1) 2 W
Continuous total power dissipation at (or below) 40°C case temperature (see Note 1)
Operating free-air, T _A , case, T _C , or virtual junction, T _J , temperature range –40°C to 150°C
Storage temperature range, T _{stq} –65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: For operation above $T_A = 25^{\circ}C$ and $T_C = 40^{\circ}C$, refer to Figures 1 and 2. To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded. Due to variation in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.



CASE TEMPERATURE DISSIPATION DERATING CURVE 25 Maximum Continuous Dissipation - W 20 15 10 5 Derating Factor = 181.8 mW/°C Above 40°C R₀JC ≈ 5.5°C/W 150 25 75 100 125 50 T_C - Case Temperature - °C

Figure 1

Figure 2

recommended operating conditions over recommended virtual junction temperature range

	:		MIN	MAX	UNIT
		TL75xM05	6	26	
Innut voltage range V		TL75xM08	9	26	V
Input voltage range, V _I		TL75xM10	11	26	v
		TL75xM12	13	26	
High-level ENABLE input voltage, VIH		TL751Mxx	2	15	V
Low-level ENABLE input voltage, VIL		TL751Mxx	0 -	0.8	·V
Output current range, IO				750	mA
Operating virtual junction temperature range. T.		TL75xMxxC	0	125	°C
Operating virtual junction temperature range, T _J		TL75xMxxQ	-40	125	-0

TL750M, TL751M SERIES LOW-DROPOUT VOLTAGE REGULATORS

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electrical characteristics, V_I = 14 V, I_O = 300 mA, ENABLE at 0 V for TL751M05, T_J = 25°C (unless otherwise noted) (see Note 2)

PARAMETER		TEST CONDITIONS			TL750M05, TL751M05		
PARAMETER					TYP	MAX	UNIT
Output voltage	V _I = 6 V to 26 V,	lo - 0 m4 to 750 m4	T _J = 25°C	4.9	5	5.1	v
	V = 0 V 10 20 V,	$V_1 = 6 \text{ V to } 26 \text{ V}, \qquad I_O = 0 \text{ mA to } 750 \text{ mA} $	T _J = MIN to MAX [†]	4.9		5.1	V
Input voltage regulation	$V_1 = 9 V \text{ to } 16 V,$	I _O = 250 mA			10	25	m\/
Input voltage regulation	$V_{I} = 6 \text{ V to } 26 \text{ V},$	I _O = 250 mA			12	50	mV
Ripple rejection	V _I = 8 V to 18 V,	f = 120 Hz		50	55		dB
Output voltage regulation	I _O = 5 mA to 750 mA				20	50	mV
Dropout voltage	I _O = 500 mA					0.5	V
Dropout voltage	I _O = 750 mA					0.6	V
Output noise voltage	f = 10 Hz to 100 kHz				500		μV
Dies current	I _O = 750 mA				60	75	A
Bias current	I _O = 10 mA					5	mA
Bias current (TL751Mxx only)	ENABLE V _{IH} ≥ 2 V					200	μΑ

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF tantalum capacitor on the output with equivalent series resistance within the guidelines shown in Figure 3.

electrical characteristics, V_I = 14 V, I_O = 300 mA, \overline{ENABLE} at 0 V for TL751M08, T_J = 25°C (unless otherwise noted) (see Note 2)

PARAMETER		TEST CONDITIONS			TL750M08, TL751M08		
PANAMETER					TYP	MAX	UNIT
Output voltage	V 0.V/+0.06.V/	l= 0 mA to 750 mA	T _J = 25°C	7.84	8	8.16	. v
	V = 9 V 10 26 V,	$V_I = 9 \text{ V to } 26 \text{ V}, \qquad I_O = 0 \text{ mA to } 750 \text{ mA}$	T _J = MIN to MAX [†]	7.84		8.16	٧
Input voltage regulation	V _I = 10 V to 17 V,	I _O = 250 mA			12	40	m\/
Input voltage regulation	$V_{I} = 9 V \text{ to } 26 V,$	I _O = 250 mA		5	15	68	mV
Ripple rejection	V _I = 11 V to 21 V,	f = 120 Hz		50	55		dB
Output voltage regulation	I _O = 5 mA to 750 mA				24	80	mV
Dropout voltage	I _O = 500 mA					0.5	V
Dropout voltage	I _O = 750 mA					0.6	v
Output noise voltage	f = 10 Hz to 100 kHz				500		μV
Pine gurrent	I _O = 750 mA		-		60	75	A
Bias current	I _O = 10 mA					5	mA
Bias current (TL751Mxx only)	ENABLE V _{IH} ≥ 2 V					200	μΑ

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF tantalum capacitor on the output with equivalent series resistance within the guidelines shown in Figure 3.

TL750M, TL751M SERIES LOW-DROPOUT VOLTAGE REGULATORS

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electrical characteristics, V_I = 14 V, I_O = 300 mA, \overline{ENABLE} at 0 V for TL751M10, T_J = 25°C (unless otherwise noted) (see Note 2)

PARAMETER		TEST CONDITIONS			TL750M10, TL751M10		
PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
Output voltage	Vi - 11 V to 26 V	In _ 0 mA to 750 mA	T _J = 25°C	9.8	10	10.2	V
Odiput voltage	$V_{I} = 11 \text{ V to 26 V}, \qquad I_{O} = 0 \text{ mA to 750 mA}$	T _J = MIN to MAX†	9.8		10.2	V,	
Input voltage regulation	V _I = 12 V to 18 V,	I _O = 250 mA			15	43	mV
input voltage regulation	$V_{\parallel} = 11 \text{ V to 26 V}, \qquad I_{\parallel} = 250 \text{ mA}$			20	75	IIIV	
Ripple rejection	V _I = 13 V to 23 V,	f = 120 Hz		50	55		dB
Output voltage regulation	I _O = 5 mA to 750 mA				30	100	mV
Dropout voltage	I _O = 500 mA					0.5	V
Dropout voltage	I _O = 750 mA					0.6	·
Output noise voltage	f = 10 Hz to 100 kHz				1000		μV
Bias current	I _O = 750 mA				60	75	A
Dids Current	I _O = 10 mA					5	mA
Bias current (TL751Mxx only)	ENABLE V _{IH} ≥ 2 V					200	μА

For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

electrical characteristics, V_I = 14 V, I_O = 300 mA, \overline{ENABLE} at 0 V for TL751M12, T_J = 25°C (unless otherwise noted) (see Note 2)

PARAMETER		TEGT COMPLETIONS		TL750M12, TL751M12			
PARAMETER		TEST CONDITIONS			TYP	MAX	UNIT
Output voltage	V: 10 V to 00 V	I- 0 4 to 750 4	T _J = 25°C	11.76	12	12.24	V
	$V_{\parallel} = 13 \text{ V to } 26 \text{ V},$	$I_O = 0$ mA to 750 mA	T _J = MIN to MAX†	11.76		12.24	\ \
Input voltage regulation	V _I = 14 V to 19 V,	I _O = 250 mA			15	43	mV
	V _I = 13 V to 26 V,	I _O = 250 mA			20	78	
Ripple rejection	V _I = 13 V to 23 V,	f = 120 Hz		50	55		dB
Output voltage regulation	I _O = 5 mA to 750 mA				30	120	mV
Dropout voltage	I _O = 500 mA					0.5	V
	I _O = 750 mA					0.6	V
Output noise voltage	f = 10 Hz to 100 kHz		,		1000		μV
Bias current	I _O = 750 mA				60	75	4
	I _O = 10 mA					5	mA
Bias current (TL751Mxx only)	ENABLE V _{IH} ≥ 2 V					200	μΑ

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

electrical characteristics, V_I = 14 V, I_O = 300 mA,T_J = 25°C

PARAMETER	T	TL751Mxx		
PARAMETER	MIN	TYP	MAX	UNIT
Response time, ENABLE to output		50		μs

NOTE 2: Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-uF capacitor across the input and a 10-uF tantalum capacitor on the output with equivalent series resistance within the guidelines shown in Figure 3.

NOTE 2: Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-µF capacitor across the input and a 10-µF tantalum capacitor on the output with equivalent series resistance within the guidelines shown in Figure 3.

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electrical characteristics, $V_I = 14 \text{ V}$, $I_O = 300 \text{ mA}$, $\overline{\text{ENABLE}}$ at 0 V, $T_J = 25 ^{\circ}\text{C}$ (unless otherwise noted) (see Note 2)

PARAMETER	TEST CONDITIONS			TL750M05Y		
	TEST CONDITIONS		MIN	TYP	MAX	UNIT
Output voltage	$V_1 = 6 \text{ V to } 26 \text{ V}, \qquad I_0 = 0 \text{ mA to } 750 \text{ mA},$			5		٧
Input voltage regulation	$V_{I} = 9 \text{ V to } 16 \text{ V}, \qquad I_{O} = 250 \text{ mA}$			10		mV
	$V_{I} = 6 \text{ V to } 26 \text{ V}, \qquad I_{O} = 250 \text{ mA}$			12		
Ripple rejection	V _I = 8 V to 18 V, f = 120 Hz			55		dB
Output voltage regulation	I _O = 5 mA to 750 mA			20		mV
Output noise voltage	f = 10 Hz to 100 kHz	,		500		μV
Bias current	I _O = 750 mA			60		mA

NOTE 2: Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-µF capacitor across the input and a 10-µF tantalum capacitor on the output with equivalent series resistance within the guidelines shown in Figure 3.

electrical characteristics, $V_I = 14 \text{ V}$, $I_O = 300 \text{ mA}$, $\overline{\text{ENABLE}}$ at 0 V, $T_J = 25 ^{\circ}\text{C}$ (unless otherwise noted) (see Note 2)

PARAMETER	TEST CONDITIONS	TEST COMPLETIONS			TL750M08Y		
	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
Output voltage	$V_1 = 9 \text{ V to } 26 \text{ V}, \qquad I_0 = 0 \text{ mA to } 750 \text{ mA},$			8		V	
Input voltage regulation	V _I = 10 V to 17 V, I _O = 250 mA			12		mV	
	V _I = 9 V to 26 V, I _O = 250 mA			15			
Ripple rejection	V _I = 11 V to 21 V, f = 120 Hz			55		dB	
Output voltage regulation	I _O = 5 mA to 750 mA			24		mV	
Output noise voltage	f = 10 Hz to 100 kHz	•		500		μV	
Bias current	I _O = 750 mA			60		mA	

NOTE 2: Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF tantalum capacitor on the output with equivalent series resistance within the guidelines shown in Figure 3.

electrical characteristics, V_I = 14 V, I_O = 300 mA, \overline{ENABLE} at 0 V, T_J = 25°C (unless otherwise noted) (see Note 2)

PARAMETER	TEST CONDITIONS	TL750M10Y		
	TEST CONDITIONS	MIN TYP MAX	UNIT	
Output voltage	$V_I = 11 \text{ V to } 26 \text{ V}, \qquad I_O = 0 \text{ mA to } 750 \text{ mA},$. 10	٧	
Input voltage regulation	V _I = 12 V to 18 V, I _O = 250 mA	15	mV	
	V _I = 11 V to 26 V, I _O = 250 mA	20	mv	
Ripple rejection	V _I = 13 V to 23 V, f = 120 Hz	55	dB	
Output voltage regulation	I _O = 5 mA to 750 mA	30	mV	
Output noise voltage	f = 10 Hz to 100 kHz	1000	μV	
Bias current	I _O = 750 mA	60	mA	

NOTE 2: Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF tantalum capacitor on the output with equivalent series resistance within the guidelines shown in Figure 3.

TL750M, TL751M SERIES LOW-DROPOUT VOLTAGE REGULATORS

SLVS021D - JANUARY 1988 - REVISED AUGUST 1995

TL751M12Y electrical characteristics, $V_I = 14$ V, $I_O = 300$ mA, \overline{ENABLE} at 0 V, $T_J = 25^{\circ}C$ (unless otherwise noted) (see Note 2)

DADAMETED		TEST SOMBITIONS	TL750M12Y	
PARAMETER	100	TEST CONDITIONS	MIN TYP MAX	UNIT
Output voltage		$V_I = 13 \text{ V to } 26 \text{ V}, \qquad I_O = 0 \text{ mA to } 750 \text{ mA},$	12	٧
		V _I = 14 V to 19 V, I _O = 250 mA	15	\/
Input voltage regulation		$V_{I} = 13 \text{ V to } 26 \text{ V}, \qquad I_{O} = 250 \text{ mA}$	20	mV
Ripple rejection		V _I = 13 V to 23 V, f = 120 Hz	55	dB
Output voltage regulation		I _O = 5 mA to 750 mA	30	mV
Output noise voltage		f = 10 Hz to 100 kHz	1000	μV
Bias current		I _O = 750 mA	60	mA

NOTE 2: Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 10-μF tantalum capacitor on the output with equivalent series resistance within the guidelines shown in Figure 3.

PARAMETER MEASUREMENT INFORMATION

The TL751Mxx is a low-dropout regulator. This means that the capacitance loading is important to the performance of the regulator because it is a vital part of the control loop. The capacitor value and the equivalent series resistance (ESR) both affect the control loop and must be defined for the load range and the temperature range. Figures 3 and 4 can establish the capacitance value and ESR range for best regulator performance.

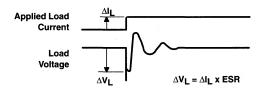
Figure 3 shows the recommended range of ESR for a given load with a 10μ F capacitor on the output. This figure also shows a maximum ESR limit of 2 Ω and a load-dependent minimum ESR limit.

For applications with varying loads, the lightest load condition should be chosen since it is the worst case. Figure 4 shows the relationship of the reciprocal of ESR to the square root of the capacitance with a minimum capacitance limit of 10 μ F and a maximum ESR limit of 2 Ω . This figure establishes the amount that the minimum ESR limit shown in Figure 3 can be adjusted for different capacitor values. For example, if the minimum load needed is 200 mA, Figure 4 suggests an ESR range of 0.8 Ω to 2 Ω for 10 μ F. Figure 4 shows that changing the capacitor from 10 μ F to 400 μ F can change the ESR minimum by greater than 3/0.5 (or 6). Therefore, the new minimum ESR value is 0.8/6 (or 0.13 Ω). This now allows an ESR range of 0.13 Ω to 2 Ω , achieving an expanded ESR range by using a larger capacitor at the output. [For better stability in low-current applications, a small resistance placed in series with the capacitor (see Table 1) is recommended, so that ESRs better approximate those shown in Figures 3 and 4.]

PARAMETER MEASUREMENT INFORMATION

Table 1. Compensations for Increased Stability at Low Currents

MANUFACTURER	CAPACITANCE	ESR TYP	PART NUMBER	ADDITIONAL RESISTANCE
AVX	15 μF	0.9 Ω	TAJB156M010S	1 Ω
KEMET	33 μF	0.6 Ω	T491D336M010AS	0.5 Ω



OUTPUT CAPACITOR EQUIVALENT SERIES RESISTANCE (ESR)

vs LOAD CURRENT RANGE

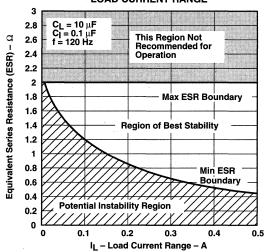


Figure 3

STABILITY .vs

EQUIVALENT SERIES RESISTANCE (ESR)

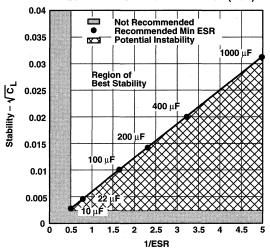


Figure 4

table of graphs

			FIGURE
Transient input voltage		vs Time	5
Output voltage		vs Input voltage	6
ì	I _O = 10 mA	vs Input voltage	7
Input current	I _O = 100 mA	vs Input voltage	8
Dropout voltage		vs Output current	9
Quiescent current		vs Output current	10
Load transient response			11
Line transient response			12

TRANSIENT INPUT VOLTAGE

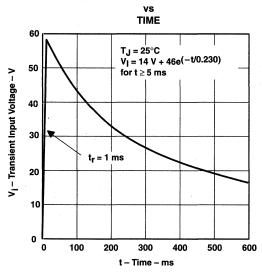


Figure 5

OUTPUT VOLTAGE vs INPUT VOLTAGE

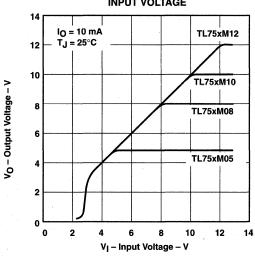
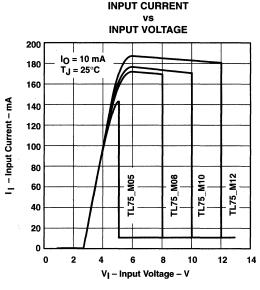


Figure 6

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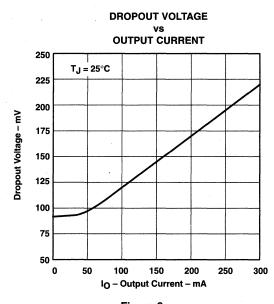
TYPICAL CHARACTERISTICS



INPUT CURRENT vs **INPUT VOLTAGE** 350 IO = 100 mA T_J = 25°C 300 I - Input Current - mA 250 TL75_M12 200 TL75_M08 TL75_M10 TL75 | 150 100 50 0 0 2 8 10 12 14 V_I - Input Voltage - V

Figure 7





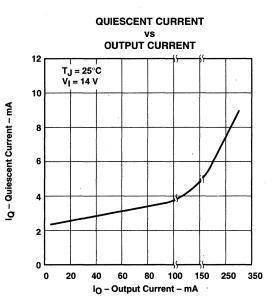


Figure 9

Figure 10

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TYPICAL CHARACTERISTICS

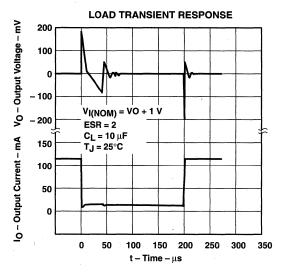


Figure 11

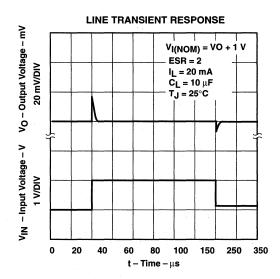


Figure 12

TL780 SERIES POSITIVE VOLTAGE REGULATORS

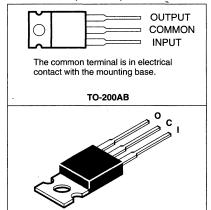
SLVS055B - APRIL 1981 - REVISED AUGUST 1995

- ±1% Output Tolerance at 25°C
- ±2% Output Tolerance Over Full Operating Range
- Thermal Shutdown
- Internal Short-Circuit Current Limiting
- Pinout Identical to μA7800 Series
- Improved Version of μA7800 Series

description

Each fixed-voltage precision regulator in this series is capable of supplying 1.5 A of load current. A unique temperature-compensation technique coupled with an internally trimmed band-gap reference has resulted in improved accuracy when compared to other 3-terminal regulators. Advanced layout techniques provide excellent line, load, and thermal regulation. The internal current limiting and thermal shutdown features make the devices essentially immune to overload.

KC PACKAGE (TOP VIEW)



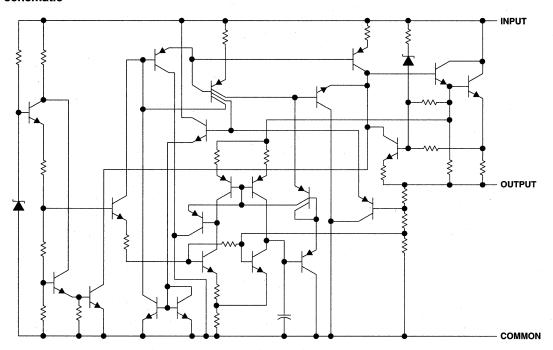
AVAILABLE OPTIONS

		PACKAGED DEVICES	CHIP
TJ	V _O TYP (V)	HEAT-SINK MOUNTED (3-PIN) (KC)	FORM (Y)
	5	TL78005CKC	TL78005Y
0°C to 125°C	12	TL78012CKC	TL78012Y
	15	TL78015CKC	TL78015Y

TL780 SERIES POSITIVE VOLTAGE REGULATORS

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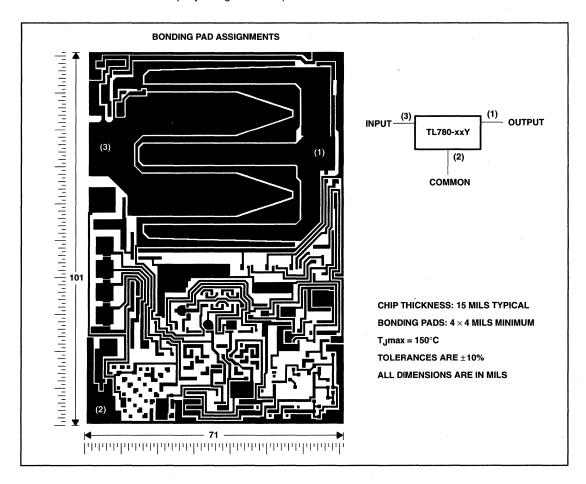
schematic



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TL780-05Y, TL780-12Y, and TL780-15Y chip information

These chips, when properly assembled, display characteristics similar to the TL780-xxC Series. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



absolute maximum ratings over operating temperature range (unless otherwise noted)†

Input voltage, V _I	35 V
Continuous total dissipation at T _A = 25°C (see Note 1)	2 W
Continuous total power dissipation at (or below) T _C = 25°C (see Note 1)	15 W
Operating free-air, T _A , case, T _C , or virtual junction, T _J , temperature range	150°C
Storage temperature range, T _{stq} –65°C to	150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

FREE-AIR TEMPERATURE **DISSIPATION DERATING CURVE** ${f P_D}$ – Maximum Continuous Power Dissipation – mW 2000 1800 1600 1400 1200 1000 800 600 400 Derating factor = 16 mW/°C 200 $R_{\theta JA} \approx 62.5^{\circ} \text{C/W}$ 0 100 125 150 25 50 75 TA - Free-Air Temperature - °C

Figure 1

CASE TEMPERATURE DISSIPATION DERATING CURVE

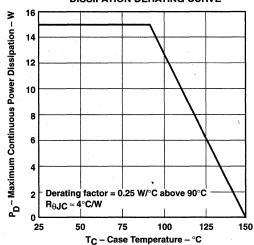


Figure 2

recommended operating conditions

		MIN	MAX	UNIT
	TL780-05C	7	25	
Input voltage, V _I	TL780-12C	14.5	30	V
	TL780-15C	17.5	30	
Output current, IO			1.5	Α
Operating virtual junction temperature, T	J	0	125	°C

NOTE 1: For operation above T_A = 25°C or T_C = 25°C, refer to Figures 1 and 2. To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded. Due to variations in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

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electrical characteristics at specified virtual junction temperature, V_I = 10 V, I_O = 500 mA (unless otherwise noted)

DADAMETED	TEGT COMPLETIONS	T _ +	TL780-05C			UNIT	
PARAMETER	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	UNII	
Outro de colho co	$I_0 = 5 \text{ mA to 1 A}, P \le 15 \text{ W},$	25°C	4.95	5	5.05	V	
Output voltage	V _I = 7 V to 20 V	0°C to 125°C	4.9		5.1	ľ	
In the second of	V _I = 7 V to 25 V	0500		0.5	5		
Input voltage regulation	V _I = 8 V to 12 V	25°C		0.5	5	mV	
Ripple rejection	V _I = 8 V to 18 V, f = 120 Hz	0°C to 125°C	70	85		dB	
Output voltage regulation	I _O = 5 mA to 1.5 A	0500		4	25	mV	
	I _O = 250 mA to 750 mA	25°C		1.5	15		
Output resistance	f = 1 kHz	0°C to 125°C		0.0035		Ω	
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C		0.25		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	25°C		75		μV	
Dropout voltage	I _O = 1 A	25°C		2		V	
Input bias current		25°C		5	8	mA	
	V _I = 7 V to 25 V	000 1- 40500		0.7	1.3	mA	
nput bias current change	I _O = 5 mA to 1 A	0°C to 125°C		0.003	0.5		
Short-circuit output current		25°C		750		mA	
Peak output current		25°C		2.2		Α	

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.22-µF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_{\rm I}$ = 19 V, $I_{\rm O}$ = 500 mA (unless otherwise noted)

DADAMETED	TECT COMPLTIONS	+ +	TL780-12	UNIT		
PARAMETER	TEST CONDITIONS	TJ [†]	MIN TYP	MAX	UNII	
O. danida salaha sa	$I_0 = 5 \text{ mA to 1 A}, P \le 15 \text{ W},$	25°C	11.88 12	12.12	V	
Output voltage	V _I = 14.5 V to 27 V	0°C to 125°C,	11.76	12.24	1 V	
	V _I = 14.5 V to 30 V	0500	1.2	12		
Input voltage regulation	V _I = 16 V to 22 V	25°C	1.2	12	mV	
Ripple rejection	V _I = 15 V to 25 V, f = 120 Hz	0°C to 125°C	65 80		dB	
Output voltage regulation	I _O = 5 mA to 1.5 A	0500	6.5	60	mV	
	I _O = 250 mA to 750 mA	25°C	2.5	36		
Output resistance	f = 1 kHz	0°C to 125°C	0.0035		Ω	
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C	0.6		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	25°C	180		μV	
Dropout voltage	I _O = 1 A	25°C	2		·V	
Input bias current		25°C	5.5	8	mA	
	V _I = 14.5 V to 30 V	0001 40500	0.4	1.3		
Input bias current change	I _O = 5 mA to 1 A	0°C to 125°C	0.03	0.5	mA	
Short-circuit output current		25°C	350		mA	
Peak output current		25°C	2.2		Α	

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.22-µF capacitor across the output.

TL780 SERIES POSITIVE VOLTAGE REGULATORS

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electrical characteristics at specified virtual junction temperature, V_I = 23 V, I_O = 500 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	-+	TL	TL780-15C			
PARAMETER	TEST CONDITIONS	TJŤ	MIN	TYP	MAX	UNIT	
0	$I_0 = 5 \text{ mA to 1 A}, P \le 15 \text{ W},$	25°C	14.85	15	15.15	v	
Output voltage	V _I = 17.5 V to 30 V	0°C to 125°C	14.7	-	15.3	\ \	
	V _I = 17.5 V to 30 V	25°C		1.5	15	5	
Input voltage regulation	V _I = 20 V to 26 V	25°C		1.5	15	mV	
Ripple rejection	V _I = 18.5 V to 28.5 V, f = 120 Hz	0°C to 125°C	60	75		dB	
Output voltage regulation	I _O = 5 mA to 1.5 A			7	75	mV	
	I _O = 250 mA to 750 mA	25°C		2.5	45	mv	
Output resistance	f = 1 kHz	1		0.0035		Ω	
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C		0.62		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	25°C		225		μV	
Dropout voltage	I _O = 1 A	25°C		2		V	
Input bias current		25°C		5.5	8	mA	
	V _I = 17.5 V to 30 V	0004-10500		0.4	1.3	4	
Input bias current change	I _O = 5 mA to 1 A	0°C to 125°C		0.02	0.5	mA .	
Short-circuit output current		25°C		230		.mA	
Peak output current		25°C		2.2		Α	

T Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately, All characteristics are measured with a 0.33-µF capacitor across the input and a 0.22-µF capacitor across the output.

electrical characteristics, $V_I = 10 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

TEGT COMPLETONOT	TL780-05Y	
TEST CONDITIONS	MIN TYP MAX	UNIT
$I_0 = 5 \text{ mA to 1 A}, P \le 15 \text{ W},$	5	V
V _I = 7 V to 25 V	0.5	mV
V _I = 8 V to 12 V	0.5	l IIIV
I _O = 5 mA to 1.5 A	4	mV
I _O = 250 mA to 750 mA	1.5	1111
f = 10 Hz to 100 kHz	75	μV
I _O = 1 A	2	V
	5	mA
	750	mA
	2.2	Α
	V _I = 7 V to 25 V V _I = 8 V to 12 V I _O = 5 mA to 1.5 A I _O = 250 mA to 750 mA f = 10 Hz to 100 kHz	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.22-µF capacitor across the output.

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electrical characteristics, $V_I = 19 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETER	TEST COMPLETIONS	TL7			
ut voltage regulation	TEST CONDITIONS†	MIN	TYP	MAX	UNIT
Output voltage	$I_0 = 5 \text{ mA to 1 A}, P \le 15 \text{ W},$		12		V
	V _I = 14.5 V to 30 V		1.2		
input voltage regulation	V _I = 16 V to 22 V		1.2		mV
Output voltage regulation	I _O = 5 mA to 1.5 A		6.5		\/
	I _O = 250 mA to 750 mA		2.5		mV
Output noise voltage	f = 10 Hz to 100 kHz		180		μV
Dropout voltage	I _O = 1 A		2		٧
Input bias current			5.5		mA
Short-circuit output current			350		mA
Peak output current			2.2		Α

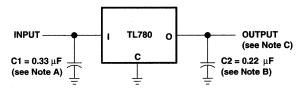
The Pulse-testing techniques the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.22-µF capacitor across the output.

electrical characteristics, $V_I = 23 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEST CONDITIONS†	TL780-15Y	UNIT
PARAMETER	TEST CONDITIONS!	MIN TYP MAX	
Output voltage	$I_{O} = 5 \text{ mA to 1 A}, \qquad P \le 15 \text{ W},$	15	٧
In a state of the	V _I = 17.5 V to 30 V	1.5	mV
Input voltage regulation	V _I = 20 V to 26 V	1.5	mv
0	I _O = 5 mA to 1.5 A	7	mV
Output voltage regulation	I _O = 250 mA to 750 mA	2.5	mv
Output resistance	f = 1 kHz	0.0035	Ω
Output noise voltage	f = 10 Hz to 100 kHz	225	μV
Dropout voltage	I _O = 1 A	2	·V
Input bias current		5.5	mA
Short-circuit output current		230	mA
Peak output current		2.2	Α

TPulse-testing techniques the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.22-µF capacitor across the output.

PARAMETER MEASUREMENT INFORMATION



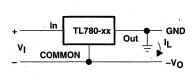
NOTES: A. C1 is required when the regulator is far from the power supply filter.

- B. C2 is not required for stability; however, transient response is improved.
- C. Permanent damage can occur when output is pulled below ground.

Figure 3. Test Circuit



APPLICATION INFORMATION



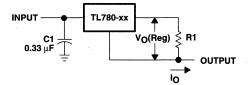


Figure 4. Positive Regulator in Negative Configuration (V_I Must Float)

I_O = (V_O/R1) + I_O Bias Current Figure 5. Current Regulator

operation with a load common to a voltage of opposite polarity

In many cases, a regulator powers a load that is not connected to ground but instead is connected to a voltage source of opposite polarity (e.g., operational amplifiers, level-shifting circuits, etc.). In these cases, a clamp diode should be connected to the regulator output as shown in Figure 6. This protects the regulator from output polarity reversals during startup and short-circuit operation.

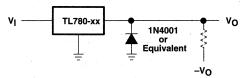


Figure 6. Output Polarity Reversal Protection Circuit

reverse-bias protection

Occasionally, the input voltage to the regulator can collapse faster than the output voltage. This, for example, could occur when the input supply is crowbarred during an output overvoltage condition. If the output voltage is greater than approximately 7 V, the emitter-base junction of the series pass element (internal or external) could break down and be damaged. To prevent this, a diode shunt can be employed, as shown in Figure 7.

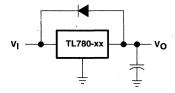


Figure 7. Reverse-Bias Protection Circuit

TL783C, TL783Y HIGH-VOLTAGE ADJUSTABLE REGULATORS

KC PACKAGE

(TOP VIEW)

SLVS036B - SEPTEMBER 1981 - REVISED AUGUST 1995

- Output Adjustable From 1.25 V to 125 V When Used With an External Resistor Divider
- 700-mA Output Current
- Full Short-Circuit, Safe-Operating-Area, and Thermal Shutdown Protection
- 0.001%/V Typical Input Voltage Regulation
- 0.15% Typical Output Voltage Regulation
- 76-dB Typical Ripple Rejection
- Standard TO-220AB Package

description

The TL783C is an adjustable 3-terminal high-voltage regulator with an output range of 1.25 V to 125 V and a DMOS output transistor capable of sourcing more than 700 mA. It is designed for use in high-voltage applications where standard

INPUT OUTPUT ADJUSTMENT
The output terminal is in electrical contact with the mounting base.

TO-220AB

bipolar regulators cannot be used. Excellent performance specifications, superior to those of most bipolar regulators, are achieved through circuit design and advanced layout techniques.

As a state-of-the-art regulator, the TL783C combines standard bipolar circuitry with high-voltage double-diffused MOS transistors on one chip to yield a device capable of withstanding voltages far higher than standard bipolar integrated circuits. Because of its lack of secondary breakdown and thermal runaway characteristics usually associated with bipolar outputs, the TL783C maintains full overload protection while operating at up to 125 V from input to output. Other features of the device include current limiting, safe-operating-area (SOA) protection, and thermal shutdown. Even if the adjustment terminal is inadvertently disconnected, the protection circuitry remains functional.

Only two external resistors are required to program the output voltage. An input bypass capacitor is necessary only when the regulator is situated far from the input filter. An output capacitor, although not required, improves transient response and protection from instantaneous output short circuits. Excellent ripple rejection can be achieved without a bypass capacitor at the adjustment terminal.

AVAILABLE OPTIONS

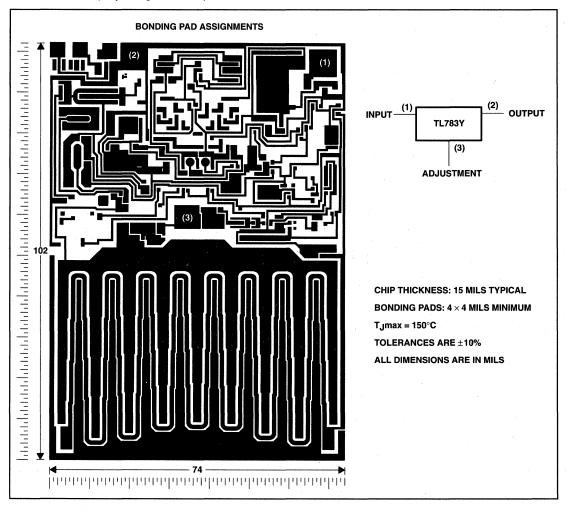
ТЈ	PACKAGED DEVICE HEAT-SINK MOUNTED (3-PIN) (KC)	CHIP FORM (Y)
0°C to 125°C	TL783CKC	TL783Y



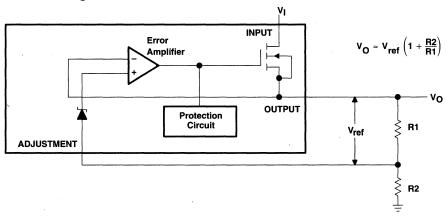
SLVS036B - SEPTEMBER 1981 - REVISED AUGUST 1995

TL783Y chip information

This chip, when properly assembled, displays characteristics similar to the TL783C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



functional block diagram

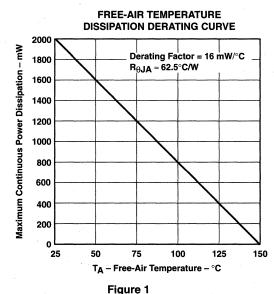


absolute maximum ratings over operating temperature range (unless otherwise noted)†

Input-to-output differential voltage, V _I – V _O	125 V
Continuous total power dissipation at (or below) T _A = 25°C (see Note 1)	2 W
Continuous total power dissipation at (or below) T _C = 70°C (see Note 1)	. 20 W
Operating free-air, T _A , case, T _C , or virtual junction, T _J , temperature range 0°C to	150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: For operation above T_A = 25°C or T_C = 70°C, refer to Figures 1 and 2, respectively. To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded. Due to variations in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation



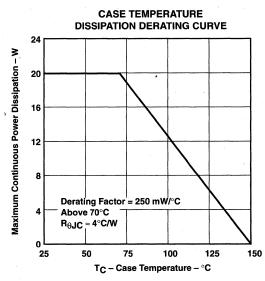


Figure 2

TL783C, TL783Y HIGH-VOLTAGE ADJUSTABLE REGULATORS

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recommended operating conditions

	MIN	MAX	UNIT
Input-to-output voltage differential, V _I – V _O		125	V
Output current, IO	15	700	mA
Operating virtual junction temperature, TJ	0	125	°C

electrical characteristics at $V_I - V_O = 25 \text{ V}$, $I_O = 0.5 \text{ A}$, $T_J = 0^{\circ}\text{C}$ to 125°C (unless otherwise noted)

DADAMETED	<u>-</u>	ST CONDITIONS†			TL783C		LINUT
PARAMETER	[]	MIN	TYP	MAX	UNIT		
Input voltage regulation‡	$V_I - V_O = 20 \text{ V to } 125 \text{ V},$	D < rated dissination	T _J = 25°C		0.001	0.01	%/V
Input voltage regulation+	V - V() = 20 V to 125 V,	r ≤ rateu dissipation	T _J = 0°C to 125°C		0.004	0.02	70/ V
Ripple rejection	$\Delta V_{I(PP)} = 10 \text{ V},$	V _O = 10 V,	f = 120 Hz	66	76		dB
	IO = 15 mA to 700 mA,	T _{.1} = 25°C	V _O ≤ 5 V	-	7.5	25	mV
Output voltage regulation	10 = 15 mA to 700 mA,	1 J = 25 C	V _O ≥ 5 V		0.15%	0.5%	
Output voltage regulation	IO = 15 mA to 700 mA,	D < rated dissination	V _O ≤ 5 V		20	70	mV
	IO = 15 IIIA to 700 IIIA,	r ≤ rateu dissipation	V _O ≥ 5 V		0.3%	1.5%	
Output voltage change with temperature					0.4%		-
Output voltage long-term drift	1000 hours at T _J = 125°C,	$V_I - V_O = 125 V$	See Note 2		0.2%		
Output noise voltage	f = 10 Hz to 10 kHz,	T _J = 25°C			0.003%		
Minimum output current to maintain regulation	V _I – V _O = 125 V					15	mA
	V _I – V _O = 25 V,	t = 1 ms			1100		
Baals audmint ausmant	V _I – V _O = 15 V,	t = 30 ms			715		
Peak output current	$V_I - V_O = 25 V$,	t = 30 ms		700	900		mA
	V _I – V _O = 125 V,	t = 30 ms		100	250		
Adjustment-terminal current					83	110	μА
Change in adjustment- terminal current	$V_I - V_O = 15 \text{ V to } 125 \text{ V},$	$I_{O} = 15 \text{ mA to } 700 \text{ mA},$	P≤rated dissipation		0.5	. 5	μА
Reference voltage (OUTPUT to ADJUSTMENT)	$V_I - V_O = 10 \text{ V to } 125 \text{ V},$ See Note 3	$I_0 = 15 \text{ mA to } 700 \text{ mA},$	P≤rated dissipation,	1.2	1.27	1.3	٧

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

[‡] Input voltage regulation is expressed here as the percentage change in output voltage per 1-V change at the input.

NOTES: 2. Since long-term drift cannot be measured on the individual devices prior to shipment, this specification is not intended to be a guarantee or warranty. It is an engineering estimate of the average drift to be expected from lot to lot.

Due to the dropout voltage and output current-limiting characteristics of this device, output current is limited to less than 700 mA at input-to-output voltage differentials of less than 25 V.

TL783C, TL783Y HIGH-VOLTAGE ADJUSTABLE REGULATORS

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electrical characteristics at $V_I - V_O = 25 \text{ V}$, $I_O = 0.5 \text{ A}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

		TL783Y				
PARAMETER	Т	MIN TYP	MAX	UNIT		
Input voltage regulation‡	$V_{I} - V_{O} = 20 \text{ V to } 125 \text{ V},$	P ≤ rated dissipation		0.001		%/V
Ripple rejection	$\Delta V_{I(PP)} = 10 \text{ V},$	V _O = 10 V,	f = 120 Hz	76		dB
	In 15 mA to 700 mA		V _O ≤ 5 V	7.5		mV
Outro di volto do voquilation	I _O = 15 mA to 700 mA		V _O ≥ 5 V	0.15%		
Output voltage regulation	L- 15 A to 700 A	D < valuation discinction	V _O ≤ 5 V	20		mV
	$I_O = 15 \text{ mA to } 700 \text{ mA},$	P ≤ rated dissipation	V _O ≥ 5 V	0.3%		
Output voltage change with temperature				0.4%		
Output noise voltage	f = 10 Hz to 10 kHz			0.003%		
	$V_1 - V_0 = 25 V$,	t = 1 ms	1100			
Dools output output	$V_I - V_O = 15 V$,	t = 30 ms		715		mA
Peak output current	$V_I - V_O = 25 V$,	t = 30 ms		900		mA
	$V_{I} - V_{O} = 125 V$	t = 30 ms 250		250		
Adjustment-terminal current				83		μА
Change in adjustment- terminal current	$V_{I,-} V_{O} = 15 \text{ V to } 125 \text{ V},$	$I_0 = 15 \text{ mA to } 700 \text{ mA},$	P≤rated dissipation	0.5		μΑ
Reference voltage (OUTPUT to ADJUSTMENT)	$V_I - V_O = 10 \text{ V to } 125 \text{ V},$ See Note 3	$I_O = 15 \text{mA} \text{to} 700 \text{mA},$	P≤rated dissipation,	1.27	·	V

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

[‡] Input voltage regulation is expressed here as the percentage change in output voltage per 1-V change at the input.

NOTES: 2 Since long-term drift cannot be measured on the individual devices prior to shipment, this specification is not intended to be a guarantee or warranty. It is an engineering estimate of the average drift to be expected from lot to lot.

³ Due to the dropout voltage and output current-limiting characteristics of this device, output current is limited to less than 700 mA at input-to-output voltage differentials of less than 25 V.

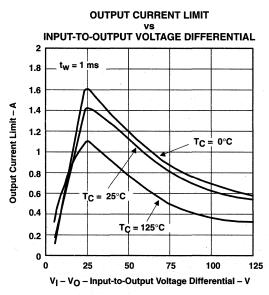


Figure 3

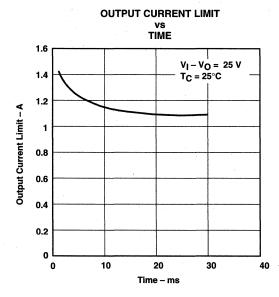


Figure 5

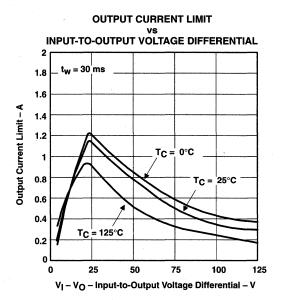


Figure 4

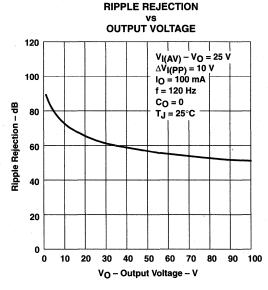
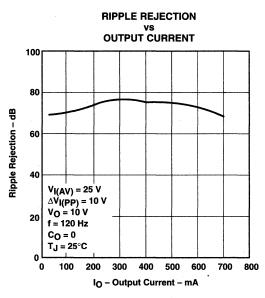


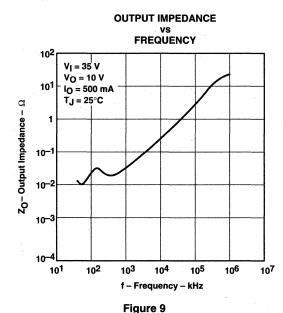
Figure 6



RIPPLE REJECTION **FREQUENCY** 100 90 80 Ripple Rejection - dB 70 C_O = 10 μF 60 50 40 $C_0 = 0$ 30 V_{I(AV)} = 25 V $\Delta V_{I(PP)} = 10 V$ 20 V_O = 10 V IO = 500 mA 10 T_J = 25°C 0 0.1 10 100 1000 0.01 f - Frequency - kHz

Figure 7





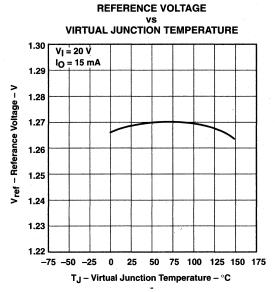


Figure 10

ADJUSTMENT-TERMINAL CURRENT VIRTUAL JUNCTION TEMPERATURE 90 $V_1 = 25 \dot{V}$ V_O = V_{ref} I_O = 500 mA 88 $_{ m adj}$ – Adjustment Current – μ A 86 84 82 80 25 75 100 125 0 50 T_J - Virtual Junction Temperature - °C

Figure 11

OUTPUT VOLTAGE DEVIATION

VIRTUAL JUNCTION TEMPERATURE V_I = 25 V Vo = 5 V Io = 15 mA to 700 mA -0.1 △VO - Output Voltage Deviation - % -0.2 -0.3 -0.4-0.550 75 100 125 150 T_J - Virtual Junction Temperature - °C

Figure 13

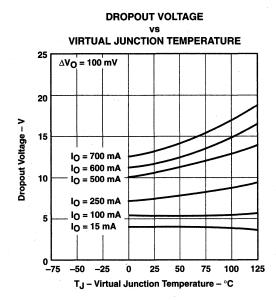
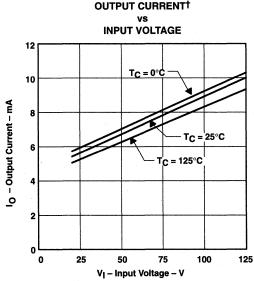


Figure 12



†This is the minimum current required to maintain voltage regulation.

Figure 14



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TYPICAL CHARACTERISTICS



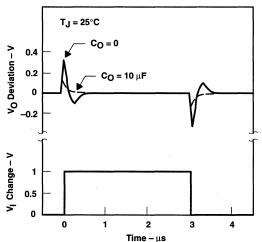


Figure 15

LOAD TRANSIENT RESPONSE

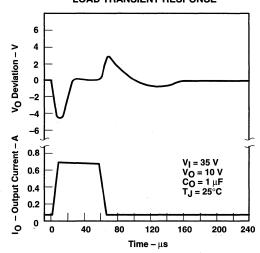


Figure 16

DESIGN CONSIDERATIONS

The internal reference (see functional block diagram) generates 1.25 V nominal (V_{ref}) between the output and adjustment terminals. This voltage is developed across R1 and causes a constant current to flow through R1 and the programming resistor R2, giving an output voltage of:

$$V_{O} = V_{ref} (1 + R2/R1) + I_{adj} (R2)$$

or
 $V_{O} \sim V_{ref} (1 + R2/R1)$.

The TL783C was designed to minimize I_{adj} and maintain consistency over line and load variations, thereby minimizing the I_{adj} (R2) error term.

To maintain I_{adj} at a low level, all quiescent operating current is returned to the output terminal. This quiescent current must be sunk by the external load and is the minimum load current necessary to prevent the output from rising. The recommended R1 value of 82 Ω provides a minimum load current of 15 mA. Larger values can be used when the input-to-output differential voltage is less than 125 V (see output current curve) or when the load sinks some portion of the minimum current.

bypass capacitors

The TL783C regulator is stable without bypass capacitors; however, any regulator becomes unstable with certain values of output capacitance if an input capacitor is not used. Therefore, the use of input bypassing is recommended whenever the regulator is located more than four inches from the power-supply filter capacitor. A 1-μF tantalum or aluminum electrolytic capacitor is usually sufficient.

DESIGN CONSIDERATIONS

bypass capacitors (continued)

Adjustment-terminal capacitors are not recommended for use on the TL783C because they can seriously degrade load transient response as well as create a need for extra protection circuitry. Excellent ripple rejection is presently achieved without this added capacitor.

Due to the relatively low gain of the MOS output stage, output voltage dropout may occur under large load transient conditions. The addition of an output bypass capacitor greatly enhances load transient response as well as prevent dropout. For most applications, it is recommended that an output bypass capacitor be used with a minimum value of:

$$C_{O}(\mu F) = 15/V_{O}$$

Larger values provide proportionally better transient response characteristics.

protection circuitry

The TL783C regulator includes built-in protection circuits capable of guarding the device against most overload conditions encountered in normal operation. These protective features are current limiting, safe-operating-area protection, and thermal shutdown. These circuits are meant to protect the device under occasional fault conditions only. Continuous operation in the current limit or thermal shutdown mode is not recommended.

The internal protection circuits of the TL783C protect the device up to maximum-rated V₁ as long as certain precautions are taken. If V_I is instantaneously switched on, transients exceeding maximum input ratings may occur, which can destroy the regulator. These are usually caused by lead inductance and bypass capacitors causing a ringing voltage on the input. In addition, when rise times in excess of 10 V/ns are applied to the input. a parasitic npn transistor in parallel with the DMOS output can be turned on causing the device to fail. If the device is operated over 50 V and the input is switched on rather than ramped on, a low-Q capacitor, such as tantalum or aluminum electrolytic should be used rather than ceramic, paper, or plastic bypass capacitors. A Q factor of 0.015 or greater usually provides adequate damping to suppress ringing. Normally, no problems occur if the input voltage is allowed to ramp upward through the action of an ac line rectifier and filter network.

Similarly, when an instantaneous short circuit is applied to the outputs, both ringing and excessive fall times can result. A tantalum or aluminum electrolytic bypass capacitor is recommended to eliminate this problem. However, if a large output capacitor is used and the input is shorted, addition of a protection diode may be necessary to prevent capacitor discharge through the regulator. The amount of discharge current delivered is dependent on output voltage, size of capacitor, and fall time of V_I. A protective diode (see Figure 17) is required only for capacitance values greater than:

$$C_O(\mu F) = 3 \times 10^4/(V_O)^2$$
.

Care should always be taken to prevent insertion of regulators into a socket with power on. Power should be turned off before removing or inserting regulators.



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DESIGN CONSIDERATIONS

protection circuitry (continued)

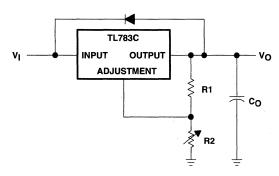


Figure 17. Regulator With Protective Diode

load regulation

The current set resistor (R1) should be located close to the regulator output terminal rather than near the load. This eliminates long line drops from being amplified through the action of R1 and R2 to degrade load regulation. To provide remote ground sensing, R2 should be near the load ground.

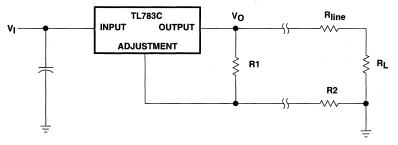
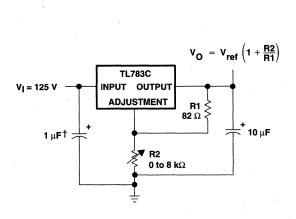


Figure 18. Regulator With Current-Set Resistor

APPLICATION INFORMATION



† Needed if device is more than 4 inches from filter capacitor

Figure 19. 1.25-V to 115-V Adjustable Regulator

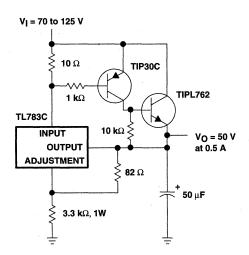


Figure 21. 50-V Regulator With Current Boost

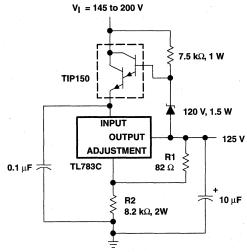


Figure 20. 125-V Short-Circuit-Protected **Off-Line Regulator**

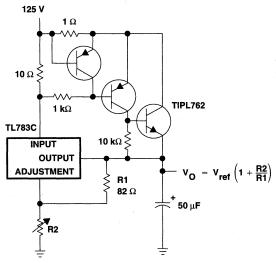


Figure 22. Adjustable Regulator With Current **Boost and Current Limit**

APPLICATION INFORMATION

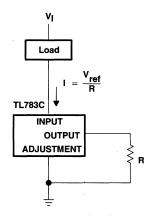


Figure 23. Current-Sinking Regulator

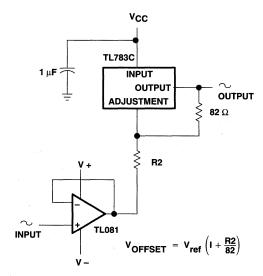


Figure 25. High-Voltage Unity-Gain Offset Amplifier

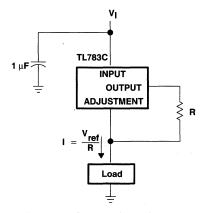


Figure 24. Current-Sourcing Regulator

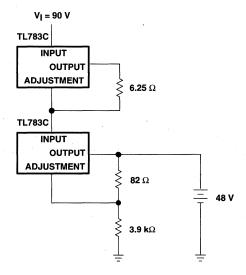


Figure 26. 48-V, 200-mA Float Charger

TL1431C, TL1431Q, TL1431Y PRECISION PROGRAMMABLE REFERENCES

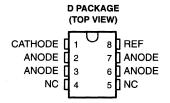
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- 0.4% Initial Voltage Tolerance
- 0.1-Ω Typical Output Impedance
- Fast Turn On . . . 500 ns
- Sink Current Capability . . . 1 mA to 100 mA
- Low REF Current
- Adjustable Output Voltage . . . V_{ref} to 36 V
- Available In Two High-Density Packaging Options:
 - Small Outline (D)
 - TO-226AA (LP)

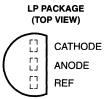
description

The TL1431 is a precision programmable reference with specified thermal stability over applicable automotive and commercial temperature ranges. The output voltage may be set to any value between $V_{I(ref)}$ (approximately 2.5 V) and 36 V with two external resistors (see Figure 16). These devices have a typical output impedance of 0.1 Ω . Active output circuitry provides a very sharp turn-on characteristic, making these devices excellent replacements for zener diodes and other types of references in applications such as on-board regulation, adjustable power supplies, and switching power supplies.

The TL1431 is offered in a wide variety of high-density packaging options. It is also available in both the automotive temperature range and the commercial temperature range. The TL1431C is characterized for operation over the commercial temperature range of 0°C to 70°C. The TL1431Q is characterized for operation over the automotive temperature range of -40°C to 125°C.



NC - No internal connection ANODE terminals are internally connected.



application schematic

5-V Precision Regulator $V_{0} = 5 \text{ V}$ $V_{0} = 5 \text{ V}$

NOTE A: R_b should provide cathode current \geq 1-mA to the TL1431.

AVAILABLE OPTIONS

	PA	CKAGED DEVICES	CHIP FORM		
	TA	SMALL OUTLINE (D)	TO-226AA (LP)	(Y)	
į	0°C to 70°C	TL1431CD	TL1431CLP	TL1431Y	
	-40°C to 125°C	TL1431QD	TL1431QLP	114311	

The D and LP packages are available taped and reeled. Add R suffix to device type (e.g., TL1431CDR). Chip forms are tested at 25°C.



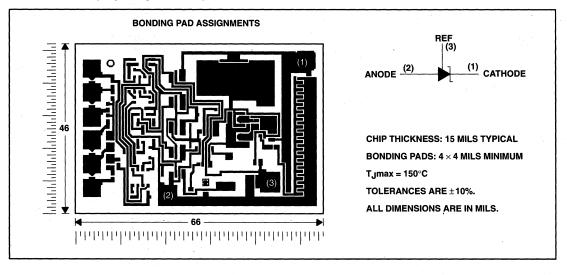
TL1431C, TL1431Q, TL1431Y PRECISION PROGRAMMABLE REFERENCES

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Symbol functional block diagram CATHODE REF ANODE CATHODE Vref ANODE

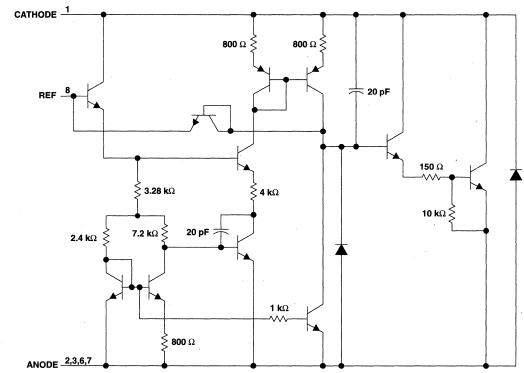
TL1431Y chip information

This chip, when properly assembled, displays characteristics similar to the TL1431. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The $chi_{\rm P}$ may be mounted with conductive epoxy or a gold-silicon preform.



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equivalent schematic



NOTE A: All component values are nominal.

TL1431C, TL1431Q, TL1431Y PRECISION PROGRAMMABLE REFERENCES

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

cathode voltage, V _{KA} (see Note 1)	37 V
Continuous cathode current range, IKA	
Reference input current range, I _{I(REF)}	
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, TA: C suffix	0°C to 70°C
Q suffix	
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to ANODE unless otherwise noted.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 105°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	261 mW	145 mW
LP	775 mW	6.2 mW/°C	496 mW	279 mW	155 mW

recommended operating conditions

		FIX	Q SUF	UNIT	
	MIN	MAX	MIN	MAX	UNII
cathode voltage, V _{KA}	V _{l(ref)}	36	V _{I(ref)}	36	٧
cathode current, IKA	1	100	. 1	100	mA ·
Operating free-air temperature, T _A	0	70	-40	125	°C



TL1431C, TL1431Q, TL1431Y PRECISION PROGRAMMABLE REFERENCES

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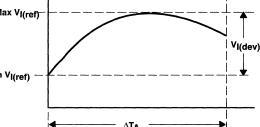
electrical characteristics at specified free-air temperature, IKA = 10 mA (unless otherwise noted)

PARAMETER TEST CONDITIONS		TEST CONDITIONS	- +	TEST	1	TL1431C			TL1431Q		
	PARAMETER	1EST CONDITIONS	T _A †	CIRCUIT	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
			25°C		2490	2500	2510	2490	2500	2510	-
V _{I(ref)}	Reference input voltage	VKA = VI(ref)	Full range	1	2480		2520	2470		2530	mV
V _{I(dev)}	Deviation of reference input voltage over full temperature range‡	V _K A = V _I (ref)	Full range	1		4	20		17	55	mV
ΔV _{I(ref)} ΔV _K A	Ratio of change in reference input voltage to the change in cathode voltage	ΔV _{KA} = 3 V to 36 V	Full range	2		-1.1	-2		-1.1	-2	mV/V
			25°C			1.5	2.5		1.5	2.5	
I(ref)	Reference input current	R1 = 10 kΩ, R2 = ∞	Full range	2	e		3			3	μА
I(dev)	Deviation of reference input current over full temperature range‡	R1 = 10 kΩ, R2 = ∞	Full range	2		0.2	1.2		0.5	1.2	μА
	Minimum cathode current for regulation	V _{KA} = V _{I(ref)} to 36 V	25°C	1		0.45	1		0.45	1	mA
	Off-state cathode		25°C			0.18	0.5		0.18	0.5	
loff	current	$V_{KA} = 36 \text{ V}, V_{I(ref)} = 0$	Full range	3			2			2	μА
IzKAI	Output impedance§	$V_{KA} = V_{I(ref)}$, $f \le 1$ kHz, $I_{KA} = 1$ mA to 100 mA	25°C	1		0.1	0.2		0.1	0.2	Ω

[†] Full range is 0°C to 70°C for C-suffix devices and -40°C to 125°C for Q-suffix devices.

$$\left|\alpha_{\text{VI(ref)}}\right| \left(\frac{\text{ppm}}{^{\circ}\text{C}}\right) = \frac{\left(\frac{\text{V}_{\text{I(dev)}}}{\text{V}_{\text{I(ref)}} \text{ at } 25^{\circ}\text{C}}\right) \times 10^{6}}{\Delta T_{\text{A}}} \qquad \qquad \text{Max V}_{\text{I(ref)}}$$

where $\Delta T_{\mbox{\scriptsize A}}$ is the rated operating temperature range of the device. Min VI(ref)



 α_{Vref} is positive or negative depending on whether minimum $V_{I(ref)}$ or maximum $V_{I(ref)}$, respectively, occurs at the lower temperature.

§ The output impedance is defined as: $|z_{KA}| = \frac{\Delta V_{KA}}{\Delta I_{KA}}$

When the device is operating with two external resistors (see Figure 2), the total dynamic impedance of the circuit is given by:

 $|z'| = \frac{\Delta V}{\Delta I}$, which is approximately equal to $|z_{KA}| \left(1 + \frac{R1}{R2}\right)$.

[‡] The deviation parameters V_{I(dev)} and I_{I(dev)} are defined as the differences between the maximum and minimum values obtained over the rated temperature range. The average full-range temperature coefficient of the reference input voltage α_{VI(ref)} is defined as:

TL1431C, TL1431Q, TL1431Y PRECISION PROGRAMMABLE REFERENCES

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electrical characteristics at $I_{KA} = 10$ mA, $T_A = 25$ °C

	DADAMETED	TEST CONDITIONS	TEST	TL1431Y			UNIT	
PARAMETER		TEST CONDITIONS	CIRCUIT	MIN	TYP	MAX	ONII	
V _{I(ref)} .	Reference input voltage	V _{KA} = V _{I(ref)}	1	2490	2500	2510	mV	
$\frac{\Delta V_{I(ref)}}{\Delta V_{KA}}$	Ratio of change in reference input voltage to the change in cathode voltage	ΔV _{KA} = 3 V to 36 V	2		-1.1	-2	mV/V	
I(ref)	Reference input current	R1 = 10 kΩ, R2 = ∞	2		1.44	2.5	μΑ	
I _{KA} min	Minimum cathode current for regulation	V _{KA} = V _{I(ref)} to 36 V	1		0.45	1	mA	
loff	Off-state cathode current	$V_{KA} = 36 \text{ V}, V_{ref} = 0$	3		0.18	0.5	μΑ	
IZKAI	Output impedance†	$V_{KA} = V_{I(ref)}, f \le 1 \text{ kHz},$ $I_{KA} = 1 \text{ mA to } 100 \text{ mA}$	1		0.1	0.2	G	

[†] The output impedance is defined as: $|z'| = \frac{\Delta V}{\Delta I}$

When the device is operating with two external resistors (see Figure 2), the total dynamic impedance of the circuit is given by

$$\left|z_{KA}\right| = \frac{\Delta V_{KA}}{\Delta I_{KA}} \ \, \text{, which is approximately equal to} \ \, \left|z_{KA}\right| \left(1 + \frac{R1}{R2}\right) \, .$$

PARAMETER MEASUREMENT INFORMATION

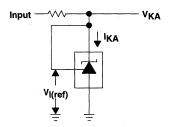


Figure 1. Test Circuit for $V_{(KA)} = V_{ref}$

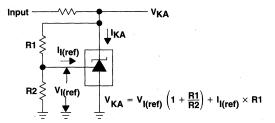


Figure 2. Test Circuit for $V_{(KA)} > V_{ref}$

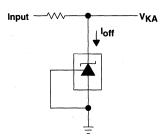


Figure 3. Test Circuit for Ioff

TL1431C, TL1431Q, TL1431Y PRECISION PROGRAMMABLE REFERENCES

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TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
V _{I(ref)}	Reference voltage	vs Free-air temperature	4
I _I (ref)	Reference current	vs Free-air temperature	5
^I KA	Cathode current .	vs Cathode voltage	6, 7
IKA(off)	Off-state cathode current	vs Free-air temperature	8
ΔV _{I(ref)}	Ratio of delta reference voltage to delta cathode voltage	vs Free-air temperature	9
V	Equivalent input noise voltage	vs Frequency	10
v _n	Equivalent input noise voltage	Over a 10-second time period	11
A _V	Small-signal voltage amplification	vs Frequency	12
IzKAI	Reference impedance	vs Frequency	13
	Pulse response		14
	Stability boundary conditions		15

TYPICAL CHARACTERISTICS[†]

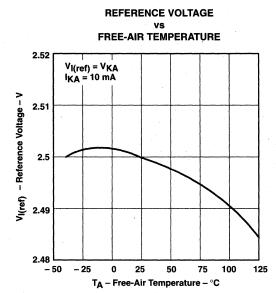


Figure 4

CATHODE CURRENT

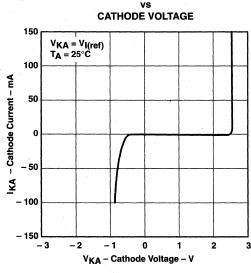


Figure 6



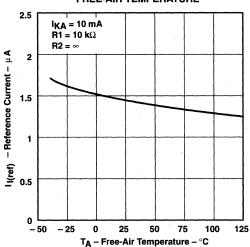


Figure 5

CATHODE CURRENT CATHODE VOLTAGE

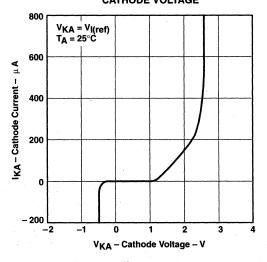


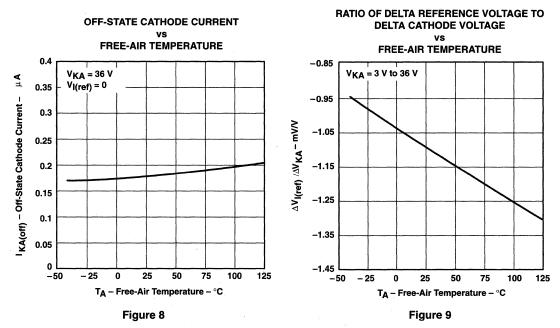
Figure 7

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

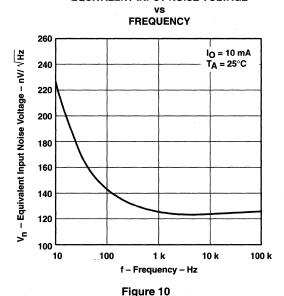


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TYPICAL CHARACTERISTICS†



EQUIVALENT INPUT NOISE VOLTAGE

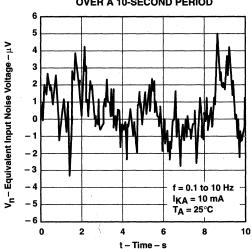


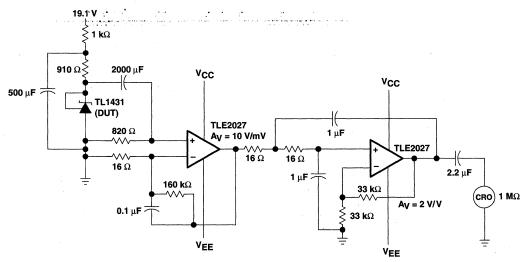
[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS

EQUIVALENT INPUT NOISE VOLTAGE OVER A 10-SECOND PERIOD



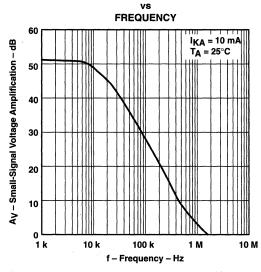


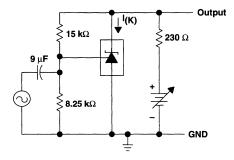
TEST CIRCUIT FOR 0.1-Hz TO 10-Hz EQUIVALENT INPUT NOISE VOLTAGE

Figure 11

TYPICAL CHARACTERISTICS

SMALL-SIGNAL VOLTAGE AMPLIFICATION





TEST CIRCUIT FOR VOLTAGE AMPLIFICATION

Figure 12

REFERENCE IMPEDANCE

FREQUENCY

100

IKA = 1 mA to 100 mA

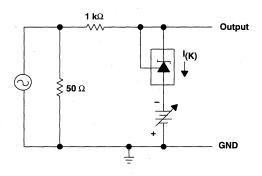
TA = 25°C

10

10

1 k 10 k 100 k 1 M 1 M

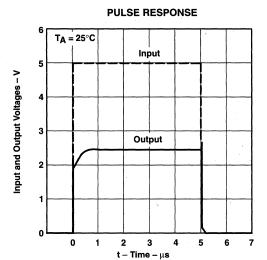
1 F-Frequency - Hz

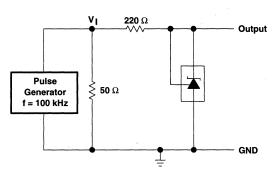


TEST CIRCUIT FOR REFERENCE IMPEDANCE

Figure 13

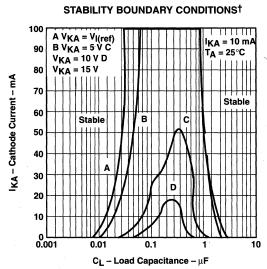
TYPICAL CHARACTERISTICS

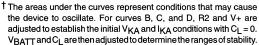




TEST CIRCUIT FOR PULSE RESPONSE

Figure 14





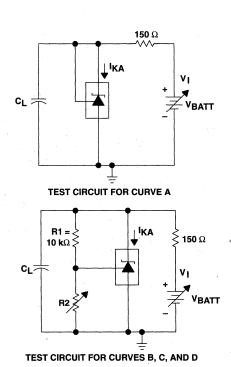


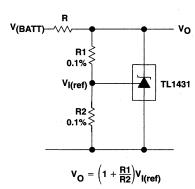
Figure 15



APPLICATION INFORMATION

Table of Application Circuits

APPLICATION	FIGURE
Shunt regulator	16
Single-supply comparator with temperature-compensated threshold	17
Precision high-current series regulator	18
Output control of a 3-terminal fixed regulator	19
Higher-current shunt regulator	20
Crowbar	21
Precision 5-V, 1.5-A, 0.5% regulator	22
Efficient 5-V precision regulator	23
PWM down converter with 0.5% reference	24
Voltage monitor	25
Delay timer	26
Precision current limiter	27
Precision constant-current sink	28



NOTE A: R should provide cathode current ≥ 1-mA to the TL1431 at minimum V(BATT.)

Figure 16. Shunt Regulator

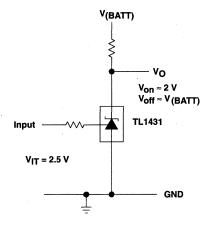
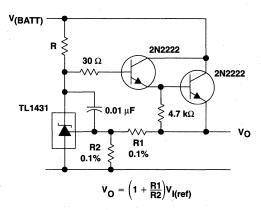


Figure 17. Single-Supply Comparator With Temperature-Compensated Threshold

APPLICATION INFORMATION



NOTE A: R should provide cathode current ≥ 1-mA to the TL1431 at minimum V_(BATT).

Figure 18. Precision High-Current **Series Regulator**

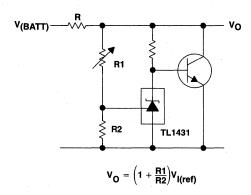
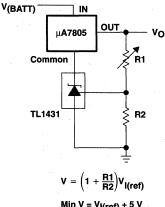
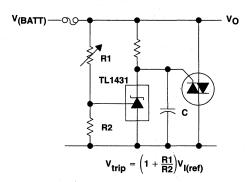


Figure 20. Higher-Current Shunt Regulator



 $Min V = V_{I(ref)} + 5 V$

Figure 19. Output Control of a 3-Terminal **Fixed Regulator**



NOTE A: Refer to the stability boundary conditions on Figure 15 to determine allowable values for the capacitor.

Figure 21. Crowbar

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APPLICATION INFORMATION

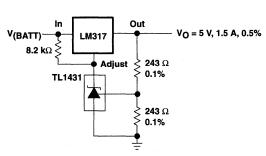
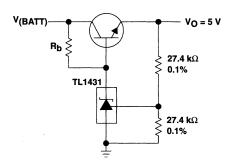


Figure 22. Precision 5-V, 1.5-A, 0.5% Regulator



NOTE A: R_b should provide cathode current ≥ 1-mA to the TL1431.

Figure 23. 5-V Precision Regulator

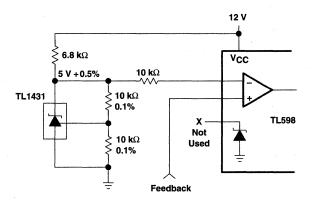
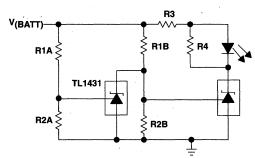


Figure 24. PWM Converter With 0.5% Reference

APPLICATION INFORMATION



NOTE A: R3 & R4 are selected to provide the desired LED intensity and cathode current ≥ 1 mA to the TL1431.

Figure 25. Voltage Monitor

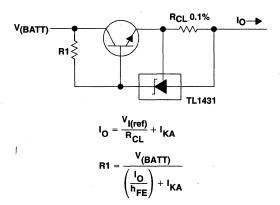


Figure 27. Precision Current Limiter

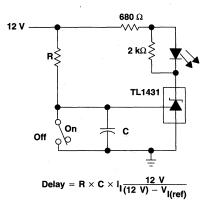


Figure 26. Delay Timer

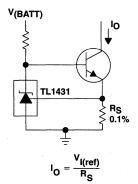


Figure 28. Precision Constant-Current Sink

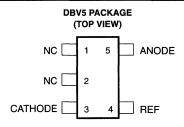
TLV431A LOW-VOLTAGE ADJUSTABLE PRECISION SHUNT REGULATORS

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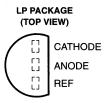
- Low-Voltage Operation . . . to 1.24 V
- 1% Reference Voltage Tolerance
- Adjustable Output Voltage,
 V_O = V_{ref} to 6 V
- Low Operational Cathode Current . . . 80 μA
- 0.25 Ω Typical Output Impedance
- SOT-23 Package

description

The TLV431A is a low-voltage 3-terminal adjustable voltage reference with specified thermal stability over applicable industrial and commercial temperature ranges. Output voltage may be set to any value between $V_{ref}(1.24\ V)$ and 6 V with two external resistors (see Figure 2). The TLV431A operates from a lower voltage (1.24 V) than the widely used TL431 and TL1431 shunt regulator references.



NC - No internal connection



When used with an optocoupler, the TLV431A is an ideal voltage reference in an isolated feedback circuit for 3-V to 3.3-V switching-mode power supplies. This device has a typical output impedance of 0.25 Ω . Active output circuitry provides a very sharp turn-on characteristic, making the TLV431A an excellent replacement for low-voltage zener diodes in many applications, including on-board regulation and adjustable power supplies.

AVAILABLE OPTIONS

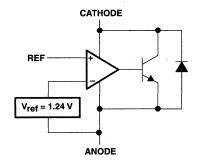
	PACKAC	CHIP FORM		
TA	TO-92 (LP)	SOT-23 (DBV5)	(Y)	
0°C to 70°C	TLV431ACLP	TLV431ACDBV5	TLV431AY	
-40°C to 85°C	TLV431AILP	TLV431AIDBV5] ILV43IAY	

The LP package is available taped and reeled. Add R suffix to device type (e.g., TLV431ACLPR). The DBV5 is only available taped and reeled (no R suffix is required).

symbol

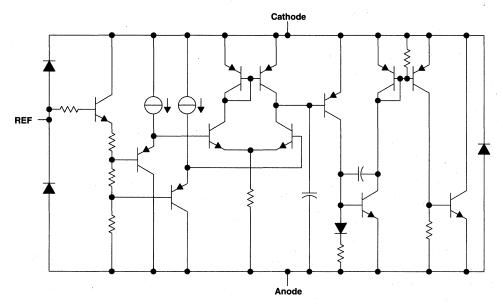
REF Anode Cathode

functional block diagram



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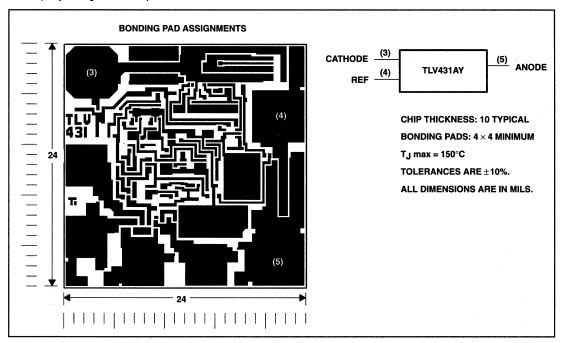
equivalent schematic



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TLV431AY chip information

This chip, when properly assembled, displays characteristics similar to the TLV431A. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



TLV431A LOW-VOLTAGE ADJUSTABLE PRECISION SHUNT REGULATORS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Cathode voltage, V _{KA} (see Note 1)	7 V
Continuous cathode current range, I _K	
Reference current range, I _{ref}	
Power dissipation, P _D	See Dissipation Rating Table
Operating free-air temperature range, T _A : C-suffix	
I-suffix	40°C to 85°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. NOTE 1: Voltage values are with respect to the anode terminal, unless otherwise noted.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	
LP	775 mW	6.2 mW/°C	496 mW	403 mW	
DBV5	150 mW	1.2 mW/°C	96 mW	78 mW	

recommended operating conditions

		MIN	MAX	UNIT
Cathode voltage, V _{KA}		V _{ref}	6	٧
Cathode current, IK	*	0.1	15	mA
Operating free-air temperature range, T₄	TLV431AC	0	70	°C
Operating nee-air temperature range, 14	TLV431AI	-40	85	U

TLV431A LOW-VOLTAGE ADJUSTABLE PRECISION SHUNT REGULATORS

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electrical characteristics at 25°C free-air temperature (unless otherwise noted)

PARAMETER		TEST	201	IDITIONS	TLV431AC		С	1	UNIT		
ļ	PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	MIN	TYP	MAX	UNII
V .	Reference voltage	V _{KA} = V _{ref} ,		T _A = 25°C	1.228	1.240	1.252	1.228	1.240	1.252	V
V _{ref}	neierence voltage	I _K = 10 mA, See Figure 1		T _A = full range	1.221		1.259	1.215		1.265	V
V _{ref(dev)}	V _{ref} deviation over full temperature range (see Note 3)		V _{KA} = V _{ref} , I _K = 10 mA, See Note 2 and Figure 1			4	12 -		6	20	mV
$\frac{\Delta V_{ref}}{\Delta V_{KA}}$	Ratio of V _{ref} change in cathode voltage change	I _K = 10 mA, See Figure 2				-1.5	-2.7	-	-1.5	-2.7	mV V
ref	Reference terminal current	, ,	• • • • • • • • • • • • • • • • • • • •			0.15	0.5		0.15	0.5	μА
Iref(dev)	I _{I(ref)} deviation over full temperature range (see Note 3)	I _K = 10 mA, I R2 = ∞, See Note 2 and I		= 10 kΩ, ire 2		0.05	0.3		0.1	0.4	μА
lK(min)	Minimum cathode current for regulation	V _{KA} = V _{ref} ,	V _{KA} = V _{ref} , See Figure 1			55	80		55	80	μА
loff	Off-state cathode current	V _{KA} = 6 V, See Figure 3	V _{ref}	= 0,		0.001	0.1		0.001	0.1	μΑ
z _{ka}	Dynamic impedance (see Note 4)	$V_{KA} = V_{ref}$, f $I_K = 0.1$ mA to 15 See Figure 1		kHz, A		0.25	0.4		0.25	0.4	Ω

NOTES: 2. Full temperature range is -40°C to 85°C for TLV431AI, and 0°C to 70°C for the TLV431AC.

The deviation parameters V_{ref(dev)} and I_{ref(dev)} are defined as the differences between the maximum and minimum values obtained
over the rated temperature range. The average full-range temperature coefficient of the reference input voltage, αV_{ref},
is defined as:

$$\left|\alpha V_{ref}\right|\!\!\left(\!\frac{ppm}{^{\circ}C}\right) = \frac{\left(\frac{V_{ref}(dev)}{V_{ref}\left(T_{A}\!=\!25^{\circ}C\right)}\right) \times 10^{6}}{_{\Delta}T_{A}}$$

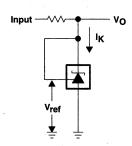
where ΔT_A is the rated operating free-air temperature range of the device.

 α_{Vref} can be positive or negative depending on whether minimum V_{ref} or maximum V_{ref} , respectively, occurs at the lower temperature.

4. The dynamic impedance is defined as: $|z_{ka}| = \frac{\Delta V_{KA}}{\Delta I_{K}}$

When the device is operating with two external resistors (see Figure 2), the total dynamic impedance of the circuit is given by:

$$\left|z_{ka}\right| \, = \frac{\Delta V}{\Delta I} \approx \ \left|z_{ka}\right| \ \times \left(1 \, + \frac{R1}{R2}\right)$$



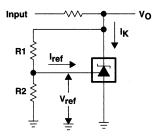


Figure 1. Test Circuit for $V_{KA} = V_{ref}$ $V_O = V_{KA} = V_{ref}$

Figure 2. Test Circuit for $V_{KA} > V_{ref}$ $V_O = V_{KA} = V_{ref} \times (1 + R1/R2) + I_{ref} \times R1$

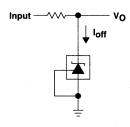
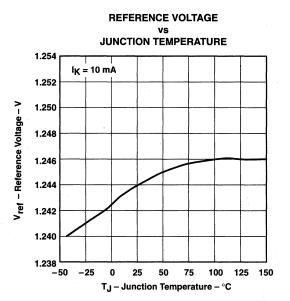


Figure 3. Test Circuit for Ioff

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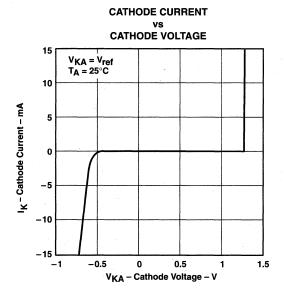
PARAMETER MEASUREMENT INFORMATION



vs JUNCTION TEMPERATURE 250 I_K = 10 mA $R1 = 10 k\Omega$ R2 = ∞ ref - Reference Input Current - nA 200 150 100 50 -50 -25 25 50 75 100 125 150 T_J - Junction Temperature - °C

REFERENCE INPUT CURRENT

Figure 4



CATHODE CURRENT vs CATHODE VOLTAGE

Figure 5

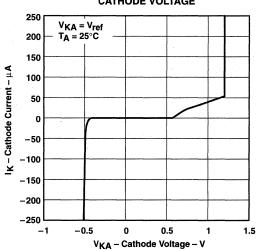
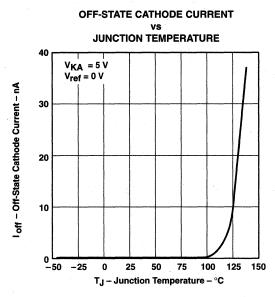


Figure 6

Figure 7



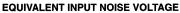


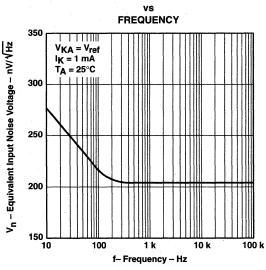
RATIO OF DELTA REFERENCE VOLTAGE TO DELTA CATHODE VOLTAGE **JUNCTION TEMPERATURE** 0 ∆V_{ref/}∆V_{KA} – Ratio of Delta Reference Voltage -0.1 to Delta Cathode Voltage - mV/V -0.2 -0.3-0.4 -0.5 -0.6IK = 10 mA -0.7 $\Delta V_{KA} = V_{ref}$ to 6 V -0.8 -50 -25 25 50 75 100 125

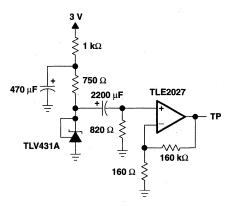
Figure 8

Figure 9

T_J - Junction Temperature - °C



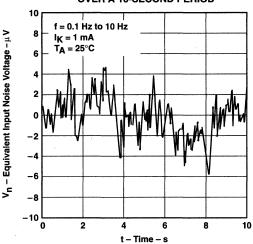


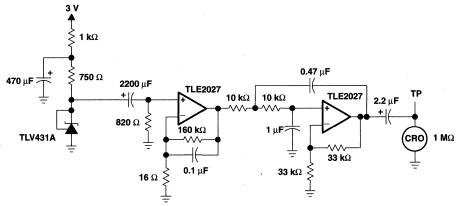


Test circuit for equivalent noise voltage

Figure 10

EQUIVALENT INPUT NOISE VOLTAGE OVER A 10-SECOND PERIOD

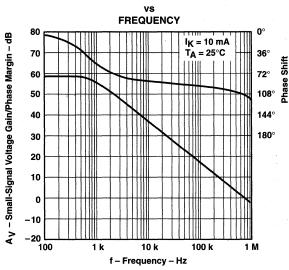




Test circuit for 0.1-Hz to 10-Hz equivalent noise voltage

Figure 11

SMALL-SIGNAL VOLTAGE GAIN /PHASE MARGIN



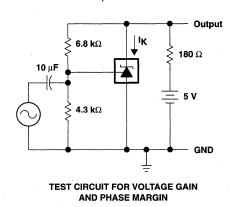
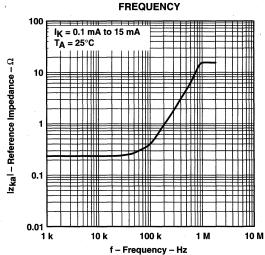


Figure 12

REFERENCE IMPEDANCE vs



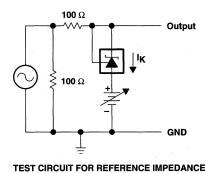
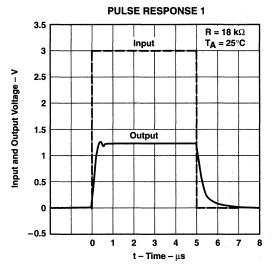


Figure 13



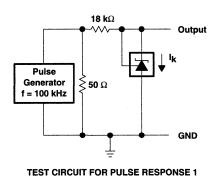
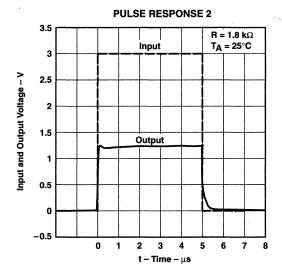


Figure 14



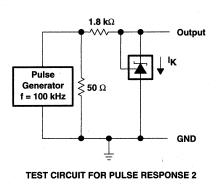
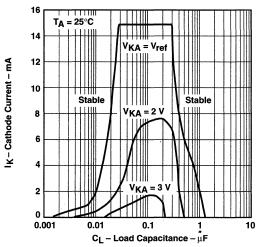
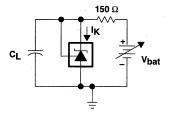
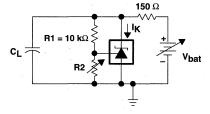


Figure 15

STABILITY BOUNDARY CONDITION[†]







TEST CIRCUIT FOR V_{KA} = V_{ref}

TEST CIRCUIT FOR V_{KA} = 2 V, 3 V

Figure 16

[†] The areas under the curves represent conditions that may cause the device to oscillate. For $V_{KA} = 2 V$ and 3 V curves, R2 and V_{bat} were adjusted to establish the initial V_{KA} and V_{KA} and V_{KA} and V_{CA} and $V_$

APPLICATION INFORMATION

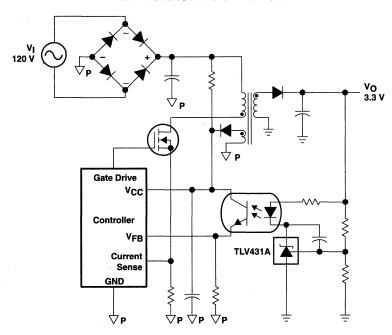


Figure 17. Flyback with Isolation using TLV431A as Voltage Reference and Error Amplifier.

Figure 17 shows the TLV431A used in a 3.3-V isolated flyback supply. V_O of the TLV431A can be as low as V_{ref} (1.244 V \pm 1%). The output of the regulator plus the forward voltage drop of the optocoupler LED (1.244 + 1.4 = 2.644 V) determine the minimum voltage that can be regulated in an isolated supply configuration. Regulated voltage as low as 2.7 Vdc is possible in the above topology.

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- Fixed 3.3-V Output
- ±1% Maximum Output Voltage Tolerance at T_{.1} = 25°C
- 500-mV Maximum Dropout Voltage at 500-mA
- 500-mA Dropout Current
- ±2% Absolute Output Voltage Variation
- Internal Overcurrent Limiting
- Internal Thermal Overload Protection
- Internal Overvoltage Protection

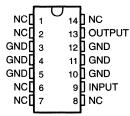
description

The TLV2217-33 is a low-dropout 3.3-V fixed voltage regulator. The regulator is capable of sourcing 500 mA of current with an input-output differential of 0.5 V or less. The TLV 2217-33 provides internal overcurrent limiting, thermal overload protection, and overvoltage protection.

The 0.5-V dropout for the TLV2217-33 makes it ideal for battery applications in 3.3-V logic systems. For example, battery input voltage to the regulator may drop as low as 3.8 V, and the TLV2217-33 will continue to regulate the system. For higher voltage systems, the TLV2217-33 may be operated with a continuous input voltage of 12 V.

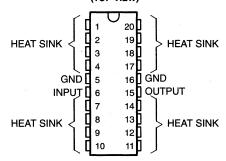
The TLV2217-33N and TLV2217-33KC cannot be harmed by temporary mirror-image insertion. This regulator is characterized for operation from 0°C to 125°C virtual junction temperature.

N PACKAGE (TOP VIEW)



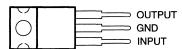
NC - No internal connection

PW PACKAGE (TOP VIEW)

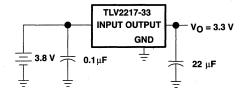


HEAT SINK – These pins have an internal resistive connection to ground and should be grounded.

(TOP VIEW)



application schematic



AVAILABLE OPTIONS

		CHIP		
TJ	PLASTIC POWER (KC)	PLASTIC DIP	SURFACE MOUNT (PW)†	FORM (Y)
0°C to 125°C	TLV2217-33KC	TLV2217-33N	TLV2217-33PWLE	TLV2217-33Y

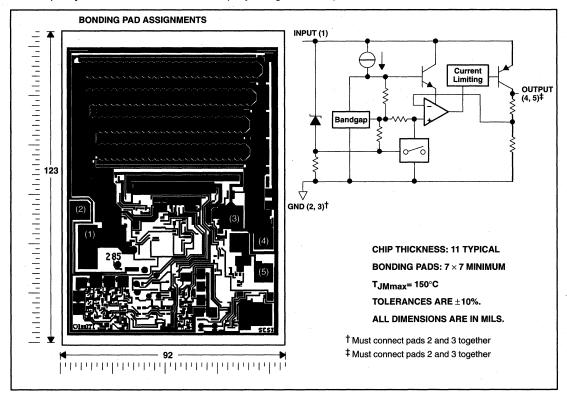
[†]The PW package is only available left-end taped and reeled.



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TLV2217-33Y chip information

These chips, when properly assembled, display characteristics similar to the TLV2217-33 (see electrical Tables). Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating virtual junction temperature range (unless otherwise noted) \dagger

NOTE 1: Refer to Figures 1 and 2 to avoid exceeding the design maximum virtual junction temperature; these ratings should not be exceeded.

Due to variation in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

DISSIPATION RATING TABLE

			*			
PACKAGE	POWER RATING AT	T ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T = 25°C	T = 70°C POWER RATING	T = 85°C POWER RATING	T = 125°C POWER RATING
VC.	TA	2000 mW	16.0 mW/°C	1280 mW	1040 mW	400 mW
КС	τ _C †	20000 mW :	182.0 mW/°C	14540 mW	11810 mW	4645 mW
N.	TA	2250 mW	18.0 mW/°C	1440 mW	1170 mW	450 mW
N	T _C	11850 mW	94.8 mW/°C	7584 mW	6162 mW	2370 mW
DW	TA	950 mW	7.6 mW/°C	608 mW	494 mW	190 mW
PW .	TC	4625 mW	37.0 mW/°C	2960 mW	2405 mW	925 mW

[†] Derate above 40°C

25

MAXIMUM CONTINUOUS DISSIPATION

FREE-AIR TEMPERATURE 2400 D - Maximum Continuous Dissipation - mW 2200 2000 1800 $R_{\theta JA} = 62.5^{\circ}C/W$ 1600 1400 $R_{\theta JA} = 55.6$ °C/W 1200 1000 800 600 400 PW = 133°C/W 200 0

Figure 1

TA - Free-Air Temperature - °C

MAXIMUM CONTINUOUS DISSIPATION

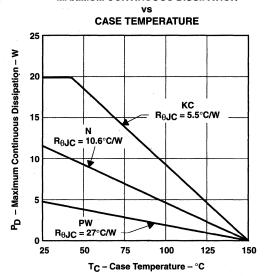


Figure 2

150

125

100

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

TLV2217-33, TLV2217-33Y LOW-DROPOUT 3.3-V FIXED VOLTAGE REGULATORS

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recommended operating conditions

	MIN	MAX	UNIT
Input voltage, V _I	3.8	12	V
Output current, IO	0	500	mA
Operating virtual junction temperature range, TJ	0	125	°C

electrical characteristics at $V_I = 4.5 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONST			TLV2217-33			
PARAMETER	lesi CONDI	TEST CONDITIONS			MAX	UNIT	
Output voltage	I _O = 20 mA to 500 mA,	T _J = 25°C	3.267	3.30	3.333	V	
	V _I = 3.8 V to 5.5 V	T _J = 0°C to 125°C	3.234		3.366	٧	
Input voltage regulation	V _I = 3.8 V to 5.5 V		5	15	mV		
Ripple rejection	f = 120 Hz, V _{ripple} = 1 V _{PP}			-62	,	dB	
Output voltage regulation	I _O = 20 mA to 500 mA			5	30	mV	
Output noise voltage	f = 10 Hz to 100 kHz			500		μV	
Dropout voltage	I _O = 250 mA				400	mV	
Diopout voltage	I _O = 500 mA			500	1117		
Bias current	IO = 0			2	5	mA	
Dias current	I _O = 500 mA			19	49	ША	

electrical characteristics at $V_I = 4.5 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

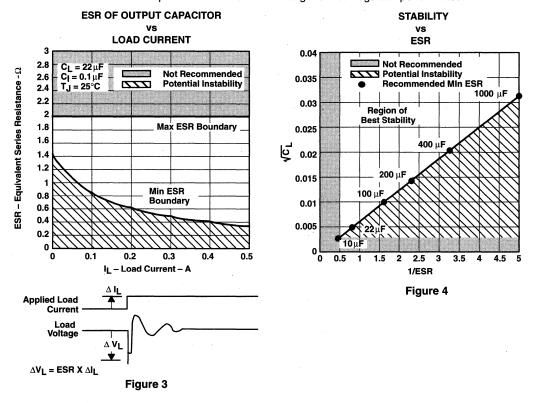
PARAMETER	TEST SOME	TEST CONDITIONS†			TLV2217-33Y			
PARAMETER	IESI CONL				MAX	UNIT		
Output voltage	I _O = 20 mA to 500 mA,	V _I = 3.8 V to 5.5 V	3.267	3.30	3.333	V		
Input voltage regulation	V _I = 3.8 V to 5.5 V		1	5	15	mV		
Ripple rejection	f = 120 Hz, V _{ripple} = 1 Vpp			-62		dB		
Output voltage regulation	I _O = 20 mA to 500 mA			5	30	mV		
Output noise voltage	f = 10 Hz to 100 kHz			500	,	μV		
Dropout voltage	I _O = 250 mA				400	mV		
Dropout voltage	I _O = 500 mA				500	1110		
Bias current	I _O = 0			2	5	mA		
Dias current	I _O = 500 mA			19	49	III/A		

[†] Pulse-testing techniques are used to maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1- μ F capacitor across the input and a 22- μ F tantalum capacitor with equivalent series resistance of $1.5~\Omega$ on the output.

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COMPENSATION CAPACITOR SELECTION INFORMATION

The TLV2217-33 is a low-dropout regulator. This means that the capacitance loading is important to the performance of the regulator because it is a vital part of the control loop. The capacitor value and the equivalent series resistance (ESR) both affect the control loop and must be defined for the load range and the temperature range. Figures 3 and 4 can be used to establish the capacitance value and ESR range for best regulator performance.



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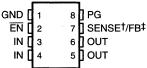
- Available in 5-V, 4.85-V, and 3.3-V
 Fixed-Output and Adjustable Versions
- Very Low-Dropout Voltage . . . Maximum of 32 mV at I_O = 100 mA (TPS7150)
- Very Low Quiescent Current Independent of Load . . . 285 µA Typ
- Extremely Low Sleep-State Current 0.5 μA Max
- 2% Tolerance Over Full Range of Load, Line, and Temperature for Fixed-Output Versions
- Output Current Range of 0 mA to 500 mA
- TSSOP Package Option Offers Reduced Component Height for Critical Applications
- Power Good (PG) Status Output

description

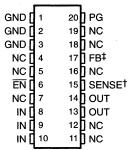
The TPS71xx integrated circuits are a family of micropower low-dropout (LDO) voltage regulators. An order of magnitude reduction in dropout voltage and quiescent current over conventional LDO performance is achieved by replacing the typical pnp pass transistor with a PMOS device.

Because the PMOS device behaves as a low-value resistor, the dropout voltage is very low (maximum of 32 mV at an output current of 100 mA for the TPS7150) and is directly proportional to the output current (see Figure 1). Additionally, since the PMOS pass element is a voltage-driven device, the quiescent current is very low and remains independent of output loading (typically 285 μA over the full range of output current, 0 mA to 500 mA). These two key specifications yield a significant improvement in operating life for battery-powered systems. The LDO family also features a sleep mode; applying a TTL high signal to EN (enable) shuts down the regulator, reducing the guiescent current to 0.5 µA maximum at $T_{.J} = 25^{\circ}C.$





PW PACKAGE (TOP VIEW)



NC – No internal connection † SENSE – Fixed voltage options only (TPS7133, TPS7148, and TPS7150) ‡ FB – Adjustable version only (TPS7101)

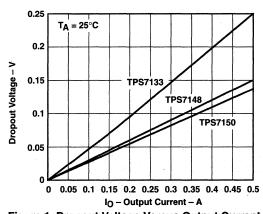


Figure 1. Dropout Voltage Versus Output Current

Power good (PG) reports low output voltage and can be used to implement a power-on reset or a low-battery indicator.

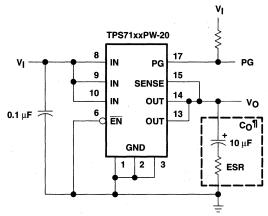
The TPS71xx is offered in 3.3-V, 4.85-V, and 5-V fixed-voltage versions and in an adjustable version (programmable over the range of 1.2 V to 9.75 V). Output voltage tolerance is specified as a maximum of 2% over line, load, and temperature ranges (3% for adjustable version). The TPS71xx family is available in PDIP (8 pin), SO (8 pin), and TSSOP (20 pin) packages. The TSSOP has a maximum height of 1.2 mm.

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AVAILABLE OPTIONS

_	OUTPUT VOLTAGE (V)			PÁ	CHIP FORM		
TJ	MIN	TYP	MAX	SMALL OUTLINE (D)	PLASTIC DIP (P)	TSSOP (PW)	(Y)
	4.9	5	5.1	TPS7150QD	TPS7150QP	TPS7150QPWLE	TPS7150Y
	4.75	4.85	4.95	TPS7148QD	TPS7148QP	TPS7148QPWLE	TPS7148Y
-55°C to 150°C	3.23	3.3	3.37	TPS7133QD	TPS7133QP	TPS7133QPWLE	TPS7133Y
	l .	ljustable V to 9.75		TPS7101QD	TPS7101QP	TPS7101QPWLE	TPS7101Y

The D package is available taped and reeled. Add R suffix to device type (e.g., TPS7150QDR). The PW package is only available left-end taped and reeled and is indicated by the LE suffix on the device type (i.e., TPS7150QPWLE). The TPS7101Q is programmable using an external resistor divider (see application information). The chip form is tested at 25°C.



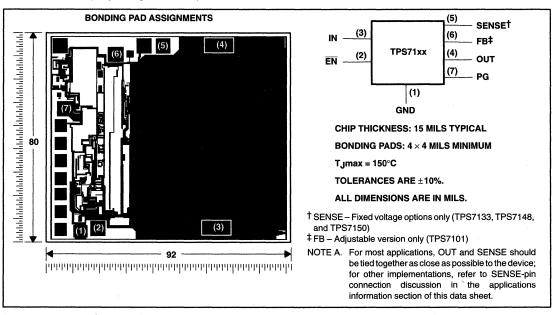
[¶] Capacitor selection is nontrivial. See application information section for details.

Figure 2. Typical Application Configuration

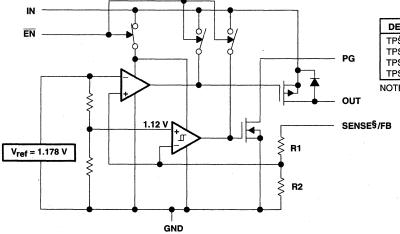
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TPS71xx chip information

These chips, when properly assembled, display characteristics similar to the TPS71xxQ. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



functional block diagram



RESISTOR DIVIDER OPTIONS

DEVICE	R1	R2	UNIT
TP\$7101	0	∞.	Ω
TPS7133	420	233	kΩ
TPS7148	726	233	kΩ
TPS7150	756	233	kΩ

NOTE: Resistors are nominal values only.

[§] For most applications, SENSE should be externally connected to OUT as close as possible to the device. For other implementations, refer to SENSE-pin connection discussion in applications information section.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Input voltage range‡, V _I , PG, SENSE, EN	0.3 to 10 V
Output current, IO	2 A
Continuous total power dissipation	See Dissipation Rating Tables 1 and 2
Operating virtual junction temperature range, T _J	–55°C to 150°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE 1 - FREE-AIR TEMPERATURE (see Figure 3)

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	145 mW
Р	1175 mW	9.4 mW/°C	752 mW	235 mW
PW§	700 mW	5.6 mW/°C	448 mW	140 mW

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE (see Figure 4)

PACKAGE	T _C ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _C = 25°C	T _C = 70°C POWER RATING	T _C = 125°C POWER RATING
D	2188 mW	17.5 mW/°C	1400 mW	438 mW
P	2738 mW	21.9 mW/°C	1752 mW	548 mW
PW§	4025 mW	32.2 mW/°C	2576 mW	805 mW

[§] Refer to thermal information section for detailed power dissipation considerations when using the TSSOP package.

DISSIPATION DERATING CURVE

FREE-AIR TEMPERATURE

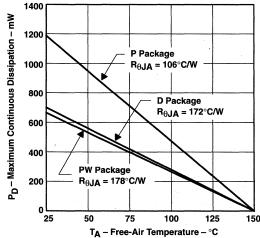


Figure 3

DISSIPATION DERATING CURVE

CASE TEMPERATURE

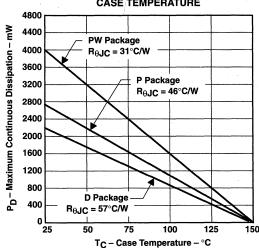


Figure 4

[‡] All voltage values are with respect to network terminal ground.

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recommended operating conditions

			MIN	MAX	UNIT
	TPS7101Q		2.5	10	
Input voltage, Vi [†]	TPS7133Q		3.77	10	v
input voitage, vpi	TPS7148Q		5.2	10	v
	TPS7150Q		5.33	10	
High-level input voltage at EN, VIH			2		٧
Low-level input voltage at EN, V _{IL}				0.5	٧
Output current range, IO			0	500	mA
Operating virtual junction temperature range, TJ		,	-40	125	°C

[†] Minimum input voltage defined in the recommended operating conditions is the maximum specified output voltage plus dropout voltage at the maximum specified load range. Since dropout voltage is a function of output current, the usable range can be extended for lighter loads. To calculate the minimum input voltage for your maximum output current, use the following equation:

Because the TPS7101 is programmable, $r_{DS(on)}$ should be used to calculate V_{DO} before applying the above equation. The equation for calculating V_{DO} from $r_{DS(on)}$ is given in Note 2 in the electrical characteristics table. The minimum value of 2.5 V is the absolute lower limit for the recommended input voltage range for the TPS7101.

electrical characteristics at I $_{O}$ = 10 mA, $\overline{\text{EN}}$ = 0 V, C_{O} = 4.7 μ F/ESR † = 1 Ω , SENSE/FB shorted to OUT (unless otherwise noted)

PARAMETER	TEST COI	NDITIONS‡	T,j		1Q, TPS 8Q, TPS		UNIT	
				MIN	TYP	MAX		
Cround current (active made)	EN ≤ 0.5 V,	V _I = V _O + 1 V,	25°C		285	350		
Ground current (active mode)	0 mA ≤ I _O ≤ 500 m		-40°C to 125°C			460	μΑ	
Input current (standby mode)	EN V	071/41/4401/	25°C			0.5		
input current (standby mode)	EN = VI,	2.7 V \(\times \(\times \) \(\times \) \(\times \)	-40°C to 125°C		1	2	μΑ	
Output current limit	V- 0V	V- 40.V	25°C		1.2	2	A	
Output current limit	TEST CONDITIONS‡ $\overline{EN} \le 0.5 \text{ V}, V_{I} = V_{O} + 1 \text{ or } mA \le I_{O} \le 500 \text{ mA}$ $\overline{EN} = V_{I}, 2.7 \text{ V} \le V_{I} \le V_{O} = 10 \text{ V}$ $\overline{EN} = V_{I}, 2.7 \text{ V} \le V_{I} \le V_{O} = 10 \text{ V}$ Normal operation, $V_{PG} = 10 \text{ V}$ $2.5 \text{ V} \le V_{I} \le 6 \text{ V}$ $6 \text{ V} \le V_{I} \le 10 \text{ V}$ $2.7 \text{ V} \le V_{I} \le 10 \text{ V}$ $0 \text{ V} \le V_{I} \le 10 \text{ V}$ $1_{PG} = 300 \text{ μA}$	V = 10 V	-40°C to 125°C			2	A	
Pass-element leakage current	EN V 07V (V (10V		25°C			0.5		
in standby mode	EN = VI,	$2.7 \text{ V} \leq \text{V}_1 \leq 10 \text{ V}$	-40°C to 125°C			1	μΑ	
PG leakage current		V _{PG} = 10 V	25°C		0.02	0.5	μΑ	
	Normal operation,		-40°C to 125°C			0.5		
Output voltage temperature coefficient			-40°C to 125°C		61	75	ppm/°C	
Thermal shutdown junction temperature					165		°C	
TAI leade black (should be under	2.5 V ≤ V _I ≤ 6 V		-40°C to 125°C	2			.,	
EN logic high (standby mode)	6 V ≤ V _I ≤ 10 V		-40°C to 125°C	1.2 2 25°C 2 25°C 0.5 25°C 0.5 25°C 0.5 25°C 61 75 165 25°C 2 2.7 0.8 25°C 0.5		٧		
EVI I and I	0.7.1/ < 40.1/		25°C			0.5	V	
EN logic low (active mode)	$0 \text{ mA} \le I_O \le 500 \text{ m}$ $\overline{EN} = V_I,$ $V_O = 0 \text{ V},$ $\overline{EN} = V_I,$ Normal operation, $2.5 \text{ V} \le V_I \le 6 \text{ V}$ $6 \text{ V} \le V_I \le 10 \text{ V}$ $2.7 \text{ V} \le V_I \le 10 \text{ V}$ $0 \text{ V} \le V_I \le 10 \text{ V}$		-40°C to 125°C			0.5	\ \	
EN hysteresis voltage			25°C		50		mV	
EN :	0.1/ < 1/ < 10.1/		25°C	-0.5		0.5		
EN input current	0 0 2 0 2 10 0		-40°C to 125°C	-0.5		0.5	μΑ	
Minimum V _I for active pass element			25°C		2.05	2.5	V	
withinfull vi for active pass element			-40°C to 125°C		-	2 2 2 2 0.5 1 2 0.5 0.5 5 0.5 0.5 0.5 0.5 0.5 0.5 0.5 0	ľ	
Minimum V. for valid DC	1 000 4		25°C		1.06	1.5		
Minimum V _I for valid PG	IPG = 300 μA		-40°C to 125°C		,	1.9	V	

[†]ESR refers to the equivalent resistance, including internal resistance and series resistance.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.



 $V_{I(min)} = V_{O(max)} + V_{DO(max load)}$

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electrical characteristics at I_O = 10 mA, V_I = 3.5 V, $\overline{\text{EN}}$ = 0 V, C_O = 4.7 $\mu\text{F/ESR}^{\dagger}$ = 1 Ω , FB shorted to OUT at device leads (unless otherwise noted)

	TEST CONDITIONS‡			· _	7				
PARAMETER	TEST CO	NDITION	IS T	TJ	MIN	TYP	MAX	UNIT	
Reference voltage	V _I = 3.5 V,	IO = 10) mA	25°C		1.178		٧	
(measured at FB with OUT connected to FB)	2.5 V ≤ V _I ≤ 10 V, See Note 1	5 mA ≤	I _O ≤ 500 mA,	-40°C to 125°C	1.143		1.213	V	
Reference voltage temperature coefficient				-40°C to 125°C	·	61	75	ppm/°C	
	V _I = 2.4 V,	A	A	25°C		0.7	1		
		50 μA s	≤ I _O ≤ 150 mA	-40°C to 125°C			1		
	V 0.4V	450		25°C		0.83	1.3	1	
Pass-element series resistance (see Note 2)	$V_1 = 2.4 V,$	150 m/	$A \le I_O \le 500 \text{ mA}$	-40°C to 125°C			1.3		
	V 00V	F0. 4	-1 FOO A	25°C		0.52	0.85	Ω	
	$V_1 = 2.9 V_1$	50 μA s	≤ I _O ≤ 500 mA	-40°C to 125°C			0.85	1	
l ∨	V _I = 3.9 V,	50 μA s	≤ I _O ≤ 500 mA	25°C		0.32			
	V _I = 5.9 V,	50 μA s	≤ I _O ≤ 500 mA	25°C		0.23			
	V _I = 2.5 V to 10 V,	50 μ A ≤ I _O ≤ 500 mA,		25°C			18	mV	
	See Note 1			-40°C to 125°C			25	IIIV	
	$I_O = 5$ mA to 500 mA, 2.5 V \leq V $_I \leq$ 10 V, See Note 1		V _I ≤ 10 V,	25°C			14	mV	
				-40°C to 125°C			25] ""	
Output regulation	$I_O = 50 \ \mu A$ to 500 mA, $2.5 \ V \le V_I \le 10 \ V$, See Note 1		25°C			22	mV		
			-40°C to 125°C			54	liiv		
			Io - 50A	25°C	48	59		dB	
Ripple rejection	f = 120 Hz		ΙΟ = 50 μΑ	-40°C to 125°C	44				
nipple rejection	1 = 120 HZ		I _O = 500 mA, See Note 1	25°C	45	54] ub	
				-40°C to 125°C	44				
Output noise-spectral density	f = 120 Hz			25°C		2		μV/√ Hz	
			C _O = 4.7 μF	25°C		95			
Output noise voltage	10 Hz \leq f \leq 100 kHz, ESRT = 1 Ω		C _O = 10 μF	25°C		89		μVrms	
			C _O = 100 μF	25°C		74			
PG trip-threshold voltage§	VFB voltage decreasing from above VPG		-40°C to 125°C	0.92 × VFB(nom)	- 1	0.98 × V _{FB(nom)}	V		
PG hysteresis voltage§	Measured at VFB		25°C		12		mV		
PO	100.4	ν' C.	10.1/	25°C		0.1	0.4	, , , , , , , , , , , , , , , , , , ,	
PG output low voltage§	I _{PG} = 400 μA,	V _I = 2.	13 V	-40°C to 125°C			0.4	'	
FD :			-	25°C	-10	0.1	10		
FB input current				-40°C to 125°C	-20	1.	20	nA	

 $[\]dagger$ ESR refers to the equivalent resistance including internal resistance and series resistance.

 $V_{DO} = I_O \cdot r_{DS(on)}$

 $r_{DS(on)}$ is a function of both output current and input voltage. The parametric table lists $r_{DS(on)}$ for $V_I = 2.4$ V, 2.9 V, 3.9 V, and 5.9 V, which corresponds to dropout conditions for programmed output voltages of 2.5 V, 3 V, 4 V, and 6 V, respectively. For other programmed values, refer to Figure 30.



[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

[§] Output voltage programmed to 2.5 V with closed-loop configuration (see application information).

NOTES: 1. When V_I < 2.9 V and I_O > 150 mA simultaneously, pass element r_{DS(on)} increases (see Figure 31) to a point such that the resulting dropout voltage prevents the regulator from maintaining the specified tolerance range.

^{2.} To calculate dropout voltage, use equation:

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electrical characteristics at I_O = 10 mA, V_I = 4.3 V, $\overline{\text{EN}}$ = 0 V, C_O = 4.7 $\mu\text{F/ESR}^{\dagger}$ = 1 Ω , SENSE shorted to OUT (unless otherwise noted)

040445750	TEST CONDITIONS‡		-	TPS7133Q			
PARAMETER	TEST CON	IDITIONS+	TJ	MIN	TYP	MAX	UNIT
Outrout wells as	V _I = 4.3 V,	I _O = 10 mA	25°C		3.3	3.37 6 8 60 80 300 400 0.6 0.8 20 27 38 75 60 120	V
Output voltage	$4.3 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V},$	5 mA ≤ I _O ≤ 500 mA	-40°C to 125°C	3.23		3.37	l ^v
	I= 10 mA	V. 2.02.V	25°C		0.02	6	
	I _O = 10 mA,	V _I = 3.23 V	-40°C to 125°C			8	
Dunnandrialtana	IO = 100 mA,	V _I = 3.23 V	25°C		47	60	mV
Dropout voltage	10 = 100 mA,	V = 3.23 V	-40°C to 125°C			80	1117
	lo 500 mA	V 2 22 V	25°C		235	300	
e e	$I_{O} = 500 \text{ mA},$	V _I = 3.23 V	-40°C to 125°C			400	
Pass-element series resistance	(3.23 V - V _O)/I _O ,	V _I = 3.23 V,	25°C		0.47	0.6	0
rass-element series resistance	I _O = 500 mA	500 mA	-40°C to 125°C			0.8	Ω
Input regulation	V _I = 4.3 V to 10 V,	50 μA ≤ I _O ≤ 500 mA	25°C			20	mV
			-40°C to 125°C			27	
	I _O = 5 mA to 500 mA,	4.3 V ≤ V _I ≤ 10 V	25°C		21	38	mV
			-40°C to 125°C			75	mv
Output regulation	I _O = 50 μA to 500 mA,	, 4.3 V ≤ V _I ≤ 10 V	25°C		30	60	mV
			-40°C to 125°C			120	
		I- 50 A	25°C	43	54		dB
Dinula valentian	f = 120 Hz	ΙΟ = 50 μΑ	-40°C to 125°C	40			
Ripple rejection	1 = 120 HZ	I _O = 500 mA	25°C	39	49		
			-40°C to 125°C	36			
Output noise-spectral density	f = 120 Hz	-	25°C		. 2		μV/√Hz
		C _O = 4.7 μF	25°C		274		
Output noise voltage	10 Hz \leq f \leq 100 kHz, ESR [†] = 1 Ω	C _O = 10 μF	25°C		228		μVrms
	LON1 = 1 12	C _O = 100 μF	25°C		159		
PG trip-threshold voltage	VO voltage decreasing	<u> </u>	-40°C to 125°C	0.92× V _{O(nom)}		0.98 × V _{O(nom)}	٧
PG hysteresis voltage			25°C		35		mV
BO			25°C		0.22	0.4	,,
PG output low voltage	IPG = 1 mA,	$V_{ } = 2.8 \text{ V}$	-40°C to 125°C			0.4	V

[†] ESR refers to the equivalent resistance including internal resistance and series resistance.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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electrical characteristics at I $_{O}$ = 10 mA, V $_{I}$ = 5.85 V, \overline{EN} = 0 V, C_{O} = 4.7 μ F/ESR † = 1 Ω , SENSE shorted to OUT (unless otherwise noted)

***	TEST CONDITIONS‡			TF	UNIT		
PARAMETER	TEST CON	IDITIONS+	TJ	MIN	TYP	MAX	UNII
O. da. da. alta ana	V _I = 5.85 V,	I _O = 10 mA	25°C		4.85 4.95 0.08 6 8 30 37 54 150 180 250 0.32 0.35 0.52 27 37 12 42 80 42 60 130 53 50 2 410 328 212 2× 0.98 >		V
Output voltage	$5.85 \text{ V} \le \text{V}_{\parallel} \le 10 \text{ V},$	5 mA ≤ I _O ≤ 500 mA	-40°C to 125°C	4.75		4.95	V 1
	1 40 4	V 475V	25°C		0.08	6	
	I _O = 10 mA,	V _I = 4.75 V	-40°C to 125°C			8	
	100 4	V. 475.V	25°C		30	37	mV
Dropout voltage	I _O = 100 mA,	$V_{I} = 4.75 \text{ V}$	-40°C to 125°C			54	mv
		\\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	25°C		150	180	
	I _O = 500 mA,	$V_{ } = 4.75 \text{ V}$	-40°C to 125°C			250	
D	(4.75 V – V _O)/I _O ,	V _I = 4.75 V,	25°C		0.32	0.35	Ω
Pass-element series resistance	l _O = 500 mA	•	-40°C to 125°C			0.52	
h11	V 505V4-40V	F0 A < L < F00 A	25°C			27	mV
Input regulation	$V_{\parallel} = 5.85 \text{ V to } 10 \text{ V},$	20 ha ≥ 10 ≥ 200 ma	-40°C to 125°C			37	
	I _O = 5 mA to 500 mA,	5.85 V ≤ V _I ≤ 10 V	25°C		12	42	mV
Out and an analysis and			-40°C to 125°C			80	
Output regulation	L	, 5.85 V ≤ V _I ≤ 10 V	25°C		42	60	mV
	$10 = 50 \mu\text{A}$ to 500 mA,		-40°C to 125°C			130	
		T	25°C	42	53		
Disalement	40011-	IO = 50 μA	-40°C to 125°C	39			ا ا
Ripple rejection	f = 120 Hz	I _O = 500 mA	25°C	39	50		dB
			-40°C to 125°C	35			
Output noise-spectral density	f = 120 Hz		25°C		2		μV/√Hz
		C _O = 4.7 μF	25°C		410		
Output noise voltage	10 Hz \leq f \leq 100 kHz, ESR [†] = 1 Ω	C _O = 10 μF	25°C		328		μVrms
	LOT(1 = 1 32	C _O = 100 μF	25°C		212		
PG trip-threshold voltage	VO voltage decreasing from above VpG		-40°C to 125°C	0.92 × V _{O(nom)}		0.98 × V _{O(nom)}	V
PG hysteresis voltage			25°C		50		mV
DC autout law alta as	12 mA	V: - 4.12 V	25°C		0.2	0.4	v
PG output low voltage	IPG = 1.2 mA,		-40°C to 125°C			0.4]

[†] ESR refers to the equivalent resistance including internal resistance and series resistance.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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electrical characteristics at I_O = 10 mA, V_I = 6 V, \overline{EN} = 0 V, C_O = 4.7 μ F/ESR[†] = 1 Ω , SENSE shorted to OUT (unless otherwise noted)

PARAMETER	TEST CONDITIONS‡		т.	TPS7150Q			UNIT
PARAMETER	I ESI CON	NDITIONS+	TJ	MIN	TYP	MAX	UNII
Output voltage	V _I = 6 V,	I _O = 10 mA	25°C		5	5.1 6 8 32 47 170 230 0.32 0.47 25 32 45 86 65 140	V
Output voitage	6 V ≤ V _I ≤ 10 V,	$5 \text{ mA} \le I_{\text{O}} \le 500 \text{ mA}$	-40°C to 125°C	4.9		5.1	1 °
	I- 10 A	V: 400 V	25°C		0.13	6	
	I _O = 10 mA,	V _I = 4.88 V	-40°C to 125°C			8	
Dunnandrialtana	IO = 100 mA,	V _I = 4.88 V	25°C		27	32	mV
Dropout voltage	10 = 100 IIIA,	V = 4.00 V	-40°C to 125°C			47	l mv
	I- 500 A	V 4.00 V	25°C		146	170	1
	I _O = 500 mA,	V _I = 4.88 V	-40°C to 125°C			230	1
Dana alamanta and a maintana	(4.88 V – V _O)/I _O ,	V _I = 4.88 V.	25°C		0.29	0.32	
Pass-element series resistance	I _O = 500 mA		-40°C to 125°C			0.47	Ω
Input regulation V _I	V _I = 6 V to 10 V,	50 μA ≤ I _O ≤ 500 mA	25°C			25	mV
			-40°C to 125°C			32	
	l- 5 A t- 500 A	6 V ≤ V _I ≤ 10 V	25°C		30	45	mV
Outros to a sudation	10 = 5 mA to 500 mA,		-40°C to 125°C			86	
Output regulation	I _O = 50 μA to 500 mA,	, 6 V ≤ V _I ≤ 10 V	25°C		45	65	m∨
			-40°C to 125°C		311.00	140	
			25°C	45	55		dB
Disale seiseties	f 400 H-	I _O = 50 μA	-40°C to 125°C	40			
Ripple rejection	f = 120 Hz	I _O = 500 mA	25°C	42	52		
			-40°C to 125°C	36			
Output noise-spectral density	f = 120 Hz		25°C		2		μV/√Hz
		C _O = 4.7 μF	25°C		430		
Output noise voltage	10 Hz \leq f \leq 100 kHz, ESR [†] = 1 Ω	C _O = 10 μF	25°C		345		μVrms
•	E2H1 = 177	C _O = 100 μF	25°C		220		1
PG trip-threshold voltage	VO voltage decreasing from above VpG		-40°C to 125°C	0.92 × V _{O(nom)}	_	0.98 × V _{O(nom)}	V
PG hysteresis voltage		`	25°C		53		mV
PO			25°C		0.2	0.4	T
PG output low voltage	$I_{PG} = 1.2 \text{ mA},$	V _I = 4.25 V	-40°C to 125°C			0.4	\

[†] ESR refers to the equivalent resistance including internal resistance and series resistance.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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electrical characteristics at I $_{O}$ = 10 mA, $\overline{\text{EN}}$ = 0 V, C $_{O}$ = 4.7 $\mu\text{F/ESR}^{\dagger}$ = 1 Ω , T $_{J}$ = 25°C, SENSE/FB shorted to OUT (unless otherwise noted)

PARAMETER	TEST CONDITIONS‡		TPS7101Y, TPS7133Y TPS7148Y, TPS7150Y		
		MIN	TYP	MAX	
Ground current (active mode)	$\overline{\text{EN}} \le 0.5 \text{ V}, \qquad \text{V}_{\text{I}} = \text{V}_{\text{O}} + 1 \text{ V}, \\ 0 \text{ mA} \le \text{I}_{\text{O}} \le 500 \text{ mA}$		285		μΑ
Output current limit	$V_{O} = 0 V,$ $V_{I} = 10 V$		1.2		Α
PG leakage current	Normal operation, V _{PG} = 10 V		0.02		μΑ
Thermal shutdown junction temperature			165		°C
EN hysteresis voltage			50		mV
Minimum V _I for active pass element			2.05		V
Minimum V _I for valid PG	I _{PG} = 300 μA		1.06		٧

[†] ESR refers to the equivalent resistance, including internal resistance and series resistance.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

PARAMETER		TPS7101Y				
PARAMETER	IESIC	TEST CONDITIONS‡			MAX	UNIT
Reference voltage (measured at FB with OUT connected to FB)	V _I = 3.5 V,	I _O = 10 mA		1.178		٧
	V _I = 2.4 V,	50 μA ≤ I _O ≤ 150 mA		0.7		
	V _I = 2.4 V,	150 mA $\leq I_{O} \leq$ 500 mA		0.83		
Pass-element series resistance (see Note 2)	V _I = 2.9 V,	$50 \ \mu\text{A} \le I_{\mbox{O}} \le 500 \ \mbox{mA}$		0.52		Ω
	$V_{I} = 3.9 V$,	$50 \ \mu\text{A} \le I_{\mbox{O}} \le 500 \ \mbox{mA}$		0.32		
	V _I = 5.9 V,	$50 \ \mu\text{A} \le I_{\mbox{O}} \le 500 \ \mbox{mA}$		0.23		
Input regulation	V _I = 2.5 V to 10 V, See Note 1	50μ A ≤ I O ≤ 500μ A,			18.	mV
	2.5 V ≤ V _I ≤ 10 V, See Note 1	I _O = 5 mA to 500 mA,			14	mV
Output regulation	$2.5 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V},$ See Note 1	$I_{O} = 50 \mu A \text{ to } 500 \text{ mA},$			22	mV
Ripple rejection	V _I = 3.5 V, I _O = 50 μA	f = 120 Hz,		59		dB
Output noise-spectral density	V _I = 3.5 V,	f = 120 Hz		2		μV/√Hz
	V _I = 3.5 V,	C _O = 4.7 μF		95		
Output noise voltage	10 Hz \leq f \leq 100 kHz,	C _O = 10 μF		89		μVrms
	ESR \dagger = 1 Ω	C _O = 100 μF		74		
PG hysteresis voltage§	V _I = 3.5 V,	Measured at V _{FB}		12		mV
PG output low voltage§	V _I = 2.13 V,	lpG = 400 μA		. 0.1		V
FB input current	V _I = 3.5 V			0.1		nA

 $[\]dagger$ ESR refers to the equivalent resistance including internal resistance and series resistance.

 $r_{DS(on)}$ is a function of both output current and input voltage. The parametric table lists $r_{DS(on)}$ for $V_I = 2.4$ V, 2.9 V, 3.9 V, and 5.9 V, which corresponds to dropout conditions for programmed output voltages of 2.5 V, 3 V, 4 V, and 6 V, respectively. For other programmed values, refer to Figure 30.



[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

[§] Output voltage programmed to 2.5 V with closed-loop configuration (see application information).

NOTES: 1 When V_I < 2.9 V and I_O > 150 mA simultaneously, pass element r_{DS(on)} increases (see Figure 31) to a point such that the resulting dropout voltage prevents the regulator from maintaining the specified tolerance range.

² To calculate dropout voltage, use equation:

 $V_{DO} = I_O \cdot r_{DS(on)}$

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electrical characteristics at I_O = 10 mA, \overline{EN} = 0 V, C_O = 4.7 μ F/ESR[†] = 1 Ω , T_J = 25°C, SENSE shorted to OUT (unless otherwise noted) (continued)

PARAMETER	TEOT 00	TEST CONDITIONS‡			TPS7133Y		
PARAMETER	TEST CO				MAX	UNIT	
Output voltage	V _I = 4.3 V,	I _O = 10 mA		3.3		٧	
	V _I = 3.23 V,	I _O = 10 mA		0.02			
Dropout voltage	$V_{I} = 3.23 V$	I _O = 100 mA		47		mV	
	$V_{I} = 3.23 V$	I _O = 500 mA		235			
Pass-element series resistance	(3.23 V – V _O)/I _O , I _O = 500 mA	V _I = 3.23 V,		0.47		Ω	
Output regulation	$4.3 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V},$	I _O = 5 mA to 500 mA		21		mV	
Output regulation	$4.3 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V},$	$I_{O} = 50 \mu A \text{ to } 500 \text{ mA}$		- 30		mV	
Ripple rejection	V _I = 4.3 V,	I _O = 50 μA		54	dB	dD	
nipple rejection	f = 120 Hz	I _O = 500 mA		49		UB	
Output noise-spectral density	V _I = 4.3 V,	f = 120 Hz		2		μV/√Hz	
	V _I = 4.3 V,	C _O = 4.7 μF		274			
Output noise voltage	10 Hz \leq f \leq 100 kHz,	C _O = 10 μF		228		μVrms	
	$ESR^{\dagger} = 1 \Omega$	C _O = 100 μF		159			
PG hysteresis voltage	V _I = 4.3 V			35		mV	
PG output low voltage	V _I = 2.8 V,	Ipg = 1 mA		0.22		V	

[†] ESR refers to the equivalent resistance including internal resistance and series resistance.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

DADAMETED	TEOT 00	TEST COMPLETIONS		TPS7148Y		
PARAMETER	IESI CC	TEST CONDITIONS‡			MAX	UNIT
Output voltage	V _I = 5.85 V,	I _O = 10 mA		4.85		٧
	V _I = 4.75 V,	I _O = 10 mA		0.08		
Dropout voltage	$V_{I} = 4.75 V$	I _O = 100 mA		30		m∨
	V _I = 4.75 V,	I _O = 500 mA		150		1
Pass-element series resistance	(4.75 V – V _O)/I _O , I _O = 500 mA	V _I = 4.75 V,		0.32		Ω
Outroot are materials	5.85 V ≤ V _I ≤ 10 V,	I _O = 5 mA to 500 mA		12		mV
Output regulation	$5.85 \text{ V} \le \text{V}_{j} \le 10 \text{ V},$	I _O = 50 μA to 500 mA		42		mV
Ripple rejection	V _I = 5.85 V, f = 120 Hz	ΙΟ = 50 μΑ		53	ar	dB
hippie rejection		I _O = 500 mA		50		l ub
Output noise-spectral density	V _I = 5.85 V,	f = 120 Hz		2		μV/√Hz
	V _I = 5.85 V,	C _O = 4.7 μF		410		
Output noise voltage	$10 \text{ Hz} \le \text{f} \le 100 \text{ kHz},$	C _O = 10 μF		328		μVrms
	$ESR^{\dagger} = 1 \Omega$	C _O = 100 μF		212		1
PG hysteresis voltage	V _I = 5.85 V			50		mV
PG output low voltage	V _I = 4.12 V,	IpG = 1.2 mA		0.2	0.4	V

[†] ESR refers to the equivalent resistance including internal resistance and series resistance.



[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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electrical characteristics at I $_{O}$ = 10 mA, \overline{EN} = 0 V, C_{O} = 4.7 μ F/ESR † = 1 Ω , T_{J} = 25°C, SENSE shorted to OUT (unless otherwise noted) (continued)

DADAUCTED		TEST CONDITIONS‡			TPS7150Y		
PARAMETER	TEST CO				MAX	UNIT	
Output voltage	V _I = 6 V,	I _O = 10 mA		5		٧	
	V _I = 4.88 V,	I _O = 10 mA		0.13			
Dropout voltage	V _I = 4.88 V,	I _O = 100 mA		27		mV	
-	V _I = 4.88 V,	I _O = 500 μA		146			
Pass-element series resistance	(4.88 V – V _O)/I _O , I _O = 500 mA	V _I = 4.88 V.		0.29		Ω	
	6 V ≤ V _I ≤ 10 V,	I _O = 5 mA to 500 mA		30		mV	
Output regulation	$6 \text{ V} \leq \text{V}_{\parallel} \leq 10 \text{ V},$	I _O = 50 μA to 500 mA		45		mV	
	V _I = 6 V,	ΙΟ = 50 μΑ		55		dB	
Ripple rejection	f = 120 Hz	I _O = 500 mA		52		ав	
Output noise-spectral density	V _I = 6 V,	f = 120 Hz		2		μV/√Hz	
• , •	V _I = 6 V,	C _O = 4.7 μF		430	-		
Output noise voltage	10 Hz ≤ f ≤ 100 kHz,	C _O = 10 μF		345		μVrms	
	$ESR^{\dagger} = 1 \Omega$	C _O = 100 μF		220	-	,	
PG hysteresis voltage	V _I = 6 V			53		mV	
PG output low voltage	V _I = 4.25 V,	IpG = 1.2 mA		0.2		٧	

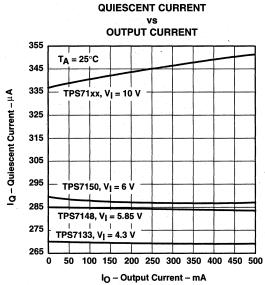
[†] ESR refers to the equivalent resistance including internal resistance and series resistance.

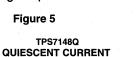
[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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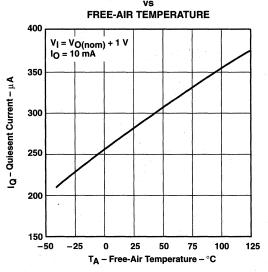


Figure 7

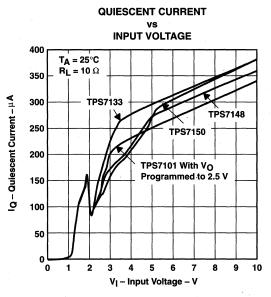


Figure 6

DROPOUT VOLTAGE vs OUTPUT CURRENT

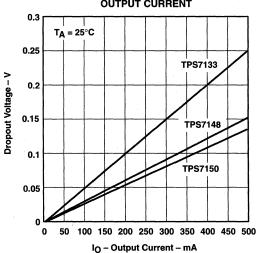


Figure 8



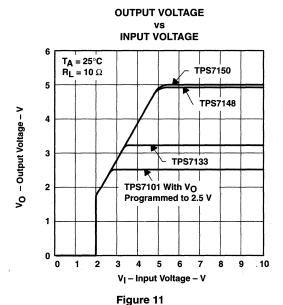
CHANGE IN OUTPUT VOLTAGE

TYPICAL CHARACTERISTICS

CHANGE IN DROPOUT VOLTAGE FREE-AIR TEMPERATURE 10 IO = 100 mA Change in Dropout Voltage – mV 6 2 0 -2 -4 -6 -8 -10 _50 -25 100 125 T_A - Free-Air Temperature - °C

FREE-AIR TEMPERATURE $V_I = V_{O(nom)} + 1 V$ Io = 10 mA 15 ∆V_O - Change in Output Voltage - mV 10 5 0 -5 -10 -15 -20 -50 -25 100 125 TA - Free-Air Temperature - °C

Figure 9



CHANGE IN OUTPUT VOLTAGE vs

Figure 10

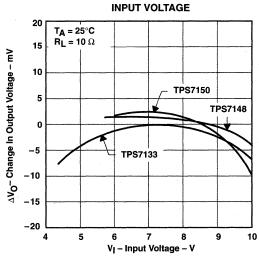
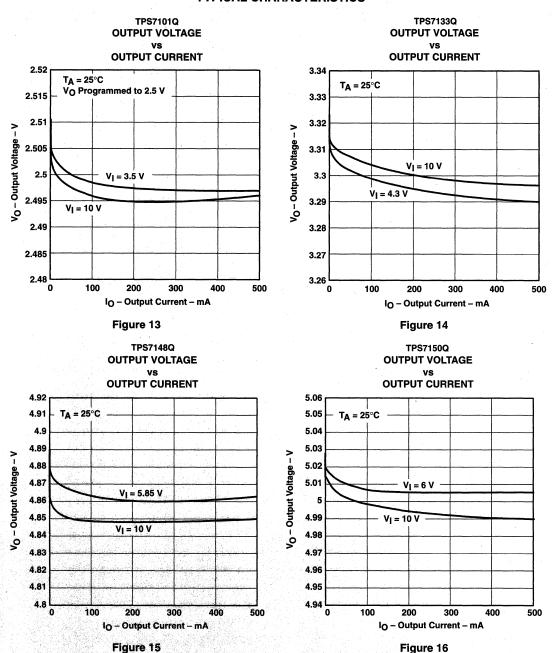


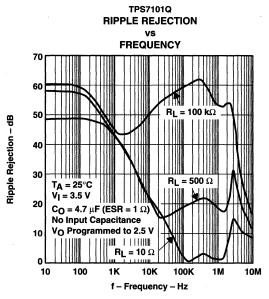
Figure 12



TPS7133Q

RIPPLE REJECTION

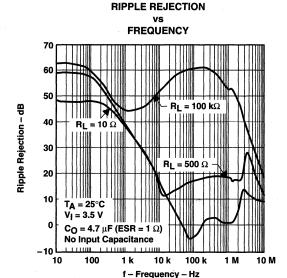
TYPICAL CHARACTERISTICS



FREQUENCY 60 50 Ripple Rejection - dB 40 30 $R_L = 10 \Omega$ 10 Vi = 3.5 V $C_{\Omega} = 4.7 \,\mu\text{F} (ESR = 1 \,\Omega)$ No Input Capacitance 10 100 10 k 100 k 10 M f - Frequency - Hz

Figure 17

TPS7148Q



TPS7150Q RIPPLE REJECTION

Figure 18

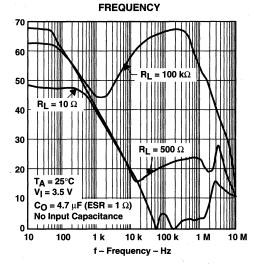


Figure 19

Figure 20



Ripple Rejection - dB

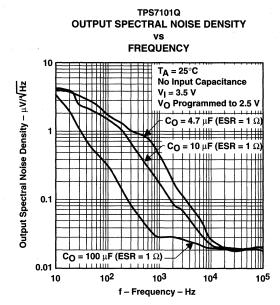


Figure 21

TPS7148Q

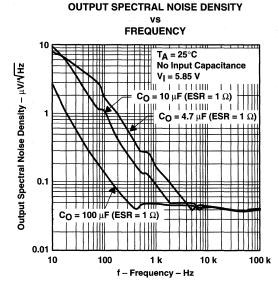


Figure 23

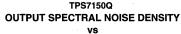
OUTPUT SPECTRAL NOISE DENSITY VS FREQUENCY 10 $T_A = 25^{\circ}C$ No Input Capacitance $V_1 = 4.3 \text{ V}$ $C_O = 10 \text{ µF (ESR = 1 }\Omega)$ $C_O = 100 \text{ µF (ESR = 1 }\Omega)$ 0.1 0.01

TPS7133Q

Figure 22

102

10



103

f - Frequency - Hz

104

105

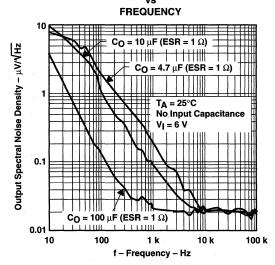


Figure 24



TYPICAL CHARACTERISTICS

PASS-ELEMENT RESISTANCE **INPUT VOLTAGE** T_A = 25°C V_{I(FB)} = 1.12 V $^{\prime}$ DS(on) – Pass-Element Resistance – $^{\Omega}$ 0.9 8.0 $I_O = 500 \text{ mA}$ 0.7 0.6 0.5 IO = 100 mA 0.4 0.3 0.2 3 2 6 V_I - Input Voltage - V

Figure 25

FIXED-OUTPUT VERSIONS

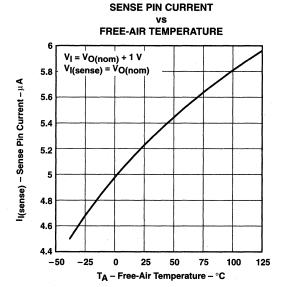


Figure 27

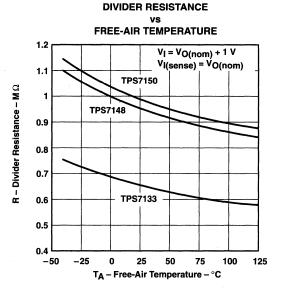
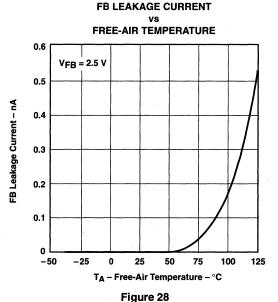


Figure 26

ADJUSTABLE VERSION





TYPICAL CHARACTERISTICS

MINIMUM INPUT VOLTAGE FOR ACTIVE PASS ELEMENT

FREE-AIR TEMPERATURE

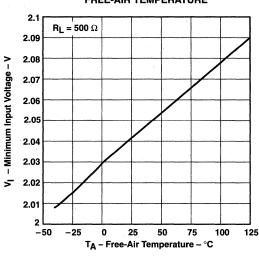


Figure 29

MINIMUM INPUT VOLTAGE FOR VALID **POWER GOOD (PG)**



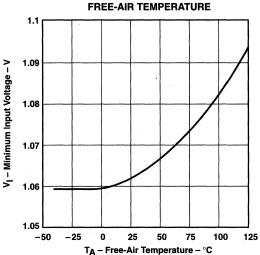


Figure 30

EN INPUT CURRENT

FREE-AIR TEMPERATURE

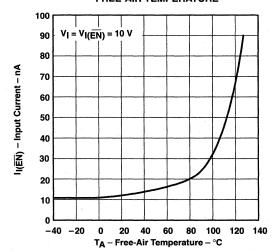


Figure 31

TYPICAL CHARACTERISTICS

OUTPUT VOLTAGE RESPONSE FROM ENABLE (EN)

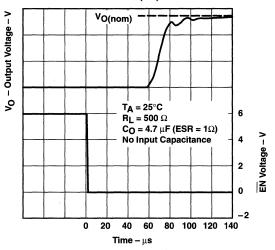


Figure 32

POWER-GOOD (PG) VOLTAGE

OUTPUT VOLTAGE

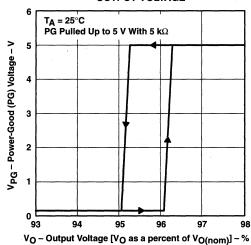


Figure 33



OUTPUT CURRENT

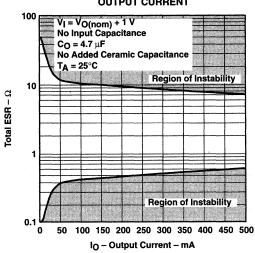


Figure 34

TYPICAL REGIONS OF STABILITY TOTAL ESR

ADDED CERAMIC CAPACITANCE

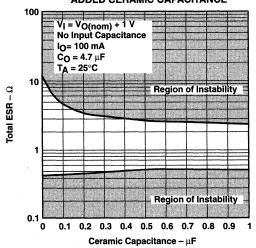


Figure 36

TYPICAL REGIONS OF STABILITY TOTAL ESR

OUTPUT CURRENT

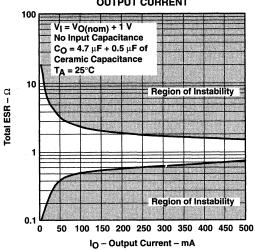


Figure 35

TYPICAL REGIONS OF STABILITY TOTAL ESR

OTAL LON

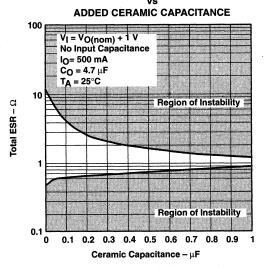


Figure 37



TYPICAL CHARACTERISTICS

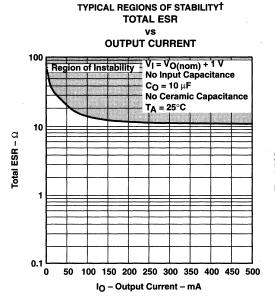


Figure 38



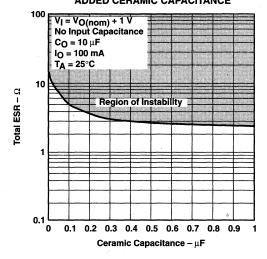


Figure 40

TYPICAL REGIONS OF STABILITY[†] **TOTAL ESR** vs **OUTPUT CURRENT**

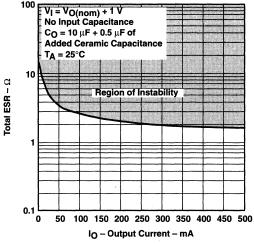


Figure 39

TYPICAL REGIONS OF STABILITY **TOTAL ESR**

ADDED CERAMIC CAPACITANCE

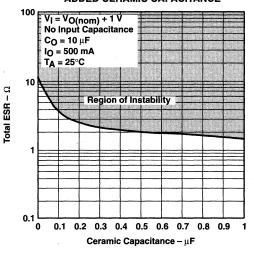


Figure 41

†ESR values below 0.1 Ω are not recommended.



TYPICAL CHARACTERISTICS

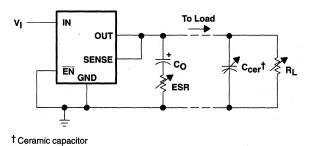


Figure 42. Test Circuit for Typical Regions of Stability (Figures 39 through 46)

THERMAL INFORMATION

In response to system-miniaturization trends, integrated circuits are being offered in low-profile and fine-pitch surface-mount packages. Implementation of many of today's high-performance devices in these packages requires special attention to power dissipation. Many system-dependent issues such as thermal coupling, airflow, added heat sinks and convection surfaces, and the presence of other heat-generating components affect the power-dissipation limits of a given component.

Three basic approaches for enhancing thermal performance are illustrated in this discussion:

- Improving the power-dissipation capability of the PWB design.
- Improving the thermal coupling of the component to the PWB
- Introducing airflow in the system

Figure 43 is an example of a thermally enhanced PWB layout for the 20-lead TSSOP package. This layout involves adding copper on the PWB to conduct heat away from the device. The $R_{\theta,JA}$ for this component/board system is illustrated in Figure 44. The family of curves illustrates the effect of increasing the size of the copper-heat-sink surface area. The PWB is a standard FR4 board (L × W × H = 3.2 inch × 3.2 inch × 0.062 inch); the board traces and heat sink area are 1-oz (per square foot) copper.

Figure 45 shows the thermal resistance for the same system with the addition of a thermally conductive compound between the body of the TSSOP package and the PWB copper routed directly beneath the device. The thermal conductivity for the compound used in this analysis is 0.815 W/m · °C.

Using these figures to determine the system $R_{\theta JA}$ allows the maximum power-dissipation limit to be calculated with the equation:

$$P_{D(max)} = \frac{T_{J(max)} - T_{A}}{R_{\theta JA(system)}}$$

Where

 $T_{J(max)}$ is the maximum allowable junction temperature, (i.e., 150°C absolute maximum and 125°C maximum recommended operating temperature for specified operation).

This limit should then be applied to the internal power dissipated by the TPS71xx regulator. The equation for calculating total internal power dissipation of the TPS71xx is:

$$P_{D(total)} = (V_I - V_O) \cdot I_O + V_I \cdot I_O$$

Because the quiescent current of the TPS71xx family is very low, the second term is negligible, further simplifying the equation to:

$$P_{D(total)} = (V_I - V_O) \cdot I_O$$

For a 20-lead TSSOP/FR4 board system with thermally conductive compound between the board and the device body, where $T_A = 55^{\circ}C$, airflow = 100 ft/min, copper heat sink area = 1 cm², the maximum power-dissipation limit can be calculated. As indicated in Figure 45, the system $R_{\theta JA}$ is 94°C/W; therefore, the maximum power-dissipation limit is:

$$P_{D(max)} = \frac{T_{J(max)} - T_{A}}{R_{\theta JA(system)}} = \frac{125^{\circ}C - 55^{\circ}C}{94^{\circ}C/W} = 745 \text{ mW}$$

If the system implements a TPS7148 regulator where $V_I = 6 \text{ V}$ and $I_O = 385 \text{ mA}$, the internal power dissipation is:

$$P_{D(total)} = (V_1 - V_0) \cdot I_0 = (6 - 4.85) \cdot 0.385 = 443 \text{ mW}$$



THERMAL INFORMATION

Comparing $P_{D(total)}$ with $P_{D(max)}$ reveals that the power dissipation in this example does not exceed the maximum limit. When it does, one of two corrective actions can be taken. The power-dissipation limit can be raised by increasing the airflow or the heat-sink area. Alternatively, the internal power dissipation of the regulator can be lowered by reducing the input voltage or the load current. In either case, the above calculations should be repeated with the new system parameters.

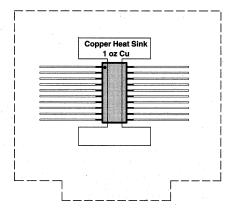


Figure 43. Thermally Enhanced PWB Layout (not to scale) for the 20-Pin TSSOP

THERMAL RESISTANCE, JUNCTION-TO-AMBIENT vs

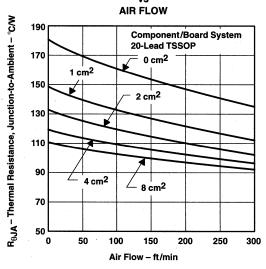


Figure 44

THERMAL RESISTANCE, JUNCTION-TO-AMBIENT

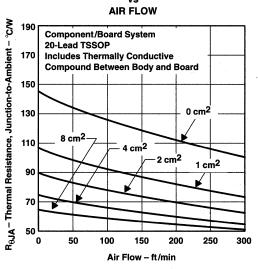


Figure 45

APPLICATION INFORMATION

The TPS71xx series of low-dropout (LDO) regulators is designed to overcome many of the shortcomings of earlier-generation LDOs, while adding features such as a power-saving shutdown mode and a power-good indicator. The TPS71xx family includes three fixed-output voltage regulators: the TPS7133 (3.3 V), the TPS7148 (4.85 V), and the TPS7150 (5 V). The family also offers an adjustable device, the TPS7101 (adjustable from 1.2 V to 9.75 V).

device operation

The TPS71xx, unlike many other LDOs, features very low quiescent currents that remain virtually constant even with varying loads. Conventional LDO regulators use a pnp-pass element, the base current of which is directly proportional to the load current through the regulator ($I_B = I_C/\beta$). Close examination of the data sheets reveals that those devices are typically specified under near no-load conditions; actual operating currents are much higher as evidenced by typical quiescent current versus load current curves. The TPS71xx uses a PMOS transistor to pass current; because the gate of the PMOS element is voltage driven, operating currents are low and invariable over the full load range. The TPS71xx specifications reflect actual performance under load.

Another pitfall associated with the pnp-pass element is its tendency to saturate when the device goes into dropout. The resulting drop in β forces an increase in I_B to maintain the load. During power up, this translates to large start-up currents. Systems with limited supply current may fail to start up. In battery-powered systems, it means rapid battery discharge when the voltage decays below the minimum required for regulation. The TPS71xx quiescent current remains low even when the regulator drops out, eliminating both problems.

Included in the TPS71xx family is a 4.85-V regulator, the TPS7148. Designed specifically for 5-V cellular systems, its 4.85-V output, regulated to within $\pm 2\%$, allows for operation within the low-end limit of 5-V systems specified to $\pm 5\%$ tolerance; therefore, maximum regulated operating lifetime is obtained from a battery pack before the device drops out, adding crucial talk minutes between charges.

The TPS71xx family also features a shutdown mode that places the output in the high-impedance state (essentially equal to the feedback-divider resistance) and reduces quiescent current to under 2 μ A. If the shutdown feature is not used, $\overline{\text{EN}}$ should be tied to ground. Response to an enable transition is quick; regulated output voltage is reestablished in typically 120 μ s.

minimum load requirements

The TPS71xx family is stable even at zero load; no minimum load is required for operation.

SENSE-pin connection

The SENSE pin of fixed-output devices must be connected to the regulator output for proper functioning of the regulator. Normally, this connection should be as short as possible; however, the connection can be made near a critical circuit (remote sense) to improve performance at that point. Internally, SENSE connects to a high-impedance wide-bandwidth amplifier through a resistor-divider network and noise pickup feeds through to the regulator output. Routing the SENSE connection to minimize/avoid noise pickup is essential. Adding an RC network between SENSE and OUT to filter noise is not recommended because it can cause the regulator to oscillate.

external capacitor requirements

An input capacitor is not required; however, a ceramic bypass capacitor (0.047 pF to 0.1 μ F) improves load transient response and noise rejection if the TPS71xx is located more than a few inches from the power supply. A higher-capacitance electrolytic capacitor may be necessary if large (hundreds of milliamps) load transients with fast rise times are anticipated.



APPLICATION INFORMATION

external capacitor requirements (continued)

As with most LDO regulators, the TPS71xx family requires an output capacitor for stability. A low-ESR 10- μ F solid-tantalum capacitor connected from the regulator output to ground is sufficient to ensure stability over the full load range (see Figure 46). Adding high-frequency ceramic or film capacitors (such as power-supply bypass capacitors for digital or analog ICs) can cause the regulator to become unstable unless the ESR of the tantalum capacitor is less than 1.2 Ω over temperature. Capacitors with published ESR specifications such as the AVX TPSD106K035R0300 and the Sprague 593D106X0035D2W work well because the maximum ESR at 25°C is 300 m Ω (typically, the ESR in solid-tantalum capacitors increases by a factor of 2 or less when the temperature drops from 25°C to -40°C). Where component height and/or mounting area is a problem, physically smaller, 10- μ F devices can be screened for ESR. Figures 34 through 41 show the stable regions of operation using different values of output capacitance with various values of ceramic load capacitance.

In applications with little or no high-frequency bypass capacitance (< 0.2 μ F), the output capacitance can be reduced to 4.7 μ F, provided ESR is maintained between 0.7 and 2.5 Ω . Because minimum capacitor ESR is seldom if ever specified, it may be necessary to add a 0.5- Ω to 1- Ω resistor in series with the capacitor and limit ESR to 1.5 Ω maximum. As show in the ESR graphs (Figures 34 through 41), minimum ESR is not a problem when using 10- μ F or larger output capacitors.

Below is a partial listing of surface-mount capacitors usable with the TPS71xx family. This information (along with the ESR graphs, Figures 34 through 41) is included to assist in selection of suitable capacitance for the user's application. When necessary to achieve low height requirements along with high output current and/or high ceramic load capacitance, several higher ESR capacitors can be used in parallel to meet the guidelines above.

All load and temperature conditions with up to 1 µF of added ceramic load capacitance:

PART NO.	MFR.	VALUE	MAX ESR [†]	SIZE $(H \times L \times W)^{\dagger}$
T421C226M010AS	Kemet	22 μF, 10 V	0.5	$2.8 \times 6 \times 3.2$
593D156X0025D2W	Sprague	15 μF, 25 V	0.3	$2.8 \times 7.3 \times 4.3$
593D106X0035D2W	Sprague	10 μF, 35 V	0.3	$2.8 \times 7.3 \times 4.3$
TPSD106M035R0300	AVX	10 μF, 35 V	0.3	$2.8 \times 7.3 \times 4.3$

Load < 200 mA, ceramic load capacitance < 0.2 μF, full temperature range:

PART NO.	MFR.	VALUE	MAX ESRT	SIZE $(H \times L \times W)^{\dagger}$
592D156X0020R2T	Sprague	15 μF, 20 V	1.1	$1.2 \times 7.2 \times 6$
595D156X0025C2T	Sprague	15 μF, 25 V	1	$2.5 \times 7.1 \times 3.2$
595D106X0025C2T	Sprague	10 μF, 25 V	1.2	$2.5 \times 7.1 \times 3.2$
293D226X0016D2W	Sprague	22 μF, 16 V	1.1	$2.8 \times 7.3 \times 4.3$

Load < 100 mA, ceramic load capacitance < 0.2 μ F, full temperature range:

PART NO.	MFR.	VALUE	MAX ESR†	SIZE $(H \times L \times W)^{\dagger}$
195D106X06R3V2T	Sprague	10 μF, 6.3 V	1.5	$1.3\times3.5\times2.7$
195D106X0016X2T	Sprague	10 μF, 16 V	1.5	$1.3 \times 7 \times 2.7$
595D156X0016B2T	Sprague	15 μF, 16 V	1.8	$1.6 \times 3.8 \times 2.6$
695D226X0015F2T	Sprague	22 μF, 15 V	1.4	$1.8\times6.5\times3.4$
695D156X0020F2T	Sprague	15 μF, 20 V	1.5	$1.8 \times 6.5 \times 3.4$
695D106X0035G2T	Sprague	10 μF, 35 V	1.3	$2.5 \times 7.6 \times 2.5$

[†] Size is in mm. ESR is maximum resistance at 100 kHz and $T_A = 25^{\circ}$ C. Listings are sorted by height.



APPLICATION INFORMATION

external capacitor requirements (continued)

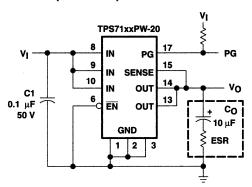


Figure 46. Typical Application Circuit

programming the TPS7101 adjustable LDO regulator

Programming the adjustable regulators is accomplished using an external resistor divider as shown in Figure 9. The equation governing the output voltage is:

$$V_{O} = V_{ref} \cdot \left(1 + \frac{R1}{R2}\right) \tag{1}$$

where

V_{ref} = reference voltage, 1.178 V typ

Resistors R1 and R2 should be chosen for approximately 7-μA divider current. A recommended value for R2 is 169 k Ω with R1 adjusted for the desired output voltage. Smaller resistors can be used, but offer no inherent advantage and consume more power. Larger values of R1 and R2 should be avoided as leakage currents at FB will introduce an error. Solving equation 1 for R1 yields a more useful equation for choosing the appropriate resistance:

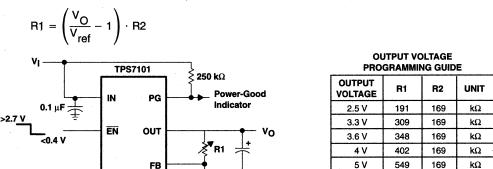


Figure 47. TPS7101 Adjustable LDO Regulator Programming

R2

FB

GND



169

169

750

6.4 V

kΩ

(2)

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APPLICATION INFORMATION

power-good indicator

The TPS71xx features a power-good (PG) output that can be used to monitor the status of the regulator. The internal comparator monitors the output voltage: when the output drops to between 92% and 98% of its nominal regulated value, the PG output transistor turns on, taking the signal low. The open-drain output requires a pullup resistor. If not used, it can be left floating. PG can be used to drive power-on reset circuitry or as a low-battery indicator. PG does not assert itself when the regulated output voltage falls outside the specified 2% tolerance, but instead reports an output voltage low, relative to its nominal regulated value.

regulator protection

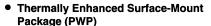
The TPS71xx PMOS-pass transistor has a built-in back diode that safely conducts reverse currents when the input voltage drops below the output voltage (e.g., during power down). Current is conducted from the output to the input and is not internally limited. If extended reverse voltage is anticipated, external limiting may be appropriate.

The TPS71xx also features internal current limiting and thermal protection. During normal operation, the TPS71xx limits output current to approximately 1 A. When current limiting engages, the output voltage scales back linearly until the overcurrent condition ends. While current limiting is designed to prevent gross device failure, care should be taken not to exceed the power dissipation ratings of the package. If the temperature of the device exceeds 165°C, thermal-protection circuitry shuts it down. Once the device has cooled, regulator operation resumes.

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11

GND/HEATSINK



- High-Current (500-mA) LDO Regulator
- Very Low-Dropout Voltage . . . Maximum of 60 mV at I_O = 100 mA
- Extremely Low Sleep-State Current 0.5 μA Max
- 2% Output-Voltage Tolerance Over Full Range of Load, Line, and Temperature
- Output Current Range of 0 mA to 500 mA
- Power Good (PG) Status Output

description

The TPS7133QPWP is a micropower low-dropout (LDO) voltage regulator with a fixed 3.3-V output voltage, rated for loads up to 500 mA. The device is ideal for applications that require 3.3 V from a 5-V supply, or a constant output from a battery, such as alkaline or lithium ion, that drops off considerably in voltage as it discharges.

To maximize the advantage of its high-outputcurrent capability, the TPS7133QPWP is now offered in a new thermally enhanced surfacemount power package. Designed to the same dimensions as the 20-pin TSSOP (just 1.2 mm high), the part has an innovative thermal pad, which, when soldered to the printed-wiring board (PWB), enables the device to dissipate several watts of power (see Figure 1 and Thermal Information section).

Using a PMOS transistor as the pass element keeps the quiescent current very low and constant, independent of output loading (typically 270 μA over the full range of output current, 0 mA to 500 mA). Because the PMOS device also behaves as a low-value resistor, the dropout is very low – maximum of 60 mV at 100 mA. These two key specifications yield a significant improvement in operating life for battery-powered systems. The LDO also features a sleep mode; applying a TTL high signal to $\overline{\text{EN}}$ shuts down the regulator, reducing the quiescent current to 0.5 μA .

(TOP VIEW) GND/HEATSINK □□ ☐☐ GND/HEATSINK GND/HEATSINK III GND/HEATSINK 19 18 GND □ 3 т ис NC I 17 D NC EN C 5 16 □□ PG IN \square ☐ SENSE 15 IN \Box 14 ш оит DOUT NC I 13 GND/HEATSINK □□ 12 GND/HEATSINK

PWP PACKAGE

NC - No internal connection

GND/HEATSINK I

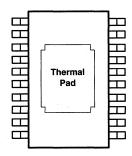


Figure 1. Bottom View of PWP Package, Showing the Thermal Pad

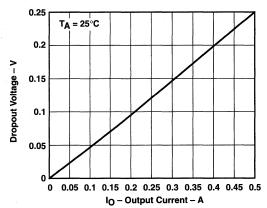


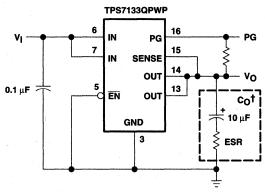
Figure 2. Typical Dropout Voltage Versus
Output Current



AVAILABLE OPTIONS†

	OUTPUT VOLTAGE (V)			PACKAGED DEVICES	CHIP FORM
'J	MIN	ТҮР	MAX	THERMALLY-ENHANCED TSSOP (PWP)	m
-55°C to 150°C	3.23	3.3	3.37	TPS7133QPWPPWPLE	TPS7133Y

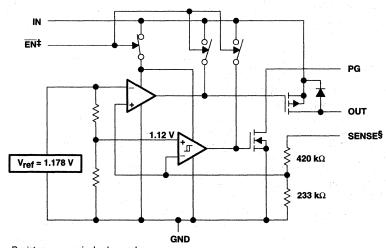
[†] The PWP package is only available left-end taped and reeled (indicated by the LE suffix on the device type; e.g., TPS7133QPWPLE). The chip form is tested at 25°C.



[†] Capacitor selection is nontrivial. See application information section for details.

Figure 3. Typical Application Configuration

functional block diagram



Resistors are nominal values only.

[§] For most applications, SENSE should be externally connected to OUT as close as possible to the device. For other implementations, refer to SENSE-pin connection discussion in applications information section.

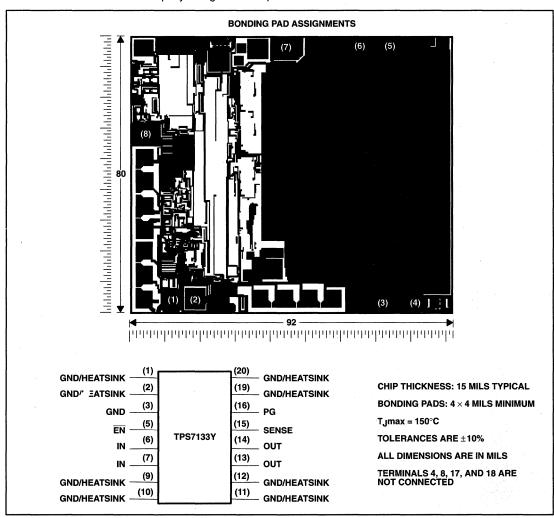


[‡] Switch positions shown with EN active low.

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TPS7133Y chip information

This chip, when properly assembled, displays characteristics similar to the TPS7133QPWP. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Input voltage range [‡] , V _I , PG, SENSE, EN	–0.3 to 10 V
Output current, IO	2 A
Continuous total power dissipation	See Dissipation Rating Tables 1 and 2
Operating virtual junction temperature range, T _J	–55°C to 150°C
Storage temperature range, T _{stg}	–65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE 1 - FREE-AIR TEMPERATURE (see Figure 4)§

PACKAGE	$T_A \le 25^{\circ}C$ POWER RATING	DERÄTING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 125°C POWER RATING	
PWP	700 mW	5.6 mW/°C	448 mW	140 mW	

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE (see Figure 5)§

PACKAGE	T _C ≤ 62.5°C	DERATING FACTOR	T _C = 70°C	T _C = 125°C
	POWER RATING	ABOVE T _C = 62.5°C	POWER RATING	POWER RATING
PWP	25 W	285.7 mW/°C	22.9 W	7.1 W

MAXIMUM CONTINUOUS DISSIPATION§

FREE-AIR TEMPERATURE 800 P_D - Maximum Continuous Dissipation - mW 700 $R_{\theta JA} = 178^{\circ}C/W$ 600 500 400 300 200 100 0 25 50 75 100 125 150 TA - Free-Air Temperature - °C

MAXIMUM CONTINUOUS DISSIPATION§

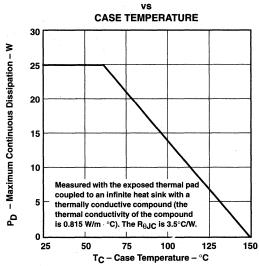


Figure 4

Figure 5

[‡] All voltage values are with respect to network terminal ground.

^{\$} Dissipation rating tables and figures are provided for maintenance of junction temperature at or below absolute maximum temperature of 150°C. For guidelines on maintaining junction temperature within recommended operating range, see the Thermal Information section.

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recommended operating conditions

	MIN	MAX	UNIT
Input voltage, V _I †	3.77	10	V
High-level input voltage at EN, VIH	2		V
Low-level input voltage at EN, V _{IL}		0.5	V
Output current range, IO	0	500	mA
Operating virtual junction temperature range, T _J	-40	125	°C

[†] Minimum input voltage defined in the recommended operating conditions is the maximum specified output voltage plus dropout voltage VDO[‡] at the maximum specified load range. Since dropout voltage is a function of output current, the usable range can be extended for lighter loads. To calculate the minimum input voltage for your maximum output current, use the following equation:

electrical characteristics at I $_{O}$ = 10 mA, $\overline{\text{EN}}$ = 0 V, C $_{O}$ = 4.7 $\mu\text{F/ESR}^{\ddagger}$ = 1 Ω , SENSE shorted to OUT (unless otherwise noted)

DADAMETED	TEST CO.	IDITIONOS	TJ	TPS7133QPWP			UNIT	
PARAMETER	I ESI CON	TEST CONDITIONS§		MIN	TYP	MAX	I UNII	
Ground current (active mode)	$\overline{EN} \le 0.5 \text{ V}, \qquad V_1 = V_O + 1 \text{ V}$		25°C		285	350		
Ground current (active mode)	$0 \le I_O \le 500 \text{ mA}$		-40°C to 125°C			460	μΑ	
Input current (standby mode)	EU V 6-V-V-40V	671/21/2401/	25°C			0.5	μА	
Imput current (standby mode)	EN = V _I ,	2.7 V ≤ V _I ≤ 10 V	-40°C to 125°C		_	2	μΑ	
Output current limit	\v- 0	V _I = 10 V	25°C		1.2	2	А	
Output current limit	V _O = 0,	V = 10 V	-40°C to 125°C			2	_ ^	
Pass-element leakage current in	EN V	071/41/4401/	25°C			0.5	T .	
standby mode	EN = V _I ,	2.7 V ≤ V _I ≤ 10 V	-40°C to 125°C			1	μΑ	
DO I - I	Normal or arction		25°C		0.02	0.5		
PG leakage current	Normal operation, V _{PG} = 10 V		-40°C to 125°C			0.5	μΑ	
Output voltage temperature coefficient			-40°C to 125°C		61	75	ppm/°C	
Thermal shutdown junction temperature					165		°C	
EN la sia bissa (atau dha ann an da)	2.5 V ≤ V _I ≤ 6 V		-40°C to 125°C	2			V	
EN logic high (standby mode)	6 V ≤ V _I ≤ 10 V		-40°C to 125°C	2.7			1 °	
	0.74.74.74.74		25°C			0.5	V	
EN logic low (active mode)	$ 2.7 \vee \leq \vee \leq 10 \vee$	2.7 V ≤ V _I ≤ 10 V				0.5	V	
EN hysteresis voltage			25°C		50		mV	
	0 < 1/ < 10 1/	0.1/		-0.5		0.5		
EN input current	0 ≤ V _I ≤ 10 V		-40°C to 125°C	-0.5		0.5	μA	
Minimum V. for active need element			25°C		2.05	2.5	V	
Minimum V _I for active pass element			-40°C to 125°C			2.5	V ,	
Minimum V. for valid PG	PG		25°C		1.06	1.5	٧	
Minimum V _I for valid PG			-40°C to 125°C			1.9	_ v	

[§] ESR refers to the equivalent series resistance, including internal and external resistance.

 $V_{I(min)} = V_{O(max)} + V_{DO(max load)}$

[‡] This symbol is not currently listed within EIA or JEDEC standards for semiconductor symbology.

Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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electrical characteristics at I_O = 10 mA, V_I = 4.3 V, $\overline{\text{EN}}$ = 0 V, C_O = 4.7 $\mu\text{F/ESR}^{\dagger}$ = 1 Ω , SENSE shorted to OUT (unless otherwise noted)

21211222	TEST CONDITIONS‡		-	TPS7133QPWP			UNIT
PARAMETER			TJ	MIN	TYP	MAX	UNII
0.4	V _I = 4.3 V,	I _O = 10 mA	25°C		3.3		V
Output voltage	$4.3 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V},$	5 mA ≤ I _O ≤ 500 mA	-40°C to 125°C	3.23		3.37	1 °
		V _I = 3.23 V	25°C		0.02	6	
	I _O = 10 mA,		-40°C to 125°C			. 8	
Donatal			25°C		47	60	mV
Dropout voltage	l _O = 100 mA,	V _I = 3.23 V	-40°C to 125°C			80] ""
	In 500 mA	V _I = 3.23 V	25°C		235	300	
	I _O = 500 mA,	V = 3.23 V	-40°C to 125°C			400	}
Pass-element series resistance	(3.23 V - V _O)/I _O ,	V _I = 3.23 V,	25°C		0.47	0.6	Ω
rass-element series resistance	I _O = 500 mA		-40°C to 125°C			0.8	32
Innut veltone regulation	V _I = 4.3 V to 10 V,	50 μA ≤ I _O ≤ 500 mA	25°C			20	mV
Input voltage regulation			-40°C to 125°C			27] ""V
	I _O = 5 mA to 500 mA,	4.3 V ≤ V _I ≤ 10 V	25°C		21	38	mV
Outro de colto do mandation			-40°C to 125°C			75	l IIIV
Output voltage regulation	$I_{O} = 50 \ \mu\text{A} \text{ to } 500 \ \text{mA}, \ 4.3 \ \text{V} \le \text{V}$	4.9.V.	25°C		30	60	mV
		, 4.3 V ≤ V ≤ 10 V	-40°C to 125°C			120] ''''
		ΙΟ = 50 μΑ	25°C	43	54		
Dinnle rejection			-40°C to 125°C	40			dB
Ripple rejection	f = 120 Hz		25°C	39	49		ub .
		I _O = 500 mA	-40°C to 125°C	36			
Output noise-spectral density	f = 120 Hz		25°C		2		μV/√Hz
		C _O = 4.7 μF	25°C		274		
Output noise voltage	10 Hz \leq f \leq 100 kHz, ESR [†] = 1 Ω	C _O = 10 μF	25°C		228		μVrms
		C _O = 100 μF	25°C		159		1
PG trip-threshold voltage	VO voltage decreasing		-40°C to 125°C	0.92 × V _{O(nom)}		0.98× V _{O(nom)}	V
PG hysteresis voltage			25°C		35		mV
		V _I = 2.8 V	25°C		0.22	0.4	
PG output low voltage	IPG = 1 mA,		-40°C to 125°C			0.4	\ \

[†] ESR refers to the equivalent series resistance, including internal and external resistance.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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electrical characteristics at I $_{O}$ = 10 mA, \overline{EN} = 0 V, C $_{O}$ = 4.7 μ F/ESR ‡ = 1 Ω , T $_{J}$ = 25 $^{\circ}$ C, SENSE shorted to OUT (unless otherwise noted)

DADAMETED	TEGT CONDITIONS	Т	TPS7133Y		
PARAMETER	TEST CONDITIONS§	MIN	TYP	MAX	UNIT
Ground current (active mode)	$\overline{EN} \le 0.5 \text{ V}, \qquad V_I = V_O + 1 \text{ V}, \\ 0 \le I_O \le 500 \text{ mA}$		285		μΑ
Output current limit	$V_{O} = 0,$ $V_{I} = 10 \text{ V}$		1.2		Α
PG leakage current	Normal operation, VpG = 10 V		0.02		μА
Thermal shutdown junction temperature			165		°C
EN hysteresis voltage			50		mV
Minimum V _I for active pass element			2.05		٧
Minimum V _I for valid PG	IPG = 300 μA		1.06		V

[§] ESR refers to the equivalent series resistance, including internal and external resistance.

electrical characteristics at I $_{O}$ = 10 mA, V $_{I}$ = 4.3 V, \overline{EN} = 0 V, C $_{O}$ = 4.7 μ F/ESR † = 1 Ω , T $_{J}$ = 25°C, SENSE shorted to OUT (unless otherwise noted)

DA DALLETTO		TEST COMPLETIONS		TPS7133Y		
PARAMETER	lesi co	TEST CONDITIONS‡			MAX	UNIT
Output voltage	V _I = 4.3 V,	I _O = 10 mA		3.3		V
	I _O = 10 mA,	V _I = 3.23 V		0.02		
Dropout voltage	$I_{O} = 100 \text{ mA},$	V _I = 3.23 V		47		mV
	$I_O = 500 \text{ mA},$	V _I = 3.23 V		235		
Pass-element series resistance	$(3.23 \text{ V} - \text{V}_{\text{O}})/\text{I}_{\text{O}},$ $\text{I}_{\text{O}} = 500 \text{ mA}$	V _I = 3.23 V,		0.47		Ω
Output valtage vegulation	I _O = 5 mA to 500 mA,	$I_0 = 5 \text{ mA to } 500 \text{ mA}, 4.3 \text{ V} \le V_1 \le 10 \text{ V}$		21		mV
Output voltage regulation	$I_O = 50 \mu\text{A}$ to 500 mA	, 4.3 V ≤ V _I ≤ 10 V		30		mV
Ripple rejection	f = 120 Hz	ΙΟ = 50 μΑ		54	di	dB
nippie rejection	1 = 120 HZ	I _O = 500 mA		49		uБ
Output noise-spectral density	f = 120 Hz	f = 120 Hz		2		μV/√Hz
		C _O = 4.7 μF		274	-	
Output noise voltage	10 Hz \leq f \leq 100 kHz, ESR [†] = 1 Ω	C _O = 10 μF		228		μVrms
	25.11 = 132	C _O = 100 μF		159		
PG hysteresis voltage				35		mV
PG output low voltage	I _{PG} = 1 mA,	V _I = 2.8 V		0.22		٧

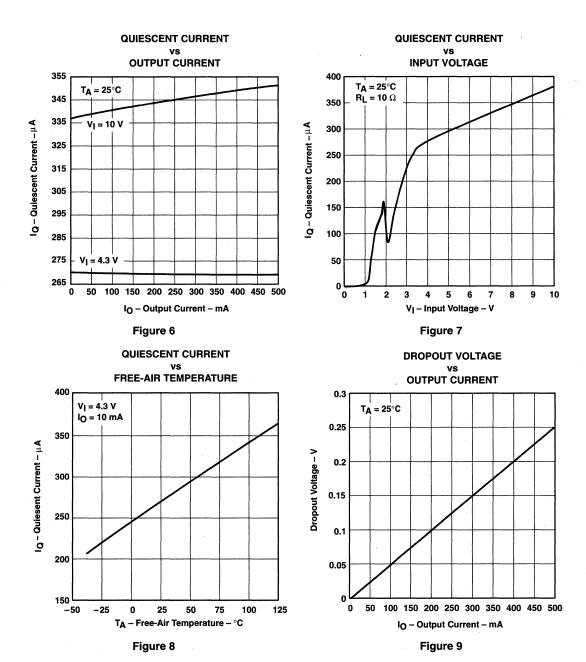
[†] ESR refers to the equivalent series resistance, including internal and external resistance.

Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

Table of Graphs

			FIGURE
		vs Output current	6
lQ	Quiescent current	vs Input voltage	7
•	en e	vs Free-air temperature	8
V_{DO}	Typical dropout voltage	vs Output current	9
ΔV_{DO}	Change in dropout voltage	vs Free-air temperature	10
ΔVΟ	Change in output voltage	vs Free-air temperature	11
Vo	Output voltage	vs Input voltage	12
Δ۷Ο	Change in output voltage	vs Input voltage	13
Vo	Output voltage	vs Output current	14
	Ripple rejection	vs Frequency	15
	Output special noise density	vs Frequency	16
rDS(on)	Pass-element resistance	vs Input voltage	17
R	Divider resistance	vs Free-air temperature	18
I(SENSE)	SENSE pin current	vs Free-air temperature	19
V.	Minimum input voltage (active-pass element)	vs Free-air temperature	20
VI	Minimum input voltage (valid PG)	vs Free-air temperature	21
I(EN)	EN Input current	vs Free-air temperature	22
	Output voltage response from Enable (EN)		23
V _{PG}	Power-good (PG) voltage	vs Output voltage	24
	T. 1500		25
	Total ESR	vs Output current	26
	T-t-LEOD	A	27
	Total ESR	vs Added ceramic capacitance	28
	Total ECD	Lie Cuteut aurent	29
£.	Total ESR	vs Output current	
	Total ECD	vo Added coromic constitutes	31
	Total ESR	vs Added ceramic capacitance	32



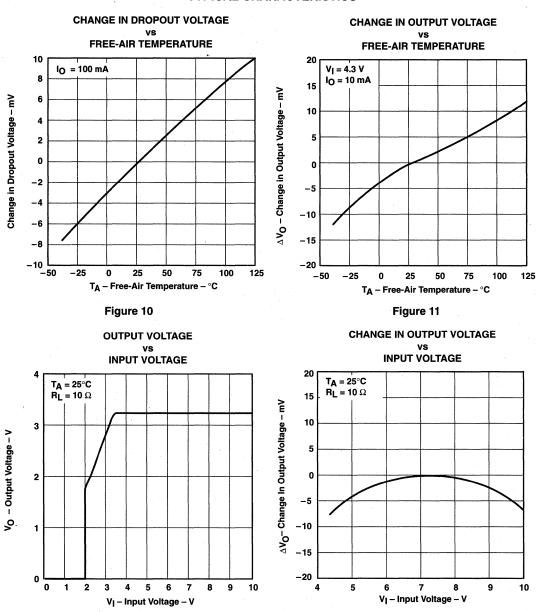
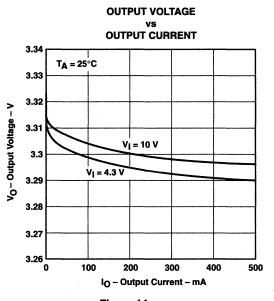


Figure 13

Figure 12



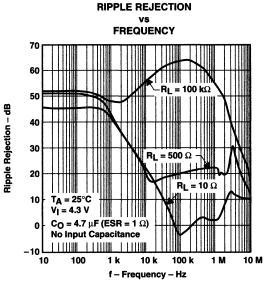


Figure 14

OUTPUT SPECTRAL NOISE DENSITY

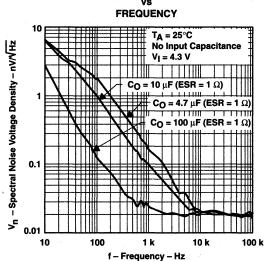


Figure 16

Figure 15

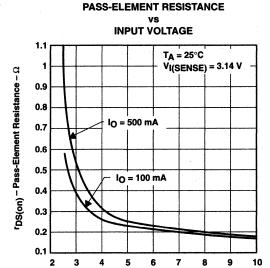


Figure 17

V_I - Input Voltage - V

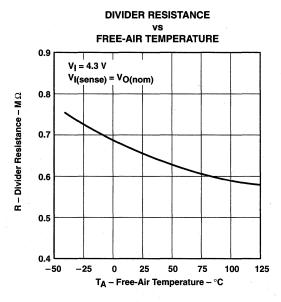


Figure 18



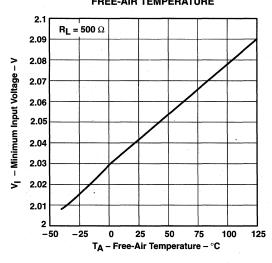


Figure 20

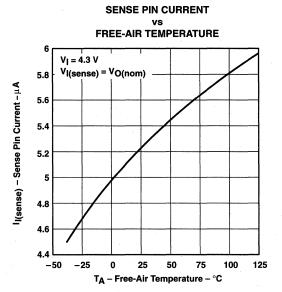


Figure 19

MINIMUM INPUT VOLTAGE (VALID PG)

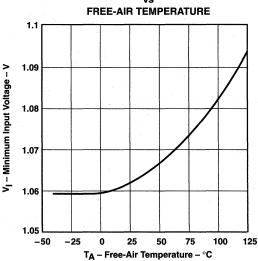
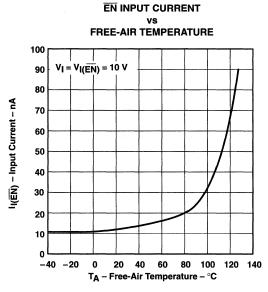


Figure 21



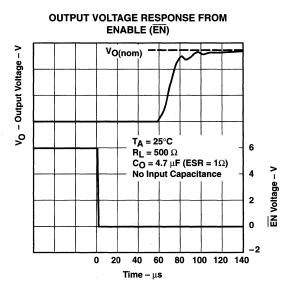
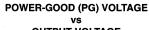


Figure 22

Figure 23



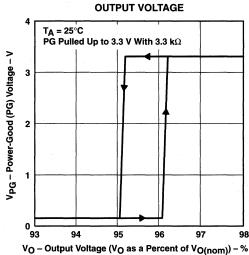


Figure 24

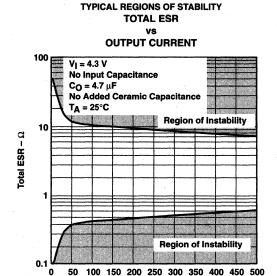


Figure 25

TYPICAL REGIONS OF STABILITY

IO - Output Current - mA

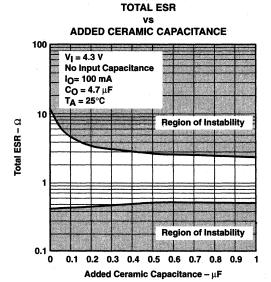


Figure 27

TYPICAL REGIONS OF STABILITY TOTAL ESR vs OUTPUT CURRENT

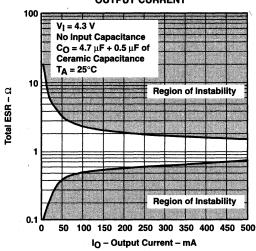


Figure 26

TYPICAL REGIONS OF STABILITY TOTAL ESR VS

ADDED CERAMIC CAPACITANCE

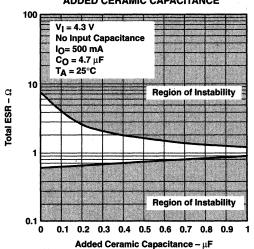
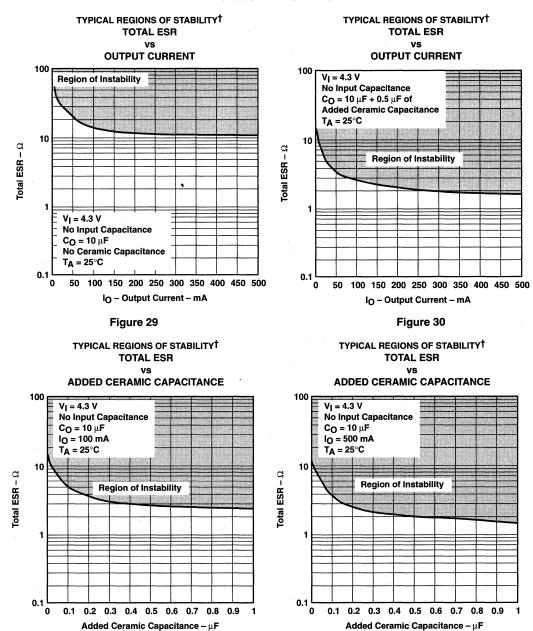


Figure 28



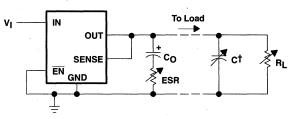
† ESR values below 0.1 Ω are not recommended.

Figure 31



Figure 32

TYPICAL CHARACTERISTICS



† Ceramic capacitor

Figure 33. Test Circuit for Typical Regions of Stability (Figures 25 through 32)

THERMAL INFORMATION

The thermally enhanced PWP package is based on the 20-pin TSSOP, but includes a thermal pad [see Figure 34(c)] to provide an effective thermal contact between the IC and the PWB.

Traditionally, surface mount and power have been mutually exclusive terms. A variety of scaled-down TO220-type packages have leads formed as gull wings to make them applicable for surface-mount applications. These packages, however, suffer from several shortcomings: they do not address the very low profile requirements (<2 mm) of many of today's advanced systems, and they do not offer a pin-count high enough to accommodate increasing integration. On the other hand, traditional low-power surface-mount packages require power-dissipation derating that severely limits the usable range of many high-performance analog circuits.

The PWP package (thermally enhanced TSSOP) combines fine-pitch surface-mount technology with thermal performance comparable to much larger power packages.

The PWP package is designed to optimize the heat transfer to the PWB. Because of the very small size and limited mass of a TSSOP package, thermal enhancement is achieved by improving the thermal conduction paths that remove heat from the component. The thermal pad is formed using a lead-frame design (patent pending) and manufacturing technique to provide the user with direct connection to the heat-generating IC. When this pad is soldered or otherwise coupled to an external heat dissipator, high power dissipation in the ultrathin, fine-pitch, surface-mount package can be reliably achieved.

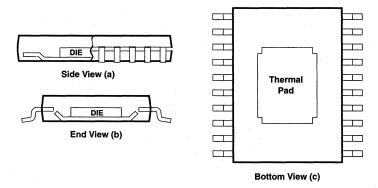


Figure 34. Views of Thermally Enhanced PWP Package



THERMAL INFORMATION

Because the conduction path has been enhanced, power-dissipation capability is determined by the thermal considerations in the PWB design. For example, simply adding a localized copper plane (heat-sink surface), which is coupled to the thermal pad, enables the PWP package to dissipate 2.5 W in free air (reference Figure 36(a), 8 cm² of Cu heat sink and natural convection). Increasing the heat-sink size increases the power dissipation range for the component. The power dissipation limit can be further improved by adding airflow to a PWB/IC assembly (see Figures 35 and 36). The line drawn at 0.3 cm² in Figures 35 and 36 indicates performance at the minimum recommended heat-sink size, illustrated in Figure 38.

The thermal pad is directly connected to the substrate of the IC, which for the TPS7133QPWP is a secondary electrical connection to device ground. The heat-sink surface that is added to the PWB can be a ground plane or left electrically isolated. In other TO220-type surface-mount packages, the thermal connection is also the primary electrical connection for a given terminal which is not always ground. The PWP package provides up to 12 independent leads that can be used as inputs and outputs (Note: leads 1, 2, 9, 10, 11, 12, 19, and 20 are internally connected to the thermal pad and the IC substrate).

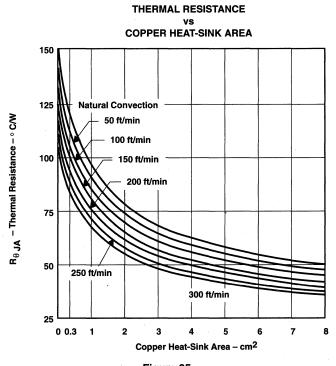


Figure 35

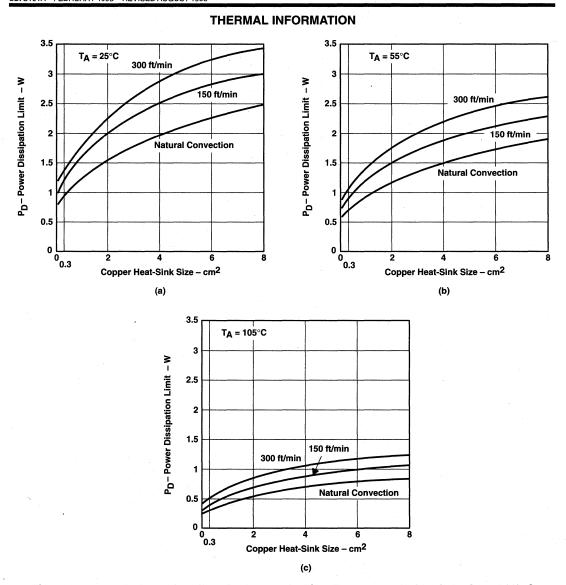
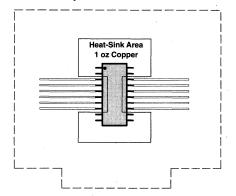


Figure 36. Power Ratings of the PWP Package at Ambient Temperatures of 25°C, 55°C, and 105°C

THERMAL INFORMATION

Figure 37 is an example of a thermally enhanced PWB layout for use with the new PWP package. This board configuration was used in the thermal experiments that generated the power ratings shown in Figures 35 and 36. As discussed earlier, copper has been added on the PWB to conduct heat away from the device. $R_{\theta JA}$ for this assembly is illustrated in Figure 35 as a function of heat-sink area. A family of curves is included to illustrate the effect of airflow introduced into the system.



Board thickness 62 mils
Board size 3.2 in. × 3.2 in.
Board material FR4
Cu trace/heat sink 1 oz
Exposed pad mounting 63/67 tin/lead solder

Figure 37. PWB Layout (Including Cu Heatsink Area) for Thermally Enhanced PWP Package

From Figure 35, $R_{\theta JA}$ for a PWB assembly can be determined and used to calculate the maximum power-dissipation limit for the component/PWB assembly, with the equation:

$$P_{D(max)} = \frac{T_{J}max - T_{A}}{R_{\theta JA(system)}}$$

Where

 T_J max is the maximum specified junction temperature (150°C absolute maximum limit, 125°C recommended operating limit) and T_A is the ambient temperature.

 $P_{D(max)}$ should then be applied to the internal power dissipated by the TPS7133QPWP regulator. The equation for calculating total internal power dissipation of the TPS7133QPWP is:

$$P_{D(total)} = (V_{I} - V_{O}) \cdot I_{O} + V_{I} \cdot I_{Q}$$

Since the quiescent current of the TPS7133QPWP is very low, the second term is negligible, further simplifying the equation to:

$$P_{D(total)} = (V_I - V_O) \cdot I_O$$

For the case where $T_A = 55^{\circ}$ C, airflow = 200 ft/min, copper heat-sink area = 4 cm², the maximum power-dissipation limit can be calculated. First, from Figure 35, we find the system $R_{\theta JA}$ is 50°C/W; therefore, the maximum power-dissipation limit is:

$$P_{D(max)} = \frac{T_J max - T_A}{R_{\theta JA(system)}} = \frac{125^{\circ}C - 55^{\circ}C}{50^{\circ}C/W} = 1.4 \text{ W}$$

If the system implements a TPS7133QPWP regulator, where $V_I = 6 \text{ V}$ and $I_O = 500 \text{ mA}$, the internal power dissipation is:

$$P_{D(total)} = (V_1 - V_0) \cdot I_0 = (6 - 3.3) \cdot 0.5 = 1.35 W$$

Comparing $P_{D(total)}$ with $P_{D(max)}$ reveals that the power dissipation in this example does not exceed the calculated limit. When it does, one of two corrective actions should be made: raising the power-dissipation limit by increasing the airflow or the heat-sink area, or lowering the internal power dissipation of the regulator by reducing the input voltage or the load current. In either case, the above calculations should be repeated with the new system parameters.

mounting information

Since the thermal pad is not a primary connection for an electrical signal, the importance of the electrical connection is not significant. The primary requirement is to complete the thermal contact between the thermal pad and the PWB metal. The thermal pad is a solderable surface and is fully intended to be soldered at the time the component is mounted. Although voiding in the thermal-pad solder-connection is not desirable, up to 50% voiding is acceptable. The data included in Figures 35 and 36 is for soldered connections with voiding between 20% and 50%. The thermal analysis shows no significant difference resulting from the variation in voiding percentage.

Figure 38 shows the solder-mask land pattern for the PWP package. The minimum recommended heat-sink area is also illustrated. This is simply a copper plane under the body extent of the package, including metal routed under terminals 1, 2, 9, 10, 11, 12, 19, and 20.

reliability information

This section includes demonstrated reliability test results obtained from the qualification program. Accelerated tests are performed at high-stress conditions so that product reliability can be established during a relatively short test duration. Specific stress conditions are chosen to represent accelerated versions of various device-application environments and allow meaningful extrapolation to normal operating conditions.

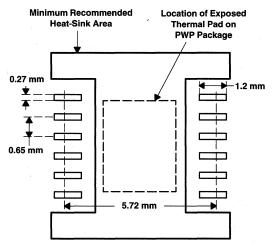


Figure 38. PWP Package Land Pattern

TPS7133QPWP, TPS7133Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS

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THERMAL INFORMATION

component level reliability test results

preconditioning

Preconditioning of components prior to reliability testing is employed to simulate the actual board assembly process used by the customer. This ensures that reliability test results are more representative of those that would be seen in the final application. The general form of the preconditioning sequence includes a moisture soak followed by multiple vapor-phase-reflow or infrared-reflow solder exposures. All components used in the following reliability tests were preconditioned in accordance with JEDEC Test Method A113 for Level 1 (not moisture-sensitive) products.

high-temperature life test

High-temperature life testing is used to demonstrate long-term reliability of the product under bias. The potential failure mechanisms evaluated with this stress are those associated with dielectric integrity and design or process sensitivity to mobile-ion phenomena. Components are tested at an elevated ambient temperature of 155°C for an extended period. Results are derated using the Arrhenius equation to an equivalent number of unit hours at a representative application temperature. The corresponding predicted failure rate is expressed in FITs, or failures per billion device-hours. The failure rate shown in this case is data-limited since no actual failures were experienced during qualification testing.

PREDICTED LONG-TERM FAILURE RATE						
Number of Units	Equivalent Unit Hours at 55°C and 0.7 eV	FITs at 50% CL				
325	24,468,090	36.2				

biased humidity test

Biased humidity testing is used to evaluate the effects of moisture penetration on plastic-encapsulated devices under bias. This stress verifies the integrity of the package construction and the die passivation system. The primary potential failure mechanism is electrolytic corrosion. Components are biased in a low power state to reduce heat dissipation and are subjected to a 120°C, 85%-relative-humidity environment for 100 hours.

BIASED HUMIDITY TEST RESULTS				
Equivalent Unit Hours at 85°C and 85% RH	Failures			
357,000	0			

autoclave test

The autoclave stress is used to assess the capabilities of the die and package construction materials with respect to moisture ingress and extended exposure. Predominant failure mechanisms include leakage currents that result from internal moisture accumulation and galvanic corrosion resulting from reactions with any present ionic contaminants. Components are subjected to a 121°C, 15 PSIG, 100%-relative-humidity environment for 240 hours.

AUTOCLAVE TEST RESULTS				
Total Unit Hours	Failures			
54,720	0			



THERMAL INFORMATION

thermal shock test

Thermal shock testing is used to evaluate the capability of the component to withstand mechanical stress resulting from differences in thermal coefficients of expansion among the die and package construction materials. Failure mechanisms are typically related to physical damage at interface locations between different materials. Components are cycled between –65°C and 150°C in liquid mediums for a total duration of 1000 cycles.

THERMAL SHOCK TEST	RESULTS
Total Unit Cycles	Failures
345,000	0

PWB assembly level reliability results

temperature cycle test

Temperature cycle testing of the PWB assembly is used to evaluate the capability of the assembly to withstand mechanical stress resulting from the differences in thermal coefficients of expansion among die, package, and PWB board materials. This testing is also used to sufficiently age the soldered thermal connection between the thermal pad and the Cu trace on the FR4 board and evaluate the degradation of the thermal resistance for a board-mounted test unit. The assemblies were cycled between temperature extremes of -40° C and 125° C for a total duration of 730 cycles.

TEMPERATURE CYCLE TEST RESULTS							
Total Unit Cycles Failures Average Change in R ₀ JA(system)							
36,500	0 -0.41%						

solderability test

Solderability testing is used to simulate actual board-mount performance in a reflow process.

Solderability testing is conducted as follows: The test devices are first steam-aged for 8 hours. A stencil is used to apply a solder-paste terminal pattern on a ceramic substrate (nominal stencil thickness is 0.005 inch). The test units are manually placed on the solder-paste footprint with proper implements to avoid contamination. The ceramic substrate and components are subjected to the IR reflow process as follows:

IR REFLOW PROCESS

	PREHEAT SOAK	REFLOW
Temperature	150°C to 170°C	215°C to 230°C
Time	60 sec	60 sec

After cooling to room temperature, the component is removed from the ceramic substrate and the component terminals are subjected to visual inspection at 10X magnification.

Test results are acceptable if all terminations exhibit a continuous solder coating free of defects for a minimum 95% of the critical surface area of any individual termination. Causes for rejection include: dewetting, nonwetting, and pin holes. The component leads and the exposed thermal pad were evaluated against this criteria.

SOLDERABILITY TEST RESULTS					
Number of Test Units	Failures				
22	. 0				

X-ray test

X-ray testing is used to examine and quantify the voiding of the soldered attachment between the thermal pad and the PWB copper trace. Voiding between 20% and 50% was observed on a 49-piece sample.



TPS7133QPWP, TPS7133Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS

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APPLICATION INFORMATION

The TPS7133QPWP low-dropout (LDO) regulator is designed to overcome many of the shortcomings of earlier-generation LDOs, while adding features such as a power-saving shutdown mode and a power-good indicator.

device operation

The TPS7133QPWP, unlike many other LDOs, features very low quiescent currents that remain virtually constant even with varying loads. Conventional LDO regulators use a pnp-pass element, the base current of which is directly proportional to the load current through the regulator ($I_B = I_C/\beta$). Close examination of the data sheets reveals that those devices are typically specified under near no-load conditions; actual operating currents are much higher as evidenced by typical quiescent-current versus load-current curves. The TPS7133QPWP uses a PMOS transistor to pass current; because the gate of the PMOS element is voltage driven, operating currents are low and invariable over the full load range. The TPS7133QPWP specifications reflect actual performance under load.

Another pitfall associated with the pnp-pass element is its tendency to saturate when the device goes into dropout. The resulting drop in β forces an increase in I_B to maintain the load. During power up, this translates to large start-up currents. Systems with limited supply current may fail to start up. In battery-powered systems, it means rapid battery discharge when the voltage decays below the minimum required for regulation. The TPS7133QPWP quiescent current remains low even when the regulator drops out, eliminating both problems.

The TPS7133QPWP also features a shutdown mode that places the output in the high-impedance state (essentially equal to the feedback-divider resistance) and reduces quiescent current to under $2\,\mu A$. \overline{EN} is pulled down internally, requiring no external connection for continuous operation. Response to an enable transition is quick; regulated output voltage is reestablished in typically 120 μs .

minimum load requirements

The TPS7133QPWP is stable even at zero load; no minimum load is required for operation.

sense-pin connection

The SENSE pin must be connected to the regulator output for proper functioning of the regulator. Normally, this connection should be as short as possible; however, the connection can be made near a critical circuit (remote sense) to improve performance at that point. Internally, SENSE connects to a high-impedance wide-bandwidth amplifier through a resistor-divider network and noise pickup feeds through to the regulator output. Routing the SENSE connection to minimize/avoid noise pickup is essential. Adding an RC network between SENSE and OUT to filter noise is not recommended because it can cause the regulator to oscillate.

external capacitor requirements

An input capacitor is not required; however, a ceramic bypass capacitor (0.047-pF) to $0.1\text{-}\mu\text{F})$ improves load transient response and noise rejection if the TPS7133QPWP is located more than a few inches from the power supply. A higher-capacitance electrolytic capacitor may be necessary if large (hundreds of milliamps) load transients with fast rise times are anticipated.

As with most LDO regulators, the TPS7133QPWP requires an output capacitor for stability. A low-ESR 10- μ F solid-tantalum capacitor connected from the regulator output to ground is sufficient to ensure stability over the full load range (see Figure 39). Adding high-frequency ceramic or film capacitors (such as power-supply bypass capacitors for digital or analog ICs) can cause the regulator to become unstable unless the ESR of the tantalum capacitor is less than 1.2 Ω over temperature. Capacitors with published ESR specifications such as the



APPLICATION INFORMATION

AVX TPSD106K035R0300 and the Sprague 593D106X0035D2W work well because the maximum ESR at 25°C is 300 m Ω (typically, the ESR in solid-tantalum capacitors increases by a factor of 2 or less when the temperature drops from 25°C to -40°C). Where component height and/or mounting area is a problem, physically smaller, 10- μ F devices can be screened for ESR. Figures 25 through 32 show the stable regions of operation using different values of output capacitance with various values of ceramic load capacitance.

In applications with little or no high-frequency bypass capacitance (< 0.2 μ F), the output capacitance can be reduced to 4.7 μ F, provided ESR is maintained between 0.7 and 2.5 Ω . Because minimum capacitor ESR is seldom if ever specified, it may be necessary to add a 0.5- Ω to 1- Ω resistor in series with the capacitor and limit ESR to 1.5 Ω maximum. As shown in the ESR graphs (Figures 25 through 32), minimum ESR is not a problem when using 10- μ F or larger output capacitors.

Below is a partial listing of surface-mount capacitors usable with the TPS7133QPWP. This information (along with the ESR graphs, Figures 25 through 32) is included to assist in selection of suitable capacitance for the user's application. When necessary to achieve low height requirements along with high output current and/or high ceramic load capacitance, several higher ESR capacitors can be used in parallel to meet the guidelines above.

All load and temperature conditions with up to 1 µF of added ceramic load capacitance:

PART NO.	MFR.	VALUE	MAX ESR†	SIZE $(H \times L \times W)^{\dagger}$
T421C226M010AS	Kemet	22 μF, 10 V	0.5	$2.8 \times 6 \times 3.2$
593D156X0025D2W	Sprague	15 μF, 25 V	0.3	$2.8 \times 7.3 \times 4.3$
593D106X0035D2W	Sprague	10 μF, 35 V	0.3	$2.8 \times 7.3 \times 4.3$
TPSD106M035R0300	AVX	10 μF, 35 V	0.3	$2.8 \times 7.3 \times 4.3$

Load < 200 mA, ceramic load capacitance < 0.2 μF, full temperature range:

PART NO.	MFR.	VALUE	MAX ESR†	SIZE $(H \times L \times W)^{\dagger}$
592D156X0020R2T	Sprague	15 μF, 20 V	1.1	$1.2 \times 7.2 \times 6$
595D156X0025C2T	Sprague	15 μF, 25 V	1	$2.5 \times 7.1 \times 3.2$
595D106X0025C2T	Sprague	10 μF, 25 V	1.2	$2.5 \times 7.1 \times 3.2$
293D226X0016D2W	Sprague	22 μF, 16 V	1.1	$2.8 \times 7.3 \times 4.3$

Load < 100 mA, ceramic load capacitance < 0.2 μ F, full temperature range:

PART NO.	MFR.	VALUE	MAX ESR†	SIZE $(H \times L \times W)^{\dagger}$
195D106X06R3V2T	Sprague	10 μF, 6.3 V	1.5	$1.3\times3.5\times2.7$
195D106X0016X2T	Sprague	10 μF, 16 V	1.5	$1.3 \times 7 \times 2.7$
595D156X0016B2T	Sprague	15 μF, 16 V	1.8	$1.6 \times 3.8 \times 2.6$
695D226X0015F2T	Sprague	22 μF, 15 V	1.4	$1.8 \times 6.5 \times 3.4$
695D156X0020F2T	Sprague	15 μF, 20 V	1.5	$1.8 \times 6.5 \times 3.4$
695D106X0035G2T	Sprague	10 μF, 35 V	1.3	$2.5 \times 7.6 \times 2.5$

[†] Size is in mm. ESR is maximum resistance at 100 kHz and T_A = 25°C. Listings are sorted by height.

APPLICATION INFORMATION

external capacitor requirements (continued)

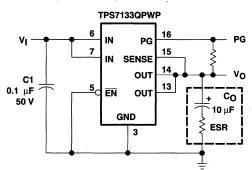


Figure 39. Typical Application Circuit

power-good indicator

The TPS7133QPWP features a power-good (PG) output that can be used to monitor the status of the regulator. The internal comparator monitors the output voltage: when the output drops to between 92% and 98% of its nominal regulated value, the PG output transistor turns on, taking the signal low. The open-drain output requires a pullup resistor. If not used, it can be left floating. PG can be used to drive power-on reset circuitry or used as a low-battery indicator. PG does not assert itself when the regulated output voltage falls out of the specified 2% tolerance, but instead reports an output voltage low, relative to its nominal regulated value.

regulator protection

The TPS7133QPWP PMOS-pass transistor has a built-in back diode that safely conducts reverse currents when the input voltage drops below the output voltage (e.g., during power down). Current is conducted from the output to the input and is not internally limited. If extended reverse voltage is anticipated, external limiting may be appropriate.

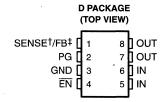
The TPS7133QPWP also features internal current limiting and thermal protection. During normal operation, the TPS7133QPWP limits output current to approximately 1 A. When current limiting engages, the output voltage scales back linearly until the overcurrent condition ends. While current limiting is designed to prevent gross device failure, care should be taken not to exceed the power dissipation ratings of the package. If the temperature of the device exceeds 165°C, thermal-protection circuitry shuts it down. Once the device has cooled, regulator operation resumes.

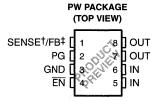
- Available in 5-V, 4.85-V, and 3.3-V
 Fixed-Output and Adjustable Versions
- Dropout Voltage <85 mV Max at IO = 100 mA (TPS7250)
- Low Quiescent Current, Independent of Load, 155 μΑ Typ
- 8-Pin SOIC and 8-Pin TSSOP Package (Product Preview)
- Output Regulated to ±2% Over Full Operating Range for Fixed-Output Versions
- Extremely Low Sleep-State Current, 0.5 μA Max
- Power-Good (PG) Status Output

description

The TPS72xx family of low-dropout (LDO) voltage regulators offers the benefits of low-dropout voltage, micropower operation and miniaturized packaging. These regulators feature extremely low dropout voltages and quiescent currents compared to conventional LDO regulators. Offered in small-outline integrated-circuit (SOIC) packages and (product preview only) 8-terminal thin shrink small-outline (TSSOP), the TPS72xx series devices are ideal for cost-sensitive designs and where board space is at a premium.

A combination of new circuit design and process innovation has enabled the usual pnp pass transistor to be replaced by a PMOS device. Because the PMOS pass element behaves as a low-value resistor, the dropout voltage is very low - maximum of 85 mV at 100 mA of load current (TPS7250) - and is directly proportional to the load current (see Figure 1). Since the PMOS pass element is a voltage-driven device, the guiescent current is very low (300 µA maximum) and is stable over the entire range of output load current (0 mA to 250 mA). Intended for use in portable systems such as laptops and cellular phones, the low-dropout voltage feature and micropower operation result in a significant increase in system battery operating life.





†SENSE – Fixed voltage options only (TPS7233, TPS7248, and TPS7250) ‡FB – Adjustable version only (TPS7201)

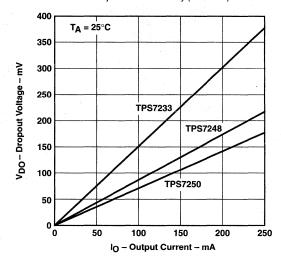


Figure 1. Typical Dropout Voltage Versus
Output Current

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AVAILABLE OPTIONS

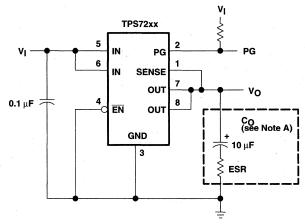
-	OUTPUT VOLTAGE (V)		PACKAGE	CHIP FORM		
Тл	MIN	TYP	MAX	SMALL OUTLINE (D)	TSSOP (PW)	(Y)
	4.9	5	5.1	TPS7250QD	TPS7250QPWLE	TPS7250Y
	4.75	4.85	4.95	TPS7248QD	TP\$7248QPWLE	TPS7248Y
-55°C to 150°C	3.23	3.3	3.37	TPS7233QD	TPS7283QPWLE	TPS7233Y
J.		ljustable V to 9.75		TPS7201QD	TP\$7201QPWLE	TPS7201Y

The D package is available taped and reeled. Add R suffix to device type (e.g., TPS7250QDR). The PW package is only available left-end taped and reeled. The TPS7201Q is programmable using an external resistor divider (see application information). The chip form is tested at 25°C.

description (continued)

The TPS72xx also features a logic-enabled sleep mode to shut down the regulator, reducing quiescent current to $0.5\,\mu\text{A}$ maximum at $T_J = 25^{\circ}\text{C}$. Other features include a power-good function that reports low output voltage and may be used to implement a power-on reset or a low-battery indicator.

The TPS72xx is offered in 3.3-V, 4.85-V, and 5-V fixed-voltage versions and in an adjustable version (programmable over the range of 1.2 V to 9.75 V). Output voltage tolerance is specified as a maximum of 2% over line, load, and temperature ranges (3% for adjustable version).

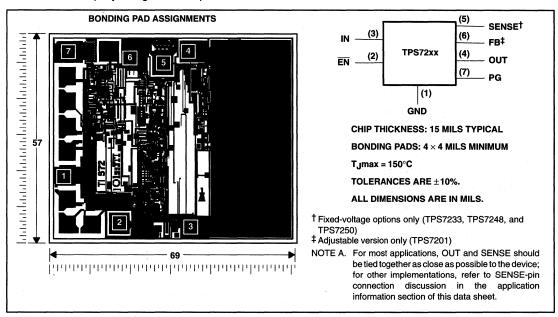


NOTE A. Capacitor selection is nontrivial. See application information section for details.

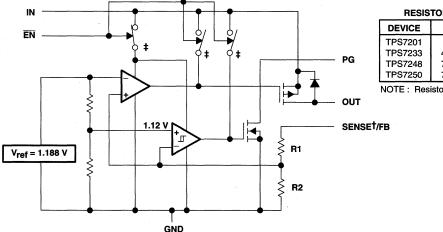
Figure 2. Typical Application Configuration

TPS72xx chip information

These chips, when properly assembled, display characteristics similar to the TPS72xxQ. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



functional block diagram



RESISTOR DIVIDER OPTIONS

DEVICE	R1	R2	UNIT
TPS7201	0	∞	Ω
TPS7233	420	233	kΩ
TPS7248	726	233	kΩ
TPS7250	756	233	. kΩ

NOTE: Resistors are nominal values only.

[†] For most applications, SENSE should be externally connected to OUT as close as possible to the device. For other implementations, refer to the SENSE-pin connection discussion in application information section.

[‡] Switch positions are shown with EN low (active).

TPS7201Q, TPS7233Q, TPS7248Q, TPS7250Q TPS7201Y, TPS7233Y, TPS7248Y, TPS7250Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Input voltage range [‡] , V _I , PG, SENSE, EN	0.3 to 10 V
Output current, IO	1.5 A
Continuous total power dissipation	
Operating virtual junction temperature range, T _J	–55°C to 150°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE 1 - FREE-AIR TEMPERATURE (see Note 1 and Figure 3)

PACKAGE	T _A ≤ 25°C	DERATING FACTOR	T _A = 70°C	T _A = 85°C	T _A = 125°C
	POWER RATING	ABOVE T _A = 25°C	POWER RATING	POWER RATING	POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW	145 mW
PW§	525 mW	4.2 mW/°C	336 mW	273 mW	105 mW

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE (see Note 1 and Figure 4)

PACKAGE	T _C ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _C = 25°C	T _C = 70°C POWER RATING	T _C = 85°C POWER RATING	T _C = 125°C POWER RATING
D	2063 mW	16.5 mW/°C	1320 mW	1073 mW	413 mW
PW§	2900 mW	23.2 mW/°C	1856 mW	1508 mW	580 mW

[§] The PW package information is product preview only and is not yet available.

NOTE 1: Dissipation rating tables and figures are provided for maintenance of junction temperature at or below absolute maximum of 150 °C. For guidelines on maintaining junction temperature within the recommended operating range, see application information section.

MAXIMUM CONTINUOUS DISSIPATION

FREE-AIR TEMPERATURE 800 $\mathsf{P_D}$ – Maximum Continuous Dissipation – mW 700 600 D Package 500 $R_{\theta JA} = 172^{\circ}C/W$ 400 300 PW Package 200 R_{0.14} = 238°C/W 100 0 L 25 75 100 125 TA - Free-Air Temperature - °C

Figure 3

MAXIMUM CONTINUOUS DISSIPATION

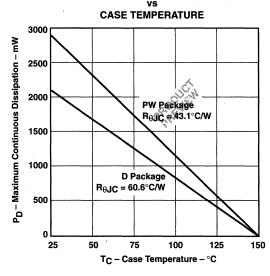


Figure 4

[‡] All voltage values are with respect to network ground terminal.

TPS7201Q, TPS7233Q, TPS7248Q, TPS7250Q TPS7201Y, TPS7233Y, TPS7248Y, TPS7250Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS

recommended operating conditions

		MIN	MAX	UNIT
	TPS7201Q	2.5	10	
Input voltage, V _I †	TPS7233Q	3.98	10	l v
	TPS7248Q	5.24	10	ľ
	TPS7250Q	5.41	10	
High-level input voltage at EN, VIH		2		٧
Low-level input voltage at EN, VIL			0.5	V
Output current, IO		0	250	mA
Operating virtual junction temperature, TJ		-40	125	°C

[†] Minimum input voltage defined in the recommended operating conditions is the maximum specified output voltage plus dropout voltage at the maximum specified load range. Since dropout voltage is a function of output current, the usable range can be extended for lighter loads. To calculate the minimum input voltage for the maximum load current used in a given application, use the following equation:

$$V_{I(min)} = V_{O(max)} + V_{DO(max load)}$$

Because the TPS7201 is programmable, $r_{DS(on)}$ should be used to calculate V_{DO} before applying the above equation. The equation for calculating V_{DO} from $r_{DS(on)}$ is given in Note 3 under the TPS7201 electrical characteristics table. The minimum value of 2.5 V is the absolute lower limit for the recommended input-voltage range for the TPS7201.

TPS7201Q, TPS7233Q, TPS7248Q, TPS7250Q TPS7201Y, TPS7233Y, TPS7248Y, TPS7250Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS SLVS102C - MARCH 1995 - REVISED AUGUST 1995

electrical characteristics, I_O = 10 mA, \overline{EN} = 0 V, C_O = 4.7 μF (CSR[†] = 1 Ω), SENSE/FB shorted to OUT (unless otherwise noted)

PARAMETER	TEST CONDITIONS‡	TJ		1Q, TPS 8Q, TPS		UNIT
			MIN	TYP	MAX	
0	$\overline{\text{EN}} \le 0.5 \text{ V}, \text{V}_{\text{I}} = \text{V}_{\text{O}} + 1 \text{ V},$	25°C		180	225	
Ground current (active mode)	0 mA ≤ I _O ≤ 250 mA	-40°C to 125°C			325	μА
lament comment (atom discount da)	EU V 07V 4V 440V	25°C			0.5	
Input current (standby mode)	$\overline{\text{EN}} = V_{\parallel}, \qquad 2.7 \text{ V} \le V_{\parallel} \le 10 \text{ V}$	-40°C to 125°C			1	μA
O. A. A. A. W. A. B. Martin and A. A.	V 0V V 40V	25°C		0.6	1	
Output current limit threshold	$V_{O} = 0 \text{ V}, \qquad V_{I} = 10 \text{ V}$	-40°C to 125°C			1.5	. A
Pass-element leakage current	= V 0=V 1V 140V	25°C			0.5	
in standby mode	$\overline{EN} = V_{\parallel},$ $2.7 \text{ V} \leq V_{\parallel} \leq 10 \text{ V}$	-40°C to 125°C			1	μΑ
	V 40 V N	25°C			0.5	μА
PG leakage current	V _{PG} = 10 V, Normal operation	-40°C to 125°C			0.5	
Output voltage temperature coefficient		-40°C to 125°C		31	75	ppm/°C
Thermal shutdown junction temperature				165		°C
	2.5 V ≤ V _I ≤ 6 V	-40°C to 125°C	2			.,
EN logic high (standby mode)	6 V ≤ V _I ≤ 10 V	1-40°C to 125°C	2.7			V
	0.77/ < 107/	25°C			0.5	V
EN logic low (active mode)	$2.7 \text{ V} \leq \text{V}_{\text{I}} \leq 10 \text{ V}$	-40°C to 125°C			0.5	V -
EN hysteresis voltage		25°C		50		mV
	0.7.57.540.7	25°C	-0.5		0.5	
EN input current	0 V ≤ V _I ≤ 10 V	-40°C to 125°C	-0.5		0.5	μΑ
Minimum V. for posting many plants		25°C		1.9	2.5	.,
Minimum V _I for active pass element	num V _I for active pass element				2.5	٧
Minimum V formula BO	1 000 4	25°C		0.95	1.5	V
Minimum V _I for valid PG	IPG = 300 μA	-40°C to 125°C			1.9	٧

TCSR(compensation series resistance) refers to the total series resistance, including the equivalent series resistance (ESR) of the capacitor, any series resistance added externally, and PWB trace resistance to CO.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

TPS7201Q, TPS7233Q, TPS7248Q, TPS7250Q TPS7201Y, TPS7233Y, TPS7248Y, TPS7250Y MICROPOWER LOW-DROPOUT (LDO) VÓLTAGE REGULATORS SLVS102C – MARCH 1995 – REVISED AUGUST 1995

TPS7201Q electrical characteristics, $I_{O} = 10$ mA, $V_{I} = 3.5$ V, $\overline{EN} = 0$ V, $C_{O} = 4.7$ μF (CSR[†] = 1 Ω), FB shorted to OUT at device leads (unless otherwise noted)

DADAMETED		TEST CONDITIONS		-	TPS7201Q			LINUT
PARAMETER	TEST CONDITIONS‡			TJ	MIN	TYP	MAX	UNIT
Reference voltage (measured at	V _I = 3.5 V,	I _O = 10) mA	25°C		1.188		V
FB with OUT connected to FB)	$2.5 \text{ V} \le \text{V}_1 \le 10 \text{ V}, \qquad 5 \text{ mA} \le \text{I}_O \le 250 \text{ mA},$ See Note 2		-40°C to 125°C	1.152		1.224	٧	
Reference voltage temperature coefficient				-40°C to 125°C		31	75	ppm/°C
	V 04V	50 · · A	<a< td=""><td>25°C</td><td></td><td>2.1</td><td>4.2</td><td></td></a<>	25°C		2.1	4.2	
	V _I = 2.4 V,	50 μA :	≤ I _O ≤ 100 mA	-40°C to 125°C			4.8	
	V 04V	100) < l = < 000 A	25°C		2.9	4.4	
Pass-element series resistance	V _I = 2.4 V,	100 m	$A \le I_O \le 200 \text{ mA}$	-40°C to 125°C			4.6	
(see Note 3)	у ооу	50 · A	-1 050 A	25°C		1.6	2.7	Ω
	V _I = 2.9 V,	50 μA :	≤ I _O ≤ 250 mA	-40°C to 125°C			4.5	
	V _I = 3.9 V,	50 μA :	≤ I _O ≤ 250 mA	25°C		1		
	V _I = 5.9 V,	50 μA :	≤ I _O ≤ 250 mA	25°C		0.8		
1	V_{\parallel} = 2.5 V to 10 V, 50 μ A \leq I $_{\square}$ \leq 250 mA, See Note 2		$V_1 = 2.5 \text{ V to } 10 \text{ V}, 50 \mu\text{A} \le I_{O} \le 250 \text{ mA}. 25^{\circ}$	25°C			23	
Input regulation			-40°C to 125°C			36	mV	
	IO = 5 mA to 250 mA	A, 2.5 V ≤	V _I ≤ 10 V,	25°C		15	25	
	See Note 2			-40°C to 125°C		*	36	
Output regulation	I_C = 50 μA to 250 mA, 2.5 V \leq V $_I \leq$ 10 V, See Note 2		25°C		17	27	mV	
			-40°C to 125°C		4	43		
			J. 50 A	25°C	49	60		
Director attended		ΙΟ = 50 μΑ	-40°C to 125°C	32		1.5		
Ripple rejection	f = 120 Hz		IO = 250 mA,	25°C	45	50		dB
			See Note 2	-40°C to 125°C	30			
Output noise spectral density	f = 120 Hz	***************************************		25°C		2		μV/√Hz
			C _O = 4.7 μF	25°C		235		
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSR [†] = 1 Ω		C _O = 10 μF	25°C		190		μVrms
	CSH1 = 1 12		C _O = 100 μF	25°C		125		
PG trip-threshold voltage§	V _{FB} voltage decreas	sing from a	bove VpG	-40°C to 125°C		0.95 × V _{FB(nom)}		٧
PG hysteresis voltage§	Measured at VFB		25°C		12		mV .	
	<u> </u>			25°C		0.1	0.4	
PG output low voltage§	I _{PG} = 400 μA,	$V_{\parallel} = 2.$	13 V	-40°C to 125°C			0.4	V .
				25°C	-10	0.1	10	
B input current			-40°C to 125°C	-20		20	nA	

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance

 $V_{DO} = I_O \cdot r_{DS(on)}$

 $r_{DS(0n)}$ is a function of both output current and input voltage. The parametric table lists $r_{DS(0n)}$ for $V_1 = 2.4$ V, 2.9 V, 3.9 V, and 5.9 V, which corresponds to dropout conditions for programmed output voltages of 2.5 V, 3 V, 4 V, and 6 V, respectively. For other programmed values, refer to Figures 10 and 11.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

[§] Output voltage programmed to 2.5 V with closed-loop configuration (see application information).

NOTES: 2. When $V_I < 2.9 \text{ V}$ and $I_O > 100 \text{ mA}$ simultaneously, pass element $r_{DS(on)}$ increases (see Figure 10) to a point such that the resulting dropout voltage prevents the regulator from maintaining the specified tolerance range.

^{3.} To calculate dropout voltage, use equation:

TPS7201Q, TPS7233Q, TPS7248Q, TPS7250Q TPS7201Y, TPS7233Y, TPS7248Y, TPS7250Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS

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TPS7233Q electrical characteristics, I $_{O}$ = 10 mA, V $_{I}$ = 4.3 V, \overline{EN} = 0 V, C $_{O}$ = 4.7 μF (CSR† = 1 Ω), SENSE shorted to OUT (unless otherwise noted)

DADAMETED	T	TEST CONDITIONS‡		TPS7233Q			UNIT
PARAMETER	IEST CON	IDITIONS+	Ту	MIN	TYP	MAX	UNII
Output voltage	V _I = 4.3 V,	I _O = 10 mA	25°C		3.3		V
Output voltage	$4.3 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V},$	$5 \text{ mA} \le I_{\text{O}} \le 250 \text{ mA}$	-40°C to 125°C	3.23		3.37] ' '
	I- 10 mA	V: 0.00 V	25°C		14	20	
	I _O = 10 mA,	$V_{j} = 3.23 \text{ V}$	-40°C to 125°C			30]
Buring and a second	IO = 100 mA,	V _I = 3.23 V	25°C		140	180	mV
Dropout voltage	IO = 100 IIIA,	V = 3.23 V	-40°C to 125°C			232	'''V
	In 050 mA	V. 2.02.V	25°C		360	460]
	$I_O = 250 \text{ mA},$	$V_{I} = 3.23 \text{ V}$	-40°C to 125°C			610	1
Pass-element series resistance	(3.23 V – V _O)/I _O ,	V _I = 3.23 V,	25°C		1.5	1.84	Ω
Pass-element series resistance	I _O = 250 mA	· -	-40°C to 125°C			2.5	1 32
Input regulation	V: 4.2.V to 10.V	50 A < 1 - < 050 m A	25°C		8	25	mV
Input regulation	$V_{i} = 4.3 \text{ V to } 10 \text{ V},$	50μ A ≤ I_O ≤ 250 mA	-40°C to 125°C			33	''''
	In EmA to 050 mA	mA, $4.3 \text{ V} \le \text{V}_{\parallel} \le 10 \text{ V}$	25°C		32	42	mV
Output regulation	10 = 5 IIIA 10 250 IIIA,		-40°C to 125°C			71	
Output regulation	In 50 A to 050 mA		25°C		41	55	
	$10 = 50 \mu\text{A} \cdot 10 250 \text{mA},$	4.3 V ≤ V ≤ 10 V	-40°C to 125°C			98	1
		I- FOA	25°C	40	52		
Diamle rejection	f = 120 Hz	ΙΟ = 50 μΑ	-40°C to 125°C	38			40
Ripple rejection	1 = 120 HZ	I- 050 A	25°C	35	44		dB
		I _O = 250 mA	-40°C to 125°C	33			1
Output noise spectral density	f = 120 Hz		25°C		2		μV/√Hz
		C _O = 4.7 μF	25°C		265		
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSR [†] = 1 Ω	C _O = 10 μF	25°C		212		μVrms
	00111 = 1 32	C _O = 100 μF	25°C		135		1
PG trip-threshold voltage	VO voltage decreasing from above VPG		-40°C to 125°C		0.95 × V _{O(nom)}		V
PG hysteresis voltage			25°C		32		mV
PG output low voltage	las 1 mA	V. 0.0.V	25°C		0.22	0.4	\ \ \
PG output low voltage	IPG = I MA,	$I_{PG} = 1 \text{ mA}, \qquad V_{I} = 2.8 \text{ V}$				0.4	ı ^v

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to C_O.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

TPS7201Q, TPS7233Q, TPS7248Q, TPS7250Q TPS7201Y, TPS7233Y, TPS7248Y, TPS7250Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS SLVS102C - MARCH 1995 - REVISED AUGUST 1995

TPS7248Q electrical characteristics, I_O = 10 mA, V_I = 5.85 V, $\overline{\text{EN}}$ = 0 V, C_O = 4.7 μF (CSR[†] = 1 Ω), SENSE shorted to OUT (unless otherwise noted)

PARAMETER	TECT OF	NDITIONS‡	- .	TPS7248Q			UNIT
PARAMETER	IESI CC	JNDITIONS+	TJ	MIN	TYP	MAX	UNII
Output voltage	V _I = 5.85 V,	I _O = 10 mA	25°C		4.85		v
Output voltage	5.85 V ≤ V _I ≤ 10 V,	5 mA ≤ I _O ≤ 250 mA	-40°C to 125°C	4.75		4.95	\
,	IO = 10 mA,	V _I = 4.75 V	25°C		10	19	
	10 = 10 IIIA,	VI = 4.75 V	-40°C to 125°C			30	
Description	IO = 100 mA,	V _I = 4.75 V	25°C		90	100	m∨
Dropout voltage	10 = 100 mA,	V = 4.75 V	-40°C to 125°C			150] ""
	l- 050 4 V		25°C		216	250	l
	I _O = 250 mA,	V _I = 4.75 V	-40°C to 125°C			285	1
Pass-element series resistance	(4.75 V - V _O)/I _O ,	V _I = 4.75 V,	25°C		0.8	1	Ω
rass-element series resistance	I _O = 250 mA		-40°C to 125°C			1.4] 12
Input regulation	V E 95 V to 10 V	50 μA ≤ I _O ≤ 250 mA	25°C			34	m∨
Input regulation	V = 5.85 V 10 10 V,	30 μA ≤ 10 ≤ 250 111A	-40°C to 125°C			50	
Output regulation	I _O = 5 mA to 250 mA,	5.85 V ≤ V _I ≤ 10 V	25°C		43	55	mV
			-40°C to 125°C			95	
	I _O = 50 μA to 250 mA,	, 5.85 V ≤ V _I ≤ 10 V	25°C		55	. 75	
			-40°C to 125°C			135	
		ΙΟ = 50 μΑ	25°C	42	53		
Dianta raigation	f = 120 Hz		-40°C to 125°C	36			٦,
Ripple rejection	1 = 120 HZ	I- 050 mA	25°C	36	46		dB
		I _O = 250 mA	-40°C to 125°C	34			
Output noise spectral density	f = 120 Hz		25°C		2		μV/√Hz
		C _O = 4.7 μF	25°C		370		
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSRT = 1 Ω	C _O = 10 μF	25°C		290	***************************************	μVrms
	00117 = 132	C _O = 100 μF	25°C		168		
PG trip-threshold voltage	VO voltage decreasing from above VpG		-40°C to 125°C		0.95 × V _{O(nom)}		V
PG hysteresis voltage			25°C		50		mV
			25°C	· · · · · · · · · · · · · · · · · · ·	0.2	0.4	
PG output low voltage	IPG = 1.2 mA,	V _I = 4.12 V	-40°C to 125°C			0.4	٧

TCSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

TPS7201Q, TPS7233Q, TPS7248Q, TPS7250Q TPS7201Y, TPS7233Y, TPS7248Y, TPS7250Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS SLVS102C - MARCH 1995 - REVISED AUGUST 1995

TPS7250Q electrical characteristics, I_Q = 10 mA, V_I = 6 V, \overline{EN} = 0 V, C_Q = 4.7 μF (CSR † = 1 Ω), SENSE shorted to OUT (unless otherwise noted)

DADAMETED	TEST CONDITIONS‡		-	TPS7250Q			UNIT	
PARAMETER	IESI CO	ONDITIONS+	TJ	MIN	TYP	MAX	UNII	
O. da. da. da.	V _I = 6 V,	I _O = 10 mA	25°C		5		V	
Output voltage	6 V ≤ V _I ≤ 10 V,	5 mA ≤ I _O ≤ 250 mA	-40°C to 125°C	4.9		5.1		
	1 404	V 400V	25°C		8	12		
	I _O = 10 mA,	V _I = 4.88 V	-40°C to 125°C			30		
Daniel and a state of the same	I= 100 mA	V _I = 4.88 V	25°C		76	85	mV	
Dropout voltage	I _O = 100 mA,	V = 4.00 V	-40°C to 125°C			136] '''v	
	I= 050A	V. 400 V	25°C		190	206		
	$I_{O} = 250 \mu\text{A},$	V _I = 4.88 V	-40°C to 125°C			312	1	
Dans alamant savina vasistanas	(4.88 V – V _O)/I _O ,	V _I = 4.88 V,	25°C		0.76	0.825		
Pass-element series resistance	I _O = 250 mA	•	-40°C to 125°C			1.25	Ω	
lanut vanulation	V CV to 10 V	50 A < l = < 050 A	25°C			28	mV	
Input regulation	$V_{I} = 6 \text{ V to } 10 \text{ V},$	$50 \mu\text{A} \le I_{\text{O}} \le 250 \text{mA}$	-40°C to 125°C			35	IIIV	
Output regulation	In EmAto 050 mA	61/21/2101/	25°C		46	61	mV	
	$I_O = 5$ mA to 250 mA,	0 4 7 4 1 7 10 4	-40°C to 125°C			100		
	$I_O = 50 \mu\text{A}$ to 250 mA, 6 V	01/21/2401/	25°C		59	79		
		, 0 V S V S 10 V	-40°C to 125°C			150		
		I- 50A	25°C	41	52			
Ripple rejection	f = 120 Hz	ΙΟ = 50 μΑ	-40°C to 125°C	37			dB	
rippie rejection	1 = 120 HZ	IO = 250 mA	25°C	36	46		l ub	
		10 = 250 IIIA	-40°C to 125°C	32				
Output noise spectral density	f = 120 Hz		25°C		2		μV/√Hz	
		C _O = 4.7 μF	25°C		390			
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSRT = 1 Ω	C _O = 10 μF	25°C		300		μVrms	
	C3N1 = 1 12	C _O = 100 μF	25°C		175		1	
PG trip-threshold voltage	VO voltage decreasing	g from above VPG	-40°C to 125°C		0.95 × V _{O(nom)}		٧	
PG hysteresis voltage			25°C		50		mV	
PO 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1			25°C		0.19	0.4	,,	
PG output low voltage IPG = 1.2 mA, V _I = 4.25 V		V _I = 4.25 V	-40°C to 125°C			0.4	- V	

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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electrical characteristics, I_O = 10 mA, $\overline{\text{EN}}$ = 0 V, C_O = 4.7 μF (CSR[†] = 1 Ω), T_J = 25°C, SENSE/FB shorted to OUT (unless otherwise noted)

PARAMETER	TEST CONDITIONS‡	TPS7201Y, TPS7233Y TPS7248Y, TPS7250Y			UNIT
		MIN	TYP	MAX	
Ground current (active mode)	$\overline{EN} \le 0.5 \text{ V}, \qquad V_I = V_O + 1 \text{ V},$ $0 \text{ mA} \le I_O \le 250 \text{ mA}$		180		μА
Output current limit threshold	$V_{O} = 0 \text{ V}, \qquad V_{I} = 10 \text{ V}$		0.6		Α
Thermal shutdown junction temperature			165		°C
EN hysteresis voltage			50		mV
Minimum V _I for active pass element			1.9		V
Minimum V _I for valid PG	IPG = 300 μA		0.95		V

TCSR(compensation series resistance) refers to the total series resistance, including the equivalent series resistance (ESR) of the capacitor, any series resistance added externally, and PWB trace resistance to CO.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

TPS7201Q, TPS7233Q, TPS7248Q, TPS7250Q TPS7201Y, TPS7233Y, TPS7248Y, TPS7250Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS

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electrical characteristics, I_O = 10 mA, \overline{EN} = 0 V, C_O = 4.7 μF (CSR† = 1 Ω), T_J = 25°C, FB shorted to OUT at device leads (unless otherwise noted)

DADAMETED		0.1mm.o.1o+		TPS7201Y		LINUT
PARAMETER	IESI C	TEST CONDITIONS‡			MAX	UNIT
Reference voltage (measured at FB with OUT connected to FB)	V _I = 3.5 V,	I _O = 10 mA		1.188		٧
	V _I = 2.4 V,	50 μA ≤ I _O ≤ 100 mA		2.1		
	V _I = 2.4 V,	100 mA ≤ I _O ≤ 200 mA		2.9		
Pass-element series resistance (see Note 3)	V _I = 2.9 V,	$50 \mu A \le I_O \le 250 mA$		1.6		Ω
	V _I = 3.9 V,	50μ A ≤ I_O ≤ 250 mA		1	-	
	V _I = 5.9 V,	$50 \mu\text{A} \le l_{\text{O}} \le 250 \text{mA}$		0.8		
Output regulation	2.5 V ≤ V _I ≤ 10 V, See Note 2	$I_O = 5$ mA to 250 mA,		15		.,
	$2.5 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V},$ See Note 2	$I_O = 50 \mu A \text{ to } 250 \text{ mA},$		17		mV
	V. 05V	I _O = 50 μA		60		
Ripple rejection	V _I = 3.5 V, f = 120 Hz	I _O = 250 mA, See Note 2		50		dB
Output noise spectral density	V _I = 3.5 V,	f = 120 Hz		2		μV/√Hz
	V _I = 3.5 V,	C _O = 4.7 μF		235		
Output noise voltage	10 Hz ≤ f ≤ 100 kHz,	C _O = 10 μF		190		μVrms
	CSR [†] = 1 Ω	C _O = 100 μF	125			
PG hysteresis voltage§	V _I = 3.5 V,	Measured at V _{FB}		12		mV
PG output low voltage§	V _I = 2.13 V,	I _{PG} = 400 μA		0.1		- V
FB input current	V _I = 3.5 V	:		0.1		nA

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to Co.

3 To calculate dropout voltage, use equation:

 $V_{DO} = I_O \cdot r_{DS(on)}$

 $r_{DS(0n)}$ is a function of both output current and input voltage. The parametric table lists $r_{DS(0n)}$ for $V_1 = 2.4$ V, 2.9 V, 3.9 V, and 5.9 V, which corresponds to dropout conditions for programmed output voltages of 2.5 V, 3 V, 4 V, and 6 V, respectively. For other programmed values, refer to Figures 10 and 11.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

[§] Output voltage programmed to 2.5 V with closed-loop configuration (see application information).

NOTES: 2 When V₁ < 2.9 V and I_O > 100 mA simultaneously, pass element r_{DS(on)} increases (see Figure 10) to a point such that the resulting dropout voltage prevents the regulator from maintaining the specified tolerance range.

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electrical characteristics, I_Q = 10 mA, \overline{EN} = 0 V, C_Q = 4.7 μF (CSR † = 1 Ω), T_J = 25°C, SENSE shorted to OUT (unless otherwise noted)

DADAMETED			Т	PS7233	Y	
PARAMETER	1EST C	TEST CONDITIONS‡			MAX	UNIT
Output voltage	V _I = 4.3 V,	I _O = 10 mA		3.3		V
	V _I = 3.23 V,	I _O = 10 mA		14		
Dropout voltage	V _I = 3.23 V,	I _O = 100 mA		140		mV
	V _I = 3.23 V,	I _O = 250 mA		360		
Pass-element series resistance	$(3.23 \text{ V} - \text{V}_{\text{O}})/\text{I}_{\text{O}},$ $\text{I}_{\text{O}} = 250 \text{ mA}$	V _I = 3.23 V,		1.5		Ω
Input regulation	V _I = 4.3 V to 10 V,	50 μA ≤ I _O ≤ 250 mA		8		mV
Output regulation	4.3 V ≤ V _I ≤ 10 V,	I _O = 5 mA to 250 mA		32		m\/
	$4.3 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V},$	I _O = 50 μA to 250 mA		41		mV
Dinale rejection	V _I = 4.3 V,	ΙΟ = 50 μΑ		52		dB
Ripple rejection	f = 120 Hz	I _O = 250 mA		44		uв
Output noise spectral density	V _I = 4.3 V,	f = 120 Hz		2		μV/√Hz
	V _I = 4.3 V,	C _O = 4.7 μF		265		
Output noise voltage	10 Hz ≤ f ≤ 100 kHz,	C _O = 10 μF		212		μVrms
	$CSR^{\dagger} = 1 \Omega$	C _O = 100 μF		135		
PG hysteresis voltage	V _I = 4.3 V			32		mV
PG output low voltage	V _I = 2.8 V,	IPG = 1 mA		0.22		V

[†]CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to CO.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

DADAMETED	TEGT OF	TEST CONDITIONS‡		TPS7248Y		
PARAMETER	IESI CO			MAX	UNIT	
Output voltage	V _I = 5.85 V,	I _O = 10 mA	4.85		V	
1	V _I = 4.75 V,	I _O = 10 mA	10			
Dropout voltage	V _I = 4.75 V,	I _O = 100 mA	90		mV	
	V _I = 4.75 V,	I _O = 250 mA	216		1	
Pass-element series resistance	(4.75 V – V _O)/I _O , I _O = 250 mA	V _I = 4.75 V,	0.8		Ω	
Output regulation	5.85 V ≤ V _I ≤ 10 V	I _O = 5 mA to 250 mA	43			
	5.85 V ≤ V _I ≤ 10 V	l _O = 50 μA to 250 mA	55		mV	
Ripple rejection	V _I = 5.85 V,	I _O = 50 μA	53		dB	
	f = 120 Hz	I _O = 250 mA	46			
Output noise spectral density	V _I = 5.85 V,	f = 120 Hz	2		μV/√Hz	
Output noise voltage	V _I = 5.85 V,	C _O = 4.7 μF	370			
	10 Hz \leq f \leq 100 kHz,	C _O = 10 μF	290		μVrms	
	CSR [†] = 1 Ω	C _O = 100 μF	168			
PG hysteresis voltage	V _I = 5.85 V		50		mV	
PG output low voltage	V _I = 4.12 V,	IPG = 1.2 mA	0.2		V	

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

TPS7201Q, TPS7233Q, TPS7248Q, TPS7250Q TPS7201Y, TPS7233Y, TPS7248Y, TPS7250Y MICROPOWER LOW-DROPOUT (LDO) VOLTAGE REGULATORS

electrical characteristics, I_O = 10 mA, \overline{EN} = 0 V, C_O = 4.7 μF (CSR † = 1 Ω), T_J = 25°C, SENSE shorted to OUT (unless otherwise noted) (continued)

DADAMETED			TPS7250Q				
PARAMETER	IESI C	TEST CONDITIONS‡		TYP	MAX	UNIT	
Output voltage	V _I = 6 V,	I _O = 10 mA		5		V	
Dropout voltage	V _I = 4.88 V,	I _O = 10 mA		. 8			
	V _I = 4.88 V,	I _O = 100 mA		76		mV	
	V _I = 4.88 V,	I _O = 250 μA		190			
Pass-element series resistance	(4.88 V - V _O)/I _O , I _O = 250 mA	V _I = 4.88 V,		0.76		Ω	
Input regulation	V _I = 6 V to 10 V,	50 μA ≤ I _O ≤ 250 mA				mV	
Output regulation	6 V ≤ V _I ≤ 10 V,	I _O = 5 mA to 250 mA		46			
	$6 \text{ V} \leq \text{V}_{\text{I}} \leq 10 \text{ V},$	I _O = 50 μA to 250 mA		59		mV	
Ripple rejection	V _I = 6 V,	ΙΟ = 50 μΑ		52		dB	
	f = 120 Hz	I _O = 250 mA		46			
Output noise spectral density	V _I = 6 V,	f = 120 Hz		2		μV/√Hz	
Output noise voltage	V _I = 6 V,	C _O = 4.7 μF		390			
	$10 \text{ Hz} \le \text{f} \le 100 \text{ kHz},$	C _O = 10 μF		300		μVrms	
	CSR [†] = 1 Ω	C _O = 100 μF		175			
PG hysteresis voltage	V _I = 6 V			50		mV	
PG output low voltage	V _I = 4.25 V,	Ipg = 1.2 mA	1	0.19		V	

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance

to C_O.

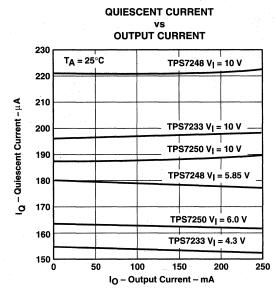
‡ Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

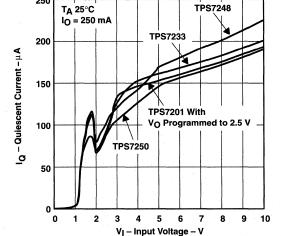
Table of Graphs

		,	FIGURE
lQ	0.::	vs Output current	5
	Quiescent current	vs Input voltage	6
ΔIQ [†]	Change in quiescent current	vs Free-air temperature	7
V _{DO}	Dropout voltage	vs Output current	8
ΔV_{DO}	Change in dropout voltage	vs Free-air temperature	9
V _{DO}	Dropout voltage (TPS7201 only)	vs Output current	10
rDS(on)	Pass-element series resistance	vs Input voltage	11
ΔVΟ	Change in output voltage	vs Free-air temperature	12
٧o	Output voltage	vs Input voltage	13
	Line regulation		14
	Load regulation (TPS7233)		15
	Load regulation (TPS7248)		16
	Load regulation (TPS7250)		17
V _{O(PG)}	Power-good (PG) voltage	vs Output voltage	18
rDS(on)PG	Power-good (PG) on-resistance	vs Input voltage	19
VI	Minimum input voltage for valid PG	vs Free-air temperature	20
	Output voltage response from enable (EN)		21
	Load transient response (TPS7201/TPS7233)		22
	Load transient response (TPS7248/TPS7250)		23
	Line transient response (TPS7201)		24
	Line transient response (TPS7233)		25
	Line transient response (TPS7248/TPS7250)		26
	Ripple rejection	vs Frequency	. 27
	Output Spectral Noise Density	vs Frequency	28
		vs Output current (C _O = 4.7 μF)	29
	Componentian agrica registeres (CCP)	vs Added ceramic capacitance ($C_O = 4.7 \mu F$)	30
	Compensation series resistance (CSR)	vs Output current (C _O = 10 μF)	31
		vs Added ceramic capacitance (C _O = 10 μF)	32

[†] This symbol is not currently listed within EIA or JEDEC standards for semiconductor symbology.

250



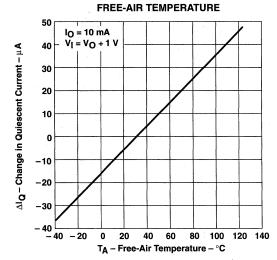


QUIESCENT CURRENT

INPUT VOLTAGE

Figure 5

CHANGE IN QUIESCENT CURRENT vs



DROPOUT VOLTAGE vs OUTPUT CURRENT

Figure 6

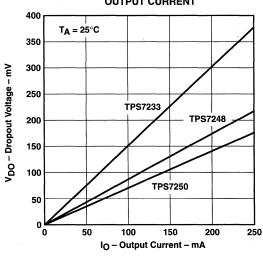


Figure 7

Figure 8



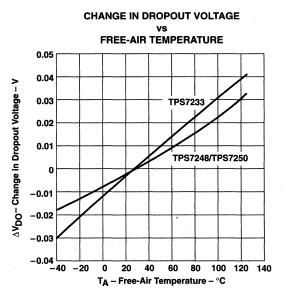


Figure 9

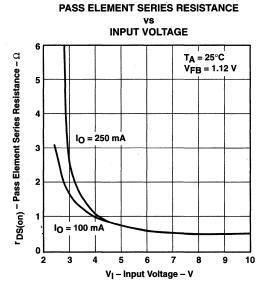


Figure 11

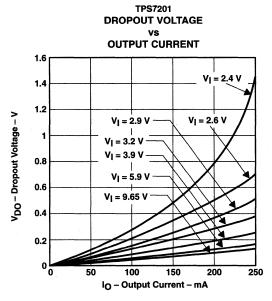


Figure 10

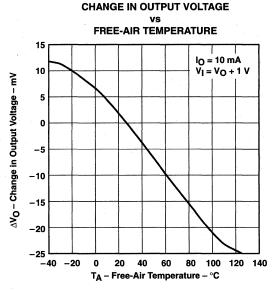


Figure 12

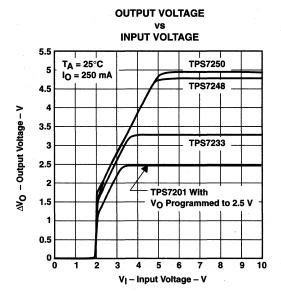


Figure 13

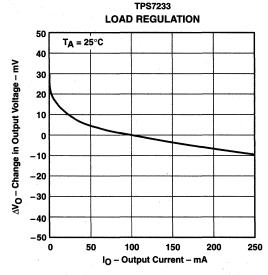


Figure 15

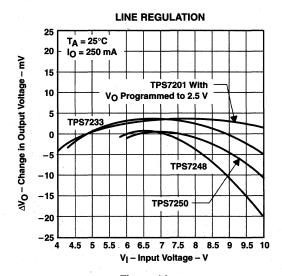


Figure 14

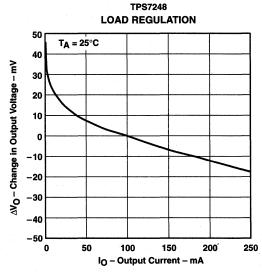


Figure 16

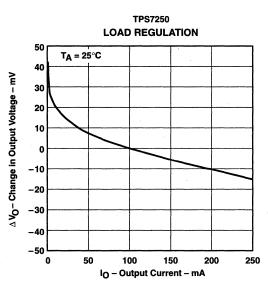
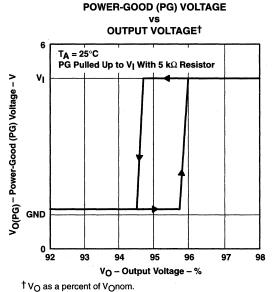


Figure 17



POWER-GOOD (PG) ON-RESISTANCE

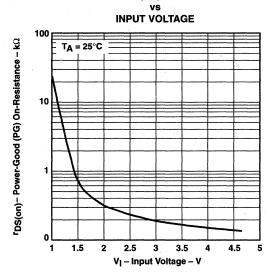


Figure 19

MINIMUM INPUT VOLTAGE FOR VALID PG

Figure 18

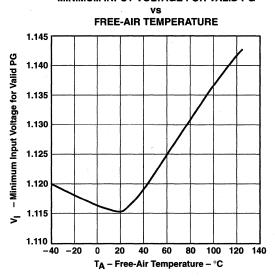


Figure 20

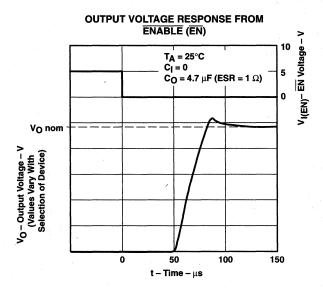


Figure 21

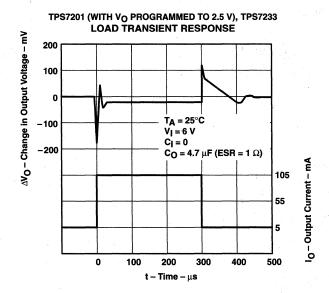


Figure 22

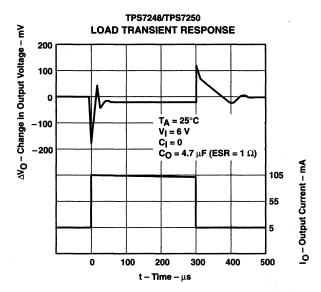


Figure 23

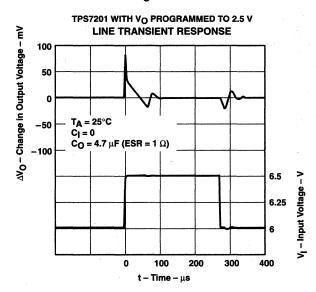


Figure 24

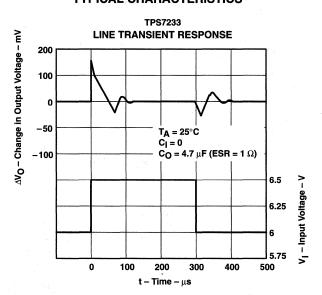


Figure 25

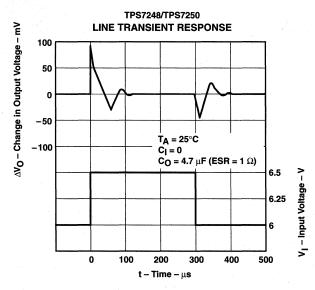


Figure 26

RIPPLE REJECTION

FREQUENCY

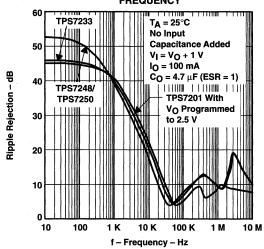


Figure 27

OUTPUT SPECTRAL NOISE DENSITY

vs

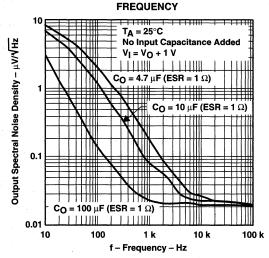
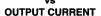


Figure 28

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TYPICAL CHARACTERISTICS

TYPICAL REGIONS OF STABILITY COMPENSATION SERIES RESISTANCE (CSR)†



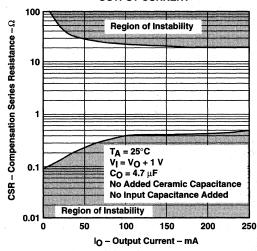


Figure 29

TYPICAL REGIONS OF STABILITY COMPENSATION SERIES RESISTANCE (CSR)[†]

OUTPUT CURRENT

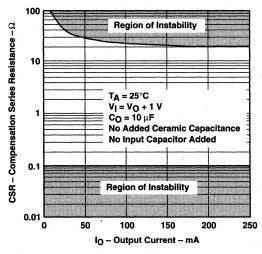


Figure 31

TYPICAL REGIONS OF STABILITY COMPENSATION SERIES RESISTANCE (CSR)†

ADDED CERAMIC CAPACITANCE

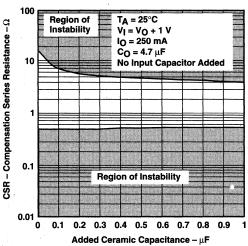


Figure 30

TYPICAL REGIONS OF STABILITY COMPENSATION SERIES RESISTANCE (CSR)†

ADDED CERAMIC CAPACITANCE

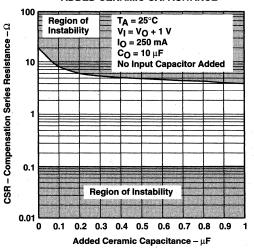


Figure 32

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to C_O.



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APPLICATION INFORMATION

The design of the TPS72xx family of low-dropout (LDO) regulators is based on the higher-current TPS71xx family. These new families of regulators have been optimized for use in battery-operated equipment and feature extremely low dropout voltages, low supply currents that remain constant over the full-output-current range of the device, and an enable input to reduce supply currents to less than 0.5 µA when the regulator is turned off.

device operation

The TPS72xx uses a PMOS pass element to dramatically reduce both dropout voltage and supply current over more conventional PNP-pass-element LDO designs. The PMOS transistor is a voltage-controlled device and, unlike a PNP transistor, does not require increased drive current as output current increases. Supply current in the TPS72xx is essentially constant from no-load to maximum.

Current limiting and thermal protection prevent damage by excessive output current and/or power dissipation. The device switches into a constant-current mode at approximately 1 A; further load increases reduce the output voltage instead of increasing the output current. The thermal protection shuts the regulator off if the junction temperature rises above 165°C. Recovery is automatic when the junction temperature drops approximately 5°C below the high temperature trip point. The PMOS pass element includes a back diode that safely conducts reverse current when the input voltage level drops below the output voltage level.

A logic high on the enable input, $\overline{\text{EN}}$, shuts off the output and reduces the supply current to less than 0.5 μ A. $\overline{\text{EN}}$ should be grounded in applications where the shutdown feature is not used.

Power good (PG) is an open-drain output signal used to indicate output-voltage status. A comparator circuit continuously monitors the output voltage. When the output drops to approximately 95% of its nominal regulated value, the comparator turns on and pulls PG low.

A typical application circuit is shown in Figure 33.

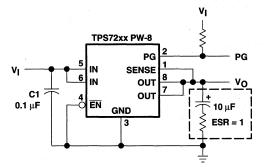


Figure 33. Typical Application Circuit

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APPLICATION INFORMATION

external capacitor requirements

Although not required, a 0.047-µF to 0.1-µF ceramic bypass input capacitor, connected between IN and GND and located close to the TPS72xx, is recommended to improve transient response and noise rejection. A higher-value electrolytic input capacitor may be necessary if large, fast-rise-time load transients are anticipated and the device is located several inches from the power source.

An output capacitor is required to stabilize the internal feedback loop. For most applications, a 10-μF to 15-μF solid-tantalum capacitor with a $0.5-\Omega$ resistor (see capacitor selection table) in series is sufficient. The maximum capacitor ESR should be limited to 1.3 Ω to allow for ESR doubling at cold temperatures. Figure 34 shows the transient response of a 5-mA to 85-mA load using a 10-μF output capacitor with a total ESR of 1.7 Ω.

A 4.7-μF solid-tantalum capacitor in series with a 1-Ω resistor may also be used (see Figures 29 and 30) provided the ESR of the capacitor does not exceed 1 Ω at room temperature and 2 Ω over the full operating temperature range.

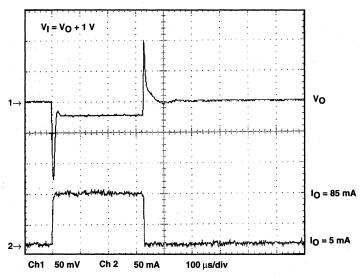


Figure 34. Load Transient Response (ESR total = 1.7 Ω), TPS7248Q

A partial listing of surface-mount capacitors usable with the TPS72xx family is provided below. This information (along with the stability graphs. Figures 29 through 32) is included to assist the designer in selecting suitable capacitors.

CAPACITOR SELECTION

PART NO.	MFR.	VALUE	MAX ESR [†]	SIZE $(H \times L \times W)^{\dagger}$
592D156X0020R2T	Sprague	15 μF, 20 V	1.1	$1.2 \times 7.2 \times 6$
595D156X0025C2T	Sprague	15 μF, 25 V	1	$2.5 \times 7.1 \times 3.2$
595D106X0025C2T	Sprague	10 μF, 25 V	1.2	$2.5 \times 7.1 \times 3.2$
695D106X0035G2T	Sprague	10 μF, 35 V	1.3	$2.5\times7.6\times2.5$

[†] Size is in mm. ESR is maximum resistance in ohms at 100 kHz and T_A = 25°C. Listings are sorted by height.



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APPLICATION INFORMATION

sense-pin connection

SENSE must be connected to OUT for proper operation of the regulator. Normally this connection should be as short as possible; however, remote sense may be implemented in critical applications when proper care of the circuit path is exercised. SENSE internally connects to a high-impedance wide-bandwidth amplifier through a resistor-divider network, and any noise pickup on the PCB trace will feed through to the regulator output. SENSE must be routed to minimize noise pickup. Filtering SENSE using an RC network is not recommended because of the possibility of inducing regulator instability.

output voltage programming

The output voltage of the TPS7201 adjustable regulator is programmed using an external resistor divider as shown in Figure 35. The output voltage is calculated using:

$$V_{O} = V_{ref} \cdot \left(1 + \frac{R1}{R2}\right) \tag{1}$$

where

 $V_{ref} = 1.188 \text{ V typ (the internal reference voltage)}$

Resistors R1 and R2 should be chosen for approximately 7- μ A divider current. Lower value resistors can be used but offer no inherent advantage and waste more power. Higher values should be avoided as leakage currents at FB increase the output voltage error. The recommended design procedure is to choose R2 = 169 k Ω to set the divider current at 7 μ A and then calculate R1 using:

$$R1 = \left(\frac{V_{O}}{V_{ref}} - 1\right) \cdot R2 \tag{2}$$

OUTPUT VOLTAGE PROGRAMMING GUIDE

OUTPUT VOLTAGE	DIVIDER RESISTANC $(k\Omega)^{\dagger}$					
(V)	R1	R2				
2.5	191	169				
3.3	309	169				
3.6	348	169				
4	402	169				
5	549	169				
6.4	750	169				



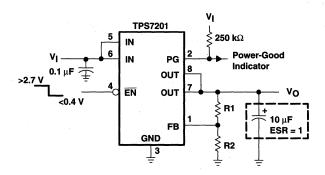


Figure 35. TPS7201 Adjustable LDO Regulator Programming

APPLICATION INFORMATION

power dissipation and junction temperature

Specified regulator operation is assured to a junction temperature of 125° C; the maximum junction temperature allowable to avoid damaging the device is 150° C. These restrictions limit the power dissipation that the regulator can handle in any given application. To ensure the junction temperature is within acceptable limits, calculate the maximum allowable dissipation, $P_{D(max)}$, and the actual dissipation, P_{D} , which must be less than or equal to $P_{D(max)}$.

The maximum-power-dissipation limit is determined using the following equation:

$$P_{D(max)} = \frac{T_{J}max - T_{A}}{R_{A,IA}}$$

Where

T_Jmax is the maximum allowable junction temperature, i.e.,150°C absolute maximum and 125°C recommended operating temperature.

 $R_{\theta JA}$ is the thermal resistance junction-to-ambient for the package, i.e., 172°C/W for the 8-terminal SOIC and 238°C/W for the 8-terminal TSSOP.

TA is the ambient temperature.

The regulator dissipation is calculated using:

$$P_{D} = (V_{I} - V_{O}) \cdot I_{O}$$

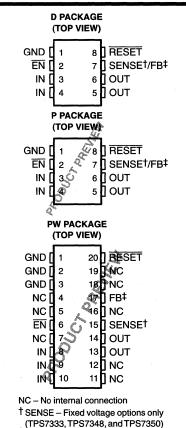
Power dissipation resulting from quiescent current is negligible.

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- Available in 3.3-V, 4.85-V, and 5-V
 Fixed-Output and Adjustable Versions
- Integrated Precision Supply-Voltage Supervisor Monitoring Regulator Output Voltage
- Active-Low Reset Signal with 200-ms Pulse Width
- Very Low Dropout Voltage . . . Maximum of 35 mV at I_O = 100 mA (TPS7350)
- Low Quiescent Current Independent of Load . . . 340 μA Typ
- Extremely Low Sleep-State Current, 0.5 μA Max
- 2% Tolerance Over Full Range of Load, Line, and Temperature for Fixed-Output Versions
- Output Current Range of 0 mA to 250 mA
- TSSOP Package Option Offers Reduced Component Height For Critical Applications

description

The TPS73xx devices are members of a family of micropower low-dropout (LDO) voltage regulators. They are differentiated from the TPS71xx and TPS72xx LDOs by their integrated delayed microprocessor-reset function. If the precision delayed reset is not required, the designer should consider the TPS71xx and TPS72xx.†



‡ FB – Adjustable version only (TPS7301)

AVAILABLE OPTIONS

TJ	OUTPU	JT VOLT (V)	AGE	NEGATIVE-GOING RESET THRESHOLD VOLTAGE (V) PACKAGED DEVICES			PACKAGED DEVICES				
	MIN	ТҮР	MAX	MIN	ТҮР	MAX	SMALL OUT- LINE (D) PLASTIC DIP TSSOP (P) (PW)			(Y)	
	4.9	5	5.1	4.55	4.65	4.75	TPS7350QD	TPS7350QP	TPS7350QPWLE	TPS7350Y	
-40°C to	4.75	4.85	4.95	4.5	4.6	4.7	TPS7348QD	TPS7348QP	TPS7348QPWLE	TPS7348Y	
125°C	3.23	3.3	3.37	2.868	2.934	3	TPS7333QD	TP\$7333QP	TP\$7333QPWLE	TPS7333Y	
	Adjustable 1.2 V to 9.75 V		1.101	1.123	1.145	TPS7301QD	TPS7301QP	TPS/301QPWLE	TPS7301Y		

The D package is available taped and reeled. Add R suffix to device type (e.g., TPS7350QDR). The PW package is only available left-end taped and reeled. The TPS7301Q is programmable using an external resistor divider (see application information). The chip form is tested at 25°C.

[†] The TPS71xx and the TPS72xx are 500-mA and 250-mA output regulators respectively, offering performance similar to that of the TPS73xx but without the delayed-reset function. The TPS72xx devices are further differentiated by availability in 8-pin thin shrink small-outline packages (TSSOP) for applications requiring minimum package size.



description (continued)

The RESET output of the TPS73xx is designed to initiate a reset in microcomputer and micro-processor systems in the event of an undervoltage condition. An internal comparator in the TPS73xx monitors the output voltage of the regulator to detect an undervoltage condition on the regulated output voltage.

If that occurs, the RESET output (open-drain NMOS) turns on, taking the RESET signal low. RESET stays low for the duration of the undervoltage condition. Once the undervoltage condition ceases, a 200-ms (typ) time-out begins. At the completion of the 200-ms delay, RESET goes high.

An order of magnitude reduction in dropout voltage and quiescent current over conventional LDO performance is achieved by replacing the typical pnp pass transistor with a PMOS device.

Because the PMOS device behaves as a low-value resistor, the dropout voltage is very low (maximum of 35 mV at an output current of 100 mA for the TPS7350) and is directly proportional to the output current (see Figure 1). Additionally, since the PMOS pass element is a voltage-driven device, the quiescent current is low and remains constant, independent of output loading (typically 340 µA over the full range of output current, 0 mA to 250 mA). These two key specifications yield a significant improvement in operating life for battery-powered systems.

The LDO family also features a sleep mode; applying a logic high signal to $\overline{\text{EN}}$ (enable) shuts down the regulator, reducing the quiescent current to 0.5 μ A maximum at $T_{\text{J}} = 25^{\circ}\text{C}$.

The TPS73xx is offered in 3.3-V, 4.85-V, and 5-V fixed-voltage versions and in an adjustable version (programmable over the range of 1.2 V to 9.75 V). Output voltage tolerance is specified as a maximum of 2% over line, load, and temperature ranges (3% for adjustable version). The TPS73xx family is available in PDIP (8 pin), SO (8 pin) and TSSOP (20 pin) packages. The TSSOP has a maximum height of 1.2 mm.

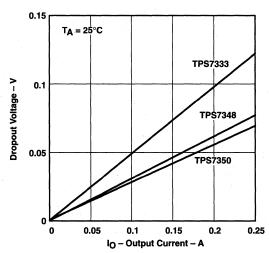
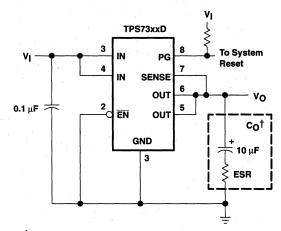


Figure 1. Dropout Voltage Versus Output Current

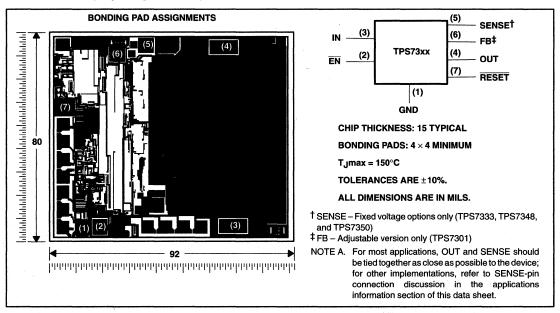


† Capacitor selection is nontrivial. See application information section for details.

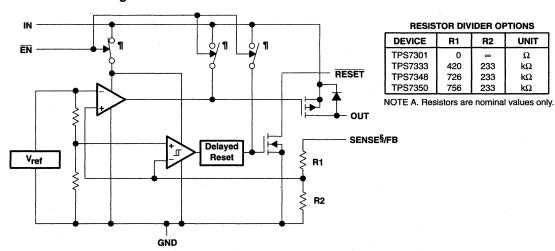
Figure 2. Typical Application Configuration

TPS73xxY chip information

These chips, when properly assembled, display characteristics similar to the TPS73xxQ. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



functional block diagram



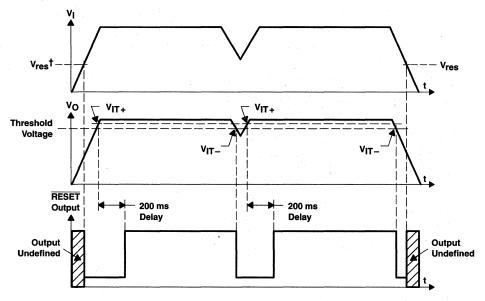
[§] For most applications, SENSE should be externally connected to OUT as close as possible to the device. For other implementations, refer to SENSE-pin connection discussion in applications information section.

[¶] Switch positions are shown with EN low (active).



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timing diagram



 $[\]dagger$ V_{res} is the minimum input voltage for a valid RESET. The symbol V_{res} is not currently listed within EIA or JEDEC standards for semiconductor symbology.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Input voltage range§, V _I , RESET, SENSE, EN	0.3 to 10 V
Output current, IO	2 A
Continuous total power dissipation	See Dissipation Rating Tables 1 and 2
Operating virtual junction temperature range, T _J	
Storage temperature range, T _{stq}	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[§] All voltage values are with respect to network terminal ground.

DISSIPATION RATING TABLE 1 - FREE-AIR TEMPERATURE (see Figure 3)

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	145 mW
P†	1175 mW	9.4 mW/°C	752 mW	235 mW
PW†‡	700 mW	5.6 mW/°C	448 mW	140 mW

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE (see Figure 4)

PACKAGE	T _C ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _C = 25°C	T _C = 70°C POWER RATING	T _C = 125°C POWER RATING
D	2188 mW	9.4 mW/°C	1765 mW	1248 mW
Ρţ	2738 mW	21.9 mW/°C	1752 mW	548 mW
PW†‡	4025 mW	32.2 mW/°C	2576 mW	805 mW

[†] The P and PW packages are product preview only and are not yet available.

MAXIMUM CONTINUOUS DISSIPATION vs FREE-AIR TEMPERATURE

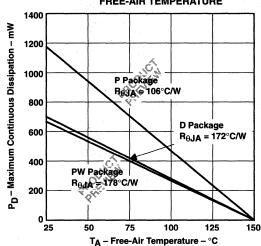


Figure 3

MAXIMUM CONTINUOUS DISSIPATION

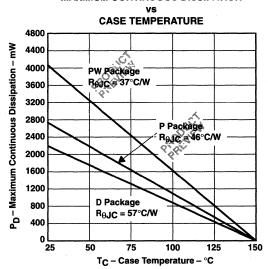


Figure 4

[‡] Refer to thermal information section for detailed power dissipation considerations when using the TSSOP package.

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recommended operating conditions

		MIN	MAX	UNIT
	TPS7301Q	2.5	10	
I to an a succession of the su	TPS7333Q	3.77	10	v
Input voltage, V _I †	TPS7348Q	5.2	10	· ·
	TPS7350Q	5.33	10	
High-level input voltage at EN, VIH		2		V
Low-level input voltage at EN, VIL			0.5	V
Output current range, IO		0	250	mA
Operating virtual junction temperature range, TJ		-40	125	°C

[†] Minimum input voltage defined in the recommended operating conditions is the maximum specified output voltage plus dropout voltage, V_{DO}, at the maximum specified load range. Since dropout voltage is a function of output current, the usable range can be extended for lighter loads. To calculate the minimum input voltage for the maximum load current used in a given application, use the following equation:

$$V_{I(min)} = V_{O(max)} + V_{DO(max load)}$$

Because the TPS7301 is programmable, $r_{DS(on)}$ should be used to calculate V_{DO} before applying the above equation. The equation for calculating V_{DO} from $r_{DS(on)}$ is given in Note 2 in the electrical characteristics table. The minimum value of 2.5 V is the absolute lower limit for the recommended input voltage range for the TPS7301.

electrical characteristics at I $_{O}$ = 10 mA, \overline{EN} = 0 V, C_{O} = 4.7 μ F(CSR ‡ = 1 Ω), SENSE/FB shorted to OUT (unless otherwise noted)

PARAMETER	TEST CO	ONDITIONS§	Ŧj		1Q, TPS 48Q, TPS		UNIT
				MIN	TYP		
Ground current (active mode)	<u>EN</u> ≤ 0.5 V,	$V_1 = V_0 + 1 V_1$	25°C		340	400	μА
Ground current (active mode)	0 mA ≤ I _O ≤ 250 m	nA	-40°C to 125°C			550	μΑ
Input current (standby mode)	EN V	0.71/ < 1/ < 10.1/	25°C		0.01	0.5	μА
input current (standby mode)	$\overline{EN} = V_{I},$	2.7 V ≤ V _I ≤ 10 V	-40°C to 125°C			. 2	μΛ
Output current limit	V- 0V	$V_0 = 0 \text{ V},$ $V_1 = 10 \text{ V}$			1.2	2	Α
Output current infint	VO = 0 V,					2	_ ^
Pass-element leakage current	T	$\overline{\text{EN}} = \text{V}_{\text{j}}, \qquad 2.7 \text{ V} \le \text{V}_{\text{j}} \le 10 \text{ V}$			0.01	0.5	
in standby mode	EN = VI,					1	μА
STORT .			25°C		0.02	0.5	μА
RESET leakage current	Normal operation,	V at RESET = 10 V	-40°C to 125°C			0.5	
Output voltage temperature coefficient			-40°C to 125°C		61	75	ppm/°C
Thermal shutdown junction temperature					165		°C
	2.5 V ≤ V _I ≤ 6 V		4000 +- 40500	2			.,
EN logic high (standby mode)	6 V ≤ V _I ≤ 10 V		-40°C to 125°C	2.7			V
	. = 1/ . 1/		25°C			0.5	v
EN logic low (active mode)	$2.7 \text{ V} \leq \text{V}_{\parallel} \leq 10 \text{ V}$		-40°C to 125°C			0.5	1 °
EN hysteresis voltage			25°C		50		mV
 -			25°C	-0.5	0.001	0.5	
EN input current	0 V ≤ V _I ≤ 10 V		-40°C to 125°C	-0.5		0.5	μА
			25°C		2.05	2.5	,,
Minimum V _I for active pass element			-40°C to 125°C	<u> </u>		2.5	٧
	1.	_	25°C		1	1.5	١,,
Minimum V _I for valid RESET	IO(RESET) = -30	0 μΑ	-40°C to 125°C			1.9	٧

[‡] CSR (compensation series resistance) refers to the total series resistance, including the equivalent series resistance (ESR) of the capacitor, any series resistance added externally, and PWB trace resistance to C_O.

[§] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.



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TPS7301Q electrical characteristics at I_O = 10 mA, V_I = 3.5 V, $\overline{\text{EN}}$ = 0 V, C_O = 4.7 μ F(CSR† = 1 Ω), FB shorted to OUT at device leads (unless otherwise noted)

PARAMETER	TEST CONDITIONS‡			TPS7301Q			UNIT
PANAMEIEN	IESI C	ONDITIONS+	TJ	MIN	TYP	MAX	UNIT
Reference voltage	V _I = 3.5 V,	I _O = 10 mA	25°C		1.182		V
(measured at FB)	2.5 V ≤ V _I ≤ 10 V, See Note 1	$5 \text{ mA} \le I_{O} \le 250 \text{ mA},$	-40°C to 125°C	1.147		1.217	٧
Reference voltage temperature coefficient			-40°C to 125°C		61	75	ppm/°C
	V _I = 2.4 V,	50 A < l = < 150 mA	25°C		0.7	1	
	V = 2.4 V,	$50 \mu\text{A} \le I_{\text{O}} \le 150 \text{mA}$	-40°C to 125°C			1	1
	V ₁ = 2.4 V,	150 mA ≤ I _O ≤ 250 mA	25°C		0.83	1.3	1
Pass-element series resistance (see Note 2)	V ₁ = 2.4 V,	190 MM ≥ 10 ≥ 590 MM	-40°C to 125°C			1.3	1
	V _I = 2.9 V,	E0 A < la < 0E0 mA	25°C		0.52	0.85	Ω
		$50 \mu\text{A} \le I_{\text{O}} \le 250 \text{mA}$	-40°C to 125°C			0.85	
	V _I ≒,3.9 V,	$50 \mu A \le I_O \le 250 mA$	25°C		0.32]
	V _I = 5.9 V,	$50 \mu\text{A} \le \text{I}_{\text{O}} \le 250 \text{mA}$	25°C		0.23		1
Innut regulation	V _I = 2.5 V to 10 V,	50 μ A ≤ I _O ≤ 250 mA,	25°C		3	18	18 mV
Input regulation	See Note 1		-40°C to 125°C		11000	25	
	2.5 V ≤ V _I ≤ 10 V, See Note 1	$I_O = 5 \text{ mA to } 250 \text{ mA},$ $I_O = 50 \mu\text{A to } 250 \text{ mA},$	25°C		5	14	mV mV
Output regulation			-40°C to 125°C			25	
Output regulation	$2.5 \text{ V} \le \text{V}_1 \le 10 \text{ V},$		25°C		7	22	
	See Note 1		-40°C to 125°C			54	
		ΙΟ = 50 μΑ	25°C	48	59		
Dinale rejection	f = 120 Hz	IQ = 20 πA	-40°C to 125°C	44			dB
Ripple rejection	1 = 120 HZ	I _O = 250 mA,	25°C	45	54		dB .
		See Note 1	-40°C to 125°C	44			
Output noise-spectral density	f = 120 Hz		25°C		2		μV/√Hz
		C _O = 4.7 μF	25°C		95		
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSR [†] = 1 Ω	C _O = 10 μF	25°C		89		μVrms
	O3N1 = 1.12	C _O = 100 μF	25°C		74		1
RESET trip-threshold voltage§	V _{O(FB)} decreasing		-40°C to 125°C	1.101		1.145	V
RESET hysteresis voltage§	Measured at V _{O(FB)}		25°C		12	***************************************	mV
	1		25°C	 	0.1	0.4	<u> </u>
RESET output low voltage§	V _I = 2.13 V,	$IO(RESET) = 400 \mu A$	-40°C to 125°C			0.4	٧
			25°C	-10	0.1	10	
FB input current			-40°C to 125°C	-20		20	nA

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to Co.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

[§] Output voltage programmed to 2.5 V with closed-loop configuration (see application information).

NOTES: 1. When V_I < 2.9 V and I_O > 150 mA simultaneously, pass element r_{DS(on)} increases (see Figure 32) to a point where the resulting dropout voltage prevents the regulator from maintaining the specified tolerance range.

To calculate dropout voltage, use equation: VDO = IO rDS(on) rDS(on) is a function of both output current and input voltage. The parametric table lists rDS(on) for VI = 2.4 V, 2.9 V, 3.9 V, and 5.9 V, which corresponds to dropout conditions for programmed output voltages of 2.5 V, 3 V, 4 V, and 6 V respectively. For other programmed values, refer to Figure 32.

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TPS7333Q electrical characteristics at I $_{O}$ = 10 mA, V $_{I}$ = 4.3 V, \overline{EN} = 0 V, C $_{O}$ = 4.7 μ F(CSR † = 1 Ω), SENSE shorted to OUT (unless otherwise noted)

DADA44====			_	TI			
PARAMETER	TEST CO	NDITIONS‡	Tj	MIN	TYP	MAX	UNIT
Output voltage	V _I = 4.3 V,	I _O = 10 mA	25°C		3.3		v
Output voltage	$4.3 \text{ V} \le \text{V}_{\parallel} \le 10 \text{ V},$	5 mA ≤ I _O ≤ 250 mA	-40°C to 125°C	3.23		3.37	1 °
	I= 40 mA	V- 0.00 V	25°C		4.5	7	
	I _O = 10 mA,	V _I = 3.23 V	-40°C to 125°C			8	1
D	IO = 100 mA,	V _I = 3.23 V	25°C		44	60	mV
Dropout voltage	10 = 100 mA,	V = 3.23 V	-40°C to 125°C			80] ""
	1- 050 mA	V- 2.02.V	25°C		108	150	
The state of the s	$I_{O} = 250 \text{ mA},$	V _I = 3.23 V	-40°C to 125°C			200	
Pass-element series resistance	(3.23 V - V _O)/I _O ,	V _I = 3.23 V,	25°C		0.44	0.6	
Fass-element series resistance	I _O = 250 mA		-40°C to 125°C		X	0.8	Ω
Input regulation	V. 40 V to 10 V	50 ·· A < l = < 050 ·· A	25°C		6	23	mV
Input regulation	V _I = 4.3 V to 10 V,	50μ A ≤ I_O ≤ 250 mA	-40°C to 125°C	25		29] ""
	I = E m A to 050 m A	4.2.V.< 10.V	25°C		21	32	mV
	$I_O = 5 \text{ mA to } 250 \text{ mA}, 4.3 \text{ V} \le V_I \le 10 \text{ V}$		-40°C to 125°C			60] ""
Output regulation	$I_{O} = 50 \mu\text{A}$ to 250 mA, 4.3 V \leq V _I \leq 10 V		25°C		31	60	mV
	10 = 50 try to 550 thy	, 4.3 V ≤ V ≤ 10 V	-40°C to 125°C			120	1 mv
	and the same	I= 50A	25°C	46	51		
Dinala valantian	4 100 11-	ΙΟ = 50 μΑ	-40°C to 125°C	44			1 _
Ripple rejection	f = 120 Hz	I- 050 A	25°C	39	49		dB
		I _O = 250 mA	-40°C to 125°C	36			1
Output noise-spectral density	f = 120 Hz		25°C		2		μV/√Hz
		C _O = 4.7 μF	25°C		274		
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSRT = 1 Ω	C _O = 10 μF	25°C		228	-	μVrms
	CSH1 = 112	C _O = 100 μF	25°C	1000	159		
RESET trip-threshold voltage	V _O decreasing		-40°C to 125°C	2.868			V
RESET trip-threshold voltage	V _O increasing		-40°C to 125°C			•	V
RESET hysteresis voltage			25°C		18		mV
			25°C		0.17	0.4	1
RESET output low voltage	$V_{I} = 2.8 V$,	IO(RESET) = -1 mA	-40°C to 125°C			0.4	- V

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to Co.

to Co.

‡ Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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TPS7348Q electrical characteristics at I_{O} = 10 mA, V_{I} = 5.85 V, \overline{EN} = 0 V, C_{O} = 4.7 μ F(CSR† = 1 Ω), SENSE shorted to OUT (unless otherwise noted)

DADAMETED	TEST CONDITIONS‡			TI	PS7348C		
PARAMETER	TEST CON	IDITIONS+	l TJ	MIN	TYP	MAX	UNIT
Output voltage	V _I = 5.85 V,	I _O = 10 mA	25°C		4.85		V
Output voltage	$5.85 \text{ V} \le \text{V}_{\parallel} \le 10 \text{ V},$	5 mA ≤ I _O ≤ 250 mA	-40°C to 125°C	4.75		4.95	1 °
	In 10 mA	V _I = 4.75 V	25°C		2.9	6	
	I _O = 10 mA,	V = 4.75 V	-40°C to 125°C			8	1
Dunnantualtana	IO = 100 mA,	V _I = 4.75 V	25°C		28	37	mV
Dropout voltage	10 = 100 IIIA,	V = 4.75 V	-40°C to 125°C			52	} ''''
	IO = 250 mA,	V _I = 4.75 V	25°C		70	91]
	IO = 250 MA,	V = 4.75 V	-40°C to 125°C			130	
Pass-element series resistance	(4.75 V – V _O)/I _O ,	V _I = 4.75 V,	25°C		0.28	0.37	Ω
rass-element series resistance	I _O = 250 mA	F	-40°C to 125°C			0.52	1 12
Input regulation	V _I = 5.85 V to 10 V,	50 μA ≤ I _O ≤ 250 mA	25°C	1.1	9	35	mV
input regulation	V = 5.85 V to 10 V,	20 HW ≥ IQ ≥ 520 IIIW	-40°C to 125°C			37	
Output regulation	le - E mA to 250 mA	$5.85 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V}$, $5.85 \text{ V} \le \text{V}_{\text{I}} \le 10 \text{ V}$	25°C		28	40	mV
	10 = 5 ma to 250 ma,		-40°C to 125°C			75	mv
Output regulation	L 50 A to 050 mA 5		25°C		42	65	mν
	10 = 50 µA to 250 mA,		-40°C to 125°C			130	
7		ΙΟ = 50 μΑ	25°C	45	53		
Ripple rejection	f 100 Hz	IO = 50 μA	-40°C to 125°C	39			ما ا
rippie rejection	f = 120 Hz	IO = 250 mA	25°C	39	50		dB
		10 = 250 IIIA	-40°C to 125°C	35			198
Output noise-spectral density	f = 120 Hz		25°C		2		μV/√Hz
		C _O = 4.7 μF	25°C		410		
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSRT = 1 Ω	C _O = 10 μF	25°C		328		μVrms
	C3H1 = 1 12	C _O = 100 μF	25°C	i	212	·	1
RESET trip-threshold voltage	VO decreasing		-40°C to 125°C	4.5		4.7	V
RESET trip-threshold voltage	V _O increasing		-40°C to 125°C				V
RESET hysteresis voltage			25°C		26		mV
			25°C		0.2	0.4	
RESET output low voltage	IO(RESET) = -1.2 mA	, V _I = 4.12 V	-40°C to 125°C			0.4	V

T CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to Co.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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TPS7350Q electrical characteristics at I $_{O}$ = 10 mA, V $_{I}$ = 6 V, \overline{EN} = 0 V, C $_{O}$ = 4.7 $\mu\text{F}(\text{CSR}^{\dagger}$ = 1 $\Omega)$, SENSE shorted to OUT (unless otherwise noted)

242447772	TEST CONDITIONS‡		_ 1991	TI	PS7350Q		UNIT	
PARAMETER	TEST CO	NDITIONST	TJ -	MIN	TYP	MAX	UNIT	
Outrust valtage	V _I = 6 V,	I _O = 10 mA	25°C		5		\ \ \	
Output voltage	6 V ≤ V _I ≤ 10 V,	5 mA ≤ I _O ≤ 250 mA	-40°C to 125°C	4.9		5.1	V	
	In 10 mA	V. 400 V	25°C		2.9	6		
	l _O = 10 mA,	V _I = 4.88 V	-40°C to 125°C			8		
Described	IO = 100 mA,	V: _ 4 00 V	25°C		27	35	mV	
Dropout voltage	10 = 100 IIIA,	V _I = 4.88 V	-40°C to 125°C			50] ""V	
	In OFO mA	V. 4 90 V	25°C		68	88]	
	I _O = 250 mA,	V _I = 4.88 V	-40°C to 125°C			125		
Pass-element series resistance	(4.88 V – V _O)/I _O ,	V _I = 4.88 V,	25°C		0.27	0.35	Ω	
Pass-element series resistance	I _O = 250 mA	-	-40°C to 125°C			0.5	1 12	
land a sociation	V _I = 6 V to 10 V,	V. C.V. 10.V. 50	50 μA ≤ I _O ≤ 250 mA	25°C		4	20	mV
Input regulation	V = 6 V 10 10 V,	30 μA 3 10 3 230 111A	-40°C to 125°C			45		
	I- 5 mA to 050 mA	6 V ≤ V _I ≤ 10 V	25°C		28	40	mV	
	10 = 5 mA to 250 mA,		-40°C to 125°C			75] ""V	
Output regulation	$I_O = 50 \mu A \text{ to } 250 \text{ mA}, \ 6 \text{ V} \le V_I \le 10 \text{ V}$	61/21/2101/	25°C		41	65	mV	
		, 6 V ≤ V ≤ 10 V	-40°C to 125°C			130	""V	
		In FO.14	25°C	43	53			
Dinula valantian	f 100 H-	ΙΟ = 50 μΑ	-40°C to 125°C	38				
Ripple rejection	f = 120 Hz	= 120 HZ	In 050 mA	25°C	41	51		dB
	en e	I _O = 250 mA	-40°C to 125°C	36			1	
Output noise-spectral density	f = 120 Hz		25°C		2		μV/√Hz	
As the second of the second		C _O = 4.7 μF	25°C		430			
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSRT = 1 Ω	C _O = 10 μF	25°C		345		μVrms	
	CSR1 = 1 12	C _O = 100 μF	25°C		220			
RESET trip-threshold voltage	V _O decreasing	<u> </u>	-40°C to 125°C	4.55		4.75	V	
RESET trip-threshold voltage	V _O increasing		-40°C to 125°C				V	
RESET hysteresis voltage			25°C		28		mV	
DECET autout law walks		1.1/. 4.05.1/	25°C	1.	0.15	0.4		
RESET output low voltage	IO(RESET) = -1.2 mA	A, V = 4.25 V	-40°C to 125°C			0.4	V	

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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switching characteristics

PARAMETER	TEST CONDITIONS	т.,	TPS7301Q, TPS7333Q TPS7348Q, TPS7350Q		UNIT	
		_	MIN	TYP	MAX	
DECET time out delay	San Figure F	25°C	140	200	260	
RESET time-out delay	SET time-out delay See Figure 5		100		300	ms

electrical characteristics at I $_{O}$ = 10 mA, \overline{EN} = 0 V, C $_{O}$ = 4.7 μ F(CSR † = 1 Ω), T $_{J}$ = 25°C, SENSE/FB shorted to OUT (unless otherwise noted)

PARAMETER	TEST CONDITIONS‡	TPS7301Y, TPS7333Y TPS7348Y, TPS7350Y	UNIT
		MIN TYP MAX	
Ground current (active mode)	$\overline{EN} \le 0.5 \text{ V}, \qquad V_I = V_O + 1 \text{ V}, \\ 0 \text{ mA} \le I_O \le 250 \text{ mA}$	340	μА
Input current (standby mode)	$\overline{\text{EN}} = \text{V}_{\text{I}}, \qquad 2.7 \text{ V} \leq \text{V}_{\text{I}} \leq 10 \text{ V}$	0.01	μА
Output current limit	V _O = 0 V, V _I = 10 V	1.2	Α
Pass-element leakage current in standby mode	$\overline{EN} = V_{\parallel},$ $2.7 \text{ V} \le V_{\parallel} \le 10 \text{ V}$	0.01	μА
RESET leakage current	Normal operation, V at RESET = 10 V	0.02	μА
Thermal shutdown junction temperature		165	°C
EN logic low (active mode)	2.7 V ≤ V _I ≤ 10 V		٧
EN hysteresis voltage		50	mV
EN input current	0 V ≤ V _I ≤ 10 V	0.001	μА
Minimum V _I for active pass element	•	2.05	V
Minimum V _I for valid RESET	IO(RESET) = -300 μA	1	V

[†] CSR (compensation series resistance) refers to the total series resistance, including the equivalent series resistance (ESR) of the capacitor, any series resistance added externally, and PWB trace resistance to CO.



[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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TPS7301Y electrical characteristics at I_O = 10 mA, V_I = 3.5 V, $\overline{\text{EN}}$ = 0 V, C_O = 4.7 $\mu\text{F}(\text{CSR}^{\dagger}$ = 1 Ω), T_J = 25°C, FB shorted to OUT at device leads (unless otherwise noted)

DADAMETER		TEST CONDITIONS‡		TPS7301Y		
PARAMETER	TEST C	TEST CONDITIONS+			MIN TYP MAX	
Reference voltage (measured at FB)	V _I = 3.5 V,	I _O = 10 mA		1.182		v
	V _I = 2.4 V,	50 μA ≤ I _O ≤ 150 mA		0.7		
	V _I = 2.4 V,	150 mA ≤ I _O ≤ 250 mA		0.83		
Pass-element series resistance (see Note 2)	V _I = 2.9 V,	$50 \mu A \le I_O \le 250 mA$		0.52		Ω
	$V_{ } = 3.9 V,$	$50 \mu A \le I_O \le 250 mA$		0.32		
	$V_{ } = 5.9 \text{ V},$	50μ A ≤ I_0 ≤ 250 mA		0.23		1
Input regulation	V _I = 2.5 V to 10 V, See Note 1	$50 \mu A \le I_O \le 250 \text{ mA},$		3		mV
	2.5 V ≤ V _I ≤ 10 V, See Note 1	I _O = 5 mA to 250 mA,		5		mV
Output regulation	2.5 V ≤ V _I ≤ 10 V, See Note 1	$I_O = 50 \mu\text{A}$ to 250 mA,		7		mV
		ΙΟ = 50 μΑ		59		
Ripple rejection	f = 120 Hz	I _O = 250 mA, See Note 1	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	54		dB
Output noise-spectral density	f = 120 Hz			2		μV/√Hz
		C _O = 4.7 μF		95		
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSR† = 1 Ω	C _O = 10 μF		89		μVrms
	C3A1 = 132	$C_{O} = 100 \mu F$		74		1
RESET hysteresis voltage§	Measured at VO(FB)			12		mV
RESET output low voltage§	V _I = 2.13 V,	IO(RESET) = 400 μA	1 1	0.1		V
FB input current				0.1		nA

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to Co.

NOTES: 1. When V_I < 2.9 V and I_O > 150 mA simultaneously, pass element r_{DS(on)} increases (see Figure 32) to a point where the resulting dropout voltage prevents the regulator from maintaining the specified tolerance range.

To calculate dropout voltage, use equation: V_{DO} = I_O · r_{DS}(on) r_{DS}(on) is a function of both output current and input voltage. The parametric table lists r_{DS}(on) for V_I = 2.4 V, 2.9 V, 3.9 V, and 5.9 V, which corresponds to dropout conditions for programmed output voltages of 2.5 V, 3 V, 4 V, and 6 V respectively. For other programmed values, refer to Figure 32.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

[§] Output voltage programmed to 2.5 V with closed-loop configuration (see application information).

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TPS7333Y electrical characteristics at I_O = 10 mA, V_I = 4.3 V, $\overline{\text{EN}}$ = 0 V, C_O = 4.7 μ F(CSR[†] = 1 Ω), T_J = 25°C, SENSE shorted to OUT (unless otherwise noted)

PARAMETER		TEST CONDITIONS‡			TPS7333Y		
PARAMETER	TEST CO				MAX	UNIT	
Output voltage	V _I = 4.3 V,	I _O = 10 mA		3.3		V	
	$I_O = 10 \text{ mA},$	V _I = 3.23 V		4.5			
Dropout voltage	$I_0 = 100 \text{ mA},$	V _I = 3.23 V		44		mV	
	$I_{O} = 250 \text{ mA},$	V _I = 3.23 V		108		ľ	
Pass-element series resistance	$(3.23 \text{ V} - \text{V}_{\text{O}})/\text{I}_{\text{O}},$ $\text{I}_{\text{O}} = 250 \text{ mA}$			0.44		Ω	
Input regulation	V _I = 4.3 V to 10 V,	50μ A ≤ I_O ≤ 250 mA		6		mV	
Outrout regulation	I _O = 5 mA to 250 mA,	4.3 V ≤ V _I ≤ 10 V		21		mV	
Output regulation	$I_O = 50 \mu\text{A}$ to 250 mA	$I_0 = 50 \mu A \text{ to } 250 \text{ mA}, 4.3 \text{ V} \le V_1 \le 10 \text{ V}$		31		mV	
Dinala rejection	f = 120 Hz	ΙΟ = 50 μΑ		51		dB	
Ripple rejection	1 = 120 HZ	I _O = 250 mA	i	49			
Output noise-spectral density	f = 120 Hz			2		μV/√Hz	
		$C_0 = 4.7 \mu F$		274			
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSRT = 1 Ω	C _O = 10 μF		228		μVrms	
	00111 = 732	C _O = 100 μF		159			
RESET hysteresis voltage			, ·	18		mV	
RESET output low voltage	V _I = 2.8 V,	IO(RESET) = -1 mA		0.17		V	

[†]CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to Co.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

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TPS7348Y electrical characteristics at I $_{O}$ = 10 mA, V $_{I}$ = 5:85 V, \overline{EN} = 0 V, C $_{O}$ = 4.7 μ F(CSR † = 1 Ω), SENSE shorted to OUT (unless otherwise noted)

0.0			1	PS7348Y	,	T	
PARAMETER	TEST C	TEST CONDITIONS [‡] MIN TYP MAX			MAX	UNIT	
Output voltage	V _I = 5.85 V,	I _O = 10 mA		4.85		V	
	I _O = 10 mA,	V _I = 4.75 V		2.9			
Dropout voltage	I _O = 100 mA,	V _I = 4.75 V	28			m∨	
	I _O = 250 mA,	V _I = 4.75 V		70		1	
Pass-element series resistance	(4.75 V - V _O)/I _O , I _O = 250 mA			0.28		Ω	
Input regulation	V _I = 5.85 V to 10 V,	$V_I = 5.85 \text{ V to } 10 \text{ V}, 50 \mu\text{A} \le I_O \le 250 \text{ mA}$		9		mV	
0	$I_0 = 5 \text{ mA to } 250 \text{ mA}, 5.85 \text{ V} \le V_1 \le 10 \text{ V}$			28		mV	
Output regulation	$I_0 = 50 \mu\text{A} \text{ to } 250 \text{mA}$, 5.85 V ≤ V _I ≤ 10 V		42		mV	
Disabasis tion	f = 120 Hz	ΙΟ = 50 μΑ		53	- dip	dB	
Ripple rejection	T = 120 HZ	I _O = 250 mA		50		l ab	
Output noise-spectral density	f = 120 Hz			2		μV/√Hz	
		C _O = 4.7 μF	410				
Output noise voltage	10 Hz \leq f \leq 100 kHz, CSR† = 1 Ω	C _O = 10 μF	1	328		μVrms	
	OSM = 1 32	C _O = 100 μF	1	212		7	
RESET hysteresis voltage				26		mV	
RESET output low voltage	IO(RESET) = -1.2 m/	A, V _I = 4.12 V		0.2		V	

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to Co.

[‡] Pulse-testing techniques are used to maintain virtual junction temperature as close as possible to ambient temperature; thermal effects must be taken into account separately.

PARAMETER MEASUREMENT INFORMATION

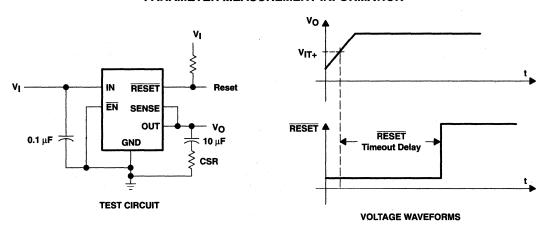


Figure 5. Test Circuit and Voltage Waveforms

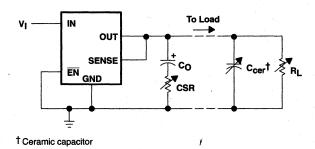
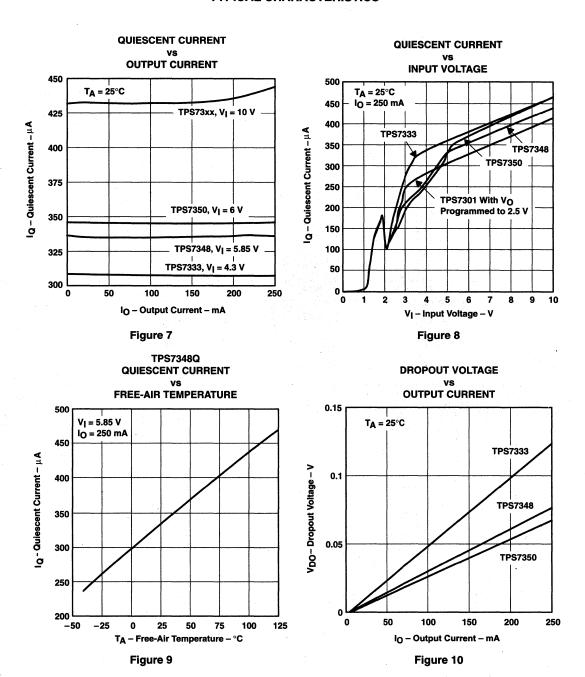


Figure 6. Test Circuit for Typical Regions of Stability (Refer to Figures 28 through 31)

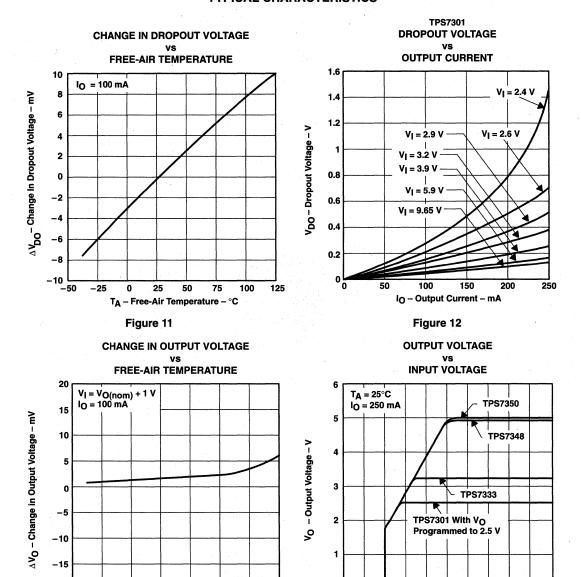
TYPICAL CHARACTERISTICS

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e e sa	Output spectral noise density	vs Frequency	27
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	Componentian coving registeres (CCR)	vs Added ceramic capacitance ($C_O = 4.7 \mu F$)	29
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TYPICAL CHARACTERISTICS





T_A - Free-Air Temperature - °C

50

75

100

125

25



5 6

V_I - Input Voltage - V

10



0 1

-20

-50

-25

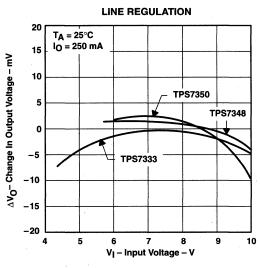


Figure 15

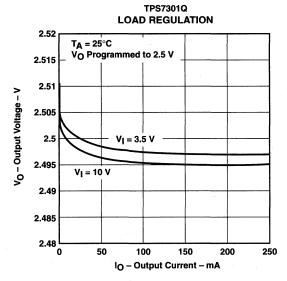


Figure 16

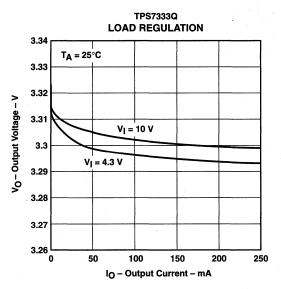


Figure 17

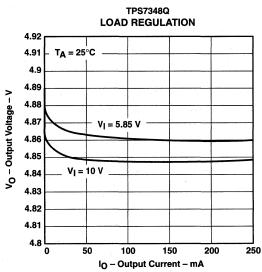
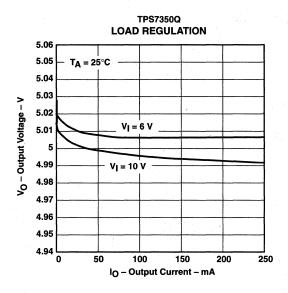


Figure 18





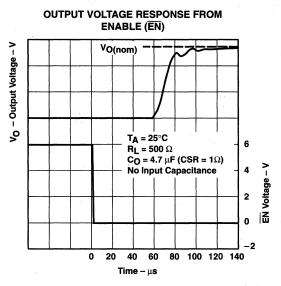


Figure 19

Figure 20

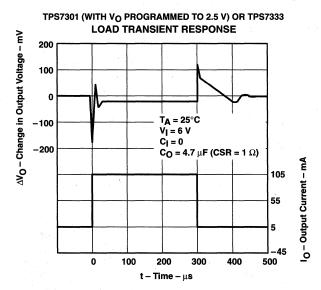


Figure 21

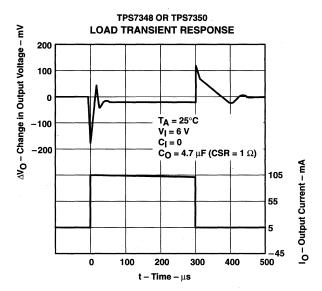


Figure 22

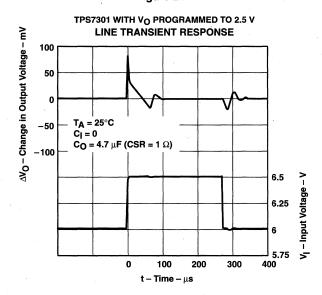


Figure 23

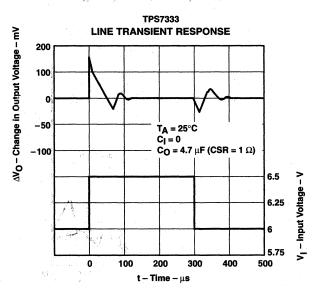


Figure 24

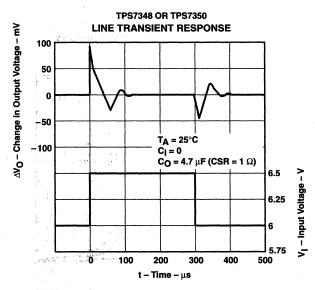


Figure 25

TYPICAL CHARACTERISTICS

RIPPLE REJECTION

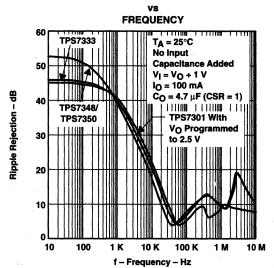


Figure 26

OUTPUT SPECTRAL-NOISE DENSITY

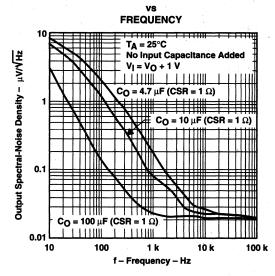


Figure 27

TYPICAL CHARACTERISTICS

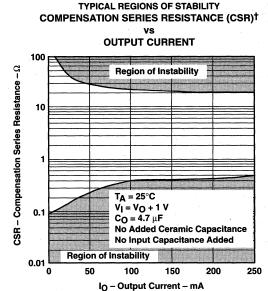
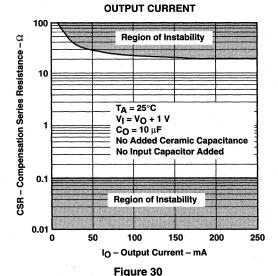


Figure 28

TYPICAL REGIONS OF STABILITY COMPENSATION SERIES RESISTANCE (CSR)† vs



TYPICAL REGIONS OF STABILITY COMPENSATION SERIES RESISTANCE (CSR)† vs



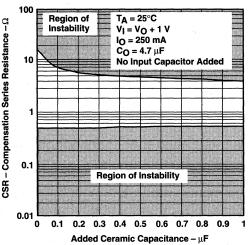


Figure 29

TYPICAL REGIONS OF STABILITY COMPENSATION SERIES RESISTANCE (CSR)†

ADDED CERAMIC CAPACITANCE

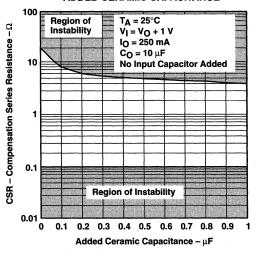


Figure 31

[†] CSR refers to the total series resistance, including the ESR of the capacitor, any series resistance added externally, and PWB trace resistance to C_O.



TYPICAL CHARACTERISTICS

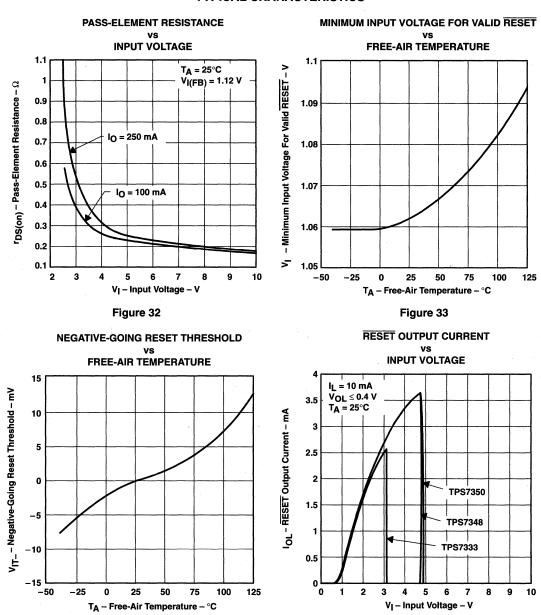


Figure 34

Figure 35

197

196

195

194

193

192

191

190

-50

-25

t_d - Reset Delay Time - ms

TYPICAL CHARACTERISTICS

RESET DELAY TIME

VS FREE-AIR TEMPERATURE

50

T_A – Free-Air Temperature –°C

100

125

Figure 36

DISTRIBUTION FOR RESET DELAY

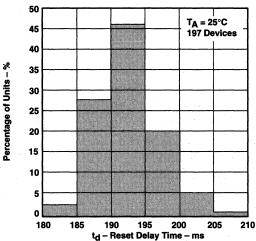


Figure 37

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THERMAL INFORMATION

In response to system-miniaturization trends, integrated circuits are being offered in low-profile and fine-pitch surface-mount packages. Implementation of many of today's high-performance devices in these packages requires special attention to power dissipation. Many system-dependent issues such as thermal coupling, airflow, added heat sinks and convection surfaces, and the presence of other heat-generating components affect the power-dissipation limits of a given component.

Three basic approaches for enhancing thermal performance are illustrated in this discussion:

- Improving the power-dissipation capability of the PWB design
- Improving the thermal coupling of the component to the PWB
- Introducing airflow in the system

Figure 38 is an example of a thermally enhanced PWB layout for the 20-lead TSSOP package. This layout involves adding copper on the PWB to conduct heat away from the device. The $R_{0,JA}$ for this component/board system is illustrated in Figure 39. The family of curves illustrates the effect of increasing the size of the copper-heat-sink surface area. The PWB is a standard FR4 board (L × W × H = 3.2 inch × 3.2 inch × 0.062 inch); the board traces and heat sink area are 1-oz (per square foot) copper.

Figure 40 shows the thermal resistance for the same system with the addition of a thermally conductive compound between the body of the TSSOP package and the PWB copper routed directly beneath the device. The thermal conductivity for the compound used in this analysis is 0.815 W/m °C.

Using these figures to determine the system $R_{\theta JA}$ allows the maximum power-dissipation limit to be calculated with the equation:

$$P_{D(max)} = \frac{T_{J(max)} - T_{A}}{R_{\theta JA(system)}}$$

Where

T_J(max) is the maximum allowable junction temperature or 125°C i.e., 150°C absolute maximum and 125°C maximum recommended operating temperature for specified operation.

This limit should then be applied to the internal power dissipated by the TPS73xx regulator. The equation for calculating total internal power dissipation of the TPS71xx is:

$$P_{D(total)} = (V_1 - V_0) \cdot I_0 + V_1 \cdot I_0$$

Because the quiescent current of the TPS73xx family is very low, the second term is negligible, further simplifying the equation to:

$$P_{D(total)} = (V_I - V_O) \cdot I_O$$

For a 20-lead TSSOP/FR4 board system with thermally conductive compound between the board and the device body, where $T_A = 55^{\circ}$ C, airflow = 100 ft/min, and copper heat sink area = 1 cm², the maximum power-dissipation limit can be calculated. As indicated in Figure 40, the system $R_{\theta JA}$ is 94°C/W; therefore, the maximum power-dissipation limit is:

$$P_{D(max)} = \frac{T_{J(max)} - T_{A}}{R_{\theta JA(system)}} = \frac{125^{\circ}C - 55^{\circ}C}{94^{\circ}C/W} = 745 \text{ mW}$$

If the system implements a TPS7348 regulator where V_I = 6 V and I_O = 385 mA, the internal power dissipation is:

$$P_{D(total)} = (V_1 - V_0) \cdot I_0 = (6 - 4.85) \cdot 0.385 = 443 \text{ mW}$$



THERMAL INFORMATION

Comparing P_{D(total)} with P_{D(max)} reveals that the power dissipation in this example does not exceed the maximum limit. When it does, one of two corrective actions can be taken. The power-dissipation limit can be raised by increasing either the airflow or the heat-sink area. Alternatively, the internal power dissipation of the regulator can be lowered by reducing either the input voltage or the load current. In either case, the above calculations should be repeated with the new system parameters.

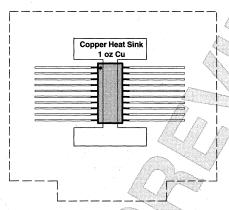


Figure 38. Thermally Enhanced PWB Layout (not to scale) for the 20-Pin TSSOP

THERMAL RESISTANCE, JUNCTION-TO-AMBIENT

AIR FLOW $R_{ extsf{0,1}}$ – Thermal Resistance, Junction-to-Ambient – °C/W 190 Component/Board System 20-Lead TSSOP 170 0 cm² 1 cm² 150 2 cm² 130 110 90 4 cm² 8 cm² 70 50

Figure 39

150

Air Flow - ft/min

200

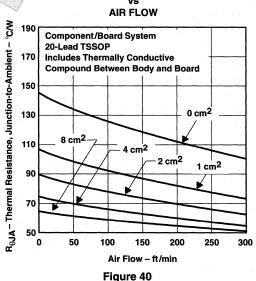
250

100

50

0

THERMAL RESISTANCE, JUNCTION-TO-AMBIENT



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APPLICATION INFORMATION

The TPS73xx series of low-dropout (LDO) regulators is designed to overcome many of the shortcomings of earlier generation LDOs, while adding features such as a power-saving shutdown mode and a supply-voltage supervisor. The TPS73xx family includes three fixed-output voltage regulators: the TPS7333 (3.3 V), the TPS7348 (4.85 V), and the TPS7350 (5 V). The family also offers an adjustable device, the TPS7301 (adjustable from 1.2 V to 9.75 V).

device operation

The TPS73xx, unlike many other LDOs, features very low quiescent currents that remain virtually constant even with varying loads. Conventional LDO regulators use a pnp-pass element, the base current of which is directly proportional to the load current through the regulator ($I_B = I_C/\beta$). Close examination of the data sheets reveals that such devices are typically specified under near no-load conditions; actual operating currents are much higher as evidenced by typical quiescent current versus load current curves. The TPS73xx uses a PMOS transistor to pass current; because the gate of the PMOS element is voltage driven, operating currents are low and invariable over the full load range. The TPS73xx specifications reflect actual performance under load.

Another pitfall associated with the pnp-pass element is its tendency to saturate when the device goes into dropout. The resulting drop in β forces an increase in IB to maintain the load. During power-up, this translates to large start-up currents. Systems with limited supply current may fail to start up. In battery-powered systems, it means rapid battery discharge when the voltage decays below the minimum required for regulation. The TPS73xx quiescent current remains low even when the regulator drops out, thus eliminating both problems.

Included in the TPS73xx family is a 4.85-V regulator, the TPS7348. Designed specifically for 5-V cellular systems, its 4.85-V output, regulated to within $\pm 2\%$, allows for operation within the low-end limit of 5-V systems specified to $\pm 5\%$ tolerance; therefore, maximum regulated operating lifetime is obtained from a battery pack before the device drops out, adding crucial talk minutes between charges.

The TPS73xx family also features a shutdown mode that places the output in the high-impedance state (essentially equal to the feedback-divider resistance) and reduces quiescent current to under $0.5\,\mu\text{A}$. When the shutdown feature is not used, $\overline{\text{EN}}$ should be tied to ground. Response to an enable transition is quick; regulated output voltage is reestablished in typically 120 μs .

minimum load requirements

The TPS73xx family is stable even at zero load; no minimum load is required for operation.

SENSE-pin connection

The SENSE terminal of fixed-output devices must be connected to the regulator output for proper functioning of the regulator. Normally, this connection should be as short as possible; however, the connection can be made near a critical circuit (remote sense) to improve performance at that point. Internally, SENSE connects to a high-impedance wide-bandwidth amplifier through a resistor-divider network, and noise pickup feeds through to the regulator output. It is essential to route the SENSE connection in such a way as to minimize/avoid noise pickup. Adding an RC network between SENSE and OUT to filter noise is not recommended because it can cause the regulator to oscillate.

external capacitor requirements

An input capacitor is not required; however, a ceramic bypass capacitor (0.047 pF to 0.1 μ F) improves load transient response and noise rejection when the TPS73xx is located more than a few inches from the power supply. A higher-capacitance electrolytic capacitor may be necessary if large (hundreds of milliamps) load transients with fast rise times are anticipated.



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APPLICATION INFORMATION

external capacitor requirements (continued)

As with most LDO regulators, the TPS73xx family requires an output capacitor for stability. A low-ESR 10- μ F solid-tantalum capacitor connected from the regulator output to ground is sufficient to ensure stability over the full load range (see Figure 41). Adding high-frequency ceramic or film capacitors (such as power-supply bypass capacitors for digital or analog ICs) can cause the regulator to become unstable unless the ESR of the tantalum capacitor is less than 1.2 Ω over temperature. Capacitors with published ESR specifications such as the AVX TPSD106K035R0300 and the Sprague 593D106X0035D2W work well because the maximum ESR at 25°C is 300 m Ω (typically, the ESR in solid-tantalum capacitors increases by a factor of 2 or less when the temperature drops from 25°C to -40°C). Where component height and/or mounting area is a problem, physically smaller, 10- μ F devices can be screened for ESR. Figures 28 through 31 show the stable regions of operation using different values of output capacitance with various values of ceramic load capacitance.

In applications with little or no high-frequency bypass capacitance (< 0.2 μ F), the output capacitance can be reduced to 4.7 μ F, provided ESR is maintained between 0.7 and 2.5 Ω . Because capacitor minimum ESR is seldom if ever specified, it may be necessary to add a 0.5- Ω to 1- Ω resistor in series with the capacitor and limit ESR to 1.5 Ω maximum. As shown in the CSR graphs (Figures 28 through 31), minimum ESR is not a problem when using 10- μ F or larger output capacitors.

Below is a partial listing of surface-mount capacitors usable with the TPS73xx family. This information, along with the CSR graphs, is included to assist in selection of suitable capacitance for the user's application. When necessary to achieve low height requirements along with high output current and/or high ceramic load capacitance, several higher ESR capacitors can be used in parallel to meet the guidelines above.

All load and temperature conditions with up to 1 μF of added ceramic load capacitance:

PART NO.	MFR.	VALUE	MAX ESR†	SIZE $(H \times L \times W)^{\dagger}$
T421C226M010AS	Kemet	22 μF, 10 V	0.5	$2.8 \times 6 \times 3.2$
593D156X0025D2W	Sprague	15 μF, 25 V	0.3	$2.8 \times 7.3 \times 4.3$
593D106X0035D2W	Sprague	10 μF, 35 V	0.3	$2.8 \times 7.3 \times 4.3$
TPSD106M035R0300	AVX	10 μF, 35 V	0.3	$2.8 \times 7.3 \times 4.3$

Load < 200 mA, ceramic load capacitance < 0.2 µF, full temperature range:

PART NO.	MFR.	VALUE	MAX ESR†	SIZE $(H \times L \times W)^{\dagger}$
592D156X0020R2T	Sprague	15 μF, 20 V	1.1	$1.2 \times 7.2 \times 6$
595D156X0025C2T	Sprague	15 μF, 25 V	1	$2.5 \times 7.1 \times 3.2$
595D106X0025C2T	Sprague	10 μF, 25 V	1.2	$2.5 \times 7.1 \times 3.2$
293D226X0016D2W	Sprague	22 μF, 16 V	1.1	$2.8 \times 7.3 \times 4.3$

Load < 100 mA, ceramic load capacitance < 0.2 μF, full temperature range:

PART NO.	MFR.	VALUE	MAX ESR†	SIZE $(H \times L \times W)^{\dagger}$
195D106X06R3V2T	Sprague	10 μF, 6.3 V	1.5	$1.3 \times 3.5 \times 2.7$
195D106X0016X2T	Sprague	10 μF, 16 V	1.5	$1.3 \times 7 \times 2.7$
595D156X0016B2T	Sprague	15 μF, 16 V	1.8	$1.6 \times 3.8 \times 2.6$
695D226X0015F2T	Sprague	22 μF, 15 V	1.4	$1.8 \times 6.5 \times 3.4$
695D156X0020F2T	Sprague	15 μF, 20 V	1.5	$1.8 \times 6.5 \times 3.4$
695D106X0035G2T	Sprague	10 μF, 35 V	1.3	$2.5 \times 7.6 \times 2.5$

[†] Size is in mm. ESR is maximum resistance at 100 kHz and $T_A = 25$ °C. Listings are sorted by height.



APPLICATION INFORMATION

external capacitor requirements (continued)

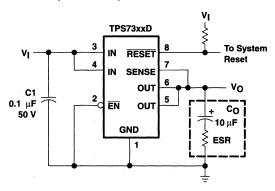


Figure 41. Typical Application Circuit

programming the TPS7301 adjustable LDO regulator

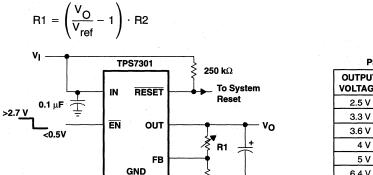
Programming the adjustable regulators is accomplished using an external resistor divider as shown in Figure 42. The equation governing the output voltage is:

$$V_{O} = V_{ref} \cdot \left(1 + \frac{R1}{R2}\right) \tag{1}$$

where

V_{ref} = reference voltage, 1.182 V typ

Resistors R1 and R2 should be chosen for approximately 7- μ A divider current. A recommended value for R2 is 169 k Ω with R1 adjusted for the desired output voltage. Smaller resistors can be used, but offer no inherent advantage and consume more power. Larger values of R1 and R2 should be avoided as leakage currents at FB will introduce an error. Solving equation 1 for R1 yields a more useful equation for choosing the appropriate resistance:



OUTPUT VOLTAGE PROGRAMMING GUIDE

OUTPUT VOLTAGE	R1	R2	UNIT			
2.5 V	191	169	kΩ			
3.3 V	309	169	kΩ			
3.6 V	348	169	kΩ			
4 V	402	169	kΩ			
5 V	549	169	kΩ			
6.4 V	750	169	kΩ			

Figure 42. TPS7301 Adjustable LDO Regulator Programming

R2



(2)

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APPLICATION INFORMATION

undervoltage supervisor function

The RESET output of the TPS73xx initiates a reset in microcomputer and microprocessor systems in the event of an undervoltage condition. An internal comparator in the TPS73xx monitors the output voltage of the regulator to detect the undervoltage condition. When that occurs, the RESET output transistor turns on taking the RESET signal low.

On power-up, the output voltage tracks the input voltage. The $\overline{\text{RESET}}$ output becomes active (low) as V_1 approaches the minimum required for a valid $\overline{\text{RESET}}$ signal (specified at 1.5 V for 25°C and 1.9 V over full recommended operating temperature range). When the output voltage reaches the appropriate positive-going input threshold ($V_{|T+}$), a 200-ms (typ) timeout period begins during which the $\overline{\text{RESET}}$ output remains low. Once the timeout has expired, the $\overline{\text{RESET}}$ output become inactive. Since the $\overline{\text{RESET}}$ output is an open-drain NMOS, a pull-up resistor should be used to ensure that a logic-high signal is indicated.

The supply-voltage-supervisor function is also activated during power-down. As the input voltage decays and after the dropout voltage is reached, the output voltage tracks linearly with the decaying input voltage. When the output voltage drops below the specified negative-going input threshold ($V_{|T-}$ — see electrical characteristics tables), the \overline{RESET} output becomes active (low). It is important to note that if the input voltage decays below the minimum required for a valid \overline{RESET} , the \overline{RESET} is undefined.

Since the circuit is monitoring the regulator output voltage, the $\overline{\text{RESET}}$ output can also be triggered by disabling the regulator or by any fault condition that causes the output to drop below V_{IT} . Examples of fault conditions include a short circuit on the output and a low input voltage. Once the output voltage is reestablished, either by reenabling the regulator or removing the fault condition, then the internal timer is initiated, which holds the $\overline{\text{RESET}}$ signal active during the 200-ms (typ) timeout period.

NOTE: V_{IT+} = V_{IT-} +Hysteresis

output noise

The TPS73xx has very low output noise, with a spectral noise density $< 2 \mu V / \sqrt{Hz}$. This is important when noise-susceptible systems, such as audio amplifiers, are powered by the regulator.

regulator protection

The TPS73xx PMOS-pass transistor has a built-in back diode that safely conducts reverse currents when the input voltage drops below the output voltage (e.g., during power down). Current is conducted from the output to the input and is not internally limited. If extended reverse voltage is anticipated, external limiting might be appropriate.

The TPS73xx also features internal current limiting and thermal protection. During normal operation, the TPS73xx limits output current to approximately 1 A. When current limiting engages, the output voltage scales back linearly until the overcurrent condition ends. While current limiting is designed to prevent gross device failure, care should be taken not to exceed the power dissipation ratings of the package. If the temperature of the device exceeds 165°C, thermal-protection circuitry shuts it down. Once the device has cooled, regulator operation resumes.



APPLICATION INFORMATION

power dissipation and junction temperature

The junction temperature must be held to 150°C or less to ensure proper regulator operation, which limits the power dissipation the regulator can handle in any given application. To ensure the junction temperature is within acceptable limits, calculate the maximum allowable dissipation, $P_{D(max)}$, and the actual dissipation, $P_{D,max}$, which must be less than or equal to $P_{D,max}$.

The maximum-power-dissipation limit is determined using the following equation:

$$P_{D(max)} = \frac{T_{J}max - T_{A}}{R_{\theta JA}}$$

Where

T_Jmax is the maximum allowable junction temperature, i.e.,150°C absolute maximum and 125°C recommended operating temperature.

 $R_{\theta JA}$ is the thermal resistance junction-to-ambient for the package, i.e., 172°C/W for the 8-terminal SOIC and 238°C/W for the 8-terminal TSSOP.

TA is the ambient temperature.

The regulator dissipation is calculated using:

$$P_{D} = (V_{I} - V_{O}) \cdot I_{O}$$

Power dissipation resulting from quiescent current is negligible.

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- 150-mA Load Current Without External Power Transistor
- Typically 0.02% Input Regulation and 0.03% Load Regulation (μΑ723Μ)
- Adjustable Current Limiting Capability
- Input Voltages to 40 V
- Output Adjustable From 2 V to 37 V
- Direct Replacement for Fairchild μA723C and μA723M

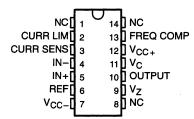
description

The µA723C and µA723M are precision monolithic integrated circuit voltage regulators featuring high ripple rejection, excellent input and load regulation, excellent temperature stability, and low standby current. The circuit consists of a temperature-compensated reference voltage amplifier, an error amplifier, a 150-mA output transistor, and an adjustable output current limiter.

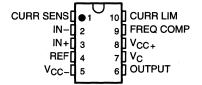
The μ A723C and μ A723M are designed for use in positive or negative power supplies as a series, shunt, switching, or floating regulator. For output currents exceeding 150 mA, additional pass elements may be connected as shown in Figures 4 and 5.

The μ A723C is characterized for operation from 0°C to 70°C. The μ A723M is characterized for operation over the full military temperature range of -55°C to 125°C.

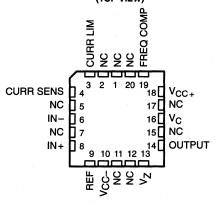
μΑ723C ... D OR N PACKAGE μΑ723M ... J PACKAGE (TOP VIEW)



μΑ723M ... U PACKAGE (TOP VIEW)



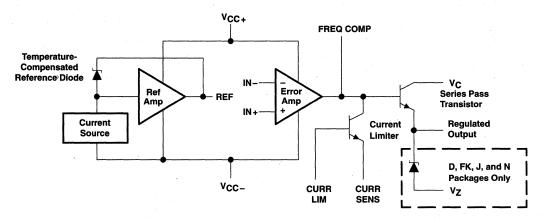
μΑ723M . . . FK PACKAGE (TOP VIEW)



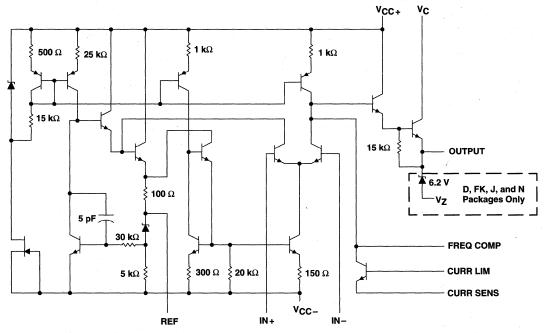
NC - No internal connection

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functional block diagram



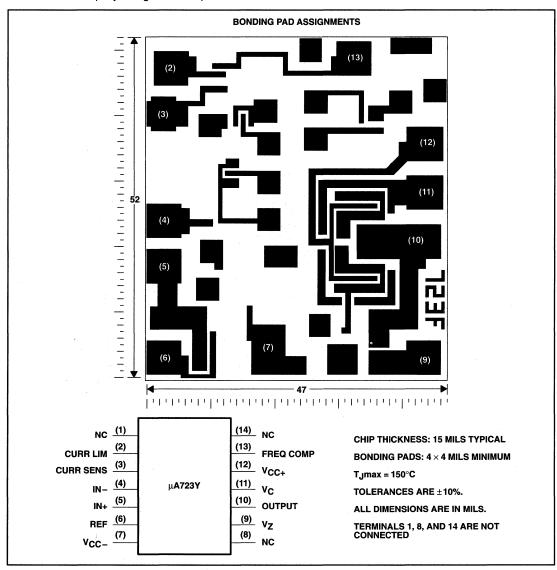
schematic



Resistor and capacitor values shown are nominal.

μΑ723Y chip information

This chip, when properly assembled, displays characteristics similar to the μ A723C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



μΑ723C, μΑ723M, μΑ723Y PRECISION VOLTAGE REGULATORS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

	Peak voltage from V_{CC+} to V_{CC-} ($t_W \le 50$ ms)	50	0 V
	Continuous voltage from V _{CC+} to V _{CC-}	40	0 V
	Input-to-output voltage differential	40	0 V.
	Differential input voltage to error amplifier	±5	5 V
	Voltage between noninverting input and V _{CC}		ΒV
1	Current from V ₇	25 r	mΑ
	Current from REF	15 r	mA.
	Continuous total dissipation (see Note 1)	ation Rating Tal	ble
	Operating free-air temperature range, T _A : µA723C	0°C to 70	O°C
	μ A723M	-55°C to 125	5°C
	Storage temperature range, T _{stq}	-65°C to 150	O°C
ş	Case temperature for 60 seconds, T _C : FK package	260)°C
	Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J or U package	300)°C
	Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or N package	260	7 ∘C
	Lead temperature 1,0 min (17 to men) nom case for to seconds. B of it package	200	, ,

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Power dissipation = $[I(standby) + I(ref)] V_{CC} + [V_C - V_O] I_O$.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	DERATE ABOVE TA	T _A = 70°C POWER RATING	T _A = 125°C POWER RATING
D	950 mW	7.6 mW/°C	25°C	608 mW	\ -
FK and J	1000 mW	11.0 mW/°C	59°C	879 mW	274 mW
N	1000 mW	9.2 mW/°C	41°C	733 mW	
Ü	675 mW	5.4 mW/°C	25°C	432 mW	135 mW

recommended operating conditions

						MIN	MAX	UNIT
Input voltage, V _I				100		9.5	40	V
Output voltage, VO						 2	37	٧
Input-to-output voltage differential, V _C - V	<u>'</u> 0	 			. J. 147	3	38	V
Output current, IO			 				150	mA

μΑ723C, μΑ723M, μΑ723Y PRECISION VOLTAGE REGULATORS

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electrical characteristics at specified free-air temperature (see Notes 2 and 3)

PARAMETER	TEST CONDITIONS	T. +		μ Α723C			μ Α723M		UNIT
PANAMEIEN	TEST CONDITIONS	TAT	MIN	TYP	MAX	MIN	TYP	MAX 1 2 3 -1.5 -6 7.35 3.5 0.015*	UNII
	V _I = 12 V to V _I = 15 V	25°C		0.1	1		0.1	1	
Input regulation	V _I = 12 V to V _I = 40 V	25°C		1	5		0.2	2	mV/V
input regulation	V _I = 12 V to V _I = 15 V	Full range			3			. 3	
Dinula valantiau	$f = 50 H_z$ to 10 kHz, $C_{ref} = 0$	25°C		74			74		-10
Ripple rejection	$f = 50 \text{ Hz to } 10 \text{ kHz}, C_{ref} = 5 \mu F$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		dB					
		25°C		-0.3	-2		-0.3	-1.5	
Output regulation					-6			-6	mV/V
Reference voltage, Vref		25°C	6.8	7.15	7.5	6.95	7.15	7.35	V
Standby current	V _I = 30 V, I _O = 0	25°C		2.3	4		2.3	3.5	mA
Temperature coefficient of output voltage		Full range		0.003	0.015		0.002	0.015*	%/°C
Short-circuit output current	$R_{SC} = 10 \Omega$, $V_{O} = 0$	25°C		65			65		mA
Outrout poles veltores	BW = 100 Hz to 10 kHz, C _{ref} = 0	25°C		20			20		
Output noise voltage	BW = 100 Hz to 10 kHz, $C_{ref} = 5 \mu F$	25°C		2.5			2.5		μV

^{*}On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

 $[\]mbox{† Full range for μA723C is 0°C to 70°C and for μA723M is <math display="inline">-55^{\circ}\text{C}$$ to 125°C.

NOTES: 2. For all values in this table, the device is connected as shown in Figure 1 with the divider resistance as seen by the error amplifier ≤ 10 kΩ. Unless otherwise specified, V_I = V_{CC+} = V_C = 12 V, V_{CC-} = 0, V_O = 5 V, I_O = 1 mA, R_{SC} = 0, and C_{ref} = 0.

^{3.} Pulse-testing techniques must be used that will maintain the junction temperature as close to the ambient temperature as possible.

μΑ723C, μΑ723M, μΑ723Y PRECISION VOLTAGE REGULATORS

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electrical characteristics, $T_A = 25$ °C (see Notes 2 and 3)

DADAMETED		μ Α723 Υ		·
PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
Institute of the participant	V _I = 12 V to V _I = 15 V	0.1		
Input regulation	$V_{ } = 12 \text{ V to } V_{ } = 40 \text{ V}$	0.1 1 74	mV/V	
Ripple rejection	$f = 50 \text{ Hz}$ to 10 kHz, $C_{ref} = 0$	74		dB
Alphie rejection	$f = 50 \text{ Hz to } 10 \text{ kHz}, C_{ref} = 5 \mu F$	86		ав
Output regulation		-0.3		mV/V
Reference voltage, V _{ref}		7.15		V
Standby current	$V_{I} = 30 \text{ V}, \qquad I_{O} = 0$	2.3		mA
Short-circuit output current	$R_{SC} = 10 \Omega$, $V_{O} = 0$	65		mA
Output paiga valtage	BW = 100 Hz to 10 kHz, C _{ref} = 0	20		
Output noise voltage	BW = 100 Hz to 10 kHz, C _{ref} = 5 µF	2.5		μV

NOTES: 2. For all values in this table, the device is connected as shown in Figure 1 with the divider resistance as seen by the error amplifier \leq 10 k Ω . Unless otherwise specified, V₁ = V_{CC+} = V_C = 12 V, V_{CC-} = 0, V_O = 5 V, I_O = 1 mA, R_{SC} = 0, and C_{ref} = 0.

3. Pulse-testing techniques must be used that will maintain the junction temperature as close to the ambient temperature as possible.

Table 1. Resistor Values ($k\Omega$) for Standard Output Voltages

OUTPUT VOLTAGE	APPLICABLE FIGURES	ОИТ	ED PUT	AD	OUTPU JUSTAE (SEE N	BLE	OUTPUT VOLTAGE	APPLICABLE FIGURES	FIX OUT ±5		AD	OUTPUT JUSTAE (SEE NO	BLE
(V)	(SEE NOTE 4)	R1 (kΩ)	R2 (kΩ)	R1 (kΩ)	P1 (kΩ)	P2 (kΩ)	(V)	(SEE NOTE 4)	R1 (kΩ)	R2 (kΩ)	R1 (kΩ)	P1 (kΩ)	R2 (kΩ)
3.0	1,5,6,9,11,	4.12	3.01	1.8	0.5	1.2	100	7	3.57	105	2.2	10	91
İ	12 (4)			1					İ				ŀ
3.6	1,5,6,9,11,	3.57	3.65	1.5	0.5	1.5	250	7	3.57	255	2.2	10	240
	12 (4)									İ			
5.0	1,5,6,9,11,	2.15	4.99	0.75	0.5	2.2	-6	3, 10	3.57	2.43	1.2	0.5	0.75
	12 (4)						(Note 6)					1	
6.0	1,5,6,9,11,	1.15	6.04	0.5	0.5	2.7	-9	3, 10	3.48	5.36	1.2	0.5	2.0
	12 (4)						<u> </u>						
9.0	2,4,(5,6,	1.87	7.15	0.75	1.0	2.7	-12	3, 10	3.57	8.45	1.2	0.5	3.3
	9,12)						1	,					
12	2,4,(5,6,	4.87	7.15	2.0	1.0	3.0	-15	3, 10	3.57	11.5	1.2	0.5	4.3
	9,12)				•							1	
15	2,4,(5,6,	7.87	7.15	3.3	1.0	3.0	-28	3, 10	3.57	24.3	1.2	0.5	10
	9,12)												
28	2,4,(5,6,	21.0	7.15	5.6	1.0	2.0	-45	8	3.57	41.2	2.2	10	33
1.2	9,12)												
45	7	3.57	48.7	2.2	10	39	-100	8	3.57	95.3	2.2	10	91
75	7	3.57	78.7	2.2	10	68	-250	8	3.57	249	2.2	10	240

NOTES: 4. 4The R1/R2 divider may be across either V_O or V_(ref). If the divider is across V_(ref), use the figure numbers without parentheses.

If the divider is across V_O, use the figure numbers in parentheses.

5. To make the voltage adjustable, the R1/R2 divider shown in the figures must be replaced by the divider shown below.



Adjustable Output Circuit

6. For Figures 3, 8, and 10, the device requires a minimum of 9 V between V_{CC+} and V_{CC-} when V_O is equal to or more positive than -9 V.

Table 2. Formulas for Intermediate Output Voltages

Outputs from 2 V to 7 V See Figures 1,5,6,9, 11, 12 (4) and Note 4 $V_O = V_{(ref)} \times \frac{R2}{R1 + R2}$	Outputs from 4 V to 250 V See Figure 7 and Note 4 $V_O = \frac{V(ref)}{2} \times \frac{R2 - R1}{R1}$ $R3 = R4$	Current Limiting $I_{\left(limit\right)} \approx \frac{0.65 \ V}{R_{SC}}$
Outputs from 7 V to 37 V See Figures 2,4,(5,6,9, 11, 12) and Note 4	Outputs from -6 V to -250 V See Figures 3, 8, 10 and Notes 4 and 6	Foldback Current Limiting See Figure 6
$V_O = V_{(ref)} \times \frac{R1 + R2}{R2}$		$I_{\text{(knee)}} \approx \frac{V_{\text{O}}R3 + (R3 + R4) \ 0.65 \ \text{V}}{R_{\text{SC}}R4}$
	R3 = R4	$I_{OS} \approx \frac{0.65 \text{ V}}{R_{SC}} \times \frac{R3 + R4}{R4}$

NOTES: 4. The R1/R2 divider may be across either V_O or V_(ref). If the divider is across V_(ref), use figure numbers without parentheses. If the divider is across V_O, use the figure numbers in parentheses.

6. For Figures 3, 8, and 10, the device requires a minimum of 9 V between V_{CC+} and V_{CC-} when V_O is equal to or more positive than -9 V.

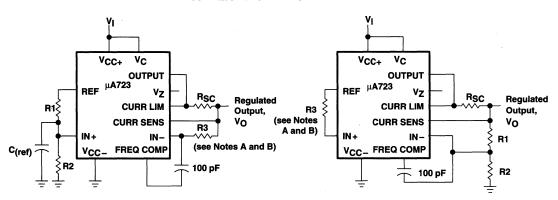


Figure 1. Basic Low-Voltage Regulator (V_O = 2 V to 7 V)

Figure 2. Basic High-Voltage Regulator (V_O = 7 V to 37 V)

NOTES: A. R3 = $\frac{R1 \times R2}{R1 + R2}$ for minimum α_{VO}

B. R3 may be eliminated for minimum component count. Use direct connection (i.e., $R_3 = 0$).

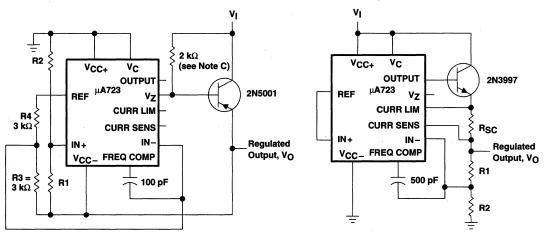


Figure 3. Negative-Voltage Regulator

Figure 4. Positive-Voltage Regulator (External N-P-N Pass Terminator)

NOTE C: When 10-lead µA723U devices are used in applications requiring Vz, an external 6.2-V regulator diode must be connected in series with OUTPUT.

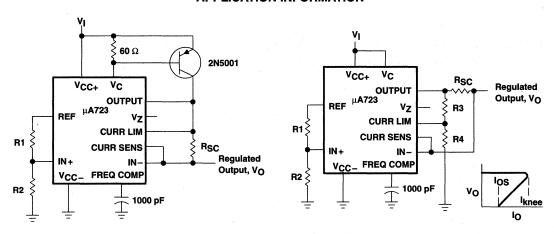


Figure 5. Positive-Voltage Regulator (External P-N-P Pass Transistor)

Figure 6. Foldback Current Limiting

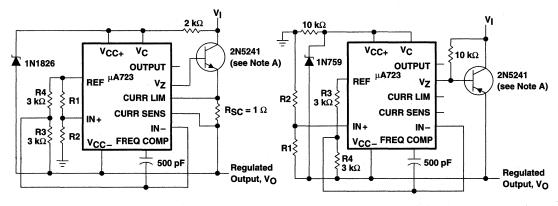


Figure 7. Positive Floating Regulator

Figure 8. Negative Floating Regulator

NOTE A: When 10-lead μA723U devices are used in applications requiring V_Z, an external 6.2-V regulator diode must be connected in series with OUTPUT.

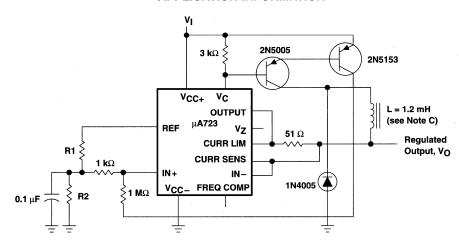


Figure 9. Positive Switching Regulator

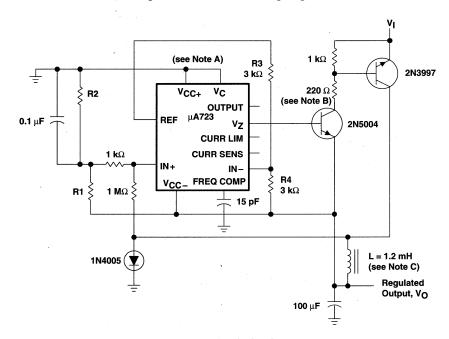
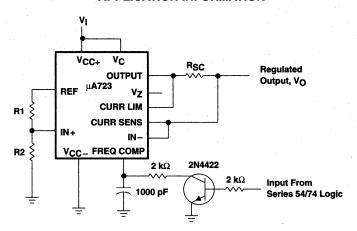


Figure 10. Negative Switching Regulator

NOTES: A. The device requires a minimum of 9 V between V_{CC-} and V_{CC-} when V_O is equal to or more positive than -9 V.

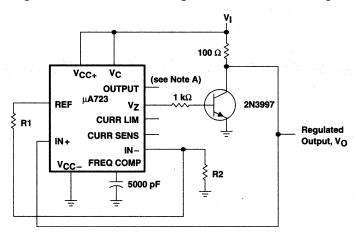
- B. When 10-lead μA723U devices are used in applications requiring V_Z, an external 6.2-V regulator diode must be connected in series with OUTPUT.
- C. L is 40 turns of No. 20 enameled copper wire wound on Ferroxcube P36/22-3B7 potted core or equivalent, with a 0.009-inch air gap.





NOTE A: A current-limit transistor may be used for shutdown if current limiting is not required.

Figure 11. Remote Shutdown Regulator With Current Limiting



NOTE A: When 10-lead μA723U devices are used in applications requiring V_Z, an external 6.2-V regulator diode must be connected in series with OUTPUT.

Figure 12. Shunt Regulator

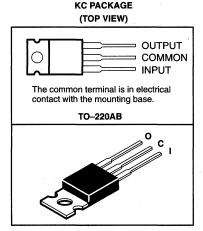
μΑ7800 SERIES POSITIVE-VOLTAGE REGULATORS

SLVS056A - MAY 1976 - REVISED AUGUST 1995

- 3-Terminal Regulators
- Output Current Up to 1.5 A
- Internal Thermal Overload Protection
- High Power Dissipation Capability
- Internal Short-Circuit Current Limiting
- Output Transistor Safe-Area Compensation
- Direct Replacements for Fairchild μA7800 Series

description

This series of fixed-voltage monolithic integratedcircuit voltage regulators is designed for a wide range of applications. These applications include on-card regulation for elimination of noise and distribution problems associated with single-point regulation. Each of these regulators can deliver up



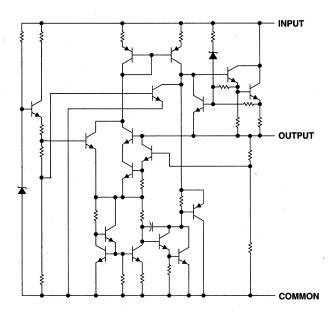
to 1.5 A of output current. The internal current limiting and thermal shutdown features of these regulators make them essentially immune to overload. In addition to use as fixed-voltage regulators, these devices can be used with external components to obtain adjustable output voltages and currents and also used as the power-pass element in precision regulators.

The μ A7800C series is characterized for operation over the virtual junction temperature range of 0°C to 125°C. The μ A7805Q and μ A7812Q are characterized for operation over the virtual junction temperature range of -40°C to 125°C.

AVAILABLE OPTIONS

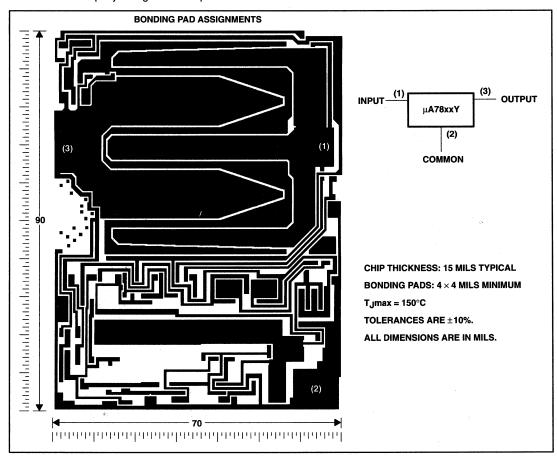
	V	PACKAGED DEVICES	CHIP FORM
ТЈ	VO(nom) (V)	PLASTIC FLANGE-MOUNT (KC)	(Y)
	5	μΑ7805CKC	μΑ7805Y
	6	μΑ7806CKC	μ Α 7806Υ
	8	μΑ7808CKC	μΑ7808Y
	8.5	μA7885CKC	μΑ7885Y
0°C to 125°C	10	μ Α7810CKC	μ Α 7810Υ
·	12	μ Α7812CKC	μ Α7812 Υ
	15	μΑ7815CKC	μΑ7815Υ
	18	μΑ7818CKC	μΑ7818Υ
	24	μΑ7824CKC	μΑ7824Y
-40°C to 125°C	5	μΑ7805QKC	
-40 C to 125 C	12	μΑ7812QKC	

schematic



μΑ78xxY chip information

These chips, when properly assembled, display characteristics similar to the μ A78xxC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



absolute maximum ratings over operating temperature ranges (unless otherwise noted)†

Input voltage, V _I : μA7824C	40 V
All others	35 V
Continuous total power dissipation at (or below) 25°C free-air temperature (see Note 1)	. 2 W
Continuous total power dissipation at (or below) 90°C case temperature (see Note 1)	15 W
Operating free-air, T _A , case, T _C , or virtual junction, T _J , temperature range	150°C
Storage temperature range, T _{stq} –65 to	150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: For operation above 25°C free-air or 90°C case temperature, refer to Figures 1 and 2. To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded. Due to variations in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

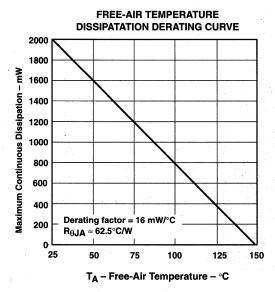


Figure 1

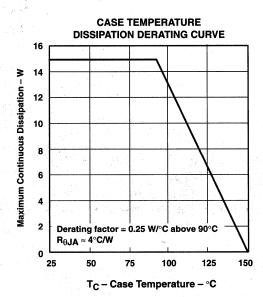


Figure 2

$\mu \text{A7800 SERIES} \\ \text{POSITIVE-VOLTAGE REGULATORS} \\$

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recommended operating conditions

		MIN	MAX	UNIT
	μΑ7805C	7	25	
	μΑ7806C	8	25	
	μΑ7808C	10.5	25	
nput voltage, V _I	μΑ7885C	10.5	25	
	μΑ7810C	12.5	28	V
	μ A 7812C	14.5	30	
	μΑ7815C	17.5	30	
	μΑ7818C	21	33	
	μΑ7824C	27	38	
Output current, IO			1.5	Α
Operating virtual junction temperature, TJ	μΑ7800C Series	0	125	°C
	μΑ7805Q, μΑ7812Q	-40	125	

electrical characteristics at specified virtual junction temperature, V_I = 10 V, I_O = 500 mA (unless otherwise noted)

	TTOT COMPLETIONS		μ Α780	5C, μΑ7	805Q		
PARAMETER	TEST CONDITIONS	ΤJ [†]	MIN	TYP	MAX	UNIT	
		25°C	4.8	5	5.2		
Output voltage [‡]	$I_{O} = 5 \text{ mA to 1 A}, \qquad V_{I} = 7 \text{ V to 20 V},$ P \leq 15 W	Full range§	4.75		5.25	V	
1	V _I = 7 V to 25 V	0500		3	100	\/	
Input voltage regulation	V _I = 8 V to 12 V	25°C		1	50	mV	
Ripple rejection	V _I = 8 V to 18 V, f = 120 Hz	Full range§	62	78		dB	
Output voltage regulation	I _O = 5 mA to 1.5 A	0500		15	100	mV	
	I _O = 250 mA to 750 mA	25°C		5	50		
Output resistance	f = 1 kHz	Full range§		0.017		Ω	
Temperature coefficient of output voltage	I _O = 5 mA	Full range§		-1.1		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	25°C		40		μV	
Dropout voltage	I _O = 1 A	25°C		2		V	
Bias current		25°C		4.2	8	mA	
Di-	V _I = 7 V to 25 V	F. II			1.3		
Bias current change	I _O = 5 mA to 1 A	Full range§			0.5	mA	
Short-circuit output current		25°C		750		mA	
Peak output current		25°C		2.2		Α	

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for the μΑ7805C and -40°C to 125°C for the μΑ7805Q.

μΑ7800 SERIES POSITIVE-VOLTAGE REGULATORS

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electrical characteristics at specified virtual junction temperature, $V_I = 11 \text{ V}$, $I_O = 500 \text{ mA}$ (unless otherwise noted)

DADAMETER	TEST SOURITIONS	_ +	μ	A7806C		UNIT	
PARAMETER	TEST CONDITIONS	T _J †	MIN	TYP	MAX	UNII	
		25°C	5.75	6	6.25		
Output voltage [‡]	$I_O = 5$ mA to 1 A, $V_I = 8$ V to 21 V, $P \le 15$ W	0°C to 125°C	5.7		TYP MAX 6 6.25 6.3 5 120 1.5 60 75 14 120 4 60 0.019 -0.8 n 45 2 4.3 8 1.3 0.5	V	
	V _I = 8 V to 25 V	25°C		5	120	mV	
Input voltage regulation	V _I = 9 V to 13 V	25°C		1.5	6.25 6.3 120 60 120 60 8 1.3	mv	
Ripple rejection	V _I = 9 V to 19 V, f = 120 Hz	0°C to 125°C	59	75		dB	
O. da. da. da. da. da. da. da. da. da. da	I _O = 5 mA to 1.5 A	0500		14	120	mV .	
Output voltage regulation	I _O = 250 mA to 750 mA	25°C		4	60		
Output resistance	f = 1 kHz	0°C to 125°C		0.019		Ω	
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C		-0.8		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	25°C		45		μV	
Dropout voltage	I _O = 1 A	25°C		2		٧	
Bias current		25°C	:	4.3	8	mA	
Diagram at a large	V _I = 8 V to 25 V	000 +- 10500			1.3		
Bias current change	I _O = 5 mA to 1 A	0°C to 125°C		1 : 4 1	0.5	mA	
Short-circuit output current		25°C		550		mA	
Peak output current		25°C		2.2		Α	

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = 14 \text{ V}$, $I_O = 500 \text{ mA}$ (unless otherwise noted)

D4.D444777D	TEST CONDITIONS	-+	μ Α7808C			UNIT
PARAMETER	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	UNII
3.		25°C	7.7	8	8.3	
Output voltage [‡]	$I_O = 5 \text{ mA to 1 A}, \qquad V_I = 10.5 \text{ V to 23 V},$ P \leq 15 W	0°C to 125°C	7.6		8.4	V
land the same and the same	V _I = 10.5 V to 25 V	0500		6	160	
Input voltage regulation	V _I = 11 V to 17 V	25°C		2	80	mV
Ripple rejection	V _I = 11.5 V to 21.5 V, f = 120 Hz	0°C to 125°C	55	72		dB
Output voltage regulation	I _O = 5 mA to 1.5 A	0500		12	160	mV
	I _O = 250 mA to 750 A	25°C		4 ·	80	mv
Output resistance	f = 1 kHz	0°C to 125°C		0.016		Ω
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C		-0.8		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	25°C		52		μV
Dropout voltage	I _O = 1 A	25°C		2		V
Bias current		25°C		4.3	- 8	mA
D:	V _I = 10.5 V to 25 V	0001 10500			1	
Bias current change	I _O = 5 mA to 1 A	0°C to 125°C		0.5	mA	
Short-circuit output current		25°C		450		mA :
Peak output current		25°C		2.2		Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, V_I = 15 V, I_O = 500 mA (unless otherwise noted)

DADAMETED	TEST CONDITIONS	- +	μ	A7885C		UNIT
PARAMETER	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	UNIT
		25°C	8.15	8.5	8.85	
Output voltage [‡]	$I_O = 5 \text{ mA to 1 A}, \qquad V_I = 11 \text{ V to 23.5 V}, \\ P \le 15 \text{ W}$	0°C to 125°C	8.1		8.9	V
land the second state	V _I = 10.5 V to 25 V	0500		6	170	mV
Input voltage regulation	V _I = 11 V to 17 V	25°C		2	85	mv
Ripple rejection	V _I = 11.5 V to 21.5 V, f = 120 Hz	0°C to 125°C	54	70		dB
Output voltage regulation	I _O = 5 mA to 1.5 A	0500	0500	12	170	
	I _O = 250 mA to 750 mA	25°C		4	85	mV
Output resistance	f = 1 kHz	0°C to 125°C		0.016		Ω
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C		-0.8		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	25°C		55		μV
Dropout voltage	I _O = 1 A	25°C		2		٧
Bias current		25°C		4.3	8	mA
	V _I = 10.5 V to 25 V				1	
Bias current change	I _O = 5 mA to 1 A	0°C to 125°C		0.5	mA	
Short-circuit output current		25°C		450		mA
Peak output current		25°C		2.2		Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

electrical characteristics at specified virtual junction temperature, V_{I} = 17 V, I_{O} = 500 mA (unless otherwise noted)

DADAMETED	TEST CONDITIONS	-+	μ Α7810C			UNIT
PARAMETER	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	UNIT
	*	25°C	9.6	10	10.4	
Output voltage [‡]	$I_O = 5 \text{ mA to 1 A}, \qquad V_I = 12.5 \text{ V to 25 V},$ P \leq 15 W	0°C to 125°C	9.5	10	10.5	٧
land a self-self-self-self-self-self-self-self-	V _I = 12.5 V to 28 V	0500		7	200	\/
Input voltage regulation	V _I = 14 V to 20 V	25°C		2	100	mV
Ripple rejection	V _I = 13 V to 23 V, f = 120 Hz	0°C to 125°C	55	71		dB
Output voltage regulation	I _O = 5 mA to 1.5 A	0500		12	200	
	I _O = 250 mA to 750 mA	25°C		4	100	mV
Output resistance	f = 1 kHz	0°C to 125°C		0.018		Ω
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C		-1	:	mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	25°C		- 70		μV
Dropout voltage	I _O = 1 A	25°C		2		٧
Bias current		25°C		4.3	8	mA
	V _I = 12.5 V to 28 V	000 + 40500			1	
Bias current change	I _O = 5 mA to 1 A	0°C to 125°C			0.5	mA
Short-circuit output current		25°C		400		mA
Peak output current		25°C		2.2		Α

The Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_{\rm I}$ = 19 V, $I_{\rm O}$ = 500 mA (unless otherwise noted)

DADAMETED	TEGT COMPLTIONS	T -+	μ	A7812C		UNIT
PARAMETER	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	UNII
		25°C	11.5	12	12.5	
Output voltage‡	$I_O = 5$ mA to 1 A, $V_I = 14.5$ V to 27 V, $P \le 15$ W	Full range§	11.4		12.6	V
land with an analytica	V _I = 14.5 V to 30 V	25°C		10	240	mV
Input voltage regulation	V _I = 16 V to 22 V	7 25-0		3	120	mv
Ripple rejection	V _I = 15 V to 25 V, f = 120 Hz	Full range§	55	71		dB
Output voltage regulation	I _O = 5 mA to 1.5 A	0500	5°C	12	240	
	I _O = 250 mA to 750 mA	7 25°C		4	120	mV.
Output resistance	f = 1 kHz	Full range§		0.018		Ω
Temperature coefficient of output voltage	I _O = 5 mA	Full range§		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	25°C		75		μV
Dropout voltage	I _O = 1 A	25°C		2		٧
Bias current		25°C		4.3	8	mA
Discount of the same	V _I = 14.5 V to 30 V	F. II			1	
Bias current change	I _O = 5 mA to 1 A	Full range§			0.5	mA
Short-circuit output current		25°C		350	17	mA
Peak output current		25°C		2.2		Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_{\rm I}$ = 23 V, $I_{\rm O}$ = 500 mA (unless otherwise noted)

DADAMETED	TEST CONDITIONS	-+	μ Α7815 C			UNIT	
PARAMETER	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	UNII	
		25°C	14.4	15	15.6	7	
Output voltage [‡]	$I_O = 5 \text{ mA to 1 A}, \qquad V_I = 17.5 \text{ V to 30 V}$ P \le 15 W	0°C to 125°C	14.25		15.75	V	
In and a self-self-self-self-self-self-self-self-	V _I = 17.5 V to 30 V	0500		11	300	mV	
Input voltage regulation	V _I = 20 V to 26 V	25°C		3	150	, mv .	
Ripple rejection	V _I = 18.5 V to 28.5 V, f = 120 Hz	0°C to 125°C	54	70		dB	
Output voltage regulation	I _O = 5 mA to 1.5 A	0500	25°C		12	300	mV
	I _O = 250 mA to 750 mA	25.0		4	150	l IIIV	
Output resistance	f = 1 kHz	0°C to 125°C		0.019		Ω	
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C		-1	-	mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	25°C		90		μV	
Dropout voltage	I _O = 1 A	25°C		2		٧	
Bias current		25°C		4.4	8	mA	
	V _I = 17.5 V to 30 V	000 + 10500			. 1		
Bias current change	I _O = 5 mA to 1 A	0°C to 125°C			0.5	mA .	
Short-circuit output current		25°C		230		mA	
Peak output current		25°C		2.1		Α	

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for the μΑ7812C and –40°C to 125°C for the μΑ7812Q.

electrical characteristics at specified virtual junction temperature, $V_I = 27 \text{ V}$, $I_O = 500 \text{ mA}$ (unless otherwise noted)

PARAMETER	TEST COMPITIONS	T.1	μ.	A7818C		UNIT
PARAMETER	TEST CONDITIONS	TJ†	MIN	TYP	MAX	UNII
		25°C	17.3	18	18.7	
Output voltage [‡]	$I_O = 5$ mA to 1 A, $V_I = 21$ V to 33 V, $P \le 15$ W	0°C to 125°C	17.1		18.9	V
Lancet college and an electrical	V _I = 21 V to 33 V	25°C		15	360	mV
Input voltage regulation	V _I = 24 V to 30 V	25-0		5	180] ^{mv}
Ripple rejection	V _I = 22 V to 32 V, f = 120 Hz	0°C to 125°C	53	69		dB
Output voltage regulation	I _O = 5 mA to 1.5 A	0500		12	360	
	I _O = 250 mA to 750 mA	25°C		4	180	mV
Output resistance	f = 1 kHz	0°C to 125°C		0.022		Ω
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	25°C		110		μV
Dropout voltage	I _O = 1 A	25°C		2		٧
Bias current		25°C		4.5	8	mA
D'annual de la company	V _I = 21 V to 33 V	000 +- 40500			1	
Bias current change	I _O = 5 mA to 1 A	0°C to 125°C			0.5	mA
Short-circuit output current		25°C		200		mA
Peak output current		25°C		2.1		Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = 33 \text{ V}$, $I_O = 500 \text{ mA}$ (unless otherwise noted)

DADAMETED	TEST COMPLETIONS	-+	μ	A7824C		UNIT
PARAMETER	TEST CONDITIONS	TJ†	MIN	TYP	MAX	UNII
		25°C	23	24	25	
Output voltage [‡]	$I_O = 5$ mA to 1 A, $V_I = 27$ V to $P \le 15$ W	38 V, 0°C to 125°C	22.8		25.2	٧
I	V _I = 27 V to 38 V	0500		18	480	mV
Input voltage regulation	V _I = 30 V to 36 V	25°C		6	240	l mv
Ripple rejection	V _I = 28 V to 38 V, f = 120 Hz	0°C to 125°C	50	66		dB
Output voltage regulation	I _O = 5 mA to 1.5 A	.25°C		12	480	mV
	I _O = 250 mA to 750 mA	.25°C		4	240	l mv
Output resistance	f = 1 kHz	0°C to 125°C		0.028		Ω
Temperature coefficient of output voltage	I _O = 5 mA	0°C to 125°C		-1.5		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	25°C		170		μV
Dropout voltage	I _O = 1 A	25°C		2		٧
Bias current		25°C		4.6	8	mA
Di	V _I = 27 V to 38 V	00C to 10E0C			1	
Bias current change	I _O = 5 mA to 1 A	0°C to 125°C			0.5	mA
Short-circuit output current		25°C		150		mA
Peak output current		25°C		2.1		Α

T Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_1 = 10 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25 \text{ °C}^{\dagger}$ (unless otherwise noted)

DADAMETED	TEST CONDITIONS	μ Α7805 Υ	UNIT
PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNII
Output voltage‡		5	٧
Input voltage regulation	V _I = 7 V to 25 V	3	mV
	V _I = 8 V to 12 V	1	mv
Ripple rejection	V _I = 8 V to 18 V, f = 120 Hz	78	dB
Output voltage regulation	I _O = 5 mA to 1.5 A	15	\/
	I _O = 250 mA to 750 mA	5	mV
Output resistance	f = 1 kHz	0.017	Ω
Temperature coefficient of output voltage	I _O = 5 mA	-1.1	mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	40	μV
Dropout voltage	I _O = 1 A	2	V
Bias current		4.2	mA
Short-circuit output current		750	mA
Peak output current		2.2	Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = 11 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}^{\dagger}$ (unless otherwise noted)

DADAMETER	TEST SOUDITIONS	μ Α7806Υ			
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output voltage‡			6		٧
Input voltage regulation	V _I = 8 V to 25 V		5		
	V _I = 9 V to 13 V		1.5		mV
Ripple rejection	V _I = 9 V to 19 V, f = 120 Hz		75		dB
Output voltage regulation	I _O = 5 mA to 1.5 A		14		
	I _O = 250 mA to 750 mA		4		mV
Output resistance	f = 1 kHz		0.019		Ω
Temperature coefficient of output voltage	I _O = 5 mA		-0.8		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz		45		μV
Dropout voltage	I _O = 1 A		. 2		٧
Bias current			4.3		. mA
Short-circuit output current			550		mA
Peak output current			2.2		Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = 14 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}^{\dagger}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	μ Α7808Υ	UNIT
PARAMETER	TEST CONDITIONS	MIN TYP MAX	CONT
Output voltage‡		8	٧
landa della na vandation	V _I = 10.5 V to 25 V	6	mV
Input voltage regulation	V _I = 11 V to 17 V	2	¬ ''''
Ripple rejection	V _I = 11.5 V to 21.5 V, f = 120 Hz	72	dB
0.1.1.1	I _O = 5 mA to 1.5 A	12	mV
Output voltage regulation	I _O = 250 mA to 750 A	4	¬ ''''
Output resistance	f = 1 kHz	0.016	Ω
Temperature coefficient of output voltage	I _O = 5 mA	-0.8	mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	52	μV
Dropout voltage	I _O = 1 A	2	٧
Bias current		4.3	mA
Short-circuit output current		450	mA
Peak output current		2.2	Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output. ‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = 15 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}^{\dagger}$ (unless otherwise noted)

DADAMETED	TEST CONDITIONS	μ Α7885 Υ	UNIT
PARAMETER	TEST CONDITIONS	MIN TYP N	IAX UNII
Output voltage‡		8.5	٧
Input voltage regulation	V _I = 10.5 V to 25 V	6	
	V _I = 11 V to 17 V	2	mV
Ripple rejection	V _I = 11.5 V to 21.5 V, f = 120 Hz	70	dB
Output voltage regulation	I _O = 5 mA to 1.5 A	12	
	I _O = 250 mA to 750 mA	4	mV
Output resistance	f = 1 kHz	0.016	Ω
Temperature coefficient of output voltage	I _O = 5 mA	-0.8	mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	55	μV
Dropout voltage	I _O = 1 A	2	V
Bias current		4.3	mA
Short-circuit output current		450	mA
Peak output current		2.2	А

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_1 = 17 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25 \text{ °C}^{\dagger}$ (unless otherwise noted)

DADASETTO	TEST CONDITIONS	μ Α7810Y	UNIT
PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNII
Output voltage‡		10	V
land to the second of the	V _I = 12.5 V to 28 V	7	mV
Input voltage regulation	V _I = 14 V to 20 V	2	mv
Ripple rejection	V _I = 13 V to 23 V, f = 120 Hz	71	dB
0.4	I _O = 5 mA to 1.5 A	12	mV
Output voltage regulation	IO = 250 mA to 750 mA	4	1 '''V
Output resistance	f = 1 kHz	0.018	Ω
Temperature coefficient of output voltage	I _O = 5 mA	-1	mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	70	μV
Dropout voltage	I _O = 1 A	2	٧
Bias current		4.3	mA
Short-circuit output current		400	mA
Peak output current		2.2	Α

T Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_1 = 19 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25 ^{\circ}\text{C}^{\dagger}$ (unless otherwise noted)

	TEST COMPLETIONS	μΑ			
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output voltage‡			12		V
landa de la companya	V _I = 14.5 V to 30 V		10		
Input voltage regulation	V _I = 16 V to 22 V		3		mV
Ripple rejection	V _I = 15 V to 25 V, f = 120 Hz		71		dB
	I _O = 5 mA to 1.5 A	12			>/
Output voltage regulation	I _O = 250 mA to 750 mA		4		mV
Output resistance	f = 1 kHz		0.018		Ω
Temperature coefficient of output voltage	I _O = 5 mA		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz		75		μV
Dropout voltage	I _O = 1 A		2		V
Bias current			4.3		mA
Short-circuit output current			350		mA
Peak output current			2.2		Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = 23 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}^{\dagger}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	μ Α7815 Υ	
PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNIT
Output voltage‡		15	V
Imput veltage vegulation	V _I = 17.5 V to 30 V	11	mV
Input voltage regulation	V _I = 20 V to 26 V	3	mv
Ripple rejection	V _I = 18.5 V to 28.5 V, f = 120 Hz	70	dB
Outro de velto de vegadation	I _O = 5 mA to 1.5 A	12	mV
Output voltage regulation	I _O = 250 mA to 750 mA	4] ^{mv}
Output resistance	f = 1 kHz	0.019	Ω
Temperature coefficient of output voltage	I _O = 5 mA	-1	mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	90	μV
Dropout voltage	I _O = 1 A	2	V
Bias current		4.4	mA
Short-circuit output current		230	mA
Peak output current		2.1	Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. ‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = 27 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}^{\dagger}$

DADAMETED	TEGT GOVERNO	μ Α7818 Υ	
PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNIT
Output voltage‡		18	V
Inner the college of	V _I = 21 V to 33 V	15	
Input voltage regulation	V _I = 24 V to 30 V	5	mV
Ripple rejection	V _I = 22 V to 32 V, f = 120 Hz	69	dB
	I _O = 5 mA to 1.5 A	12	
Output voltage regulation	I _O = 250 mA to 750 mA	4	mV
Output resistance	f = 1 kHz	0.022	Ω
Temperature coefficient of output voltage	I _O = 5 mA	-1	mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	110	μV
Dropout voltage	I _O = 1 A	2	V
Bias current		4.5	mA
Short-circuit output current		200	mA
Peak output current		2.1	Α

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

(unless otherwise noted)

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electrical characteristics at specified virtual junction temperature, $V_I = 33 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25 ^{\circ}\text{C}^{\dagger}$ (unless otherwise noted)

DADAMETED	TEGT COMPLETIONS	μ Α7824Y	
PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNIT
Output voltage‡		24	V
Innertuality as a secondaria	V _I = 27 V to 38 V	18	
Input voltage regulation	V _I = 30 V to 36 V	6 .	mV
Ripple rejection	V _I = 28 V to 38 V, f = 120 Hz	66	dB
A	I _O = 5 mA to 1.5 A	12	\/
Output voltage regulation	I _O = 250 mA to 750 mA	4	mV
Output resistance	f = 1 kHz	0.028	Ω
Temperature coefficient of output voltage	I _O = 5 mA	-1.5	mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	170	μV
Dropout voltage	I _O = 1 A	2	V
Bias current		4.6	mA
Short-circuit output current		150	mA
Peak output current		2.1	A

[†] Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

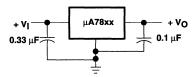


Figure 3. Fixed Output Regulator

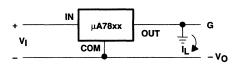
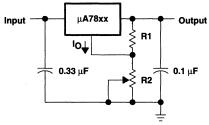


Figure 4. Positive Regulator in Negative Configuration (V_I Must Float)



NOTE A. The following formula is used when Vxx is the nominal output voltage (output to common) of the fixed regulator.

$$V_O = V_{XX} + \left(\frac{V_{XX}}{R1} + I_Q\right) R2$$

Input μΑ78xx VO(Reg) R1

Output

IO = (VO/R1) + IO Bias Current

Figure 5. Adjustable Output Regulator

Figure 6. Current Regulator

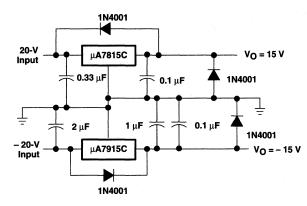


Figure 7. Regulated Dual Supply

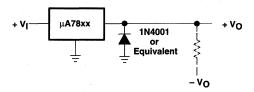


Figure 8. Output Polarity-Reversal Protection Circuit

operation with a load common to a voltage of opposite polarity

In many cases, a regulator powers a load that is not connected to ground but instead is connected to a voltage source of opposite polarity (e.g., op amps, level-shifting circuits, etc.). In these cases, a clamp diode should be connected to the regulator output as shown in Figure 8. This protects the regulator from output polarity reversals during startup and short-circuit operation.

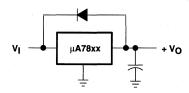


Figure 9. Reverse-Bias Protection Circuit

reverse-bias protection

Occasionally, there exists the possibility that the input voltage to the regulator can collapse faster than the output voltage. This could occur, for example, when the input supply is crowbarred during an output overvoltage condition. If the output voltage is greater than approximately 7 V, the emitter-base junction of the series pass element (internal or external) could break down and be damaged. To prevent this, a diode shunt can be employed as shown in Figure 9.



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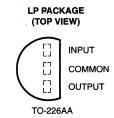
D PACKAGE (TOP VIEW)

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- 3-Terminal Regulators
- Output Current Up to 100 mA
- No External Components
- Internal Thermal Overload Protection
- Internal Short-Circuit Current Limiting
- Direct Replacements for Fairchild μA78L00 Series

description

This series of fixed-voltage monolithic integrated-circuit voltage regulators is designed for a wide range of applications. These applications include on-card regulation for elimination of noise and distribution problems associated with single-point regulation. In addition, they can be used with power-pass elements to make high-current voltage regulators. One of these regulators can deliver up to 100 mA of output current. The internal limiting and thermal shutdown features of these



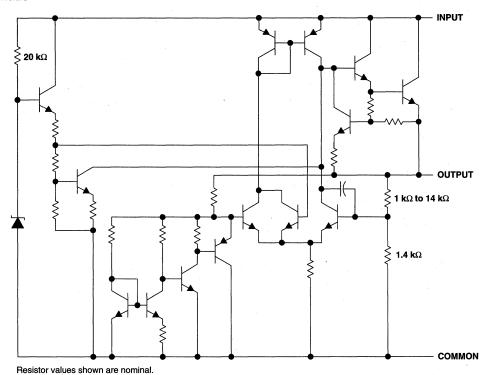
regulators make them essentially immune to overload. When used as a replacement for a zener diode-resistor combination, an effective improvement in output impedance can be obtained together with lower-bias current.

AVAILABLE OPTIONS

Tj			PACKAGE	D DEVICES		
	V _{O(nom)}	PLASTIC DIP (D)		PLASTIC CYLINDRICAL (LP)		CHIP FORM
	(V)		OUTPUT VOLTA	GE TOLERANCE		(Y)
		5%	10%	. 5%	10%	
	2.6	μΑ78L02ACD	μΑ78L02CD	μΑ78L02ACLP	μΑ78L02CLP	μΑ78L02Υ
	5	μΑ78L05ACD	μA78L05CD	μΑ78L05ACLP	μΑ78L05CLP	μΑ78L05Υ
	6.2	μΑ78L06ACD	μA78L06CD	μΑ78L06ACLP	μA78L06CLP	μΑ78L06Y
0°C to 125°C	8	μA78L08ACD	μA78L08CD	μΑ78L08ACLP	μΑ78L08CLP	μΑ78L08Y
0°C to 125°C	- 9	μΑ78L09ACD	μA78L09CD	μΑ78L09ACLP	μΑ78L09CLP	μΑ78L09Υ
	10	μΑ78L10ACD	μΑ78L10CD	μΑ78L10ACLP	μΑ78L10CLP	μΑ78L10Y
	12	μΑ78L12ACD	μΑ78L12CD	μΑ78L12ACLP	μA78L12CLP	μΑ78L12Y
	15	μΑ78L15ACD	μΑ78L15CD	μΑ78L15ACLP	μΑ78L15CLP	μΑ78L15Υ
-40°C to 125°C	5	μΑ78L05AQD	μΑ78L05QD	μΑ78L05QLP	μΑ78L05QLP	_
-40 C to 125 C	12	μΑ78L12AQD	μA78L12QD	μΑ78L12QLP	μA78L12QLP	

D and LP packages are available taped and reeled. Add R suffix to devise type (e.g., μ A78L05ACDR).

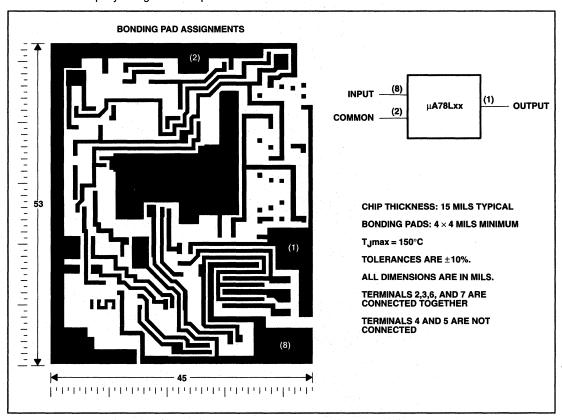
schematic



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μΑ78xxY chip information

These chips, when properly assembled, display characteristics similar to the µA78xxY. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



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μA78LxxC absolute maximum ratings over operating temperature range (unless otherwise noted)

	μΑ78L02C, μΑ78L02AC THROUGH μΑ78L10C, μΑ78L10AC	μΑ78L12C, μΑ78L12AC μΑ78L15C, μΑ78L15AC	UNIT
Input voltage	30	35	V
Continuous total power dissipation (see Note 1)	See Dissipation	on Rating Tables 1 and 2	
Operating free-air, T _A , case, T _C , or virtual junction, T _J , temperature range	0 to 125	0 to 125	°C
Storage temperature range, T _{Stg}	-65 to 150	-65 to 150	°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260	260	°C

NOTE 1: To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded. Due to variations in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

μΑ78LxxQ absolute maximum ratings over operating temperature range (unless otherwise noted)

	μ Α78L05Q , μ Α78L05AQ	μ Α78L12Q , μ Α78L12AQ	UNIT		
Input voltage	30	35	٧		
Continuous total power dissipation (see Note 1)	See Dissipation Rating Tables 1 and 2				
Operating free-air, T _A , case, T _C , or virtual junction, T _J , temperature range	-40 to 150	-40 to 150	°C		
Storage temperature range, T _{Stg}	-65 to 150	-65 to 150	°C .		
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260	260	°C		

NOTE 1: To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded. Due to variations in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

DISSIPATION RATING TABLE 1 - FREE-AIR TEMPERATURE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	DERATE ABOVE T _A	T _A = 70°C POWER RATING
D	725 mW	5.8 mW/°C	25°C	464 mW
LP†	775 mW	6.2 mW/°C	25°C	496 mW

 $[\]bar{t}$ The LP package dissipation rating is based on thermal resistance $R_{\theta JA}$ measured in still air with the device mounted in an Augat socket. The bottom of the package is 10 mm (0.375 in) above the socket.

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE

				-
PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	DERATE ABOVE T _C	T _C = 125°C POWER RATING
D	1600 mW	19.6 mW/°C	65°C	424 mW
LP	1600 mW	28.6 mW/°C	94°C	713 mW

$\mu \text{A78L00 SERIES} \\ \text{POSITIVE-VOLTAGE REGULATORS} \\$

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recommended operating conditions

		MIN	MAX	UNIT
	μΑ78L02C, μΑ78L02AC	4.75	20	
Input voltage, V _I	µА78L05С, µА78L05АС, µА78L05Q, µА78L05AQ	7	20	
	μΑ78L06C, μΑ78L06AC	8.5	20	
	μΑ78L08C, μΑ78L08AC	10.5	23	
	μΑ78L09C, μΑ78L09AC	11.5	24	٧
	μΑ78L10C, μΑ78L10AC	12.5	25	
	µА78L12С, µА78L12АС, µА78L12Q, µА78L12AQ	14.5	27	
	μΑ78L15C, μΑ78L15AC	17.5	30	
Output current, IO			100	mA
On a waking a state of the making Assessment T	μΑ78LxxC thru μΑ78LxxAC	0	125	°C
Operating virtual junction temperature, T _J	μΑ78LxxQ and μΑ78LxxAQ	-40	125	٠

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electrical characteristics at specified virtual junction temperature, V_I = 9 V, I_O = 40 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	- +	μ Α78L02C			μ Α78L02AC			UNIT
	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	MIN	TYP	MAX	UNII
		25°C	2.4	2.6	2.8	2.5	2.6	2.7	
Output voltage‡	V _I = 4.75 V to 20 V, I _O = 1 mA to 40 mA	F	2.35		2.85	2.45		2.75	٧
	I _O = 1 mA to 70 mA	2.35		2.85	2.45		2.75		
Input voltage	V _I = 4.75 V to 20 V	0500		20	125		20	100	
regulation	V _I = 5 V to 20 V	25°C		16	100		16	75	m∨
Ripple rejection	V _I = 6 V to 20 V, f = 120 Hz	25°C	42	51		43	51		dB
Output voltage	I _O = 1 mA to 100 mA	0500		12	50		12	50	
regulation	I _O = 1 mA to 40 mA	25°C		6	25		6	25	mV
Output noise voltage	f = 10 Hz to 100 kHz	25°C		30			30		μV
Dropout voltage	7	25°C		1.7			1.7	-	٧
Dies surrent		25°C		3.6	6		3.6	6	A
Bias current		125°C			5.5			5.5	mA .
Dian autrant abanca	V _I = 5 V to 20 V	F			2.5			2.5	A
Bias current change	I _O = 1 mA to 40 mA	Full range§			0.2			0.1	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = 10 \text{ V}$, $I_O = 40 \text{ mA}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ΤJ [†]	μ Α78L05C, μ Α78L05Q			μ Α78L05AC, μ Α78L05AQ			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
		25°C	4.6	5	5.4	4.8	5	5.2	100
Output voltage‡	V _I = 7 V to 20 V, I _O = 1 mA to 40 mA	F. II	4.5		5.5	4.75		5.25	٧.
	I _O = 1 mA to 70 mA	Full range§	4.5		5.5	4.75		5.25	
Input voltage regulation	V _I = 7 V to 20 V	25°C		32	200		32	150	mV
	V _I = 8 V to 20 V			26	150		26	100	
Ripple rejection	V _I = 8 V to 18 V, f = 120 Hz	25°C	40	49		41	49		dB
Output voltage	I _O = 1 mA to 100 mA			15	60		15	60	mV
regulation	I _O = 1 mA to 40 mA	25°C		8	30		8	30	
Output noise voltage	f = 10 Hz to 100 kHz	25°C	:	42			42		μV
Dropout voltage		25°C		1.7			1.7		٧
Di		25°C		3.8	6		3.8	6	
Bias current		125°C		7	5.5			5.5	mA.
D:	V _I = 8 V to 20 V				1.5			1.5	
Bias current change	I _O = 1 mA to 40 mA	Full range9			0.2			0.1	mA

[†] Pulse-testing techniques maintain T, as close to TA as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for μΑ78L02, μΑ78L02ΑC, μΑ78L05C, and μΑ78L05AC and –40°C to 125°C for μΑ78L05Q and µA78L05AQ.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for μΑ78L02, μΑ78L02ΑC, μΑ78L05C, and μΑ78L05AC and – 40°C to 125°C for μΑ78L05Q and µA78L05AQ.

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electrical characteristics at specified virtual junction temperature, V_{I} = 12 V, I_{O} = 40 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	ΤJ [†]	μ Α78L06C			μ Α78L06AC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	UNIT
Output voltage‡		25°C	5.7	6.2	6.7	5.95	6.2	6.45	٧
	$V_I = 8.5 \text{ V to } 20 \text{ V}, \qquad I_O = 1 \text{ mA to } 40 \text{ mA}$	Tull range 8	5.6		6.8	5.9		6.5	
	I _O = 1 mA to 70 mA	Full range§	5.6		6.8	5.9		6.5	
Input voltage regulation	V _I = 8.5 V to 20 V	25°C		35	200		35	175	mV
	V ₁ = 9 V to 20 V	7 200		29	150		29	125	mv
Ripple rejection	V _I = 10 V to 20 V, f = 120 Hz	25°C	39	48		40	48		dB
Output voltage regulation	IO = 1 mA to 100 mA	25°C		16	80		16	80	mV
	I _O = 1 mA to 40 mA	7 250		9	40		9	40	IIIV
Output noise voltage	f = 10 Hz to 100 kHz	25°C		46			46		μV
Dropout voltage		25°C		1.7			1.7		٧
Bias current		25°C		3.9	6		3.9	6	mA
		125°C			5.5			5.5	
Bias current change	V _I = 9 V to 20 V	F			1.5			1.5	mA
	I _O = 1 mA to 40 mA	Full range§			`0.2			0.1	

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, V_I = 14 V, I_O = 40 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T _J †	μ Α78L08C			μ Α78L08AC			
			MIN	TYP	MAX	MIN	TYP	MAX	UNIT
Output voltage‡		25°C	7.36	8	8.64	7.7	8	8.3	٧
	V _I = 10.5 V to 23 V, I _O = 1 mA to 40 mA	Full range§	7.2		8.8	7.6		8.4	
	IO = 1 mA to 70 mA		7.2		8.8	7.6		8.4	
Input voltage regulation	V _I = 10.5 V to 23 V	25°C		42	200		42	175	mV
	V _I = 11 V to 23 V			36	150		36	125	
Ripple rejection	V _I = 13 V to 23 V, f = 120 Hz	25°C	36	46		37	46		dB
Output voltage regulation	IO = 1 mA to 100 mA	25°C		18	80		18	80	mV
	IO = 1 mA to 40 mA			10	40		10	40	
Output noise voltage	f = 10 Hz to 100 kHz	25°C		54			54		μV
Dropout voltage		25°C		1.7			1.7		٧
Bias current		25°C		4	6		4	6	mA
		125°C			5.5			5.5	mA
Bias current change	V _I = 5 V to 20 V	Full range§			1.5			1.5	mA
	I _O = 1 mA to 40 mA				0.2			0.1	

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for μΑ78L06C, μΑ78L06AC, μΑ78L08C, and μΑ78L08AC.

[‡]This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for μΑ78L06C, μΑ78L06AC, μΑ78L08AC, and μΑ78L08AC.

$\mu \text{A78L00 SERIES} \\ \text{POSITIVE-VOLTAGE REGULATORS} \\$

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electrical characteristics at specified virtual junction temperature, V_{I} = 16 V, I_{O} = 40 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T.+	μ.	178L09	С	μΑ	78L09A	C	UNIT
ISHAMEIEN	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	MIN	TYP	MAX	ONLI
		25°C	8.3	9	9.7	8.6	. 9	9.4	
Output voltage‡	$V_I = 12 \text{ V to } 24 \text{ V}, \qquad I_O = 1 \text{ mA to } 40 \text{ mA}$	F	8.1		9.9	8.55		9.45	V
	I _O = 1 mA to 70 mA	Full range§	8.1		9.9	8.55		9.45	
Input voltage	V _I = 12 V to 24 V	0500		45	225		45	175	
regulation	V _I = 13 V to 24 V	25°C		40	175		40	125	mV
Ripple rejection	V _I = 15 V to 25 V, f = 120 Hz	25°C	36	45		38	45		dB
Output voltage	I _O = 1 mA to 100 mA	25°C		19	90		19	90	mV
regulation	I _O = 1 mA to 40 mA	7 25-0		11	40		11	40	mv
Output noise voltage	f = 10 Hz to 100,kHz	25°C		58			58		μV
Dropout voltage		25°C		1.7			1.7		٧
Bias current		25°C		4.1	6		4.1	6	A
Dias current		125°C			5.5			5.5	mA
Pico current change	V _I = 13 V to 24 V	F			1.5			1.5	^
Bias current change	I _O = 1 mA to 40 mA	Full range§			0.2			0.1	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, V_{I} = 14 V, I_{O} = 40 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	DITIONS		78L10	С	μ Α	78L10A	C	LINIT
TANAMETER	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
		25°C	9.2	10	10.8	9.6	10	10.4	
Output voltage‡	$V_I = 13 \text{ V to } 25 \text{ V}, \qquad I_O = 1 \text{ mA to } 40 \text{ mA}$	F	9		11	9.5		10.5	V
	I _O = 1 mA to 70 mA	Full range§	9		11	9.5		10.5	
Input voltage	V _I = 13 V to 25 V	0500		51	225		51	175	
regulation	V _I = 14 V to 25 V	25°C		42	175		42	125	mV
Ripple rejection	V _I = 15 V to 25 V, f = 120 Hz	25°C	36	44		37	44		dB
Output voltage	I _O = 1 mA to 100 mA	25°C		20	90		20	90	
regulation	I _O = 1 mA to 40 mA	25°C		. 11	40		11	40	mV
Output noise voltage	f = 10 Hz to 100 kHz	25°C		62			62		μV
Dropout voltage		25°C		1.7		-	1.7		V
Dica current		25°C		4.2	6		4.2	6	
Bias current		125°C			5.5			5.5	mA
Dice current shange	V _I = 14 V to 25 V	- 8			1.5			1.5	A
Bias current change	I _O = 1 mA to 40 mA	Full range§			0.2			0.1	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for μΑ78L09C, μΑ78L09AC, μΑ78L10C, and μΑ78L10AC.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for μΑ78L09C, μΑ78L09AC, μΑ78L10C, and μΑ78L10AC.

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electrical characteristics at specified virtual junction temperature, V_I = 19 V, I_O = 40 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TJ†	μ Α78L12C, μ Α78L12Q		•	μ Α78L12AC, μ Α78L12AQ			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
		25°C	11.1	12	12.9	11.5	12	12.5	
Output voltage‡	$V_I = 14 \text{ V to } 27 \text{ V}, \qquad I_O = 1 \text{ mA to } 40 \text{ mA}$	Full manage	10.8		13.2	11.4		12.6	٧
	I _O = 1 mA to 70 mA	Full range§	10.8		13.2	11.4		12.6	
Input voltage	V _I = 14.5 V to 27 V	0500		55	250		55	250	mV
regulation	V _I = 16 V to 27 V	25°C		49	200		49	200	
Ripple rejection	V _I = 15 V to 25 V, f = 120 Hz	25°C	36	42		37	42		dB
Output voltage	I _O = 1 mA to 100 mA	25°C		22	100		22	100	mV
regulation	I _O = 1 mA to 40 mA	7 200		13	50		13	50	1117
Output noise voltage	f = 10 Hz to 100 kHz	25°C		70			70		μV
Dropout voltage		25°C		1.7			1.7		V
Diag assument		25°C		4.3	6.5		4.3	6.5	mA
Bias current		125°C			6			6] IIIA
Dies surrent change	V _I = 16 V to 27 V	F			1.5			1.5	m۸
Bias current change	I _O = 1 mA to 40 mA	Full range§	;		0.2			0.1	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

electrical characteristics at specified virtual junction temperature, V_{I} = 23 V, I_{O} = 40 mA (unless otherwise noted)

DADAMETED	TEGT COMPITIONS	- +	μ.	μ Α78L15C		μ Α	78L15A	C	118117
PARAMETER	TEST CONDITIONS	TJ [†]	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
		25°C	13.8	15	16.2	14.4	15	15.6	
Output voltage‡	V _I = 17.5 V to 30 V, I _O = 1 mA to 40 mA	F	13.5		16.5	14.25		15.75	V
	I _O = 1 mA to 70 mA	Full range§	13.5		16.5	14.25		15.75	
Input voltage	V _I = 17.5 V to 30 V	25°C		65	300		65	300	mV
egulation V _I = 20 V to 30 V		58	250		58	250	, ,,,,		
Ripple rejection	V _I = 18.5 V to 28.5 V, f = 120 Hz	25°C	33	39		34	39		dB
Output voltage	I _O = 1 mA to 100 mA	25°C		25	150		25	150	mV
regulation	I _O = 1 mA to 40 mA	25-0		15	75		15	75] ""
Output noise voltage	f = 10 Hz to 100 kHz	25°C		82			82		μV
Dropout voltage		25°C		1.7			1.7		V
Bias current		25°C		4.6	6.5		4.6	6.5	mA
bias current		125°C			6			6] "'^
Dies surrent change	V _I = 10 V to 30 V	F. II			1.5			1.5	mΛ
Bias current change	I _O = 1 mA to 40 mA	Full range§			0.2			0.1	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

[‡]This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for μΑ78L12C, μΑ78L12AC, μΑ78L15C, and μΑ78L15AC.

[‡]This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[§] Full range virtual junction temperature is 0°C to 125°C for μΑ78L12C, μΑ78L12AC, μΑ78L15C, and μΑ78L15AC.

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electrical characteristics at specified virtual junction temperature, $V_I = 9 \text{ V}$, $I_O = 40 \text{ mA}$, $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	μ Α78L02Y	UNIT
PARAMETER	TEST CONDITIONS!	MIN TYP MAX	UNIT
Output voltage‡		2.6	٧
Input voltage regulation	V _I = 4.75 V to 20 V	20	mV
	V _I = 5 V to 20 V	16	mv
Ripple rejection	$V_1 = 6 \text{ V to } 20 \text{ V}, \qquad f = 120 \text{ Hz}$	51	dB
Output voltage	I _O = 1 mA to 100 mA	12	mV
regulation	$I_O = 1$ mA to 40 mA	6	IIIV
Output noise voltage	f = 10 Hz to 100 kHz	30	μV
Dropout voltage		1.7	V
Bias current		3.6	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = 10 \text{ V}$, $I_O = 40 \text{ mA}$, $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEGT COMPLETIONS	μ Α78L05Y		
PARAMETER	TEST CONDITIONST	MIN TYP MAX	UNIT	
Output voltage‡		5	V	
Input voltage regulation	V _I = 7 V to 20 V	32	mV	
	V _I = 8 V to 20 V	26	mv	
Ripple rejection	V _I = 8 V to 18 V, f = 120 Hz	49	dB	
Output voltage	I _O = 1 mA to 100 mA	15	mV	
regulation	I _O = 1 mA to 40 mA	8	mv	
Output noise voltage	f = 10 Hz to 100 kHz	42	μV	
Dropout voltage		1.7	٧	
Bias current		3.8	mA	

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = 12 \text{ V}$, $I_O = 40 \text{ mA}$, $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONST	μ Α78L06Y	
PARAMETER	TEST CONDITIONS!	MIN TYP MAX	UNIT
Output voltage‡		6.2	V
Input voltage	V _I = 8.5 V to 20 V	35	mV
regulation	V _I = 9 V to 20 V	29	mv
Ripple rejection	V _I = 10 V to 20 V, f = 120 Hz	48	dB
Output voltage	I _O = 1 mA to 100 mA	16	mV
regulation	I _O = 1 mA to 40 mA	9	mv
Output noise voltage	f = 10 Hz to 100 kHz	46	μV
Dropout voltage		1.7	V
Bias current		3.9	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

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electrical characteristics at specified virtual junction temperature, $V_1 = 14 \text{ V}$, $I_Q = 40 \text{ mA}$, $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONST	μ Α78L08Y	UNIT
PANAMETER	TEST CONDITIONS!	MIN TYP MAX	JONII
Output voltage‡		8	V
Input voltage	V _I = 10.5 V to 23 V	42	mV
regulation	V _I = 11 V to 23 V	36] ^{mv}
Ripple rejection	V _I = 13 V to 23 V, f = 120 Hz	46	dB
Output voltage	I _O = 1 mA to 100 mA	18	mV
regulation	I _O = 1 mA to 40 mA	10	7 '''V
Output noise voltage	f = 10 Hz to 100 kHz	54	μV
Dropout voltage		1.7	V
Bias current		4	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = 16 \text{ V}$, $I_O = 40 \text{ mA}$, $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONST	μ Α78L09Y	
	TEST CONDITIONS!	MIN TYP MAX	UNIT
Output voltage [‡]		9 .	٧
Input voltage	V _I = 12 V to 24 V	45	
regulation	V _I = 13 V to 24 V	40	mV
Ripple rejection	V _I = 15 V to 25 V, f = 120 Hz	45	dB
Output voltage	I _O = 1 mA to 100 mA	19	m۷
regulation	I _O = 1 mA to 40 mA	11	mv
Output noise voltage	f = 10 Hz to 100 kHz	58	μV
Dropout voltage		1.7	V
Bias current	. :	4.1	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a $0.33-\mu F$ capacitor across the input and a $0.1-\mu F$ capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = 14 \text{ V}$, $I_O = 40 \text{ mA}$, $T_A = 25 ^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONST	μ Α78L10Y		
	TEST CONDITIONS	MIN TYP MAX	UNIT	
Output voltage‡		10	٧	
Input voltage	V _I = 13 V to 25 V	51		
regulation	V _I = 14 V to 25 V	42	mV	
Ripple rejection	V _I = 15 V to 25 V, f = 120 Hz	44	dB	
Output voltage	I _O = 1 mA to 100 mA	20		
regulation	I _O = 1 mA to 40 mA	11	mV	
Output noise voltage	f = 10 Hz to 100 kHz	62	μV	
Dropout voltage		1.7	٧	
Bias current		4.2	mA	

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

μΑ78L00 SERIES POSITIVE-VOLTAGE REGULATORS

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electrical characteristics at specified virtual junction temperature, $V_I = 19 \text{ V}$, $I_O = 40 \text{ mA}$, $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONST	μ Α78L12Y	UNIT
PARAMETER	TEST CONDITIONS!	MIN TYP MAX	UNII
Output voltage‡		12	V
Input voltage	V _I = 14.5 V to 27 V	55	
regulation	V _I = 16 V to 27 V	49	mV
Ripple rejection	V _I = 15 V to 25 V, f = 120 Hz	42	dB
Output voltage	I _O = 1 mA to 100 mA	22	
regulation	I _O = 1 mA to 40 mA	13	mV
Output noise voltage	f = 10 Hz to 100 kHz	70	μV
Dropout voltage		1.7	V
Bias current		4.3	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, V_I = 23 V, I_O = 40 mA, T_A = 25°C (unless otherwise noted)

BARAMETER CONTRACTOR	TEGT COMPLETIONST	μ Α78L15Y	T
PARAMETER	TEST CONDITIONST	MIN TYP MAX	UNIT
Output voltage‡		15	٧
Input voltage	V _I = 17.5 V to 30 V	65	
regulation	V _I = 20 V to 30 V	58	mV
Ripple rejection	V _I = 18.5 V to 28.5 V, f = 120 Hz	39	dB
Output voltage	I _O = 1 mA to 100 mA	25	
regulation	I _O = 1 mA to 40 mA	15	mV
Output noise voltage	f = 10 Hz to 100 kHz	82	μV
Dropout voltage		1.7	V
Bias current		4.6	mA

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

APPLICATION INFORMATION

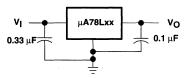


Figure 1. Fixed Output Regulator

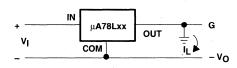


Figure 2. Positive Regulator in Negative Configuration (V_I Must Float)

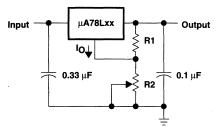


Figure 3. Adjustable Output Regulator

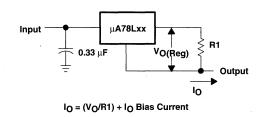


Figure 4. Current Regulator

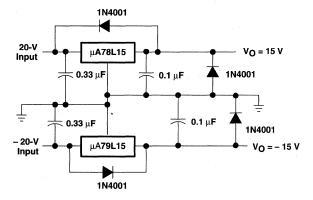


Figure 5. Regulated Dual Supply

APPLICATION INFORMATION

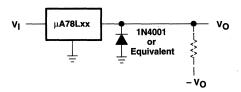


Figure 6. Output Polarity-Reversal Protection Circuit

operation with a load common to a voltage of opposite polarity

In many cases, a regulator powers a load that is not connected to ground but instead is connected to a voltage source of opposite polarity (e.g., operational amplifiers, level-shifting circuits, etc.). In these cases, a clamp diode should be connected to the regulator output as shown in Figure 6. This protects the regulator from output polarity reversals during startup and short-circuit operation.

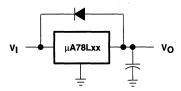


Figure 7. Reverse-Bias Protection Circuit

reverse-bias protection

Occasionally, there exists the possibility that the input voltage to the regulator can collapse faster than the output voltage. This could occur, for example, when the input supply is crowbarred during an output overvoltage condition. If the output voltage is greater than approximately 7 V, the emitter-base junction of the series pass element (internal or external) could break down and be damaged. To prevent this, a diode shunt can be employed as shown in Figure 7.

$\mu \text{A78M00 SERIES} \\ \text{POSITIVE-VOLTAGE REGULATORS} \\$

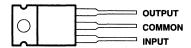
SLVS059A - JUNE 1976 - REVISED AUGUST 1995

- 3-Terminal Regulators
- Output Current Up to 500 mA
- No External Components
- Internal Thermal Overload Protection
- High Power Dissipation Capability
- Internal Short-Circuit Current Limiting
- Output Transistor Safe-Area Compensation
- Direct Replacements for Fairchild μA78M00 Series

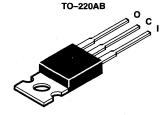
description

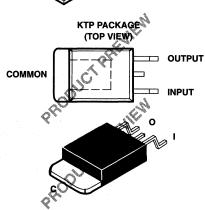
This series of fixed-voltage monolithic integrated-circuit voltage regulators is designed for a wide range of applications. These applications include on-card regulation for elimination of noise and distribution problems associated with single-point regulation. Each of these regulators can deliver up to 500 mA of output current. The internal current limiting and thermal shutdown features of these regulators make them essentially immune to overload. In addition to use as fixed-voltage regulators, these devices can be used with external components to obtain adjustable output voltages and currents and also as the power pass element in precision regulators.

KC PACKAGE (TOP VIEW)



The common terminal is in electrical contact with the mounting base.





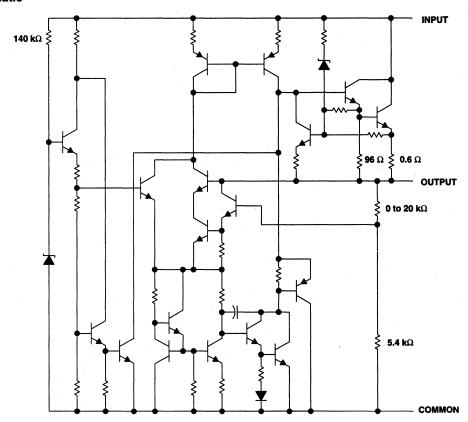
AVAILABLE OPTIONS

	V = (n n ==)	PACKAGE	D DEVICES	CHIP
TA	(V)	HEAT-SINK MOUNTED (KC)	HEAT-SINK MOUNTED† (KTP)	FORM (Y)
	5	μΑ78M05CKC	μΑ78M05CKTP	μ Α78M 05Y
	6	μΑ78М06СКС	μA78M06CKTP	μ Α78Μ06 Υ
	8	μΑ78M08CKC	µA78M08CKTP	μ Α78Μ08 Υ
	9	μΑ78М09СКС	µA78M69CKTP	μ Α78Μ 09Υ
0°C to 125°C	10	μΑ78M10CKC	µA78M10CKTP	μ Α78M10 Υ
	12	μΑ78M12CKC	µA78M12CKTP	μΑ78M12Y
	15	μΑ78M15CKC	MA78M15CKTP	μ Α78M15 Y
	20	μΑ78M20CKC	μΑ78M20CKTP	μ Α78M20 Y
	. 24	μΑ78M24CKC	μΑ78M24CKTP	μΑ78M24Y

†The KTP package is only available in tape and reel.



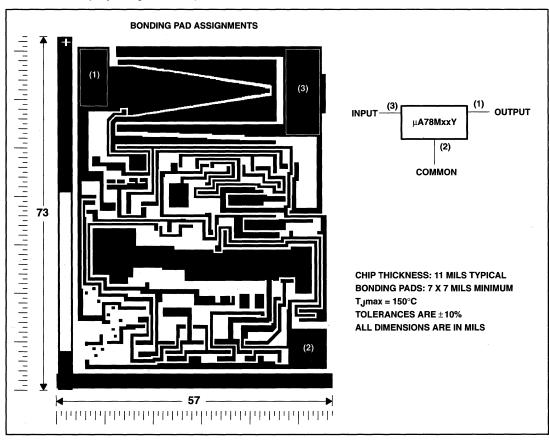
schematic



Resistor values shown are nominal.

μΑ78MxxY chip information

This chip, when properly assembled, displays characteristics similar to the μ A78MxxC. Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



absolute maximum ratings over operating temperature range (unless otherwise noted)†

		μΑ78Мхх	UNIT
	μΑ78Μ20, μΑ78Μ24	-40	.,
Input voltage, V _I	All others	35	v
Continuous total power dissipation (see Note 1)	The united to sta	See Dissipation Rating Tables	1 and 2
Operating free-air (TA), case (TC), or virtual junction (TJ) temperature r	ange	0 to 150	°C
Storage temperature range, T _{Stq}		-65 to 150	°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		260	°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded. Due to variations in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

DISSIPATION RATING TABLE 1 - FREE-AIR TEMPERATURE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING
KC	2000 mW	16 mW/°C	1280 mW
KTP			

[†] The KTP package is product preview only and derating information is not yet available.

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE

PACKAGE	T _C ≤ 50°C POWER RATING	DERATING FACTOR ABOVE T _C = 50°C	T _C = 125°C POWER RATING
KC	20 W	200 mW/°C	5 W
KTPT			

[†] The KTP package is product preview only and derating information is not yet available.

recommended operating conditions

		MIN	MAX	UNIT
	μ A 78 M 05	7	25	
	μ Α78M 06	8	25	
	μ A78M08	10.5	25	
	μΑ78Μ09	11.5	26	
ut voltage, V _I	μ Α 78 Μ 10	12.5	28	V
	μ A 78M12	14.5	30	
	μ A 78M15	17.5	30	
	μ A 78M20	23	35	
	μ A78M24	27	38	
tput current, IO			500	mA
perating virtual junction temperature, TJ		0	125	°C

electrical characteristics at specified virtual junction temperature, V_I = 10 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

DADAMETED	TEOT 0	ONDITIONST	μΑ	78M050	>	UNIT
PARAMETER	IESI CI	TEST CONDITIONS†			MAX	UNII
Output voltage‡			4.8	5	5.2	V
Cutput voltage+	$V_{i} = 7 \text{ V to } 20 \text{ V},$	T _J = 0°C to 125°C	4.75		5.25	\ \ \
		V _I = 7 V to 25 V		3	100	
Input voltage regulation	$I_{O} = 200 \text{ mA}$	V _I = 8 V to 20 V				mV
		V _I = 8 V to 25 V		1	50	
Ripple rejection	$V_1 = 8 \text{ V to } 18 \text{ V,}$ f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	62			dB
		I _O = 300 mA	62	80		l ·.
Output voltage regulation	I _O = 5 mA to 500 mA	4		20	100	
Output voltage regulation	$I_0 = 5 \text{ mA to } 200 \text{ m/s}$	4		10	50	mV
Temperature coefficient of output voltage	I _O = 5 mA	T _J = 0°C to 125°C		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz			40	200	μV
Dropout voltage				2	2.5	V
Bias current				4.5	6	mA
Bias current change	I _O = 200 mA, T _J = 0°C to 125°C	V _I = 8 V to 25 V,			0.8	mA
	$I_0 = 5 \text{ mA to } 350 \text{ mA}$	A T _J = 0°C to 125°C			0.5	1
Short-circuit output current	V _I = 35 V			300		mA
Peak output current				0.7		Α

[†] All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified virtual junction temperature, V_I = 11 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

PARAMETER	+-	TEST CONDITIONS†			μ Α78M06C		
PARAMETER	15	SICONDITIONS	MIN	TYP	MAX	UNIT	
O. 45. 4 t				5.75	6	6.25	v
Output voltage ‡	$I_0 = 5 \text{ mA to } 350 \text{ mA},$	V _I = 8 V to 21 V,	T _J = 0°C to 125°C	5.7	7	6.3	
Input voltage regulation	In 200 mA		V _I = 8 V to 25 V		5	100	\/
Input voltage regulation	I _O = 200 mA		V _I = 9 V to 25 V		1.5	50	mV
Ripple rejection V	V _I = 9 V to 19 V, f = 120 Hz	f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	59			dB
		I _O = 300 mA	59	80			
0.44	I _O = 5 mA to 500 mA				20	120	.,,
Output voltage regulation	I _O = 5 mA to 200 mA				10	60	mV
Temperature coefficient of output voltage	I _O = 5 mA,	T _J = 0°C to 125°	С .		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				45		μV
Dropout voltage	1				2		٧
Bias current					4.5	6	mA
Di	V _I = 9 V to 25 V,	I _O = 200 mA,	T _J = 0°C to 125°C		-	0.8	
Bias current change	$I_0 = 5 \text{ mA to } 350 \text{ mA},$	T _J = 0°C to 125°	C			0.5	mA
Short-circuit output current	V _I = 35 V				270		mA
Peak output current					0.7		Α

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, V_I = 14 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

DADAMETED		TEST CONDITIONS			478M08	С	UNIT
PARAMETER	16				TYP	MAX	UNII
				7.7	8	8.3	
Output voltage‡	V _I = 10.5 V to 23 V, T _J = 0°C to 125°C	$I_O = 5 \text{ mA to } 35$	50 mA,	7.6		8.4	٧
land voltage regulation	l= 000 == 1	V _I = 10.5 V to			6	100	mV
Input voltage regulation	I _O = 200 mA		V _I = 11 V to 25 V		2	50	mv
Ripple rejection	V _I = 11.5 V to 21.5 V, f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	56			dB	
			I _O = 300 mA	56 80			
Output valtage regulation	I _O = 5 mA to 500 mA				25	160	
Output voltage regulation	IO = 5 mA to 200 mA				10	80	mV
Temperature coefficient of output voltage	IO = 5 mA,	T _J = 0°C to 125	5°C		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				52		μV
Dropout voltage					2		V
Bias current					4.6	6	mA
Dies sument shares	V _I = 10.5 V to 25 V,	I _O = 200 mA,	T _J = 0°C to 125°C			0.8	^
Bias current change	IO = 5 mA to 350 mA,	T _J = 0°C to 125	S°C			0.5	mA
Short-circuit output current	V _I = 35 V				250		mA
Peak output current					0.7		Α

T All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified virtual junction temperature, $V_I = 16 \text{ V}, I_O = 350 \text{ mA}, T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED		TEST CONDITIONS†			A78M09	C	UNIT	
PARAMETER	i i	SI CONDITIONS	51	MIN	TYP	MAX	UNII	
				8.6	9	9.4		
Output voltage‡	V _I = 11.5 V to 24 V, T _J = 0°C to 125°C	I _O = 5 mA to 35	60 mA,	8.5		9.5	>	
Input voltage regulation	IO = 200 mA		V _I = 11.5 V to 26 V		6	100	mV	
Imput voltage regulation	IO = 200 IIIA		V _I = 12 V to 26 V	2			50	1110
Ripple rejection	V _I = 13 V to 23 V, f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	56			dB		
			I _O = 300 mA	56	80			
Output valtage regulation	I _O = 5 mA to 500 mA				25	180		
Output voltage regulation	IO = 5 mA to 200 mA				10	90	mV	
Temperature coefficient of output voltage	IO = 5 mA,	T _J = 0°C to 125	i°C		-1	•	mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz				58		μV	
Dropout voltage					2		٧	
Bias current					4.6	6	mA	
Diagram at about	$V_1 = 11.5 \text{ V to } 26 \text{ V},$	I _O = 200 mA,	T _J = 0°C to 125°C			0.8		
Bias current change	IO = 5 mA to 350 mA,	T _J = 0°C to 125	S°C			0.5	. mA	
Short-circuit output current	V _I = 35 V				250		mA	
Peak output current	, v.,				0.7		Α	

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, V_I = 17 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

DADAMETER	TEST COMPLICANS!			μ	UNIT			
PARAMETER	"5	TEST CONDITIONS†			TYP	MAX	UNII	
				9.6 10 10.4				
Output voltage ‡	V_{I} = 12.5 V to 25 V, I_{O} = 5 mA to 350 mA, I_{J} = 0°C to 125°C					10.5	V	
Innutualte se regulation	I- 000 A		V _I = 12.5 V to 28 V		7	100		
Input voltage regulation	I _O = 200 mA		V _I = 14 V to 28 V		2	50	m∨	
Ripple rejection	V _I = 15 V to 25 V,	f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	59			dB	
			I _O = 300 mA	55	80			
0.4	I _O = 5 mA to 500 mA				25	200		
Output voltage regulation	I _O = 5 mA to 200 mA				10	100	mV	
Temperature coefficient of output voltage	I _O = 5 mA,	T _J = 0°C to 125	5°C		-1		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz				64		μV	
Dropout voltage					2		V	
Bias current		7, **.			4.7	6	mA	
Di-	V _I = 12.5 V to 28 V,	I _O = 200 mA,	T _J = 0°C to 125°C			0.8		
Bias current change	$I_0 = 5 \text{ mA to } 350 \text{ mA},$	T _J = 0°C to 125	5°C			0.5	mA	
Short-circuit output current	V _I = 35 V				245		mA	
Peak output current		3 N. S			0.7		A	

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_{,I} as close to T_A as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified virtual junction temperature, V_I = 9 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

DADAMETED	TEST CONDITIONS			μ Α78M12C			UNIT
PARAMETER				MIN	TYP	MAX	UNII
		1,		11.5	12	12.5	
Output voltage ‡	V _I = 14.5 V to 27 V, T _J = 0°C to 125°C	I _O = 5 mA to 35	50 mA,	11.4		12.6	V
least valtage regulation	$V_{\parallel} = 16 \text{ V to } 30 \text{ V}$		V _I = 14.5 V to 30 V		8	100	
Input voltage regulation			2	50	mV		
Ripple rejection	V _I = 15 V to 25 V,	f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	55			dB
			I _O = 300 mA	55	80		
	IO = 5 mA to 500 mA				25	240	
Output voltage regulation	I _O = 5 mA to 200 mA				10	120	mV
Temperature coefficient of output voltage	I _O = 5 mA		*		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				75		μV
Dropout voltage		,			2		V
Bias current					4.8	6	mA
Ď:	V _I = 14.5 V to 30 V,	I _O = 200 mA,	T _J = 0°C to 125°C			0.8	
Bias current change	$I_O = 5 \text{ mA to } 350 \text{ mA},$	$T_{J} = 0^{\circ}C \text{ to } 125$	5°C			0.5	mA
Short-circuit output current	V _I = 35 V				240		mA
Peak output current	3 .				0.7		Α

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = 23 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETER		TEST COMPUTICALIST			μ Α78M15C		
PARAMETER	TEST CONDITIONS†			MIN	TYP	MAX	UNIT
				14.4	15	15.6	
Output voltage‡	V _I = 17.5 V to 30 V, T _J = 0°C to 125°C	I _O = 5 mA to 35	50 mA,	14.25	,	15.75	V
Input voltage regulation	V _I = 17.5 V to 30 V			10	100	mV	
Input voltage regulation	I _O = 200 mA		V _I = 20 V to 30 V		3	50] ""V
Ripple rejection	V _I = 18.5 V to 28.5 V,	f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	54			dB
		I _O = 300 mA	54	70		1	
Outrout valte as a seriet detice	I _O = 5 mA to 500 mA				25	300	
Output voltage regulation	I _O = 5 mA to 200 mA				10	150	mV
Temperature coefficient of output voltage	I _O = 5 mA,	T _J = 0°C to 125	5°C		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				90		μV
Dropout voltage					2		V
Bias current					4.8	6	mA
Dia a summat ab a sum	V _I = 17.5 V to 30 V,	I _O = 200 mA,	T _J = 0°C to 125°C			0.8	
Bias current change	I _O = 5 mA to 350 mA,	T _J = 0°C to 125	5°C			0.5	mA
Short-circuit output current	V _I = 35 V				240		mA
Peak output current	na. Nasawa sa manaka manaka manaka manaka manaka manaka manaka manaka manaka manaka manaka manaka manaka manaka ma	to the second			0.7		Α

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified virtual junction temperature, V_I = 29 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

		TEST CONDITIONS†			μ Α78M20C		
PARAMETER	į Ti				TYP	MAX	UNIT
				19.2	19.2 20	20.8	
Output voltage‡	V _I = 23 V to 35 V, I _O = 5 mA to 350 mA, T _J = 0°C to 125°C		19		21	٧	
Innuitualita de varialetica	I- 000 A		V _I = 23 V to 35 V		10	100	mV
Input voltage regulation	I _O = 200 mA		V _I = 24 V to 35 V		5	50	IIIV
Ripple rejection $V_I = 24 \text{ V to } 34 \text{ V}, f = 120 \text{ Hz}$	I _O = 100 mA, T _J = 0°C to 125°C	53			dB		
			I _O = 300 mA	53	70		
Outrout valta na nandation	I _O = 5 mA to 500 mA				30	400	\/
Output voltage regulation	I _O = 5 mA to 200 mA				10	200	mV
Temperature coefficient of output voltage	$I_O = 5 \text{ mA},$	T _J = 0°C to 125	5°C		-1.1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz			ŀ	110		μV
Dropout voltage			V		2		V
Bias current					4.9	6	mA
Diag assument about	V _I = 23 V to 35 V,	I _O = 200 mA,	T _J = 0°C to 125°C			0.8	
Bias current change	IO = 5 mA to 350 mA, T _J = 0°C to 125°C				0.5	mA	
Short-circuit output current	V _I = 35 V				240		, mA
Peak output current					0.7		ΙA

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

μΑ78M00 SERIES POSITIVE-VOLTAGE REGULATORS

SLVS059A - JUNE 1976 - REVISED AUGUST 1995

electrical characteristics at specified virtual junction temperature, V_I = 33 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

PARAMETER		:OT OONDITION	ıot	μ/	A78M24	С	LINIT
PARAMETER	I &	ST CONDITION	151	MIN	TYP	MAX	UNIT
				23	24	25	
Output voltage ‡	V _I = 27 V to 38 V, T _J = 0°C to 125°C	$I_O = 5 \text{ mA to } 3$	50 mA,	22.8		25.2	٧
Input voltage regulation	IO = 200 mA		V _I = 27 V to 38 V		10	100	mV
Imput voltage regulation	10 = 200 MA	= 200 MA V _I = 28 V to 38 V			5	50	IIIV
Ripple rejection	V _I = 28 V to 38 V,	I _O = 100 mA, T _J = 28 V to 38 V, f = 120 Hz T _J = 0°C to 125°C		50			dB
			I _O = 300 mA	50	70		
Output voltage regulation	I _O = 5 mA to 500 mA				30	480	mV
Output voltage regulation	I _O = 5 mA to 200 mA				10	240	mv
Temperature coefficient of output voltage	I _O = 5 mA,	T _J = 0°C to 12	5°C		-1.2		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				170		μV
Dropout voltage					2		V
Bias current					5	6	mA
Dies surrent shangs	$V_{ } = 27 \text{ V to } 38 \text{ V},$	I _O = 200 mA,	T _J = 0°C to 125°C			0.8	
Bias current change	$I_O = 5$ mA to 350 mA,	T _J = 0°C to 12	5°C			0.5	mA
Short-circuit output current	V _I = 35 V				240	100	mA
Peak output current					0.7		Α

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, V_I = 10 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

DADAMETED	TEST CONDITIONS†			μ Α78M05Y			
PARAMETER	1	TEST CONDITIONS			TYP	MAX	UNIT
Output voltage‡					5		٧
	L 000 A	000 4		3		>/	
Input voltage regulation	I _O = 200 mA		V _I = 8 V to 25 V		1		, mV
Ripple rejection	V _I = 8 V to 18 V,	I _O = 300 mA,	f = 120 Hz		80		dB
Outros de la companya	I _O = 5 mA to 500 mA			20			
Output voltage regulation	I _O = 5 mA to 200 mA				10		mV
Temperature coefficient of output voltage	I _O = 5 mA				-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				40		μV
Dropout voltage					2		·V
Bias current					4.5		mA
Short-circuit output current	V _I = 35 V				300		mA
Peak output current					0.7		Α

[†] All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified virtual junction temperature, V_I = 11 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

				μ Α78M06Y			
PARAMETER	TEST CONDITIONS†				TYP	MAX	UNIT
Output voltage‡					6		V
Landa Barra Latin		000		5			
Input voltage regulation	I _O = 200 mA		V _I = 9 V to 25 V		1.5		mV
Ripple rejection	V _I = 9 V to 19 V, I _O	= 300 mA, f	= 120 Hz		80		dB
I _O = 5 mA to 500 mA			20				
Output voltage regulation	I _O = 5 mA to 200 mA				10		mV
Temperature coefficient of output voltage	I _O = 5 mA				-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				45		μV
Dropout voltage					2		a V
Bias current					4.5		mA
Short-circuit output current	V _I = 35 V				270		mA
Peak output current					0.7		Α

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_{.1} as close to T_A as possible. Thermal effects must be taken into account separately.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, V_I = 14 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

DADAMETED	TEST SOMETION	TEST CONDITIONS†			Υ	UNIT
PARAMETER	TEST CONDITION	NSI	MIN	TYP	MAX	UNII
Output voltage‡				8		V
land to the manufaction	L- 000 A	V _I = 10.5 V to 25 V		6		mV
Input voltage regulation	I _O = 200 mA	V _I = 11 V to 25 V	2			'''V
Ripple rejection	$V_I = 11.5 \text{ V to } 21.5 \text{ V}, I_O = 300 \text{ mA},$	f = 120 Hz		80		dB
I _O = 5 mA to 500 mA		25				
Output voltage regulation	I _O = 5 mA to 200 mA			10		mV
Temperature coefficient of output voltage	I _O = 5 mA			-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz			52		μV
Dropout voltage				2		٧
Bias current				4.6		mA
Short-circuit output current	V _I = 35 V			250		mA
Peak output current				0.7		Α

T All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified virtual junction temperature, V_I = 16 V_I = 350 mA, T_J = 25°C (unless otherwise noted)

DADAMETED	_	TEST CONDITIONST			A78M09	Υ	UNIT	
PARAMETER					TYP	MAX	UNII	
Output voltage‡					9		V	
I and a self-self-self-self-self-self-self-self-	l- 000 A		V _I = 11.5 V to 26 V		6			
Input voltage regulation	$V_{\parallel} = 12 \text{ V to } 26 \text{ V}$		$I_O = 200 \text{ mA}$ $V_I = 12 \text{ V to } 26 \text{ V}$ 2					mV
Ripple rejection	V _I = 13 V to 23 V,	I _O = 300 mA,	f = 120 Hz		- 80		dB	
	I _O = 5 mA to 500 mA	I _O = 5 mA to 500 mA			25			
Output voltage regulation	IO = 5 mA to 200 mA				10		mV	
Temperature coefficient of output voltage	I _O = 5 mA,	T _J = 0°C to 125	5°C		-1		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz				58		μV	
Dropout voltage					2		V	
Bias current					4.6		mA	
Short-circuit output current	V _I = 35 V				250		mA	
Peak output current					0.7		Α	

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_1 = 17 \text{ V}$, $I_0 = 350 \text{ mA}$, $T_{-1} = 25 ^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEST CONDITIONST			μ	UNIT		
PARAMETER				MIN	TYP	MAX	UNII
Output voltage‡					10		٧
Innut valta as regulation	I- 000 ÷- A	- 200 - 4			7		mV
Input voltage regulation	I _O = 200 mA		V _I = 14 V to 28 V		2] ""v
Ripple rejection	V _I = 15 V to 25 V,	I _O = 300 mA,	f = 120 Hz		80		dB
Output valtage regulation	I _O = 5 mA to 500 mA			25			mV
Output voltage regulation	IO = 5 mA to 200 mA				10] ""V
Temperature coefficient of output voltage	IO = 5 mA				-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				64		μV
Dropout voltage					. 2		V
Bias current					4.7		mA .
Short-circuit output current	V _I = 35 V				245		mA
Peak output current					0.7		Α

[†] All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified virtual junction temperature, $V_I = 9 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS†			μ Α	78M12	1	UNIT
PARAMETER	IESI C	TEST CONDITIONS:			TYP	MAX	UNIT
Output voltage‡					12		V
longit voltage population	I- 000 A		V _I = 14.5 V to 30 V		8		
Input voltage regulation	I _O = 200 mA		V _I = 16 V to 30 V	2			mV
Ripple rejection	V _I = 15 V to 25 V, I _O =	300 mA,	f = 120 Hz		80		dB
Outrot valtage varieties	O = 5 mA to 500 mA		25			\/	
Output voltage regulation	IO = 5 mA to 200 mA				10		mV
Temperature coefficient of output voltage	I _O = 5 mA				-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				75		μV
Dropout voltage					2		V
Bias current					4.8		mA
Short-circuit output current	V _I = 35 V				240		mA
Peak output current		×.			0.7		Α

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

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[‡]This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, V_I = 23 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

PARAMETER	TEAT COMPLETION	TEST CONDITIONS†			С	UNIT
PARAMEIER	TEST CONDITION				MAX	UNII
Output voltage‡				15		٧
Innuit valte as negulation	1- 000 mA	V _I = 17.5 V to 30 V		10		mV
Input voltage regulation	I _O = 200 mA	V _I = 20 V to 30 V		3		mv
Ripple rejection	V _I = 18.5 V to 28.5 V, I _O = 300 mA,	f = 120 Hz		70		dB
Output valtage regulation	IO = 5 mA to 500 mA			25		
Output voltage regulation	I _O = 5 mA to 200 mA		10			mV
Temperature coefficient of output voltage	I _O = 5 mA			-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz		Ī .	90		μV
Dropout voltage				2		V
Bias current				4.8		mA
Short-circuit output current	V _I = 35 V			240		mA
Peak output current				0.7		Α

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified virtual junction temperature, V_I = 29 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

DADAMETED		TEST CONDITIONS†			μ Α78M20C		
PARAMETER	TEST CONDITIONS			MIN	TYP	MAX	UNIT
Output voltage‡					20		٧
	l- 000 A		V _I = 23 V to 35 V		10		
Input voltage regulation	I _O = 200 mA		V _I = 24 V to 35 V		5		mV
Ripple rejection	V _I = 24 V to 34 V,	f = 120 Hz,	I _O = 300 mA		70		dÉ
Outrout valtage regulation	I _O = 5 mA to 500 mA				30		mV
Output voltage regulation	IO = 5 mA to 200 mA	\			10		inv
Temperature coefficient of output voltage	I _O = 5 mA				-1.1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				110		μV
Dropout voltage					2		٧
Bias current					4.9		mA
Short-circuit output current	V _I = 35 V				240		mA
Peak output current					0.7		Α

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

μ**A78M00 SERIES**POSITIVE-VOLTAGE REGULATORS

SLVS059A - JUNE 1976 - REVISED AUGUST 1995

electrical characteristics at specified virtual junction temperature, V_I = 33 V, I_O = 350 mA, T_J = 25°C (unless otherwise noted)

PARAMETER	TEST CONDITIONST			μ Α78M24Y			UNIT
PARAMETER				MIN	TYP	MAX	UNII
Output voltage‡					24	."	V
Incut valtage regulation	I _O = 200 mA		10				
Input voltage regulation			V _I = 28 V to 38 V	8 V 5			mV
Ripple rejection	V _I = 28 V to 38 V,	I _O = 300 mA,	f = 120 Hz		70		dB
Output valtage regulation	$I_O = 5$ mA to 500 mA	O = 5 mA to 500 mA		30			
Output voltage regulation	I _O = 5 mA to 200 mA			Ĭ.	10		mV
Temperature coefficient of output voltage	I _O = 5 mA				-1.2		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz				170		μV
Dropout voltage					2		V
Bias current			:		. 5		mA
Short-circuit output current	V _I = 35 V				240		mA
Peak output current					0.7		Α

[†] All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output. Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

μΑ79M00 SERIES NEGATIVE-VOLTAGE REGULATORS

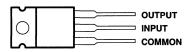
SLVS060A - JUNE 1976 - REVISED AUGUST 1995

- 3-Terminal Regulators
- Output Current Up to 500 mA
- No External Components
- High Power Dissipation Capability
- Internal Short-Circuit Current Limiting
- Output Transistor Safe-Area Compensation
- Direct Replacements for Fairchild μA79M00 Series

description

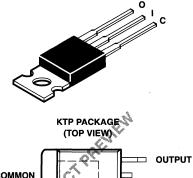
This series of fixed-negative-voltage monolithic integrated-circuit voltage regulators is designed to complement the $\mu A78M00$ series in a wide range of applications. These applications include on-card regulation for elimination of noise and distribution problems associated with single-point regulation. Each of these regulators can deliver up to 500 mÅ of output current. The internal current limiting and thermal shutdown features of these regulators make them essentially immune to overload. In addition to use as fixed-voltage regulators, these devices can be used with external components to obtain adjustable output voltages and currents and also as the power pass element in precision regulators.

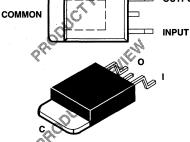
KC PACKAGE (TOP VIEW)



The input terminal is in electrical contact with the mounting base.

TO-220AB





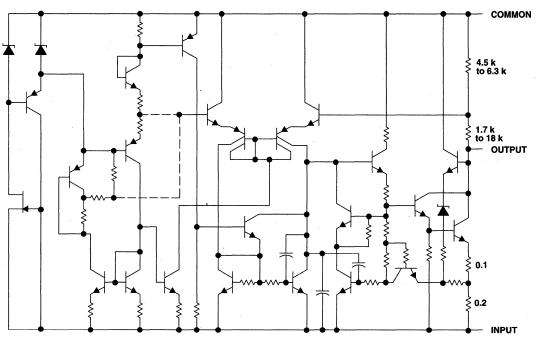
AVAILABLE OPTIONS

	T	DACKAGE	D DEVICES	CHIP
TA	V _O (nom) (V)	HEAT-SINK MOUNTED (KC)	HEAT-SINK MOUNTED†	FORM (Y)
	-5	μΑ79M05CKC	μΑ79M05CKTP	μ Α 79 Μ 05Υ
	-6	μΑ79M06CKC	μΑ79M06CKTP	μ Α 79Μ06Υ
	-8	μΑ79М08СКС	µA79M08CKTP	μ Α79M08 Υ
0°C to 125°C	-12	μΑ79M12CKC	µA79M12CKTP	μ Α7 9Μ12Υ
	-15	μΑ79M15CKC	μ Α79Μ15 CKTP	μΑ79M15Y
	-20	μΑ79M20CKC	µA79M20CKTP	μ Α 79Μ20Υ
	-24	μΑ79M24CKC	μΑ79M24CKTP	μΑ79M24Y

[†] The KTP package is only available in tape and reel.



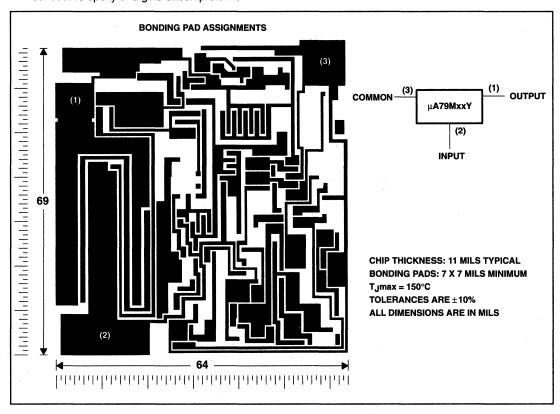
schematic



Resistor values shown are nominal and in Ω .

μΑ79MxxY chip information

This chip, when properly assembled, displays characteristics similar to the μ A79MxxC. Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



μΑ79M00 SERIES NEGATIVE-VOLTAGE REGULATORS

SLVS060A - JUNE 1976 - REVISED AUGUST 1995

absolute maximum ratings over operating temperature range (unless otherwise noted)†

		µА79МххС	UNIT
Input voltage	μΑ79Μ20, μΑ79Μ24	-40	,,
	All others	-35	1 °
Continuous total power dissipation (see Note 1)		See Dissipation Rating Tables	1 and 2
Operating free-air, TA, case, TC, or virtual junction, TJ, temperature	re range	0 to 150	°C
Storage temperature range, T _{sto}		-65 to 150	°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		260	°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded. Due to variations in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

DISSIPATION RATING TABLE 1-FREE-AIR TEMPERATURE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 125°C POWER RATING
KC	2000 mW	16 mW/°C	1280 mW	400 mW
KTPT				

[†] The KTP package is product preview only and derating information is not yet available.

DISSIPATION RATING TABLE 2-CASE TEMPERATURE

PACKAGE	T _C ≤ 120°C POWER RATING	DERATING FACTOR ABOVE T _C = 120°C	T _C = 125°C POWER RATING
КС	7.5 W	250 mW/°C	6.25 W
KTPT			

[†]The KTP package is product preview only and derating information is not yet available.

recommended operating conditions

		MIN	MAX	UNIT
	μΑ79M05C	-7	-25	
	μΑ79M06C	-8	-25	. *-
	μΑ79M08C	-10.5	-25	
Input voltage, V _I	μΑ79M12C	-14.5	30	٧
	μΑ79M15C	-17.5	-30	
	μΑ79M20C	-23	-35	
	μΑ79M24C	-27	-38	
Output current, IO			500	mA
Operating virtual junction temperature, T _J		0	125	°C

electrical characteristics at specified virtual junction temperature, $V_I = -10 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEOT 0.0	TEST CONDITIONS!		79M05	C	UNIT
PARAMETER	IESI CO			TYP	MAX	
			-4.8	-5	-5.2	
Output voltage‡	$V_{I} = -7 \text{ V to } -25 \text{ V},$ $T_{J} = 0^{\circ}\text{C to } 125^{\circ}\text{C}$	$I_O = 5$ mA to 350 mA,	-4.75		-5.25	V
Input voltage regulation	$V_1 = -7 \text{ V to } -25 \text{ V}$			7	50	mV
Input voltage regulation	$V_1 = -8 \text{ V to } -18 \text{ V}$, , , , , , , , , , , , , , , , , , , ,		3	30	l mv
Ripple rejection	$V_I = -8 \text{ V to } -18 \text{ V}, $ f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	50			dB
		I _O = 300 mA	54	60		
O. da. d	I _O = 5 mA to 500 mA			75	100	mV
Output voltage regulation	$I_0 = 5 \text{ mA to } 350 \text{ mA}$	I _O = 5 mA to 350 mA		50] ""
Temperature coefficient of output voltage	$I_O = 5 \text{ mA},$	T _J = 0°C to 125°C		-0.4		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz			125		μV
Dropout voltage				1.1		V
Bias current				1	2	mA
Pi-	$V_{ } = -8 \text{ V to } -18 \text{ V},$	Т _J = 0°C to 125°C			0.4	
Bias current change	I _O = 5 mA to 350 mA	, T _J = 0°C to 125°C			0.4	mA
Short-circuit output current	V _I = -30 V			140		mA
Peak output current				0.65		Α

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = -11 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEOT 00	TEST CONDITIONS†		μ А79М06С		
PARAMETER	TEST CO	ICMOITIUMO	MIN	TYP	MAX	UNIT
			-5.75	-6	-6.25	
Output voltage‡	$V_I = -8 \text{ V to } -25 \text{ V},$ $T_J = 0^{\circ}\text{C to } 125^{\circ}\text{C}$	$I_O = 5$ mA to 350 mA,	-5.7		-6.3	V
Input voltage regulation	$V_{I} = -8 \text{ V to } -25 \text{ V}$			7	60	mV
	$V_1 = -9 \text{ V to } -19 \text{ V}$			3	40	mv
Ripple rejection	$V_{ } = -9 \text{ V to } -19 \text{ V},$ f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	50			dB
	1 = 120 Hz	I _O = 300 mA	54	60		
	I _O = 5 mA to 500 mA			80	120	
Output voltage regulation	$I_0 = 5 \text{ mA to } 350 \text{ mA}$			55		mV
Temperature coefficient of output voltage	$I_O = 5 \text{ mA},$	T _J = 0°C to 125°C		-0.4		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz			150		μV
Dropout voltage				1.1		V
Bias current				1	2	mA
Di	$V_{I} = -9 \text{ V to } -25 \text{ V},$	T _J = 0°C to 125°C			0.4	
Bias current change	$I_0 = 5 \text{ mA to } 350 \text{ mA},$	I _O = 5 mA to 350 mA, T _J = 0°C to 125°C			0.4	mA
Short-circuit output current	V _I = -30 V			140		mA
Peak output current				0.65		Α

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = -19 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETER	T-07 001	DITIONS	μ	A79M08	C	
PARAMETER	TEST CON	DITIONS	MIN	TYP	MAX	UNIT
			-7.7	-8	-8.3	
Output voltage‡	$V_I = -10.5 \text{ V to } -25 \text{ V},$ $T_J = 0^{\circ}\text{C to } 125^{\circ}\text{C}$	I _O = 5 mA to 350 mA,	-7.6		-8.4	V
Input voltage regulation	$V_1 = -10.5 \text{ V to } -25 \text{ V}$			8	80	mV
	$V_1 = -11 \text{ V to } -21 \text{ V}$			4	50] ""V
Ripple rejection	V _I = -11.5 V to -21.5 V, f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	50	:		dB
	T = 120 HZ	IO = 300 mA	54	59		
0.4	IO = 5 mA to 500 mA			90	160	mV
Output voltage regulation	IO = 5 mA to 350 mA			60		IIIV
Temperature coefficient of output voltage	$I_O = 5 \text{ mA},$	T _J = 0°C to 125°C		-0.6		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz			200		μV
Dropout voltage	I _O = 5 mA			1.1		V
Bias current				1	2	mA
Di	$V_I = -10.5 \text{ V to } -25 \text{ V},$	T _J = 0°C to 125°C			0.4	
Bias current change	$I_0 = 5 \text{ mA to } 350 \text{ mA},$	T _J = 0°C to 125°C			0.4	mA
Short-circuit output current	V _I = -30 V			140		mA
Peak output current				0.65		Α

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = -19 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25 ^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED		TEST CONDITIONS†		μ Α79M12C		
PARAMETER	IES			TYP	MAX	UNIT
			-11.5	-12	-12.5	
Output voltage‡	$V_{j} = -14.5 \text{ V to } -14.5 \text{ V to } -14.5 \text{ V}$	30 V, $I_O = 5$ mA to 350 mA,	-11.4		-12.6	V
landa de la companya	V _I = -14.5 V to -	30 V		9	80	
Input voltage regulation	$V_{ } = -15 \text{ V to } -2$	5 V		5	50	mV
Ripple rejection	V _I = -15V to -25	$I_{O} = 100 \text{ mA},$ $I_{J} = 0^{\circ}\text{C to } 125^{\circ}\text{C}$	50			dB
	f = 120 Hz	I _O = 300 mA	54	60		1
	I _O = 5 mA to 500	I _O = 5 mA to 500 mA		65	240	
Output voltage regulation	I _O = 5 mA to 350	mA		45		mV
Temperature coefficient of output voltage	I _O = 5 mA,	T _J = 0°C to 125°C		-0.8		mV/°C
Output noise voltage	f = 10 Hz to 100	(Hz		300		μV
Dropout voltage			1	1.1		V
Bias current				1.5	3	mA
D	$V_1 = -14.5 \text{ V to } -$	30 V, T _J = 0°C to 125°C	1		0.4	
Bias current change	IO = 5 mA to 350 mA, T _J = 0°C to 125°C				0.4	mA
Short-circuit output current	V _I = -30 V			140		mA
Peak output current			1	0.65		Α

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = -23 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED		TEST CONDITIONS†		79M15	С	UNIT
PARAMETER	IESI CON			TYP	MAX	UNII
			-14.4	-15	-15.6	
Output voltage [‡]	$V_I = -17.5 \text{ V to } -30 \text{ V},$ $T_J = 0^{\circ}\text{C to } 125^{\circ}\text{C}$	$I_O = 5$ mA to 350 mA,	-14.25		-15.75	V
Input voltage regulation	$V_{ } = -17.5 \text{ V to } -30 \text{ V}$			9	80	
Tiput voltage regulation	$V_1 = -18 \text{ V to } -28 \text{ V}$			7	50	mV
Ripple rejection	$V_I = -18.5 \text{ V to } -28.5 \text{ V},$ f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	50			dB
	1 = 120 HZ	IO = 300 mA	54	59		
Out	I _O = 5 mA to 500 mA			65	240	mV
Output voltage regulation	I _O = 5 mA to 350 mA			45		IIIV
Temperature coefficient of output voltage	$I_O = 5 \text{ mA},$	T _J = 0°C to 125°C		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz			375		μV
Dropout voltage	I _O = 5 mA			1.1		٧
Bias current				1.5	3	mA
Dies summet skappe	$V_{\parallel} = -17.5 \text{ V to } -30 \text{ V},$	T _J = 0°C to 125°C			0.4	A
Bias current change	$I_O = 5 \text{ mA to } 350 \text{ mA},$	T _J = 0°C to 125°C			0.4	mA
Short-circuit output current	V _I = -30 V			140		mA
Peak output current				0.65		Α

T Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = -29 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEOT 001	TEST COMPLETIONS		μ Α79M20C		
PARAMETER	IESI COI	TEST CONDITIONS†			MAX	UNIT
			-19.2	-20	-20.8	
Output voltage [‡]	$V_I = -23 \text{ V to } -35 \text{ V},$ $T_J = 0^{\circ}\text{C to } 125^{\circ}\text{C}$	$I_O = 5$ mA to 350 mA,	-19		-21	V
Innuit valtage pagulation	$V_1 = -23 \text{ V to } -35 \text{ V}$			12	80	
Input voltage regulation	$V_1 = -24 \text{ V to } -34 \text{ V}$			10	70	mV
Ripple rejection	V _I = -24 V to -34 V, f = 120 Hz	I _O = 100 mA, T _J = 0°C to 125°C	50			dB
	1= 120 m2	I _O = 300 mA	54	58		
Outro de colto de mandation	I _O = 5 mA to 500 mA	I _O = 5 mA to 500 mA		75	300	
Output voltage regulation	I _O = 5 mA to 350 mA			50		mV
Temperature coefficient of output voltage	I _O = 5 mA,	T _J = 0°C to 125°C		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz			500		μV
Dropout voltage				1.1		. V
Bias current	·			1.5	3.5	mA
Dia a summer de la constant de la co	$V_1 = -23 \text{ V to } -35 \text{ V},$	T _J = 0°C to 125°C			0.4	
Bias current change	$I_0 = 5 \text{ mA to } 350 \text{ mA},$	T _J = 0°C to 125°C			0.4	mA
Short-circuit output current	V ₁ = -30 V			140		mA
Peak output current				0.65		Α

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.



[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

μ**A79M00 SERIES NEGATIVE-VOLTAGE REGULATORS**

SLVS060A - JUNE 1976 - REVISED AUGUST 1995

electrical characteristics at specified virtual junction temperature, $V_I = -33 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	7507.00	NUDITIONOT	μ	79M24	С	UNIT
PARAMETER	IESI CC	ONDITIONST	MIN	TYP	MAX	UNII
			-23	-24	-25	
Output voltage‡	$V_I = -27 \text{ V to } -38 \text{ V},$ $T_J = 0^{\circ}\text{C to } 125^{\circ}\text{C}$	$I_O = 5$ mA to 350 mA,	-22.8		-25.2	V
Innuit valtana vanulatian	$V_{I} = -27 \text{ V to } -38 \text{ V}$			12	80	mV
Input voltage regulation	$V_1 = -28 \text{ V to } -38 \text{ V}$			12	70	1111
Ripple rejection	$V_{I} = -28 \text{ V to } -38 \text{ V},$ $f = 120 \text{ Hz}$	I _O = 100 mA, T _J = 0°C to 125°C	50			dB
	1 = 120 HZ	I _O = 300 mA	54	58		
Outrout valte as a secondation	I _O = 5 mA to 500 mA			75	300	
Output voltage regulation	$I_O = 5 \text{ mA to } 350 \text{ mA}$			50		mV
Temperature coefficient of output voltage	I _O = 5 mA,	T _J = 0°C to 125°C		-1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz			600		μV
Dropout voltage				1.1		V
Bias current				1.5	3.5	mA
Dia annual dia annual	$V_{I} = -27 \text{ V to } -38 \text{ V},$	T _J = 0°C to 125°C			0.4	
Bias current change	I _O = 5 mA to 350 mA	I _O = 5 mA to 350 mA, T _J = 0°C to 125°C			0.4	mA ·
Short-circuit output current	V _I = -30 V			140		mA
Peak output current				0.65		Α

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = -10 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEST SOURITIONS!	μ Α79M0	UNIT	
PARAMETER	TEST CONDITIONS†	MIN TYP	MAX	UNII
Output voltage‡		-5		٧
Input voltage regulation	V _I = -7 V to -25 V	7		
	$V_{\parallel} = -8 \text{ V to } -18 \text{ V}$	3		mV
Ripple rejection	$V_{\parallel} = -8 \text{ V to } -18 \text{ V}, I_{\bigcirc} = 300 \text{ mA}, f = 120 \text{ Hz}$	60		dB
Outro de contra de contra de diser	I _O = 5 mA to 500 mA	75		mV
Output voltage regulation	I _O = 5 mA to 350 mA	50		mv
Temperature coefficient of output voltage	I _O = 5 mA	-0.4		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	125		μV
Dropout voltage		1.1		V
Bias current		1		mA
Short-circuit output current	V _I = -30 V	140		mA
Peak output current		0.65		Α

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = -11 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEST CONDITIONS†	μ Α79M06Y				
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Output voltage‡			-6		V	
lanut valtaga vagulatian	$V_1 = -8 \text{ V to } -25 \text{ V}$		7		mV	
Input voltage regulation	$V_{I} = -9 \text{ V to } -19 \text{ V}$	3		mv		
Ripple rejection	$V_1 = -9 \text{ V to } -19 \text{ V}, I_0 = 300 \text{ mA}, f = 120 \text{ Hz}$		60		dB	
0.4.4.4	I _O = 5 mA to 500 mA		80		mV	
Output voltage regulation	IO = 5 mA to 350 mA		55		l mv	
Temperature coefficient of output voltage	I _O = 5 mA		-0.4		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz		150		μV	
Dropout voltage			1.1		V	
Bias current		-	1		mA	
Short-circuit output current	V ₁ = -30 V		140		mA	
Peak output current			0.65		Α	

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

[‡]This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_I = -19 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	μ Α79Μ08Υ	UNIT	
PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNII	
Output voltage‡		-8	٧.	
Innut voltage regulation	V _I = -10.5 V to -25 V	8		
Input voltage regulation	V ₁ = −11 V to −21 V	4	mV	
Ripple rejection	$V_I = -11.5 \text{ V to } -21.5 \text{ V}, I_O = 300 \text{ mA}, f = 120 \text{ Hz}$	59	dB	
0.4	I _O = 5 mA to 500 mA	90	mV	
Output voltage regulation	IO = 5 mA to 350 mA	60	IIIV	
Temperature coefficient of output voltage	I _O = 5 mA	-0.6	mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	200	μV	
Dropout voltage	I _O = 5 mA	1.1	٧	
Bias current		1	mA	
Short-circuit output current	V _I = -30 V	140	mA	
Peak output current		0.65	Α	

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = -19 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETEO	TEGT COMPLETONOT	μ Α79M12Y		
PARAMETER	TEST CONDITIONS†	MIN TYP MAX	UNIT	
Output voltage‡		-12	V	
Inn. A. velte as a seculation	V _I = -14.5 V to -30 V	9		
Input voltage regulation	$V_{I} = -15 \text{ V to } -25 \text{ V}$	5	m∨	
Ripple rejection	$V_I = -15V$ to $-25 V$, $I_O = 300$ mA, $f = 120$ Hz	60	dB	
Outro de calda que mandadia a	I _O = 5 mA to 500 mA	65		
Output voltage regulation	I _O = 5 mA to 350 mA	45	mV	
Temperature coefficient of output voltage	I _O = 5 mA	-0.8	mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	300	μV	
Dropout voltage		1.1	V	
Bias current		1.5	mA	
Short-circuit output current	V _I = -30 V	140	mA	
Peak output current		0.65	A	

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

electrical characteristics at specified virtual junction temperature, $V_1 = -23 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TEST COMPLETIONS	μ Α79M15Y			LINIT	
PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNIT	
Output voltage‡			-15		V	
landa da V _I = −17.5 V to −30 V	9 7			·		
Input voltage regulation	V _I = -18 V to -28 V			mV		
Ripple rejection	V _I = -18.5 V to -28.5 V, I _O = 300 mA, f = 120 Hz		59		dB	
Output voltage regulation	I _O = 5 mA to 500 mA		65			
	I _O = 5 mA to 350 mA		45		mV	
Temperature coefficient of output voltage	I _O = 5 mA		-1		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz		375		μV	
Dropout voltage	I _O = 5 mA		1.1		٧	
Bias current			1.5		mA	
Short-circuit output current	V _I = -30 V		140		mA	
Peak output current			0.65		Α	

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = -29 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

DADAMETED	TTOT COUNTY OUG	μ Α79M20Y		
PARAMETER	TEST CONDITIONS†	MIN TYP MAX	UNIT	
Output voltage‡		-20	V	
I	$V_{I} = -23 \text{ V to } -35 \text{ V}$	12	1	
Input voltage regulation	$V_{I} = -24 \text{ V to } -34 \text{ V}$	10	⊢ mV	
Ripple rejection	$V_1 = -24 \text{ V to } -34 \text{ V}, I_0 = 300 \text{ mA}, f = 120 \text{ Hz}$	58	dB	
Outro de contrata de la contrata del contrata de la contrata del contrata de la contrata del contrata de la contrata de la contrata de la contrata del contrata de la contrata del contrata de la contrata de la contrata del contrata de la contrata de la contrata de la contrata del contrata del contrata del contrata de la contrata del contrata del contrata del contra	I _O = 5 mA to 500 mA	75		
Output voltage regulation	I _O = 5 mA to 350 mA	50	mV	
Temperature coefficient of output voltage	I _O = 5 mA	-1	mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	500	μV	
Dropout voltage		1.1	V	
Bias current		1.5	mA	
Short-circuit output current	V _I = -30 V	140	mA	
Peak output current		0.65	A	

[†] Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

[‡] This specification applies only for dc power dissipation permitted by absolute maximum ratings.

μΑ79M00 SERIES NEGATIVE-VOLTAGE REGULATORS

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electrical characteristics at specified virtual junction temperature, $V_1 = -33 \text{ V}$, $I_O = 350 \text{ mA}$, $T_J = 25 ^{\circ}\text{C}$ (unless otherwise noted)

BARAMETER	TEST CONDITIONS!	μ Α79M24Y				
PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNIT	
Output voltage‡			-24		٧	
land Assellance and assellation	$V_{I} = -27 \text{ V to } -38 \text{ V}$		12			
Input voltage regulation	$V_1 = -28 \text{ V to } -38 \text{ V}$		12		mV	
Ripple rejection	$V_I = -28 \text{ V to } -38 \text{ V}, I_O = 300 \text{ mA}, f = 120 \text{ Hz}$		58		dB	
Output valtage regulation	I _O = 5 mA to 500 mA		75			
Output voltage regulation	I _O = 5 mA to 350 mA		50		mV	
Temperature coefficient of output voltage	$I_{O} = 5 \text{ mA},$ $T_{J} = 0^{\circ}\text{C to } 125^{\circ}\text{C}$		-1		mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz		600		μV	
Dropout voltage			1.1		V	
Bias current			1.5		mA	
Short-circuit output current	V _I = -30 V		140		mA	
Peak output current			0.65		Α	

T Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-µF capacitor across the input and a 1-µF capacitor across the output. ‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.

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SG2524, SG3524, SG3524Y REGULATING PULSE-WIDTH MODULATORS

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- Complete PWM Power Control Circuitry
- Uncommitted Outputs for Single-Ended or Push-Pull Applications
- Low Standby Current . . . 8 mA Typ
- Interchangeable With Silicon General SG2524 and SG3524

description

The SG2524 and SG3524 incorporate on single monolithic chips all the functions required in the construction of a regulating power supply, inverter, or switching regulator. They can also be used as

(TOP VIEW) 16 REF OUT IN-IN+ **1** 2 15 V_{CC} OSC OUT I 3 14 | EMIT 2 CURR LIM+ [4 13 COL 2 12 COL 1 CURR LIM- 1 5 11 EMIT 1 RT 1 6 CT 7 10 SHUTDOWN 9 COMP GND I

D OR N PACKAGE

the control element for high-power-output applications. The SG2524 and SG3524 were designed for switching regulators of either polarity, transformer-coupled dc-to-dc converters, transformerless voltage doublers, and polarity converter applications employing fixed-frequency, pulse-width-modulation (PWM) techniques. The complementary output allows either single-ended or push-pull application. Each device includes an on-chip regulator, error amplifier, programmable oscillator, pulse-steering flip-flop, two uncommitted pass transistors, a high-gain comparator, and current-limiting and shut-down circuitry.

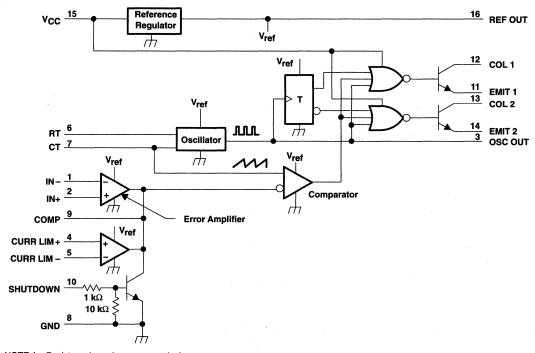
The SG2524 is characterized for operation from -25° C to 85°C, and the SG3524 is characterized for operation from 0°C to 70°C.

AVAILABLE OPTIONS

	INPUT	PACKAGED DEVICES		CHIP FORM	
TA	REGULATION MAX (mV)	SMALL OUTLINE (D)	PLASTIC DIP (N)	(Y)	
0°C to 70°C	30	SG3524D	SG3524N	SG3524Y	
-25°C to 85°C	20	SG2524D	SG2524N	·	

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functional block diagram

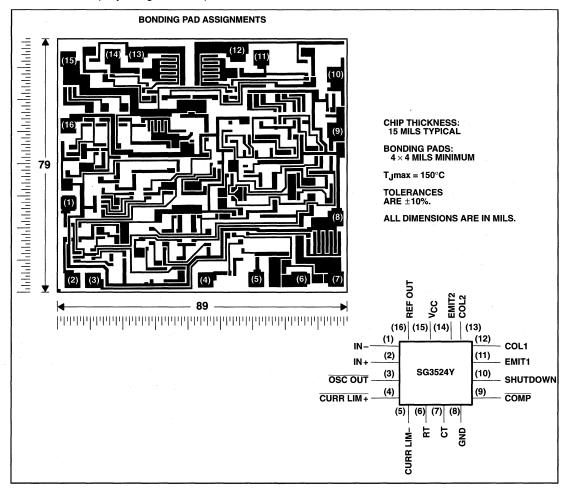


NOTE A. Resistor values shown are nominal.

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SG3524Y chip information

This chip, when properly assembled, displays characteristics similar to the SG3524. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



SG2524, SG3524, SG3524Y **REGULATING PULSE-WIDTH MODULATORS**

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Notes 1 and 2)	40 V
Collector output current, I _{CC}	
Reference output current, I _{O(ref)}	
Current through CT terminal	–5 mA
Continuous total power dissipation	
Operating free-air temperature range, T _A : SG2524	
SG3524	0°C to 70°C
Storage temperature range, T _{stq}	–65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	DERATE ABOVE T _A	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
N	1000 mW	9.2 mW/ °C	41°C	733 mW	595 mW
D	950 mW	7.6 mW/ °C	25°C	608 mW	494 mW

recommended operating conditions

	SG2	524	SG3524		UNIT
	MIN	MAX	MIN	MAX	UNH
Supply voltage, V _{CC}	8	40	8	40	V
Reference output current	0	50	. 0	50	mA
Current through CT terminal	-0.03	-2	-0.03	-2	mA
Timing resistor, R _T	1.8	100	1.8	100	kΩ
Timing capacitor, C _T	0.001	0.1	0.001	0.1	μF
Operating free-air temperature	-25	85	0	70	°C

^{2.} The reference regulator may be bypassed for operation from a fixed 5-V supply by connecting the V_{CC} and reference output pin both to the supply voltage. In this configuration, the maximum supply voltage is 6 V.

electrical characteristics over recommended operating free-air temperature range, V_{CC} = 20 V, f = 20 kHz (unless otherwise noted)

reference section

PARAMETER	TEST CONDITIONS†		SG2524			SG3524		5	G3524Y		UNIT
PANAMETEN	TEST CONDITIONS	MIN	TYP‡	MAX	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNII
Output voltage		4.8	5	5.2	4.6	5	5.4		5		V
Input regulation	V _{CC} = 8 V to 40 V		10	20		10	30		10		mV
Ripple rejection	f = 120 Hz		66			66			66		dB
Output regulation	I _O = 0 mA to 20 mA		20	50		20	50		20		mV
Output voltage change with temperature	T _A = MIN to MAX		0.3%	1%		0.3%	1%				
Short-circuit output current§	V _{ref} = 0		100			100			100		mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values, except for temperature coefficients, are at $T_A = 25$ °C

§ Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

$$\sigma = \sqrt{\frac{\sum_{n=1}^{N} (x_n - \overline{X})^2}{N-1}}$$

oscillator section

	PARAMETER		SG2524, SG3524			5	UNIT		
	PARAMETER	TEST CONDITIONS†	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNII
fosc	Oscillator frequency	$C_T = 0.001 \mu F$, $R_T = 2 k\Omega$		450			450		kHz
	Standard deviation of frequency§	All values of voltage, temperature, resistance, and capacitance constant		5%			5%		
A.f	Frequency change with voltage	V _{CC} = 8 V to 40 V, T _A = 25°C			1%			1%	
∆fosc	Frequency change with temperature	T _A = MIN to MAX			2%				
	Output amplitude at OSC OUT	T _A = 25°C		3.5			3.5		V
t _W	Output pulse duration (width) at OSC OUT	C _T = 0.01 μF, T _A = 25°C		0.5			0.5		μs

T For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] All typical values, except for temperature coefficients, are at T_A = 25°C

§ Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

$$x = \sqrt{\frac{\sum_{n=1}^{N} (x_n - \overline{X})^2}{N - 1}}$$

SG2524, SG3524, SG3524Y REGULATING PULSE-WIDTH MODULATORS

electrical characteristics over recommended operating free-air temperature range, V_{CC} = 20 V, f = 20 kHz (unless otherwise noted)

error amplifier section

	PARAMETER	TEGT COMPLETIONS		SG2524			SG3524		9	G3524Y		UNIT
	FANAMEIEN	TEST CONDITIONST	MIN	TYP‡	MAX	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNII
VIO	Input offset voltage	V _{IC} = 2.5 V		0.5	5		2	10		2		mV
lв	Input bias current	V _{IC} = 2.5 V		. 2	10		2	10		2		μА
	Open-loop voltage amplification		72	80		60	80			80		dB
VICR	Common-mode input voltage range	T _A = 25°C	1.8 to 3.4			1.8 to 3.4					~	٧
CMMR	Common-mode rejection ratio			70			70			70		dB
B ₁	Unity-gain bandwidth			3			3			3		MHz
	Output swing	T _A = 25°C	0.5		3.8	0.5		3.8	0.5		3.8	٧

T For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

output section

	PARAMETER	TEST CONDITIONS		534, SG3	524	S	G3524Y		
	PARAMETER	TEST CONDITIONST	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
V _{(BR)CE}	Collector-emitter breakdown voltage		- 40						٧
	Collector off-state current	V _{CE} = 40 V		0.01	50		0.01		μΑ
V _{sat}	Collector-emitter saturation voltage	IC = 50 mA		1	2		1		٧
V _O	Emitter output voltage	V _C = 20 V, I _E = -250 μA	17	18			18		٧
t _r	Turn-off voltage rise time	R _C = 2 kΩ		0.2			0.2		μs
tf	Turn-on voltage fall time	$R_C = 2 k\Omega$		0.1			0.1		μs

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

comparator section

	PARAMETER	TEST CONDITIONS†	SG2	534, SG3	524	5	G3524Y		LIAUT
	FARAWEICH	TEST CONDITIONS	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
	Maximum duty cycle, each output		45%						
\[\tilde{\pi}\]	Input threshold voltage at COMP	Zero duty cycle		1			1		· ·
VIT	Input threshold voltage at COMP	Maximum duty cycle		3.5			3.5		V
I _{IB}	Input bias current			-1			-1		μΑ

T For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

SG2524, SG3524, SG3524Y
REGULATING PULSE-WIDTH MODULATORS

[‡] All typical values, except for temperature coefficients, are at T_A = 25°C

[‡] All typical values, except for temperature coefficients, are at TA = 25°C

[‡] All typical values, except for temperature coefficients, are at T_A = 25°C

electrical characteristics over recommended operating free-air temperature range, V_{CC} = 20 V, f = 20 kHz (unless otherwise noted)

current limiting section

	PARAMETER	TEST CONDITIONS SO		SG2524		SG3524			SG3524Y			UNIT
	PARAMETER	1231 CONDITIONS	MIN	TYP†	MAX	MIN	TYP	MAX	MIN	түрт	MAX	UNII
			-1			-1						
VI	Input voltage range (either input)		to			to						V
			1			1						
V(SENSE)	Sense voltage at T _A = 25°C	$V_{(IN+)} - V_{(IN-)} \ge 50 \text{ mV},$	175	200	225	175	200	225	175	200	225	mV
	Temperature coefficient of sense voltage	V _(COMP) = 2 V		0.2			0.2			0.2		mV/°C

[†] All typical values, except for temperature coefficients, are at $T_A = 25$ °C.

total device

	PARAMETER TEST CONDITIONS	SG2	524, SG3	524	9	G3524Y		UNIT	
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	ONII
Ist	Standby current	V_{CC} = 40 V, IN-, CURR LIM+, C_T , GND, COMP, EMIT 1, EMIT 2 grounded IN+ at 2 V, All other inputs and outputs open		8	10		8		mA

[†] All typical values, except for temperature coefficients, are at T_A = 25°C.

PARAMETER MEASUREMENT INFORMATION

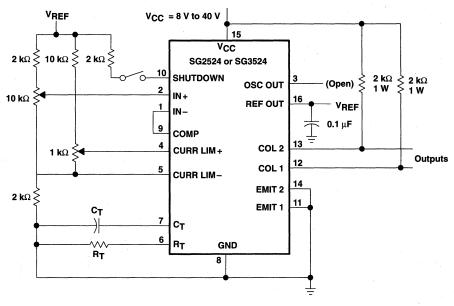


Figure 1. General Test Circuit

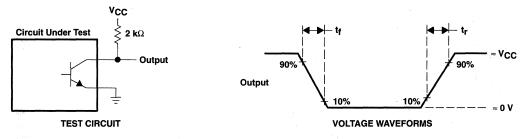
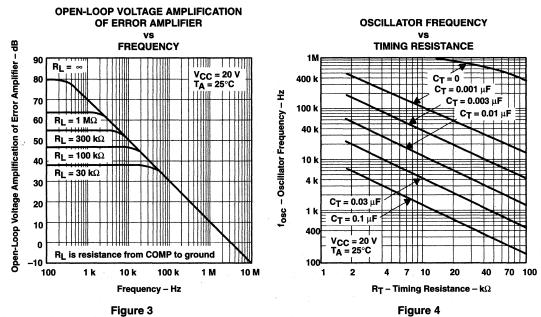


Figure 2. Switching Times

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TYPICAL CHARACTERISTICS





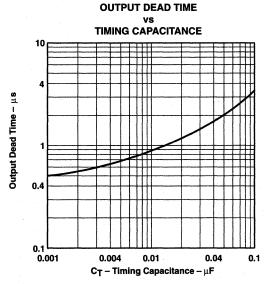


Figure 5

PRINCIPLES OF OPERATION[†]

The SG2524 is a fixed-frequency pulse-width-modulation voltage-regulator control circuit. The regulator operates at a fixed frequency that is programmed by one timing resistor, R_T, and one timing capacitor C_T. R_T establishes a constant charging current for C_T . This results in a linear voltage ramp at C_T , which is fed to the comparator providing linear control of the output pulse duration (width) by the error amplifier. The SG2524 contains an on-board 5-V regulator that serves as a reference as well as supplying the SG2524 internal regulator control circuitry. The internal reference voltage is divided externally by a resistor ladder network to provide a reference within the common-mode range of the error amplifier as shown in Figure 6, or an external reference may be used. The output is sensed by a second resistor divider network and the error signal is amplified. This voltage is then compared to the linear voltage ramp at C_T. The resulting modulated pulse out of the high-gain comparator is then steered to the appropriate output pass transistor (Q1 or Q2) by the pulse-steering flip-flop, which is synchronously toggled by the oscillator output. The oscillator output pulse also serves as a blanking pulse to ensure both outputs are never on simultaneously during the transition times. The duration of the blanking pulse is controlled by the value of C_T . The outputs may be applied in a push-pull configuration in which their frequency is half that of the base oscillator, or paralleled for single-ended applications in which the frequency is equal to that of the oscillator. The output of the error amplifier shares a common input to the comparator with the current-limiting and shut-down circuitry and can be overridden by signals from either of these inputs. This common point is also available externally and may be employed to control the gain of, to compensate the error amplifier, or to provide additional control to the regulator.

APPLICATION INFORMATION[†]

oscillator

The oscillator controls the frequency of the SG2524 and is programmed by R_T and C_T as shown in Figure 4.

$$f \approx \frac{1.30}{R_T C_T}$$

where R_T is in $k\Omega$ C_T is in μF

f is in kHz

Practical values of C_T fall between 0.001 and 0.1 μ F. Practical values of R_T fall between 1.8 and 100 $k\Omega$. This results in a frequency range typically from 130 Hz to 722 kHz.

blanking

The output pulse of the oscillator is used as a blanking pulse at the output. This pulse duration is controlled by the value of C_T as shown in Figure 5. If small values of C_T are required, the oscillator output pulse duration may still be maintained by applying a shunt capacitance from OSC OUT to ground.

synchronous operation

When an external clock is desired, a clock pulse of approximately 3 V can be applied directly to the oscillator output terminal. The impedance to ground at this point is approximately $2 \, k\Omega$. In this configuration, $R_T \, C_T$ must be selected for a clock period slightly greater than that of the external clock.

[†]Throughout these discussions, references to the SG2524 apply also to the SG3524.



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APPLICATION INFORMATION[†]

synchronous operation (continued)

If two or more SG2524 regulators are to be operated synchronously, all oscillator output terminals should be tied together. The oscillator programmed for the minimum clock period is the master from which all the other SG2524s operate. In this application, the C_{TRT} values of the slaved regulators must be set for a period approximately 10% longer than that of the master regulator. In addition, C_T (master) = 2 C_T (slave) to ensure that the master output pulse, which occurs first, has a longer pulse duration and subsequently resets the slave regulators.

voltage reference

The 5-V internal reference may be employed by use of an external resistor divider network to establish a reference common-mode voltage range (1.8 V to 3.4 V) within the error amplifiers as shown in Figure 6, or an external reference may be applied directly to the error amplifier. For operation from a fixed 5-V supply, the internal reference may be bypassed by applying the input voltage to both the V_{CC} and V_{REF} terminals. In this configuration, however, the input voltage is limited to a maximum of 6 V.

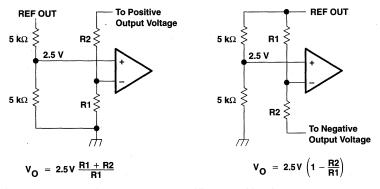


Figure 6. Error Amplifier Bias Circuits

error amplifier

The error amplifier is a differential-input transconductance amplifier. The output is available for dc gain control or ac phase compensation. The compensation node (COMP) is a high-impedance node ($R_L = 5 \text{ M}\Omega$). The gain of the amplifier is $A_V = (0.002 \ \Omega^{-1})R_I$ and can easily be reduced from a nominal 10,000 by an external shunt resistance from COMP to ground. Refer to Figure 3 for data.

compensation

COMP, as discussed above, is made available for compensation. Since most output filters introduce one or more additional poles at frequencies below 200 Hz, which is the pole of the uncompensated amplifier, introduction of a zero to cancel one of the output filter poles is desirable. This can best be accomplished with a series RC circuit from COMP to ground in the range of 50 kΩ and 0.001 μF. Other frequencies can be canceled by use of the formula $f \approx 1/RC$.

[†] Throughout these discussions, references to the SG2524 apply also to the SG3524.



APPLICATION INFORMATION[†]

shut-down circuitry

COMP can also be employed to introduce external control of the SG2524. Any circuit that can sink 200 µA can pull the compensation terminal to ground and thus disable the SG2524.

In addition to constant-current limiting, CURR LIM+ and CURR LIM- may also be used in transformer-coupled circuits to sense primary current and shorten an output pulse should transformer saturation occur. CURR LIMmay also be grounded to convert CURR LIM+ into an additional shut-down terminal.

current limiting

A current-limiting sense amplifier is provided in the SG2524. The current-limiting sense amplifier exhibits a threshold of $200 \,\mathrm{mV} \pm 25 \,\mathrm{mV}$ and must be applied in the ground line since the voltage range of the inputs is limited to 1 V to -1 V. Caution should be taken to ensure the -1 V limit is not exceeded by either input, otherwise damage to the device may result.

Foldback current limiting can be provided with the network shown in Figure 7. The current-limit schematic is shown in Figure 8.

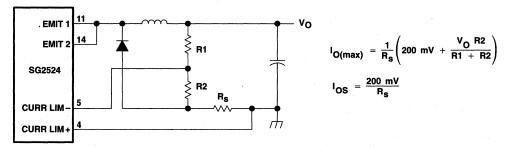


Figure 7. Foldback Current Limiting for Shorted Output Conditions

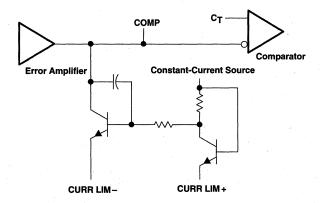


Figure 8. Current-Limit Schematic

[†] Throughout these discussions, references to the SG2524 apply also to the SG3524.



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APPLICATION INFORMATION[†]

output circuitry

The SG2524 contains two identical npn transistors, the collectors and emitters of which are uncommitted. Each transistor has antisaturation circuitry that limits the current through that transistor to a maximum of 100 mA for fast response.

general

There are a wide variety of output configurations possible when considering the application of the SG2524 as a voltage regulator control circuit. They can be segregated into three basic categories:

- 1. Capacitor-diode-coupled voltage multipliers
- 2. Inductor-capacitor-implemented single-ended circuits
- 3. Transformer-coupled circuits

Examples of these categories are shown in Figures 9, 10 and 11 respectively. Detailed diagrams of specific applications are shown in Figures 12 through 15.

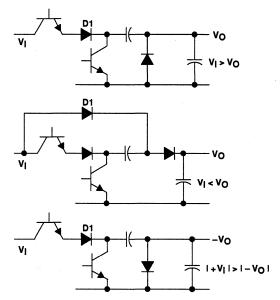


Figure 9. Capacitor-Diode-Coupled **Voltage-Multiplier Output Stages**

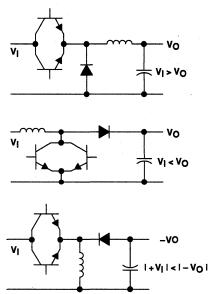


Figure 10. Single-Ended Inductor Circuit

[†] Throughout these discussions, references to the SG2524 apply also to the SG3524.



APPLICATION INFORMATION†

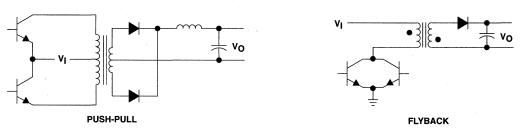


Figure 11. Transformer-Coupled Outputs

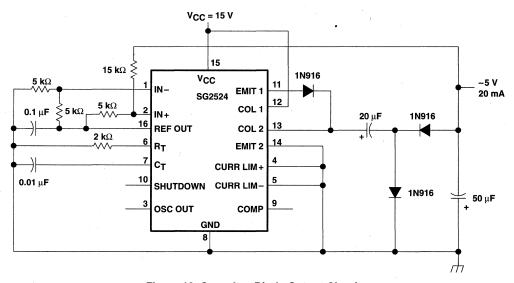


Figure 12. Capacitor-Diode Output Circuit

[†]Throughout these discussions, references to the SG2524 apply also to the SG3524.



APPLICATION INFORMATION†

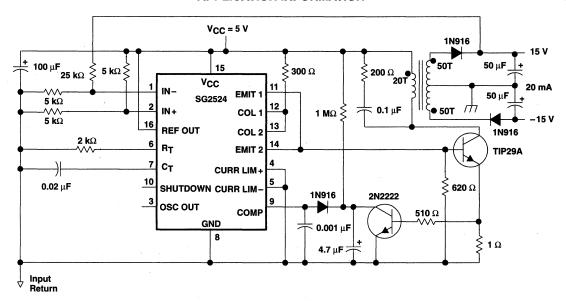


Figure 13. Flyback Converter Circuit

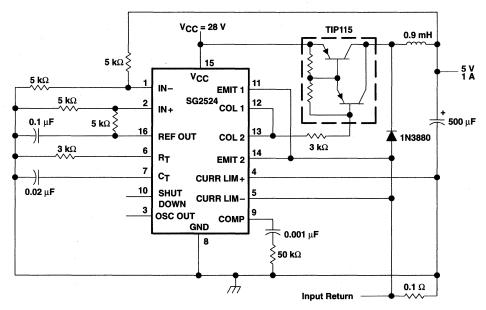


Figure 14. Single-Ended LC Circuit

[†]Throughout these discussions, references to the SG2524 apply also to the SG3524.



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APPLICATION INFORMATION†

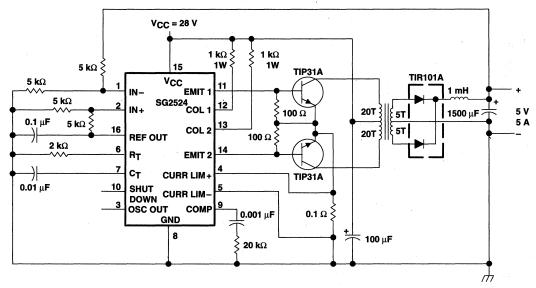


Figure 15. Push-Pull Transformer-Coupled Circuit

†Throughout these discussions, references to the SG2524 apply also to the SG3524.



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- Complete PWM Power Control Circuitry
- Uncommitted Outputs for 200-mA Sink or Source Current
- Output Control Selects Single-Ended or Push-Pull Operation
- Internal Circuitry Prohibits Double Pulse at Either Output
- Variable Dead Time Provides Control Over Total Range
- Internal Regulator Provides a Stable 5-V Reference Supply With 5% Tolerance
- Circuit Architecture Allows Easy Synchronization

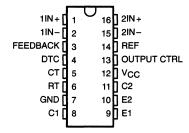
description

The TL494 incorporates on a single monolithic chip all the functions required in the construction of a pulse-width-modulation control circuit. Designed primarily for power supply control, this device offers the systems engineer the flexibility to tailor the power supply control circuitry to a specific application.

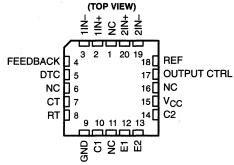
The TL494 contains two error amplifiers, an on-chip adjustable oscillator, a dead-time control (DTC) comparator, a pulse-steering control flip-flop, a 5-V, 5%-precision regulator, and output-control circuits.

The error amplifiers exhibit a common-mode voltage range from -0.3 V to $V_{\rm CC}-2$ V. The dead-time control comparator has a fixed offset that provides approximately 5% dead time. The on-chip oscillator may be bypassed by terminating RT to the reference output and providing a sawtooth input to CT, or it may drive the common circuits in synchronous multiple-rail power supplies.

TL494C, TL494I ... D, N, OR PW PACKAGE TL494M ... J PACKAGE (TOP VIEW)



TL494M ... FK PACKAGE



NC - No internal connection

FUNCTION TABLE

INPUT TO OUTPUT CTRL	OUTPUT FUNCTION
V _I = GND	Single-ended or parallel output
V _I = V _{ref}	Normal push-pull operation

AVAILABLE OPTIONS

		PAC	KAGED DEVICE	S		CHIP
TA	SURFACE MOUNT (D)†	CHIP CARRIER (FK)	CERAMIC DIP (J)	PLASTIC DIP (N)	SHRINK SMALL OUTLINE (PW)‡	FORM (Y)
0°C to 70°C	TL494CD			TL494CN	TL494CPW	TL494Y
-40°C to 85°C	TL494ID		-	TL494IN		_
-55°C to 125°C	— , — ,	TL494MFK	TL494MJ			

[†] The D package is available taped and reeled. Add R suffix to device type (e.g., TL494CDR).

[‡] The PW package is only available left-end taped and reeled.



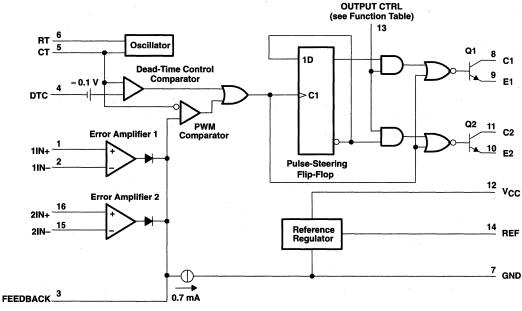
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description (continued)

The uncommitted output transistors provide either common-emitter or emitter-follower output capability. The TL494 provides for push-pull or single-ended output operation, which may be selected through the output-control function. The architecture of this device prohibits the possibility of either output being pulsed twice during push-pull operation.

The TL494C is characterized for operation from 0° C to 70° C. The TL494I is characterized for operation from -40° C to 85° C. The TL494M is characterized for operation from -55° C to 125° C.

functional block diagram



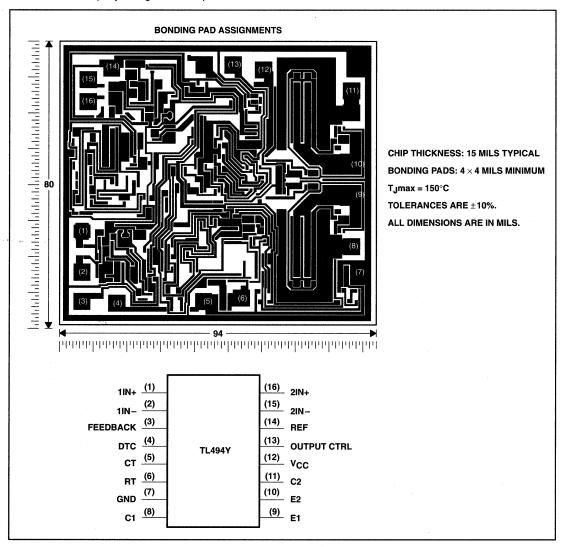
NOTE A. The terminal numbers indicated apply only to the D, J, N, and PW packages.

TL494C, TL494I, TL494M, TL494Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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TL494Y chip information

This chip, when properly assembled, display characteristics similar to the TL494C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



TL494C, TL494I, TL494M, TL494Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

	TL494C	TL494I	TL494M	UNIT
Supply voltage, V _{CC} (see Note 1)	41	41	41	٧
Amplifier input voltage, V _I	V _{CC} + 0.3	V _{CC} + 0.3	V _{CC} + 0.3	V
Collector output voltage, VO	41	41	41	V
Collector output current, IO	250	250	250	.mA
Continuous total power dissipation	See Dissipation Rating Table			
Operating free-air temperature range, TA	0 to 70	-40 to 85	-55 to 125	°C
Storage temperature range, T _{Stg}	-65 to 150	-65 to 150	-65 to 150	°C
Case temperature for 60 seconds, T _C : FK package			260	°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D, N, or PW package	260	260		°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: J package	_		300	°C

T Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values, except differential voltages, are with respect to the network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	DERATE ABOVE T _A	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	900 mW	7.6 mW/°C	25°C	558 mW	444 mW	
FK	1375 mW	11.0 mW/°C	25°C	880 mW	715 mW	275 mW
J	1375 mW	11.0 mW/°C	25°C	880 mW	715 mW	275 mW
N	1000 mW	9.2 mW/°C	41°C	733 mW	595 mW	
PW	700 mW	5.6 mW/°C	25°C .	448 mW		-

recommended operating conditions

	TL4	TL494C		TL494I		TL494M	
	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
Supply voltage, V _{CC}	. 7	40	7	40	7	40	V
Amplifier input voltage, V _I	0.3	V _{CC} -2	-0.3	V _{CC} -2	-0.3	V _{CC} -2	V
Collector output voltage, VO		40		40		40	٧
Collector output current (each transistor)		200		200		200	mA
Current into feedback terminal		0.3		0.3		0.3	mA
Oscillator frequency, fosc	1	300	1	300	1	300	kHz
Timing capacitor, C _T	0.47	10 000	0.47	10000	0.47	10000	nF
Timing resistor, R _T	1.8	500	1.8	500	1.8	500	kΩ
Operating free-air temperature, TA	0	70	-40	85	-55	125	°C

TL494C, TL494I, TL494M, TL494Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 15 V, f = 10 kHz (unless otherwise noted)

reference section

		TL4	TL494C, TL494I			TL494M		
PARAMETER	TEST CONDITIONST	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
Output voltage (REF)	I _O = 1 mA	4.75	5	5.25	4.75	5	5.25	V
Input regulation	V _{CC} = 7 V to 40 V		2	25		2	25	mV
Output regulation	I _O = 1 mA to 10 mA		1	15		1	15	mV
Output voltage change with temperature	ΔT _A = MIN to MAX		2	10		2	30*	mV/V
Short-circuit output current§	REF = 0 V		25			-25		mA

^{*} On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

oscillator section, $C_T = 0.01 \mu F$, $R_T = 12 k\Omega$ (see Figure 1)

		TL494C, TL494I	TL494M	T
PARAMETER	TEST CONDITIONST	MIN TYP# MAX	MIN TYP# MAX	UNIT
Frequency		10	10	kHz
Standard deviation of frequency [¶]	All values of V _{CC} , CT, RT, and T _A constant	100	100	Hz/kHz
Frequency change with voltage	V _{CC} = 7 V to 40 V, T _A = 25°C	1	1	Hz/kHz
Frequency change with temperature#	ΔT _A = MIN to MAX	10	10*	Hz/kHz

^{*} On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

‡ All typical values except for parameter changes with temperature are at T_A = 25°C.

Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

#Temperature coefficient of timing capacitor and timing resistor not taken into account.

 $\sigma = \sqrt{\frac{\sum_{n=1}^{N} (x_n - \overline{X})^2}{N-1}}$

error amplifier section (see Figure 2)

PARAMETER	TEST CON	TEST CONDITIONS			TL494C, TL494I TL494M			
			MIN	TYP‡	MAX			
Input offset voltage	VO (FEEDBACK) = 2.5 V			2	10	mV		
Input offset current	VO (FEEDBACK) = 2.5 V			25	250	nA		
Input bias current	VO (FEEDBACK) = 2.5 V	e e		0.2	1	μА		
Common-mode input voltage range	V _{CC} = 7 V to 40 V		-0.3 to V _{CC} -2			٧.		
Open-loop voltage amplification	$\Delta V_O = 3 \text{ V}, \qquad \text{R}_L = 2 \text{ k}\Omega,$	V _O = 0.5 V to 3.5 V	70	95		dB		
Unity-gain bandwidth	V _O = 0.5 V to 3.5 V,	R _L = 2 kΩ	·	800		kHz		
Common-mode rejection ratio	$\Delta V_O = 40 \text{ V}, T_A = 25^{\circ}\text{C}$		65	80		dB		
Output sink current (FEEDBACK)	$V_{ID} = -15 \text{ mV to } -5 \text{ V},$	V (FEEDBACK) = 0.7 V	0.3	0.7		mA		
Output source current (FEEDBACK)	V _{ID} = 15 mV to 5 V,	V (FEEDBACK) = 3.5 V	-2			mA		

[‡] All typical values except for parameter changes with temperature are at T_A = 25°C.

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

[‡] All typical values except for parameter changes with temperature are at T_A = 25°C.

[§] Duration of the short circuit should not exceed one second.

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

TL494C, TL494I, TL494M, TL494Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 15 V, f = 10 kHz, T_A = 25°C (unless otherwise noted)

reference section

			TL494Y			
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Output voltage (REF)	I _O = 1 mA		5		V	
Input regulation	V _{CC} = 7 V to 40 V		2		mV	
Output regulation	I _O = 1 mA to 10 mA		1		mV	
Short-circuit output current‡	REF = 0 V		25		mA	

oscillator section, C_T = 0.01 μ F, R_T = 12 $k\Omega$ (see Figure 1)

PARAMETER	TEGT COMPITIONS				
	TEST CONDITIONS	MIN	TYP†	MAX	ÜNIT
Frequency			10		kHz
Standard deviation of frequency§	All values of V _{CC} , CT, RT, and T _A constant		100		Hz/kHz
Frequency change with voltage	V _{CC} = 7 V to 40 V, T _A = 25°C		1		Hz/kHz

error amplifier section (see Figure 2)

		TL4		
PARAMETER	TEST CONDITIONS	MIN 7	rypt M	AX UNIT
Input offset voltage	V _O (FEEDBACK) = 2.5 V		2	mV
Input offset current	V _O (FEEDBACK) = 2.5 V		25	nA
Input bias current	V _O (FEEDBACK) = 2.5 V		0.2	μΑ
Open-loop voltage amplification	$\Delta V_{O} = 3 \text{ V}, \qquad R_{L} = 2 \text{ k}\Omega, \qquad V_{O} = 0.5 \text{ V to } 3.5 \text{ V}$		95	dB
Unity-gain bandwidth	$V_{O} = 0.5 \text{ V to } 3.5 \text{ V}, \qquad R_{L} = 2 \text{ k}\Omega$		800	kHz
Common-mode rejection ratio	$\Delta V_{O} = 40 \text{ V}, T_{A} = 25^{\circ}\text{C}$		80	dB
Output sink current (FEEDBACK)	$V_{ID} = -15 \text{ mV to} - 5 \text{ V}, \qquad V \text{ (FEEDBACK)} = 0.7 \text{ V}$		0.7	mA

[†] All typical values except for parameter changes with temperature are at T_A = 25°C.

$$\sqrt{\frac{\sum_{n=1}^{N} (x_n - \overline{X})^2}{N-1}}$$

[‡] Duration of the short circuit should not exceed one second.

[§] Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

TL494C, TL494I, TL494M, TL494Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 15 V, f = 10 kHz (unless otherwise noted)

output section

PARAMETER		TEST COND	TL49	UNIT			
				MIN	TYP†	MAX]
Collector off-state current		V _{CE} = 40 V,	V _{CC} = 40 V		2	100	μА
Emitter off-state current		$V_{CC} = V_{C} = 40 \text{ V},$	V _E = 0			-100	μА
Collector-emitter saturation voltage	Common emitter	VE = 0,	I _C = 200 mA		1.1	1.3	V
Collector-entitler saturation voltage	Emitter follower	$V_{O(C1 \text{ or } C2)} = 15 \text{ V},$	I _E = -200 mA		1.5	2.5	V
Output control input current		V _I = V _{ref}				3.5	mA

[†] All typical values except for temperature coefficient are at $T_A = 25$ °C.

dead-time control section (see Figure 1)

PARAMETER	TEST CONDITIONS	TL494C, TL494I TL494Y			TL494M			UNIT
		MIN	TYP†	MAX	MIN	TYP†	MAX	
Input bias current (DEAD-TIME CTRL)	V _I = 0 to 5.25 V		-2	-10		-2	-10	μА
Maximum duty cycle, each output	V_I (DEAD-TIME CTRL) = 0, C_T = 0.1 μ F, R_T = 12 $k\Omega$		45%			45%	50%*	
(0540 7045 0704)	Zero duty cycle		3	3.3		3	3.3	.,
Input threshold voltage (DEAD-TIME CTRL)	Maximum duty cycle	0			0*			V

^{*} On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

PWM comparator section (see Figure 1)

PARAMETER	TEST CONDITIONS	TL49	UNIT		
		MIN	TYP	MAX	1 .
Input threshold voltage (FEEDBACK)	Zero duty cycle		4	4.5	V
Input sink current (FEEDBACK)	V (FEEDBACK) = 0.7 V	0.3	0.7		mA

[†] All typical values except for temperature coefficient are at $T_A = 25$ °C.

total device

PARAMETER	TEST CONDITIONS	TL494C, TL494I TL494Y			TL494M			UNIT	
			MIN	TYP†	MAX	MIN	TYP	MAX	
Standby supply surrent	RT = V _{ref} ,	V _{CC} = 15 V		6	10		6	21	mA
Standby supply current All other inputs and outputs op		V _{CC} = 40 V		9	15		9	26	MA
Average supply current	V _I (DEAD-TIME CTRL) = 2 V,	See Figure 1		7.5			7.5		mA

[†] All typical values except for temperature coefficient are at T_A = 25°C.

 $^{^{\}dagger}$ All typical values except for temperature coefficient are at $T_A = 25^{\circ}C$.

TL494C, TL494I, TL494M, TL494Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 15 V, f = 10 kHz (unless otherwise noted) (continued)

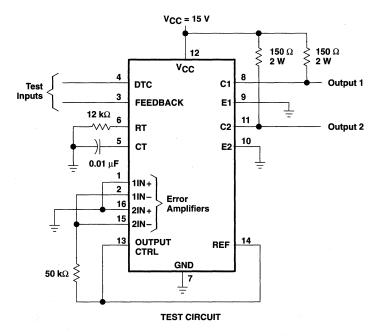
switching characteristics, $T_A = 25^{\circ}C$

PARAMETER	TEST CONDITION	TEST CONDITIONS			TL494C, TL494I TL494Y			TL494M			
		*	MIN	TYPT	MAX	MIN	TYPT	MAX			
Rise time	C	See Figure 3		100	200		100	200*	ns		
Fall time	Common-emitter configuration,			25	100		25	100*	ns		
Rise time	Emitter-follower configuration.	. See Figure 4		100	200		100	200*	ns		
Fall time	Emilier-follower comiguration,	See Figure 4		40	100		40	100*	ns		

^{*} On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

[†] All typical values except for temperature coefficient are at $T_A = 25$ °C.

PARAMETER MEASUREMENT INFORMATION



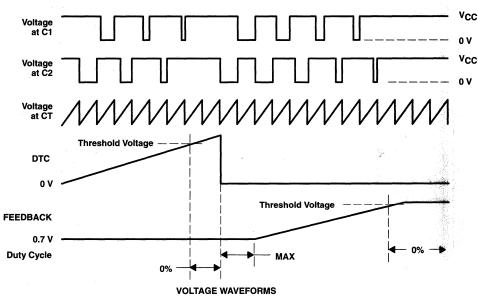


Figure 1. Operational Test Circuit and Waveforms

PARAMETER MEASUREMENT INFORMATION

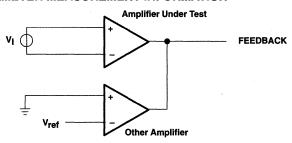


Figure 2. Amplifier Characteristics

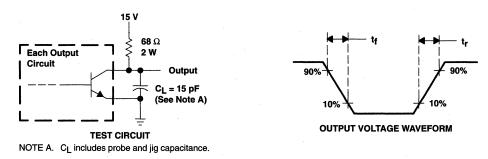


Figure 3. Common-Emitter Configuration

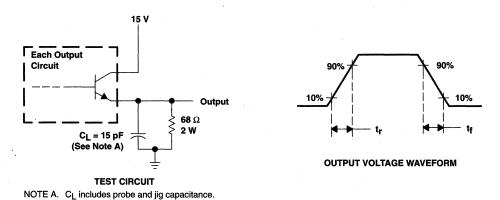


Figure 4. Emitter-Follower Configuration

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TYPICAL CHARACTERISTICS

OSCILLATOR FREQUENCY AND FREQUENCY VARIATION†

TIMING RESISTANCE

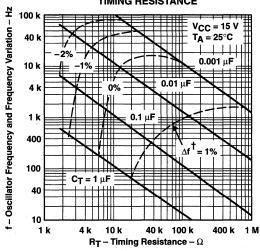


Figure 5

† Frequency variation (Δf) is the change in oscillator frequency that occurs over the full temperature range.

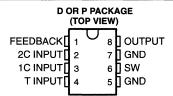
AMPLIFIER VOLTAGE AMPLIFICATION

vs FREQUENCY 100 V_{CC} = 15 V ΔV_O = 3 V 90 A - Amplifier Voltage Amplification - dB T_A = 25°C 80 70 60 50 40 30 20 10 0 10 100 1 k 10 k 100 k f - Frequency - Hz

Figure 6

SLVS012B - AUGUST 1978 - REVISED AUGUST 1995

- Internal Step-Up Switching Regulator
- Fixed 9-V Output
- Charges Battery Source During Transformer-Coupled-Input Operation
- Minimum External Components Required (1 Inductor, 1 Capacitor, 1 Diode)
- 1- or 2-Cell-Input Operation



Terminals 5 and 7 are connected together internally.

description

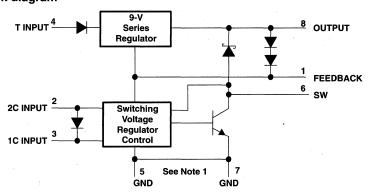
The TL496C power-supply control circuit is designed to provide a 9-V regulated supply from a variety of input sources. Operable from a 1- or 2-cell battery input, the TL496C performs as a switching regulator with the addition of a single inductor and filter capacitor. When ac coupled with a step-down transformer, the TL496C operates as a series regulator to maintain the regulated output voltage and, with the addition of a single catch diode, time shares to recharge the input batteries.

The design of the TL496C allows minimal supply current drain during standby operation (125 μ A typical). With most battery sources, this allows a constant bias to be maintained on the power supply. This makes power instantly available to the system, thus eliminating power-up sequencing problems.

AVAILABLE OPTIONS

	PACKAGED	DEVICES	CHIP
TA	SURFACE MOUNT (D)	PLASTIC DIP (P)	FORM (Y)
0°C to 70°C	TL496CD	TL496CP	TL496Y

functional block diagram

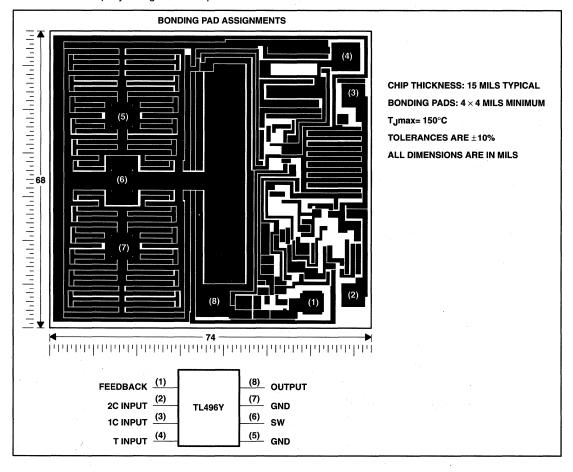


NOTE 1: Terminals 5 and 7, though connected together internally, must both be terminated to ground to ensure proper circuit operation.

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TL496Y chip information

This chip, when properly assembled, displays characteristics similar to the TL496C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



TL496C, TL496Y 9-VOLT POWER-SUPPLY CONTOLLERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Input voltage, V _I : 2C INPUT	
1C INPUT	
T INPUT	20 V
Output voltage, VO (SW)	
Diode reverse voltage (OUTPUT)	
Switch current (SW)	
Diode current (OUTPUT)	
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, T _A	0°C to 70°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	T _A = 70°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW
Р	1000 mW	8.0 mW/°C	640 mW

recommended operating conditions

	MIN	MAX	UNIT
Input voltage, one-cell operation (2C and 1C INPUTS to ground)	1.1	1.5	- V
Input voltage, two-cell operation (2C INPUT to ground)	2.3	3	٧
Input voltage, one-cell or two-cell operation (T INPUT to ground)	V _O +2	20	٧

TL496C, TL496Y 9-VOLT POWER-SUPPLY CONTROLLERS

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electrical characteristics over recommended operating conditions, $T_A = 25$ °C (unless otherwise noted)

series regulator section (T INPUT)

PARAMETER	TEST CONDITION	TEST CONDITIONS			MAX	UNIT
Dropout voltage	$V_{I} = 5 \text{ V}, \qquad I_{O} = -50 \text{ mA}$	$V_{I} = 5 \text{ V}, \qquad I_{O} = -50 \text{ mA}$			2	٧
Download and a state of the sta	V. 00 V	I _O = -50 μA	9.5	10.1	11.2	
	V _I = 20 V,	$I_{O} = -80 \text{ mA}$	9	10	11	v
Regulated output voltage	V _I = 20 V,	I _O = -50 μA	8.5	9	9.7	v
	FEEDBACK shorted to OUTPUT	IO = -80 mA	6.7	8.6	9.5	
Standby current, T INPUT	V _I = 20 V, OUTPUT = 12	: V			400	μΑ
Reverse current through T INPUT	$V_I = -1.5 \text{ V}$, 1 mA into OU	$V_I = -1.5 \text{ V}$, 1 mA into OUTPUT			-25	μΑ

output switch

PARAMETER		TEST CONDITIONS			TYP	MAX	UNIT
V _{CE(sat)}	Collector-emitter saturation voltage	800 mA into SW,	2C INPUT = 2.25 V		0.35	0.6	٧

diode (SW to OUTPUT)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
٧F	Forward voltage	I _F = 1.5 A		1.6	2.5	V
I _R	Reverse current through SW	SW at 0 V, 1 mA into OUTPUT			-20	μΑ

control section

PARAMETER	PARAMETER TEST CONDITIONS				UNIT
On-state current (2C INPUT)	FEEDBACK and OUTPUT = 0 V, 2C INPUT = 3 V		60	100	mA
Standby current (FEEDBACK)	FEEDBACK = 8.65 V, 2C INPUT and SW = 3 V			40	μΑ
Standby current (2C INPUT and SW)	FEEDBACK = 8.65 V, 2C INPUT and SW = 3 V			400	μΑ
Start-up current (current into SW to initiate cycle)	FEEDBACK, 2C INPUT, SW, and OUTPUT = 2.25 V	16			mA



APPLICATION INFORMATION

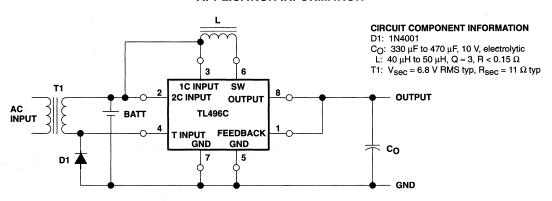


Figure 1. One-Cell Operation

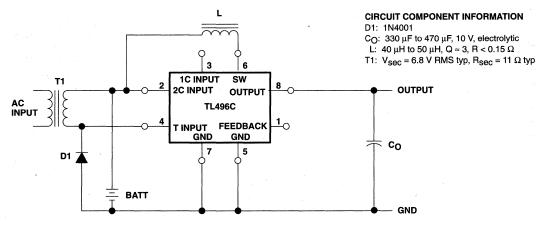


Figure 2. Two-Cell Operation

electrical characteristics for one- and two-cell input operations

PARA	METER	ONE-CELL OPERATION (see Figure 1)	TWO-CELL OPERATION (see Figure 2)
	No load	125 μΑ	125 μΑ
Input current	$R_L = 120 \Omega$	525 mA	405 mA
0	No ac input	7.2 V	8.6 V
Output voltage	With ac input	8.6 V	10 V
Output current capabil	ity	40 mA	80 mA
Efficiency		66%	66%
Battery life (AA NiCad) no load		60 days	166 days

TL496C, TL496Y 9-VOLT POWER-SUPPLY CONTROLLERS

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functional description

The TL496C is designed to operate from either a single-cell or two-cell battery source. To operate the device from a single cell (1.1 V to 1.5 V), the source must be connected to both inputs 1C INPUT and 2C INPUT as shown in Figure 1. For a two-cell operation (2.3 V to 3 V), the input is applied to 2C INPUT only and 1C INPUT is left open (see Figure 2).

battery operation

The TL496C operates as a switching regulator from a battery input. The cycle is initiated when a low-voltage condition is sensed by the internal feedback (the thresholds at terminals 1 and 8 are approximately 7.2 and 8.6 V respectively). An internal latch is set and the output transistor is turned on. This causes the current in the external inductor (L) to increase linearly until it reaches a peak value of approximately 1 A. When the peak current is sensed, the internal latch is reset and the output transistor is turned off. The energy developed in the inductor is then delivered to the output storage capacitor through the blocking diode. The latch remains in the off state until the feedback signal indicates the output voltage is again deficient.

transformer-coupled operation

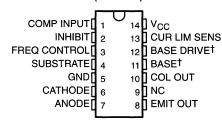
The TL496C operates on alternate half cycles of the ac input during transformer-coupled operation to first sustain the output voltage and second to recharge the batteries. The TL496C performs like a series regulator to supply charge to the output filter/storage capacitor during the first half cycle. The output voltage of the series regulator is slightly higher than that created by the switching circuit. This maintains the feedback voltage above the switching regulator control circuit threshold, effectively inhibiting the switching control circuitry. During the second half cycle, an external diode (1N4001) is used to clamp the negative-going end of the transformer secondary to ground, thus allowing the positive-going end (end connected to V+ side of battery) to pump a charge into the standby batteries.

TL497AC, TL497AI, TL497AY SWITCHING VOLTAGE REGULATORS

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- High Efficiency . . . 60% or Greater
- Output Current . . . 500 mA
- Input Current Limit Protection
- TTL-Compatible Inhibit
- Adjustable Output Voltage
- Input Regulation . . . 0.2% Typ
- Output Regulation . . . 0.4% Typ
- Soft Start-Up Capability

TL497AC, TL497AI . . . D, N, OR PW PACKAGE (TOP VIEW)



NC - No internal connection

description

The TL497AC and TL497AI incorporate on a single monolithic chip all the active functions required in the construction of switching voltage regulators. They can also be used as the control element to drive external components for high-power-output applications. The TL497AC and TL497AI were designed for ease of use in step-up, step-down, or voltage inversion applications requiring high efficiency.

The TL497AC and TL497Al are fixed-on-time variable-frequency switching-voltage-regulator control circuits. The switch-on time is programmed by a single external capacitor connected between FREQ CONTROL and GND. This capacitor, C_T , is charged by an internal constant-current generator to a predetermined threshold. The charging current and the threshold vary proportionally with V_{CC} . Thus, the switch-on time remains constant over the specified range of input voltage (4.5 V to 12 V). Typical on times for various values of C_T are as follows:

TIMING CAPACITOR, C _T (pF)	200	250	350	400	500	750	1000	1500	2000
ON TIME (μs)	19	22	26	32	44	56	80	120	. 180

The output voltage is controlled by an external resistor ladder network (R1 and R2 in Figures 1, 2, and 3) that provides a feedback voltage to the comparator input. This feedback voltage is compared to the reference voltage of 1.2 V (relative to SUBSTRATE) by the high-gain comparator. When the output voltage decays below the value required to maintain 1.2 V at the comparator input, the comparator enables the oscillator circuit, which charges and discharges C_T as described above. The internal pass transistor is driven on during the charging of C_T . The internal transistor may be used directly for switching currents up to 500 mA. Its collector and emitter are uncommitted, and it is current driven to allow operation from the positive supply voltage or ground. An internal Schottky diode matched to the current characteristics of the internal transistor is also available for blocking or commutating purposes. The TL497AC and TL497AI also have on-chip current-limit circuitry that senses the peak currents in the switching regulator and protects the inductor against saturation and the pass transistor against overstress. The current limit is adjustable and is programmed by a single sense resistor, R_{CL} , connected between V_{CC} and CUR LIM SENS. The current-limit circuitry is activated when 0.7 V is developed across R_{CL} . External gating is provided by the INHIBIT input. When the INHIBIT input is high, the output is turned off.

AVAILABLE OPTIONS

TA	PACKAGED DEVICES			CHIP
	SURFACE MOUNT (D)	PLASTIC DIP (N)	SHRINK SMALL OUTLINE (PW)	FORM (Y)
0°C to 70°C	TL497ACD	TL497ACN	TL497ACPW	TL497AY
-40°C to 85°C	TL497AID	TL497AIN	_	

TEXAS INSTRUMENTS

[†]BASE (11) and BASE DRIVE (12) are used for device testing only. They are not normally used in circuit applications of the device.

TL497AC, TL497AI, TL497AY SWITCHING VOLTAGE REGULATORS

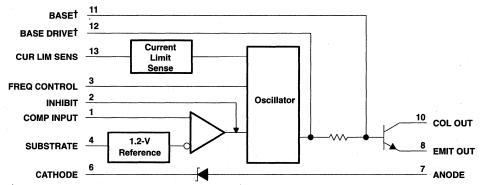
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description (continued)

Simplicity of design is a primary feature of the TL497AC and TL497AI. With only six external components (three resistors, two capacitors, and one inductor), the TL497AC and TL497AI operates in numerous voltage conversion applications (step-up, step-down, invert) with as much as 85% of the source power delivered to the load. The TL497AC and TL497AI replace the TL497 in all applications.

The TL497AC is characterized for operation from 0°C to 70°C, and the TL497AI is characterized for operation from –40°C to 85°C.

functional block diagram

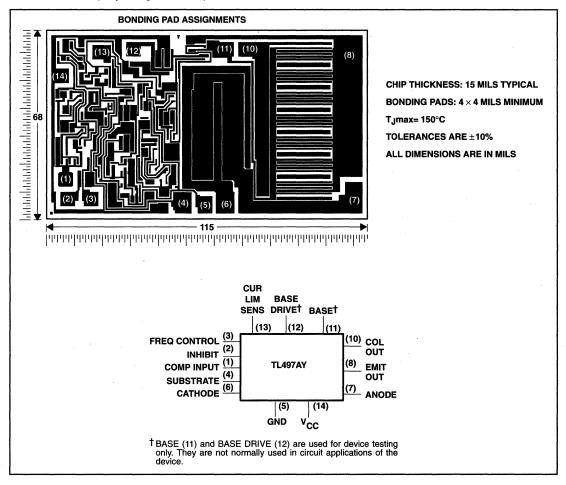


†BASE and BASE DRIVE are used for device testing only. They are not normally used in circuit applications of the device.

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TL497AY chip information

This chip, when properly assembled, displays characteristics similar to the TL497AC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



TL497AC, TL497AI, TL497AY SWITCHING VOLTAGE REGULATORS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)		15 V
Output voltage, VO		
Input voltage, V _I (COMP INPUT)		5 V
Input voltage, V _I (INHIBIT)		5 V
Diode reverse voltage		35 V
Power switch current		750 mA
Diode forward current		750 mA
Continuous total power dissipation	*	See Dissipation Rating Table
Operating free-air temperature range, TA:	TL497AC	0°C to 70°C
	TL497AI	40°C to 85°C
Storage temperature range, T _{sta}		65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) fron	n case for 60 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values except diode voltages are with respect to network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	DERATE ABOVE T _A	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	950 mW	7.6 mW/°C	25°C	608 mW	494 mW
N	1000 mW	9.2 mW/°C	41°C	733 mW	595 mW
PW	700 mW	5.6 mW/°C	25°C	448 mW	

recommended operating conditions

	figure and the second s			MIN	MAX	UNIT
Supply voltage,	Vcc			4.5	12	٧
High-level input	voltage, V _{IH,} INHIBIT			2.5		٧
Low-level input	voltage, V _{IL,} INHIBIT				0.8	٧
	Step-up configuration (see Figure 1)			V _I + 2	30	
Output voltage	Step-down configuration (see Figure 2	2)		V _{ref}	V _I – 1	٧
	Inverting regulator (see Figure 3)			-V _{ref}	-25	
Power switch cu	rrent				500	mA
Diode forward c	iode forward current				500	mA
Operating free-air temperature, T _A		TL497AC		0	70	ာ့
Operating nee-a	iii terriperature, rg	TL497AI		-40	85	

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electrical characteristics over recommended operating conditions, $V_{CC} = 6 \text{ V}$ (unless otherwise noted)

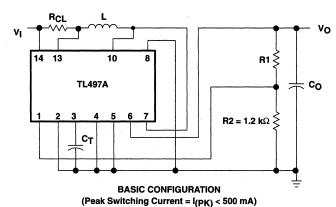
PARAMETER	TEST OF	NIDITIONS		T	L497AC		-	TL497AI		
PANAMEIEN	TEST CONDITIONS		T _A †	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
High-level input current, INHIBIT	V _{I(i)} = 5 V	V _{I(I)} = 5 V			0.8	1.5		0.8	1.5	mA
Low-level input current, INHIBIT	V _{I(I)} = 0 V		Full range		5	10		5	20	μΑ
Comparator reference voltage	V _I = 4.5 V to	6 V	Full range	1.08	1.2	1.32	1.14	1.2	1.26	V
Comparator input bias current	V _I = 6 V		Full range		40	100	_	40	100	μΑ
Switch on atota valtage	V _I = 4.5 V	I _O = 100 mA	25°C		0.13	0.2		0.13	0.2	V
Switch on-state voltage	V = 4.5 V	I _O = 500 mA	Full range			0.85			1	V
Switch off-state current	V. 45V	V= 20.V	25°C		10	50		10	50	
Switch on-state current	V _I = 4.5 V,	νO = 20 Λ	Full range			200			500	μΑ
Sense voltage, CUR LIM SENS	V _I = 6 V		25°C	0.45		1	0.45		1	٧
	I _O = 10 mA		Full range		0.75	0.85		0.75	0.95	
Diode forward voltage	I _O = 100 mA		Full range		0.9	1		0.9	1.1	٧
	I _O = 500 mA		Full range		1.33	1.55		1.33	1.75	
Diodo roverso veltage	I _O = 500 μA		Full range				30			V
Diode reverse voltage	ΙΟ = 200 μΑ		Full range	30						V
On state cumply current					11	14		11	14	A
On-state supply current			Full range			15			16	mA
Off state supply suggest			25°C		6	9		6	9	^
Off-state supply current			Full range			10		-	11	mA

[†] Full range for the TL497AC is 0°C to 70°C and full range for the TL497AI is -40°C to 85°C.

electrical characteristics over recommended operating conditions, V_{CC} = 6 V, T_A = 25°C (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TL497AY	UNIT	
PARAMETER	1EST CONDITIONS	MIN TYP MAX	UNIT	
High-level input current, INHIBIT	V _{I(I)} = 5 V	0.8	mA	
Low-level input current, INHIBIT	V _{I(I)} = 0 V	5	μА	
Comparator reference voltage	V _I = 4.5 V to 6 V	1.2	٧	
Comparator input bias current	V _I = 6 V	40	μА	
Switch on-state voltage	V _I = 4.5 V, I _O = 100 mA	0.13	V	
Switch off-state current	V _I = 4.5 V, V _O = 30 V	10	μА	
	I _O = 10 mA	0.75		
Diode forward voltage	I _O = 100 mA	0.9	v	
	I _O = 500 mA	1.33	1	
On-state supply current		11	mA	
Off-state supply current		6	mA	

[‡] All typical values are at $T_A = 25$ °C.

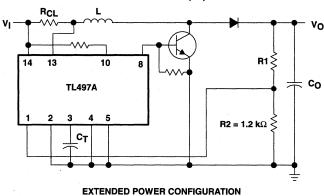


DESIGN EQUATIONS

- $I_{(PK)} = 2 I_{O} \max \left[\frac{V_{O}}{V_{I}} \right]$
- L (μ H) = $\frac{V_1}{I_{(PK)}}t_{on}$ (μ s)

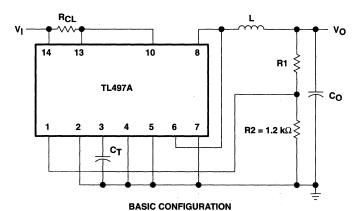
Choose L (50 to 500 μ H), calculate ton (25 to 150 μ s)

- $C_T(pF) \approx 12 t_{OR} (\mu s)$
- R1 = $(V_O 1.2) k\Omega$
- $\bullet \quad R_{CL} = \frac{0.5 \text{ V}}{I_{(PK)}}$ $\bullet \quad C_{O} (\mu F) \approx t_{On}(\mu S) \frac{\left[\frac{V_{I}}{V_{O}} \mid_{(PK)} + \mid_{O}\right]}{V_{ripple} (PK)}$



(using external transistor)

Figure 1. Positive Regulator, Step-Up Configurations

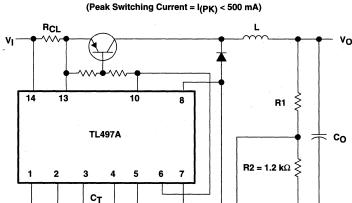


DESIGN EQUATIONS

- I_(PK) = 2 I_O max
- L (μ H) = $\frac{V_I V_O}{I_{(PK)}} t_{ON}(\mu s)$

Choose L (50 to 500 μ H), calculate ton (10 to 150 μs)

- $C_T(pF) \approx 12 t_{on}(\mu s)$
- R1 = $(V_{\Omega} 1.2) k\Omega$



EXTENDED POWER CONFIGURATION (using external transistor)

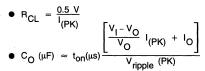
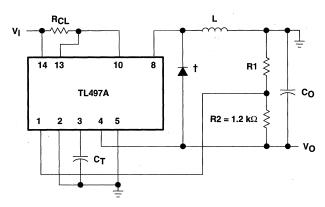
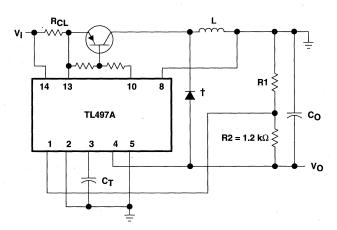


Figure 2. Positive Regulator, Step-Down Configurations



BASIC CONFIGURATION
(Peak Switching Current = I_(PK) < 500 mA)



DESIGN EQUATIONS

$$\bullet \ I_{(PK)} = 2 I_{O} \max \left[1 + \frac{|V_{O}|}{V_{I}} \right]$$

• L (
$$\mu$$
H) = $\frac{V_I}{I_{(PK)}} t_{on}(\mu s)$

Choose L (50 to 500 $\mu H),$ calculate t_{On} (10 to 150 $\mu s)$

•
$$C_T(pF) \approx 12 t_{on}(\mu s)$$

• R1 =
$$(|V_{\Omega}| - 1.2) k\Omega$$

$$\begin{array}{ll} \mathsf{R}_{\mathsf{CL}} &= \frac{0.5 \ \mathsf{V}}{^{\mathsf{I}}(\mathsf{PK})} \\ \bullet & \mathsf{C}_{\mathsf{O}} \ (\mu\mathsf{F}) \ \approx \ t_{\mathsf{on}}(\mu\mathsf{s}) \\ \end{array} \underbrace{\left[\frac{\mathsf{V}_{\mathsf{I}}}{|\mathsf{V}_{\mathsf{O}}|} \ ^{\mathsf{I}}(\mathsf{PK}) \ ^{\mathsf{H}} \ ^{\mathsf{I}}_{\mathsf{O}} \right]}_{\mathsf{V}_{\mathsf{ripple}}} \ ^{\mathsf{I}}(\mathsf{PK})}_{\mathsf{V}_{\mathsf{ripple}}} \end{array}$$

EXTENDED POWER CONFIGURATION

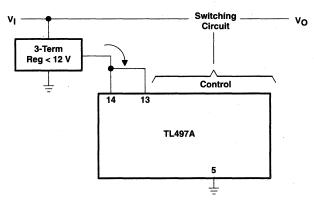
(using external transistor)

† Use external catch-diode, e.g., 1N4001, when building an inverting supply with the TL497A.

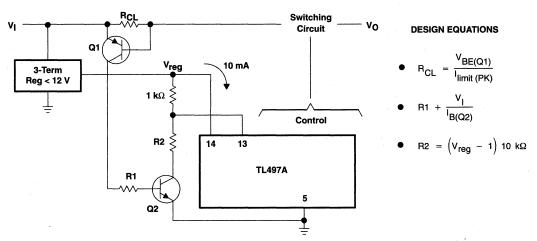
Figure 3. Inverting Applications

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APPLICATION INFORMATION



EXTENDED INPUT CONFIGURATION WITHOUT CURRENT LIMIT



CURRENT LIMIT FOR EXTENDED INPUT CONFIGURATION

Figure 4. Extended Input Voltage Range (V_I > 12 V)

TL499AC, TL499AY WIDE-RANGE POWER SUPPLY CONTROLLERS

SLVS029B - JANUARY 1984 - REVISED AUGUST 1995

- Internal Series-Pass and Step-Up Switching Regulator
- Output Adjustable From 2.9 V to 30 V
- 1-V to 10-V Input for Switching Regulator
- 4.5-V to 32-V Input for Series Regulator
- Externally-Controlled Switching Current
- No External Rectifier Required

SERIES IN1 1 8 OUTPUT REF 2 7 GND (PWR) SW REG IN2 3 6 SW IN SW CURRENT CTRL 4 5 GND

description

The TL499AC is a monolithic integrated circuit designed to provide a wide range of adjustable regulated supply voltages. The regulated output voltage is adjustable from 2.9 V to 30 V by adjusting two external resistors. When the TL499AC is ac-coupled to line power through a step-down transformer, it operates as a series dc voltage regulator to maintain the regulated output voltage. With the addition of a battery from 1.1 V to 10 V, an inductor, a filter capacitor, and two resistors, the TL499AC operates as a step-up switching regulator during an ac-line failure.

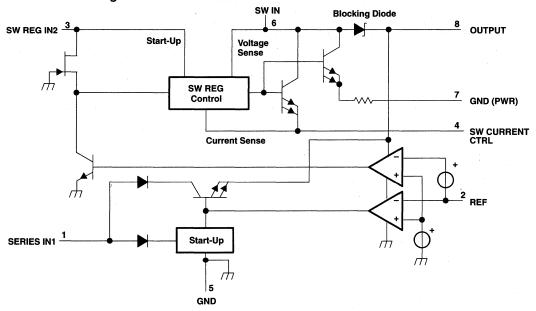
The adjustable regulated output voltage makes the TL499AC useful for a wide range of applications. Providing backup power during an ac-line failure makes the TL499AC extremely useful in microprocessor memory applications.

The TL499AC is designed for operation from -20°C to 85°C.

AVAILABLE OPTIONS

	PACKAGED	CHIP	
TA	SURFACE MOUNT (D)		FORM (Y)
-20°C to 85°C	TL499ACD	TL499ACP	TL499AY

functional block diagram



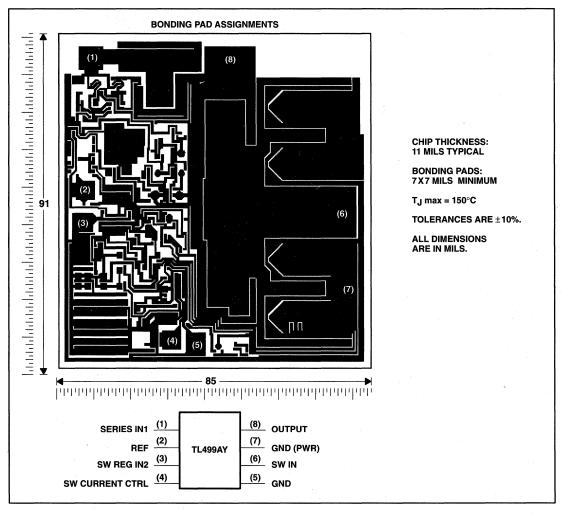
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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TL499AY chip information

This chip, when properly assembled, displays characteristics similar to the TL499AC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



TL499AC, TL499AY WIDE-RANGE POWER SUPPLY CONTROLLERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Output voltage, VO (see Note 1)		5 V
Input voltage, series regulator, V ₁ 1		5 V
Input voltage, switching regulator, V _I 2		0 V
Blocking diode reverse voltage		
Blocking diode forward current		1 A
Power switch current (SW IN)		1 A
Continuous total power dissipation	See Dissipation Rating Ta	able
Operating free-air temperature range, T _A	–20°C to 85	5°C
Storage temperature range, T _{sta}	65°C to 150	0°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 85°C POWER RATING
D	825 mW	6.6 mW/°C	429 mW
P	1000 mW	8 mW/°C	520 mW

recommended operating conditions

	MIN	NOM	MAX	UNIT
	2.9		30	V
1 1	4.5		32	V
	1.1		10	V
	1.2		28.9	٧
			100	mA
		-	500	mA
	150		1000	Ω
	100		470	μF
		0.1		μF
	50		150	μН
	-20		. 85	°C
		2.9 4.5 1.1 1.2 150 100	2.9 4.5 1.1 1.2 150 100 0.1	2.9 30 4.5 32 1.1 10 1.2 28.9 100 500 150 1000 100 470 0.1 50 150

NOTE 2: When operating temperature range is T_A ≤ 70°C, minimum V_O − V_I2 is ≥ 1.2 V. When operating temperature range is T_A ≤ 85°C, minimum $V_O - V_1 2$ is $\ge 1.9 \text{ V}$.



TL499AC, TL499AY WIDE-RANGE POWER SUPPLY CONTROLLERS

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electrical characteristics over recommended operating conditions (unless otherwise noted)

DADAUETE	5		TOT COMPLTION	in	TL499AC			UNIT
PARAMETE	:R		TEST CONDITIONS				MAX	UNIT
Voltage deviation (see Note 3)						20	30	mV/V
,	Switching regulator	$T_A = -20^{\circ}C$ to 7	70°C	1			1.2	V
Dropout voltage	Switching regulator	$T_A = -20^{\circ}C \text{ to } 8$	35°C	Talent year		•	1.9	V
	Series regulator	V _I 1 = 15 V,	I _O = 50 mA				1.8	V
Reference voltage (internal)		V _I 2 = 5 V,	V _O = 3 V,	i _O = 1 mA	1.2	1.26	1.32	٧
Reference voltage change with temperature		T _A = -20°C to 85°C				5	10	mV/V
Output regulation (of reference	voltage)	I _O = 1 mA to 50 mA				10	30	mV/V
	·	V _I 2 = 1.1 V, T _A = 25°C	V _O = 12 V,	$R_{CL} = 150 \Omega$,	10			
Output current (see Figure 1)	Switching regulator	V _I 2 = 1.5 V, T _A = 25°C	V _O = 15 V,	R_{CL} = 150 Ω ,	15			mA
		V _I 2 = 6 V, T _A = 25°C	V _O = 30 V,	R _{CL} = 150 Ω,	65	,		
	Series regulator	2					100	
Standby current	Switching regulator	V _I 2 = 3 V,	V _O = 9 V,	T _A = 25°C		15	80	μΑ
Standby current	Series regulator	V _I 1 = 15 V,	V _O = 9 V,	$R_{E}2 = 4.7 \text{ k}\Omega$		0.8	1.2	mA

NOTE 3: Voltage deviation is the output voltage differences that occurs in a change from series regulation to switching regulation.

voltage deviation = V_O (series reg) – (switching reg)

electrical characteristics over recommended operating conditions, $T_A = 25^{\circ}C$ (unless otherwise noted)

PARAMETE			TOT CONDITION	10	T	L499AY		UNIT
FARAMETER		1	TEST CONDITIONS				MAX	UNIT
Voltage deviation (see Note 3)						20	30	mV/V
	Curitabina regulator						1.2	٧
Dropout voltage	Switching regulator						1.9	V
	Series regulator	V _I 1 = 15 V,	I _O = 50 mA				1.8	V
Reference voltage (internal)		V _I 2 = 5 V,	V _O = 3 V,	I _O = 1 mA	1.2	1.26	1.32	٧
Reference voltage change with	temperature					5	10	mV/V
Output regulation (of reference	voltage)	$I_0 = 1 \text{ mA to } 50$	mA			10	30	mV/V
		V _I 2 = 1.1 V,	V _O = 12 V,	R _{CL} = 150 Ω	10			
0.1.1	Switching regulator	V _I 2 = 1.5 V,	V _O = 15 V,	R _{CL} = 150 Ω	15			
Output current (see Figure 1)		V _I 2 = 6 V,	V _O = 30 V,	R _{CL} = 150 Ω	65			mA
Series regulator							100	
Standburgunger Switching regulator		V _I 2 = 3 V,	V _O = 9 V			15	80	μА
Standby current	Series regulator	V _I 1 = 15 V,	V _O = 9 V,	$R_{E}2 = 4.7 \text{ k}\Omega$		0.8	1.2	mA.

NOTE 3: Voltage deviation is the output voltage differences that occurs in a change from series regulation to switching regulation.

voltage deviation = VO (series reg) - (switching reg)



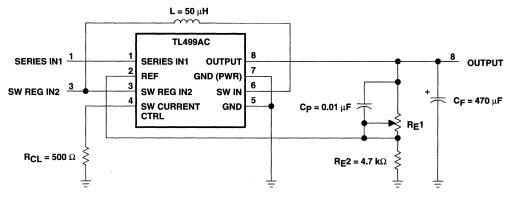


Figure 1. TL499AC Basic Configuration

Table 1. Maximum Output Current vs Input and Output Voltages for Step-Up Switching Regulator With R_{CL} = 150 Ω

OUTPUT			SWITC	HING REC	BULATOR IN	IPUT VOL	TAGE (SW	REG IN2	2) (V)		
VOLTAGE	1.1	1.2	1.3	1.5	1.7	2	2.5	3	5	6	9
(V)					OUTPUT (CURRENT	(mA)				
30				-						65	90
25									50	80	100
20	İ					20	25	30	80	100	100
15				15	20	30	45	55	100	100	100
12	10	15	20	25	30	40	55	70	100	100	100
10	15	20	25	30	35	45	65	80	100	100	
9	20	25	25	35	40	50	70	90	100	100	
6	30	35	40	45	55	75	95	100		en en en en en en en en en en en en en e	
5	35	40	45	55	70	85	100	100	Circuit of	Figure 1 ex	cept:
4.5	35	45	50	60	75	95	100	100†		L = 150 Ω	
3	55	65†	75†	95†	100†				CF	= 330 μF	
2.9	60†	70†	75†	100†	100†				CF	$\rho = 0.1 \mu F$	

[†] The difference between the output and input voltage for these combinations is greater than the minimum output-to-input differential voltage specification at 70°C (1.2 V), but less than the minimum at 85°C (1.9 V).

Table 2. Maximum Output Current vs Input and Output Voltages for Step-Up Switching Regulator With R_{CL} = 200 Ω

OUTPUT	1		SWITC	HING REC	GULATOR	NPUT VOL	TAGE (SW	REG IN2)	(V)		
VOLTAGE	1.1	1.2	1.3	1.5	1.7	2	2.5	3	5	6	. 9
(V)	OUTPUT CURRENT (mA)										
30										50	100
25									50	70	100
20						15	25	30	70	90	100
15				10	15	25	35	45	90	100	100
12	10	10	15	20	25	35	45	60	100	100	100
10	15	20	20	25	30	40	55	70	100	100	
9	20	20	25	30	35	45	60	80	100		
6	25	30	35	45	50	65	90	100			
5	30	35	40	. 55	60	75	100	100	Circuit of	Figure 1 ex	cept:
4.5	35	40	45	55	65	85	100	100†	RC	L = 200 Ω	
3	50	55†	65†	80†	90†				CF	= 330 μF	
2.9	50†	60†	65†	85†	100†				CF	= 0.1 μF	

[†] The difference between the output and input voltage for these combinations is greater than the minimum output-to-input differential voltage specification at 70°C (1.2 V), but less than the minimum at 85°C (1.9 V).

Table 3. Maximum Output Current vs Input and Output Voltages for Step-Up Switching Regulator With R_{CL} = 300 Ω

OUTPUT			SWITC	HING REG	ULATOR IN	IPUT VOLT	TAGE (SW	REG IN2)	(V)		
VOLTAGE	1.1	1.2	1.3	1.5	1.7	2	2.5	3	5	6	9
(v)					OUTPUT (URRENT	(mA)				
30										40	70
25									40	55	100
20						10	15	20	55	70	100
15				10	10	20	30	35	75 /	95	100
12	10	10	10	15	20	25	35	45	95	100	100
10	15	15	15	20	25	30	45	55	100	100	
9	15	15	20	25	30	35	50	60	100	100	
6	25	25	30	35	45	55	70	90			
5	30	30	35	45	50	65	85	100	Circuit of	Figure 1 ex	cept:
4.5	. 30	35	40	45	55	70	95	100†	RC	L = 300 Ω	
3	45	50†	55†	70†	90†				CF	$= 330 \mu F$	
2.9	45†	50†	60†	75†	95†				CF	= 0.1 μF	

[†] The difference between the output and input voltage for these combinations is greater than the minimum output-to-input differential voltage specification at 70°C (1.2 V), but less than the minimum at 85°C (1.9 V).

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APPLICATION INFORMATION

Table 4. Maximum Output Current vs Input and Output Voltages for Step-Up Switching Regulator With R_{CL} = 510 Ω

OUTPUT			SWITC	HING REG	ULATOR IN	IPUT VOL	TAGE (SW	REG IN2)	(V)		
VOLTAGE	1.1	1.2	1.3	1.5	1.7	2	2.5	3	5	6	9
(V)					OUTPUT (URRENT	(mA)				
30										30	50
25									25	40	75
20	İ								40	55	90
15							15	20	55	70	100
12					10	15	25	35	65	80	100
10				10	20	25	30	40	70	85	
9	10	10	10	15	20	25	35	45	75	100	
6	15	20	20	25	30	35	50	60			
5	20	20	25	30	35	45	55	70	Circuit of	Figure 1 ex	cept:
4.5	20	25	30	35	40	50	65	90†	RC	L = 510 Ω	
3	35	35†	40†	50†	75†				CF	= 330 μF	
2.9	35†	35†	40†	55†	80†				CF	= 0.1 μF	

[†] The difference between the output and input voltage for these combinations is greater than the minimum output-to-input differential voltage specification at 70°C (1.2 V), but less than the minimum at 85°C (1.9 V).

Table 5. Maximum Output Current vs Input and Output Voltages for Step-Up Switching Regulator With R_{CL} = 1 k Ω

OUTPUT			SWITC	HING REG	ULATOR IN	PUT VOLT	AGE (SW	REG IN2)	(V)		
VOLTAGE	1.1	1.2	1.3	1.5	1.7	2	2.5	3	5	6	9
(V)	OUTPUT CURRENT (mA)										
30			-								35
25										35	50
20										35	60
15								10	30	45	65
12								20	40	45	85
10							15	25	40	55	
9				10	10	15	25	30	45	60	
6	10	10	10	15	20	20	30	35			
5	10	10	15	20	20	25	35	40	Circuit of F	igure 1 exe	cept:
4.5	15	15	15	20	25	30	40	45†	RC	L = 1 kΩ	
3	20	25†	25†	30†	35†				CF	= 330 μF	
2.9	20†	25†	25†	30†	45†				CP	= 0.1 μF	

[†] The difference between the output and input voltage for these combinations is greater than the minimum output-to-input differential voltage specification at 70°C (1.2 V), but less than the minimum at 85°C (1.9 V).



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- Complete PWM Power Control Circuitry
- Uncommitted Outputs for 200-mA Sink or Source Current
- Output Control Selects Single-Ended or Push-Pull Operation
- Internal Circuitry Prohibits Double Pulse at Either Output
- Variable Dead Time Provides Control Over Total Range
- Internal Regulator Provides a Stable 5-V Reference Supply Trimmed to 1%
- Circuit Architecture Allows Easy Synchronization
- Undervoltage Lockout for Low V_{CC} Conditions

description

The TL594 incorporates on a single monolithic chip all the functions required in the construction

of a pulse-width-modulation control circuit. Designed primarily for power supply control, these devices offer the systems engineer the flexibility to tailor the power supply control circuitry to a specific application.

The TL594 contains two error amplifiers, an on-chip adjustable oscillator, a dead-time control (DTC) comparator, a pulse-steering control flip-flop, a 5-V regulator with a precision of 1%, an undervoltage lockout control circuit, and output control circuitry.

The error amplifiers exhibit a common-mode voltage range from $-0.3 \,\mathrm{V}$ to $\mathrm{V}_{\mathrm{CC}} - 2 \,\mathrm{V}$. The DTC comparator has a fixed offset that provides approximately 5% dead time. The on-chip oscillator may be bypassed by terminating RT to the reference output and providing a sawtooth input to CT, or it may be used to drive the common circuitry in synchronous multiple-rail power supplies.

The uncommitted output transistors provide either common-emitter or emitter-follower output capability. Each device provides for push-pull or single-ended output operation with selection by means of the output-control function. The architecture of these devices prohibits the possibility of either output being pulsed twice during push-pull operation. The undervoltage lockout control circuit locks the outputs off until the internal circuitry is operational.

The TL594C is characterized for operation from 0° C to 70° C. The TL594I is characterized for operation from -40° C to 85° C.

D OR N PACKAGE (TOP VIEW) 16 1 2IN+ 1IN+ 1IN-[15 1 2IN-2 14 REF FEEDBACK [DTC [13 OUTPUT CTRL СТ Г 5 12 1 VCC RT 11 T C2 6 GND [10 E2 E1 C.

FUNCTION TABLE

INPUT OUTPUT CTRL	OUTPUT FUNCTION
$V_{I} = 0$ $V_{I} = V_{ref}$	Single-ended or parallel output Normal push-pull operation

AVAILABLE OPTIONS

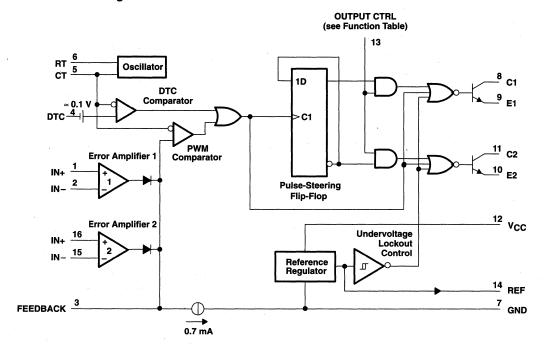
	PACKAGED I	CHIP FORM	
T _A	SMALL OUTLINE† (D)	PLASTIC DIP (N)	(Y)
0°C to 70°C	TL594CD	TL594CN	TL594Y
-40°C to 85°C	TL594ID	TL594IN	115941

[†] The D package is available taped and reeled. Add "R" suffix to device type (e.g., TL594CDR).



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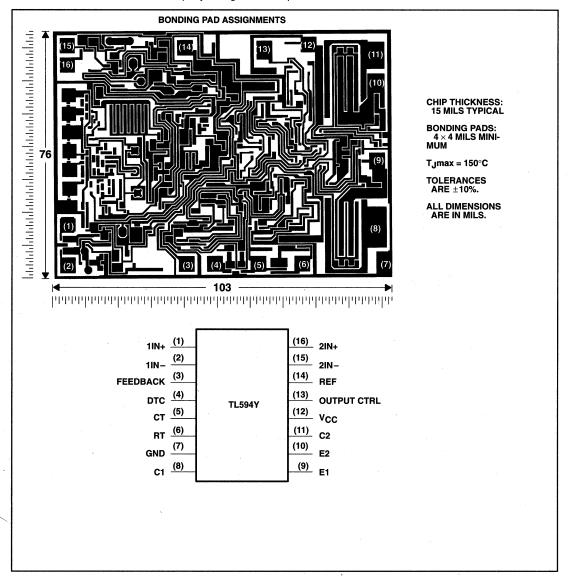
functional block diagram



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TL594Y chip information

This chip, when properly assembled, displays characteristics similar to the TL594C (see electrical tables). Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

	TL594C	TL594I	UNIT
Supply voltage, V _{CC} (see Note 1)	41	41	, V
Amplifier input voltage	V _{CC} +0.3	V _{CC} +0.3	V
Collector output voltage	41	41	V
Collector output current	250	250	mA
Continuous total dissipation	See Dis	sipation Rating Ta	ble
Operating free-air temperature range, TA	0 to 70	-40 to 85	°C
Storage temperature range, T _{Stg}	-65 to 150	-65 to 150	°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260	260	°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values, except differential voltages, are with respect to the network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	$T_A \le 25^{\circ}C$ POWER RATING	DERATING FACTOR	DERATE ABOVE T _A	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	950 mW	7.6 mW/°C	25°C	608 mW	494 mW
N.	1000 mW	9.2 mW/°C	41°C	733 mW	595 mW

recommended operating conditions

	TL59	94C	TL5	941	
	MIN	MAX	MIN	MAX	UNIT
Supply voltage, V _{CC}	7	40	7	40	V
Amplifier input voltage, V ₁	-0.3	V _{CC} -2	-0.3	V _{CC} -2	V
Collector output voltage, VO		40		40	V
Collector output current (each transistor)		200		200	mA
Current into feedback terminal		0.3		0.3	mA
Timing capacitor, C _T	0.47	10000	0.47	10 000	nF
Timing resistor, R _T	1.8	500	1.8	500	kΩ
Oscillator frequency, f _{OSC}	1	300	1	300	kHz
Operating free-air temperature, T _A	Ō	70	-40	85	°C

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electrical characteristics over recommended operating conditions, V_{CC} = 15 V, (unless otherwise noted)

reference section

PARAMETER	TEST SOUR	TEST CONDITIONS†			941	UNIT
PARAMETER	IESI CONDI				MAX	
Output voltage (REF)	I _O = 1 mA,	T _A = 25°C	4.95	5	5.05	V
Input regulation	$V_{CC} = 7 \text{ V to } 40 \text{ V},$	T _A = 25°C		2	25	mV
Output regulation	$I_0 = 1$ to 10 mA,	T _A = 25°C		14	35	mV
Output voltage change with temperature	$\Delta T_A = MIN \text{ to MAX}$			2	10	mV/V
Short-circuit output current§	V _{ref} = 0		10	35	50	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

amplifier section (see Figure 1)

DADAMETED		TEST CONDITIONS				941	UNIT
PARAMETER	15	ST CONDITION:	•	MIN	TYPT	MAX	UNIT
Input offset voltage, error amplifier	FEEDBACK = 2.5 V				2	10	mV
Input offset current	FEEDBACK = 2.5 V				25	250	nA
Input bias current	FEEDBACK = 2.5 V				0.2	1	μΑ
Common-mode input voltage range, error amplifier	V _{CC} = 7 V to 40 V			0.3 to V _{CC} -2	2		٧
Open-loop voltage amplification, error amplifier	$\Delta V_{O} = 3 V$,	R _L = 2 kΩ,	V _O = 0.5 V to 3.5 V	70	95		dB
Unity-gain bandwidth	$V_O = 0.5 \text{ V to } 3.5 \text{ V},$	R _L = 2 kΩ			800		kHz
Common-mode rejection ratio, error amplifier	V _{CC} = 40 V,	T _A = 25°C		65	80		dB
Output sink current, FEEDBACK	$V_{ID} = -15 \text{ mV to } -5 \text{ V},$	FEEDBACK = (0.5 V	0.3	0.7		mA
Output source current, FEEDBACK	$V_{ID} = 15 \text{ mV to 5 V},$	FEEDBACK = 3	3.5 V	-2			mA

[†] All typical values except for parameter changes with temperature are at T_A = 25°C.

oscillator section, $C_T = 0.01 \mu F$, $R_T = 12 k\Omega$ (see Figure 2)

PARAMETER	TEST SOURITIONS!	TL5	941	UNIT	
PARAMETER	TEST CONDITIONS†	MIN	TYP‡	MAX	CIALL
Frequency			10		kHz
Standard deviation of frequency§	All values of VCC, CT, RT, and TA constant		100		Hz/kHz
Frequency change with voltage	V _{CC} = 7 V to 40 V, T _A = 25°C		1		Hz/kHz
Frequency change with temperature¶	$\Delta T_A = MIN \text{ to MAX}$			50	Hz/kHz

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

 \P Temperature coefficient of timing capacitor and timing resistor not taken into account.

or =
$$\sqrt{\frac{\sum_{n=1}^{N} (x_n - \overline{X})^2}{N-1}}$$

 $[\]ddagger$ All typical values except for parameter changes with temperature are at $T_A = 25$ °C.

[§] Duration of the short circuit should not exceed one second.

[‡] All typical values except for parameter changes with temperature are at $T_A = 25$ °C.

[§] Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 15 V, (unless otherwise noted)

dead-time control section (see Figure 2)

DARAMETER	TEGT COMPLETIONS	TL5	TL594C, TL594I			
PARAMETER	TEST CONDITIONS	MIN	TYP	94I MAX -10	UNIT	
Input bias current	V _I = 0 to 5.25 V		-2	-10	μΑ	
Maximum duty cycle, each output	DTC = 0 V	0.45				
Input threshold voltage	Zero duty cycle		3	3.3	V	
I input threshold voltage	Maximum duty cycle	0			v	

[†] All typical values except for parameter changes with temperature are at TA = 25°C.

output section

PARAMETER		TEST CON	IDITIONS	TL594C, TL594I			UNIT
PARAMETER		IEST CON	IDITIONS	MIN	TYP†	MAX	UNII
		$V_C = 40 \text{ V}, V_E = 0 \text{ V},$	V _{CC} = 40 V		2	100	
ollector off-state current mitter off-state current		DTC and OUTPUT CTF V _C = 15 V, V _{CC} = 1 to 3 V	RL = 0 V, V _E = 0 V,		4	200	μΑ
Emitter off-state current		$V_{CC} = V_{C} = 40 \text{ V},$	VE = 0			-100	μΑ
Callantan amittan anti-matian valtage	Common emitter	V _E = 0,	I _C = 200 mA		1.1	1.3	V
Collector-emitter saturation voltage	Emitter follower	V _C = 15 V,	I _E = -200 mA		1.5	2.5	v .
Output control input current		V _I = V _{ref}				3.5	mA

[†] All typical values except for parameter changes with temperature are at $T_A = 25$ °C.

pwm comparator section (see Figure 2)

PARAMETER	TEST CONDITIONS	TL59	94C, TL5	941	UNIT
PARAMETER	TEST CONDITIONS	MIN	MIN TYPT MAX	וואט	
Input threshold voltage, FEEDBACK	Zero duty cycle		4	4.5	V
Input sink current, FEEDBACK	FEEDBACK = 0.5 V	0.3	0.7		mA

[†] All typical values except for parameter changes with temperature are at T_A = 25°C.

undervoltage lockout section (see Figure 2)

PARAMETER		TEST CONDITIONS†	TL594C,	TL594C, TL594I	
PARAMETER Threshold voltage	TEST CONDITIONS!	MAX	UNIT		
Throphold voltage	T _A = 25°C		, . 6	.,	
i nresnoid voitage		$\Delta T_A = MIN \text{ to MAX}$	3.5	6.9	V
Hysteresis [‡]			100		mV ·

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

total device (see Figure 2)

DADAMETED	TEST CONDI	FIONE	TL5	TL594C, TL594I		
PARAMETER	TEST CONDIT	IIUNS	MIN	TYP	MAX 15 18	UNIT
Chandlessands	RT at V _{ref} ,	V _{CC} = 15 V		9	. 15	A
Standby supply current	All other inputs and outputs open	V _{CC} = 40 V		11	18	mA
Average supply current	DTC = 2 V,	See Figure 2		12.4		mA

[†] All typical values except for parameter changes with temperature are at T_A = 25°C.

[‡] Hysteresis is the difference between the positive-going input threshold voltage and the negative-going input threshold voltage.

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electrical characteristics over recommended operating free-air temperature range, $V_{CC} = 15 \text{ V}$, (unless otherwise noted) (continued)

switching characteristics, T_A = 25°C

PARAMETER	TEST COND	TIONS	TL594C, TL594I			UNIT
PARAMETER	TEST CONDI	ITIONS	MIN	TYP	MAX	UNIT
Output voltage rise time	Common omittor configuration	Can Figure 0		100	200	ns
Output voltage fall time	Common-emitter configuration,	See Figure 3	30	100	ns	
Output voltage rise time	Emitter-follower configuration,	See Figure 4		200	400	ns
Output voltage fall time	- Ernitter-tollower corniguration,	See Figure 4		45	100	ns

[†] All typical values except for parameter changes with temperature are at T_A = 25°C.

electrical characteristics over recommended operating conditions, V_{CC} = 15 V, T_A = 25°C (unless otherwise noted)

reference section

PARAMETER	TEST COMPITIONS		ΓL594Y		UNIT
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX] UNIT
Output voltage (REF)	I _O = 1 mA,		5		V
Input regulation	V _{CC} = 7 V to 40 V,		2		mV
Output regulation	I _O = 1 to 10 mA,		14		mV .
Short-circuit output current	V _{ref} = 0		35		mA

[†] Duration of the short circuit should not exceed one second.

oscillator section, C_T = 0.01 μ F, R_T = 12 $k\Omega$ (see Figure 2)

PARAMETER	TEST CONDITIONS			LINUT	
	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Frequency			10		kHz
Standard deviation of frequency†	All values of V _{CC} , C _T , R _T , and T _A constant		100		Hz/kHz
Frequency change with voltage	V _{CC} = 7 V to 40 V,		1		Hz/kHz

[†] Standard deviation is a measure of the statistical distribution about the mean as derived from the formula;

 $\sigma = \sqrt{\frac{\sum_{n=1}^{N} (x_n - \overline{X})^2}{N-1}}$

amplifier section (see Figure 1)

PARAMETER		ST CONDITION		Т	L594Y		UNIT
PARAMETER	15	SICONDITION	3	MIN	TYP	MAX	UNIT
Input offset voltage, error amplifier	FEEDBACK = 2.5 V				2		mV
Input offset current	FEEDBACK = 2.5 V				25		nA
Input bias current	FEEDBACK = 2.5 V				0.2		μА
Open-loop voltage amplification, error amplifier	ΔV _O = 3 V,	R _L = 2 kΩ,	V _O = 0.5 V to 3.5 V		95		dB
Unity-gain bandwidth	$V_O = 0.5 \text{ V to } 3.5 \text{ V},$	R _L = 2 kΩ			800		kHz
Common-mode rejection ratio, error amplifier	V _{CC} = 40 V,	T _A = 25°C			80		dB
Output sink current, FEEDBACK	$V_{ID} = -15 \text{ mV to } -5 \text{ V},$	FEEDBACK =	0.5 V		0.7		mA

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 15 V, T_A = 25°C (unless otherwise noted)

dead-time control section (see Figure 2)

PARAMETER	TEST CONDITIONS	TL594Y			UNIT
PARAMETER,	TEST CONDITIONS	MIN	TYP	MAX	UNII
Input bias current	V _I = 0 to 5.25 V		-2		μА
Input threshold voltage	Zero duty cycle		3		V

output section

DADAMETED		7507.00	NIDITIONO	TL	TL594Y		
PARAMETER		I IESI CC	ONDITIONS	MIN TYPT MA	UNIT		
		$V_C = 40 \text{ V}, V_E = 0 \text{ V}$, V _{CC} = 40 V	2			
Collector off-state current		DTC and OUTPUT C V _C = 15 V, V _{CC} = 1 to 3 V	TRL = 0 V, V _E = 0 V,		4	μА	
Emitter off-state current		$V_{CC} = V_{C} = 40 \text{ V},$	VE = 0			μА	
Collector-emitter saturation voltage	Common emitter	V _E = 0,	I _C = 200 mA		1.1	\Box \lor	
Concolor crimiter saturation voltage	Emitter follower	V _C = 15 V,	I _E = -200 mA		1.5		

pwm comparator section (see Figure 2)

PARAMETER	TEST CONDITIONS		UNIT		
PARAMETER	TEST CONDITIONS	MIN TYP MAX			UNII
Input threshold voltage, FEEDBACK	Zero duty cycle	4		V	
Input sink current, FEEDBACK	FEEDBACK = 0.5 V		0.7		mA

total device (see Figure 2)

PARAMETER	TEST CONDI	TIONS	-	ΓL594Y		LINUT		
PARAMETER TEST CONDITIONS			MIN	TYP	MAX	UNIT		
Standby supply current	All other inputs and outputs open	R _T at V _{ref} ,		9		mA		
Average supply current	DTC = 2 V,	See Figure 2		12.4		mA		

switching characteristics, $T_A = 25^{\circ}C$

PARAMETER	TEST CONDITIONS	-	UNIT		
FARAWEIER	TEST CONDITIONS	MIN	TYP	MAX	UNII
Output voltage rise time	0		100		ns
Output voltage fall time	Common-emitter configuration, See Figure 3		30		ns
Output voltage rise time	Emitter-follower configuration, See Figure 4		200		ns
Output voltage fall time	Emilier-follower configuration, See Figure 4		45		ns

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PARAMETER MEASUREMENT INFORMATION

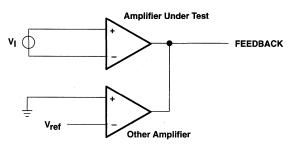


Figure 1. Amplifier Characteristics Test Circuit

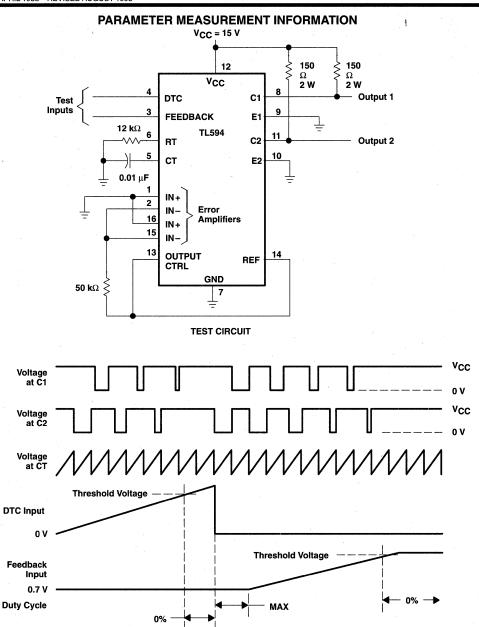


Figure 2. Operational Test Circuit and Waveforms

VOLTAGE WAVEFORMS



PARAMETER MEASUREMENT INFORMATION

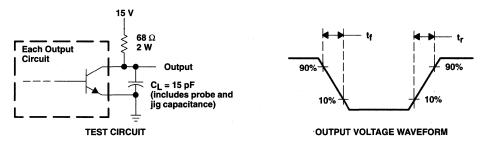


Figure 3. Common-Emitter Configuration

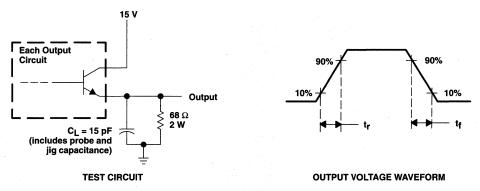


Figure 4. Emitter-Follower Configuration

TYPICAL CHARACTERISTICS

OSCILLATOR FREQUENCY AND FREQUENCY VARIATION[†]

٧s **TIMING RESISTANCE**

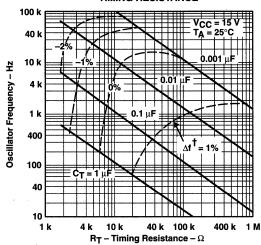


Figure 5

AMPLIFIER VOLTAGE AMPLIFICATION

FREQUENCY 100 V_{CC} = 15 V ΔV_O = 3 V 90 TA = 25°C 80 Voltage Amplification - dB 70 60 50 40 30 20 10 0 10 100 1 k 10 k 100 k 1 M f - Frequency - Hz

[†] Frequency variation (Δf) is the change in oscillator frequency that occurs over the full temperature range.

TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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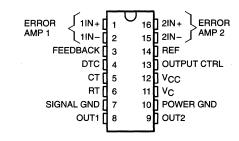
- Complete PWM Power Control Function
- Totem-Pole Outputs for 200-mA Sink or Source Current
- Output Control Selects Parallel or Push-Pull Operation
- Internal Circuitry Prohibits Double Pulse at Either Output
- Variable Dead-Time Provides Control Over Total Range
- Internal Regulator Provides a Stable 5-V Reference Supply, Trimmed to 1% Tolerance
- On-Board Output Current-Limiting Protection
- Undervoltage Lockout for Low V_{CC} Conditions
- Separate Power and Signal Grounds
- TL598Q Has Extended Temperature Range...-40°C to 125°C

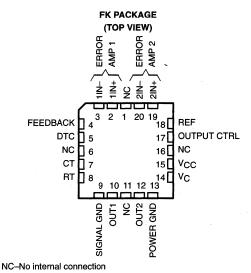
description

The TL598 incorporates all the functions required in the construction of pulse-width-modulated (PWM) controlled systems on a single monolithic chip. Designed primarily for power supply control, the TL598 provides the systems engineer with the flexibility to tailor the power supply control circuits to a specific application.

The TL598 contains two error amplifiers, an internal oscillator (externally adjustable), a dead-time control (DTC) comparator, a pulse-steering flip-flop, a 5-V precision reference, undervoltage lockout control, and output control circuits. Two totem-pole outputs provide exceptional rise and fall time performance for power FET control. The outputs share a common source supply and common power ground terminals, which allow system designers to eliminate errors caused by high current-induced voltage drops and common-mode noise.

D, J, OR N PACKAGE (TOP VIEW)





FUNCTION TABLE

INPUT OUTPUT CTRL	OUTPUT FUNCTION
V _I = GND	Single-ended or parallel output
VI = REF	Normal push-pull operation

AVAILABLE OPTIONS

TA	IA OUTLINE CAR		OUTLINE CARRIER DIP		'A OUTLINE C		OUTLINE CARRIER DIP		CHIP FORM (Y)
0°C to 70°C	TL598CD			TL598CN					
-40°C to 125°C	TL598QD	_		TL598QN	TL598Y				
-55°C to 125°C	_	TL598MFK	TL598MJ	_					

Chip forms are tested at 25°C.



TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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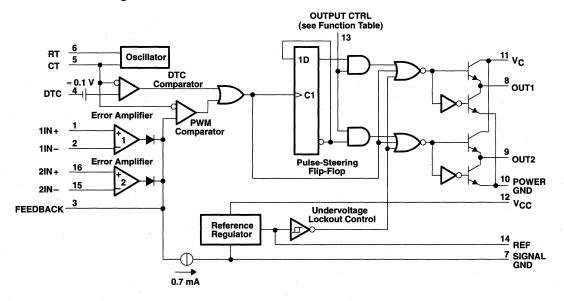
The error amplifier has a common-mode voltage range from 0 V to V_{CC} –2 V. The DTC comparator has a fixed offset that prevents overlap of the outputs during push-pull operation. A synchronous multiple supply operation may be achieved by connecting RT to the reference output and providing a sawtooth input to CT.

The TL598 device provides an output control function to select either push-pull or parallel operation. Circuit architecture prevents either output from being pulsed twice during push-pull operation. The output frequency

for push-pull applications is one-half the oscillator frequency $\left(f_{o} = \frac{1}{2 \text{ RT CT}}\right)$. For single-ended applications: $f_{o} = \frac{1}{BT \text{ CT}}$

The TL598C is characterized for operation from 0°C to 70°C. The TL598Q is characterized for operation from -40°C to 125°C. The TL598M is characterized for operation from -55°C to 125°C.

functional block diagram

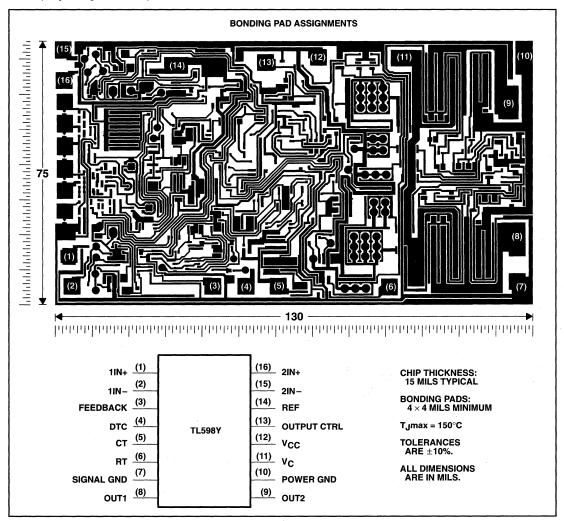


TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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TL598Y chip information

This chip, when properly assembled, displays characteristics similar to the TL598C. Thermal compression or ultrasonic bonding can be used on the doped aluminum bonding pads. The chip can be mounted with conductive epoxy or a gold-silicon preform.



TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)		41 V
Amplifier input voltage, V _I		
Collector voltage		41 V
Output current (each output), sink or source, IO		250 mA
Continuous total power dissipation		See Dissipation Rating Table
Operating virtual junction temperature range, T _J :	TL598C	0°C to 150°C
	TL598Q	40°C to 150°C
	TL598M	55°C to 150°C
Storage temperature range, T _{stq}		65°C to 150°C
Case temperature for 60 seconds, T _C : FK packa	ge	260°C
Lead temperature 1,6 mm (1/16 inch) from case		
Lead temperature 1,6 mm (1/16 inch) from case	for 60 seconds: J package .	300°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values, except differential voltages, are with respect to the signal ground terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 125°C POWER RATING
D	950 mW	7.6 mW/°C	608 mW	190 mW
FK	1375 mW	11 mW/°C	880 mW	275 mW
J	1375 mW	11 mW/°C	800 mW	275 mW
N	1150 mW	9.2 mW/°C	736 mW	230 mW

recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V _{CC}		7	40	V
Amplifier input voltage, V _I		0	V _{CC} -2	V
Collector voltage			40	V
Output current (each output), sink or source, IO			200	mA .
Current into feedback terminal, I _{IL}			0.3	mA
Timing capacitor, C _T		0.00047	10	μF
Timing resistor, R _T		1.8	500	kΩ
Oscillator frequency, fosc		1	300	kHz
	TL598C	0	70	
Operating free-air temperature, TA	TL598Q	-40	125	°C
	TL598M	-55	125	

TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 15 V (unless otherwise noted)

reference section (see Note 2)

PARAMETER	TEST COL	TEST CONDITIONS†		TL598C			TL598Q		LINUT
PARAMETER	I EST CON			TYP‡	MAX	MIN	TYP‡	MAX	UNIT
Output voltage (REF)	la 1 mA	T _A = 25°C	4.95	5	5.05	4.95	5	5.05	v
	I _O = 1 mA	T _A = MIN to MAX	4.9		5.1	4.9		5.1	· V
Input regulation	V _{CC} = 7 V to 40 V	T _A = 25°C		2	25		2	22	mV
Output regulation	l= 1 m A to 10 m A	T _A = 25°C		1	15		1	15	
	IQ = 1 IIIA to 10 IIIA	$I_O = 1 \text{ mA to } 10 \text{ mA}$ $T_A = \text{MIN to MAX}$			50			80	mV
Output voltage change with temperature	$\Delta T_A = MIN \text{ to MAX}$			2	10		2	10	mV/V
Short-circuit output current§	REF = 0 V		-10	-48		-10	-48		mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

oscillator section, $C_T = 0.001 \,\mu\text{F}$, $R_T = 12 \,\text{k}\Omega$ (see Figure 1) (see Note 2)

PARAMETER	TEST COMPLETIONS!	TL59	TL598C, TL598Q			
	TEST CONDITIONS [†]	MIN	TYP‡	MAX	UNIT	
Frequency			100		kHz	
Standard deviation of frequency¶	All values of V _{CC} , C _T , R _T , T _A constant		100		Hz/kHz	
Frequency change with voltage	V _{CC} = 7 V to 40 V, T _A = 25°C		1	10	Hz/kHz	
Frequency change with temperature#	$\Delta T_A = MIN \text{ to MAX}$		70	120	Hz/kHz	
	$\Delta T_A = MIN \text{ to MAX}, C_T = 0.01 \mu\text{F}$		50	80	HZ/KHZ	

For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

 \P Standard deviation is a measure of the statistical distribution about the mean as derived from the formula: $\,\sigma$

NOTE 2: Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.

error amplifier section (see Note 2)

PARAMETER		TEST CONDITIONS			TL598C, TL598Q			
PARAMETER	IESI				TYP‡	MAX	UNIT	
Input offset voltage	FEEDBACK = 2.5 V				2	10	mV	
Input offset current	FEEDBACK = 2.5 V				25	250	nA	
Input bias current	FEEDBACK = 2.5 V				0.2	1	μА	
				0				
Common-mode input voltage range	V _{CC} = 7 V to 40 V			to	_		V	
				VCC-	2			
Open-loop voltage amplification	ΔV_O (FEEDBACK) = 3 V,	VO (FEEDBACK	() = 0.5 V to 3.5 V	70	95		dB	
Unity-gain bandwidth					800		kHz	
Common-mode rejection ratio	V _{CC} = 40 V,	$\Delta V_{IC} = 6.5 \text{ V},$	T _A = 25°C	65	80		dB	
Output sink current (FEEDBACK)	FEEDBACK = 0.5 V			0.3	0.7		mA	
Output source current (FEEDBACK)	FEEDBACK = 3.5 V			-2			mA	
Phase margin at unity gain	FEEDBACK = 0.5 V to 3.5	V,	R _L = 2 kΩ		65°			
Supply voltage rejection ratio	FEEDBACK = 2.5 V,	$\Delta V_{CC} = 33 V$,	R _L = 2 kΩ		100		dB	

 $[\]ddagger$ All typical values except for parameter changes with temperature are at T_A = 25°C.

NOTE 2: Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.



[‡] All typical values except for parameter changes with temperature are at $T_A = 25$ °C.

[§] Duration of the short circuit should not exceed one second.

NOTE 2: Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.

[‡] All typical values except for parameter changes with temperature are at $T_A = 25$ °C.

[#] Effects of temperature on external RT and CT are not taken into account.

TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics over recommended operating free-air temperature range, $V_{CC} = 15 \text{ V}$ (unless otherwise noted)

undervoltage lockout section (see Note 2)

PARAMETER	TEST CONDITIONS†		TL598C		TL598Q	
			MAX	MIN	MAX	UNIT
There are also contains	T _A = 25°C	4	6	4	6	V
Threshold voltage	$\Delta T_A = MIN \text{ to MAX}$	3.5	6.9	3	6.9	V .
	T _A = 25°C	100		100		mV
Hysteresis [‡]	T _A = MIN to MAX	50		30		IIIV

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

output section (see Note 2)

DADAMETED	TEST CONDITIONS			TL598C, TL598Q		
PARAMETER				MAX	UNIT	
High-level output voltage	V _{CC} = 15 V,	$I_{O} = -200 \text{ mA}$	12		·V	
	V _C = 15 V	$I_O = -20 \text{ mA}$	13		\	
Law lawel autout value	V _{CC} = 15 V,	I _O = 200 mA		2	V	
Low-level output voltage	V _C = 15 V	I _O = 20 mA		0.4	V	
Output control input current	V _I = V _{ref}			3.5	mA	
Output control input current	V _I = 0.4 V			100	μA	

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

dead-time control section (see Figure 1) (see Note 2)

PARAMETER	TEST CONDITIONS		TL598C			TL598Q		
PANAMETER	TEST CONDITIONS	MIN	TYP§	MAX	MIN	TYP§	MAX	UNIT
Input bias current (DTC)	V _I = 0 to 5.25 V		-2	-10		-2	-25	μΑ
Maximum duty cycle, each output	DTC = 0 V	0.45			0.45			
Input threshold voltage (DTC)	Zero duty cycle		3	3.3		3	3.2	V
	Maximum duty cycle	0			0			. v

[§] All typical values except for parameter changes with temperature are at $T_A = 25$ °C.

pwm comparator section (see Note 2)

PARAMETER	TEST CONDITIONS		TL598C, TL598Q		
	TEST CONDITIONS	MIN	TYP§	MAX	UNIT
Input threshold voltage (FEEDBACK)	DTC = 0 V		3.75	4.5	V
Input sink current (FEEDBACK)	V(FEEDBACK) = 0.5 V	0.3	0.7		mA

[§] All typical values except for parameter changes with temperature are at T_A = 25°C.

total device (see Figure 1) (see Note 2)

PARAMETER	TEGT CONDI	TEST CONDITIONS TL MIN			98Q	
	TEST CONDI				MAX	UNIT
0. "	RT = V _{ref} ,	V _{CC} = 15 V		15	21	
Standby supply current	All other inputs and outputs open	V _{CC} = 40 V		20	26	mA
Average supply current	DTC = 2 V			15		mA

 $[\]S$ All typical values except for parameter changes with temperature are at $T_A = 25$ °C.



[‡] Hysteresis is the difference between the positive-going input threshold voltage and the negative-going input threshold voltage.

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

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NOTÉ 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 15 V (unless otherwise noted)

switching characteristics, $T_{\Delta} = 25^{\circ}C$ (see Note 2)

PARAMETER		TEGT CONDIT	10110	TL59	8C, TL5	98Q	
PARAMETER		TEST CONDIT	IONS	MIN TYP		MAX	UNIT
Output voltage rise time	CL = 1500 pF,	VC = 15 V,	VCC = 15 V,		60	150	ns
Output voltage fall time	See Figure 2				35	75	115

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

reference section (see Note 2)

PARAMETER	TEST 001	TEST CONDITIONS†			TL598M			
PARAMETER	IESI CON				MAX	UNIT		
Output voltage (REE)	1- 1-0	T _A = 25°C	4.95	5	5.05	V		
Output voltage (REF)	I _O = 1 mA	$T_A = MIN \text{ to MAX}$	4.9		5.1)		
Input regulation	V _{CC} = 7 V to 40 V	T _A = 25°C		2	22	mV		
Outrost as mulation		T _A = 25°C		1	15			
Output regulation	$I_O = 1 \text{ mA to } 10 \text{ mA}$	T _A = MIN to MAX			80	mV		
Output voltage change with temperature	$\Delta T_A = MIN \text{ to MAX}$			0.5%				
Short-circuit output current§	REF = 0		-10	-48		mA		

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

oscillator section, $C_T = 0.001 \mu F$, $R_T = 12 k\Omega$ (see Figure 1) (see Note 2)

DADAMETED	RAMETER TEST CONDITIONS [†]		
PARAMETER	TEST CONDITIONS	MIN TYP# MAX	UNIT
Frequency		100	kHz
Standard deviation of frequency	All values of V _{CC} , C _T , R _T , T _A constant	10%	
Frequency change with voltage	$V_{CC} = 7 \text{ V to } 40 \text{ V}, \qquad T_{A} = 25^{\circ}\text{C}$	0.1% 1%	
Frequency change with temperature#	$\Delta T_A = MIN \text{ to MAX}$	7% 15%*	

^{*} On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values except for parameter changes with temperature are at $T_A = 25$ °C.

Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

Effects of temperature on external R_T and C_T are not taken into account.

 $= \sqrt{\frac{\sum_{n=1}^{N} (x_n - X)^2}{N-1}}$

NOTE 2: Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.

 $[\]ddagger$ All typical values except for parameter changes with temperature are at $T_A = 25^{\circ}C$.

[§] Duration of the short circuit should not exceed one second.

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electrical characteristics over recommended operating free-air temperature range, $V_{CC} = 15 \text{ V}$ (unless otherwise noted)

error amplifier section (see Note 2)

1 a	T			TL598M			T
PARAMETER	TES	T CONDITIONS		MIN	TYPT	MAX	UNIT
Input offset voltage	FEEDBACK at 2.5 V				2	10	mV
Input offset current	FEEDBACK at 2.5 V				25	250	nA.
Input bias current	FEEDBACK at 2.5 V				0.2	1	μΑ
Common-mode input voltage range	V _{CC} = 7 V to 40 V			0 to V _{CC} -	2		٧
Open-loop voltage amplification	ΔV_O (FEEDBACK) = 3 V,	VO (FEEDBACH	() = 0.5 V to 3.5 V	70	95		dB
Unity-gain bandwidth					800		kHz
Common-mode rejection ratio	V _{CC} = 40 V,	$\Delta V_{IC} = 6.5 \text{ V},$	T _A = 25°C	65	80		dB
Output sink current (FEEDBACK)	FEEDBACK at 0.5 V			0.3	0.7		mA
Output source current (FEEDBACK)	FEEDBACK at 3.5 V	:-		-2	-		mA
Phase margin at unity gain	FEEDBACK at 0.5 V to 3	.5 V,	R _L = 2 kΩ		65°		
Supply voltage rejection ratio	FEEDBACK at 2.5 V,	$\Delta V_{CC} = 33 \text{ V},$	$R_L = 2 k\Omega$		100		dB

[†] All typical values except for parameter changes with temperature are at T_A = 25°C.

undervoltage lockout section (see Note 2)

DADAMETED	TEST CONDITIONS!	TL59	TL598M		
PARAMETER	TEST CONDITIONS‡	MIN	MAX	UNIT	
Threshold voltage	T _A = 25°C	4	6	.,	
	$\Delta T_A = MIN \text{ to MAX}$	3	6.9	V .	
Hysteresis §	T _A = 25°C	100		mV	
	T _A = MIN to MAX	30		mv	

[‡] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

output section (see Note 2)

DADAMETED		TEST CONDITIONS			TL598M			
PARAMETER		TEST C	ONDITIONS	MIN	TYP MAX	UNIT		
Collector off-state current	V _{CE} = 40 V,	V _{CC} = 40 V,	DTC connected to 0 V		2 100	μА		
High-level output voltage	V _{CC} = 15 V,	$I_{O} = -200 \text{ mA}$		12		\ \ \		
	V _C = 15 V	$I_0 = -20 \text{ mA}$		13		1 °		
Law lavel autout valtage	V _{CC} = 15 V,	I _O = 200 mA			2	v		
Low-level output voltage V _C	V _C = 15 V	I _O = 20 mA			0.4	1 °		
Output control input accurant	V _I = REF				3.5	mA		
Output control input current	$V_{I} = 0.4 \text{ V}$				100	μА		

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

NOTÉ 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

[§] Hysteresis is the difference between the positive-going input threshold voltage and the negative-going input threshold voltage.

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 15 V (unless otherwise noted)

dead-time control section (see Figure 1) (see Note 2)

DADAMETED	TEST CONDITIONS		TL598M		
PARAMETER	TEST CONDITIONS	MIN	TYPT	MAX	UNIT
Input bias current (DTC)	V _I = 0 to 5.25 V		-2	-25	μΑ
Maximum duty cycle, each output	DTC at 0 V	45%*			
Input threshold voltage (DTC)	Zero duty cycle		3	3.2	V
	Maximum duty cycle	0*			\

^{*} On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

pwm comparator section (see Note 2)

PARAMETER	TEST CONDITIONS		TL598M		UNIT
PARAMETER	TEST CONDITIONS		TYPT	MAX	UNII
Input threshold voltage (FEEDBACK)	DTC = 0 V		3.75	4.5	V
Input sink current (FEEDBACK)	V(FEEDBACK) = 0.5 V	0.3	0.7		mA

 $[\]overline{\text{†}}$ All typical values except for parameter changes with temperature are at $T_A = 25^{\circ}\text{C}$.

total device (see Figure 1) (see Note 2)

DADAMETED	TEST CONDI	TEST CONDITIONS			TL598M		
PARAMETER	TEST CONDI	TEST CONDITIONS		TYP†	MAX	UNIT	
	RT at REF,	V _{CC} = 15 V		15	21		
Standby supply current	All other inputs and outputs open	V _{CC} = 40 V		20	26	mA	
Average supply current	DTC at 2 V			15		mA	

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

switching characteristics, $T_A = 25^{\circ}C$ (see Note 2)

PARAMETER	TEST CONDITIONS				TL598M		
				MIN	TYP	MAX	UNIT
Output voltage rise time	CL = 1500 pF,	VC = 15 V,	VCC = 15 V,			150*	ns
Output voltage fall time	See Figure 2					75*	115

^{*} On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

[†] All typical values except for parameter changes with temperature are at T_A = 25°C.

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

NOTE 2: Pulse-testing techniques must be used that maintain the junction temperature as close to the ambient temperature as possible.

TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics, $V_{CC} = 15 \text{ V}$, $T_A = 25^{\circ}\text{C}$

reference section (see Note 2)

DADAMETED	TEST CONDITIONS	TL598Y	
PARAMETER	TEST CONDITIONS	MIN TYPT MAX	UNIT
Output voltage (REF)	I _O = 1 mA	5	٧
Input regulation	V _{CC} = 7 V to 40 V	2	mV
Output regulation	I _O = 1 mA to 10 mA	1	mV
Output voltage change with temperature	$\Delta T_A = MIN \text{ to MAX}$	2	mV/V
Short-circuit output current‡	REF = 0 V	-48	mA

T All typical values except for parameter changes with temperature are at TA = 25°C.

oscillator section, C_T = 0.001 μ F, R_T = 12 k Ω (see Figure 1) (see Note 2)

PARAMETER	TEST CONDITIONS	1	FL598Y		LINUT
PARAWETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Frequency			100		kHz
Standard deviation of frequency§	All values of V _{CC} , C _T , R _T , T _A constant		100		Hz/kHz
Frequency change with voltage	V _{CC} = 7 V to 40 V,		. 1		Hz/kHz

§ Standard deviation is a measure of the statistical distribution about the mean as derived from the formula:

$$\sigma = \sqrt{\frac{\sum_{n=1}^{N} (x_n - X)^2}{N-1}}$$

NOTE 2 Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.

error amplifier section (see Note 2)

PARAMETER	TEST COMPITIONS	•			
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input offset voltage	Feedback = 2.5 V		2	4	mV
Input offset current	Feedback = 2.5 V		25		nA
Input bias current	Feedback = 2.5 V		0.2	-	μΑ
Open-loop voltage amplification	ΔV_O (FEEDBACK) = 3 V, V_O (FEEDBACK) = 0.5 V to 3.5 V		95		dB
Unity-gain bandwidth			800		kHz
Common-mode rejection ratio	$V_{CC} = 40 \text{ V}, \qquad \Delta V_{IC} = 6.5 \text{ V},$		80		dB
Output sink current (FEEDBACK)	FEEDBACK = 0.5 V		0.7		mA
Phase margin at unity gain	FEEDBACK = 0.5 V to 3.5 V, $R_L = 2 k\Omega$		65°		
Supply voltage rejection ratio	FEEDBACK = 2.5 V, $\Delta V_{CC} = 33 \text{ V}$, $R_L = 2 \text{ k}\Omega$		100		dB

NOTE 2 Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.

[‡] Duration of the short circuit should not exceed one second.

NOTE 2 Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.

TL598C, TL598Q, TL598M, TL598Y PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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electrical characteristics, $V_{CC} = 15 \text{ V}$, $T_A = 25^{\circ}\text{C}$

dead-time control section (see Figure 1) (see Note 2)

PARAMETER	TEST COMPITIONS	TL598Y					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
Input bias current (DTC)	V _I = 0 to 5.25 V	-2		μΑ			
Input threshold voltage (DTC)	Zero duty cycle		3		V		

NOTE 2 Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.

pwm comparator section (see Note 2)

PARAMETER	TEST CONDITIONS C = 0 V	T	UNIT		
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNII
Input threshold voltage (FEEDBACK)	DTC = 0 V		3.75		V
Input sink current (FEEDBACK)	FEEDBACK = 0.5 V		0.7		mA

NOTE 2 Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.

total device (see Figure 1) (see Note 2)

PARAMETER	TEST CONDIT	TIONE	1	UNIT		
PARAMETER	TEST CONDIT	IIONS	MIN	TYP	MAX	UNIT
Standby cupply current	RT = V _{ref} ,	V _{CC} = 15 V		15		m A
Standby supply current	All other inputs and outputs open	V _{CC} = 40 V		20		mA
Average supply current	DTC = 2 V			15		mA ⁻

NOTE 2 Pulse-testing techniques that maintain the junction temperature as close to the ambient temperature as possible must be used.

PARAMETER MEASUREMENT INFORMATION

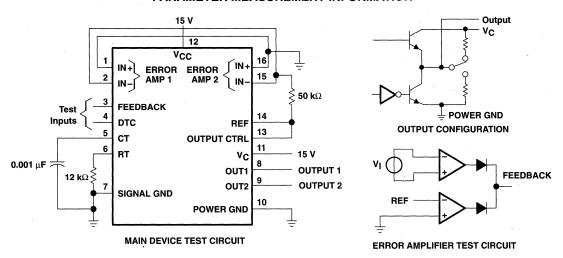


Figure 1. Test Circuits

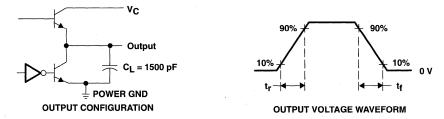
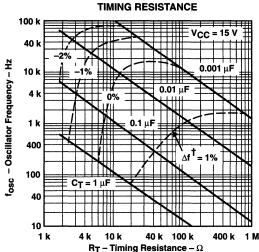


Figure 2. Switching Output Configuration and Voltage Waveform

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TYPICAL CHARACTERISTICS

OSCILLATOR FREQUENCY AND FREQUENCY VARIATION †



† Frequency variation (Δf) is the change in predicted oscillator frequency that occurs over the full temperature range.

Figure 3

AMPLIFIER VOLTAGE AMPLIFICATION vs FREQUENCY

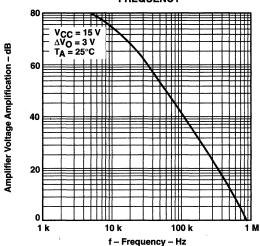


Figure 4

TL1451AC, TL1451AY DUAL PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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Complete PWM Power Control Circuitry

- Completely Synchronized Operation
- Internal Undervoltage Lockout Protection
- Wide Supply Voltage Range
- Internal Short-Circuit Protection
- Oscillator Frequency . . . 500 kHz Max
- Variable Dead Time Provides Control Over Total Range
- Internal Regulator Provides a Stable 2.5-V Reference Supply

(TOP VIEW) 16 NEF 15 SCP ∫1IN+[]3 14 1 2IN+l ERROR **ERROR** AMPLIFIER 1 Ì 1IN−[AMPLIFIER 2 13 1 2IN-12 2FEÉDBACK 1FEEDBACK [1DTC 1 6 1 2DTC 10UT / 7 10 1 2OUT GND [Vcc

DB. N. NS. OR PW PACKAGE

description

The TL1451AC incorporates on a single monolithic chip all the functions required in the construction of two pulse-width-modulation (PWM) control circuits. Designed primarily for power supply control, the TL1451AC contains an on-chip 2.5-V regulator, two error amplifiers, an adjustable oscillator, two dead-time comparators, undervoltage lockout circuitry, and dual common-emitter output transistor circuits.

The uncommitted output transistors provide common-emitter output capability for each controller. The internal amplifiers exhibit a common-mode voltage range from 1.04 V to 1.45 V. The dead-time control (DTC) comparator has no offset unless externally altered and can provide 0% to 100% dead time. The on-chip oscillator can be operated by terminating RT and CT. During low V_{CC} conditions, the undervoltage lockout control circuit feature locks the outputs off until the internal circuitry is operational.

The TL1451AC is characterized for operation from -20°C to 85°C.

AVAILABLE OPTIONS

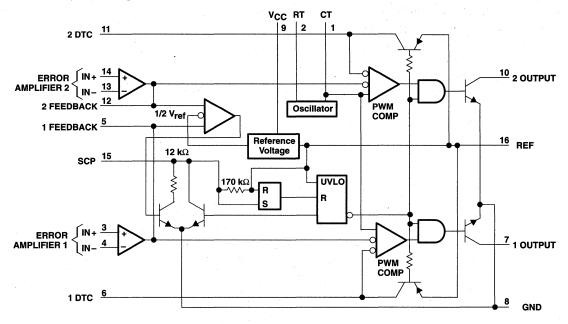
		PACKAGE	DEVICES		CHIP FORM
TA	SMALL OUTLINE (DB)†	SMALL OUTLINE (NS)	TSSOP (PW) [†]	(Y)	
-20°C to 85°C	TL1451ACDB	TL1451ACN	TL1451ACNS	TL1451ACPW	TL1451AY

† The DB and PW packages are only available left-end taped and reeled (add LE suffix, i.e., TL1451ACPWLE).

TL1451AC, TL1451AY DUAL PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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functional block diagram



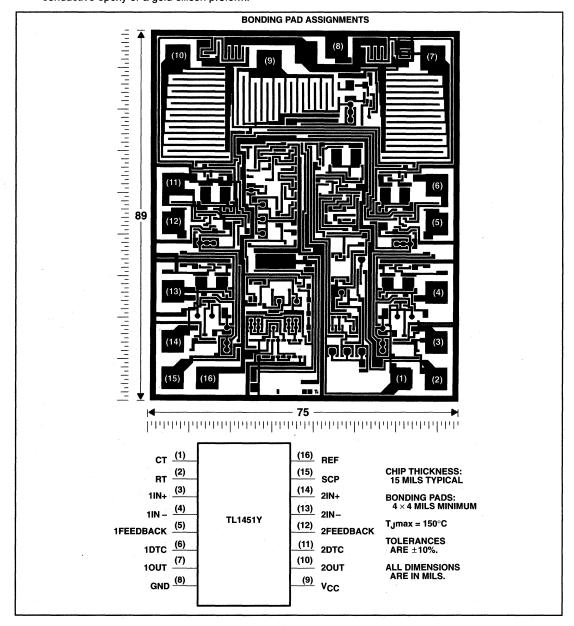
COMPONENT COUNT

Resistors	65	
Capacitors	8	
Transistors	105	
JFETs	18	

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TL1451AY chip information

This chip, when properly assembled, displays characteristics similar to the TL1451AC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



TL1451AC, TL1451AY DUAL PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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absolute maximum ratings over operating free-air temperature range†

Supply voltage, V _{CC}	51 V
Amplifier input voltage, V _I	20 V
Collector output voltage, VO	51 V
Collector output current, IO	
Continuous power total dissipation	See Dissipation Rating Table
Operating free-air temperature range, T _A	–20°C to 85°C
Storage temperature range, T _{stq}	
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
DB	775 mW	6.2 mW/°C	496 mW	403 mW
N .	1000 mW	8.0 mW/°C	640 mW	520 mW
NS	500 mW	4.0 mW/°C	320 mW	260 mW
PW	700 mW	5.6 mW/°C	448 mW	364 mW

recommended operating conditions

				 			MIN	MAX	UNIT
Supply voltage, V _{CC}							3.6	50	٧
Amplifier input voltage, V _I							1.05	1.45	: V
Collector output voltage, VO			 					50	V
Collector output current, IO								20	mA
Current into feedback terminal								45	μΑ
Feedback resistor, RF						11.1	100		kΩ
Timing capacitor, C _T	7	100					150	15000	pF
Timing resistor, R _T						-	5.1	100	kΩ
Oscillator frequency					-		1	500	kHz
Operating free-air temperature, TA							-20	85	°C

electrical characteristics over recommended operating free-air temperature range, $V_{CC} = 6 \text{ V}$, f = 200 kHz (unless otherwise noted)

reference section

		TL1451AC					l	
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYPT	MAX	UNIT
Output voltage (pin 16)	I _O = 1 mA	2.4	2.5	2.6		2.5		٧
O. t	T _A = -20°C to 25°C		-0.1%	±1%		-0.1%		
Output voltage change with temperature	T _A = 25°C to 85°C		-0.2%	±1%		-0.2%		
Input voltage regulation	V _{CC} = 3.6 V to 40 V		2	12.5		2		mV
Output voltage regulation	I _O = 0.1 mA to 1 mA		1	7.5		1		mV
Short-circuit output current	V _O = 0	3	10	30		10		mA

[†] All typical values are at T_A = 25°C.



TL1451AC, TL1451AY DUAL PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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undervoltage lockout section

		TL1451AC, TL1451AY	UNIT
PARAMETER	TEST CONDITIONS	MIN TYPT MAX	
Upper threshold voltage (V _{CC})		2.72	V
Lower threshold voltage (V _{CC})	I 0.1 T- 05°C	2.6	V
Hysteresis (V _{CC})	I _{O(ref)} = 0.1 mA, T _A = 25°C	80 120	mV
Reset threshold voltage (V _{CC})		1.5 1.9	V

[†] All typical values are at $T_A = 25$ °C.

short-circuit protection control section

DADAMETER	7507.0	TEST CONDITIONS -		TL1451AC			TL1451AY		
PARAMETER	IESI C			TYP†	MAX	MIN	TYP	MAX	UNIT
Input threshold voltage (SCP)	T _A = 25°C		0.65	0.7	0.75	0.65	0.7	0.75	٧
Standby voltage (SCP)	No pullup		140	185	230		185		mV
Latched input voltage (SCP)	No pullup			60	120		60		mV
Input (source) current	V _I = 0.7 V,	T _A = 25°C	-10	-15	-20	-10	-15	-20	μΑ
Comparator threshold voltage (FEEDBACK)				1.18			1.18		٧

[†] All typical values are at T_A = 25°C.

oscillator section

PARAMETER	TEGT COMPITIONS		TL1451C			TL1451AY			UNIT
PARAMETER	IESI CON	TEST CONDITIONS		TYP	MAX	MIN	TYPT	MAX	UNIT
Frequency	C _T = 330 pF,	$R_T = 10 \text{ k}\Omega$		200			200		kHz
Standard deviation of frequency	C _T = 330 pF,	$R_T = 10 \text{ k}\Omega$		10%			10%		
Frequency change with voltage	V _{CC} = 3.6 V to 40 V	V		1%			1%		
	T _A = -20°C to 25°C	;		-0.4%	±2%		-0.4%		
Frequency change with temperature	T _A = 25°C to 85°C			-0.2%	±2%		-0.2%		

[†] All typical values are at T_A = 25°C.

dead-time control section

PARAMETER	TEST CONDITIONS	TL1451AC			TL1451AY			UNIT	
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYPT	MAX	UNII	
Input bias current (DTC)				1				μΑ	
Latch mode (source) current (DTC)	T _A = 25°C	-80	-145		-80	-145		μА	
Latched input voltage (DTC)	ΙΟ = 40 μΑ	2.3						٧	
Institute three hold welto go at 5 10 kHz (DTC)	Zero duty cycle		2.05	2.25		2.05		V	
Input threshold voltage at f = 10 kHz (DTC)	Maximum duty cycle	1.2	1.45			1.45		v	

[†] All typical values are at $T_A = 25$ °C.

TL1451AC, TL1451AY DUAL PULSE-WIDTH-MODULATION CONTROL CIRCUITS

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error-amplifier section

DADAMETED	TEGE COMPLETIONS	TL	1451AC		T	L1451AY	,	
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP†	MAX	UNIT
Input offset voltage	V _O (FEEDBACK) = 1.25 V			±6				mV
Input offset current	V _O (FEEDBACK) = 1.25 V			±100				nA
Input bias current	V _O (FEEDBACK) = 1.25 V		160	500		160		nA
Common-mode input voltage range	V _{CC} = 3.6 V to 40 V	1.05 to 1.45			•	-		٧
Open-loop voltage amplification	R _F = 200 kΩ	70	80			80		dB
Unity-gain bandwidth			1.5			1.5		MHz
Common-mode rejection ratio		60	80			80		dB
Positive output voltage swing		V _{ref} -0.1						٧
Negative output voltage swing				1				٧
Output (sink) current (FEEDBACK)	$V_{ID} = -0.1 \text{ V}, V_{O} = 1.25 \text{ V}$	0.5	1.6			1.6		mA
Output (source) current (FEEDBACK)	$V_{ID} = 0.1 \text{ V}, V_{O} = 1.25 \text{ V}$	-45	-70			-70		μΑ

[†] All typical values are at $T_A = 25$ °C.

output section

PARAMETER	TEST CONDITIONS	TL1451A	TL1451AY			UNIT	
PARAMETER	1EST CONDITIONS	MIN TYPT	MAX	MIN	TYP	MAX	UNIT
Collector off-state current	V _O = 50 V		10				μА
Output saturation voltage	I _O = 10 mA	1.2	2		1.2		V
Short-circuit output current	V _O = 6 V	90			90		mA

[†] All typical values are at $T_A = 25$ °C.

pwm comparator section

PARAMETER	TEST CONDITIONS	TL1451AC			TL1451AY			UNIT
PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	MIN	TYP	MAX	UNII
land threehold valters at f. 10 kHz (FFFDBACK)	Zero duty cycle		2.05	2.25		2.05		
Input threshold voltage at f = 10 kHz (FEEDBACK)	Maximum duty cycle	1.2	1.45			1.45		V

[†] All typical values are at $T_A = 25$ °C.

total device

PARAMETER	TEST CONDITIONS	TL1451AC			TI	UNIT		
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYPT .	MAX	ONIT
Standby supply current	Off-state		1.3	1.8		1.3		mA
Average supply current	R _T = 10 kΩ		1.7	2.4		1.7		mA

[†] All typical values are at $T_A = 25$ °C.

PARAMETER MEASUREMENT INFORMATION

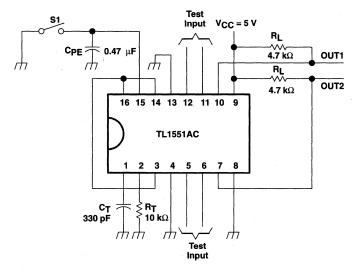
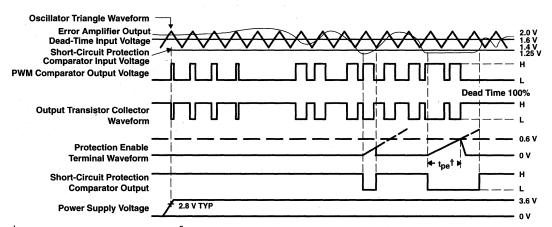


Figure 1. Test Circuit



† Protection Enable Time, $t_{pe} = (0.051 \times 10^6 \times C_{pe})$ in seconds

Figure 2. TL1451AC Timing Diagram

TRIANGLE OSCILLATOR FREQUENCY vs **TIMING RESISTANCE** 1 M VCC = 5 V fosc - Triangle Oscillator Frequency - Hz TA = 25°C $C_T = 150 pF$ 100 k $C_T = 1500 pF$ 10 k $C_T = 15000 pF$ 1 k 1 k 4 k 10 k 40 k 100 k 400 k 1 M

Figure 3

 R_T - Timing Resistance - Ω

TRIANGLE WAVEFORM SWING VOLTAGE

vs **TIMING CAPACITANCE** 2.6 V_{CC} = 5 V $R_T = 5.1 \text{ k}\Omega$ 2.4 Triangle Waveform Swing Voltage - V T_A = 25°C 2.2 2 1.8 1.6 1.4 1.2 1 0.8 102 104 101 103 105 CT - Timing Capacitance - pF

Figure 5

OSCILLATOR FREQUENCY VARIATION ٧s FREE-AIR TEMPERATURE

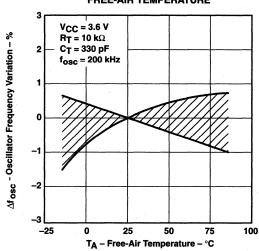


Figure 4

TRIANGLE WAVEFORM PERIOD vs

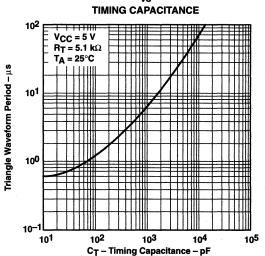


Figure 6

REFERENCE OUTPUT VOLTAGE VARIATION

FREE-AIR TEMPERATURE

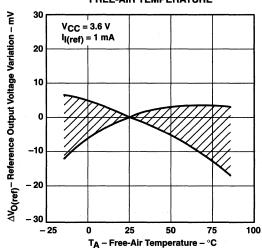


Figure 7

FREE-AIR TEMPERATURE

REFERENCE OUTPUT VOLTAGE VARIATION

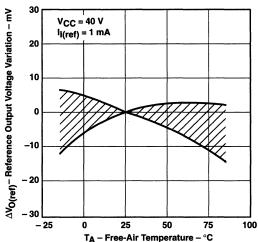


Figure 8

REFERENCE OUTPUT VOLTAGE

SUPPLY VOLTAGE

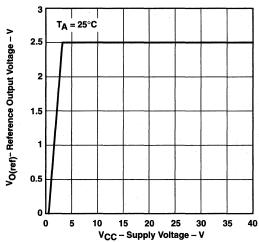


Figure 9

DROPOUT VOLTAGE VARIATION vs

FREE-TEMPERATURE

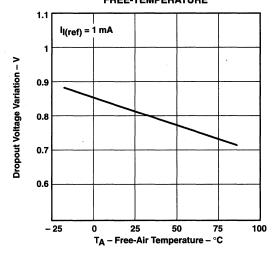
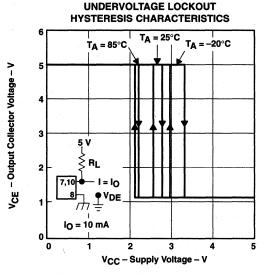


Figure 10



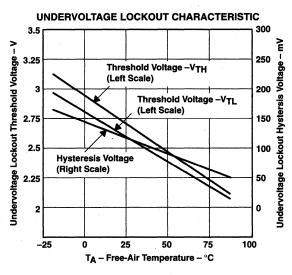


Figure 11

Figure 12

SHORT-CIRCUIT PROTECTION CHARACTERISTICS

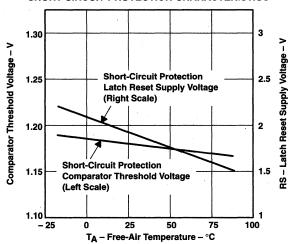
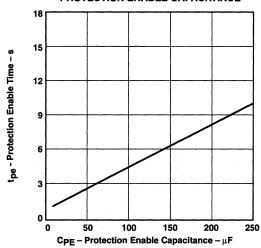


Figure 13

PROTECTION ENABLE TIME

vs PROTECTION ENABLE CAPACITANCE



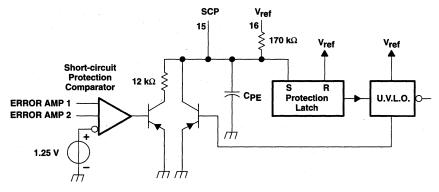


Figure 14

ERROR AMP MAXIMUM OUTPUT VOLTAGE SWING vs **FREQUENCY** 2.25 V_{CC} = 5 V Error Amp Maximum Output Voltage Swing - V 2 T_A = 25°C 1.75 1.5 1.25 1 0.75 0.5 0.25 1 k 10 k 100 k 1 M 10 M f - Frequency - Hz

OPEN-LOOP VOLTAGE AMPLIFICATION FREQUENCY 90 V_{CC} = 5 V 80 TA = 25°C Open-Loop Voltage Amplification - dB 70 60 50 40 30 20 10 0 100 1 k 10 k 100 k 1 M 2 M

Figure 15

Figure 16

f – Frequency – Hz

GAIN (AMPLIFIER IN UNITY-GAIN CONFIGURATION)

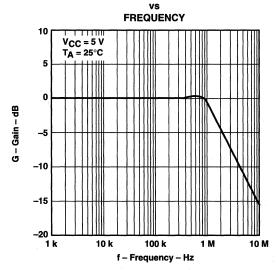
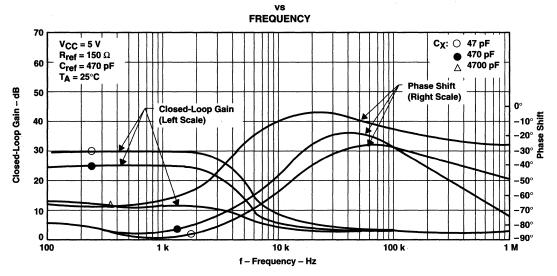


Figure 17

CLOSED-LOOP GAIN AND PHASE SHIFT



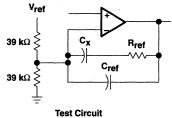
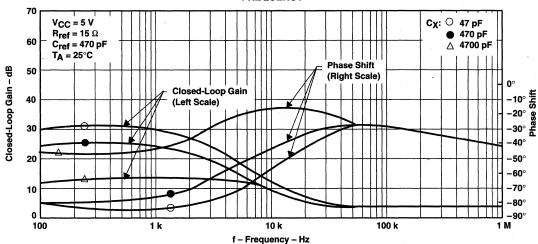


Figure 18

CLOSED-LOOP GAIN AND PHASE SHIFT

FREQUENCY



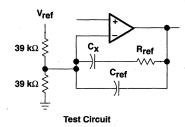
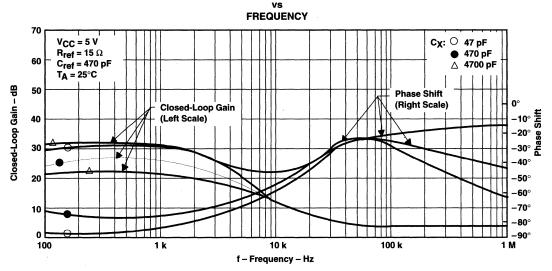


Figure 19

CLOSED-LOOP GAIN AND PHASE SHIFT



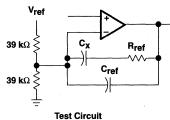
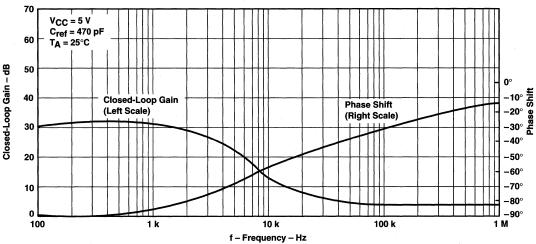


Figure 20

CLOSED-LOOP GAIN AND PHASE SHIFT

FREQUENCY



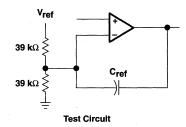


Figure 21

OUTPUT SINK CURRENT

COLLECTOR OUTPUT SATURATION VOLTAGE

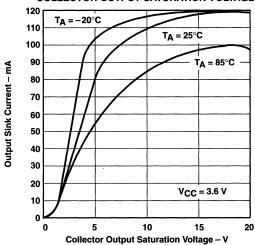
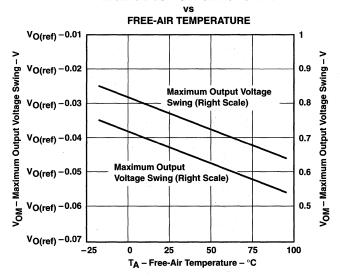


Figure 22

MAXIMUM OUTPUT VOLTAGE SWING



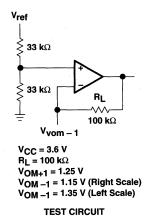


Figure 23

OUTPUT TRANSISTOR "ON" DUTY CYCLE DEAD-TIME INPUT VOLTAGE V_{CC} = 3.6 V 10 $R_T = 10k\Omega$ Output Transistor "On" Duty Cycle - % $C_{T} = 330 \text{ pF}$ 20 30 40 50 60 70 80 90 100 0.5 3.5 0 Dead-Time Input Voltage - V

Figure 24

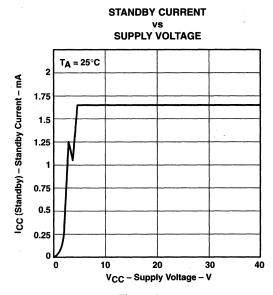


Figure 25

STANDBY CURRENT vs FREE-AIR TEMPERATURE

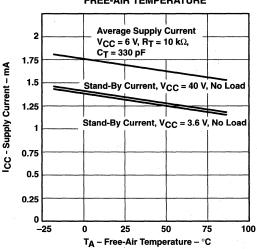


Figure 26

MAXIMUM CONTINUOUS POWER DISSIPATION

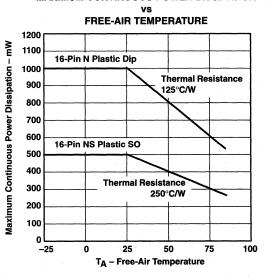
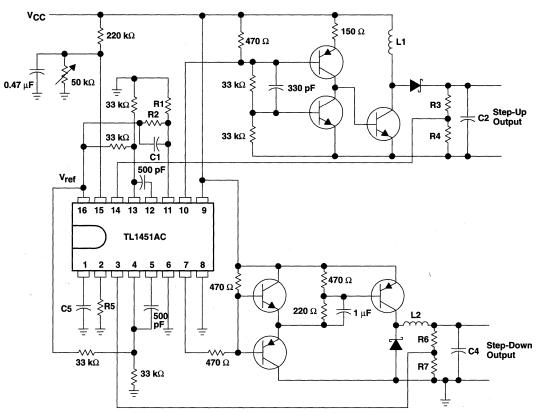


Figure 27

TL1451AC, TL1451AY DUAL PULSE-WIDTH-MODULATION CONTROL CIRCUITS

SLVS024C - FEBRUARY 1983 - REVISED OCTOBER 1995

APPLICATION INFORMATION



NOTE A. Values for R1 through R7, C1 through C4, and L1 and L2 depend upon individual application.

Figure 28. High-Speed Dual Switching Regulator

SLVS086A - APRIL 1995 - REVISED OCTOBER 1995

 Two Complete PWM Control Circuits Outputs Drive MOSFETs Directly 	•	OR PW PAC	
Oscillator Frequency 50 kHz to 2 MHz	ст Г	1 16	l 1 REF
● 3.6-V to 20-V Supply-Voltage Range		4	SCP
 Low Supply Current 3.5 mA Typ 	DTC1	3 14	DTC2
 Adjustable Dead-Time Control, 0% to 100% 	IN1+ [4 13] IN2+
• 1.25-V Reference	IN1- [5 12] IN2-
,	COMP1 [6 11	COMP2
description	GND [7 10] v _{cc}
	OUT1 [8 9	OUT2

The TL1454 is a dual-channel pulse-widthmodulation (PWM) control circuit, primarily intended for low-power, dc/dc converters. Applications include LCD displays, backlight

inverters, notebook computers, and other products requiring small, high-frequency, dc/dc converters. Each PWM channel has its own error amplifier, PWM comparator, dead-time control comparator, and MOSFET driver. The voltage reference, oscillator, undervoltage lockout, and short-circuit protection are common to both channels.

Channel 1 is configured to drive n-channel MOSFETs in step-up or flyback converters, and channel 2 is configured to drive p-channel MOSFETs in step-down or inverting converters. The operating frequency is set with an external resistor and an external capacitor, and dead time is continuously adjustable from 0 to 100% duty cycle with a resistive divider network. Soft start can be implemented by adding a capacitor to the dead-time control (DTC) network. The error-amplifier common-mode input range includes ground, which allows the TL1454 to be used in ground-sensing battery chargers as well as voltage converters.

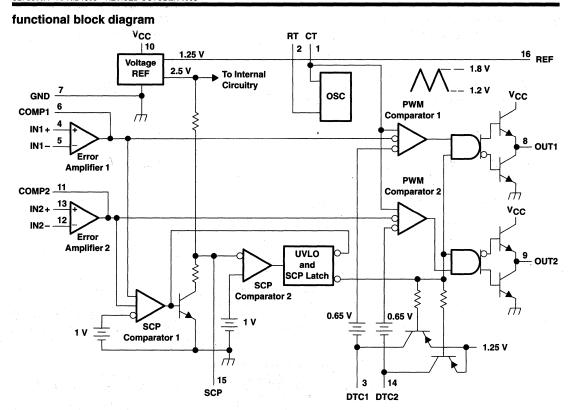
AVAILABLE OPTIONS

	P/	CHIP FORM		
TA	SMALL OUTLINE (D)			(Y)
-20°C to 85°C	TL1454CD	TL1454CN	TL1454CPWLE	TL1454Y
-40°C to 85°C	TL1454ID	TL1454IN	_	-

[†] The D package is available taped and reeled. Add the suffix R to the device name (e.g., TL1454CDR). The PW package is available only left-end taped and reeled (indicated by the LE suffix on the device type; e.g., TL1454CPWLE).

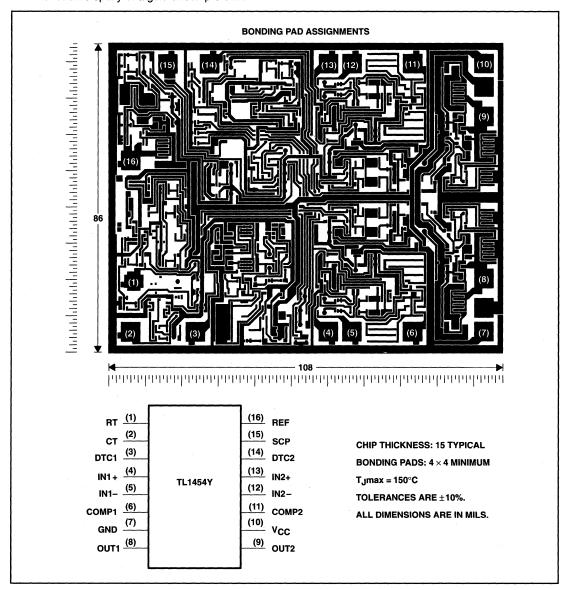


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TL1454Y chip information

This chip, when properly assembled, displays characteristics similar to the TL1454C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



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theory of operation

reference voltage

A linear regulator operating from V_{CC} generates a 2.5-V supply for the internal circuits and the 1.25-V reference, which can source a maximum of 1 mA for external loads. A small ceramic capacitor (0.047 μ F to 0.1 μ F) between REF and ground is recommended to minimize noise pickup.

error amplifier

The error amplifier generates the error signal used by the PWM to adjust the power-switch duty cycle for the desired converter output voltage. The signal is generated by comparing a sample of the output voltage to the voltage reference and amplifying the difference. An external resistive divider connected between the converter output and ground, as shown in Figure 1, is generally required to obtain the output voltage sample.

The amplifier output is brought out on COMP to allow the frequency response of the amplifier to be shaped with an external RC network to stabilize the feedback loop of the converter. DC loading on the COMP output is limited to $45 \mu A$ (the maximum amplifier source current capability).

Figure 1 illustrates the sense-divider network and error-amplifier connections for converters with positive output voltages. The divider network is connected to the noninverting amplifier input because the PWM has a phase inversion; the duty cycle decreases as the error-amplifier output increases.

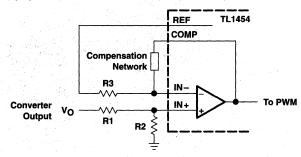


Figure 1. Sense Divider/Error Amplifier
Configuration for Converters with Positive Outputs

The output voltage is given by:

$$V_O = V_{ref} \left(1 + \frac{R1}{R2} \right)$$

where $V_{ref} = 1.25 \text{ V}$.

The dc source resistance of the error-amplifier inputs should be 10 k Ω or less and approximately matched to minimize output voltage errors caused by the input-bias current. A simple procedure for determining appropriate values for the resistors is to choose a convenient value for R3 (10 k Ω or less) and calculate R1 and R2 using:

$$R_1 = \frac{R_3 V_0}{V_0 - V_{ref}}$$

$$R_2 = \frac{R_3 V_0}{V_{ref}}$$



error amplifier

R1 and R2 should be tight-tolerance ($\pm 1\%$ or better) devices with low and/or matched temperature coefficients to minimize output voltage errors. A device with a $\pm 5\%$ tolerance is suitable for R3.

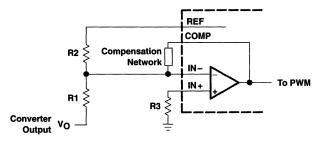


Figure 2. Sense Divider/Error Amplifier Configuration for Converters with Negative Outputs

Figure 2 shows the divider network and error-amplifier configuration for negative output voltages. In general, the comments for positive output voltages also apply for negative outputs. The output voltage is given by:

$$V_O = -\frac{R_1 V_{ref}}{R_2}$$

The design procedure for choosing the resistor value is to select a convenient value for R2 (instead of R3 in the procedure for positive outputs) and calculate R1 and R3 using:

$$R_1 = -\frac{R_2 V_0}{V_{ref}}$$

$$R_3 = \frac{R_1 R_2}{R_1 + R_2}$$

Values in the 10- $k\Omega$ to 20- $k\Omega$ range work well for R2. R3 can be omitted and the noninverting amplifier connected to ground in applications where the output voltage tolerance is not critical.

oscillator

The oscillator frequency can be set between 50 kHz and 2 MHz with a resistor connected between RT and GND and a capacitor between CT and GND (see Figure 3). Figure 6 is used to determine R_T and C_T for the desired operating frequency. Both components should be tight-tolerance, temperature-stable devices to minimize frequency deviation. A 1% metal-film resistor is recommended for R_T , and a 10%, or better, NPO ceramic capacitor is recommended for C_T .

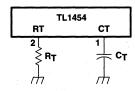


Figure 3. Oscillator Timing

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dead-time control (DTC) and soft start

The two PWM channels have independent dead-time control inputs so that the maximum power-switch duty cycles can be limited to less then 100%. The dead-time is set with a voltage applied to DTC; the voltage is typically obtained from a resistive divider connected between the reference and ground as shown in Figure 4. Soft start is implemented by adding a capacitor between REF and DTC.

The voltage, V_{DT}, required to limit the duty cycle to a maximum value is given by

$$V_{DT} = V_{O(max)} - D(V_{O(max)} - V_{O(min)}) - 0.65$$

where $V_{O(max)}$ and $V_{O(min)}$ are obtained from Figure 9, and D is the maximum duty cycle.

Predicting the regulator startup or rise time is complicated because it depends on many variables, including: input voltage, output voltage, filter values, converter topology, and operating frequency. In general, the output will be in regulation within two time constants of the soft-start circuit. A five-to-ten millisecond time constant usually works well for low-power converters.

The DTC input can be grounded in applications where achieving a 100% duty cycle is desirable, such as a buck converter with a very low input-to-output differential voltge. However, grounding DTC prevents the inplementation of soft start, and the output voltage overshoot at power-on is likely to be very large. A better arrangement is to omit R_{DT1} (see Figure 4) and choose R_{DT2} = 47 k Ω . This configuration ensures that the duty cycle can reach 100% and still allows the designer to implement soft start using C_{SS} .

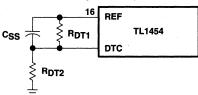


Figure 4. Dead-Time Control and Soft Start

PWM comparator

Each of the PWM comparators has dual inverting inputs. One inverting input is connected to the output of the error amplifier; the other inverting input is connected to the DTC terminal. Under normal operating conditions, when either the error-amplifier output or the dead-time control voltage is higher than that for the PWM triangle wave, the output stage is set inactive (OUT1 low and OUT2 high), turning the external power stage off.

undervoltage-lockout (UVLO) protection

The undervoltage-lockout circuit turns the output circuit off and resets the SCP latch whenever the supply voltage drops too low (to approximately 2.9 V) for proper operation. A hysteresis voltage of 200 mV eliminates false triggering on noise and chattering.

short-circuit protection (SCP)

The TL1454 SCP function prevents damage to the power switches when the converter output is shorted to ground. In normal operation, SCP comparator 1 clamps SCP to approximately 185 mV. When one of the converter outputs is shorted, the error amplifier output (COMP) will be driven below 1 V to maximize duty cycle and force the converter output back up. When the error amplifier output drops below 1 V, SCP comparator 1 releases SCP, and capacitor, C_{SCP} , which is connected between SCP and GND, begins charging. If the error-amplifier output rises above 1 V before C_{SCP} is charged to 1 V, SCP comparator 1 discharges C_{SCP} and normal operation resumes. If C_{SCP} reaches 1 V, SCP comparator 2 turns on and sets the SCP latch, which turns off the output drives and resets the soft-start circuit. The latch remains set until the supply voltage is lowered to 2 V or less, or C_{SCP} is discharged externally.



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short-circuit protection (SCP) (continued)

The SCP time-out period must be greater than the converter start-up time or the converter will not start. Because high-value capacitor tolerances tend to be $\pm 20\%$ or more and IC resistor tolerances are loose as well, it is best to choose an SCP time-out period ten-to-fifteen times greater than the converter startup time. The value of C_{SCP} may be determined using Figure 6, or it can be calculated using:

$$C_{SCP} = \frac{T_{SCP}}{80.3}$$

where C_{SCP} is in μF and T_{SCP} is the time-out period in ms.

output stage

The output stage of the TL1454 is a totem-pole output with a maximum source/sink current rating of 40 mA and a voltage rating of 20 V. The output is controlled by a complementary output AND gate and is turned on (sourcing current for OUT1, sinking current for OUT2) when all the following conditions are met: 1) the oscillator triangle wave voltage is higher than both the DTC voltage and the error-amplifier output voltage, 2) the undervoltage-lockout circuit is inactive, and 3) the short-circuit protection circuit is inactive.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)	
Error amplifier input voltage: IN1+, IN1-, IN2+, IN2	
Output voltage: OUT1, OUT2	20 V
Continuous output current: OUT1, OUT2	±200 mA
Peak output current: OUT1, OUT2	
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range, TA: C suffix	–20°C to 85°C
I suffix	–40°C to 85°C
Storage temperature range, T _{stq}	–65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to network GND.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	950 mW	7.6 mW/°C	608 mW	494 mW
N	1250 mW	10.0 mW/°C	800 mW	650 mW
PW	500 mW	4.0 mW/°C	320 mW	260 mW

recommended operating conditions

				MIN	MAX	UNIT
Supply voltage, V _{CC}				3.6	20	٧
Error amplifier common-mode input volta	ige			-0.2	1.45	V
Output voltage, VO					20	V
Output current, IO					±40	mA
COMP source current					-45	μΑ
COMP sink current					100	μΑ
Reference output current		-	 		1	mA
COMP dc load resistance				100		kΩ
Timing capacitor, C _T				10	4000	pF
Timing resistor, R _T				5.1	100	kΩ
Oscillator frequency				50	2000	kHz
Operating free cir temperature T.	TL1454C			-20	85	°C
Operating free-air temperature, TA	TL1454I		 	-40	85	10

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 6 V, f_{OSC} = 500 kHz (unless otherwise noted)

reference

	PARAMETER	TEST COND	TIONS	TL1454			UNIT
	PARAMETER	IEST COND	IIIONS	MIN	TYP	MAX	UNIT
V .	Output voltage DEE	I _O = 1 mA,	T _A = 25°C	1.23	1.25	1.28	V
V _{ref}	Output voltage, REF	I _O = 1 mA		1.2		1.31	V
	Input regulation	$V_{OC} = 3.6 \text{ V to } 20 \text{ V},$	I _O = 1 mA		2	6	mV
	Output regulation	I _O = 0.1 mA to 1 mA			1	7.5	mV
	Output valtage shangs with temperature	$T_A = T_{A(min)}$ to 25°C,	I _O = 1 mA	-12.5	-1.25	12.5	mV
	Output voltage change with temperature	$T_A = 25^{\circ}C \text{ to } 85^{\circ}C,$	I _O = 1 mA	-12.5	-2.5	12.5	IIIV
los	Short-circuit output current	V _{ref} = 0 V			30		mA

undervoltage lockout (UVLO)

	PARAMETER	TEST CONDITIONS		UNIT		
	PARAMETER	MIN T				UNIT
V _{IT+}	Positive-going threshold voltage			2.9		٧
VIT-	Negative-going threshold voltage	T _A = 25°C		2.7		V
V _{hys}	Hysteresis, V _{IT+} – V _{IT}		100	200		mV

short-circuit protection (SCP)

	DADAMETED	7507.001	TEST CONDITIONS		TL1454			
	PARAMETER	TEST CONL			TYP	MAX	UNIT	
V _{IT}	Input threshold voltage	T _A = 25°C		0.95	1	1.05	٧	
v _{stby} †	Standby voltage	NaIII		140	185	230	mV	
V _I (latched)	Latched-mode input voltage	No pullup			60	120	mV	
VIT(COMP)	Comparator threshold voltage	COMP1, COMP2			1		٧	
	Input source current	T _A = 25°C,	V _{O(SCP)} = 0	-5	-15	-20	μА	

[†] This symbol is not presently listed within EIA/JEDEC standards for semiconductor symbology.

oscillator

	PARAMETER	TEC	ST CONDITIONS TL145		L1454		UNIT
	PARAMETER	159	CONDITIONS	MIN	TYP	MAX	UNIT
fosc	Frequency	C _T = 120 pF,	$R_T = 10 \text{ k}\Omega$		500		kHz
	Standard deviation of frequency				50		kHz
	Frequency change with voltage	V _{CC} = 3.6 V to 20	V, T _A = 25°C		5		kHz
	Fragues at the page with towns and the	$T_A = T_{A(min)}$ to 25	5°C		-2	±20	kHz
	Frequency change with temperature	$T_A = 25^{\circ}C \text{ to } 85^{\circ}C$)		-10	±20	KHZ
	Maximum ramp voltage				1.8		٧
	Minimum ramp voltage				1.1		V

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 6 V, f_{OSC} = 500 kHz (unless otherwise noted) (continued)

dead-time control (DTC)

,	PARAMETER	TEST CONDITIONS				
	PARAMETER TEST CONDITIONS		MIN	TYP	MAX	UNIT
V.		Duty cycle = 0%	1	1.1	1.2	V
VIT	Input threshold voltage	Duty cycle = 100%	0.4 0.5	0.6		
V _{I(latched)}	Latched-mode input voltage			1.2		٧
lВ	Common-mode input bias current	DTC1, IN1+ ≈ 1.2 V			4	μА
	Latched-mode (source) current	T _A = 25°C		-100		μΑ

error-amplifier

	DADAMETED	TEGT COMPLETIONS	TL	TL1454			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
V _{IO}	Input offset voltage				6	mV	
lo	Input offset current	V _O = 1.25 V, V _{IC} = 1.25 V			100	nA	
I _{IB}	Input bias current			-160	-500	nA	
VICR	Input voltage range	V _{CC} = 3.6 V to 20 V	-0.2 to 1.45			· V	
Ay	Open-loop voltage gain	R _{FB} = 200 kΩ	70	80		dB	
	Unity-gain bandwidth			3		MHz	
CMRR	Common-mode rejection ratio		60	80		dB	
V _{OM(max)}	Positive output voltage swing		2.3	2.43		v	
VOM(min)	Negative output voltage swing			0.63	0.8]	
lO+	Output sink current	$V_{ID} = -0.1 \text{ V}, \qquad V_{O} = 1.20 \text{ V}$	0.1	0.5		mA	
10-	Output source current	V _{ID} = 0.1 V, V _O = 1.80 V	-45	-70		μΑ	

output

	DADAMETED	TEST CONDITIONS		TL1454			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
VOH	High level cute it valte as	$I_O = -8 \text{ mA}$	V _{CC} -2	4.5		V	
	High-level output voltage	I _O = -40 mA	V _{CC} -2	4.4		V .	
V-:	Low lovel subsubvelters	I _O = 8 mA		0.1	0.4	ı v	
VOL	Low-level output voltage	I _O = 40 mA		1.8	2.5	V	
t _{rv}	Output voltage rise time	O 2000 = T 0500		220			
tfv	Output voltage fall time	$C_L = 2000 \text{ pF}, T_A = 25^{\circ}C$		220		ns	

supply current

PARAMETER		TEST CONDITIONS	TL1454			UNIT
		TEST CONDITIONS	MIN TYP MAX		MAX] 01111
ICC(stdby)	Standby supply current	RT open, CT = 1.5 V, V _O (COMP1, COMP2) = 1.25 V, No load		3.1	6	mA
ICC(average)	Average supply current	R_T = 10 k Ω , C_T = 120 pF, 50% duty cycle, Outputs open		3.5	7	mA

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electrical characteristics, V_{CC} = 6 V, f_{OSC} = 500 kHz, T_A = 25°C (unless otherwise noted)

reference

	DADAUETED	TEST COMPLETIONS	Т	TL1454Y		TL1454Y		
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
V _{ref}	Output voltage, REF	I _O = 1 mA,		1.25		٧		
	Input regulation	$V_{OC} = 3.6 \text{ V to } 20 \text{ V}, I_{O} = 1 \text{ mA}$		2		mV		
	Output regulation	I _O = 0.1 mA to 1 mA		1		mV		
		I _O = 1 mA	-1.25	-1.25		>/		
	Output voltage change with temperature	I _O = 1 mA	-2.5			mV		
los	Short-circuit output current	V _{ref} = 0 V		30		mA		

undervoltage lockout (UVLO)

PARAMETER		TEST CONDITIONS	Т	UNIT			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNII	
V _{IT+}	Positive-going threshold voltage			2.9		٧	
V _{IT} -	Negative-going threshold voltage			2.7		V	
V _{hys}	Hysteresis, V _{IT+} – V _{IT}	7		200		mV	

short-circuit protection (SCP)

	DADAMETED	TEST CONDITIONS	T	TL1454Y			
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
V _{IT}	Input threshold voltage			1		٧	
v _{stby} †	Standby voltage	Namelle		185		mV	
V _I (latched)	Latched-mode input voltage	No pullup		60		mV	
VIT(COMP)	Comparator threshold voltage	COMP1, COMP2		1		٧	
	Input source current	V _{O(SCP)} = 0		-15		μΑ	

[†] This symbol is not presently listed within EIA/JEDEC standards for semiconductor symbology.

oscillator

PARAMETER		TEO	TEST CONDITIONS		TL1454Y			
		IES			TYP	MAX	UNIT	
fosc	Frequency	C _T = 120 pF,	$R_T = 10 \text{ k}\Omega$		500		kHz	
	Standard deviation of frequency				50		kHz	
	Frequency change with voltage	V _{CC} = 3.6 V to 20	V		5		kHz	
	Frequency change with temperature		-		-2	,	kHz	
					-10			
	Maximum ramp voltage				1.8		V	
	Minimum ramp voltage		the second second		1.1		٧	

TL1454, TL1454Y DUAL-CHANNEL PULSE-WIDTH-MODULATION (PWM) CONTROL CIRCUITS

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electrical characteristics, $V_{CC} = 6 \text{ V}$, $f_{OSC} = 500 \text{ kHz}$, $T_A = 25^{\circ}\text{C}$ (unless otherwise noted) (continued)

dead-time control (DTC)

PARAMETER		TEST CONDITIONS	TL1454Y			UNIT
		TEST CONDITIONS	MIN	TYP	MAX	UNII
V _{IT} Input threshold voltage	Duty cycle = 0%		1.1		V	
	input threshold voltage	Duty cycle = 100%		0.5		•
V _{I(latched)}	Latched-mode input voltage			1.2		٧
	Latched-mode (source) current			-100		μΑ

error-amplifier

PARAMETER		TEST OF	TEST CONDITIONS				UNIT
		IESI CI	TEST CONDITIONS		TYP	MAX	UNII
IB	Input bias current	$V_0 = 1.25 V$,	V _{IC} = 1.25 V		-160		nA
Av	Open-loop voltage gain	$R_{FB} = 200 \text{ k}\Omega$			80		dB
	Unity-gain bandwidth				. 3		MHz
CMRR	Common-mode rejection ratio				80		dB
V _{OM(max)}	Positive output voltage swing				2.43		V
V _{OM(min)}	Negative output voltage swing				0.63		V
10+	Output sink current	$V_{ID} = -0.1 V$,	V _O = 1.20 V		0.5		mA
10-	Output source current	V _{ID} = 0.1 V,	V _O = 1.80 V		-70		μА

output

PARAMETER		TEST CONDITIONS	TL1454Y	UNIT
		TEST CONDITIONS	MIN TYP MAX	UNII
Var. High level collections		I _O = -8 mA	4.5	V
VOH High-level output voltage	I _O = -40 mA	4.4		
V	Low-level output voltage	I _O = 8 mA	0.1	V
VOL	Low-level output voltage	I _O = 40 mA	1.8	
trv	Output voltage rise time	C. 2000 = E	220	
t _{fv}	Output voltage fall time	C _L = 2000 pF	220	ns

supply current

	PARAMETER	TEST CONDITIONS TL14		TL1454Y		UNIT
PARAMETER		TEST CONDITIONS		TYP	MAX	ONI
ICC(stdby)	Standby supply current	RT open, CT = 1.5 V, V _O (COMP1, COMP2) = 1.25 V, No load		3.1		mA
ICC(average)	Average supply current	R_T = 10 k Ω , C_T = 120 pF, 50% duty cycle, Outputs open		3.5		mA

PARAMETER MEASUREMENT INFORMATION

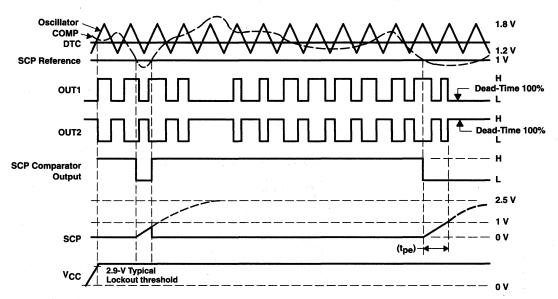
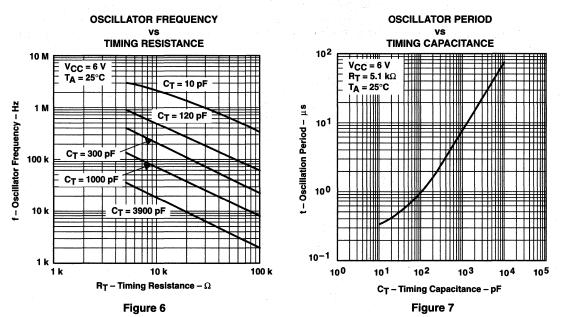


Figure 5. Timing Diagram

TYPICAL CHARACTERISTICS



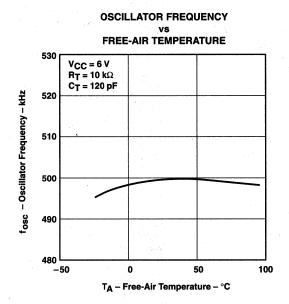


Figure 8

DTC INPUT THRESHOLD VOLTAGE

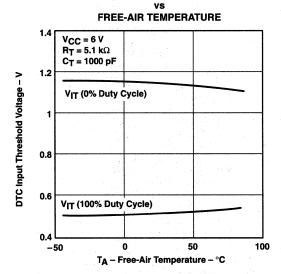


Figure 10

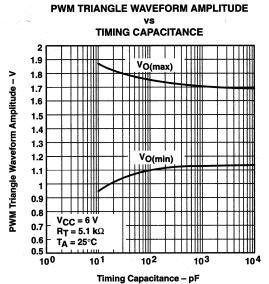


Figure 9

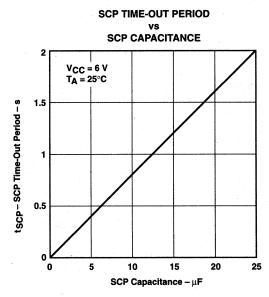
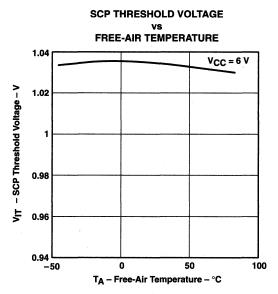


Figure 11

SCP LATCH RESET VOLTAGE

TYPICAL CHARACTERISTICS



FREE-AIR TEMPERATURE

3.5

VCC = 6 V

2.5

1.5

Figure 12

UVLO THRESHOLD VOLTAGE

VS
FREE-AIR TEMPERATURE

3.5

VIT(H)

VIL(L)

1.5

-50 -25 0 25 50 75 100

Figure 13

T_A - Free-Air Temperature - °C

-25

-50

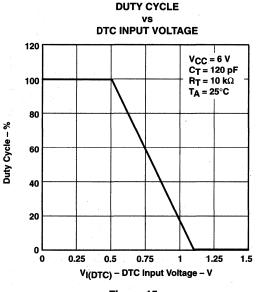


Figure 14

T_A - Free-Air Temperature - °C

100

SOURCE CURRENT 2.5 V_{CC} = 6 V V_{ID} = 0.1 V T_A = 25°C

Figure 16

ERROR AMPLIFIER MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE SWING

Source Current - µA

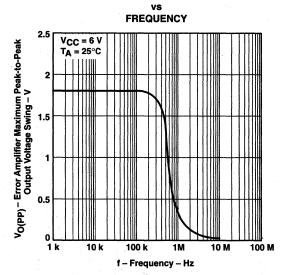


Figure 18

ERROR-AMPLIFIER MINIMUM OUTPUT VOLTAGE

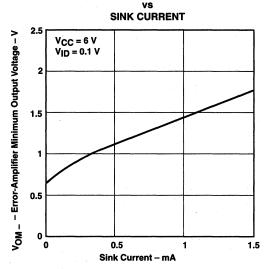


Figure 17

ERROR-AMPLIFIER MINIMUM OUTPUT VOLTAGE SWING

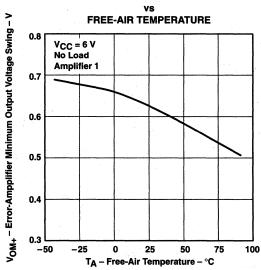


Figure 19

ERROR AMPLIFIER OPEN-LOOP GAIN AND PHASE SHIFT

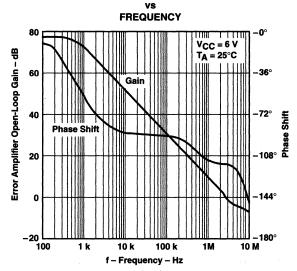


Figure 20

ERROR-AMPLIFIER POSITIVE OUTPUT VOLTAGE SWING

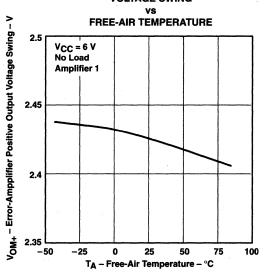


Figure 21

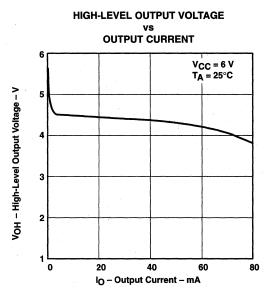


Figure 22

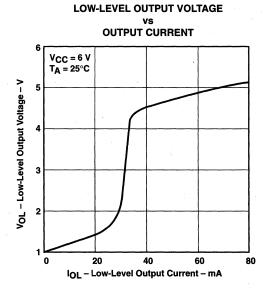


Figure 24

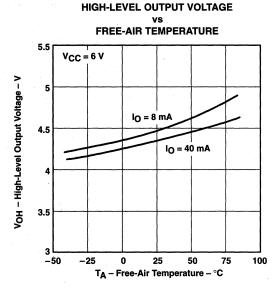


Figure 23

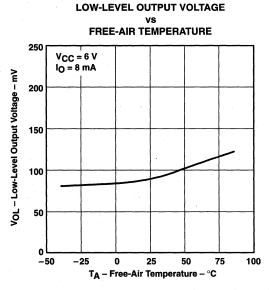


Figure 25

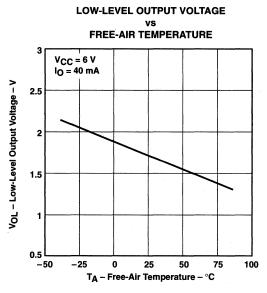


Figure 26

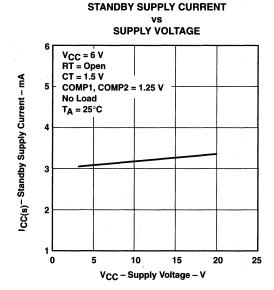


Figure 28

AVERAGE SUPPLY CURRENT vs

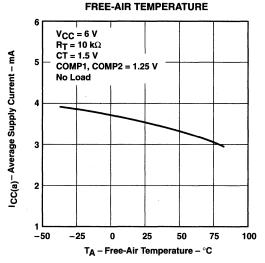


Figure 27

STANDBY SUPPLY CURRENT

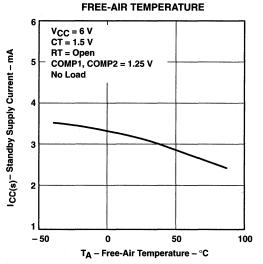
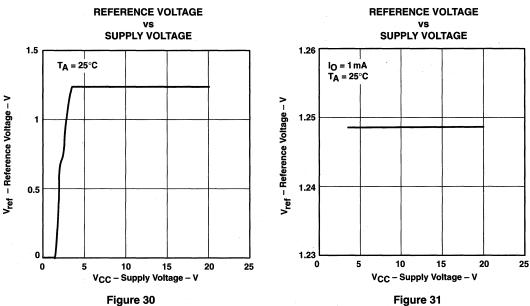


Figure 29



REFERENCE VOLTAGE

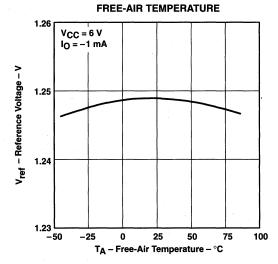
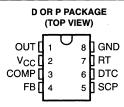


Figure 32

SLVS084C - APRIL 1994 - REVISED SEPTEMBER 1995

Complete PWM Power Control

- 3.6-V to 40-V Operation
- Internal Undervoltage-Lockout Circuit
- Internal Short-Circuit Protection
- Oscillator Frequency . . . 40 kHz to 400 kHz
- Variable Dead Time Provides Control Over Total Range



description

The TL5001 incorporates on a single monolithic chip all the functions required for a pulse-width-modulation (PWM) control circuit. Designed primarily for power-supply control, the TL5001 contains an error amplifier, a regulator, an oscillator, a PWM comparator with a dead-time-control input, undervoltage lockout (UVLO), short-circuit protection (SCP), and an open-collector output transistor.

The error-amplifier common-mode voltage ranges from 0 V to 1.5 V. The noninverting input of the error amplifier is connected to a 1-V reference. Dead-time control (DTC) can be set to provide 0% to 100% dead time by connecting an external resistor between DTC and GND. The oscillator frequency is set by terminating RT with an external resistor to GND. During low V_{CC} conditions, the UVLO circuit turns the output off until V_{CC} recovers to its normal operating range.

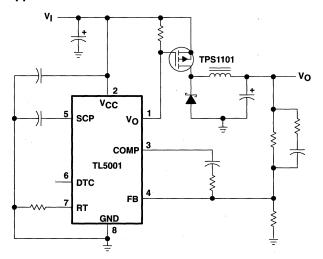
The TL5001C is characterized for operation from -20° C to 85°C. The TL5001I is characterized for operation from -40° C to 85°C.

AVAILABLE OPTIONS

	PACKAGED	DEVICES	
TA	SMALL OUTLINE (D)	PLASTIC DIP (P)	CHIP FORM (Y)
-20°C to 85°C	TL5001CD	TL5001CP	TL5001Y
-40°C to 85°C	TL5001ID	TL5001IP	_

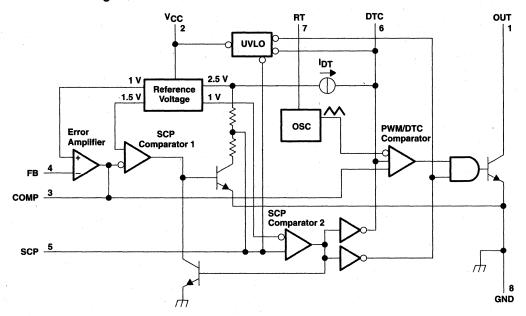
The D package is available taped and reeled. Add the suffix R to the device type (e.g., TL5001CDR). Chip forms are tested at $T_A = 25$ °C.

schematic for typical application



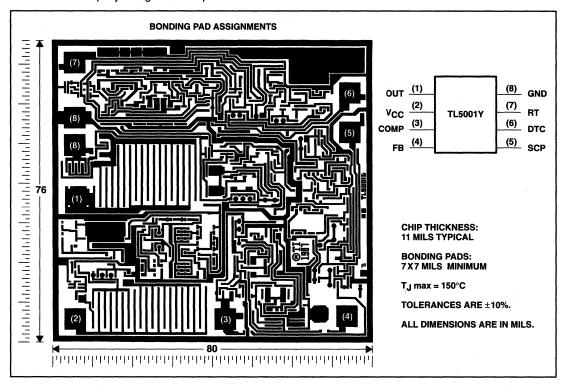
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functional block diagram



TL5001Y chip information

This chip, when properly assembled, displays characteristics similar to the TL5001C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



detailed description

voltage reference

A 2.5-V regulator operating from V_{CC} is used to power the internal circuitry of the TL5001 and as a reference for the error amplifier and SCP circuits. A resistive divider provides a 1-V reference for the error amplifier noninverting input. The 1-V reference remains within 5% of nominal over the operating temperature range.

error amplifier

The error amplifier compares a sample of the dc-to-dc converter output voltage to the 1-V reference and generates an error signal for the PWM comparator. The dc-to-dc converter output voltage is set by selecting the error-amplifier gain (see Figure 1), using the following expression:

$$V_0 = (1 + R1/R2) (1 V)$$

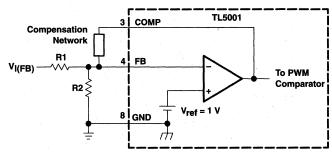


Figure 1. Error-Amplifier Gain Setting

error amplifier (continued)

The error-amplifier output is brought out as COMP for use in compensating the dc-to-dc converter control loop for stability. Because the amplifier can only source 45 μ A, the total dc load resistance should be 100 k Ω or more.

oscillator/PWM

The oscillator frequency (f_{osc}) can be set between 40 kHz and 400 kHz by connecting a resistor between RT and GND. Acceptable resistor values range from 15 k Ω to 250 k Ω . The oscillator frequency can be determined by using the graph shown in Figure 5.

The oscillator output is a triangular wave with a minimum value of approximately 0.7 V and a maximum value of approximately 1.3 V. The PWM comparator compares the error-amplifier output voltage and the DTC input voltage to the triangular wave and turns the output transistor off whenever the triangular wave is greater than the lesser of the two inputs.

dead-time control (DTC)

DTC provides a means of limiting the output-switch duty cycle to a value less than 100%, which is critical for boost and flyback converters. A current source generates a reference current (IDT) at DTC that is nominally equal to the current at the oscillator timing terminal, RT. Connecting a resistor between DTC and GND generates a dead-time reference voltage (VDT), which the PWM/DTC comparator compares to the oscillator triangle wave as described in the previous section. Nominally, the maximum duty cycle is 0% when V_{DT} is 0.7 V or less and 100% when V_{DT} is 1.3 V or greater. Because the triangle wave amplitude is a function of frequency and the source impedance of RT is relatively high (1250 Ω), choosing R_{DT} for a specific maximum duty cycle, D, is accomplished using the following equation and the voltage limits for the frequency in question as found in Figure 11 (V_{osc}max and V_{osc}min are the maximum and minimum oscillator levels):



$$R_{DT} = (R_t + 1250) [D(V_{osc}max - V_{osc}min) + V_{osc}min]$$

where

RDT and Rt are in ohms, D in decimal

Soft start can be implemented by paralleling the DTC resistor with a capacitor (C_{DT}) as shown in Figure 2. During soft start, the voltage at DTC is derived by the following equation:

$$V_{DT} \approx I_{DT}R_{DT} \left(1 - e^{\left(-t/R_{DT}C_{DT}\right)}\right)$$

$$c_{DT} = \frac{6}{2} DTC \qquad TL5001$$

Figure 2. Soft-Start Circuit

If the dc-to-dc converter must be in regulation within a specified period of time, the time constant, $R_{DT}C_{DT}$, should be $t_0/3$ to $t_0/5$. The TL5001 remains off until $V_{DT} \approx 0.7$ V, the minimum ramp value. C_{DT} is discharged every time UVLO or SCP becomes active.

undervoltage-lockout (UVLO) protection

The undervoltage-lockout circuit turns the output transistor off and resets the SCP latch whenever the supply voltage drops too low (approximately 3 V) for proper operation. A hysteresis voltage of 200 mV eliminates false triggering on noise and chattering.

short-circuit protection (SCP)

The TL5001 includes short-circuit protection (see Figure 3), which turns the power switch off to prevent damage when the converter output is shorted. When activated, the SCP prevents the switch from being turned on until the internal latching circuit is reset. The circuit is reset by reducing the input voltage until UVLO becomes active or until the SCP terminal is pulled to ground externally.

When a short circuit occurs, the error-amplifier output at COMP rises to increase the power-switch duty cycle in an attempt to maintain the output voltage. SCP comparator 1 starts an RC timing circuit when COMP exceeds 1.5 V. If the short is removed and the error-amplifier output drops below 1.5 V before time out, normal converter operation continues. If the fault is still present at the end of the time-out period, the timer sets the latching circuit and turns off the TL5001 output transistor.

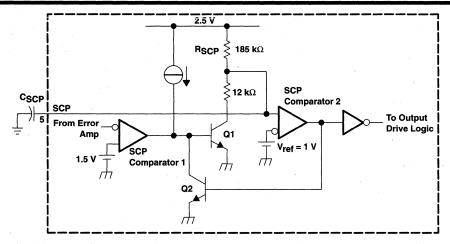


Figure 3. SCP Circuit

The timer operates by charging an external capacitor (C_{SCP}), connected between the SCP terminal and ground, towards 2.5 V through a 185-k Ω resistor (R_{SCP}). The circuit begins charging from an initial voltage of approximately 185 mV and times out when the capacitor voltage reaches 1 V. The output of SCP comparator 2 then goes high, turns on Q2, and latches the timer circuit. The expression for setting the SCP time period is derived from the following equation:

$$V_{SCP} = (2.5 - 0.185)(1 - e^{-t/\tau}) + 0.185$$

where

$$\tau = R_{SCP}C_{SCP}$$

The end of the time-out period, t_{SCP} occurs when $V_{SCP} = 1$ V. Solving for C_{SCP} yields:

$$C_{SCP} = 12.46 \times t_{SCP}$$

where

t is in seconds, C in µF.

t_{SCP} must be much longer (generally 10 to 15 times) than the converter start-up period or the converter will not start.

output transistor

The output of the TL5001 is an open-collector transistor with a maximum collector current rating of 21 mA and a voltage rating of 51 V. The output is turned on under the following conditions: the oscillator triangle wave is lower than both the DTC voltage and the error-amplifier output voltage, the UVLO circuit is inactive, and the short-circuit protection circuit is inactive.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)		41 V
Amplifier input voltage, V _{I(FB)}		20 V
Output voltage, VO, OUT		51 V
Output current, IO, OUT		21 mA
Output peak current, IO(peak), OUT		100 mA
Output peak current, I _{O(peak)} , OUT Continuous total power dissipation		. See Dissipation Rating Table
Operating ambient temperature range, TA:	TL5001C	–20°C to 85°C
	TL5001I	
Storage temperature range, T _{stg}		65°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from	case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to network ground terminal.

DISSIPATION RATING TABLE

	_			
PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW
Р	1000 mW	8.0 mW/°C	640 mW	520 mW

recommended operating conditions

			MIN	MAX	UNIT
Supply voltage, V _{CC}			3.6	40	V
Amplifier input voltage, V _{I(FB)}			0	1.5	V
Output voltage, VO, OUT		÷ -		50	V
Output current, IO, OUT				20	mA
COMP source current				45	μΑ
COMP de load resistance			100		kΩ
Oscillator timing resistor, Rt			15	250	kΩ
Oscillator frequency, fosc			40	400	kHz
Operating ambient temperature, T _A	TL5001C		-20	85	°C
	TL5001I		-40	85	

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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 6 V, f_{OSC} = 100 kHz (unless otherwise noted)

reference

DADAMETED	TEST CONDITIONS	TL50	TL5001C, TL5001I			
PARAMETER	TEST CONDITIONS		TYPT	MAX	UNIT	
Output voltage	COMP connected to FB	0.95	1	1.05	٧	
Input regulation	V _{CC} = 3.6 V to 40 V		2	12.5	mV	
	T _A = -20°C to 25°C (TL5001C)	-10	-1	10		
Output voltage change with temperature	T _A = -40°C to 25°C (TL5001I)	-10	-1	10	mV/V	
	T _A = 25°C to 85°C	-10	-2	10		

[†] All typical values are at T_A = 25°C.

undervoltage lockout

	PARAMETER	TL50	TL5001C, TL5001I		
		MIN	TYP	MAX	
Upper threshold voltage			3		٧
Lower threshold voltage			2.8		٧
Hysteresis		100	200		mV

[†] All typical values are at T_A = 25°C.

short-circuit protection

PARAMETER	TEST SOMPLEIONS	TL50			
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
SCP threshold voltage	T _A = 25°C	0.95	1.00	1.05	٧
SCP voltage, latched	No pullup	140	185	230	mV
SCP voltage, UVLO standby	No pullup		60	120	mV
Timing resistance			185		kΩ
SCP comparator 1 threshold voltage			1.5		V

[†] All typical values are at $T_A = 25$ °C.

oscillator

DADAMETED	TEGT COMPLETIONS	TL50			
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Frequency	$R_t = 100 \text{ k}\Omega$		97		kHz
Standard deviation of frequency			15		kHz
Frequency change with voltage	V _{CC} = 3.6 V to 40 V		1		kHz
Fusion and the second state Assessment	T _A = -20°C to 25°C	-4	-0.4	4	1.1 1
Frequency change with temperature	T _A = 25°C to 85°C	-4	-0.2	4	kHz
Voltage at RT			1		V

[†] All typical values are at T_A = 25°C.



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electrical characteristics over recommended operating free-air temperature range, V_{CC} = 6 V, f_{OSC} = 100 kHz (unless otherwise noted) (continued)

dead-time control

PARAMETER	TEST CONDITIONS	TL500	UNIT		
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output (source) current		0.9 × I _{RT} ‡		1.1 × IRT	μΑ
Input threehold veltage	Duty cycle = 0%	0.5	0.7		v
Input threshold voltage	Duty cycle = 100%		1.3	1.5	, v

[†] All typical values are at T_A = 25°C. ‡ Output source current at RT

error amplifier

PARAMETER		TEST CONDITIONS	TL50	TL5001C, TL5001I			
PAHAMETER	PARAMETER		MIN	TYP	MAX	UNIT	
Input voltage		V _{CC} = 3.6 V to 40 V	0		1.5	V	
Input bias current	The second second			-160	-500	nA	
Output voltage swing	Positive		1.5	2.3		٧	
Output voltage swing	Negative			0.3	0.4	٧	
Open-loop voltage amplification				80		dB	
Unity-gain bandwidth				1.5		MHz	
Output (sink) current		V _{I(FB)} = 1.2 V, COMP = 1 V	100	600		μΑ	
Output (source) current		V _{I(FB)} = 0.8 V, COMP = 1 V	-45	-90		μΑ	

[†] All typical values are at $T_A = 25$ °C.

output

PARAMETER	TEST COMPLETIONS	TL5001C, TL5	LIMIT	
PARAMETER	TEST CONDITIONS	MIN TYPT	MAX	UNIT
Output saturation voltage	I _O = 10 mA	1.5	2	٧
Off-state current	V _O = 50 V, V _{CC} = 0		10	
On-state current	V _O = 50 V		10	μA
Short-circuit output current	V _O = 6 V	40		mA

[†] All typical values are at $T_A = 25$ °C.

total device

PARAMETER		\(\)	TECT COMPLETIONS	TL50	UNIT		
PARAMETER			TEST CONDITIONS	MIN	TYP	MAX	ONII
Standby supply current		Off state			1	1.5	mA
Average supply current			$R_t = 100 \text{ k}\Omega$		1.1	2.1	mA

[†] All typical values are at $T_A = 25$ °C.



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electrical characteristics, V_{CC} = 6 V, f_{OSC} = 100 kHz, T_A = 25°C (unless otherwise noted)

reference

PARAMETER	TEST CONDITIONS		TL5001Y			
PANAMETEN	TEST CONDITIONS		TYP	MAX	UNIT	
Output voltage	COMP connected to FB		1		٧	
Input regulation	V _{CC} = 3.6 V to 40 V		2		mV	
Output voltage change with temperature			-2		mV/V	

undervoltage lockout

	PARAMETER		PARAMETER			Т	L5001Y		UNIT
				MIN	TYP	MAX			
Upper threshold voltage					3		٧		
Lower threshold voltage					2.8		٧		
Hysteresis			:		200		mV		

short-circuit protection

PARAMETER	TEST CONDITIONS	TL5001Y	UNIT
PARAMETER	I EST CONDITIONS	MIN TYP MAX	UNIT
SCP threshold voltage		1	٧
SCP voltage, latched	No pullup	185	mV
SCP voltage, UVLO standby	No pullup	60	mV
Timing resistance		185	kΩ
SCP comparator 1 threshold voltage		1.5	V

oscillator

PARAMETER	TEST CONDITIONS	TL5001Y	UNIT
FARAMETER	l rest conditions	MIN TYP MAX	UNII
Frequency	$R_t = 100 \text{ k}\Omega$	97	kHz
Standard deviation of frequency		15	kHz
Frequency change with voltage	V _{CC} = 3.6 V to 40 V	. 1	kHz
Frequency change with temperature		-0.4	kHz
Frequency change with temperature		-0.2	KHZ
Voltage at RT		1	V

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electrical characteristics, V_{CC} = 6 V, f_{osc} = 100 kHz, T_A = 25°C (unless otherwise noted) (continued)

dead-time control

PARAMETER	TEST CONDITIONS	7	UNIT		
PANAMETER	1E31 CONDITIONS	MIN	TYP	MAX	UNIT
Input threshold voltage	Duty cycle = 0%		0.7		V
Input threshold voltage	Duty cycle = 100%		1.3		ľ

error amplifier

PARAMETER		TEST COL	NDITIONS	Т	L5001Y		UNIT
FARAMETER		IESI COI	MIN	TYP	MAX	ONLI	
Input bias current					-160		nA
Outrot valters avier	Positive				2.3		٧
Output voltage swing	Negative				0.3		٧
Open-loop voltage amplification					80		dB
Unity-gain bandwidth	1				1.5		MHz
Output (sink) current		V _{I(FB)} = 1.2 V,	COMP = 1 V		600		μА
Output (source) current		$V_{I(FB)} = 0.8 \text{ V},$	COMP = 1 V		-90		μА

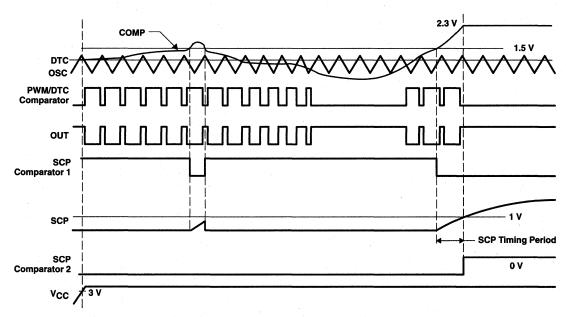
output

PARAMETER	TECT COMPITIONS	Т	UNIT		
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output saturation voltage	I _O = 10 mA		1.5	2	٧
Short-circuit output current	V _O = 6 V		40		mA

total device

PARAMETER		TEST CONDITIONS	Т	L5001Y		UNIT
PARAMETER		1EST CONDITIONS	MIN	TYP	MAX	UNIT
Standby supply current	Off state			1		mA
Average supply current		$R_t = 100 \text{ k}\Omega$		1.1		mA ·

PARAMETER MEASUREMENT INFORMATION



NOTE A. The waveforms show timing characteristics for an intermittent short circuit and a longer short circuit that is sufficient to activate SCP.

Figure 4. PWM Timing Diagram

TYPICAL CHARACTERISTICS

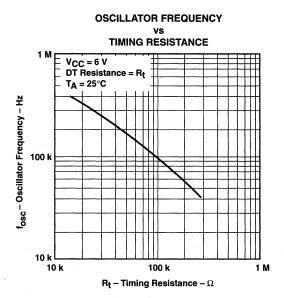


Figure 5

REFERENCE OUTPUT VOLTAGE vs

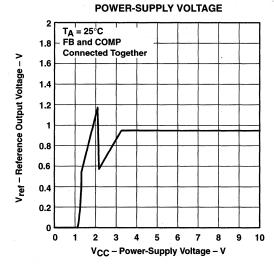


Figure 7

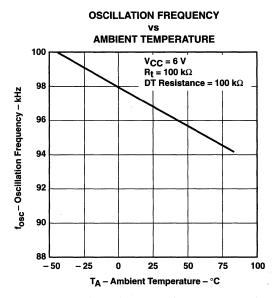


Figure 6

REFERENCE OUTPUT VOLTAGE FLUCTUATION

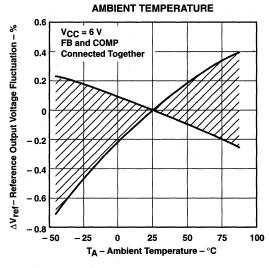


Figure 8

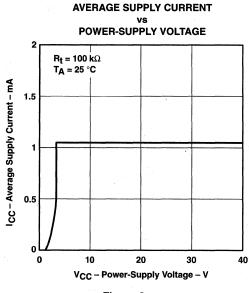


Figure 9

PWM TRIANGLE WAVE AMPLITUDE VOLTAGE OSCILLATOR FREQUENCY

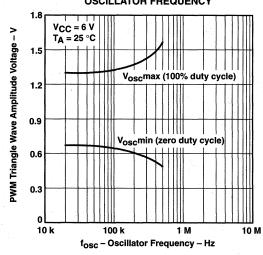


Figure 11

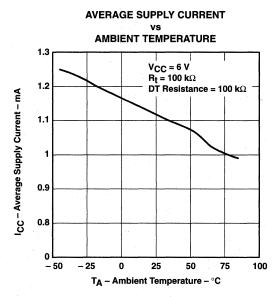


Figure 10

ERROR AMPLIFIER OUTPUT VOLTAGE

OUTPUT (SINK) CURRENT V_{CC} = 6 V V_{I(FB)} = 1.2 V V_O - Error Amplifier Output Voltage - V TA = 25 °C 2.5 2 1.5

0.5 0 0.2 0 0.4 IO - Output (Sink) Current - mA

0.6

Figure 12

1

ERROR AMPLIFIER OUTPUT VOLTAGE

TYPICAL CHARACTERISTICS

ERROR AMPLIFIER OUTPUT VOLTAGE OUTPUT (SOURCE) CURRENT 3 VCC = 6 V $V_{I(FB)} = 0.8 V$ TA = 25 °C V_O - Error Amplifier Output Voltage - V 2.5 2 1.5 1 0.5 0 60 80 100 0 120 IO - Output (Source) Current - µA

Figure 13

vs AMBIENT TEMPERATURE 2.46 VCC = 6 V V_{I(FB)} = 0.8 V No Load Vo - Error Amplifier Output Voltage - V 2.45 2.44 2.43 2.42 2.41 2.40 - 50 - 25 25 50 75 100 T_A - Ambient Temperature - °C

Figure 14

ERROR AMPLIFIER OUTPUT VOLTAGE

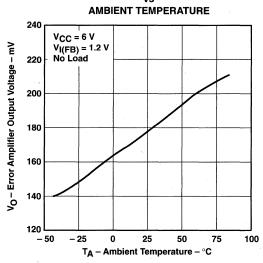


Figure 15

ERROR AMPLIFIER CLOSED-LOOP GAIN AND PHASE SHIFT

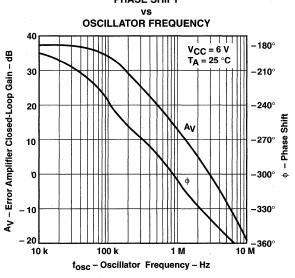
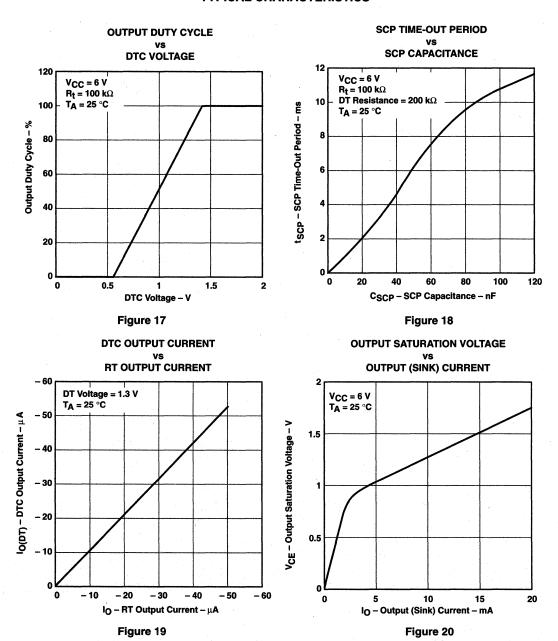


Figure 16



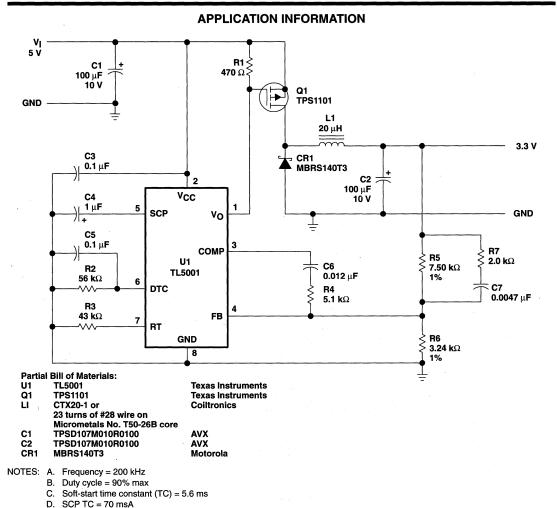


Figure 21. Step-Down Converter

EN [

COMP

SS II 3

D OR P PACKAGE (TOP VIEW)

8 [] V_{CC}

7 **[]** FB

6 DOUT

1 GND

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- Pin-for-Pin Compatible With MAX734
- Programming Voltage for Flash Memory
- 2.7-V to 11-V Input Operating Range
- Output Current of 120 mA or Greater From 3.75-V or Higher Input
- 3-μA Maximum Supply Current in Shutdown
- Only 5 External Components Required
- High Efficiency . . . 85% Typical (5-V Input, 120-mA Output)
- 8-Pin SOIC and DIP Packages
- -40°C to 85°C Free-Air Operating Temperature Range

description

The TPS6734 is a fixed 12-V output boost converter capable of delivering 120 mA from inputs as low as 3.75 V. The device is pin-for-pin compatible with the MAX734 regulator and offers the following advantages: lower supply current, wider operating input-voltage range, and higher output currents. As shown in Figure 1, the only external components required are: an inductor, a Schottky rectifier, an output filter capacitor, an input filter capacitor, and a small capacitor for loop compensation. The entire converter occupies less than 0.7 in 2 of PCB space when implemented with surface-mount components. An enable input is provided to shut the converter down and reduce the supply current to 3 μ A when 12 V is not needed.

The TPS6734 is a 170-kHz current-mode PWM (pulse-width modulation) controller with an n-channel MOSFET power switch. Gate drive for the switch is derived from the 12-V output after start-up to minimize the die area needed to realize the $0.7-\Omega$ MOSFET and improve efficiency at input voltages below 5 V. Soft start is accomplished with the addition of one small capacitor. A 1.22-V reference (pin 2) is brought out for external use.

High efficiency at low supply voltages and low supply current in shutdown make the TPS6734 particularly attractive for flash memory programming supplies, PCMCIA cards, and operational amplifiers in battery-powered equipment. The TPS6734 is available in 8-pin DIP and SOIC packages and operates over a free-air temperature range of -40°C to 85°C.

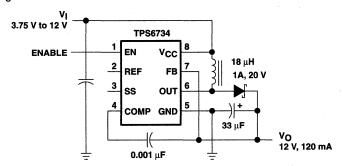


Figure 1. Typical Operating Circuit



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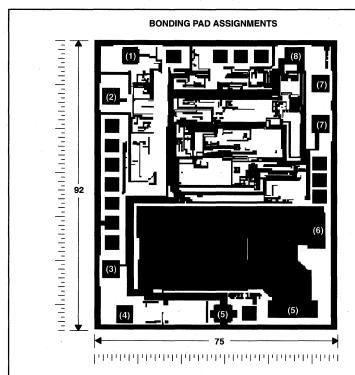
AVAILABLE OPTIONS

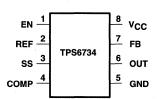
	PACKAGE		
TA	SMALL OUTLINE (D)	PLASTIC DIP (P)	
-40°C to 85°C	TPS6734ID	TPS6734IP	

The D package is available taped and reeled. Add the suffix R to the device type (e.g., TPS6734IDR).

TPS6734 chip information

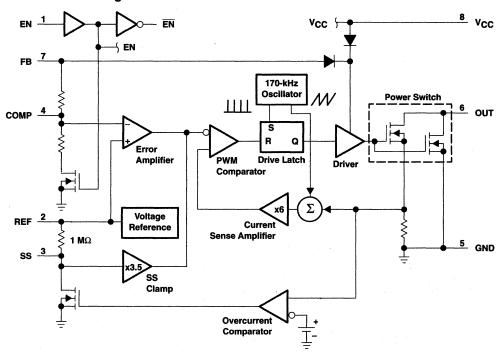
Thermal compression or ultrasonic bonding can be used on the doped-aluminum bonding pad. Chips can be mounted with conductive epoxy or a gold-silicon preform. Contact factory for die sales.





CHIP THICKNESS: 15 MILS TYPICAL BONDING PADS: 4X4 MILS MINIMUM T_Jmax = 150°C TOLERANCES ARE ±10% ALL DIMENSIONS ARE IN MILS.

functional block diagram



Terminal Functions

TERMINAL		DECORPTION
NAME	NO.	DESCRIPTION
EN	1	Enable. EN ≥ 2 V turns on the TPS6734. EN ≤ 0.4 V turns it off and reduces the supply current to 3 μA max.
REF	2	1.22-V reference voltage output. REF can source 100 μA for external loads.
SS	3	Soft Start. A capacitor between SS and GND brings the output voltage up slowly at power-up.
COMP	4	Compensation connection. A 0.001-μF capacitor between COMP and FB stabilizes the feedback loop.
GND	5	Ground
OUT	6	N-channel MOSFET drain connection
FB .	. 7	Feedback voltage. FB is connected to the converter output for the feedback loop.
VCC	- 8	Supply voltage input

TPS6734I FIXED 12-V 120-mA BOOST-CONVERTER SUPPLY

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detailed description

The following descriptions refer to the functional block diagram.

reference

The internal 1.22-V reference is brought out on REF and can source 100 μ A maximum to external loads. A 0.01- μ F to 0.1- μ F decoupling capacitor connected between REF and GND is recommended to minimize noise pickup.

oscillator and ramp generator

The oscillator circuit provides a 170-kHz clock, to set the converter operating frequency, and a timing ramp for slope compensation. The clock waveform is a pulse, a few hundred nanoseconds in duration, that is used to limit the maximum power-switch duty cycle to 95%. The timing ramp is summed with the current-sense signal at the input to the current-sense amplifier.

driver latch

The latch, which consists of a set/reset flip-flop and associated logic, is used to control the state of the power switch by turning the driver on and off. A high output from the latch turns the switch on; a low output from the latch turns it off. In normal operation, the flip-flop is set high during the clock pulse, but gating keeps the latch output low until the clock pulse is over. The latch is reset when the PWM comparator output goes high.

current-sense amplifier

The current-sense amplifier has a fixed gain of 6. It amplifies the slope-compensated current-sense voltage (a summation of the voltage on the current-sense resistor and the oscillator ramp) and feeds it to the PWM comparator.

error amplifier

The error amplifier is a high-gain differential amplifier used to regulate the converter output voltage. The amplifier generates an error signal, which is fed to the PWM comparator. The error signal is generated when a sample of the output voltage is compared to the internal reference and the difference is amplified. The output sample is obtained from a resistive divider connected between FB and GND. FB is externally connected to the converter output, and the divider output is connected to both the error amplifier input and COMP. A 0.001- μ F capacitor connected between FB and COMP stabilizes the voltage control loop.

PWM comparator

The PWM comparator resets the drive latch and turns off the power switch whenever the slope-compensated current-sense signal from the current-sense amplifier exceeds the error signal.

power switch

The power switch is a $0.7-\Omega$ n-channel MOSFET with current-sensing. The drain is connected to OUT and the current sense is connected to a resistor. The voltage across the resistor is proportional to the current in the power switch and is tied to the overcurrent comparator and the current-sense amplifier. In normal operation, the power switch is turned on at the start of each clock cycle and turned off when the PWM comparator resets the drive latch.

SS clamp

The SS (soft-start) clamp circuit limits the signal level on error-amplifier output during start-up. The voltage on SS is amplified and used to momentarily override the error-amplifier output until it rises above that output, at which point the error-amplifier takes over. This prevents the input to the PWM comparator from exceeding its common-mode range (the error-amplifier output too high to be reached by the current ramp) by limiting the maximum voltage on the error-amplifier output during start-up.



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soft start

Soft start causes the output voltage to increase to the regulation point at a controlled rate of rise. The voltage on the charging soft-start capacitor gradually raises the clamp on the error-amplifier output voltage, limiting surge currents at power-up by increasing the current-limit threshold on a cycle-by-cycle basis. Even if SS has no capacitor installed, some distributed capacitance will always be present. A soft-start cycle is initiated when either the enable signal (EN) is switched high, or an overcurrent fault condition triggers the discharge of the soft-start capacitor.

overcurrent comparator

The overcurrent comparator monitors the current in the power switch. The comparator trips and initiates a soft-start cycle if the power-switch current exceeds 1.5-A peak. On each clock cycle, the power switch turns on and attempts to deliver current until the overcurrent limits are exceeded.

enable (EN)

A logic low on EN puts the TPS6734 in shutdown mode. In shutdown, the output power switch, voltage reference, and other functions are shut off, the supply current is reduced to 3 μ A maximum, and the soft-start capacitor is discharged through a 1-M Ω resistance. The output voltage falls to a diode drop below the input voltage because of the current path from input to output through the inductor and diode.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW
Р	1175 mW	9.4 mW/°C	752 mW	611 mW

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Pin voltages: V _{CC.} OUT (see Note 1)	–0.3 V to 15 V
SS, COMP, EN (see Note 1)	
Peak switch current	1.5 A
Reference current	2.5 mA
Continuous power dissipation	See Dissipation Rating Table
Operating free-air temperature range, T _A	–40°C to 85°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 s	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to network terminal ground.

TEXAS INSTRUMENTS

TPS6734I FIXED 12-V 120-mA BOOST-CONVERTER SUPPLY

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recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage	2.7	5	12	٧
Compensation capacitor		0.001		μF
Output current at REF	0		100	μА
Reference capacitor		0.01		μF
Operating free-air temperature, TA	-40		85	°C

electrical characteristics over recommended operating free-air temperature range, $V_{CC} = 5 \text{ V}$, $I_{O(LOAD)} = 0 \text{ mA}$, EN = 5 V, typical values are at $T_A = 25^{\circ}\text{C}$ (unless otherwise noted) (refer to circuit shown in Figure 13)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNITS
	Operating	Entire circuit		1.2	2.5	mA
Supply current	Standby	EN = 0.4 V, entire circuit			3	μА
	Stariuby	EN = 0.4 V, into V _{CC}			3	μА
High-level input threshold voltage at EN			2			٧
Low-level input threshold voltage at EN					0.4	V
Shutdown input leaka	ge current at EN		-1		1	μΑ
On resistance at OUT		Current at OUT = 500 mA		0.7		Ω
Leakage current at Ol	UT	V _{DS} = 12 V		1		μА
Reference voltage				1.22		٧
Reference drift		$T_A = -40$ °C to 85°C		6.7		ppm/°C
Oscillator frequency				170		kHz
Compensation pin imp	pedance			7500		Ω

performance characteristics over recommended operating free-air temperature range, typical circuit connected as shown in Figure 13, typical values are at $T_A = 25^{\circ}$ C (unless otherwise noted)

PARAMETER	TES1	CONDITIONS	MIN	TYP	MAX	UNITS
Output voltage	V _{CC} = 4.75 V,	0 mA < I _{O(LOAD)} < 120 mA	11.64	12.12	12.6	V
Load current	V _{CC} = 3.75 V		120	150		A
	$V_{CC} = 3.0 \text{ V},$	Figure 11		150		mA
Line regulation	V _{CC} = 5 V to 12 V,	I _{O(LOAD)} = 50 mA		0.20%		
Load regulation	$I_{O(LOAD)} = 0$ mA to 13	$I_{O(LOAD)} = 0$ mA to 120 mA		0.0042%		
Efficiency	V _{CC} = 5 V,	I _{O(LOAD)} = 120 mA		86%		

LOAD TRANSIENT RESPONSE

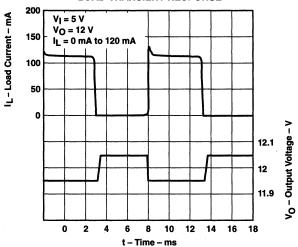


Figure 2

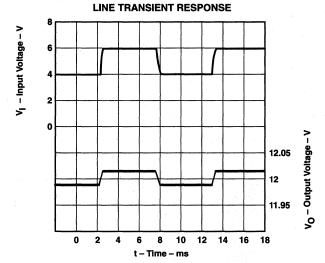


Figure 3

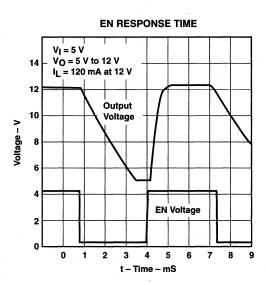


Figure 4

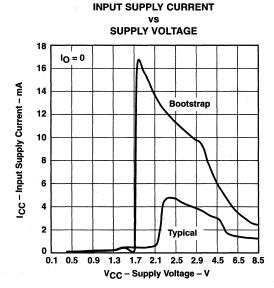


Figure 6

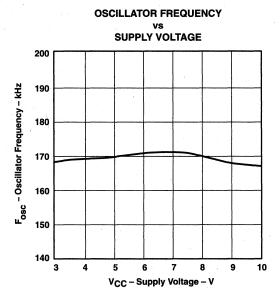


Figure 5

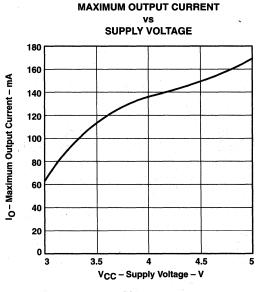


Figure 7

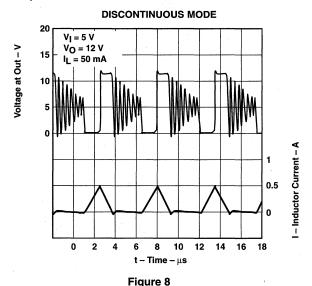
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APPLICATION INFORMATION

The TPS6734 operates in a boost circuit as shown in Figures 1 and 11. Figure 1 shows the typical application circuit, which generates 12 V from a nominal 5-V source. The circuit is ideal for processor interface for energy management, because EN can be controlled by logic signals to place the 12-V source into the shutdown mode (3-µA current drain) when 12 V is not needed. An example of such an application is a flash memory device that requires 12 V for the erase cycle.

discontinuous mode

The circuit shown in Figure 1 operates in discontinuous mode over most of the range of input voltage and output current. In discontinuous mode, current through the inductor begins at zero, rises to a peak value, then ramps down to zero each cycle as shown by the voltage and current waveforms in Figure 8. The ringing in the voltage waveform on OUT results from a resonance between the inductor and the power switch capacitance and is normal for discontinuous operation.

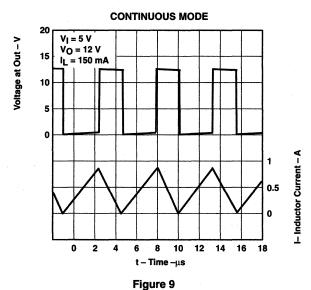


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APPLICATION INFORMATION

continuous mode

When the converter is delivering heavy loads from low voltage sources, it operates in continuous mode. As shown in Figure 9, the inductor current does not drop to zero and the ringing is gone from the OUT voltage waveform.



pulse-skipping mode

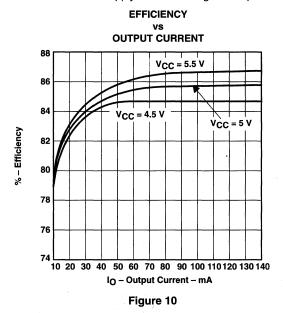
At very light load currents, the TPS6734 cannot generate drive pulses sufficiently narrow to maintain regulation and operate at 170 kHz. Under these circumstances, the converter operates in a pulse-skipping mode, in which cycles are skipped. In pulse-skipping mode, the waveforms are irregular and the output ripple contains a low-frequency component that may exceed 50 mV peak-to-peak.

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APPLICATION INFORMATION

efficiency

Typical efficiency for the converter circuit shown in Figure 13 is plotted in Figure 10. The efficiency falls off rapidly at very light currents because the supply current is a significant percentage of the load.



inductor selection

Inductance value is directly proportional to the input voltage and inversely proportional to the output power. The 18 μ H shown in the typical circuit is the proper value for operation from 5-V sources up to 2-W loads. A lower inductance value should be used when operating from 3-V sources. Operation from 7 V and higher sources may require inductance values greater than 18 μ H. The inductor's saturation current rating should be greater than three times the dc load current for 5-V inputs and five times the dc load for 3-V inputs.

output filter capacitor selection

The output filter capacitor should be selected for minimum ESR (equivalent series resistance). Capacitor ESR \times ΔI_L (change in inductor current) determines the amplitude of the high-frequency ripple on the output voltage. The ESR of the capacitor should be less than 0.25 Ω to keep the output ripple less than 50 mV peak-to-peak over the entire current range (using 18- μ H inductor).

diode

A Schottky diode or a high-speed silicon rectifier should be used. The continuous current rating of the diode should be at least 300 mA for full load (120 mA) operation.

soft-start capacitor

Soft-start timing is controlled by the value of the SS capacitor. Table 1 lists soft-start time intervals for selected capacitor values and circuit conditions. If the circuit starts up with no load (e.g. in flash-memory programming supplies), no soft start is needed. Omitting the soft-start capacitor provides a minimum output-voltage rise time from the shutdown state, improving the output start-up time.

Table 1. Typical Soft-Start Times

SUPPLY	sor	SOFT-START TIME [†] (ms) VERSUS CAPACITANCE (μF)											
VOLTAGE (V)	NO. CAP	0.047	0.1	0.47	1.0								
5	0.70	22	42	220	400								
7	0.46	15	37	185	225								
9	0.38	10	17	88	155								

[†] Soft-start times are ±35%

printed-circuit layout

Printed-circuit-board (PCB) layout is critical to quiet operation. A ground plane is recommended. Special attention should be given to minimizing the lengths of the switching loops. The first loop is formed by OUT, the diode, the output capacitor, and GND, the length of which can be minimized by connecting the anode of the diode close to OUT. The output capacitor should be connected, directly between the diode cathode and GND with the shortest possible path. The second loop is formed by OUT, the inductor, the input capacitor, and GND. This loop is less critical than the first; however, the connection of OUT, the inductor and the anode of the diode must be minimized. Bypass capacitors should be located as close to the device as possible to prevent instability and noise pickup. If a large V_{CC}-to-GND bypass capacitor cannot be placed adjacent to the IC pins, the pins should be bypassed directly with a small ceramic capacitor (e.g., 0.1 µF). The recommended layout shown in Figures 14 through 17 can provide guidance for PCB configuration (the ground plane beneath the TPS6734 and the short loops should be noted).

Plastic plug-in-type proto boards, or any construction scheme that allows long leads and the possibility of noise pickup, should not be used when assembling a breadboard or prototype application circuit implementing the TPS6734.

bootstrapped output circuit

For operation below 2.7 V, the TPS6734 may be connected in a bootstrap configuration as shown in Figure 11. The bootstrap configuration is less efficient (requires more supply current and suffers a loss in efficiency at voltages below 5 V; see Figure 12) and is not recommended except for very low voltage operating conditions. Because the output-driver stage, which benefits most from higher voltages, is diode-coupled to the output voltage (see Figure 2), the bootstrapped configuration provides no benefit except at very low voltages. In the shutdown mode (EN = low), no-load quiescent current is unchanged (3 μ A max) whether in the bootstrap or the typical configuration.

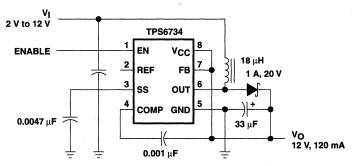
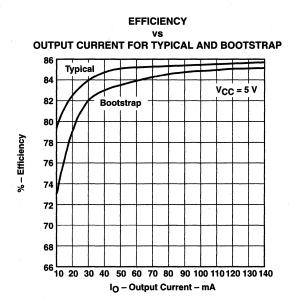


Figure 11. TPS6734 Bootstrap Configuration

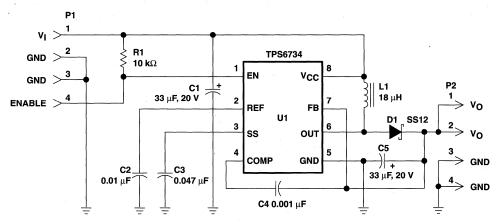


TEXAS INSTRUMENTS

Figure 12

TPS6734 converter design with recommended layout

The following schematic (Figure 13) and a required-components table are provided for a 12-V-output boost converter. The converter is capable of delivering 120 mA of output current over an input voltage range of 3.75 V to 12 V. Recommended layout and detailed artwork for a PCB are provided in Figures 14 through 17.



NOTE A: A jumper between pins P1-3 and P1-4 shuts off the TPS7634. Remove the jumper to resume normal operation.

Figure 13. Schematic for Printed Circuit Board (shown in Figures 14 through 17)

Required Components

QTY.	DESCRIPTION	REF DES	MANUFACTURER'S PART NO.	MANUFACTURER
1	IC, power supply, 12 V for flash memory	U1	TPS6734ID	Texas Instruments
1	Diode, Schottky	D1	SS12	General Instruments
1	Inductor, 18 μH, 150 mΩ, 1.23 A(DC)	L1	CD54180MC	Sumida
2	Capacitor, 33 μF, 20 V, tantalum	C1,5	TAPSD336M020R0200	AVX
1	Capacitor, 0.01 μF, 50 V, ceramic, 0805	C2		
1	Capacitor, 0.047 μF, 50 V, ceramic, 1206	C3		
1.	Capacitor, 0.001 μF, 50 V, ceramic, 0805	C4		
2	Connector, header, 4-pin	P1,2		Molex
1	PCB, TPS6734			

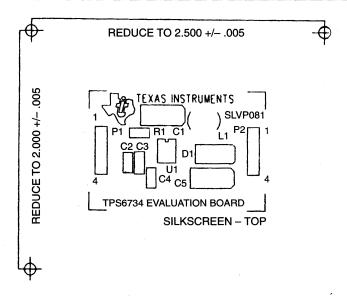


Figure 14. Component Placement

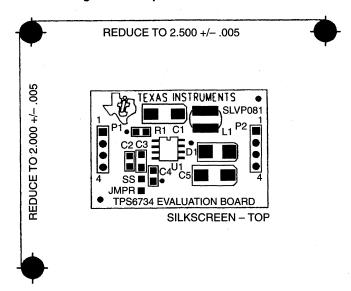


Figure 15. Solder Paste Mask

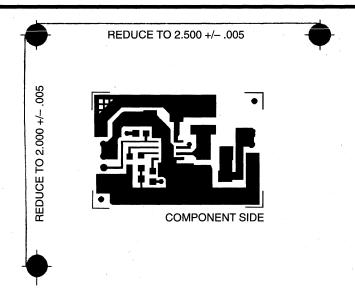


Figure 16. Printed Circuit, Component Side

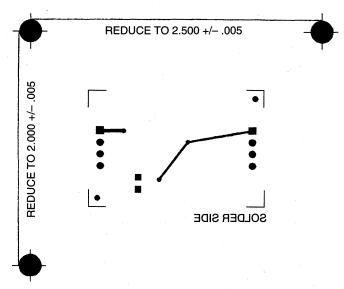


Figure 17. Printed Circuit, Wiring Side (Viewed from Component Side)

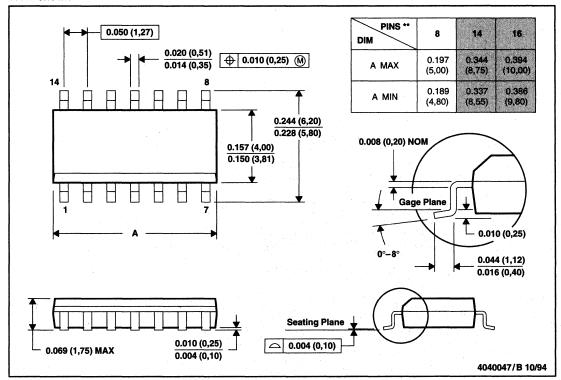
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MECHANICAL DATA

D (R-PDSO-G**)

14 PIN SHOWN

PLASTIC SMALL-OUTLINE PACKAGE

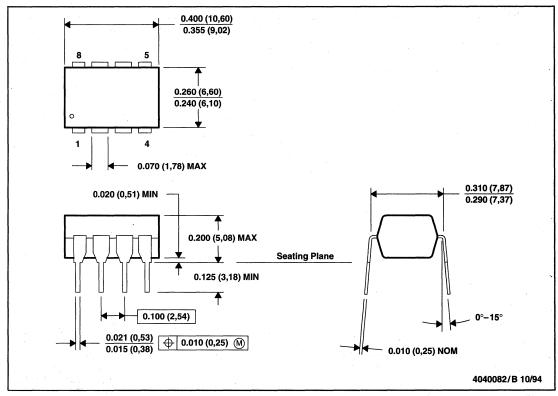


- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 - D. Four center pins are connected to die mount pad
 - E. Falls within JEDEC MS-012

MECHANICAL DATA

P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001

UC284x, UC384x, UC384xY CURRENT-MODE PWM CONTROLLERS

VFB[

3

ISENSE

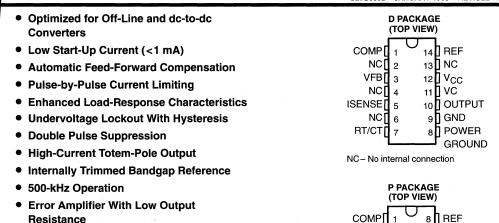
RT/CT

SLVS038B - JANUARY 1989 - REVISED AUGUST 1995

7 Vcc

5 GND

6 OUTPUT



description

• Designed to Be Interchangable With

Unitrode UC2842 and UC3842 Series

The UC2842 and UC3842 series of control integrated circuits provide the features that are necessary to implement off-line or dc-to-dc fixed-frequency current-mode control schemes with a minimum number of external components. Some of the internally implemented circuits are an undervoltage lockout (UVLO) featuring a start-up current of less than 1 mA and a precision reference trimmed for accuracy at the error amplifier input. Other internal circuits include logic to ensure latched operation, a pulse-width modulation (PWM) comparator (which also provides current-limit control), and a totem-pole output stage designed to source or sink high-peak current. The output stage, suitable for driving N-channel MOSFETs, is low when it is in the off state.

The primary difference between the UC2842-series devices and the UC3842-series devices is the ambient operating temperature range. The UC2842-series devices operate between -40° C and 85° C; the UC3842-series devices operate between 0° C and 70° C. Major differences between members of these series are the UVLO thresholds and maximum duty cycle ranges. Typical UVLO thresholds of 16 V (on) and 10 V (off) on the UCx842 and UCx844 devices make them ideally suited to off-line applications. The corresponding typical thresholds for the UCx843 and UCx845 devices are 8.4 V (on) and 7.6 V (off). The UCx842 and UCx843 devices can operate to duty cycles approaching 100%. A duty cycle range of 0 to 50% is obtained by the UCx844 and UCx845 by the addition of an internal toggle flip-flop, which blanks the output off every other clock cycle.

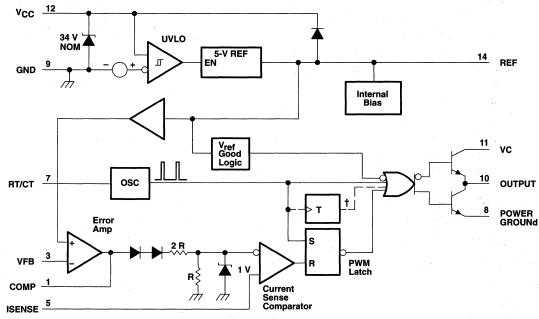
AVAILABLE OPTIONS

	PACKAGE	DEVICES	CHIP
TA	SMALL OUTLINE	PLASTIC DIP	FORM
	(D)	(P)	(Y)
0°C to 70°C	UC3842D	UC3842P	UC3842Y
	UC3843D	UC3843P	UC3843Y
	UC3844D	UC3844P	UC3844Y
	UC3845D	UC3845P	UC3845Y
-40°C to 85°C	UC2842D UC2843D UC2844D UC2845D	UC2842P UC2843P UC2844P UC2845P	

The DW package is available taped and reeled. Add the suffix R to the device type, (i.e., LT1054CDWR).



functional block diagram

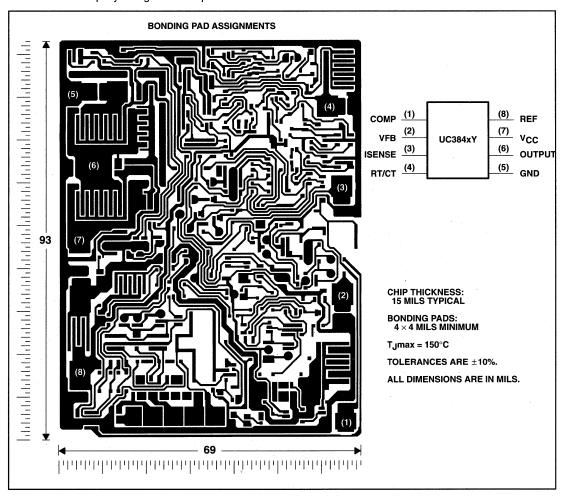


† The toggle flip-flop is present only in UC2844, UC2845, UC3844, and UC3845. NOTE A: Terminal numbers apply to the D package only.

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UC384xY chip information

This chip, when properly assembled, displays characteristics similar to the UC384x. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



UC284x, UC384x, UC384xY CURRENT-MODE PWM CONTROLLERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage (see Note 1) (I _{CC} < 30 mA)	Self Limiting
Analog input voltage range, V _I (VFB and ISENSE terminals)	
Output voltage, VO (OUTPUT terminal)	
Input voltage, V _I , (VC terminal, D package only)	35 V
Supply current, I _{CC}	30 mA
Output current, I _O	
Error amplifier output sink current	10 mA
Continuous total power dissipation	. See Dissipation Rating Table
Output energy (capacitive load)	5 μJ
Operating free-air temperature range, T _A : UC284x	– 40°C to 85°C
UC384x	
Storage temperature range, T _{stq}	– 65°C to 150°C
Lead temperature, 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltages are with respect to the device GND terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATE ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	950 mW	7.6 mW/°C	608 mW	494 mW
Р	1000 mW	8.0 mW/°C	640 mW	520 mW

recommended operating conditions

		UC284x		, · · · · ·	UNIT		
	MIN	NOM	MAX	MIN	NOM	MAX	UNII
Supply voltage, V _{CC} and V _C [†]			30		1. 1. 1	30	V
Input voltage, V _I , RT/CT	0	1.1	5.5	0		5.5	٧
Input voltage, V _I , VFB and ISENSE	0		5.5	0		5.5	V
Output voltage, VO, OUTPUT	0	14.	30	0		30	V.
Output voltage, VO, POWER GROUND†	-0.1		1	-0.1		1	٧
Supply current, externally limited, I _{CC}			25			25	mA
Average output current, IO			200		V	200	mA
Reference output current, IO(ref)			-20			-20	mΑ
Timing capacitance, C _T				1			nF
Oscillator frequency, fosc		100	500		100	500	kHz
Operating free-air temperature, TA	-40		85	0		70	°C

[†] These recommended voltages for V_C and POWER GROUND apply only to the D package.

UC284x, UC384x, UC384xY **CURRENT-MODE CONTROLLERS**

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electrical characteristics, V_{CC} = 15 V (see Note 2), R_T = 10 k Ω , C_T = 3.3 nF, T_A = full range (unless otherwise specified)

reference section

DADAMETED	TEGT CONDI	TEST CONDITIONS		UC284x			UC384x		
PARAMETER	IEST CONDI	IIONS	MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT
Output voltage	I _O = 1 mA,	T _J = 25°C	4.95	5	5.05	4.9	5	5.1	V
Line regulation	V _{CC} = 12 V to 25 V			. 6	20		6	20	mV
Load regulation	I _O = 1 mA to 20 mA			6	25		6	25	mV
Temperature coefficient of output voltage				0.2	0.4		0.2	0.4	mV√v°C
Output voltage with worst-case variation	$V_{CC} = 12 \text{ V to } 25 \text{ V},$ $I_{O} = 1 \text{ mA to } 20 \text{ mA}$		4.9		5.1	4.82		5.18	٧
Output noise voltage	f = 10 Hz to 10 kHz,	T _J = 25°C		50			50		μV
Output voltage long-term drift	After 1000 h at TA = 2	25°C		5	25		5	25	mV
Short-circuit output current			-30	-100	-180	-30	-100	-180	mA

[†] All typical values are at T_J = 25°C.

NOTE 2: Adjust V_{CC} above the start threshold before setting it to 15 V.

oscillator section

PARAMETER	TEST COMPITIONS		UC284x			UC384x			UNIT
PARAMETER	TEST CONDITIONS		MIN	TYP [†]	MAX	MIN	TYP	MAX	UNII
Oscillator frequency (see Note 3)	T _J = 25°C		47	52	57	47	52	57	kHz
Frequency change with supply voltage	V _{CC} = 12 V to 25 V			2	10		2	10	Hz/kHz
Frequency change with temperature	TA = T _{MIN} to T _{MAX}			50			50		Hz/kHz
Peak-to-peak amplitude at RT/CT				1.7			1.7		V

[†] All typical values are at $T_J = 25$ °C.

NOTÉS: 2. Adjust V_{CC} above the start threshold before setting it to 15 V.
3. Output frequency equals oscillator frequency for the UCx842 and UCx843. Output frequency is one-half oscillator frequency for the UCx844 and UCx845.

error amplifier section

PARAMETER	TECT	TEST CONDITIONS		UC284x			UC384x		UNIT
PARAMETER	1531	CONDITIONS	MIN	TYPT	MAX	MIN	TYPT	MAX	UNII
Feedback input voltage	COMP at 2.5 V		2.45	2.50	2.55	2.42	2.50	2.58	V
Input bias current				-0.3	-1		-0.3	-2	μΑ
Open-loop voltage amplification	V _O = 2 V to 4 V		65	90		65	90		dB
Gain-bandwidth product			0.7	. 1		0.7	. 1		MHz
Supply voltage rejection ratio	V _{CC} = 12 V to 2	25 V	60	70		60	70		dB
Output sink current	VFB at 2.7 V,	COMP at 1.1 V	2	6		2	6		mA
Output source current	VFB at 2.3 V,	COMP at 5 V	-0.5	-0.8		-0.5	-0.8		mA
High-level output voltage	VFB at 2.3 V,	$R_L = 15 \text{ k}\Omega \text{ to GND}$	5	6		5	6		V
Low-level output voltage	VFB at 2.7 V,	$R_L = 15 \text{ k}\Omega \text{ to GND}$		0.7	1.1		0.7	1.1	V

[†] All typical values are at $T_J = 25$ °C.

NOTE 2: Adjust V_{CC} above the start threshold before setting it to 15 V.

UC284x, UC384x, UC384xY CURRENT-MODE PWM CONTROLLERS

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electrical characteristics, V_{CC} = 15 V (see Note 2), R_T = 10 k Ω , C_T = 3.3 nF, T_A = full range (unless otherwise specified) (continued)

current sense section

PARAMETER	TEST CONDITIONS		UC284x			UC384x			UNIT
PARAMETER	TEST CONL	DITIONS	MIN	TYPT	MAX	MIN	TYPT	MAX	UNII
Voltage amplification	See Notes 4 and 5		2.85	3	3.13	2.85	3	3.15	V/V
Current sense comparator threshold	COMP at 5 V,	See Note 4	0.9	1	1.1	0.9	1	1.1	V
Supply voltage rejection ratio	$V_{CC} = 12 \text{ V to } 25 \text{ V},$	See Note 4		70			70		dB
Input bias current				-2	-10		-2	-10	μΑ
Delay time to output				150	300		150	300	ns

[†] All typical values are at T_J = 25°C.

NOTES: 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

4. These parameters are measured at the trip point of the latch with VFB at 0 V.

5. Voltage amplification is measured between ISENSE and COMP with the input changing from 0 V to 0.8 V.

output section

DADAMETED	TEOT 0011D	TEST CONDITIONS		UC284x			UC384x		
PARAMETER	1EST COND	IIIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
High level output voltage	I _{OH} = -20 mA		13	13.5		13	13.5		V
High-level output voltage	I _{OH} = -200 mA		12	13.5		12	13.5		V
Low lovel output voltage	I _{OL} = 20 mA			0.1	0.4		0.1	0.4	V
Low-level output voltage	I _{OL} = 200 mA			1.5	2.2		1.5	2.2	٧
Rise time	C _L = 1 nF,	T _J = 25°C		50	150		50	150	ns
Fall time	C _L = 1 nF,	T _J = 25°C		50	150		50	150	ns

[†] All typical values are at T_J = 25°C.

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

undervoltage lockout section

PARAMETER	TEST CO	TEST CONDITIONS		UC284x			UC384x			
PARAMETER			MIN	TYPT	MAX	MIN	TYPT	MAX	UNIT	
Chart thus abald walter as	UCx842,	UCx844	15	16	17	14.5	16	17.5	37	
Start threshold voltage	UCx843,	UCx845	7.8	8.4	9	7.8	8.4	17.5 9	V	
Minimum operating valters ofter start up	UCx842,	UCx844	9	10	11	8.5	10	11.5	.,	
Minimum operating voltage after start-up	UCx843,	UCx845	7	7.6	8.2	7	7.6	8.2	V	

[†] All typical values are at $T_{.1} = 25$ °C.

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

pulse-width-modulator section

PARAMETER	TEST OO	TEST CONDITIONS -		UC284x			UC384x		
PARAMETER	lesi co			TYPT	MAX	MIN	TYPT	MAX	UNIT
Maximum duty cycle	UCx842,	UCx843	95%	97%	100%	95%	97%	100%	
	UCx844,	UCx845	46%	48%	50%	46%	48%	50%	
Minimum duty cycle					0			. 0	

[†] All typical values are at T_J = 25°C.

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

supply voltage

PARAMETER	TEST COMPITIONS	UC284x			UC384x			LINUT
PARAMETER	TEST CONDITIONS —		TYPT	MAX	MIN	TYP	MAX	UNIT
Start-up current			0.5	. 1		0.5	1	mA
Operating supply current	VFB and ISENSE at 0 V		11	. 17		11	17	mA
Limiting voltage	I _{CC} = 25 mA	- 27	34			34		٧

[†] All typical values are at $T_J = 25$ °C.

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.



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electrical characteristics, $V_{CC} = 15 \text{ V}$ (see Note 2), $R_T = 10 \text{ k}\Omega$, $C_T = 3.3 \text{ nF}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise specified)

reference section

DADAMETED	TEGT CONDITIONS	UC384		
PARAMETER	TEST CONDITIONS	MIN TY	P MAX	UNIT
Output voltage	I _O = 1 mA		5	V
Line regulation	V _{CC} = 12 V to 25 V		6	mV
Load regulation	I _O = 1 mA to 20 mA		6	mV
Temperature coefficient of output voltage		0	.2	mV√°C
Output noise voltage	f = 10 Hz to 10 kHz	5	50	μV
Output voltage long-term drift	After 1000 h at T _A = 25°C		5	mV
Short-circuit output current		-10	00	mA

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

oscillator section

DADAMETED	TEST CONDITIONS	U	UC384xY			
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Oscillator frequency (see Note 3)			52		kHz	
Frequency change with supply voltage	V _{CC} = 12 V to 25 V		2		Hz/kHz	
Frequency change with temperature			5		Hz/kHz	
Peak-to-peak amplitude at RT/CT			1.7		V	

NOTES: 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

3. Output frequency equals oscillator frequency for the UCx842 and UCx843. Output frequency is one-half oscillator frequency for the UCx844 and UCx845.

error amplifier section

PARAMETER	TEGT COMPLETIONS	UC384xY	UNIT
PARAMETER	TEST CONDITIONS	MIN TYP MA	X
Feedback input voltage	COMP at 2.5 V	2.50	V
Input bias current		-0.3	μА
Open-loop voltage amplification	V _O = 2 V to 4 V	90	dB
Gain-bandwidth product		1	MHz
Supply voltage rejection ratio	V _{CC} = 12 V to 25 V	70	dB
Output sink current	VFB at 2.7 V, COMP at 1.1 V	6	mA
Output source current	VFB at 2.3 V, COMP at 5 V	-0.8	mA
High-level output voltage	VFB at 2.3 V, $R_L = 15 \text{ k}\Omega$ to GN	ID 6	V
Low-level output voltage	VFB at 2.7 V, $R_L = 15 \text{ k}\Omega$ to GN	ID 0.7	V

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

current sense section

DADAMETED		TEST COMPLETIONS	U	UNIT		
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNII
Voltage amplification		See Notes 4 and 5		3		V/V
Current sense comparator threshold		COMP at 5 V, See Note 4		1	-	V
Supply voltage rejection ratio		V _{CC} = 12 V to 25 V, See Note 4	1	70		dB
Input bias current	J. 1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1			-2		μΑ
Delay time to output				150		ns

NOTES: 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

4. These parameters are measured at the trip point of the latch with VFB at 0 V.

5. Voltage amplification is measured between ISENSE and COMP with the input changing from 0 V to 0.8 V.



UC284x, UC384x, UC384xY CURRENT-MODE PWM CONTROLLERS

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electrical characteristics, V $_{CC}$ = 15 V (see Note 2), R $_{T}$ = 10 k $\Omega,$ C $_{T}$ = 3.3 nF, T $_{J}$ = 25°C (unless otherwise specified) (continued)

output section

DADAMETED	TEST COMPLETIONS	U	LINUT		
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Lligh lavel autout valeage	I _{OH} = −20 mA		13.5		V
High-level output voltage	I _{OH} = -200 m/A	13.5			7 °
Low-level output voltage	I _{OL} = 20 mA		0.1		·
Low-level output voltage	I _{OL} = 200 mA		1.5		, v
Rise time	C _L = 1 nF		50		ns
Fall time	C _L = 1 nF		50		ns

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

undervoltage lockout section

PARAMETER	TEST CO	U	LINUT			
PARAMETER	Ī			TYP	MAX	UNIT
Chart thurs sheeld well-are	UC3842Y,	UC3844Y		16		V
Start threshold voltage	UC3843Y,	UC3845Y		8.4		V
Minimum aparating valtage after start up	UC3842Y,	UC3844Y		10		
Minimum operating voltage after start-up	UC3843Y,	UC3845Y		7.6		· V

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

pulse-width-modulator section

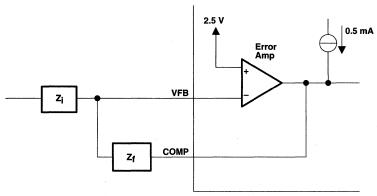
PARAMETER		7507.00	NOTIONS	U	C384xY		
		TEST CO	TEST CONDITIONS		TYP	MAX	UNIT
Maximum duty cycle		UC3842Y,	UC3843Y		97%		
waxiinam daty cycle		UC3844Y,	UC3845Y		48%		

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.

supply voltage

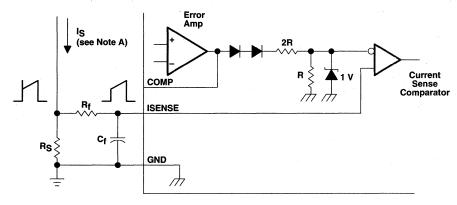
PARAMETER	TEST CONDITIONS	, u	UNIT		
PANAMETER	TEST CONDITIONS		TYP	MAX	UNIT
Start-up current			0.5	1	mA
Operating supply current	VFB and ISENSE at 0 V		11	17	mA
Limiting voltage	I _{CC} = 25 mA		34		V

NOTE 2. Adjust V_{CC} above the start threshold before setting it to 15 V.



NOTE A. Error amplifier can source or sink up to 0.5 mA.

Figure 1. Error Amplifier Configuration



NOTE A: Peak current (I_S) is determined by the formula:

$$I_{S(max)} = \frac{1 \text{ V}}{R_S}$$

A small RC filter formed by resistor R_f and capacitor C_f may be required to suppress switch transients.

Figure 2. Current Sense Circuit

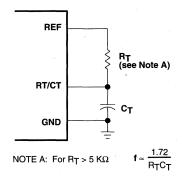


Figure 3. Oscillator Section

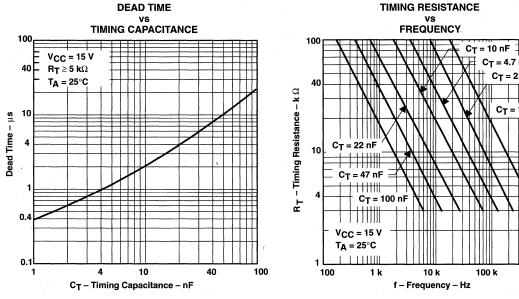


Figure 5

1 M

open-loop laboratory test fixture

In the open-loop laboratory test fixture shown in Figure 6, high-peak currents associated with loads necessitate careful grounding techniques. Timing and bypass capacitors should be connected close to the GND terminal in a single-point ground. The transistor and $5-k\Omega$ potentiometer sample the oscillator waveform and apply an adjustable ramp to the ISENSE terminal.

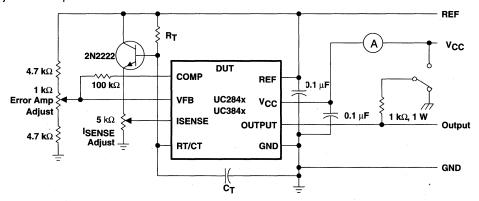


Figure 6. Open-Loop Laboratory Test Fixture

shutdown technique

Shutdown of the PWM controller (see Figure 7) can be accomplished by two methods: either raise the voltage at ISENSE above 1 V or pull the COMP terminal below a voltage two diode drops above ground. Either method causes the output of the PWM comparator to be high (refer to block diagram). The PWM latch is reset dominant so that the output remains low until the next clock cycle after the shutdown condition at the COMP or ISENSE terminal is removed. In one example, an externally latched shutdown may be accomplished by adding an SCR that resets by cycling V_{CC} below the lower UVLO threshold. At this point the reference turns off, allowing the SCR to reset.

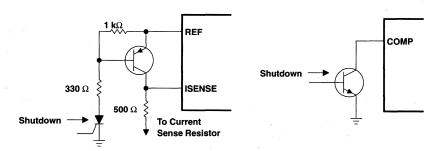


Figure 7. Shutdown Techniques

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APPLICATION INFORMATION

A fraction of the oscillator ramp can be resistively summed with the current sense signal to provide slope compensation for converters requiring duty cycles over 50% (see Figure 8). Note that capacitor C forms a filter with R2 to suppress the leading-edge switch spikes.

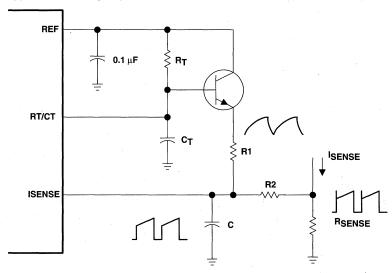


Figure 8. Slope Compensation

General Information	1
Voltage References	2
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TL77xxB	Supply Voltage Supervisors	5–15
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	Protector	5–25
TL7759	Supply Voltage Supervisors	5–37
TL7770-xx	Dual Power-Supply Supervisors	5–43
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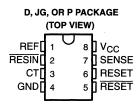
- **Power-On Reset Generator**
- **Automatic Reset Generation After** Voltage Drop
- Wide Supply Voltage Range
- **Precision Voltage Sensor**

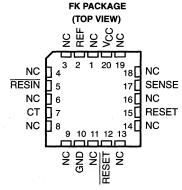
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include

- **Temperature-Compensated Voltage** Reference
- **True and Complement Reset Outputs**
- **Externally Adjustable Pulse Duration**

description

The TL77xxA family of monolithic integrated circuit supply voltage supervisors are specifically designed for use as reset controllers in microcomputer and microprocessor systems. The supply voltage supervisor monitors the supply for undervoltage conditions at the SENSE input. During power up, the RESET output becomes active (low) when V_{CC} attains a value approaching 3.6 V. At this point (assuming that SENSE is above V_{IT+}), the delay timer function activates a time delay after which outputs RESET and





NC - No internal connection

RESET go inactive (high and low respectively). When an undervoltage condition occurs during normal operation, outputs RESET and RESET go active. To ensure that a complete reset occurs, the reset outputs remain active for a time delay after the voltage at the SENSE input exceeds the positive-going threshold value. The time delay is determined by the value of the external capacitor C_T : $t_d = 1.3 \times 10^4 \times C_T$, where C_T is in farads (F) and t_d is in seconds (s).

During power down (assuming that SENSE is below V_{IT}), the outputs remain active until the V_{CC} falls below a maximum of 2 V. After this, the outputs are undefined.

An external capacitor (typically 0.1 uF for the TL77xxAC and TL77xxAI and typically 0.02 uF for the TL77xxAM) must be connected to REF to reduce the influence of fast transients in the supply voltage.

The TL77xxAC series are characterized for operation from 0°C to 70°C. The TL77xxAI series are characterized for operation from -40°C to 85°C. The TL7702AM and TL7705AM are characterized for operation over the full military range of -55°C to 125°C.

AVAILABLE OPTIONS

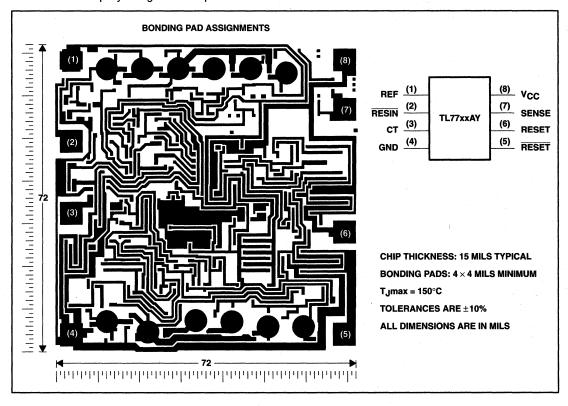
		CHIP FORM			
TA	SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	(Y)
0°C to 70°C	TL7702ACD ~ TL7715ACD			TL7702ACP – TL7715ACP	TL7702ACY - TL7715ACY
-40°C to 85°C	TL7702AID - TL7715AID			TL7702AIP – TL7715AIP	
−55°C to 125°C		TL7702AMFK TL7705AMFK	TL7702AMJG TL7705AMJG		



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TL77xxAY chip information

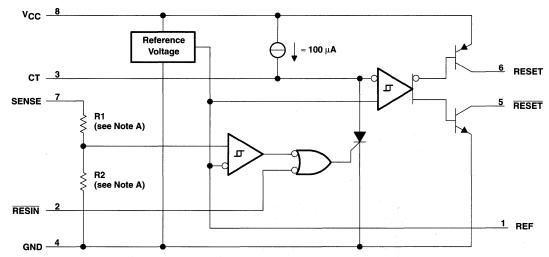
This chip, when properly assembled, displays characteristics similar to the TL77xxAC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



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functional block diagram

The functional block diagram is shown for illustrative purposes only; the actual circuit includes a trimming network to adjust the reference voltage and sense comparator trip point.



NOTES: A. TL7702A: R1 = 0 Ω , R2 = open

TL7705A: R1 = 7.8 kΩ, R2 = 10 kΩ

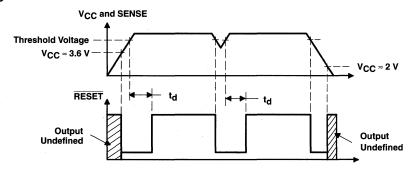
TL7709A: R1 = 19.7 kΩ, R2 = 10 kΩ TL7712A: R1 = 32.7 kΩ, R2 = 10 kΩ

TL7715A: R1 = 43.4 k Ω , R2 = 10 k Ω

B. Terminal numbers shown are for the D, JG, or P package.

C. Resistor values shown are nominal.

timing diagram



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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)	20 V
Input voltage range, V _I , RESIN	–0.3 V to 20 V
Input voltage range, V _I , SENSE:TL7702A (see Note 2)	–0.3 V to 6 V
TL7705A	0.3 V to 20 V
TL7709A	0.3 V to 20 V
TL7712A, TL7715A	
High-level output current, IOH, RESET	–30 mA
Low-level output current, IOL, RESET	30 mA
Continuous total power dissipation	
Operating free-air temperature range, T _A : TL77xxAC	
TL77xxAI	
TL7702AM, TL7705AM	
Storage temperature range, T _{stg}	65°C to 150°C
Case temperature for 60 seconds, T _C : FK package	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or P pack	· ·
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: JG package	3000€

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to the network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW	145 mW
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
P	1000 mW	8.0 mW/°C	640 mW	520 mW	200 mW

recommended operating conditions

		TL77xxA	AC, TL77xxAI	TL	77xxAM	
		MIN	MAX	MIN	MAX	UNIT
Supply voltage, V _{CC}		3.5	18	3.6	10	V
High-level input voltage at RESIN, VIH		2		2		V
Low-level input voltage at RESIN, VIL			0.6		0.6	V
	TL7702A	0	See Note 2	0	See Note 2	
	TL7705A	0	10	0	10	
Input voltage, SENSE, V _I	TL7709A	0	15			V
	TL7712A	0	20			
	TL7715A	, 0	20			
High-level output current, RESET, IOH			-16		-16	mA
Low-level output current, RESET, IOL			16		16	mA
Timing capacitor, C _T			10		10	μF
	TL77xxAC	0	70		1	
Operating free-air temperature range, TA	TL77xxAI	-40	85			°C
	TL7702AM, TL7705AM			-55	125	

NOTE 2: For proper operation of the TL7702A, the voltage applied to the SENSE terminal should not exceed V_{CC}-1 V or 6 V, whichever is less.



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electrical characteristics over recommended operating conditions (unless otherwise noted)

	DADAMETED			TL77xxA	C, TL77	xxAl	UNIT
PARAMETER		TEST CONDITIONST	MIN	TYP	MAX	UNII	
Vон	High-level output voltage, RESET		I _{OH} = -16 mA	V _{CC} -1.5			٧
VOL	Low-level output voltage, RESET		I _{OL} = 16 mA			0.4	٧
V _{ref}	Reference voltage		T _A = 25°C	2.48	2.53	2.58	٧
		TL7702A		2.48	2.53	2.58	
		TL7705A		4.5	4.55	4.6	
VIT-	Negative-going input threshold voltage, SENSE	TL7709A	T _A = 25°C	7.5	7.6	7.7	V
Ì		TL7712A		10.6	10.8	11	
		TL7715A		13.2	13.5	13.8	
		TL7702A	T _A = 25°C		10		
		TL7705A			15		
V _{hys}	Hysteresis, SENSE (V _{IT+} - V _{IT-})	TL7709A			20		mV -
		TL7712A			35		
		TL7715A			45		
	beat and DEON		V _I = 2.4 V to V _{CC}			20	
11	Input current, RESIN		V _I = 0.4 V			-100	μА
l _l	Input current, SENSE	TL7702A	V _{ref} < V _I < V _{CC} - 1.5 V		0.5	2	μА
ЮН	High-level output current, RESET		V _O = 18 V			50	, μΑ
lOL	Low-level output current, RESET		V _O = 0			-50	μΑ
Icc	Supply current		All inputs and outputs open		1.8	3	mA

[†] All electrical characteristics are measured with 0.1-μF capacitors connected at REF, CT, and V_{CC} to GND.

switching characteristics over recommended operating conditions (unless otherwise noted)

	DADAMETED		TL77xx	TL77xxAC, TL77xxAI			
	PARAMETER	TEST CONDITIONS‡	MIN	TYP	MAX	UNIT	
-	Output pulse duration	C _T = 0.1 μF	0.65	1.2	2.6	μs	
	Input pulse duration at RESIN		0.4			μs	
t _{w(S)}	Pulse duration at SENSE input to switch outputs	V _{IH} = V _{IT} + 200 mV, V _{IL} = V _{IT} - 200 mV	2			μs	
t _{pd}	Propagation delay time from RESIN to RESET	V _{CC} = 5 V			1	μs	
	RESET				0.2		
t _r	RESET	Van EV See Note 2			3.5	μs	
tf	RESET	V _{CC} = 5 V, See Note 3			3.5		
	RESET				0.2	μs	

[‡] All switching characteristics are measured with 0.1- μ F capacitors connected at REF and V_{CC} to GND. NOTE 3: The rise and fall times are measured with a 4.7- κ Ω load resistor at RESET and RESET.



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electrical characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER			TL7702A	TL7702AM, TL7705AM			
	PARAMETER		TEST CONDITIONS†	MIN	TYP	MAX	UNIT
Vон	High-level output voltage, RESET		I _{OH} = -16 mA	V _{CC} -1.5			V
VOL	Low-level output voltage, RESET		I _{OL} = 16 mA			0.4	٧
V _{ref}	Reference voltage			2.38	2.53	2.63	V
V	Negative-going input threshold voltage,	TL7702AM	V 00V4-40V	2.38	2.53	2.63	V
V _{IT} -	SENSE	TL7705AM	V _{CC} = 3.6 V to 10 V	4.25	4.55	4.7	V
V.	Hysteresis SENSE (V _{IT+} - V _{IT-})	TL7702AM	V 26 V+- 10 V		10		
V _{hys}		TL7705AM	V _{CC} = 3.6 V to 10 V		15		mV
	Land Court DECIN		V _I = 2.4 V to V _{CC}			20	
11	Input current, RESIN		V _I = 0.4 V			-100	μА
I _I	Input current, SENSE	TL7702AM	V _{ref} < V _I < V _{CC} - 1.5 V		0.5	2	μΑ
ЮН	High-level output current, RESET		V _O = 10 V			50	μА
lOL	Low-level output current, RESET		V _O = 0			-50	μА
Icc	Supply current		All inputs and outputs open		1.8	3	mA

[†] All electrical characteristics are measured with 0.02-μF capacitors connected at REF, CT, and V_{CC} to GND.

switching characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS‡	TL7702	LINUT			
PARAMEIER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
^t w(S)	Pulse duration at SENSE input to switch outputs	V _{IH} = V _{IT} + 200 mV, V _{IL} = V _{IT} - 200 mV	2*			μs	
tpd	Propagation delay time, RESIN to RESET	V _{CC} = 5 V		1.5		μs	
	RESET				0.2*		
tr	RESET	Value E.V. Can Nata 0			3.5*	μs	
t _f	RESET	$V_{CC} = 5 \text{ V},$ See Note 3	3.5*		3.5*		
	RESET				0.2*	μs	

^{*} On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

[‡] All switching characteristics are measured with 0.02-μF capacitors connected at REF and V_{CC} to GND.

NOTE 3: The rise and fall times are measured with a 4.7-k Ω load resistor at $\overline{\text{RESET}}$ and RESET.

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electrical characteristics over recommended operating conditions, $T_A = 25$ °C (unless otherwise noted)

	DADAMETED		TL77xxAY			UNIT	
PARAMETER			TEST CONDITIONS†	MIN	TYP	MAX	UNII
V _{ref}	Reference voltage				2.53		٧
		TL7702A			2.53		
		TL7705A			4.55		
V _{IT} _	Negative-going input threshold voltage, SENSE	TL7709A			7.6		V
		TL7712A			10.8		
		TL7715A	i i		13.5		
		TL7702A			10		
		TL7705A			15		
V _{hys}	Hysteresis, SENSE (V _{IT+} - V _{IT-})	TL7709A			20		mV
		TL7712A			35		
		TL7715A			45		
l _l	Input current, SENSE	TL7702A	V _{ref} < V _I < V _{CC} - 1.5 V		0.5		μΑ
Icc	Supply current		All inputs and outputs open		1.8		mA

[†] All electrical characteristics are measured with 0.1-μF capacitors connected at REF, CT, and V_{CC} to GND.

switching characteristics over recommended operating conditions, $T_A = 25^{\circ}C$ (unless otherwise noted)

Γ	PARAMETER	TTOT COMPLEMENT	T	UNIT		
	PARAMETER	TEST CONDITIONS‡		TYP	MAX	UNI
Γ	Output pulse duration	C _T = 0.1 μF		1.2		μs

[‡] All switching characteristics are measured with 0.1-μF capacitors connected at REF and V_{CC} to GND.

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PARAMETER MEASUREMENT INFORMATION

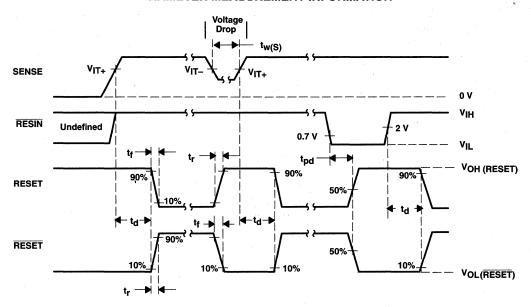
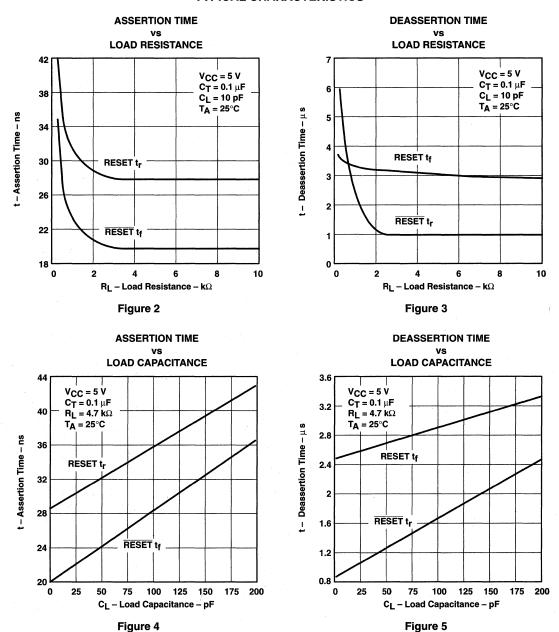


Figure 1. Voltage Waveforms

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TYPICAL CHARACTERISTICS†



[†] For proper operation both RESET and RESET should be terminated with resistors of similar value. Failure to do so may cause unwanted plateauing in either output waveform during switching.



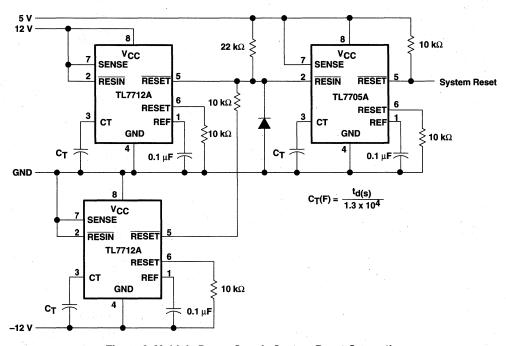


Figure 6. Multiple Power Supply System Reset Generation

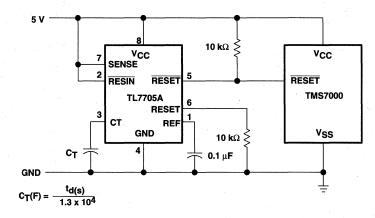


Figure 7. Reset Controller for TMS7000 System

Terminal numbers shown are for the D, JG, and P packages.

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APPLICATION INFORMATION

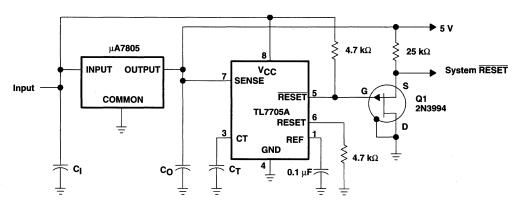


Figure 8. Eliminating Undefined States Using a P-Channel JFET

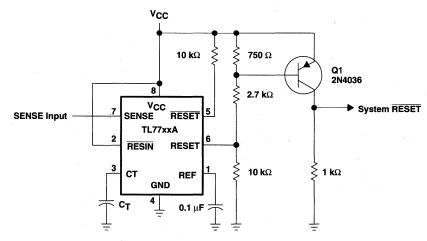


Figure 9. Eliminating Undefined States Using a pnp Transistor

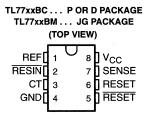
Terminal numbers shown are for the D, JG, and P packages.

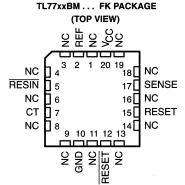
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- Power-On Reset Generator
- Automatic Reset Generation After Voltage Drop
- RESET Output Defined From V_{CC} ≥ 1 V
- Precision Voltage Sensor
- Temperature-Compensated Voltage Reference
- True and Complement Reset Outputs
- Externally Adjustable Pulse Duration

description

The TL7702B and TL7705B are monolithic integrated circuit voltage supervisors designed for use as reset controllers in microcomputer and microprocessor systems. The supply voltage supervisor monitors the supply for undervoltage conditions at the SENSE input. During power up, the $\overline{\text{RESET}}$ output becomes active (low) when V_{CC} attains a value approaching 1 V. As V_{CC} approaches 3 V (assuming that SENSE is above V_{T+}), the delay timer function activates a time delay after which outputs $\overline{\text{RESET}}$ and $\overline{\text{RESET}}$ go





NC-No internal connection

inactive (high and low respectively). When an undervoltage condition occurs during normal operation, outputs $\overline{\text{RESET}}$ and $\overline{\text{RESET}}$ go active. To ensure that a complete reset occurs, the reset outputs remain active for a time delay after the voltage at the SENSE input exceeds the positive-going threshold value. The time delay is determined by the value of the external capacitor C_T : $t_d \approx 1.3 \times 10^4 \times C_T$, where C_T is in farads (F) and t_d is in seconds (s).

An external capacitor (typically 0.1 μ F) must be connected to REF to reduce the influence of fast transients in the supply voltage.

The TL7702BC and TL7705BC are characterized from 0°C to 70°C. The TL7702BI and TL7705BI are characterized for operation from -40°C to 85°C. The TL7702BQ and TL7705BQ are characterized for operation from -40°C to 125°C. The TL7702BM and TL7705BM are characterized for operation from -55°C to 125°C.

AVAILABLE OPTIONS

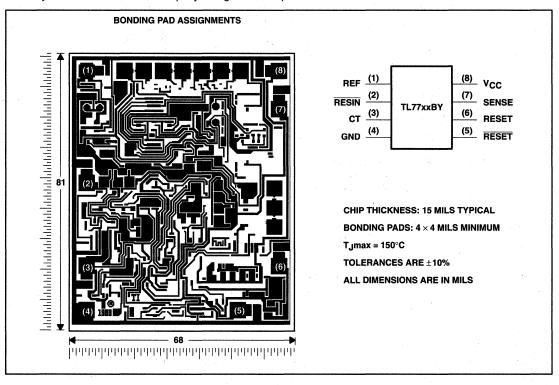
	PACKAGE					
TA	SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	CHIP FORM (Y)	
0°C to 70°C	TL7702BCD, TL7705BCD			TL7702BCP, TL7705BCP		
-40°C to 85°C	TL7702BID, TL7705BID	_	-	TL7702BIP, TL7705BIP	TL7702BY	
-40°C to 125°C	TL7702BQD, TL7705BQD	_		TL7702BQP, TL7705BQP	TL7705BY	
-55°C to 125°C		TL7702BMFK TL7705BMFK	TL7702BMJG TL7705BMJG			

TEXAS INSTRUMENTS

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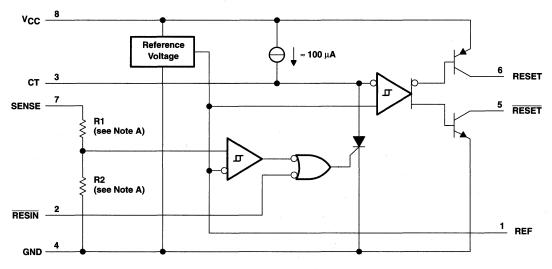
TL7702BY and TL7705BY chip information

These chips, when properly assembled, display characteristics similar to the TL7702BC and the TL7705BC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



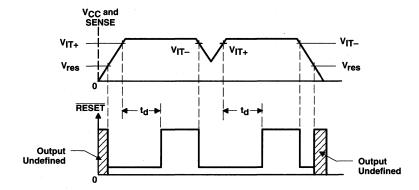
functional block diagram

The functional block diagram is shown for illustrative purposes only; the actual circuit includes a trimming network to adjust the reference voltage and sense comparator trip point.



NOTE A: TL7702B: R1 = 0 Ω , R2 = open TL7705B: R1 = 23 k Ω , R2 = 10 k Ω , nominal

typical timing diagram



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)		20 V
Input voltage range, VI (RESIN)	*****	0.3 V to 20 V
Input voltage range, V _I (SENSE)		
High-level output current, IOH (RESET)		
Low-level output current, IOI (RESET)		
Continuous total power dissipation		See Dissipation Rating Table
Operating free-air temperature range, T	Δ: TL770xBC	0°C to 70°C
		–40°C to 85°C
	TL770xBQ	40°C to 125°C
	TL770xBM	–55°C to 125°C
Storage temperature range, T _{stq}		65°C to 150°C
Case temperature for 60 seconds, T _C :	FK package	260°C
Lead temperature 1,6 mm (1/16 inch) fr		
Lead temperature 1,6 mm (1/16 inch) fr	om case for 10 seconds: D or P p	packages 260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to the network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW	145 mW
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
P	1000 mW	8.0 mW/°C	640 mW	520 mW	200 mW

recommended operating conditions

				М	N	MAX	UNIT
Supply voltage, V _{CC}				3	.6	18	٧
High-level input voltage, V _{IH}	RESIN		the second secon		2	18	٧
Low-level input voltage, V _{IL}	RESIN	4.0			0	0.8	٧
Input voltage, V _I	SENSE				0	18	V
High-level output current, IOH	RESET	*				-16	mA
Low-level output current, IOL	RESET	RESET			٠.	16	mA
Timing capacitor, C _T						10	μF
		TL770xBC		,	0	70	
Operating free air temperature re	ango T.	TL770xBI		-4	10	85	°C
Operating free-air temperature range, TA		TL770xBQ		-4	10	125	C
		TL770xBM			55	125	

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electrical characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST COND	TEST CONDITIONS†		TL77xxBC, TL77xxBI TL77xxBQ			
				•		TYP	MAX	
Vон	High-level output voltage, RESET		I _{OH} = -16 mA		V _{CC} -1.5			٧
VOL	Low-level output voltage, RESET		I _{OL} = 16 mA				0.4	٧
V _{ref}	Reference voltage		I _{ref} = 500 μA,	T _A = 25°C	2.48	2.53	2.58	
		TL7702B	T _A = 25°C		2.505	2.53	2.555	
V	Negative-going input threshold	TL7705B	1A = 25°C		4.5	4.55	4.6	٧
V _{IT} _	voltage, SENSE	TL7702B	+		2.48	2.53	2.58	
	TL7705B	T _A = Full range‡		4.45	4.55	4.65		
.,	Harris OFNOT (V	TL7702B	$V_{CC} = 3.6 \text{ V to } 18 \text{ V},$			10		
V_{hys}	Hysteresis, SENSE (V _{IT+} – V _{IT-})	TL7705B	T _A = 25°C			30		mV
v _{res} §	Power-up reset voltage		IOL at RESET = 2 mA,	T _A = 25°C			1	٧
l _l	Input current, RESIN		V _I = 0.4 V to V _{CC}				-10	μΑ
l _l	Input current, SENSE	TL7702B	V _I = V _{ref} to 18 V			-0.1	-2	μΑ
ЮН	High-level output current, RESET		V _O = 18 V,	See Figure 1			50	μА
lOL	Low-level output current, RESET		V _O = 0 V,	See Figure 1			-50	μΑ
			V _{SENSE} = 15 V,	RESIN ≥ 2 V		1.8	3	mA
ICC	Supply current		V _{CC} = 18 V	T _A = Full range‡			3.5	. IIIA

[†] All electrical characteristics are measured with 0.1-μF capacitors connected at REF, CT, and V_{CC} to GND.

switching characteristics, $V_{CC} = 5 \text{ V}$, CT open, $T_A = 25^{\circ}\text{C}$

PARAMETER		FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	TL77xxBC, TL77xxBI TL77xxBQ			UNIT	
			(OUTPUT)		MIN	TYP	MAX		
^t PLH	Propagation delay time from low-to-high-level output	RESIN	RESET	See Figures 1, 2, and 3		270	500	ns	
^t PHL	Propagation delay time from high-to-low-level output	RESIN	RESET	See Figures 1, 2, and 3		270	500	ns	
	Effective pulse duration	RESIN		See Figure 2		150		ns	
t _w	Ellective pulse duration	SENSE		See Figure 2		100		115	
t _r	Rise time		RESET				75		
tf	Fall time		HESEI	See Figures 1 and 3		150	200	ns	
t _r	Rise time		RESET	See rigules I aliu 3		75	150	ns	
t _f	Fall time		NESET				50		

[‡] Full range for the C-suffix device is 0°C to 70°C, full range for the I-suffix is -40°C to 85°C, and full range for the Q-suffix device is -40°C to 125°C.

[§] This is the lowest voltage at which RESET becomes active.

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electrical characteristics over recommended operating conditions (unless otherwise noted)

	DADAMETED				TL7702B	M, TL77	05BM	LINUT
	PARAMETER		TEST CONDITIONST		MIN	TYP	MAX	UNIT
Vон	High-level output voltage, RESET		IOH = -16 mA		V _{CC} -1.5			٧
VOL	Low-level output voltage, RESET		I _{OL} = 16 mA				0.4	٧
V _{ref}	Reference voltage		l _{ref} = 500 μA,	T _A = 25°C	2.48	2.53	2.58	
		TL7702B	T _A = 25°C	*	2.505	2.53	2.555	2
\ _{\/.} _	Negative-going input threshold	TL7705B	1A = 25 C		4.5	4.55	4.6	v
VIT-	voltage at SENSE input	TL7702B			2.48	2.53	2.58	-
		TL7705B	T _A = Full range‡		4.45	4.55	4.65	
Ţ.,	Libratoria OFNOF (V	TL7702B	$V_{CC} = 3.6 \text{ V to } 18 \text{ V},$			10		>/
V _{hys}	Hysteresis, SENSE (V _{IT+} – V _{IT-})	TL7705B	T _A = 25°C			30		mV
v _{res} §	Power-up reset voltage		IOL at RESET = 2 mA,	T _A = 25°C			. 1	٧
1 ₁	Input current, RESIN		V _I = 0.4 V to V _{CC}				-10	μА
l _j	Input current, SENSE	TL7702B	$V_I = V_{ref}$ to $V_{CC} - 1.5 V_{cc}$			-0.1	-2	μА
IOH	High-level output current, RESET		V _O = 18 V				50	μА
loL	Low-level output current, RESET		V _O = 0				-50	μA
laa	Supply aurrent		V _{SENSE} = 15 V,	RESIN ≥ 2 V		1.8	3	m A
ICC	Supply current		V _{CC} = 18 V T _A	= Full range‡			4	mA

[†] All electrical characteristics are measured with 0.1-μF capacitors connected at REF, CT, and V_{CC} to GND.

switching characteristics, $V_{CC} = 5 \text{ V}$, CT open, $T_A = 25^{\circ}\text{C}$

PARAMETER		FROM TO		TEST CONDITIONS	TL7702BM, TL7705BM			UNIT	
	PARAMETER	(INPUT) (OUTPUT)		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
^t PLH	Propagation delay time from low-to-high-level output	RESIN	RESET	See Figures 1.2 and 2		270	500*	ns	
tPHL	Propagation delay time from high-to-low-level output	RESIN	RESET	RESET See Figures 1, 2, and 3		270	500*	ns	
	Effective pulse duration	RESIN		See Figure 2		150		ns	
t _w	Ellective pulse duration	SENSE		See Figure 2		100		115	
t _r	Rise time		RESET				75*		
tf	Fall time		HESEI	See Figures 1 and 3		150	200*	ns	
t _r	Rise time		RESET	Occ i iguico i aliu o		75	150*	ns	
tf	Fall time		RESET				50*	l iis	

^{*}For products compliant to MIL-STD-883, Class B, these parameters are not production tested.

[‡] Full range for the M-suffix device is -55°C to 125°C.

[§] This is the lowest value at which RESET becomes active.

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electrical characteristics over recommended operating conditions, $T_A = 25$ °C (unless otherwise noted)

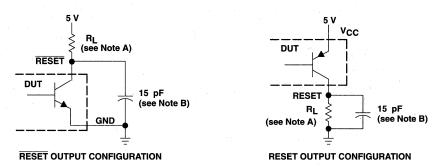
	PARAMETER		TEST COND	TEST CONDITIONST		TL7702Y, TL7705Y		
			TEST CONDITIONS!		MIN	TYP	MAX	UNIT
Vон	High-level output voltage, RESET	,	I _{OH} = -16 mA		V _{CC} -1.5			٧
VOL	Low-level output voltage, RESET		I _{OL} = 16 mA				0.4	٧
V _{ref}	Reference voltage		I _{ref} = 500 μA		2.48	2.53	2.58	
Vir	Negative-going input threshold	TL7702Y			2.505	2.53	2.555	٧
V _{IT} _	voltage, SENSE	TL7705Y			4.5	4.55	4.6	
V.	Hystoresia SENSE (V V)	TL7702Y	V 26 V to 10 V			10		\/
V _{hys}	Hysteresis, SENSE (V _{IT+} – V _{IT-})	TL7705Y	V _{CC} = 3.6 V to 18 V			30		mV
v _{res} ‡	Power-up reset voltage		IOL at RESET = 2 mA				1	٧
l _l	Input current, RESIN		V _I = 0.4 V to V _{CC}				-10	μА
lj	Input current, SENSE	TL7702Y	V _I = V _{ref} to 18 V			-0.1	-2	μА
ЮН	High-level output current, RESET		V _O = 18 V,	See Figure 1			50	μА
loL	Low-level output current, RESET		V _O = 0 V,	See Figure 1			-50	μА
Icc	Supply current		V _{SENSE} = 15 V,	RESIN ≥ 2 V		1.8	. 3	mA

[†] All electrical characteristics are measured with 0.1-µF capacitors connected at REF, CT, and V_{CC} to GND. † This is the lowest voltage at which RESET becomes active.

switching characteristics, V_{CC} = 5 V, CT open, T_A = 25°C

	PARAMETER		то	TEST CONDITIONS	TL7702Y, TL7705Y			UNIT	
PANAMETER		(INPUT)	(OUTPUT)	1EST CONDITIONS	MIN	TYP	MAX	ONLI	
tPLH	Propagation delay time from low-to-high-level output	RESIN	RESET	Can Figure 1 0 and 2		270	500	ns	
^t PHL	Propagation delay time from high-to-low-level output	RESIN	RESET	See Figures 1, 2, and 3		270	500	ns	
÷	Effective pulse duration	RESIN		See Figure 2		150		ns	
t _W	SEI	SENSE		See Figure 2		100		115	
tr	Rise time		RESET				75		
tf	Fall time		HESEI	See Figures 1 and 3		150	200	ns	
t _r	Rise time		RESET	See Figures 1 and 3		75	150	ne	
tf	Fall time		RESET				50	ns	

PARAMETER MEASUREMENT INFORMATION



NOTES: A. For I $_{OL}$ and I $_{OH}$, R $_{L}$ = 10 k $_{\Omega}$. For all switching characteristics, R $_{L}$ = 511 $_{\Omega}$. B. This figure includes jig and probe capacitance.

Figure 1. RESET and RESET Output Configurations



Figure 2. Input Pulse Definition

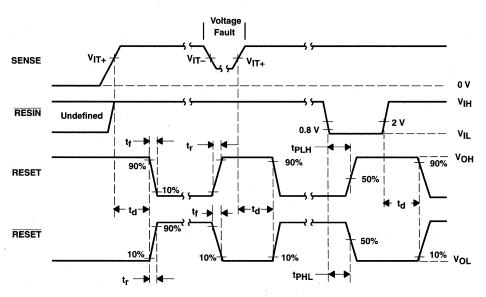
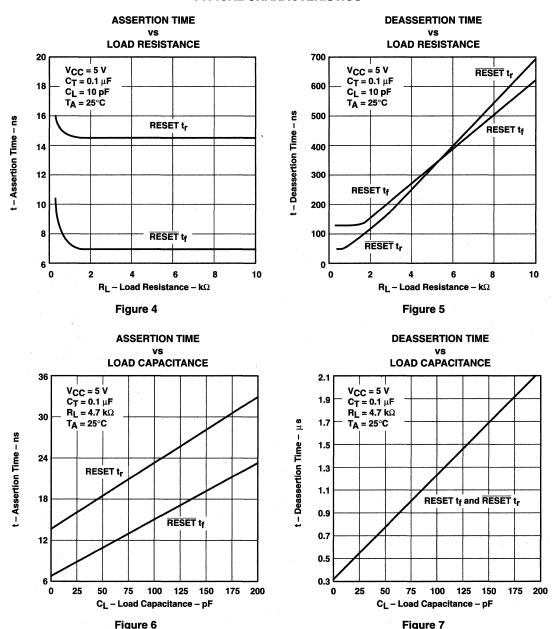


Figure 3. Voltage Waveforms

TYPICAL CHARACTERISTICS[†]



[†] For proper operation, both RESET and RESET should be terminated with resistors of similar value. Failure to do so may cause unwanted plateauing in either output waveform during switching.



APPLICATION INFORMATION

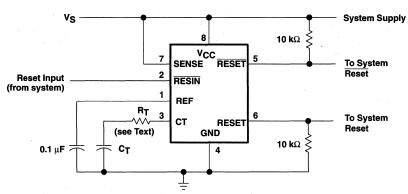


Figure 8. System Reset Controller With Undervoltage Sensing

When the TL770xB SENSE terminal is used to monitor V_{CC} , a current-limiting resistor in series with C_T is recommended. During normal operation, the timing capacitor is charged by the on-board current source to approximately V_{CC} or an internal voltage clamp (\approx 7.1-V zener), whichever is less. When the circuit is then subjected to an undervoltage condition during which V_{CC} is rapidly slewed down, the voltage on CT exceeds that on V_{CC} . This forward biases a secondary path internally, which falsely activates the outputs. A fault is indicated when V_{CC} drops below V_(CT), not when V_{SENSE} falls below V_{T-}.

Texas Instruments performs a 100% electrical screen to verify that the outputs do not switch with 1 mA forced into the CT terminal. Adding the external resistor, R_T, prevents false triggering. Its value is calculated as follows:

$$\frac{V_{(CT)} - V_{T-}}{R_T} < 1 \text{ mA}$$

 $V_{(CT)} = V_{CC}$ or 7.1 V, whichever is less $V_{T-} = 4.55$ V (nom)

= value of series resistor required

for $V_{CC} = 5 \text{ V}$:

$$\frac{5 - 4.55}{R_T}$$
 < 1 mA

Therefore,

$$R_T > 450 \Omega$$

Using a 20% tolerance resistor, R_T should be greater than 560 Ω .

Adding this series resistor changes the duration of the reset pulse by no more than 10%. R_T extends the discharge of C_T , but also skews the $V_{(CT)}$ threshold. These effects tend to cancel one another. The precise percentage change can be derived theoretically, but the equation is complicated by this interaction and is dependent upon the duration of the supply voltage fault condition.

Both outputs of the TL770xB should be terminated with similar value resistors, even when only one is being used. This prevents unwanted plateauing in either output waveform during switching, which may be interpreted as an undefined state or delay system reset.



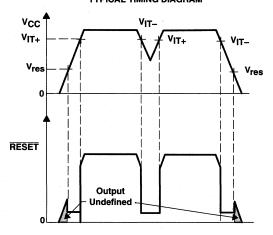
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available features

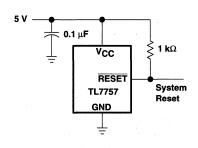
- Power-On Reset Generator
- Automatic Reset Generation After Voltage Drop
- Low Standby Current . . . 20 μA
- Reset Output Defined When V_{CC} Exceeds 1 V

- Complementary Reset Output
- Precision Threshold Voltage 4.55 V +120 mV
- High Output Sink Capability . . . 20 mA
- Comparator Hysteresis Prevents Erratic Resets

TYPICAL TIMING DIAGRAM



TYPICAL APPLICATION DIAGRAM



description

The TL7757 is a monolithic supply voltage supervisor designed for use in microcomputer and microprocessor systems. The supervisor monitors the supply voltage for undervoltage conditions. During power up, when the supply voltage, V_{CC} , attains a value approaching 1 V, the $\overline{\text{RESET}}$ output becomes active (low) to prevent undefined operation. If at any time, the supply voltage drops below threshold voltage level (V_{IT-}), the $\overline{\text{RESET}}$ output goes to the active (low) level until the supply undervoltage fault condition is eliminated.

The C-suffix device is characterized for operation from 0°C to 70°C. The I-suffix device is characterized for operation from -40°C to 85°C. The M-suffix device is characterized for operation from -55°C to 125°C.

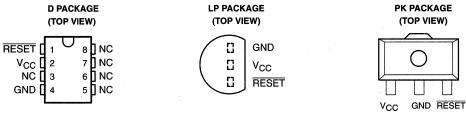
AVAILABLE OPTIONS

	PACK			
TA	SMALL OUTLINE (D)	TO-226AA (LP)	SOT-89 (PK)	CHIP FORM (Y)
0°C to 70°C	TL7757CD	TL7757CLP	TL7757CPK	
-40°C to 85°C	TL7757ID	TL7757ILP	TL7757IPK	TL7757Y
-55°C to 125°C	TL7757MD	TL7757MLP	I . —	

D and LP packages are available taped and reeled. Add R suffix to device type (e.g., TL7757CDR). Chips are tested at 25° C.



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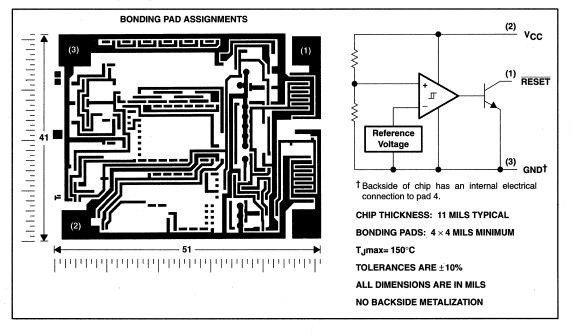


NC-No internal connection

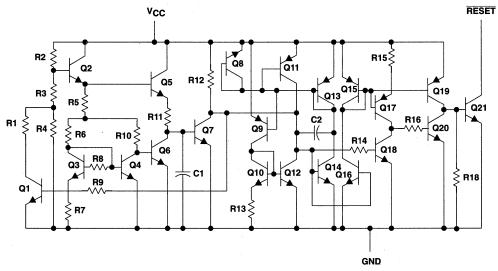
GND is in electrical contact with the tab.

TL7757Y chip information

This chip, when properly assembled, displays characteristics similar to the TL7757C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



equivalent schematic



ACTUAL DI COMPONENT	
Transistors	27
Resistors	20
Capacitors	2

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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{CC} (see Note 1)	0.3 V to 20 V
Offstate output voltage range (see Note 1)	0.3 V to 20 V
Output current, IO	
Operating free-air temperature range, TA: C-suffix	0°C to 70°C
I-suffix	40°C to 85°C
M-suffix	55°C to 125°C
Continuous total power dissipation	See Dissipation Rating Tables
Storage temperature range, T _{Stq}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to network terminal ground.

DISSIPATION RATING TABLE 1 - FREE-AIR TEMPERATURE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	DERATE ABOVE	T _A = 70°C	T _A = 85°C	T _A = 125°C
D	725 mW	5.8 mW/°C	T _A = 25°C	464 mW	377 mW	145 mW
, LP	775 mW	6.2 mW/°C	$T_A = 25^{\circ}C$	496 mW	403 mW	155 mW
PK	500 mW	4.0 mW/°C	T _A = 25°C	320 mW	260 mW	

DISSIPATION RATING TABLE 2 - CASE TEMPERATURE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	DERATE ABOVE	T _A = 70°C	T _A = 85°C
PK	3125 mW	25 mW/°C	T _C =110°C	2000 mW	1625 mW

recommended operating conditions

	C-SUFFIX		I-SUFFIX		M-SUFFIX		UNIT	
	MIN	MAX	MIN	MAX	MIN	MAX	UNII	
Supply voltage, V _{CC}	1	7	. 1	7	. 1	7	٧	
High-level output voltage, VOH		15		15		15	V	
Low-level output current, IOL		20		20		20	mA	
Operating free-air temperature, TA	0	70	-40	85	-55	125	°C	

electrical characteristics at specified free-air temperature

	DADAMETED	TEST CONDI	TIONS	T. †	TL7757C			LIMIT
	PARAMETER	TEST CONDI	IONS	T _A †	MIN	TYP	MAX	UNIT
V	Negative-going input threshold			25°C	4.43	4.55	4.67	V
V _{IT} _	voltage at V _{CC}			Full range	4.4		4.7	V
v +	Hystoropia at V = =			25°C	40	50	60	mV
V _{hys} ‡	Hysteresis at V _{CC}			Full range	30		70	IIIV
V- Low level - drud - drud	Law law law to the ca	1 00A V	20 mA, V _{CC} = 4.3 V	25°C		0.4	0.8	v
VOL	Low-level output voltage	IOL = 20 IIIA, VCC =		Full range			0.8	· •
1	High level subject surrent	V _{CC} = 7 V, V _{OH} =	V _{OH} = 15 V,	25°C			1	
ЮН	High-level output current	See Figure 1		Full range			1	μΑ
8	Down up react veltage	D. O.O.kO. V als		25°C		0.8	1	V
V _{res} §	Power-up reset voltage	$R_L = 2.2 \text{ k}\Omega$, V_{CC} sle	ew rate ≤ 5 V/μs	Full range			1.2	V
		V 40V	V _{CC} = 4.3 V			1400	2000	
Icc	Supply current	ACC = 4.3 A					2000	μΑ
		V _{CC} = 5.5 V		Full range			40	

[†] Full range is 0°C to 70°C.

switching characteristics at $T_A = 25^{\circ}C$ (unless otherwise noted)

	PARAMETER	TEST COMPITIONS	T. T	TL7757C			LIMIT
	PARAMETER	TEST CONDITIONS	T _A †	MIN	TYP	MAX	UNIT
t n	Propagation delay time, low-to-high-level output	V _{CC} slew rate ≤ 5 V/μs,	25°C		3.4	5	
^t PLH	Propagation delay time, low-to-night-level output	See Figures 2 and 3	Full range			5	μs
	Drangation delay time, high to law level output	Can Figures 2 and 2	25°C		2	5	
^t PHL	Propagation delay time, high-to-low-level output	See Figures 2 and 3	Full range			5	μs
	Rise time	V _{CC} slew rate ≤ 5 V/μs,	25°C		0.4	1	
t _r	Hise urile	See Figures 2 and 3	e Figures 2 and 3 Full range			1	μs
4.	Fall time	Can Figures 0 and 0	25°C		0.05	1	
tf	raii ume	See Figures 2 and 3	Full range			1	μs
	Minimum mulas duration at V = - few authors transport		25°C			5	
^t w(min)	Minimum pulse duration at V _{CC} for output response]	Full range			5	μs

[†] Full range is 0°C to 70°C.

[‡] This is the difference between positive-going input threshold voltage, V_{IT+}, and negative-going input threshold voltage, V_{IT-}. § This is the lowest voltage at which RESET becomes active.

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electrical characteristics at specified free-air temperature

	PARAMETER	TEST CONDITIONS	- .+	1	L77571	``.	UNIT
	PARAMETER	TEST CONDITIONS	T _A †	MIN	TYP	MAX	UNIT
V	Negative-going input threshold	-	25°C	4.43	4.55	4.67	V
VIT-	voltage at V _{CC}		Full range	4.4		4.7	V
+	Hystoresia at V		25°C	40	50	60	mV
V _{hys} ‡	Hysteresis at V _{CC}		Full range	30		70	mv
V	VOI Low-level output voltage IOI = 20 mA, V	L- 00 A - W 40 W	25°C		0.4	0.8	V
VOL	Low-level output voltage	I _{OL} = 20 mA, V _{CC} = 4.3 V	Full range			0.8	V
	Lligh level autout august	V _{CC} = 7 V, V _{OH} = 15 V,	25°C		1	1	
ЮН	High-level output current	See Figure 1	Full range			1	μА
	Davida va acceptante	D. 0.01-0. We a slew water & 5.Wha	25°C		0.8	1	V
V _{res} §	Power-up reset voltage	$R_L = 2.2 \text{ k}\Omega$, V_{CC} slew rate $\leq 5 \text{ V/}\mu\text{s}$	Full range			1.2	V
		V 40V	25°C		1400	2000	
Icc	Supply current	V _{CC} = 4.3 V	Full range			2100	μА
		V _{CC} = 5.5 V	Full range			40	

[†] Full range is -40°C to 85°C.

switching characteristics at $T_A = 25$ °C (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	T. T	TL7757I			UNIT
	PANAMETEN	TEST CONDITIONS	TAT	MIN	TYP	MAX	ONIT
	Propagation delay time, low-to-high-level output	V _{CC} slew rate ≤ 5 V/μs,	25°C		3.4	5	
tPLH	Propagation delay time, low-to-nigh-level output	See Figures 2 and 3	Full range			5	μs
4	Dispression delegations high to level entered	Can Figures 0 and 0	25°C		2	5	μs
^t PHL	Propagation delay time, high-to-low-level output	See Figures 2 and 3	Full range			5	
	Rise time	V _{CC} slew rate ≤ 5 V/μs,	25°C		0.4	1	
t _r	nise time	See Figures 2 and 3	Full range			. 1	μs
	Fall time	0 5	25°C		0.05	1	
tf	raii time	See Figures 2 and 3	Full range			1	μs
	Minimum mula advumbian ad V for a double was a		25°C			5	
^t w(min)	Minimum pulse duration at V _{CC} for output response		Full range			5	μs

[†] Full range is -40°C to 85°C.

[‡]This is the difference between positive-going input threshold voltage, VIT+, and negative-going input threshold voltage, VIT-.

[§] This is the lowest voltage at which RESET becomes active.

electrical characteristics at specified free-air temperature

	DADAMETED	TEST COMPLIANCE	T. +	TL7757M			
	PARAMETER	TEST CONDITIONS	TAT	MIN	TYP	MAX	UNIT
V	Negative-going input threshold		25°C	4.43	4.55	4.67	V
V _{IT} _	voltage at V _{CC}		Full range	4.35		4.7	· ·
· +	Hystorosis at V = =		25°C	40	50	60	
V _{hys} ‡	Hysteresis at V _{CC}		Full range	30		70	mV
V	Law layed autout valtage	1- 00 mA - V 40 V	25°C		0.4	0.8	٧
VOL	Low-level output voltage	$I_{OL} = 20 \text{ mA}, V_{CC} = 4.3 \text{ V}$	Full range			0.8	
la	Lligh level autout aument	V _{CC} = 7 V, V _{OH} = 15 V,	25°C			1	
ЮН	High-level output current	See Figure 1	Full range			1	μА
v 8	Power up recet veltege	D. O.O.KO. Was allow rate < 5.	25°C		0.8	1	V
V _{res} §	Power-up reset voltage	$R_L = 2.2 \text{ k}\Omega$, V_{CC} slew rate $\leq 5 \text{ N}$	Full range			1.2	V .
		V 42V	25°C		1400	2000	μА
Icc	Supply current	V _{CC} = 4.3 V	Full range			2500	
		V _{CC} = 5.5 V	Full range			40	

[†] Full range is -55°C to 125°C.

switching characteristics at $T_A = 25$ °C (unless otherwise noted)

	PARAMETER	TECT COMPLETIONS	T. +	TL7757M			11117
	PARAMETER	TEST CONDITIONS	TA [†]	MIN	TYP	MAX	UNIT
•=	Propagation delay time, low-to-high-level output	V _{CC} slew rate ≤ 5 V/μs,	25°C		3.4	5*	
^t PLH	Propagation delay time, low-to-night-level output	See Figures 2 and 3	Full range			5*	μs
	Demonstran delegations high to lead have a street	Can Figures 0 and 0	25°C		2	5*	
tPHL .	Propagation delay time, high-to-low-level output	See Figures 2 and 3	Full range			5*	μs
	Disables	V _{CC} slew rate ≤ 5 V/μs,	25°C		0.4	1*	
t _r	Rise time	See Figures 2 and 3	Full range			1*	μs
	Fall kinns	C Figure 0 10	25°C		0.05	1*	
tf	Fall time	See Figures 2 and 3	Full range)		1	μs
	Minimum and a district and the state of the		25°C			5*	
^t w(min)	Minimum pulse duration at V _{CC} for output response		Full range			5*	μs

^{*}On products compliant to MIL-STD-883, Class B, this parameter is not production tested.

[‡] This is the difference between positive-going input threshold voltage, V_{IT+}, and negative-going input threshold voltage, V_{IT-}. § This is the lowest voltage at which RESET becomes active.

[†] Full range is -55°C to 125°C.

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electrical characteristics at T_A = 25°C

	DADAMETED	TECT COMPLETIONS	TL7757Y		LINUT
	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
V _{IT} _	Negative-going input threshold voltage at V _{CC}		4.55		٧
v _{hys} †	Hysteresis at V _{CC}		50		mV
VOL	Low-level output voltage	$I_{OL} = 20 \text{ mA}, V_{CC} = 4.3 \text{ V}$	0.4		٧
ЮН	High-level output current	$V_{CC} = 7 \text{ V}$, $V_{OH} = 15 \text{ V}$, See Figure 1			μΑ
v _{res} ‡	Power-up reset voltage	$R_L = 2.2 \text{ k}\Omega$, V_{CC} slew rate $\leq 5 \text{ V/μs}$	0.8	h .	٧
lcc	Supply current	V _{CC} = 4.3 V V _{CC} = 5.5 V	1400		μА

[†] This is the difference between positive-going input threshold voltage, V_{IT+}, and negative-going input threshold voltage, V_{IT-}.

switching characteristics at $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	Т	TL7757Y		
	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
^t PLH	Propagation delay time, low-to-high-level output	V_{CC} slew rate ≤ 5 V/μs, See Figures 2 and 3		3.4	-	μs
^t PHL	Propagation delay time, high-to-low-level output	See Figures 2 and 3,		2		μs
t _r	Rise time	V _{CC} slew rate ≤ 5 V/μs, See Figures 2 and 3		0.4		μs
tf	Fall time	See Figures 2 and 3		0.05		μs



[‡]This is the lowest voltage at which RESET becomes active.

PARAMETER MEASUREMENT INFORMATION

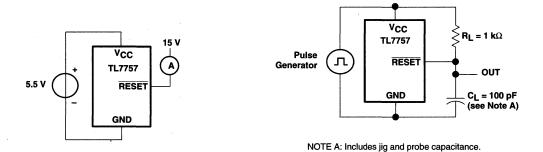
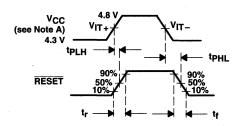


Figure 1. Test Circuit for Output Leakage Current

Figure 2. Test Circuit for RESET Output **Switching Characteristics**



NOTE A: V_{CC} slew rate $\leq 5 \, \mu s$

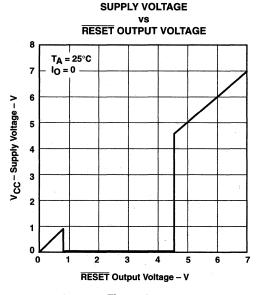
Figure 3. Switching Diagram

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TYPICAL CHARACTERISTICS†

table of graphs

			FIGURE
VCC	Supply voltage	vs RESET output voltage	4
	Supply current	vs Supply voltage	5
ICC	Supply current	vs Free-air temperature	6
V	Low level output veltage	vs Low-level output current	7
VOL	Low-level output voltage	vs Free-air temperature	8
lOL	Output current	vs Supply voltage	9
V _{IT} _	Input threshold voltage (negative-going V _{CC})	vs Free-air temperature	10
V _{res}	Power-up reset voltage	vs Free-air temperature	11
V _{res}	Power-up reset voltage and supply voltage	vs Time	12
	Propagation delay time		13





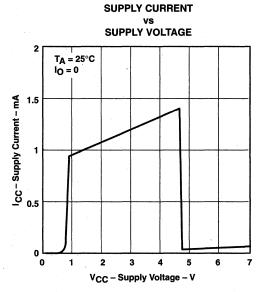
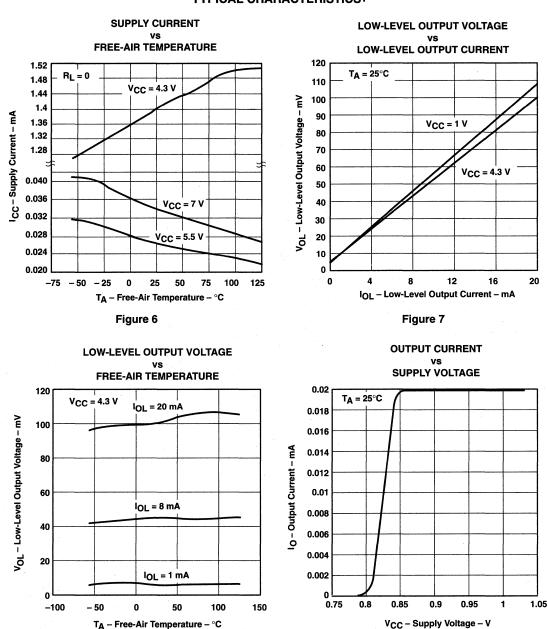


Figure 5

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS†



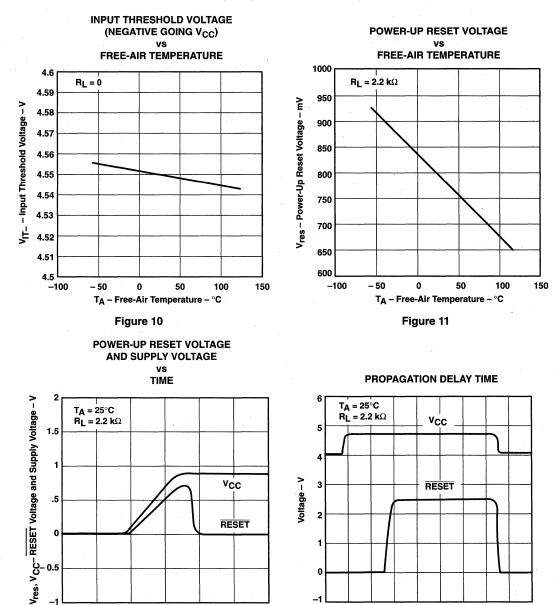
[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 8



Figure 9

TYPICAL CHARACTERISTICS[†]



† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



0 2

4

10 12

t - Time - μs

Figure 13

14

0

0.5

1.5

Figure 12

t - Time - μs

TL7759, TL7759Y SUPPLY VOLTAGE SUPERVISORS

SLVS042B - JANUARY 1991 - REVISED AUGUST 1995

- Power-On Reset Generator
- Automatic Reset Generation After Voltage Drop
- Precision Input Threshold Voltage 4.55 V ±120 mV
- Low Standby Current . . . 20 μA
- Reset Outputs Defined When V_{CC} Exceeds 1 V
- True and Complementary Reset Outputs
- Wide Operating Temperature Range 0°C to 70°C
- Wide Supply Voltage Range . . . 1 V to 7 V

NC - No internal connection

description

The TL7759C is a monolithic supply voltage supervisor designed for use as a reset controller in microcomputer and microprocessor systems. The supervisor monitors the supply voltage for undervoltage conditions. During power-up, when the supply voltage, V_{CC} , attains a value approaching 1 V, the RESET and \overline{RESET} outputs become active (high and low, respectively) to prevent undefined operation. If at any time the supply voltage drops below the input threshold voltage level (V_{IT-}), the reset outputs go to the reset active state until the supply voltage has returned to its nominal value.

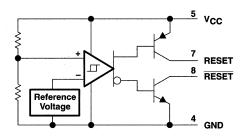
The TL7759C is characterized for operation from 0°C to 70°C.

AVAILABLE OPTIONS

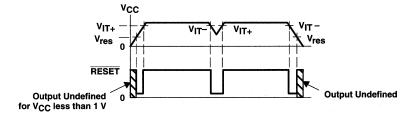
Γ		•	PACKAGE	CHIP	
	TA	V _{IO} max AT 25°C	SMALL OUTLINE (D)	PLASTIC DIP (P)	FORM (Y)
ľ	0°C to 70°C	2.5 mV	TL7759CD	TLC7759CP	TL7759Y

The D packages are available taped and reeled. Add R suffix to device type (e.g., TL7759CDR). Chips are tested at 25°C.

functional block diagram

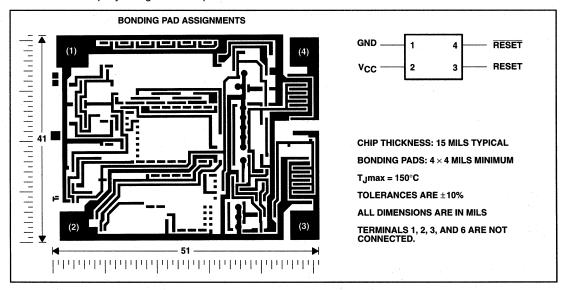


timing diagram



TL7759Y chip information

This chip, when properly assembled, displays characteristics similar to the TL7759C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.





TL7759, TL7759Y SUPPLY VOLTAGE SUPERVISORS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)	20 V
Off-state output voltage range: RESET voltage	0.3 V to 20 V
RESET voltage	0.3 V to 20 V
Low-level output current, I _{OL} (RESET)	30 mA
High-level output current, IOH (RESET)	–10 mA
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, T _A	0°C to 70°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW
P	1000 mW	8.0 mW/°C	640 mW	520 mW

recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V _{CC}		1	7	V
Output voltage, VO (see Note 2)	Transistor off RESET voltage		15	V
	Transistor off RESET voltage	0		
Low-level output current, IOL	RESET		24	mA
High-level output current, IOH	RESET		,-8	mA
Operating free-air temperature, TA		0	70	°C

NOTE 2: RESET output must not be pulled down below GND potential.

NOTE 1: All voltage values are with respect to the network ground terminal.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

-	DADAMETED	TEST CONDITIONS		1	TL7759C			
	PARAMETER			MIN	TYPT	MAX	UNIT	
VOL	Low-level output voltage	RESET	V _{CC} = 4.3 V	IOL = 24 mA		0.4	0.8	V
VOH	High-level output voltage	RESET	VCC = 4.5 V	I _{OH} = -8 mA	V _{CC} -1			V
v`		-i\	T _A = 25°C		4.43	4.55	4.67	7 v
VIT-	V _{IT} — Input threshold voltage (negative-going V _{CC})		$T_A = 0$ °C to 70°C	· · · · · · · · · · · · · · · · · · ·	4.4		4.7	V
v +	Power-up reset voltage		D. 0.0kO	T _A = 25°C		0.8	1	J
V _{res} ‡	Power-up reset voltage		$R_L = 2.2 \text{ k}\Omega$ $T_A = 0^{\circ}\text{C to } 70^{\circ}\text{C}$				1.2	· V
v. c	I historia at V innut		T _A = 25°C		40	50	60	\/
V _{hys} §	Hysteresis at V _{CC} input		$T_A = 0$ °C to 70°C		30		70	mV
ЮН	High-level output current	RESET	V _{CC} = 7 V,	V _{OH} = 15 V		,	1	
lOL	Low-level output current	RESET	See Figure 1	V _{OL} = 0 V			-1	μА
loo	Supply current		No load	V _{CC} = 4.3 V		1400	2000	
ICC	Supply current		V _{CC} = 5.5 V				40	μА

[†] Typical values are at $T_A = 25$ °C.

switching characteristics at $T_A = 25$ °C (unless otherwise noted)

	PARAMETER		то	TEST	TL77	'59C	UNIT
	PANAMETEN	(INPUT)	(OUTPUT)	CONDITIONS	MIN	MAX	UNII
t _{PLH}	Propagation delay time, low-to-high-level output	Vcc	RESET	See Figures 2 and 3 [†]		5	
tPHL	Propagation delay time, high-to-low-level output	VCC	RESET	See Figures 2 and 4		5	μs
t _r	Rise time		RESET	See Figures 2 and 4 [†]		1	μs
tf	Fall time		RESET	See Figures 2 and 4		1	μs
tw(min)	Minimum pulse duration	Vcc	RESET	See Figures 2 and 4	. 5		μs

[†] V_{CC} slew rate > 5 V/μs.

electrical characteristics, T_A = 25°C (unless otherwise noted)

DADAMETED		TEST COMPLETIONS		TL7759Y			UNIT	
	PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
VOL	Low-level output voltage	RESET	V _{CC} = 4.3 V	I _{OL} = 24 mA		0.4		V
V _{IT} _	V _{IT} _ Input threshold voltage (negative-going V _{CC})					4.55		٧
v _{res} †	Power-up reset voltage		$R_L = 2.2 \text{ k}\Omega$			0.8		V
V _{hys} ‡	Hysteresis at V _{CC} input					50		mV
Icc	Supply current		V _{CC} = 4.3 V,	No load		1400		μA

[†] This is the lowest voltage at which \overline{RESET} becomes active, V_{CC} slew rate $\geq 5 \text{ V/}\mu s$.

[‡] This is the lowest voltage at which RESET becomes active, V_{CC} slew rate ≥ 5 V/μs. § This is the difference between positive-going input threshold voltage, V_{IT+}, and negative-going input threshold voltage, V_{IT+}.

[‡] This is the difference between positive-going input threshold voltage, V_{IT-}, and negative-going input threshold voltage, V_{IT-}.

PARAMETER MEASUREMENT INFORMATION

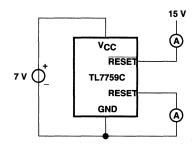


Figure 1. Test Circuit for Output Leakage Current

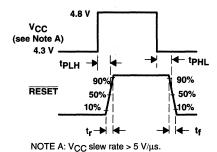


Figure 2. Switching Diagram

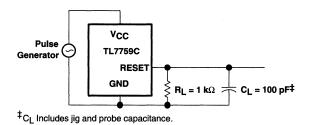
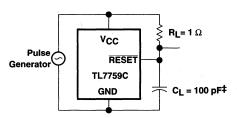


Figure 3. Test Circuit for RESET Output **Switching Characteristics**



[‡]C_L Includes jig and probe capacitance.

Figure 4. Test Circuit for RESET Output **Switching Characteristics**

APPLICATION INFORMATION

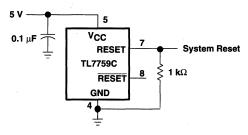


Figure 5. Power Supply System Reset Generation

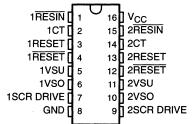


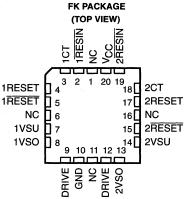
- Power-On Reset Generator
- Automatic Reset Generation After Voltage Drop
- RESET Defined When V_{CC} Exceeds 1 V
- Wide Supply Voltage Range . . . 3.5 V to 18 V
- Precision Overvoltage and Undervoltage Sensing
- 250-mA Peak Output Current for Driving SCR Gates
- 2-mA Active-Low SCR Gate Drive for False Trigger Protection
- Temperature-Compensated Voltage Reference
- True and Complementary Reset Outputs
- Externally Adjustable Output Pulse Duration

description

The TL7770 is a monolithic integrated circuit system supervisor designed for use as a reset controller in microcomputer and microprocessor power supply systems. This device contains two independent supply-voltage supervisors that monitor the supplies for overvoltage and undervoltage conditions at the VSO and VSU terminals respectively. When V_{CC} attains the minimum voltage of 1 V during power-up, the $\overline{\rm RESET}$ output becomes active (low). As V_{CC} approaches 3.5 V, the delay timer function activates latching RESET







SSCR

NC-No internal connection

SCR [

and $\overline{\text{RESET}}$ active (high and low, respectively) for a time delay, t_d , after system voltages have achieved normal levels. Above $V_{CC}=3.5$ V, taking $\overline{\text{RESIN}}$ low activates the time delay function, RESET and $\overline{\text{RESET}}$, during normal system voltage levels. To ensure that the microcomputer system has reset, the outputs remain active until the voltage at VSU exceeds the threshold value V_{IT+} for a time delay, t_d , which is determined by an external timing capacitor such that:

$$t_d \approx 20 \times 10^3 \times capacitance$$

where t_d is in seconds and capacitance is in farads.

The overvoltage-detection circuit is programmable for a wide range of user designs. During an overvoltage condition, an internal silicon-controlled rectifier (SCR) is triggered, providing 250-mA peak instantaneous current and 25-mA continuous current to the SCR gate drive terminal, which can drive an external high-current SCR gate or an overvoltage warning circuit.

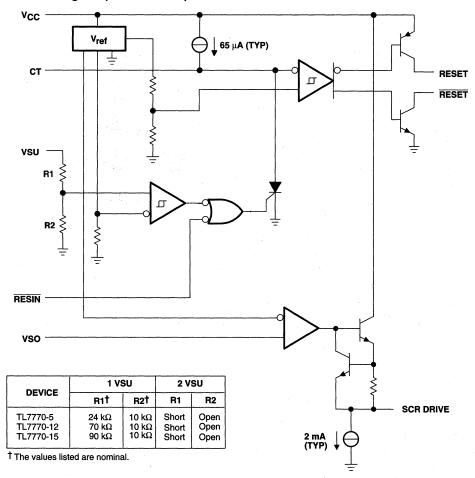
The TL7770C is characterized for operation from 0° C to 70° C. The TL7770M series is characterized for operation from -55° C to 125° C. The TL7770Q series is characterized for operation from -40° C to 125° C.



Δ١	/ΔΙΙ	ΔRI	E O	PTI	ONS	3

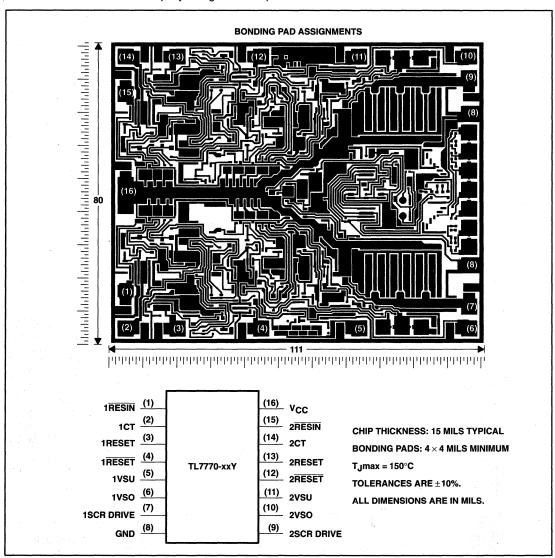
		OUID FORM			
TA	SMALL OUTLINE (DW)	CHIP CARRIER (FK)	CERAMIC DIP (J)	PLASTIC DIP (N)	CHIP FORM (Y)
	TL7770-5CDW	_		TL7770-5CN	TL7770-5Y
0°C to 70°C	TL7770-12CDW		-	TL7770-12CN	TL7770-12Y
	TL7770-15CDW		· —	TL7770-15CN	TL7770-15Y
	TL7770-5QDW	_	-	TL7770-5QN	_
-40°C to 125°C	TL7770-12QDW	_		TL7770-12QN	_
	TL7770-15QDW		_	TL7770-15QN	_
	_	TL7770-5MFK	TL7770-5MJ	_	
-55°C to 125°C	<u></u>	TL7770-12MFK	TL7770-12MJ		
	-	TL7770-15MFK	TL7770-15MJ		_

functional block diagram (each channel)



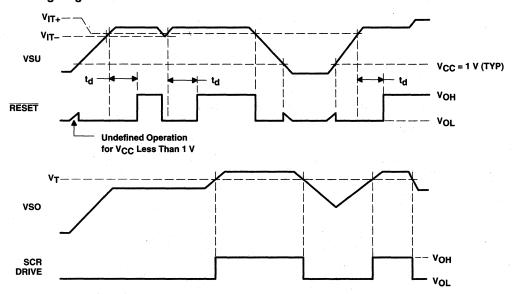
TL7770-xxY chip information

These chips, when properly assembled, display characteristics similar to the TL7770-xxC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



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typical timing diagram



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Input voltage range, V _I : 1VSU, 2VSU, 1VSO, and 2VSO (see Note 1)
Low-level output current (1RESET and 2RESET), I _{OL}
High-level output current (1RESET and 2RESET), I _{OH}
Continuous total power dissipation
Operating free-air temperature range, T _A : TL7770_C
TL7770_M55°C to 125°C
TL7770–Q—40°C to 125°C
Operating virtual junction temperature range, T _J
Storage temperature range, T _{stg} 65°C to 150°C
Case temperature for 60 seconds: FK package
Lead temperature 1,6 mm (1/16 in) from case for 10 seconds: DW or N package
Lead temperature 1,6 mm (1/16 in) from case for 60 seconds: J package

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to the network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
DW	1025 mW	8.2 mW/°C	656 mW	533 mW	205 mW
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
J	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
N	1150 mW	9.2 mW/°C	736 mW	598 mW	230 mW



TL7770-5, TL7770-12, TL7770-15 TL7770-5Y, TL7770-12, TL7770-15Y DUAL POWER-SUPPLY SUPERVISORS

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recommended operating conditions

		MIN	MAX	UNIT	
Supply voltage, V _{CC}		3.5	18	٧	
Input voltage range, V _I (see Note 2)	1VSU, 2VSU, 2VSO, 1VSO	0	18	V	
Output voltage (1CT and 2CT), VO			5	٧	
High-level input voltage range, V _{IH} , 1RES	IN, 2RESIN	2	18	٧	
Low-level input voltage range, V _{IL} , 1RESIN, 2RESIN		0	0.8	V	
Output sink current (1CT and 2CT), IO	ut sink current (1CT and 2CT), IO 50		50	μА	
High-level output current (1RESET and 2F	RESET), IOH		-16	mA	
Low-level output current (1RESET and 2R	ESET, I _{OL}		16	mA	
Continuous output current (1SCR DRIVE	and 2SCR DRIVE), IO		25	mA	
Timing Capacitor, C _T			10	μF	
	TL7770C Series	0	70		
Operating free-air temperature, TA	TL7770M Series	-55	125	°C	
	TL7770Q Series	-40	125	Ì	

NOTE 2: The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic voltage levels only.

TL7770-5, TL7770-12, TL7770-15 TL7770-5Y, TL7770-12Y, TL7770-15Y **DUAL POWER-SUPPLY SUPERVISORS**

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electrical characteristics over recommended ranges of supply voltage, input voltage, output current, and free-air temperature (unless otherwise noted)

supply supervisor section

	PARAM	TEST CONDITIONST	TL7770-5 TL7770-1 TL7770-12	UNIT			
				MIN	TYP‡	MAX	
V	Lligh lovel output voltage	RESET	I _{OH} = -15 mA	V _{CC} -1.5			V
VOH	High-level output voltage	SCR DRIVE	I _{OH} = -20 mA	V _{CC} -1.5			V
VOL	Low-level output voltage RESET I _{OL} = 15 mA		I _{OL} = 15 mA			0.4	V
	,	TL7770-5 (5-V sense, 1VSU)	· .	4.5	4.55	4.6	
		TL7770-12 (12-V sense, 1VSU)		10.8	10.9	11.02	
V _{IT} _		TL7770-15 (15-V sense, 1VSU)	T _A = 25°C	13.5	13.64	13.77	
	Undervoltage input thresh-	TL7770-5, TL7770-12, TL7770-15 (programmable sense, 2VSU)		1.485	1.5	1.515	
	old at VSU (negative-going)	VSU (negative-going) TL7770-5 (5-V sense, 1VSU) 4.46		4.64	V		
		TL7770-12 (12-V sense, 1VSU)		10.68		11.12	
		TL7770-15 (15-V sense, 1VSU)	$T_A = MIN \text{ to } MAX$	13.36		13.91	
		TL7770-5, TL7770-12, TL7770-15 (programmable sense, 2VSU)		1.47		1.53	
		TL7770-5 (5-V sense, 1VSU)			15		
		TL7770-12 (12-V sense, 1VSU)			36		
V _{hys}	Hysteresis at VSU	TL7770-15 (15-V sense, 1VSU)	T _A = 25°C		45		mV
,	(V _{IT+} – V _{IT} –)	TL7770-5, TL7770-12, TL7770-15 (programmable sense, 2VSU)			5		
	Overvoltage threshold at	TL7770-5, TL7770-12, TL7770-15	T _A = 25°C	2.53	2.58	2.63	V
VT	VSO	(VSO)	T _A = MIN to MAX	2.48		2.68	V .
	1	RESIN	V _I = 5.5 V or 0.4 V			-10	
lį.	Input current	VSO	V _I = 2.4 V		0.5	2	μΑ
ІОН	High-level output current	RESET	V _O = 18 V			50	μΑ
loL	Low-level output current	RESET	V _O = 0		-	-50	μΑ
ЮН	Peak output current	SCR DRIVE	Duration = 1 ms	250			mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified in the recommended operating conditions.

total device

	PARAMETER	TL7770-15C, TL777			TL7770-5C, TL7770-12C TL7770-15C, TL7770-5Q TL7770-12Q, TL7770-15Q			
				MIN TYP‡ MA			1	
V _{res} §	Power-up reset voltage	V _{CC} = VSU			0.8	1	V	
loo	Supply current	1VSU = 18 V, 2VSU = 2 V, 1RESIN and 2RESIN at V _{CC} ,	T _A = 25°C			5	mA	
ICC	Supply current	1VSO and 2VSO at 0 V	T _A = MIN to MAX			6.5	IIIA	

[†] For conditions shown as MIN or MAX, use the appropriate value specified in the recommended operating conditions.



[‡] Typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡] Typical values are at V_{CC} = 5 V, T_A = 25°C. § This the lowest voltage at which RESET becomes active.

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electrical characteristics over recommended ranges of supply voltage, input voltage, output current, and free-air temperature (unless otherwise noted)

supply supervisor section

PA		PARAMETER		TL7770-5M, TL7770-12M TL7770-15M			UNIT	
	•			MIN	TYP‡	MAX		
V	High-level output voltage		I _{OH} = -15 mA	V _{CC} -1.5			٧	
VOH	nigh-level output voltage	SCR DRIVE	I _{OH} = -20 mA	V _{CC} -1.5			V	
v_{OL}	Low-level output voltage	RESET	I _{OL} = 15 mA			0.4	٧	
		TL7770-5M (5-V sense, 1VSU)		4.5	4.55	4.632		
		TL7770-12M (12-V sense, 1VSU)	1	10.8	10.9	11.07		
V _{IT} _		TL7770-15M (15-V sense, 1VSU)	T _A = 25°C	13.5	13.64	13.866		
	Undervoltage input threshold at VSU	TL7770-5M, TL7770-12M, TL7770-15M (programmable sense, 2VSU)	1 1/85 15	1.527				
	(negative-going)	TL7770-5M (5-V sense, 1VSU)		4.4		4.646	V	
	(negative going)	TL7770-12M (12-V sense, 1VSU)	T _A = MIN to MAX	10.62		11.12		
		TL7770-15M (15-V sense, 1VSU)		13.36		13.916		
		TL7770-5M, TL7770-12M, TL7770-15M (programmable sense, 2VSU)		1.47		1.542		
	Hysteresis at VSU (VIT+ - VIT-)	TL7770-5M (5-V sense, 1VSU)			15		mV	
.,		TL7770-12M (12-V sense, 1VSU)			36			
V_{hys}		TL7770-15M (15-V sense, 1VSU)	T _A = 25°C		45			
	(V + - V -)	TL7770-5M, TL7770-12M, TL7770-15M (programmable sense, 2VSU)			5			
VΤ	Overvoltage threshold	TL7770-5M, TL7770-12M, TL7770-15M	T _A = 25°C	2.53	2.58	2.63	V	
	at VSO	(VSO)	T _A = MIN to MAX	2.48		2.68	V	
	I	RESIN	V _I = 5.5 V or 0.4 V			-10		
lj ja	Input current	VSO	V _I = 2.4 V		0.5	2	μΑ	
IOH	High-level output current	RESET	V _O = V _{CC}			50	μА	
lOL	Low-level output current	RESET	V _O = 1			-50	μА	
ЮН	Peak output current	SCR DRIVE	Duration = 1 ms	250			mA	
<u> </u>	<u> </u>							

[†] For conditions shown as MIN or MAX, use the appropriate value specified in the recommended operating conditions.

total device

	PARAMETER	TL7770-5M, TL7770 TEST CONDITIONST TL7770-15M					UNIT
				MIN -	TYP‡	MAX	
V _{res} §	Power-up reset voltage	Vcc	$V_{OL} = 0.4 \text{ V}, I_{OL} = 1 \text{ mA}$		0.8	. 1	٧
lcc	Supply current	1VSU 18 V, 2 VSU = 2 V, 1RESIN and 2RESIN at VCC,	T _A = 25°C			5	mA
ICC .		1VSO and 2VSO at 0 V	T _A = MIN to MAX			6.5	. 11174

For conditions shown as MIN or MAX, use the appropriate value specified in the recommended operating conditions.

[‡] Typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡] Typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

TL7770-5, TL7770-12, TL7770-15 TL7770-5Y, TL7770-12Y, TL7770-15Y DUAL POWER-SUPPLY SUPERVISORS

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electrical characteristics over recommended ranges of supply voltage, input voltage, and output current (unless otherwise noted)

supply supervisor section

	PARAN	PARAMETER		TL7770- TL	UNIT			
				MIN	TYP	MAX		
		TL7770-5 (5-V sense, 1VSU)		4.5	4.55	4.6		
V _{IT} _	Undervoltage input	TL7770-12 (12-V sense, 1VSU)		10.8	10.9	11.02		
	threshold at VSU	TL7770-15 (15-V sense, 1VSU)	T _A = 25°C	13.5	13.64	13.77	V.	
	(negative-going)	TL7770-5, TL7770-12, TL7770-15 (programmable sense, 2VSU)		1.485	1.5	1.515		
		TL7770-5 (5-V sense, 1VSU)	T _A = 25°C		15			
		TL7770-12 (12-V sense, 1VSU)		36				
V_{hys}	Hysteresis at VSU (V _{IT+} – V _{IT} –)	TL7770-15 (15-V sense, 1VSU)			45		mV	
-	(VII+ VII-)	TL7770-5, TL7770-12, TL7770-15 (programmable sense, 2VSU)	÷		5			
VT	Overvoltage threshold at VSO	TL7770-5, TL7770-12, TL7770-15 (VSO)	T _A = 25°C	2.53	2.58	2.63	V	
l _l	Input current	VSO	V _I = 2.4 V		0.5		μА	

[†] Typical values are at V_{CC} = 5 V, T_A = 25°C.

total device

	PARAMETER	TEST CONDITIONS			TL7770-5Y, TL7770-12Y TL7770-15Y		
			MIN	TYP	MAX		
V _{res} ‡ Power-up reset voltage V _{CC}		VCC	V _{OL} = 0.4 V, I _{OL} = 1 mA		0.8		V
lcc	Supply current	1VSU = 18 V, 2VSU = 2 V, 1RESIN and 2RESIN at V _{CC} , 1VSO and 2VSO at 0 V	T _A = 25°C			5	mA

[†] Typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

switching characteristics, $V_{CC} = 5 \text{ V}$, CT open, $T_A = 25^{\circ}\text{C}$

	PARAMETER		TO (OUTPUT)	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
^t PLH	Propagation delay time, low-to-high-level output	RESIN	RESET		-	270	500*	ns
^t PHL	Propagation delay time, high-to-low-level output	RESIN	RESET			270	500*	ns
t _r	Rise time		DECET	See Figure 1			75*	
tf	Fall time		RESET	Gee rigule r		150		ns
t _r	Rise time		DECET		100	75		
tf	Fall time		RESET				50*	ns
tw(min)		RESIN	RESIN Se			150		
	Minimum effective pulse duration	VSU		See Figure 2(b)		100		ns

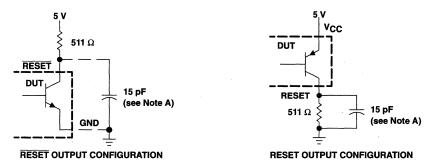
 $^{^{\}star}$ On products compliant to MIL-STD-883, Class B, this parameter is not production tested.



[‡] This the lowest voltage at which RESET becomes active.

3EV3013D - 3C10BE111387 - HEVISED 3C10B

PARAMETER MEASUREMENT INFORMATION



NOTE A: This includes jig and probe capacitance.

Figure 1. RESET and RESET Output Configurations

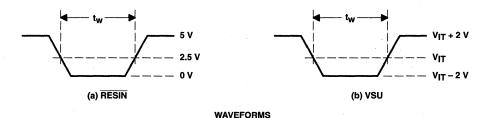
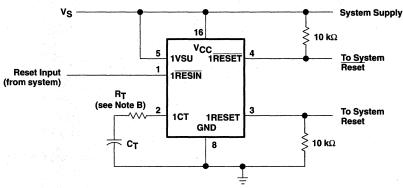


Figure 2. Input Pulse Definition

APPLICATION INFORMATION



NOTES: A. Terminal numbers shown are for the DW, J, and N packages.

B. When V_{CC} and 1VSU are connected to the same point, it is recommended that series resistance (R_T) be added between the time delay programming capacitor (C_T) and the voltage supervisor device terminal (1CT). The suggested R_T values is given by:

$$R_T > \frac{V_I - V_{IT-}}{1 \times 10^{-3}}$$
 , where V_I = (the lesser of 7.1 V or V_S)

When this series resistor is used, the t_d calculation is as follows:

$$t_{d} \ = \ \frac{1.3 - \left[\left((6.5\text{E--}5) \times 10^{-5}\right) \times R_{T}\right]}{6.5 \times 10^{-5}} \times C_{T}$$

Figure 3. System Reset Controller With Undervoltage Sensing

TLC7705, TLC7705Y MICROPOWER SUPPLY VOLTAGE SUPERVISORS

CONTROL [

RESIN I 2

GND Π 4

СТ П

3

D OR P PACKAGE (TOP VIEW)

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7 SENSE

6 TRESET

5 NRESET

- Power-On Reset Generator
- Automatic Reset Generation After Voltage Drop
- Precision Voltage Sensor of 1.5% Maximum Accuracy, Compensated Over Full Temperature Range
- Programmable Delay Time By External Capacitor
- Minimum Supply Voltage of 2 V
- Defined RESET Output from V_{DD} ≥1 V
- Power-Down Control Support for Static RAM With Battery Backup
- Maximum Supply Current of 25 μA
- Power Saving Totem-Pole Outputs

description

The TLC7705 is a micropower supply voltage supervisor designed for reset control, primarily in microcomputer and microprocessor systems.

During power-on, $\overline{\text{RESET}}$ is asserted when V_{DD} reaches 1 V. After minimum V_{DD} is established, the circuit monitors SENSE voltage and keeps the reset outputs active as long as SENSE voltage ($V_{I(SENSE)}$) remains below the threshold voltage. An internal timer delays return of the output to the inactive state to ensure proper system reset. The delay time, t_{cl} , is determined by an external capacitor:

$$t_d = 21 \times C_T$$

where

 C_T is in μf t_d is in ms

The TLC7705 has a fixed SENSE threshold voltage set by an internal voltage divider. When SENSE voltage drops below the threshold voltage, the outputs become active and stay in that state until SENSE voltage returns to above threshold voltage.

The TLC7705 is a low-power enhancement of the TL7705A. When CONTROL is tied to GND, RESET will act as active high. The voltage monitor contains additional logic intended for control of static memories with battery backup during power failure. By driving the chip select (\overline{CS}) of the memory circuit with the RESET output of the TLC7705 and with the CONTROL driven by the memory bank select signal ($\overline{CSH1}$) of the microprocessor (see Figure 4), the memory circuit is automatically disabled during a power loss. (In this application the TLC7705 power has to be supplied by the battery.)

The TLC7705 is characterized for operation over a temperature range of -40°C to 85°C.

AVAILABLE OPTIONS

TA	THRESHOLD	PACKAGED I	DEVICES	CHIP FORM
	VOLTAGE	SMALL OUTLINE (D)	PLASTIC DIP (P)	(Y)
-40°C to 85°C	4.55 V	TLC7705ID	TLC7705IP	TLC7705Y

The D package is available taped and reeled. Add the suffix R to the device type (e.g., TLC7705IDR). The chip form is tested at 25°C.



TLC7705, TLC7705Y MICROPOWER SUPPLY VOLTAGE SUPERVISORS

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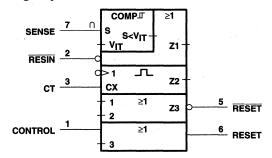
FUNCTION TABLE							
CONTROL	RESIN	VI(SENSE) >VIT+	RESET	RESET			
L	L	False	Н	L			
L	L.	True	н	L			
L.	Н	False	Н	L			
L	Н	True	L†	нt			
H	L	False	Н	L			
н	L	True	Н	L			

False

True

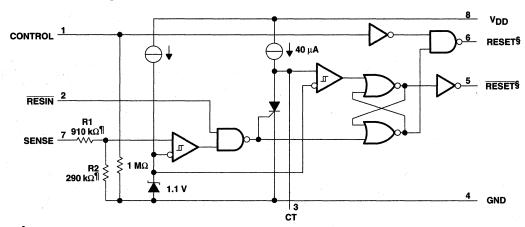
† RESET and RESET states shown are valid for t > td.

logic symbol‡



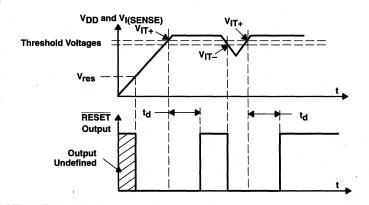
[‡] This symbol is in accordance with ANSI/IEEE Std 91–1984 and IEC Publication 617-12.

functional block diagram



н

timing diagram



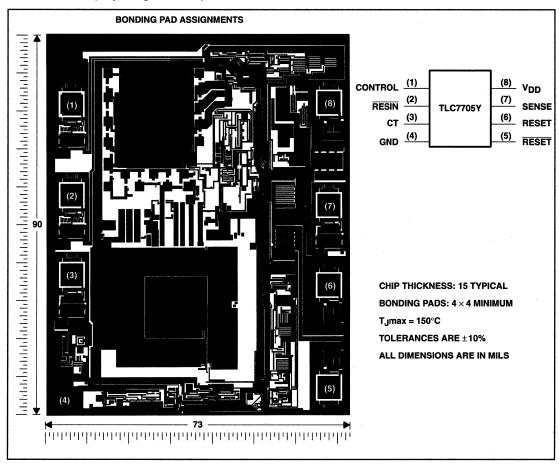
[§] Outputs are totem-pole configuration. External pullup or pulldown resistors are not required.

[¶] Nominal value

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TLC7705Y chip information

This chip, when properly assembled, displays characteristics similar to the TLC7705. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



TLC7705, TLC7705Y MICROPOWER SUPPLY VOLTAGE SUPERVISORS

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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage, V _{DD} (see Note 1)	7 V
Input voltage range (see Note 1)	
Maximum low output current, I _{OL}	10 mA
Maximum high output current, IOH	–10 mA
Input clamp current, I _{IK} (V _I < 0 or V _I > V _{DD})	±10 mA
Output clamp current, I _{OK} (V _O < 0 or V _O > V _{DD})	±10 mA
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range, T _A	40°C to 85°C
Storage temperature range, T _{stq}	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to GND.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 85°C POWER RATING
D	725 mW	5.8 mW/°C	377 mW
P	1000 mW	8.0 mW/°C	520 mW

recommended operating conditions at specified temperature range

	- 1. (1. (1. (1. (1. (1. (1. (1. (1. (1.	MIN	MAX	UNIT	
Supply voltage, V _{DD}		2	6	٧	
Timing capacitor, C _t (see Note 2)			100	μF	
Input voltage, V _I		0	6	٧	
	V _{DD} = 2 V	1.7			
High-level input voltage at RESIN and CONTROL‡, VIH	V _{DD} = 2.7 V	1.8		٧	
	V _{DD} = 4.5 V	2			
	V _{DD} = 2 V		0.3		
Low-level input voltage at RESIN and CONTROL‡, VIL	V _{DD} = 2 V 1.7 V _{DD} = 2.7 V 1.8 V _{DD} = 4.5 V 2 V _{DD} = 2.7 V 0. V _{DD} = 2.7 V 0. V _{DD} = 2.7 V 0. V _{DD} = 4.5 V 0. V _{DD} = 4.5 V 0. V _{DD} = 4.5 V 0. V _{DD} = 4.5 V 0. V _{DD} = 4.5 V 0. V _{DD} = 4.5 V 0. V _{DD} = 2.7 V 0. V _{DD} =	0.4	V		
	V _{DD} = 4.5 V		0.8		
ligh-level output current, IOH	V _{DD} = 2.7 V		-2.5	· · · · ·	
High-level output current, 10H	V _{DD} = 2.7 V V _{DD} = 4.5 V		-3	mA	
Lour lough output ausent Lou	V _{DD} = 2.7 V		2.5	mA	
Low-level output current, IOL	2 VDD = 2 V 1.7 VDD = 2.7 V 1.8 VDD = 4.5 V 2 VDD = 2.7 V VDD = 2.7 V VDD = 2.7 V VDD = 4.5 V VDD = 2.7 V VDD = 4.5 V 20 20 2	3	mA		
High-level input pulse duration at SENSE		20			
Low-level input pulse duration at SENSE		2			
High-level input pulse duration at RESIN		20		μs	
Low-level input pulse duration at RESIN		2			
Input transition rise and fall rate at RESIN and CONTROL, Δt/ΔV			100	ns/V	
Operating free-air temperature range, TA		-40	85	°C	
To operate a low supply current Viv. should be kent <0.3 V and Viv. > Von = 0.3 V				L	

 $[\]ddagger$ To ensure a low supply current, V_{IL} should be kept <0.3 V and V_{IH} > V_{DD} -0.3 V.

NOTE 2: Limited by the leakage current of the capacitor



TLC7705, TLC7705Y MICROPOWER SUPPLY VOLTAGE SUPERVISORS

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electrical characteristics over recommended operating conditions (see Note 3) (unless otherwise noted)

	PARAMETER		TEST COMPITIONS		TLC7705I		UNIT	
	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNII	
			V _{DD} = 2 V	1.8				
V	Ligh level eviteratively	I _{OH} = -20 μA	V _{DD} = 2.7 V	2.5			v	
VOH	High-level output voltage		V _{DD} = 4.5 V	4.3			V	
		I _{OH} = -3 mA	V _{DD} = 4.5 V	3.7				
	V _{OL} Low-level output voltage		V _{DD} = 2 V			0.1		
V		I _{OL} = 20 μA	V _{DD} = 2.7 V			0.1	V	
VOL			V _{DD} = 4.5 V			0.1	V	
		I _{OL} = 3 mA	V _{DD} = 4.5 V			0.4		
V _{IT} _	Negative-going input threshold (see Note 4)	l voltage, SENSE	V _{DD} = 2 V to 6 V	4.48	4.55	4.62	٧	
V _{hys}	Hysteresis, SENSE		V _{DD} = 2 V to 6 V		40		mV	
V _{res}	Power-up reset voltage‡		I _{OL} = 20 μA			1	V	
		RESIN	V _I = 0 V to V _{DD}	-1		1		
l _l	Input current	CONTROL	$V_I = V_{DD}$		5	10	μΑ	
		SENSE	V _I = 5 V		4	8		
	Supply current	T _A = -40°C to 85°C	RESIN = V _{DD} ,		9	25		
IDD		T _A = 0°C to 70°C	SENSE = $V_{DD} > V_{IT+}$, . CONTROL = 0 V, Outputs open		9	20	μА	
I _{DD(d)}	Supply current during t _d),	120	150	μА	
CI	Input capacitance, SENSE		V _I = 0 V to V _{DD}		50		pF	

[†] Typical values apply at T_A = 25°C. ‡The lowest supply voltage at which RESET becomes active. The symbol V_{res} is not currently listed within EIA or JEDEC standards for semiconductor symbology.

 $[\]$ V/T+ = V/T- + Vhys NOTES: 3. All characteristics are measured with CT = 0.1 μF .

^{4.} To ensure best stability of the threshold voltage, a bypass capacitor (ceramic, 0.1 µF) should be placed near the supply terminals.

TLC7705, TLC7705Y MICROPOWER SUPPLY VOLTAGE SUPERVISORS

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electrical characteristics over recommended operating conditions, $T_A = 25$ °C, $C_T = 0.1 \mu F$ (unless otherwise noted)

	PARAMETER		TEST COMPITIONS	T	TLC7705Y		
			TEST CONDITIONS	MIN	TYP	MAX	UNIT
V _{IT} -	Negative-going input threshold voltage, SENSE (see Note 4)		V _{DD} = 2 V to 6 V		4.55		٧
V _{hys}	Hysteresis, SENSE		V _{DD} = 2 V to 6 V		40		mV
	Andreas Andreas Andreas Andreas Andreas Andreas Andreas Andreas Andreas Andreas Andreas Andreas Andreas Andreas	CONTROL	$V_I = V_{DD}$		5		
'1	I _I Input current	SENSE	V _I = 5 V		4		μΑ
DD	Supply current		RESIN = V _{DD} , SENSE = V _{DD} > V _{IT+} †, CONTROL = 0 V, Outputs open		9		μА
I _{DD(d)}	Supply current during t _d		VDD = 5 V, VCT = 0 V, RESIN = VDD, SENSE = VDD, CONTROL = 0 V, Outputs open		120		μΑ
CI	Input capacitance, SENSE		V _I = 0 V to V _{DD}		50		pF

TV_{IT+} = V_{IT+} + V_{hys}
NOTE 4 To ensure best stability of the threshold voltage, a bypass capacitor (ceramic, 0.1 μF) should be placed near the supply terminals.

switching characteristics at V_{DD} = 5 V, R_L = 500 Ω , C_L = 50 pF, T_A = 25°C

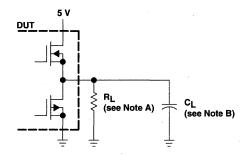
		MEASUR	ED		TLC7705I, TLC7705Y		7705Y		
	PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
^t d	Delay time	VI(SENSE) ≥ VIT+	RESET and RESET	RESIN = 2.7 V, CONTROL = 0.4 V, C _T = 100 nF, See timing diagram	1.5	2.1	3.5	ms	
^t PLH	Propagation delay time, low-to-high-level output	en en en en en en en en en en en en en e	DECET				20		
^t PHL	Propagation delay time, high-to-low-level output	SENSE	V R	V _{IH} = V _{IT+} max + 0.2 V, V _{IL} = V _{IT} min - 0.2 V,			2		
^t PLH	Propagation delay time, low-to-high-level output	SENSE		RESIN = 2.7 V, CONTROL = 0.4 V, CT = NC [†]				2	μs
tPHL	Propagation delay time, high-to-low-level output						20		
^t PLH	Propagation delay time, low-to-high-level output		DECET				20	μs	
^t PHL	Propagation delay time, high-to-low-level output	DEOIN	RESET	V _{IH} = 2.7 V, V _{IL} = 0.4 V,			35		
^t PLH	Propagation delay time, low-to-high-level output	RESIN	RESET	SENSE = V _{IT+} max + 0.2 V, CONTROL = 0.4 V, CT = NC [†]	,		45	ns	
tPHL	Propagation delay time, high-to-low-level output		HESEI				20	μs	
tPLH	Propagation delay time, low-to-high-level output	CONTROL	DECET	V _{IH} = 2.7 V, V _{IL} = 0.4 V,			30		
tPHL	Propagation delay time, high-to-low-level output	CONTROL	RESET	$\begin{array}{ll} \text{SENSE} = \text{V}_{\text{IT+}}\text{max} + 0.2 \text{ V}, \\ \hline \text{RESIN} = 2.7 \text{ V}, & \text{CT} = \text{NC}^{\dagger} \end{array}$			35	ns	
t _r	Rise time		RESET	10% to 90%		8		201	
tf	Fall time		and RESET	90% to 10%	4			ns/V	

[†] NC equals no capacitor and includes up to 100-pF probe and jig capacitance.



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PARAMETER MEASUREMENT INFORMATION



NOTES: A. For switching characteristics, R_L = 500Ω . B. C_L = 50 pF includes jig and probe capacitance.

Figure 1. RESET AND RESET Output Configurations

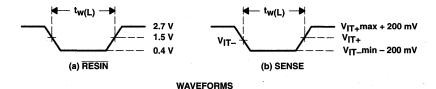


Figure 2. Input Pulse Definition

APPLICATION INFORMATION

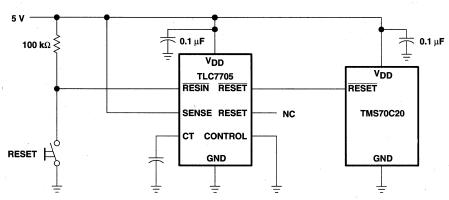


Figure 3. Reset Controller in a Microcomputer System

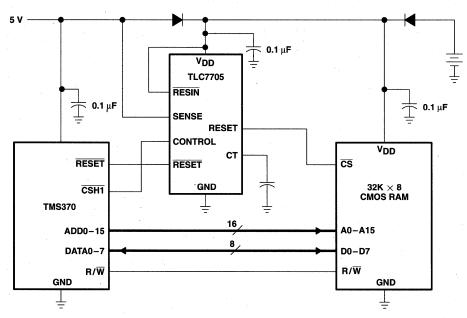


Figure 4. Data Retention During Power Down Using Static CMOS RAMs

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- Low $r_{DS(on)} \dots 0.18 \Omega$ Typ at $V_{GS} = -10 \text{ V}$
- 3 V Compatible
- Requires No External V_{CC}
- TTL and CMOS Compatible Inputs
- V_{GS(th)} = −1.5 V Max
- Available in Ultrathin TSSOP Package (PW)
- ESD Protection Up to 2 kV Per MIL-STD-883C, Method 3015

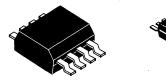
description

The TPS1100 is single P-channel enhancement-mode MOSFET. The device has been optimized for 3-V or 5-V power distribution in battery-powered systems by means of Texas Instruments LinBiCMOS™ process. With a maximum VGS(th) of -1.5 V and an IDSS of only 0.5 μA, the TPS1100 is the ideal high-side switch for low-voltage, portable battery-management systems where maximizing battery life is a primary concern. The low rDS(on) and excellent ac characteristics (rise time 10 ns typical) make the TPS1100 the logical choice for low-voltage switching applications such as power switches for pulse-width-modulated (PWM) controllers or motor/bridge drivers.

The ultrathin thin shrink small-outline package or TSSOP (PW) version with its smaller footprint and reduction in height fits in places where other P-channel MOSFETs cannot. The size advantage is especially important where board real estate is at a premium and height restrictions do not allow for an small-outline integrated circuit (SOIC) package.

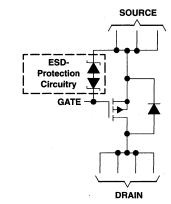
SOURCE 1 8 DRAIN SOURCE 2 7 DRAIN SOURCE 3 6 DRAIN GATE 4 5 DRAIN D PACKAGE PW PACKAGE

D OR PW PACKAGE





schematic



NOTE A. For all applications, all source pins should be connected and all drain pins should be connected.

AVAILABLE OPTIONS

	PACKAGED	PACKAGED DEVICES		
TA	SMALL OUTLINE (D)	PLASTIC DIP (P)	CHIP FORM (Y)	
-40°C to 85°C	TPS1100D	TPS1100PWLE	TPS1100Y	

The D package is available taped and reeled. Add an R suffix to device type (e.g., TPS1100DR). The PW package is available only left-end taped and reeled (indicated by the LE suffix on the device type; e.g., TPS1100PWLE). The chip form is tested at 25°C.



Caution. This device contains circuits to protect its inputs and outputs against damage due to high static voltages or electrostatic fields. These circuits have been qualified to protect this device against electrostatic discharges (ESD) of up to 2 kV according to MIL-STD-883C, Method 3015; however, it is advised that precautions be taken to avoid application of any voltage higher than maximum-rated voltages to these high-impedance circuits.

LinBiCMOS is a trademark of Texas Instruments Incorporated.

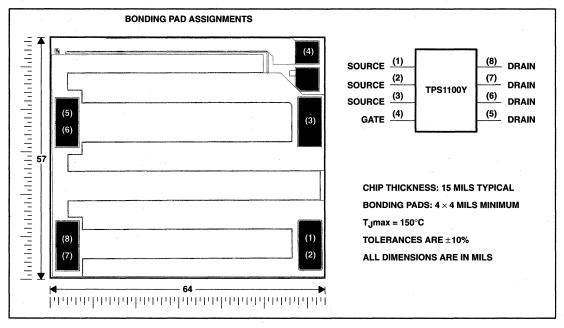
TEXAS INSTRUMENTS SLVS078C - DECEMBER 1993 - REVISED AUGUST 1995

description (continued)

Such applications include notebook computers, personal digital assistants (PDAs), cellular telephones, and PCMCIA cards. For existing designs, the D-packaged version has a pinout common with other p-channel MOSFETs in SOIC packages.

TPS1100Y chip information

This chip, when properly assembled, displays characteristics similar to the TPS1100. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

					UNIT
Drain-to-source voltage, V _{DS}				-15	٧
Gate-to-source voltage, VGS				2 or –15	V
		Dinaskaga	T _A = 25°C	±0.41	
•	V 07V	D package	T _A = 125°C	±0.28	
	VGS = -2.7 V	DW poolsome	T _A = 25°C	±0.4	
		Pw package	T _A = 125°C	±0.23	
		Dipackage	T _A = 25°C	±0.6	
	Van - 2 V	D package	T _A = 125°C	±0.33	
	V _{GS} = −3 V	-15 V 2 or -15 V 2 or -15 V 10 package TA = 25°C ±0.41 TA = 125°C ±0.28 TA = 125°C ±0.4 TA = 125°C ±0.4 TA = 125°C ±0.6 TA = 125°C ±0.6 TA = 125°C ±0.6 TA = 125°C ±0.6 TA = 125°C ±0.6 TA = 125°C ±0.7	T _A = 25°C	±0.53	
Continuous drain current (T. – 150°C) In±					
Continuous drain current (1) = 150 °C), 10+			^		
ontinuous drain current (T _J = 150°C), I _D ‡	Van - 45V		T _A = 125°C	±0.47	
	VGS = -4.5 V	PW pockage	T _A = 25°C	±0.81	
		F W package	T _A = 125°C	±0.37	
		Dipackaga	T _A = 25°C	±1.6	
	V _{GS} = -10 V	D package	T _A = 125°C	±0.72	
· .	VGS = -10 V	PW package	T _A = 25°C	±1.27	
		I W package	T _A = 125°C	±0.58	
Pulsed drain current, ID [‡]			T _A = 25°C	±7	· A
Continuous source current (diode conduction), IS			T _A = 25°C	-1	Α
Storage temperature range, T _{stg}					°C
Operating junction temperature range, TJ				-40 to 150	°C
Operating free-air temperature range, TA				-40 to 125	°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 second	ds			260	°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR‡ ABOVE TA = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	791 mW	6.33 mW/°C	506 mW	411 mW	158 mW
PW	504 mW	4.03 mW/°C	323 mW	262 mW	101 mW

[‡] Maximum values are calculated using a derating factor based on R_{BJA} = 158°C/W for the D package and R_{BJA} = 248°C/W for the PW package. These devices are mounted on an FR4 board with no special thermal considerations when tested.



[‡] Maximum values are calculated using a derating factor based on R_{0JA} = 158°C/W for the D package and R_{0JA} = 248°C/W for the PW package. These devices are mounted on an FR4 board with no special thermal considerations.

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electrical characteristics at T_J = 25°C (unless otherwise noted)

static

	DADAMETED		T CONDITION	ic		TPS1100)	Т	PS1100\	′	UNIT														
	PARAMETER	163	TEST CONDITIONS		MIN	TYP	MAX	MIN	TYP	MAX	UNII														
V _{GS(th)}	Gate-to-source threshold voltage	V _{DS} = V _{GS} ,	I _D = -250 μA		-1	-1.25	-1.50		-1.25		٧														
V _{SD}	Source-to-drain voltage (diode- forward voltage)†	I _S = -1 A,	V _{GS} = 0 V			-0.9			-0.9		٧														
IGSS	Reverse gate current, drain short circuited to source	V _{DS} = 0 V,	V _{GS} = -12 V	,			±100				nA														
Inco	Zero-gate-voltage	V _{DS} = -12 V,	Voc = 0.V	T _J = 25°C			-0.5				μА														
IDSS	drain current	VDS = -12 V,	vGS = 0 V	vGS = 0 v	vGS = 0 V	VGS = U V	vGS = 0 v	VGS = U V	VGS = U V	vGS = 0 V	VGS = U V	vGS = 0 v	vGS = 0 v	VGS = U V	vGS = 0 v	VGS = 0 V	VGS - UV	T _J = 125°C			-10				μΛ
		V _{GS} = -10 V	$I_D = -1.5 A$			180			180																
	Static drain-to-source	V _{GS} = -4.5 V	$I_D = -0.5 A$			291	400		291		mΩ														
rDS(on)	on-state resistance†	V _{GS} = -3 V	/			476	700		476		1115.2														
İ		$V_{GS} = -2.7 \text{ V}$	$I_D = -0.2 A$			606	850		606	,															
9fs	Forward transconductance†	V _{DS} = -10 V,	I _D = -2 A			2.5			2.5	·	s														

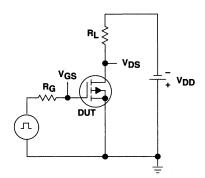
[†] Pulse test: pulse duration ≤ 300 μs, duty cycle ≤ 2%

dynamic

	PARAMETER		TEST CONDITIONS		TPS1100, TPS1100Y			UNIT
ł			TEST CONDITIONS			TYP	MAX	ONII
Q_g	Total gate charge					5.45		
Qgs	Gate-to-source charge	$V_{DS} = -10 \text{ V},$	$V_{GS} = -10 V_{s}$	I _D = -1 A		0.87		nC
Q _{gd}	Gate-to-drain charge					1.4		
t _{d(on)}	Turn-on delay time					4.5		ns
td(off)	Turn-off delay time	$V_{DD} = -10 \text{ V},$	$R_1 = 10 \Omega$	$I_D = -1 A$,		13		ns
tr	Rise time	$R_G = 6 \Omega$,	See Figures 1 and 2			10		
tf	Fall time					2		ns
trr(SD)	Source-to-drain reverse recovery time	I= = 5.3 A,	di/dt = 100 A/μs			16		

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PARAMETER MEASUREMENT INFORMATION



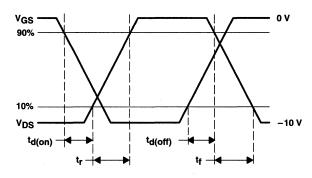


Figure 1. Switching-Time Test Circuit

Figure 2. Switching-Time Waveforms

TYPICAL CHARACTERISTICS

Table of Graphs

		FIGURE
Drain current	vs Drain-to-source voltage	3
Drain current	vs Gate-to-source voltage	4
Static drain-to-source on-state resistance	vs Drain current	5
Capacitance	vs Drain-to-source voltage	6
Static drain-to-source on-state resistance (normalized)	vs Junction temperature	7
Source-to-drain diode current	vs Source-to-drain voltage	8
Static drain-to-source on-state resistance	vs Gate-to-source voltage	9
Gate-to-source threshold voltage	vs Junction temperature	10
Gate-to-source voltage	vs Gate charge	11 .

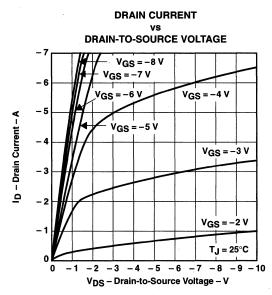
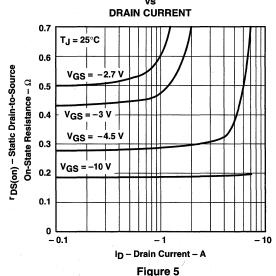


Figure 3

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE



DRAIN CURRENT

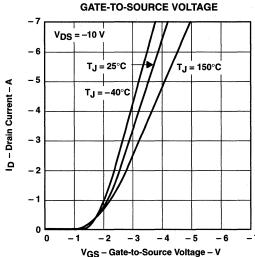
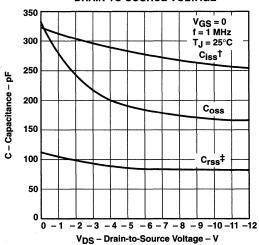


Figure 4

CAPACITANCE vs **DRAIN-TO-SOURCE VOLTAGE**



$$\begin{array}{l} \dagger \ C_{iss} \ = \ C_{gs} + C_{gd}, \ C_{ds(shorted)} \\ \\ \ddagger \ C_{rss} \ = \ C_{gd}, \ C_{oss} \ = \ C_{ds} + \frac{C_{gs} \ C_{gd}}{C_{gs} + C_{gd}} \approx C_{ds} + C_{gd} \end{array}$$

Figure 6

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE (NORMALIZED)

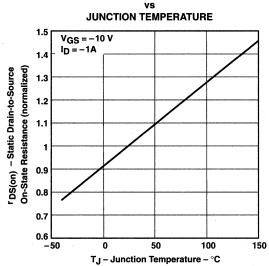


Figure 7

SOURCE-TO-DRAIN DIODE CURRENT



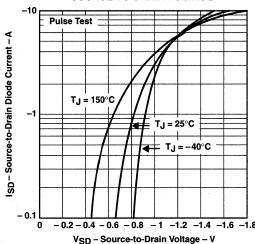


Figure 8

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

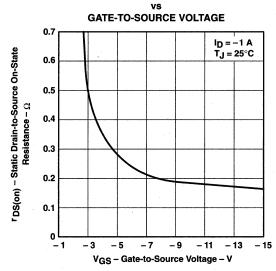


Figure 9

GATE-TO-SOURCE THRESHOLD VOLTAGE

JUNCTION TEMPERATURE

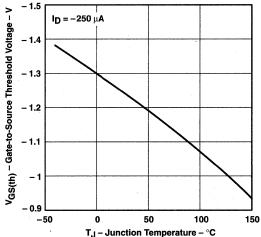


Figure 10

GATE-TO-SOURCE VOLTAGE

vs GATE CHARGE

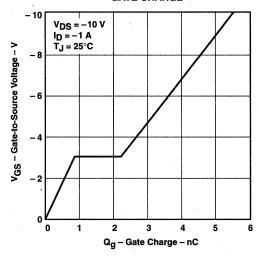


Figure 11

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TRANSIENT JUNCTION-TO-AMBIENT

THERMAL INFORMATION

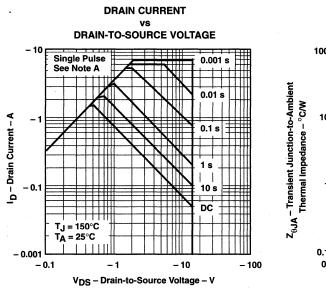


Figure 12

NOTE A. Values are for the D package and are FR4-board mounted only.

Figure 13

APPLICATION INFORMATION

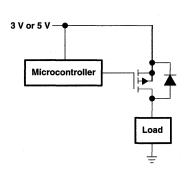


Figure 14. Notebook Load Management

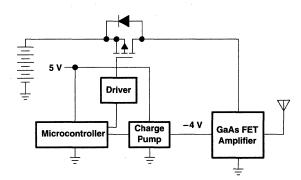


Figure 15. Cellular Phone Output Drive

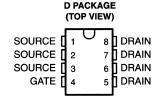
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- Low r_{DS(on)} ... 0.09 Ω Typ at V_{GS} = -10 V
- 3 V Compatible
- Requires No External V_{CC}
- TTL and CMOS Compatible Inputs
- V_{GS(th)} = −1.5 V Max
- Available in Ultrathin TSSOP Package (PW)
- ESD Protection Up to 2 kV per MIL-STD-883C, Method 3015

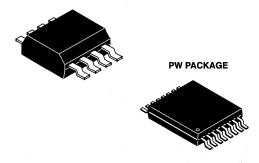
description

The TPS1101 is a single, low-r_{DS(on)}, P-channel, enhancement-mode MOSFET. The device has been optimized for 3-V or 5-V power distribution in battery-powered systems by means of the Texas Instruments LinBiCMOSTM process. With a maximum V_{GS(th)} of -1.5 V and an I_{DSS} of only 0.5 μA , the TPS1101 is the ideal high-side switch for low-voltage, portable battery-management systems where maximizing battery life is a primary concern. The low r_{DS(on)} and excellent ac characteristics (rise time 5.5 ns typical) of the TPS1101 make it the logical choice for low-voltage switching applications such as power switches for pulse-width-modulated (PWM) controllers or motor/bridge drivers.

The ultrathin thin shrink small-outline package or TSSOP (PW) version fits in height-restricted places where other P-channel MOSFETs cannot. The size advantage is especially important where board height restrictions do not allow for an small-outline integrated circuit (SOIC) package. Such applications include notebook computers, personal digital assistants (PDAs), cellular



D PACKAGE



PW PACKAGE (TOP VIEW)

NC □	10	16	□ NC
SOURCE I	2	15	DRAIN
SOURCE 🗆	∃ 3	14	DRAIN
SOURCE 🗆	4	13	DRAIN
SOURCE I	5	12	DRAIN
SOURCE I	4 6 ,	11	DRAIN
GATE 🗀	1 7	10	DRAIN
NC 🎞	8	9	□□ NC

NC - No internal connection

telephones, and PCMCIA cards. For existing designs, the D-packaged version has a pinout common with other P-channel MOSFETs in SOIC packages.

AVAILABLE OPTIONS

	PACKAGED	DEVICES†	CHID FORM
TJ	SMALL OUTLINE (D)	TSSOP (PW)	CHIP FORM (Y)
-40°C to 150°C	TPS1101D	TPS1101PWLE	TPS1101Y

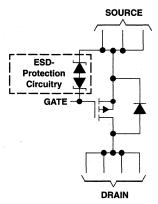
[†]The D package is available taped and reeled. Add an R suffix to device type (e.g., TPS1101DR). The PW package is only available left-end taped and reeled (indicated by the LE suffix on the device type; e.g., TPS1101PWLE). The chip form is tested at 25°C.

LinBiCMOS is a trademark of Texas Instruments Incorporated.

TEXAS INSTRUMENTS

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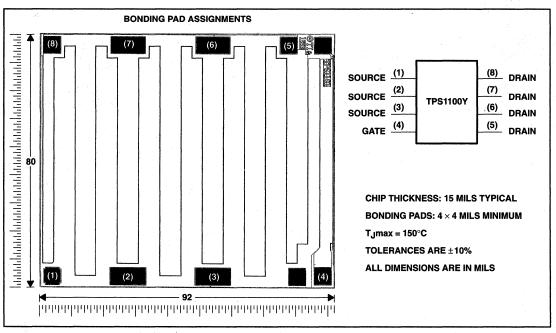
schematic



NOTE A. For all applications, all source terminals should be connected and all drain terminals should be connected.

TPS1101Y chip information

This chip, when properly assembled, displays characteristics similar to the TPS1101. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

					UNIT
Drain-to-source voltage, V _{DS}				– 15	٧
Gate-to-source voltage, VGS	2 or – 15	٧			
		D package	T _A = 25°C	±0.62	
	\\\ 0.7\\	D package	T _A = 125°C	±0.39	
	V _{GS} = -2.7 V	PW package	T _A = 25°C	±0.61	
		FW package	T _A = 125°C	±0.38	
		D package	T _A = 25°C	±0.88	
	V _{GS} = -3 V	D package	T _A = 125°C	±0.47	
		PW package	T _A = 25°C	±0.86	
Continuous drain current (T,J = 150°C), ID [‡]		FW package	T _A = 125°C	±0.45	_
Continuous drain current (1) = 150 C), 1D+	V _{GS} = -4.5 V	D package	T _A = 25°C	±1.52	Α
		D package	T _A = 125°C	±0.71	
		PW package	T _A = 25°C	±1.44	
		T VV package	T _A = 125°C	±0.67	
		D package	T _A = 25°C	±2.30	
	Van - 10 V	D package	T _A = 125°C	±1.04	
	$V_{GS} = -10 \text{ V}$	PW package	T _A = 25°C	±2.18	
		FW package	T _A = 125°C	±0.98	-
Pulsed drain current, ID [‡]			T _A = 25°C	±10	Α
Continuous source current (diode conduction), IS	5°		T _A = 25°C	-1.1	Α
Storage temperature range, T _{Stg}	-55 to 150	°C			
Operating junction temperature range, T _J	-40 to 150	°C			
Operating free-air temperature range, T _A					
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds				260	°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR [‡] ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	791 mW	6.33 mW/°C	506 mW	411 mW	158 mW
PW	710 mW	5.68 mW/°C	454 mW	369 mW	142 mW

[‡] Maximum values are calculated using a derating factor based on R_{BJA} = 158°C/W for the D package and R_{BJA} = 176°C/W for the PW package. These devices are mounted on an FR4 board with no special thermal considerations.



[‡] Maximum values are calculated using a derating factor based on R_{0JA} = 158°C/W for the D package and R_{0JA} = 176°C/W for the PW package. These devices are mounted on an FR4 board with no special thermal considerations.

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electrical characteristics at T_J = 25°C (unless otherwise noted)

static

						TPS1101		TPS1101Y																							
	PARAMETER	TES	TEST CONDITIONS		MIN	TYP	MAX	MIN	TYP	MAX	UNIT																				
V _{GS(th)}	Gate-to-source threshold voltage	V _{DS} = V _{GS} ,	I _D = -250 μA		-1	-1.25	-1.5		-1.25		٧																				
V _{SD}	Source-to-drain voltage (diode-for- ward voltage) [†]	IS = -1 A,	V _{GS} = 0 V			-1.04			-1.04		٧																				
IGSS	Reverse gate current, drain short circuited to source	V _{DS} = 0 V,	V _{GS} = -12 V				±100				nA																				
1	Zero-gate-voltage	V _{DS} = -12 V,	V 0V	T _J = 25°C			-0.5																								
DSS	drain current	VDS = -12 V,	vGS = 0 v	vGS = 0 v	vGS = 0 V	vGS = 0 V	vGS = 0 v	VGS = 0 V	VGS = 0 V	VGS = 0 V	VGS = 0 V	VGS = U V	VGS = 0 V	vgs = u v	vgs = u v	vgs = u v	VGS = U V	VGS = 0 V	VGS = 0 V	VGS - V V	VGS - 0 V	vGS = 0 v	VGS = 0 V	T _J = 125°C			-10				μA
		V _{GS} = -10 V	$I_D = -2.5 A$			90		-	90																						
	Static drain-to-source	V _{GS} = -4.5 V	$I_D = -1.5 A$			134	190		134																						
rDS(on)	on-state resistance†	V _{GS} = -3 V	. 054			198	310		198		mΩ																				
		$V_{GS} = -3 \text{ V}$ $V_{GS} = -2.7 \text{ V}$	ID = -0.5 A			232	400		232																						
9fs	Forward transconductance†	$V_{DS} = -10 \text{ V},$	I _D = -2 A			4.3			4.3		s																				

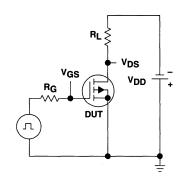
[†] Pulse test: pulse duration ≤ 300 μs, duty cycle ≤ 2%

dynamic

	PARAMETER		TEST CONDITIONS		TPS1101, TPS1101Y		1101Y	UNIT	
	PARAMETER		TEST CONDITIONS		MIN TYP MAX			UNIT	
Qg .	Total gate charge		÷.			11.25			
Qgs	Gate-to-source charge	$V_{DS} = -10 \text{ V},$	$V_{GS} = -10 \text{ V},$	$I_D = -1$ A		1.5		nC	
Q _{gd}	Gate-to-drain charge]				2.6			
td(on)	Turn-on delay time				-	6.5		ns	
^t d(off)	Turn-off delay time	$V_{DD} = -10 \text{ V},$	$R_{I} = 10 \Omega$	I _D = -1 A,	4.	19		ns	
t _r	Rise time	$R_G = 6 \Omega$	See Figures 1 and 2			5.5			
tf	Fall time	1				13		ns	
trr(SD)	Source-to-drain reverse recovery time	I _F = 5.3 A,	di/dt = 100 A/μs			16			

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PARAMETER MEASUREMENT INFORMATION



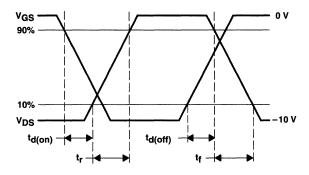


Figure 1. Switching-Time Test Circuit

Figure 2. Switching-Time Waveforms

TYPICAL CHARACTERISTICS

Table of Graphs

		FIGURE
Drain current	vs Drain-to-source voltage	3
Drain current	vs Gate-to-source voltage	4
Static drain-to-source on-state resistance	vs Drain current	5
Capacitance	vs Drain-to-source voltage	6
Static drain-to-source on-state resistance (normalized)	vs Junction temperature	7
Source-to-drain diode current	vs Source-to-drain voltage	8
Static drain-to-source on-state resistance	vs Gate-to-source voltage	9
Gate-to-source threshold voltage	vs Junction temperature	10
Gate-to-source voltage	vs Gate charge	11

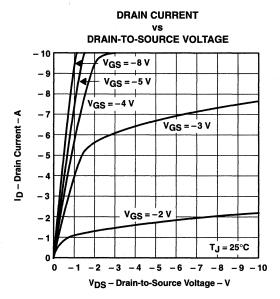


Figure 3

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

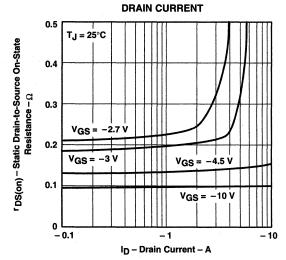


Figure 5

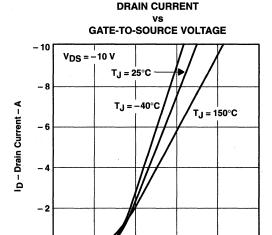


Figure 4

- 2

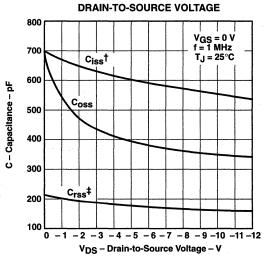
CAPACITANCE†

VGS - Gate-to-Source Voltage - V

-3

- 4

- 5



$$\dagger C_{iss} = C_{gs} + C_{gd}, C_{ds(shorted)}$$
 $C_{gs} C_{gs}$

$$\ddagger C_{rss} = C_{gd}, C_{oss} = C_{ds} + \frac{C_{gs} C_{gd}}{C_{gs} + C_{gd}} \approx C_{ds} + C_{gd}$$

Figure 6

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE (NORMALIZED)

JUNCTION TEMPERATURE 1.5 VGS = -10 V ID = -1A 1.4 On-State Resistance (normalized) DS(on) - Static Drain-to-Source 1.3 1.2 1.1 1 0.9 0.8 0.7 0.6 50 100 150 -50

Figure 7

SOURCE-TO-DRAIN DIODE CURRENT vs SOURCE-TO-DRAIN VOLTAGE

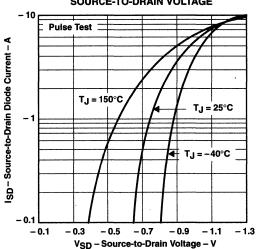


Figure 8

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

T, I - Junction Temperature - °C

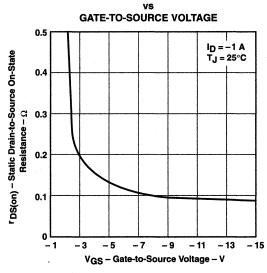


Figure 9

GATE-TO-SOURCE THRESHOLD VOLTAGE vs

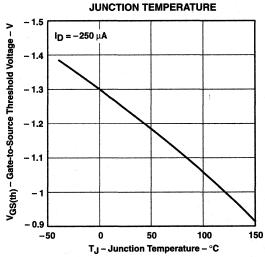


Figure 10

GATE-TO-SOURCE VOLTAGE

GATE CHARGE

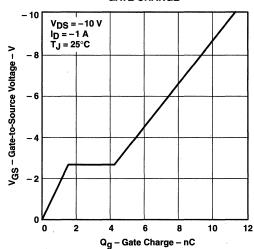


Figure 11

TRANSIENT JUNCTION-TO-AMBIENT

THERMAL INFORMATION

DRAIN CURRENT DRAIN-TO-SOURCE VOLTAGE - 100 Single Pulse See Note A - 10 0.001 s ID - Drain Current - A 0.01 s 0.1 s - 0.1 T_J = 150°C DC TA = 25°C - 0.01 - 0.1 - 10 - 100 V_{DS} - Drain-to-Source Voltage - V

Figure 12

NOTE B. Values are for the D package and are FR4-board-mounted only.

THERMAL IMPEDANCE VS PULSE DURATION 100 Single Pulse See Note A 100 0.001 0.01 0.01 10 t_w - Pulse Duration - s

Figure 13

APPLICATION INFORMATION

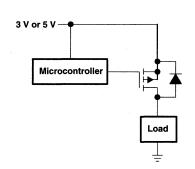


Figure 14. Notebook Load Management

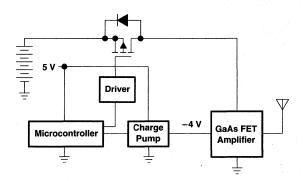
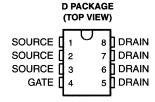


Figure 15. Cellular Phone Output Drive

TPS1110, TPS1110Y SINGLE P-CHANNEL LOGIC-LEVEL MOSFETS

SLVS100A - OCTOBER 1994 - REVISED AUGUST 1995

- Low $r_{DS(on)}$... 65 m Ω Typ at $V_{GS} = -4.5$ V
- High Current Capability
 6 A at V_{GS} = -4.5 V
- Logic-Level Gate Drive (3 V Compatible)
 V_{GS(th)} = -0.9 V Max
- Low Drain-Source Leakage Current <100 nA From 25°C to 75°C at V_{DS} = −6 V
- Fast Switching . . . 5.8 ns Typ t_{d(on)}
- Small-Outline Surface-Mount Power Package





description

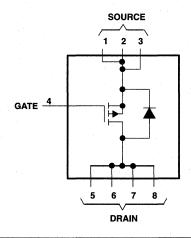
The TPS1110 is a single, $low-r_{DS(on)}$, P-channel enhancement-mode power MOS transistor. The device features extremely $low-r_{DS(on)}$ values coupled with logic-level gate-drive capability and very low drain-source leakage current. With a maximum $V_{GS(th)}$ of -0.9 V and an l_{DSS} of only -100 nA, the TPS1110 is the ideal high-side switch for low-voltage, portable battery-management power-distribution systems where maximizing battery life is an important concern. The thermal performance of the 8-pin small-outline (D) package has been greatly enhanced over the standard 8-pin SOIC, further making the TPS1110 ideally suited for many power applications. For compatibility with existing designs, the TPS1110 has a pinout common with other P-channel MOSFETs in small-outline integrated circuit (SOIC) packages. The TPS1110 is characterized for an operating junction temperature range, l_{J} , from -40° C to l_{J} C. The D package is available packaged in standard sleeves or in taped and reeled formats. When ordering the tape-and-reel format, add an R suffix to the device type number (e.g., TPS1110DR).

AVAILABLE OPTIONS

	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	
	PACKAGED DEVICET	CHIP FORM
TJ	SMALL OUTLINE (D)	(Y)
-40°C to 150°C	TPS1110D	TPS1110Y

[†] The D package is available taped and reeled. Add an R suffix to device type (e.g., TPS1110DR). The chip form is tested at 25°C.

schematic



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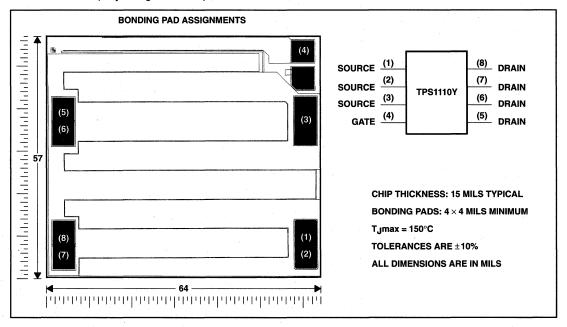
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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TPS1110Y chip information

This chip, when properly assembled, displays characteristics similar to the TPS1110C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



TPS1110, TPS1110Y SINGLE P-CHANNEL LOGIC-LEVEL MOSFETS

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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

				UNIT
Drain-to-source voltage, V _{DS}	-7	V		
Gate-to-source voltage, VGS	±7	V		
	V 0.7V	Tp = 25°C‡	-5	
Cantinuous dusis signant I	$V_{GS} = -2.7 V$	Tp = 125°C‡	-2.3	А
Continuous drain current, ID	V 45V	T _P = 25°C [‡]	-6	
	$V_{GS} = -4.5 \text{ V}$	T _P = 125°C‡	-2.7	
Pulse drain current, ID			-24	Α
Continuous source current (diode conduction), IS		T _A = 25°C	-6	Α
Continuous total power dissipation		Tp = 25°C‡	4	w
Junction-to-pin thermal resistance (θJP)	31	°C/W		
Continuous total power dissipation	T _A = 25°C	1.25	W	
Junction-to-ambient thermal resistance (θJA)		100	°C/W	
Storage temperature range, T _{Stg}			-65 to 150	°C
Operating junction temperature range, T _J				°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260	°C		

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

electrical characteristics at $T_J = 25^{\circ}C$ (unless otherwise noted)

static

PARAMETER		TEST SOMBITIONS		TPS1110			TPS1110Y			
		IEST CO	TEST CONDITIONS		TYP	MAX	MIN	TYP	MAX	UNIT
V _{GS(th)}	Gate-to-source threshold voltage	V _{DS} = V _{GS} , See Figure 9	$I_D = -250 \mu A$,	-0.5	-0.75	-0.9		-0.75		٧
V _{SD}	Source-to-drain voltage (diode forward voltage)§	I _{SD} = −3 A, See Figure 8	V _{GS} = 0 V,		-0.8			-0.8		V
IGSS	Reverse gate current, drain short circuited to source	V _{DS} = 0 V,	V _{GS} = -6 V			±100			•	nA
	Zero-gate-voltage drain current	V _{DS} = -7 V, V _{GS} = 0 V	T _J = 25°C			-100				nA
IDSS		V _{DS} = -6 V, V _{GS} = 0 V	T _J = 75°C			-100				nA
			T _J = 125°C			-10		•		μΑ
^r DS(on)	Static drain-to-source on-state resistance§	V _{GS} = -4.5 V, See Figure 5	I _D = -6 A,	Se de la constante de la const	65	75		65		0
		V _{GS} = -2.7 V, See Figure 5	I _D = −2 A,		100	110		100		mΩ
9fs	Forward transconductance§	$V_{DS} = -5 V$,	I _D = -6 A		5			5		S
Ciss	Short-circuit input capacitance, common source				275			275		
Coss	Short-circuit output capacitance, common source		V _{GS} = 0 V, See Figure 6		415			415		pF
C _{rss}	Short-circuit reverse transfer capacitance, common source				73			73		

[§] Pulse test: pulse duration ≤ 300 μs, duty cycle ≤ 2%



 $[\]ddagger$ Tp – Temperature of drain pins measured close to the package

TPS1110, TPS1110Y SINGLE P-CHANNEL LOGIC-LEVEL MOSFETS

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dynamic

PARAMETER		TEST CONDITIONS		TPS1110			TPS1110Y			UNIT
		TEST CONDITIONS			TYP	MAX	MIN	TYP	MAX	UNIT
Q_g	Total gate charge				4.3	5.4		4.3		
Qgs	Gate-to-source charge	$V_{DS} = -6 \text{ V}, V_{GS} = -6 \text{ V}, I_{D} = -6 \text{ Figures 1 and 10}$	3 A		0.66	0.83		0.66		nC
Q _{gd}	Gate-to-drain charge				0.52	0.68		0.52		
^t d(on)	Turn-on delay time				5.8	8		5.8		ns
^t d(off)	Turn-off delay time	$V_{DD} = -6 V$, $R_L = 6 \Omega$, $I_D = -$	1 A,		22	29		22		ns
t _r	Rise time	$R_G = 6 \Omega$, See Figure 2			22	29		22		
tf	Fall time	i.			4.5	7		4.5		ns
t _{rr(SD)}	Source-to-drain reverse-recovery time	V _{DS} = -6 V, di/dt = 100 A/μs, I _D = -	3 A		65	98		65	-	
Q _{rr}	Total diode charge				71			71		пC

PARAMETER MEASUREMENT INFORMATION

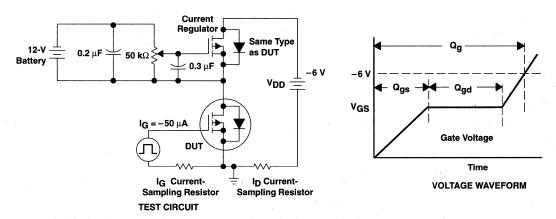


Figure 1. Gate-Charge Test Circuit and Waveform

TPS1110, TPS1110Y SINGLE P-CHANNEL LOGIC-LEVEL MOSFETS

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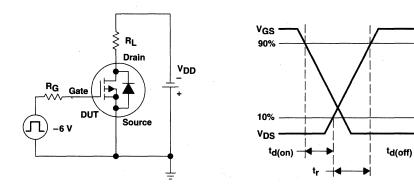


Figure 2. Resistive Switching

Table of Graphs

		FIGURE
Drain current	vs Drain-to-source voltage	3
Drain current	vs Gate-to-source voltage	4
Static drain-to-source on-state resistance	vs Drain current	5
Capacitance	vs Drain-to-source voltage	6
Static drain-to-source on-state resistance (normalized)	vs Junction temperature	7
Source-to-drain diode current	vs Source-to-drain voltage	8
Gate-to-source threshold voltage	vs Junction temperature	. 9
Gate-to-source voltage	vs Gate charge	10

DRAIN CURRENT

DRAIN-TO-SOURCE VOLTAGE

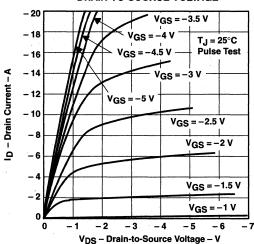


Figure 3

DRAIN CURRENT vs

GATE-TO-SOURCE VOLTAGE

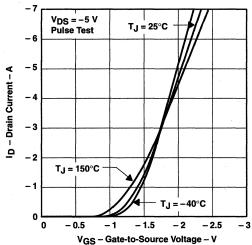
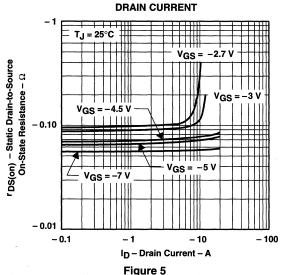


Figure 4

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE VS



CAPACITANCE† **DRAIN-TO-SOURCE VOLTAGE** 1000 V_{GS} = 0 900 f = 1 MHz $T_J = 25^{\circ}C$ 800 700 C - Capacitance - pF Coss 600 500 Cisst 400 300 200 c_{rss}‡ 100 -1.4-2.1-2.8-3.5-4.2-4.8-5.6-6.3 -7 V_{DS} - Drain-to-Source Voltage - V $\dagger C_{iss} = C_{gs} + C_{gd}, C_{ds(shorted)}$ $\ddagger C_{rss} = C_{ad}, C_{oss} = C_{ds} + C_{ad}$

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE (NORMALIZED)

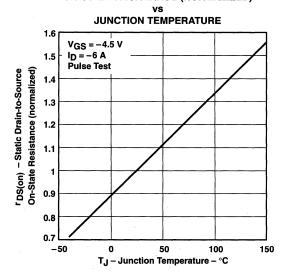


Figure 7

SOURCE-TO-DRAIN DIODE CURRENT

Figure 6

vs SOURCE-TO-DRAIN VOLTAGE

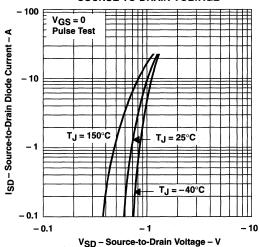
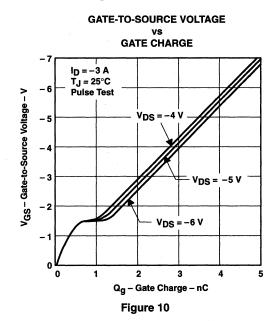


Figure 8

GATE-TO-SOURCE THRESHOLD VOLTAGE vs JUNCTION TEMPERATURE VGS(th) - Gate-to-Source Threshold Voltage - V $V_{DS} = V_{GS}$ $I_D = -250 \mu A$ - 0.9 - 0.8 - 0.7 - 0.6 - 0.5 -50 100 150 0 50 T_J - Junction Temperature - °C





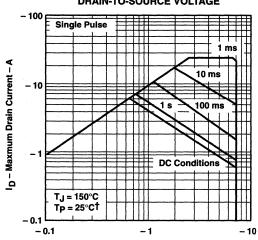
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THERMAL INFORMATION

Table of Graphs

		FIGURE
Maximum drain current	vs Drain-to-source voltage	11
Junction-to-pin thermal resistance (normalized)	vs Pulse duration	12
Junction-to-ambient thermal resistance (normalized)	vs Pulse duration	13

MAXIMUM DRAIN CURRENT vs DRAIN-TO-SOURCE VOLTAGE



V_{DS} – Drain-to-Source Voltage – V

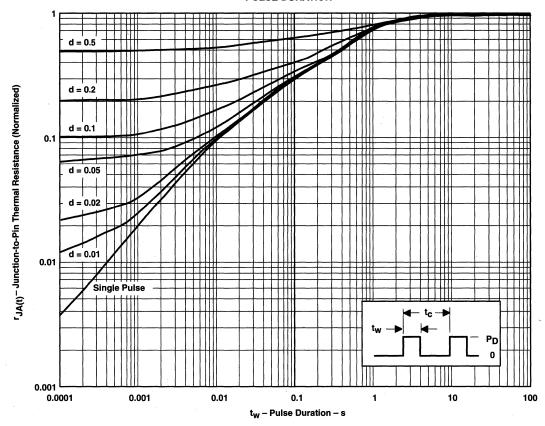
†Tp - Temperature of drain pins measured close to the package

Figure 11

THERMAL INFORMATION

JUNCTION-TO-PIN THERMAL RESISTANCE (NORMALIZED) vs





 $\begin{aligned} \text{NOTE A:} \quad & Z_{\theta,JP}(t) = r_{JP}(t) \cdot \theta_{JP} \\ & t_W = \text{pulse duration} \\ & t_C = \text{cycle time} \\ & d = \text{duty cycle} = t_W/t_C \\ & \text{peak } T_J = P_D \cdot Z_{\theta,JP}(t) + T_P \end{aligned}$

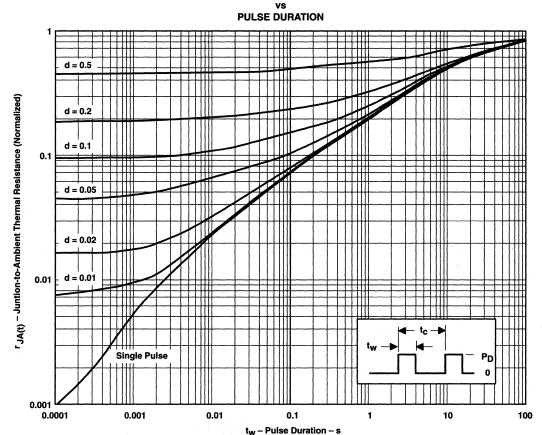
Figure 12



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THERMAL INFORMATION

JUNCTION-TO-AMBIENT THERMAL RESISTANCE (NORMALIZED)†



† Device mounted on FR4 printed-circuit board with no special thermal considerations.

 $\begin{aligned} \text{NOTE A:} \quad & Z_{\theta,JA}(t) = r_{JA}(t) \cdot \theta_{JA} \\ & t_W = \text{pulse duration} \\ & t_C = \text{cycle time} \\ & d = \text{duty cycle} = t_{W}/t_C \\ & \text{peak } T_J = P_D \cdot Z_{\theta,JA}(t) + T_A \end{aligned}$

Figure 13

TPS1120, TPS1120Y DUAL P-CHANNEL ENHANCEMENT-MODE MOSFETS

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Low r_{DS(on)} . . . 0.18 Ω at V_{GS} = -10 V

- 3-V Compatible
- Requires No External V_{CC}
- TTL and CMOS Compatible Inputs
- V_{GS(th)} = −1.5 V Max
- ESD Protection Up to 2 kV per MIL-STD-883C, Method 3015

1SOURCE 1 8 1DRAIN 1GATE 2 7 1DRAIN 2SOURCE 3 6 2DRAIN 2GATE 4 5 2DRAIN

description

The TPS1120 incorporates two independent p-channel enhancement-mode MOSFETs that have been optimized, by means of the Texas Instruments LinBiCMOS™ process, for 3-V or 5-V



power distribution in battery-powered systems. With a maximum $V_{GS(th)}$ of -1.5 V and an I_{DSS} of only 0.5 μA , the TPS1120 is the ideal high-side switch for low-voltage portable battery-management systems, where maximizing battery life is a primary concern. Because portable equipment is potentially subject to electrostatic discharge (ESD), the MOSFETs have built-in circuitry for 2-kV ESD protection. End equipment for the TPS1120 includes notebook computers, personal digital assistants (PDAs), cellular telephones, bar-code scanners, and PCMCIA cards. For existing designs, the TPS1120D has a pinout common with other p-channel MOSFETs in small-outline integrated circuit SOIC packages.

The TPS1120 is characterized for an operating junction temperature range, T_J, from -40°C to 150°C.

AVAILABLE OPTIONS

	PACKAGED DEVICEST	CHIP FORM
TJ	SMALL OUTLINE (D)	(Y)
-40°C to 150°C	TPS1120D	TPS1120Y

[†] The D package is available taped and reeled. Add an R suffix to device type (e.g., TPS1120DR). The chip form is tested at 25°C.



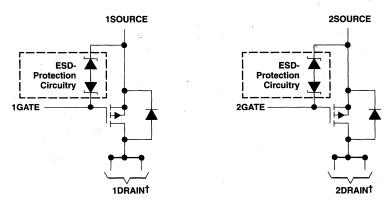
Caution. This device contains circuits to protect its inputs and outputs against damage due to high static voltages or electrostatic fields. These circuits have been qualified to protect this device against electrostatic discharges (ESD) of up to 2 kV according to MIL-STD-883C, Method 3015; however, it is advised that precautions be taken to avoid application of any voltage higher than maximum-rated voltages to these high-impedance circuits.

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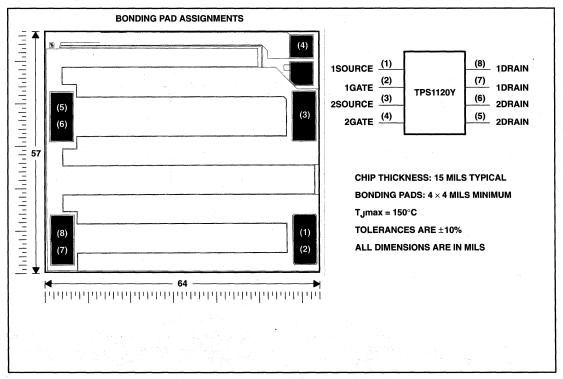
schematic



† For all applications, both drain pins for each device should be connected.

TPS1120Y chip information

This chip, when properly assembled, displays characteristics similar to the TPS1120C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



TPS1120, TPS1120Y DUAL P-CHANNEL ENHANCEMENT-MODE MOSFETS

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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

				UNIT
Drain-to-source voltage, V _{DS}				
Gate-to-source voltage, VGS			2 or –15	V
	V _{GS} = -2.7 V	T _A = 25°C	±0.39	
	VGS = -2.7 V	T _A = 125°C	±0.21	Ì
•	V 2V	T _A = 25°C	±0.5	
Continuous drain surrent, each device (T. – 150°C) In	V _{GS} = -3 V	T _A = 125°C	±0.25	A
Continuous drain current, each device (T _J = 150°C), I _D	454	T _A = 25°C	±0.74	
	V _{GS} = -4.5 V	T _A = 125°C	±0.34	
	V _{GS} = -10 V	T _A = 25°C	±1.17	
	VGS = -10 V	T _A = 125°C	±0.53	
Pulse drain current, ID		T _A = 25°C	±7	Α
Continuous source current (diode conduction), IS		T _A = 25°C	-1	Α
Continuous total power dissipation See Diss				Table
Storage temperature range, T _{stg}			-55 to 150	°C
Operating junction temperature range, TJ				°C
Operating free-air temperature range, T _A -40 to 12				
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds			260	°C

T Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	$T_{\mbox{\scriptsize A}} \le 25^{\circ}\mbox{\scriptsize C}$ POWER RATING	DERATING FACTOR [‡] ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	840 mW	6.71 mW/°C	538 mW	437 mW	169 mW

[‡] Maximum values are calculated using a derating factor based on R_{0JA} = 149°C/W for the package. These devices are mounted on an FR4 board with no special thermal considerations.

TPS1120, TPS1120Y DUAL P-CHANNEL ENHANCEMENT-MODE MOSFETS

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electrical characteristics at T_J = 25°C (unless otherwise noted)

static

DADAMETED		TEST CONDITIONS		TPS1120				
	PARAMETER	, ,,,	TEST CONDITIONS		MIN	TYP	MAX	UNIT
VGS(th)	Gate-to-source threshold voltage	V _{DS} = V _{GS} ,	I _D = -250 μA		-1	-1.25	-1.50	V
V _{SD}	Source-to-drain voltage (diode forward voltage) [†]	I _S = -1 A,	V _{GS} = 0 V			-0.9		٧
IGSS	Reverse gate current, drain short circuited to source	V _{DS} = 0 V,	V _{GS} = -12 V			: 1	±100	nA
Inco	Zero-gate-voltage drain current	V _{DS} = -12 V,	Vac = 0.V	T _J = 25°C			-0.5	^
IDSS	Zero-gate-voltage drain current	VDS = - 12 V,	VGS = 0 V	Tj = 125°C			-10	μΑ
		V _{GS} = -10 V	I _D = -1.5 A			180		
	Ola 15 - days 1	V _{GS} = -4.5 V	$I_D = -0.5 A$			291	400	0
rDS(on)	Static drain-to-source on-state resistance	V _{GS} = -3 V	I- 00A	7		476	700	mΩ
		$V_{GS} = -2.7 \text{ V}$	$I_D = -0.2 \text{ A}$			606	850	,
9fs	Forward transconductance†	$V_{DS} = -10 \text{ V},$	I _D = -2 A			2.5		S

[†] Pulse test: pulse width ≤ 300 μs, duty cycle ≤ 2%

static

	DADAMETED	PARAMETER TEST CONDITIONS		
	PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNIT
V _{GS(th)}	Gate-to-source threshold voltage	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$	-1.25	٧
V _{SD}	Source-to-drain voltage (diode forward voltage)†	$I_S = -1 A$, $V_{GS} = 0 V$	-0.9	V
		V _{GS} = -10 V I _D = -1.5 A	180	7
	0.00	V _{GS} = -4.5 V I _D = -0.5 A	291	mΩ
rDS(on)	Static drain-to-source on-state resistance	$V_{GS} = -3 V$ $I_{D} = -0.2 A$	476	11152
		$\frac{V_{GS} = -3 \text{ V}}{V_{GS} = -2.7 \text{ V}}$ $I_{D} = -0.2 \text{ A}$	606	
9fs	Forward transconductance†	V _{DS} = -10 V, I _D = -2 A	2.5	S

[†] Pulse test: pulse width ≤ 300 μs, duty cycle ≤ 2%

dynamic

PARAMETER		TEST CONDITIONS		TPS1120, TPS1120Y				
	PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
Qg	Total gate charge	-				5.45		
Qgs	Gate-to-source charge	$V_{DS} = -10 \text{ V},$	$V_{GS} = -10 \text{ V},$	$I_D = -1 A$		0.87		nC
Q_{gd}	Gate-to-drain charge					1.4		
^t d(on)	Turn-on delay time	7				4.5		ns
^t d(off)	Turn-off delay time	V _{DD} = -10 V,	$R_{l} = 10 \Omega$	I _D = -1 A,		13		ns
t _r	Rise time	$R_G = 6 \Omega$,	See Figures 1 and 2	_		10		
tf	Fall time					2		ns
trr(SD)	Source-to-drain reverse recovery time	IF = 5.3 A,	di/dt = 100 A/μs			16		

TPS1120, TPS1120Y DUAL P-CHANNEL ENHANCEMENT-MODE MOSFETS

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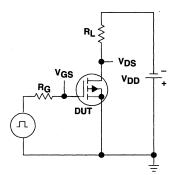


Figure 1. Switching-Time Test Circuit

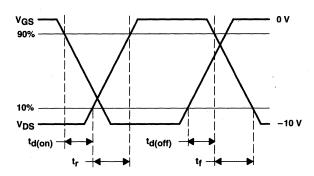
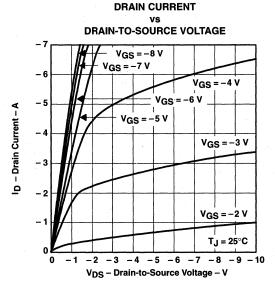


Figure 2. Switching-Time Waveforms

Table of Graphs

		FIGURE
Drain current	vs Drain-to-source voltage	3
Drain current	vs Gate-to-source voltage	4
Static drain-to-source on-state resistance	vs Drain current	5
Capacitance	vs Drain-to-source voltage	6
Static drain-to-source on-state resistance (normalized)	vs Junction temperature	. 7
Source-to-drain diode current	vs Source-to-drain voltage	8
Static drain-to-source on-state resistance	vs Gate-to-source voltage	9
Gate-to-source threshold voltage	vs Junction temperature	10
Gate-to-source voltage	vs Gate charge	11



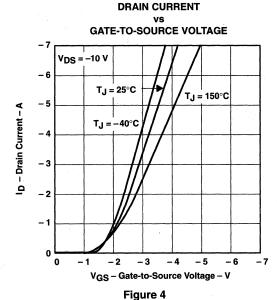


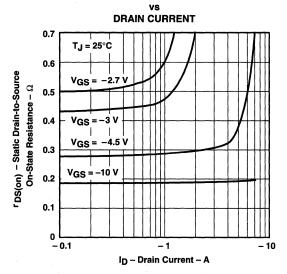
Figure 3

† All characteristics data applies for each independent MOSFET incorporated on the TPS1120.

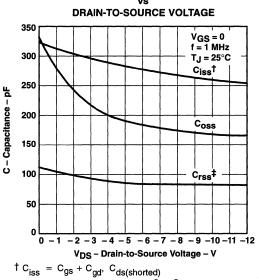
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TYPICAL CHARACTERISTICS

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE



CAPACITANCE



 $\begin{array}{l} \text{t } c_{iss} = c_{gs} + c_{gd}, \ c_{ds(shorted)} \\ \text{t } c_{rss} = c_{gd}, \ c_{oss} = c_{ds} + \frac{c_{gs} c_{gd}}{c_{gs} + c_{gd}} \approx c_{ds} + c_{gc} \\ \end{array}$

Figure 6

Figure 5

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE (NORMALIZED)

JUNCTION TEMPERATURE 1.5 VGS = -10 V ID = -1A 1.4 On-State Resistance (Normalized) DS(on) - Static Drain-to-Source 1.3 1.2 1.1 0.9 0.8 0.7 0.6 -50 50 150 T_J - Junction Temperature - °C

Figure 7

SOURCE-TO-DRAIN DIODE CURRENT

SOURCE-TO-DRAIN VOLTAGE

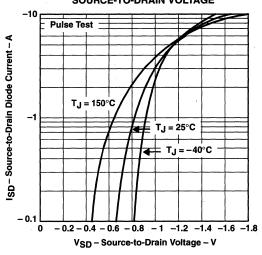


Figure 8

STATIC DRAIN-TO-SOURCE ON-STATE RESISTANCE

O.7 | Ip = -1 A | TJ = 25°C |

U.5 | O.6 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 | O.5 |

GATE-TO-SOURCE THRESHOLD VOLTAGE

JUNCTION TEMPERATURE

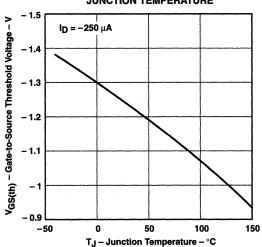


Figure 10

Figure 9

- 9

VGS - Gate-to-Source Voltage - V

- 11

- 13

GATE-TO-SOURCE VOLTAGE

GATE CHARGE

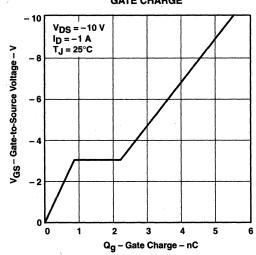
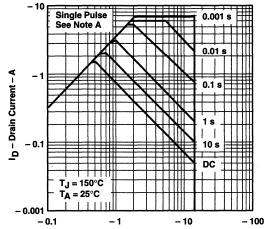


Figure 11

THERMAL INFORMATION

DRAIN CURRENT

DRAIN-TO-SOURCE VOLTAGE



V_{DS} - Drain-to-Source Voltage - V

Figure 12

TRANSIENT JUNCTION-TO-AMBIENT THERMAL IMPEDANCE

vs

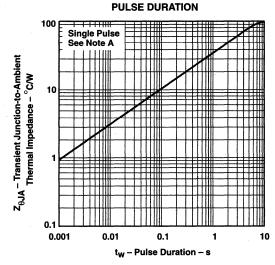


Figure 13

NOTE A: FR4-board-mounted only



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THERMAL INFORMATION

The profile of the heat sinks used for thermal measurements is shown in Figure 14. Board type is FR4 with 1-oz copper and 1-oz tin/lead (63/37) plate. Use of vias or through-holes to enhance thermal conduction was avoided.

Figure 15 shows a family of $R_{\theta JA}$ curves. The $R_{\theta JA}$ was obtained for various areas of heat sinks while subject to air flow. Power remained fixed at 0.25 W per device or 0.50 W per package. This testing was done at 25°C.

As Figure 14 illustrates, there are two separated heat sinks for each package. Each heat sink is coupled to the lead that is internally tied to a single MOSFET source and is half the total area, as shown in Figure 15. For example, if the total area shown in Figure 15 is 4 cm², each heat sink is 2 cm².

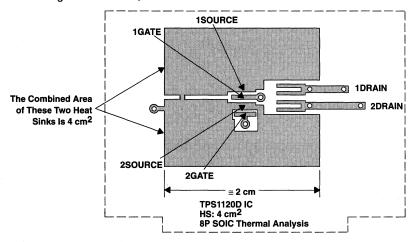


Figure 14. Profile of Heat Sinks

THERMAL RESISTANCE, JUNCTION-TO-AMBIENT

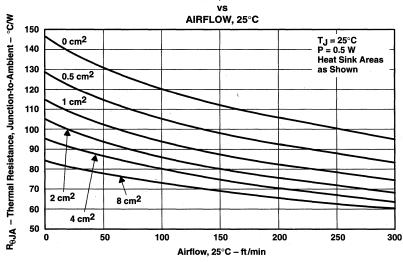


Figure 15



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THERMAL INFORMATION

Figure 16 illustrates the thermally enhanced (SO) lead frame. Attaching the two MOSFET dies directly to the source terminals allows maximum heat transfer into a power plane.

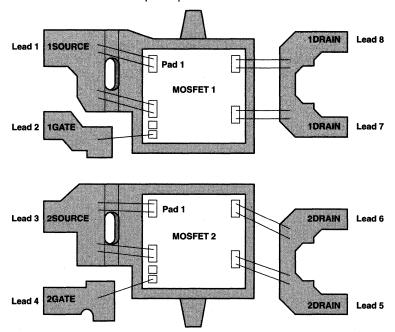


Figure 16. TPS1120 Dual MOSFET SO-8 Lead Frame

APPLICATION INFORMATION

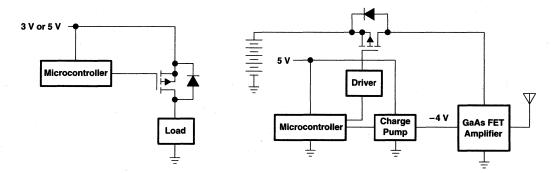


Figure 17. Notebook Load Management

Figure 18. Cellular Phone Output Drive



TPS2010, TPS2011, TPS2012, TPS2013, TPS2010Y POWER-DISTRIBUTION SWITCHES

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 95-mΩ Max (5.5-V Input) High-Side MOSFET Switch With Logic Compatible Enable Input 	D PACKAGE (TOP VIEW)	
Short-Circuit and Thermal Protection	GND T 1 8 T	OUT
 Typical Short-Circuit Current Limits: 0.4 A, TPS2010; 1.2 A, TPS2011; 2 A, TPS2012; 2.6 A, TPS2013 	IN 2 7 1 IN 3 6 2	OUT OUT OUT
 Electrostatic-Discharge Protection, 12-kV Output, 6-kV All Other Terminals 	PW PACKAGE	Ē
 Controlled Rise and Fall Times to Limit Current Surges and Minimize EMI 	(TOP VIEW)	
 SOIC-8 Package Pin Compatible With the Popular Littlefoot™ Series When GND Is Connected 	IN [] 2 13 [] IN [] 3 12 []	OUT OUT
• 2.7-V to 5.5-V Operating Range	3 6	OUT
 10-μA Maximum Standby Current 	3 6	OUT
 Surface-Mount SOIC-8 and TSSOP-14 Packages 	9 ' ' 2	OUT
 −40°C to 125°C Operating Junction 		

description

Temperature Range

The TPS201x family of power-distribution switches is intended for applications where heavy capacitive loads and short circuits are likely to be encountered. The high-side switch is a 95-m Ω N-channel MOSFET. Gate drive is provided by an internal driver and charge pump designed to control the power switch rise times and fall times to minimize current surges during switching. The charge pump operates at 100 kHz, requires no external components, and allows operation from supplies as low as 2.7 V. When the output load exceeds the current-limit threshold or a short circuit is present, the TPS201x limits the output current to a safe level by switching into a constant-current mode. Continuous heavy overloads and short circuits increase power dissipation in the switch and cause the junction temperature to rise. If the junction temperature reaches approximately 180°C, a thermal protection circuit shuts the switch off to prevent damage. Recovery from thermal shutdown is automatic once the device has cooled sufficiently.

The members of the TPS201x family differ only in short-circuit current threshold. The TPS2010 is designed to limit at 0.4-A load; the other members of the family limit at 1.2 A, 2 A, and 2.6 A (see the available options table). The TPS201x family is available in 8-pin small-outline integrated circuit (SOIC) and 14-pin thin shink small-outline (TSSOP) packages and operates over a junction temperature range of −40°C to 125°C. Versions in the 8-pin SOIC package are drop-in replacements for Siliconix's Littlefoot™ power PMOS switches, except that GND must be connected.

AVAILABLE OPTIONS

	RECOMMENDED MAXIMUM	TYPICAL SHORT-CIRCUIT	PACKAG	CHIP	
ΤJ	CONTINUOUS LOAD CURRENT (A)	OUTPUT CURRENT LIMIT AT 25°C (A)	SOIC (D)†	TSSOP (PW)‡	FORM (Y)
	0.2	0.4	TPS2010D	TPS2010PWLE	TPS2010Y
-40°C to 125°C	0.6	1.2	TPS2011D	TPS2011PWLE	TPS2011Y
-40 C to 125°C	1	2	TPS2012D	TPS2012PWLE	TPS2012Y
	1.5	2.6	TPS2013D	TPS2013PWLE	TPS2013Y

[†] The D package is available taped and reeled. Add an R suffix to device type (e.g., TPS2010DR).

Littlefoot is a trademark of Siliconix.

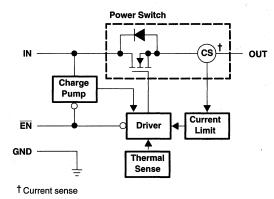


[‡] The PW package is only available left-end taped and reeled (indicated by the LE suffix on the device type; e.g., TPS2010PWLE).

TPS2010, TPS2011, TPS2012, TPS2013, TPS2010Y POWER-DISTRIBUTION SWITCHES

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functional block diagram



Terminal Functions

TERMINAL		TERMINAL				
NAME	NO.		1/0	DESCRIPTION		
NAME	D	PW	1			
EN	4	7	1	Enable input. Logic low turns power switch on.		
GND	1	1	ı	Ground		
IN .	2, 3	2-6	1.	Input voltage		
OUT	5-8	8-14	0	Power-switch output		

detailed description

power switch

The power switch is an N-channel MOSFET with a maximum on-state resistance of 95 m Ω (V_{I(IN)} = 5.5 V), configured as a high-side switch.

charge pump

An internal 100-kHz charge pump supplies power to the driver circuit and provides the necessary voltage to pull the gate of the MOSFET above the source. The charge pump operates from input voltages as low as 2.7 V and requires very little supply current.

driver

The driver controls the gate voltage of the power switch. To limit large current surges and reduce the associated electromagnetic interference (EMI) produced, the driver incorporates circuitry that controls the rise times and fall times of the output voltage. The rise and fall times are typically in the 2-ms to 4-ms range instead of the microsecond or nanosecond range for a standard FET.

enable (EN)

A logic high on the \overline{EN} input turns off the power switch and the bias for the charge pump, driver, and other circuitry to reduce the supply current to less than 10 μ A. A logic zero input restores bias to the drive and control circuits and turns the power on. The enable input is compatible with both TTL and CMOS logic levels.



TPS2010, TPS2011, TPS2012, TPS2013, TPS2010Y POWER-DISTRIBUTION SWITCHES

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current sense

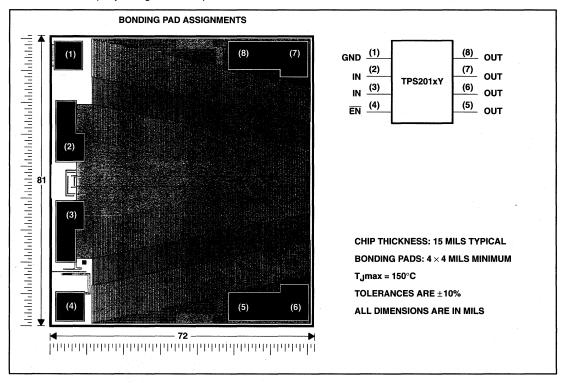
A sense FET monitors the current supplied to the load. The sense FET is a much more efficient way to measure current than conventional resistance methods. When an overload or short circuit is encountered, the current-sense circuitry sends a control signal to the driver. The driver in turn reduces the gate voltage and drives the power FET into its linear region, which switches the output into a constant current mode and simply holds the current constant while varying the voltage on the load.

thermal sense

An internal thermal-sense circuit shuts the power switch off when the junction temperature rises to approximately 180°C. Hysteresis is built into the thermal sense, and after the device has cooled approximately 20 degrees, the switch turns back on. The switch continues to cycle off and on until the fault is removed.

TPS201xY chip information

This chip, when properly assembled, displays characteristics similar to the TPS201xC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



TPS2010, TPS2011, TPS2012, TPS2013, TPS2010Y **POWER-DISTRIBUTION SWITCHES**

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Input voltage range, V _{I(IN)} (see Note 1)	0.3 V to 7 V
Output voltage range, VO (see Note 1)	$-0.3 \text{ V to V}_{I(IN)} + 0.3 \text{ V}$
Input voltage range, V _I at EN	–0.3 V to 7 V
Continuous output current, IO	internally limited
Continuous total power dissipation	See Dissipation Rating Table
Operating virtual junction temperature range, T _J	40°C to 125°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature soldering 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	DERATING FACTOR	T _A = 70°C	T _A = 125°C
	POWER RATING	ABOVE T _A = 25°C	POWER RATING	POWER RATING
D	725 mW	5.8 mW/°C	464 mW	145 mW
PW	700 mW	5.6 mW/°C	448 mW	140 mW

recommended operating conditions

NOTE 1: All voltages are with respect to GND.

			 		MIN	MAX	UNIT
Input voltage, VI(IN)					2.7	5.5	V
Input voltage, V _I at EN					0	5.5	V
	TPS2010				0	0.2	
	TPS2011		 		0	0.6	
Continuous output current, IO	TPS2012				0	0 1	Α
TPS2013	TPS2013	 			0	1.5	
Operating virtual junction tempe	rature, T _J	 		W	-40	125	°C

TPS2010, TPS2011, TPS2012, TPS2013, TPS2010Y POWER-DISTRIBUTION SWITCHES

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electrical characteristics over recommended operating junction temperature range, $V_{I(IN)} = 5.5 \text{ V}$, $I_O = \text{rated current}$, $\overline{EN} = 0 \text{ V}$ (unless otherwise noted)

power switch

	PARAMETER	TEST	TPS2010, TPS2011 TPS2012, TPS2013			UNIT	
				MIN	TYP	MAX	
	On-state resistance	$V_{I(IN)} = 5.5 V,$	T _J = 25°C		75	95	
		$V_{I(IN)} = 4.5 V$	T _J = 25°C		80	110	
		$V_{I(IN)} = 3 V$	T _J = 25°C		120	175	mΩ
		$V_{I(IN)} = 2.7 \text{ V},$	T _J = 25°C		140	215	
	Output lookage current	EN 1/	T _J = 25°C		0.001	1	
	Output leakage current	$\overline{EN} = V_{I(IN)}$	-40°C ≤ T _J ≤ 125°C			10	μА
	Output via a time	$V_{I(IN)} = 5.5 \text{ V},$	T _J = 25°C, C _L = 1 μF		4		
t _r	Output rise time	$V_{I(IN)} = 2.7 \text{ V},$	T _J = 25°C, C _L = 1 μF		3.8		ms
		$V_{I(IN)} = 5.5 \text{ V},$	T _J = 25°C, C _L = 1 μF		3.9		
tf	Output fall time	$V_{I(IN)} = 2.7 \text{ V},$	T _J = 25°C, C _L = 1 μF		3.5		ms

T Pulse-testing techniques maintain junction temperature close to ambient temperature; thermal effects must be taken into account separately.

enable input (EN)

PARAMETER	TEST CONDITIONS	TPS20	UNIT			
			MIN	TYP	MAX	
	High-level input voltage	$2.7 \text{ V} \le \text{V}_{\text{I(IN)}} \le 5.5 \text{ V}$	2			٧
	Low-level input voltage	4.5 V ≤ V _{I(IN)} ≤ 5.5 V			0.8	V
		2.7 V ≤ V _{I(IN)} < 4.5 V			0.4	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
	Input current	$\overline{EN} = 0 \text{ V or } \overline{EN} = V_{I(IN)}$	-0.5		0.5	μА
^t PLH	Propagation (delay) time, low-to-high-level output	C _L = 1 μF			20	
tPHL	Propagation (delay) time, high-to-low-level output	C _L = 1 μF			40	ms

current limit

PARAMETER	TEST CONDITIONS	TEST CONDITIONS			TPS2010, TPS2011 TPS2012, TPS2013			
					MAX	1		
	T _{.1} = 25°C,	TPS2010	0.22	0.4	0.6			
Short-circuit current	$V_{I(IN)} = 5.5 \text{ V},$	TPS2011	0.66	1.2	1.8	١.		
	OÙT connected to GND, device	TPS2012	1.1	2	3	A		
	enabled into short circuit	TPS2013	1.65	2.6	4.5			

[†] Pulse-testing techniques maintain junction temperature close to ambient temperature; thermal effects must be taken into account separately.

supply current

PARAMETER	TEST	TPS20	UNIT			
		MIN	TYP	MAX		
Cumply oursent level over output	EN V	T _J = 25°C		0.015	1	
Supply current, low-level output	EN = VI(IN)	-40°C ≤ T _J ≤ 125°C			10	μΑ
Supply current, high-level output	EN = 0 V	T _J = 25°C		73	100	
	EN = U V	–40°C ≤ T _J ≤ 125°C			100	μА



TPS2010, TPS2011, TPS2012, TPS2013, TPS2010Y POWER-DISTRIBUTION SWITCHES

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electrical characteristics over recommended operating junction temperature range, $V_{I(IN)}$ = 5.5 V, I_O = rated current, \overline{EN} = 0 V, T_J = 25°C (unless otherwise noted)

power switch

PARAMETER	TEST CONDITIONS†	TPS2010Y, TPS2011Y TPS2012Y, TPS2013Y	UNIT
		MIN TYP MAX	
On-state resistance	$V_{I(IN)} = 5.5 V,$	75	
	$V_{I(IN)} = 4.5 \text{ V},$	80	mΩ
	V _{I(IN)} = 3 V,	120	11122
	$V_{I(IN)} = 2.7 \text{ V},$	140	
Output leakage current	EN = V _{I(IN)}	0.001	μA
Output rise time	V _{I(IN)} = 5.5 V, C _L = 1 μF	4	
Output rise time	$V_{I(IN)} = 2.7 \text{ V}, \qquad C_L = 1 \mu\text{F}$	3.8	ms
Outros to Il time	$V_{I(IN)} = 5.5 \text{ V}, \qquad C_L = 1 \mu\text{F}$	3.9	
Output fall time	$V_{I(IN)} = 2.7 \text{ V}, \qquad C_L = 1 \mu\text{F}$	3.5	ms

T Pulse-testing techniques maintain junction temperature close to ambient temperature; thermal effects must be taken into account separately.

current limit

PARAMETER	TEST CONDITIONS†	TPS201 TPS201	UNIT		
		MIN	TYP	MAX	
Short-circuit current	V _{I(IN)} = 5.5 V, OUT connected to GND, Device enabled into short circuit		0.4		Α

[†] Pulse-testing techniques maintain junction temperature close to ambient temperature; thermal effects must be taken into account separately.

supply current

PARAMETER	TEST CONDITIONS	TPS201	UNIT		
		MIN	TYP	MAX	
Supply current, low-level output	EN = VI(IN)		0.015		μΑ
Supply current, high-level output	<u>EN</u> = 0 V		. 73		μΑ

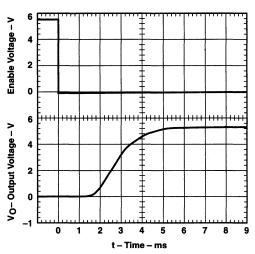


Figure 1. Propagation Delay and Rise Time With 1- μ F Load, $V_{I(IN)}$ = 5.5 V

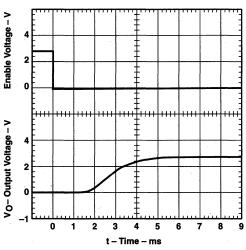


Figure 3. Propagation Delay and Rise Time With 1- μ F Load, V_{I(IN)} = 2.7 V

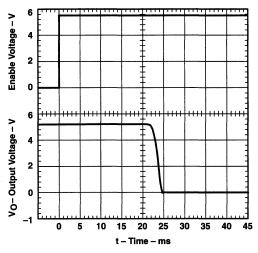


Figure 2. Propagation Delay and Fall Time With 1- μ F Load, $V_{I(IN)}$ = 5.5 V

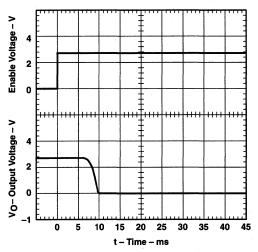


Figure 4. Propagation Delay and Fall Time With 1- μ F Load, $V_{I(IN)} = 2.7 \text{ V}$

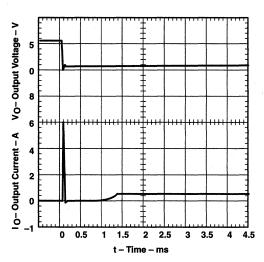


Figure 5. TPS2010, Short-Circuit Current. Short is Applied to Enabled Device, $V_{I(IN)} = 5.5 \text{ V}$

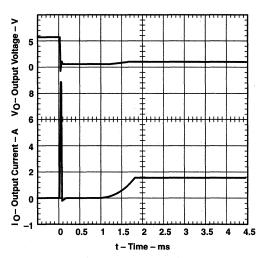


Figure 6. TPS2011, Short-Circuit Current. Short is Applied to Enabled Device, $V_{I(IN)} = 5.5 \text{ V}$

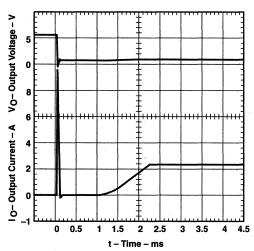


Figure 7. TPS2012, Short-Circuit Current. Short is Applied to Enabled Device, $V_{I(IN)}$ = 5.5 V

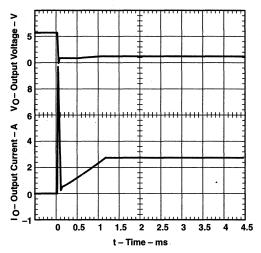


Figure 8. TPS2013 – Short-Circuit Current. Short is Applied to Enabled Device, $V_{I(IN)} = 5.5 \text{ V}$

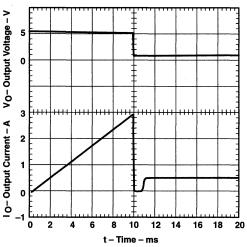


Figure 9. TPS2010 – Threshold Current, $V_{I(IN)} = 5.5 \text{ V}$

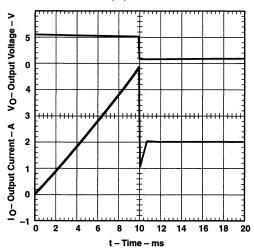


Figure 11. TPS2012 – Threshold Current, $V_{I(IN)} = 5.5 \text{ V}$

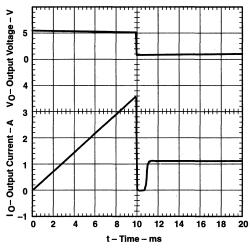


Figure 10. TPS2011 – Threshold Current, $V_{I(IN)} = 5.5 \text{ V}$

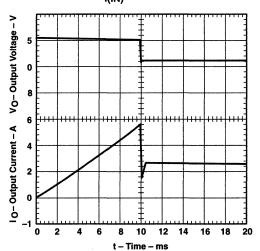


Figure 12. TPS2013 – Threshold Current, $V_{I(IN)} = 5.5 \text{ V}$

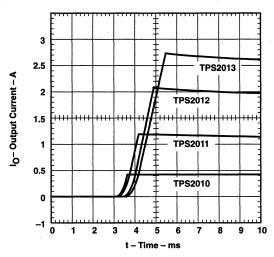


Figure 13. Turned-On (Enabled) Into Short Circuit, V_{I(IN)} = 5.5 V

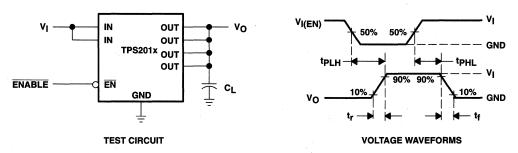
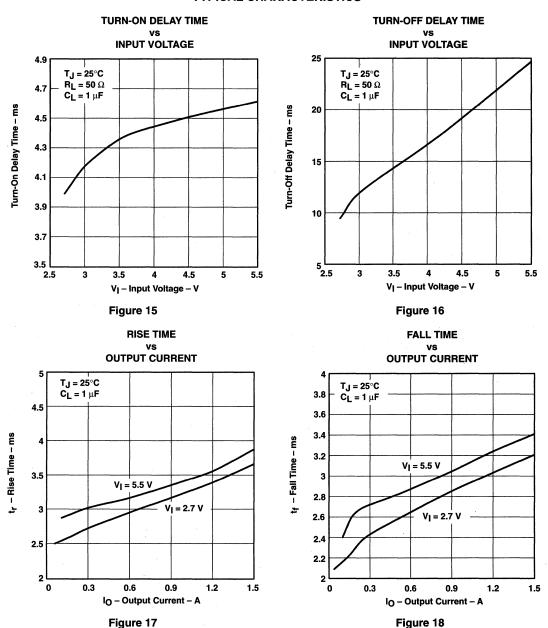


Figure 14. Test Circuit and Voltage Waveforms



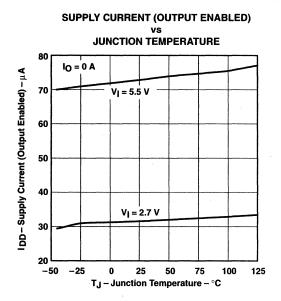
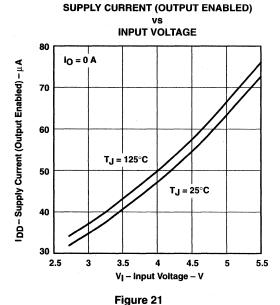


Figure 19



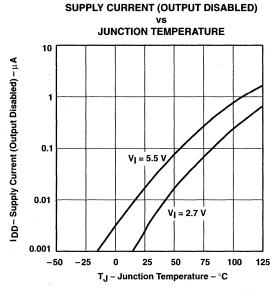


Figure 20

SUPPLY CURRENT (OUTPUT DISABLED)

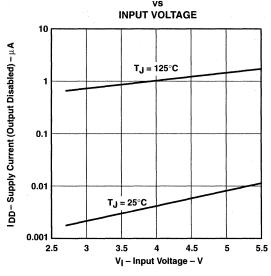


Figure 22

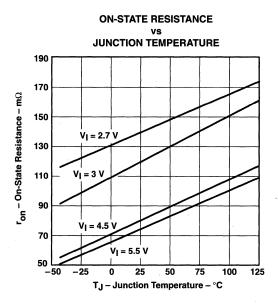


Figure 23

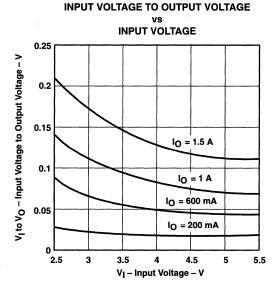


Figure 25

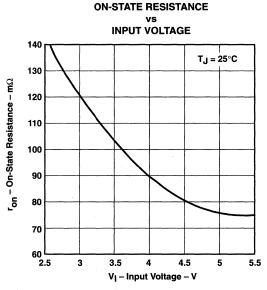


Figure 24

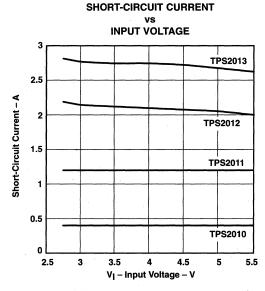
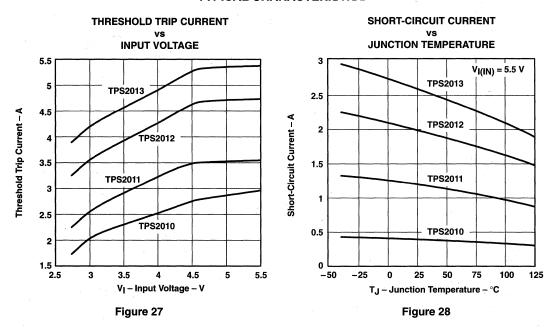


Figure 26

TPS2010, TPS2011, TPS2012, TPS2013, TPS2010Y POWER-DISTRIBUTION SWITCHES

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TYPICAL CHARACTERISTICS



TPS2010, TPS2011, TPS2012, TPS2013, TPS2010Y POWER-DISTRIBUTION SWITCHES

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APPLICATION INFORMATION

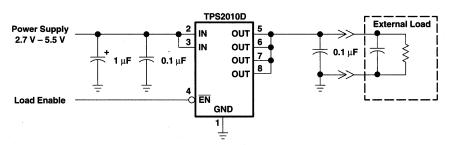


Figure 29. Typical Application

power supply considerations

The TPS201x family has multiple inputs and outputs, which must be connected in parallel to minimize voltage drop and prevent unnecessary power dissipation.

A $0.047-\mu F$ to $0.1-\mu F$ ceramic bypass capacitor between IN and GND, close to the device, is recommended. A high-value electrolytic capacitor is also desirable when the output load is heavy or has large paralleled capacitors. Bypassing the output with a $0.1-\mu F$ ceramic capacitor improves the immunity of the device to electrostatic discharge (ESD).

overcurrent

A sense FET is employed to check for overcurrent conditions. Unlike sense resistors and polyfuses, sense FETs do not increase series resistance to the current path. When an overcurrent condition is detected, the device maintains a constant output current and reduces the output voltage accordingly. Shutdown only occurs if the fault is present long enough to activate thermal limiting.

Three possible overload conditions can occur. In the first condition, the output has been shorted before the device is enabled or before $V_{I(IN)}$ has been applied (see Figure 30). The TPS201x senses the short and immediately switches into a constant-current output.

Under the second condition, the short occurs while the device is enabled. At the instant the short occurs, very high currents flow for a short time before the current-limit circuit can react (see Figures 5, 6, 7, and 8). After the current-limit circuit has tripped, the device limits normally.

Under the third condition, the load has been gradually increased beyond the recommended operating current. The current is permitted to rise until the current-limit threshold is reached (see Figures 9, 10, 11, and 12). The TPS201x family is capable of delivering currents up to the current-limit threshold without damage. Once the threshold has been reached, the device switches into its constant-current mode.

APPLICATION INFORMATION

overcurrent (continued)

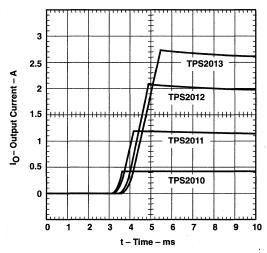


Figure 30. Turned-On (Enabled) Into Short Circuit, V_{I(IN)} = 5.5 V

power dissipation and junction temperature

The low on resistance of the N-channel MOSFET allows small surface-mount packages, such as SOIC or TSSOP to pass large currents. The thermal resistances of these packages are high compared to that of power packages; it is good design practice to check power dissipation and junction temperature. The first step is to find ron at the input voltage and operating temperature. As an initial estimate, use the highest operating ambient temperature of interest and read ron from Figure 23. Next calculate the power dissipation using:

$$P_D = r_{on} \times I^2$$

Finally, calculate the junction temperature:

$$T_J = P_D \times R_{\theta JA} + T_A$$

Where:

T_A = Ambient temperature

R_{B,IA} = Thermal resistance SOIC = 172°C/W, TSSOP = 179°C/W

Compare the calculated junction temperature with the initial estimate. If they do not agree within a few degrees, repeat the calculation using the calculated value as the new estimate. Two or three iterations are generally sufficient to get a reasonable answer.



TPS2010, TPS2011, TPS2012, TPS2013, TPS2010Y POWER-DISTRIBUTION SWITCHES

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APPLICATION INFORMATION

thermal protection

Thermal protection is provided to prevent damage to the IC when heavy-overload or short-circuit faults are present for extended periods of time. The faults force the TPS201x into its constant current mode, which causes the voltage across the high-side switch to increase; under short-circuit conditions, the voltage across the switch is equal to the input voltage. The increased dissipation causes the junction temperature to rise to dangerously high levels. The protection circuit senses the junction temperature of the switch and shuts it off. The switch remains off until the junction has dropped approximately 20°C. The switch continues to cycle in this manner until the load fault or input power is removed.

ESD protection

All TPS201x terminals incorporate ESD-protection circuitry designed to withstand a 6-kV human-body-model discharge as defined in MIL-STD-883C. Additionally, the output is protected from discharges up to 12 kV.



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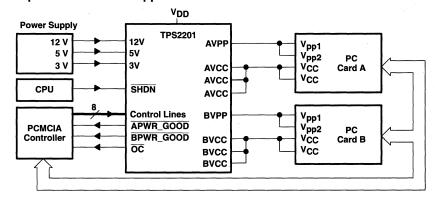
 Fully Integrated V_{CC} and V_{pp} Switching for Dual-Slot PC Card Interface 	DB OR DF PACKAGE (TOP VIEW)		
 Compatible With Controllers From Cirrus, Intel, and Texas Instruments 	5V1O 5V2	30	
 Meets PCMCIA Standards 	A_VPP_PGM3	28 B_VPP_VCC	
Internal Charge Pump (No External	A_VPP_VCC4	27 <u>B_VCC5</u>	
Capacitors Required) – 12-V Supply Can Be	A_VCC55	26 B_VCC3	
Disabled Except for Programming	A_VCC3 G	V_{DD}	
Short Circuit and Thermal Protection	12V7	24 12V	
	AVPP 🖂 8	23 BVPP	
 Space Saving SSOP (DB) Package 	AVCC □□□9	22 D BVCC	
 Compatible With 3.3-V, 5-V and 12-V PC 	AVCC 🖂 10	21 BVCC	
Cards	AVCC 11	20 BVCC	
	GND □□□ 12	19 BPWR_GOOD	
 Power Saving I_{DD} = 83 μA Typ, I_Q = 1 μA 	APWR GOOD 13	18 🞞 ŌC	
 Low r_{DS(on)} (160-mΩ V_{CC} Switch) 	SHDN 🖂 14	17 🞞 3V	
Break-Before-Make Switching	3V15	16 🞞 3V	

description

The TPS2201 PC Card (PCMCIA) power interface switch provides an integrated power-management solution for two PC Cards. All of the discrete power MOSFETs, a logic section, current limiting, thermal protection, and power-good reporting for PC Card control are combined on a single integrated circuit (IC), using Texas Instruments LinBiCMOS™ process. The circuit allows the distribution of 3-V, 5-V and/or 12-V card power and is compatible with most PCMCIA controllers. The current-limiting feature eliminates the need for fuses, which reduces component count and improves reliability; current-limit reporting can help the user isolate a system fault to a bad card.

The TPS2201 maximizes battery life by generating its own switch-drive voltage using an internal charge pump. Therefore, the 12-V supply can be powered down and only brought out of standby when flash memory needs to be written to or erased. End equipment for the TPS2201 includes notebook computers, desktop computers, personal digital assistants (PDAs), digital cameras, handiterminals, and bar-code scanners.

typical PC card power distribution application



LinBiCMOS is a trademark of Texas Instruments Incorporated.



TPS2201, TPS2201Y DUAL-SLOT PC CARD POWER-INTERFACE SWITCHES FOR PARALLEL PCMCIA CONTROLLERS SLVS094B - AUGUST 1994 - REVISED AUGUST 1995

AVAILABLE OPTIONS

	PACKAGE	DEVICES	CHIP FORM
TJ	SHINK SMALL-OUTLINE (DB)	SMALL-OUTLINE (DF)	(Y)
-40°C to 150°C	TPS2201IDB	TPS2201IDF	TPS2201Y

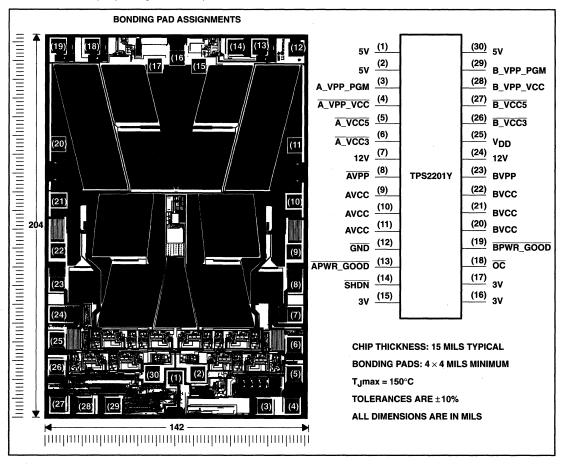
The DF package is only available left-end taped and reeled (indicated by the LE suffix on the device type; e.g., TPS2201IDFLE).

Terminal Functions

TERMI	NAL					
NAME	NO.	1/0	DESCRIPTION			
A_VCC3	6	- I	Logic input that controls voltage on AVCC (see control-logic table)			
A_VCC5	5	1	Logic input that controls voltage on AVCC (see control-logic table)			
A_VPP_PGM	3	I	Logic input that controls voltage on AVPP (see control-logic table)			
A_VPP_VCC	4	ı	Logic input that controls voltage on AVPP (see control-logic table)			
APWR_GOOD	13	0	Logic-level power-ready output that stays low as long as AVPP is within limits			
AVCC	9, 10, 11	0	Switched output that delivers 0 V, 3.3 V, 5 V, or high impedance			
AVPP	8	0	Switched output that delivers 0 V, 3.3 V, 5 V, 12 V, or high impedance			
B_VCC3	26	ı	Logic input that controls voltage on BVCC (see control-logic table)			
B_VCC5	27	1	Logic input that controls voltage on BVCC (see control-logic table)			
B_VPP_PGM	29	ı	Logic input that controls voltage on BVPP (see control-logic table)			
B_VPP_VCC	28	1	Logic input that controls voltage on BVPP (see control-logic table)			
BPWR_GOOD	19	0	Logic-level power-ready output that stays low as long as BVPP is within limits			
BVCC	20, 21, 22	0	Switched output that delivers 0 V, 3.3 V, 5 V, or high impedance			
BVPP	23	0	Switched output that delivers 0 V, 3.3 V, 5 V, 12 V, or high impedance			
SHDN	14	I	Logic input that shuts down the TPS2201 and set all power outputs to high-impedance state			
<u>oc</u>	18	0	Logic-level overcurrent reporting output that goes low when an overcurrent condition exists			
V_{DD}	25		5-V power to chip			
GND	12		Ground			
3V	15, 16, 17	ı	3-V V _{CC} input for card power			
5V	1, 2, 30	1	5-V V _{CC} input for card power			
12V	7, 24	ı	12-V VPP input for card power			

TPS2201Y chip information

This chip, when properly assembled, displays characteristics similar to the TPS2201. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{DD}	0.3 V to 7 V
Input voltage range for card power: V _{I(5V)}	
input voltage range for card power. $v_{1(5V)}$. 0.0 1 10 7 1
V _Ι (3ν) · · · · · · · · · · · · · · · · · · ·	-0.3 V to V _{I(5V)}
V _{I(12V)}	-0.3 V to 14 V
Logic input voltage	0.3 V to 7 V
Continuous total power dissipation	on Rating Table
Output current (each card): I _{O(xVCC)} ii	nternally limited
l _{O(xVPP)} i	nternally limited
Operating virtual junction temperature range, T _J	-40°C to 150°C
Operating free-air temperature range, T _A	-40°C to 85°C
Storage temperature range, T _{stg}	-55°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR‡ ABOVE TA = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
DB	1024 mW	8.2 mW/°C	655 mW	532 mW
DF	1158 mW	9.26 mW/°C	741 mW	602 mW

^{*} Maximum values are calculated using a derating factor based on R_{θJA} = 108°C/W for the package. These devices are mounted on an FR4 board with no special thermal considerations.

recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V _{DD}		4.75	5.25	٧
	V _I (5V)	0	5.25	V
Input voltage range, V _I	V _{I(3V)}	0	۷ _{I(5V)} †	٧
	V _{I(12V)}	0	13.5	٧
Output ourrent I-	I _{O(xVCC)} at 25°C		1	Α
Output current, IO	IO(xVPP) at 25°C		150	mA
Operating virtual junction tempe	rature, TJ	-40	125	°C

 $[\]dagger V_{I(3\ V)}$ should not be taken above $V_{I(5\ V)}$.

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electrical characteristics, T_A = 25°C, V_{DD} = 5 V (unless otherwise noted) dc characteristics

PARAMETER		TEST CONDITIONS	1	TPS2201			
PA	HAMEIER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
	5 V to xVCC				160	0	
	3 V to xVCC				225	mΩ	
Switch resistances	5 V to xVPP				6		
	3 V to xVPP				6	Ω	
	12 V to xVPP				1		
Clamp low voltage		Ipp at 10 mA			0.8	V	
Clamp low voltage		ICC at 10 mA			0.8	V	
	L Ligh impedance state	T _A = 25°C		. 1	10		
Leakage current	Ipp High-impedance state	T _A = 85°C			50		
Leakage current	ICC High-impedance state	T _A = 25°C		. 1	10	μА	
	ICC High-impedance state	T _A = 85°C			50		
Input current	IDD	V _{O(AVCC)} = V _{O(BVCC)} = 5 V, V _{O(AVPP)} = V _{O(BVPP)} = 12 V		83	150	μА	
input current	I _{DD} in shutdown	$V_{O(BVCC)} = V_{O(AVCC)} = V_{O(AVPP)}$ = $V_{O(BVPP)} = high Z$			1	μА	
Power-ready threshold	d, PWR_GOOD		10.72	11.05	11.4	V	
Power-ready hysteres	is, PWR_GOOD (12-V mode)			50		mV	
Short-circuit output-	lo(xVCC)	T. 95°C Outsit shorted to CND	0.75	1.3	1.9	Α	
current limit	IO(xVPP)	T _J = 85°C, Output shorted to GND	120	200	400	mA	

logic section

<u> </u>				
PARAMETER	TEST CONDITIONS	TPS22	01	UNIT
PANAMETEN	TEST CONDITIONS	MIN	MAX	UNII
Logic input current			1	μА
Logic input high level		2.7		V
Logic input low level			0.8	V
Logic output high level	I= 1 m A	V _{DD} -0.4		٧
Logic output low level	I _O = 1 mA		0.4	٧

switching characteristics†

	PARAMETER	TEST COMPITIONS	TEST CONDITIONS			TPS2201		
	PANAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
	Output rise time	VO(xVCC)			1.2		ma	
tr	Output rise time	V _{O(x} VPP)			5		ms	
Ī.,	Output fall time	VO(xVCC)			10			
tf	Odiput fair time	V _{O(x} VPP)			14		ms	
		Victoria necesta Vertical	ton		5.8		ma	
1		VI(x_VPP_PGM) to VO(xVPP)	toff		18		ms	
١	Propagation delay (see Figure 1‡)	V to 14/00 (0.10)	ton		5.8		mo	
tpd	r Topagation delay (See Figure 1+)	V _{I(x_VCC3)} to xVCC (3 V)	toff		28		ms	
		V ₁ V ₂ V ₂ V ₃ to v ₄ (CC (5 V)	ton		4		mo	
L		V _{I(x_VCC5)} to xVCC (5 V)	toff		30		ms	

[†] Refer to Parameter Measurement Information

 $[\]ddagger$ Rise and fall times are with CL = 100 $\mu\text{F}.$



TPS2201, TPS2201Y DUAL-SLOT PC CARD POWER-INTERFACE SWITCHES FOR PARALLEL PCMCIA CONTROLLERS SLVS094B - AUGUST 1994 - REVISED AUGUST 1995

electrical characteristics, T_A = 25°C, V_{DD} = 5 V (unless otherwise noted) (continued) dc characteristics

PARAMETER		TEST CONDITIONS		TPS2201Y			
		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Leakage current	Ipp High-impedance state			1			
Leakage current	ICC High-impedance state	1		1		<u>'</u> μΑ	
Input current	I _{DD}	V _O (AVCC) = V _O (BVCC) = 5 V, V _O (AVPP) = V _O (BVPP) = 12 V		83		μА	
Power-ready threshold	d, PWR_GOOD			11.05		٧	
Power-ready hysteres	is, PWR_GOOD (12-V mode)			50		mV	

switching characteristics†

	PARAMETER	TEST COMPLIANCE	TEST CONDITIONS			,	UNIT	
	PANAMETER	TEST CONDITIONS				MAX	UNII	
	Output rise time	V _{O(x} VCC)			1.2		ms	
tr	Output rise time	V _{O(x} VPP)			5		1115	
1,	Output fall time	V _{O(x} VCC)			10		ms	
tf .	Output fail time	V _{O(x} VPP)			14		1115	
		Viv. vpp. post to Vov. vpp.	ton		5.8		ms	
		V _I (x_VPP_PGM) to VO(xVPP)	toff		18		1115	
	Propagation delay (see Figure 1‡)	W. Transito WCC	ton		5.8		ms	
^t pd	Tropagation delay (see Figure 11)	V _{I(x_VCC3)} to xVCC	t _{off}		28		1115	
		Viv. Vices to xVCC	ton		4		me	
		V _{I(x_VCC5)} to xVCC	toff		30		ms	

[†] Refer to Parameter Measurement Information

[‡] Rise and fall times are with $C_L = 100 \mu F$.

PARAMETER MEASUREMENT INFORMATION

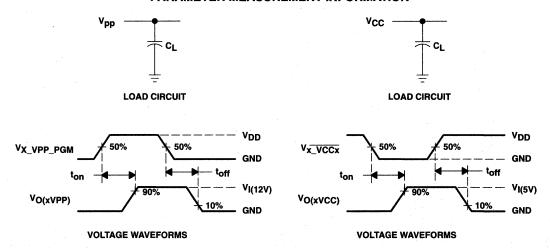


Figure 1. Test Circuits and Voltage Waveforms

Table of Timing Diagrams

	FIGURE
xVCC Propagation Delay and Rise Times With 1-μF Load, 3-V Switch	2
xVCC Propagation Delay and Fall Times With 1-μF Load, 3-V Switch	3
xVCC Propagation Delay and Rise Times With 100-μF Load, 3-V Switch	4
xVCC Propagation Delay and Fall Times With 100-μF Load, 3-V Switch	5
xVCC Propagation Delay and Rise Times With 1-μF Load, 5-V Switch	6
xVCC Propagation Delay and Fall Times With 1-μF Load, 5-V Switch	7
xVCC Propagation Delay and Rise Times With 100-μF Load, 5-V Switch	8
xVCC Propagation Delay and Fall Times With 100-μF Load, 5-V Switch	9
xVPP Propagation Delay and Rise Times With 1-μF Load, 12-V Switch	10
xVPP Propagation Delay and Fall Times With 1-μF Load, 12-V Switch	11
xVPP Propagation Delay and Rise Times With 100-μF Load, 12-V Switch	12
xVPP Propagation Delay and Fall Times With 100-μF Load, 12-V Switch	13

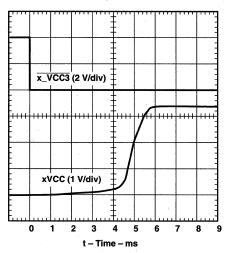


Figure 2. xVCC Propagation Delay and Rise Times With 1-μF Load, 3-V Switch

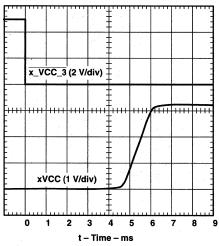


Figure 4. xVCC Propagation Delay and Rise Times With 100-µF Load, 3-V Switch

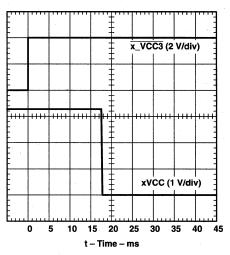


Figure 3. xVCC Propagation Delay and Fall Times With 1- μ F Load, 3-V Switch

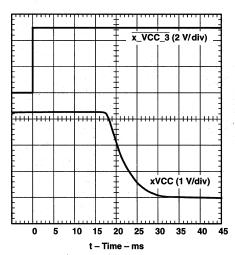


Figure 5. xVCC Propagation Delay and Fall Times With 100-μF Load, 3-V Switch

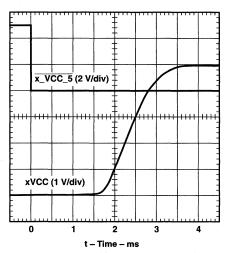


Figure 6. xVCC Propagation Delay and Rise Times With 1-μF Load, 5-V Switch

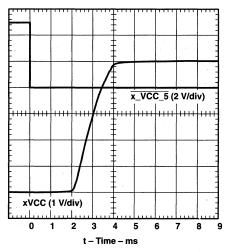


Figure 8. xVCC Propagation Delay and Rise Times With 100-μF Load, 5-V Switch

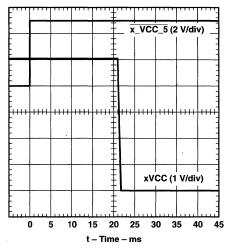


Figure 7. xVCC Propagation Delay and Fall Times With 1-µF Load, 5-V Switch

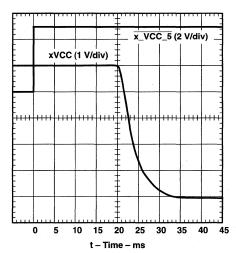


Figure 9. xVCC Propagation Delay and Fall Times With 100-μF Load, 5-V Switch



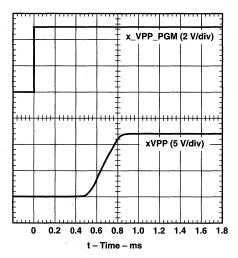


Figure 10. xVPP Propagation Delay and Rise Times With 1-µF Load, 12-V Switch

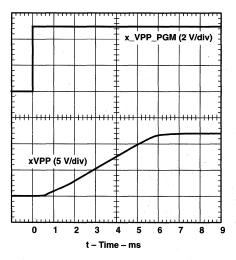


Figure 12. xVPP Propagation Delay and Rise Times With 100-µF Load, 12-V Switch

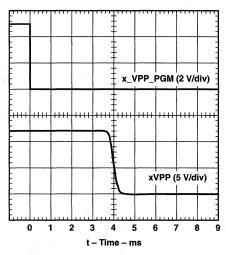


Figure 11. xVPP Propagation Delay and Fall Times With 1-µF Load, 12-V Switch

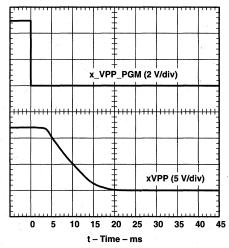


Figure 13. xVPP Propagation Delay and Fall Times With 100-µF Load, 12-V Switch

TYPICAL CHARACTERISTICS†

Table of Graphs

			FIGURE
I _{DD}	Supply current	vs Junction temperature	14
rDS(on)	Static drain-source on-state resistance, 3-V switch	vs Junction temperature	15
rDS(on)	Static drain-source on-state resistance, 5-V switch	vs Junction temperature	16
rDS(on)	Static drain-source on-state resistance, 12-V switch	vs Junction temperature	17
V _{O(xVCC)}	Output voltage, 5-V switch	vs Output current	18
VO(xVCC)	Output voltage, 3-V switch	vs Output current	19
хV _{pp}	Output voltage, V _{pp} switch	vs Output current	20
ISC(xVCC)	Short-circuit current, 5-V switch	vs Junction temperature	21
ISC(xVPP)	Short-circuit current, 12-V switch	vs Junction temperature	22

SUPPLY CURRENT

vs JUNCTION TEMPERATURE

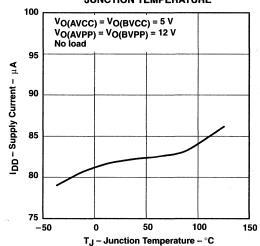


Figure 14

TYPICAL CHARACTERISTICS†

3-V SWITCH STATIC DRAIN-SOURCE ON-STATE RESISTANCE

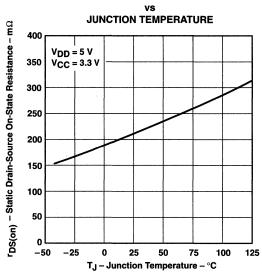


Figure 15

12-V SWITCH STATIC DRAIN-SOURCE ON-STATE RESISTANCE

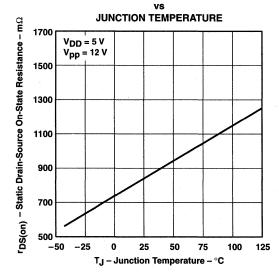
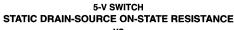


Figure 17



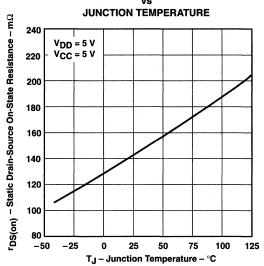


Figure 16

5-V SWITCH OUTPUT VOLTAGE

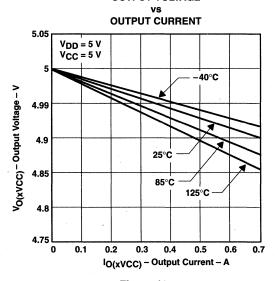
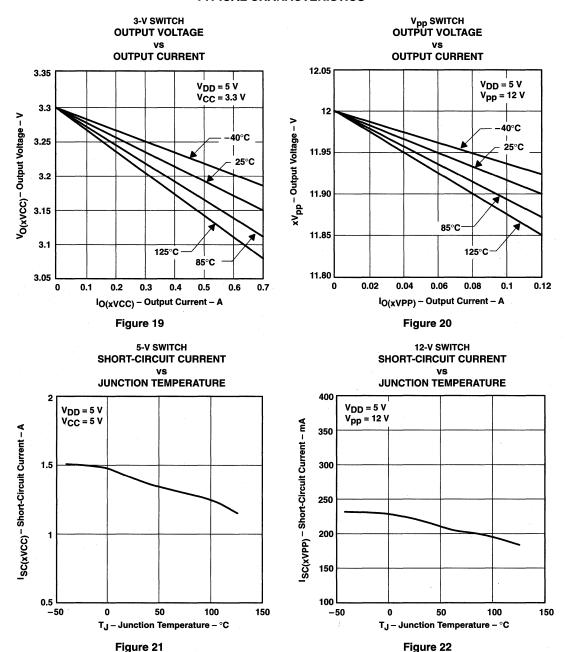


Figure 18

t = pulse tested



TYPICAL CHARACTERISTICS[†]



t = pulse tested

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APPLICATION INFORMATION

overview

PC Cards were initially introduced as a means to add EEPROM (flash memory) to portable computers with limited on-board memory. The idea of add-in cards quickly took hold: modems, wireless LANs, GPS systems, multimedia, and hard-disk versions were soon available. As the number of PC Card applications grew, the engineering community quickly recognized the need for a standard to ensure compatibility across platforms. To this end, the PCMCIA (Personal Computer Memory Card International Association) was established and was comprised of members from leading computer, software, PC card, and semiconductor manufacturers. One key goal was to realize the concept of plug and play – cards and hosts from different vendors should be compatible and able to communicate with one another transparently.

PC Card power specification

System compatibility also means power compatibility. The most current set of specifications (PC Card Standard) set forth by the PCMCIA committee states that power is to be transferred between the host and the card through eight of the PC Card connector's 68 pins. This power interface consists of two V_{CC} , two V_{pp} , and four ground pins. Multiple V_{CC} and ground pins are used to minimize connector-pin and line resistance. The two V_{pp} pins were originally specified as separate signals but are commonly tied together in the host to form a single node to minimize voltage losses. Card primary power is supplied through the V_{CC} pins; flash-memory programming and erase voltage is supplied through the V_{pp} pins. As each pin is rated to 0.5 A, V_{CC} and V_{pp} can theoretically supply up to 1 A, assuming equal pin resistance and no pin failure. A conservative design would limit current to 500 mA. Some applications, however, require higher V_{CC} currents; disk drives, for example, may need as much as 750-mA peak current to create the initial torque necessary to spin up the platter. V_{pp} currents, on the other hand, are defined by flash-memory programming requirements, typically under 120 mA.

future power trends

The 1-A physical-pin current alluded to in the PC Card specification has caused some host-system engineers to believe they are required to deliver 1 A within the voltage tolerance of the card. Future applications, such as RF cards, could use the extra power for their radio transmitters. The 5 W required for these cards will require very robust power supplies and special cooling considerations. The limited number of host sockets that will be able to support them makes the market for these high-powered PC Cards uncertain. The vast majority of the cards require less than 600 mA continuous current and the trend is towards even lower-powered PC Cards that will assure compatibility with a greater number of host systems. Recognizing the need for power derating, an adhoc committee of the PCMCIA is currently working to limit the amount of steady-state dc current to the PC Card to something less than the currently implied 1 A. If a system is designed to support 1 A, then the switch rDS(on), power supply requirements, and PC Card cooling need to be carefully considered.

designing around 1-A delivery

Delivering 1 A means minimizing voltage (and power) losses across the PC Card power interface, which requires that designers trade off switch resistance and the cost associated with large-die (low $r_{DS(on)}$) MOSFET transistors. The PC Card standard requires that 5 V $\pm 5\%$, or 3.3 V ± 0.3 V be supplied to the card. The approximate 10% tolerance for the 3.3-V supply makes the 3.3-V $r_{DS(on)}$ less critical than the 5-V switch. A conservative approach is to allow 2% for voltage-regulator tolerance and 1% for etch- and terminal-resistance drops, which leaves 2% (100 mV) voltage drop for the 5-V switch, and at least 6% (198 mV) for the 3.3-V switch.

Calculating the $r_{DS(on)}$ necessary to support a 100 mV or 198 mV switch loss, using R = E/I and setting I = 1 A, the 5-V and 3.3-V switches would need to be 100 m Ω and 198 m Ω respectively. One solution would be to pay for a more expensive switch with lower $r_{DS(on)}$. A second, less expensive approach is to increase the headroom of the power supply–for example, to increase the 5-V supply 1.5% or to 5.075 $\pm 2\%$. Working through the numbers once more, the 2% for the regulator plus 1 % for etch and terminal losses leaves 97% or 4.923 V. The allowable



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designing around 1-A delivery (continued)

voltage loss across the power distribution switch is now 4.923 V minus 4.750 V or 173 mV. Therefore, a switch with 173 m Ω or less could deliver 1 A or greater. Setting the power supply high is a common practice for delivering voltages to allow for system switch, connector, and etch losses and has a minimal effect on overall battery life. In the example above, setting the power supply 1.5% high would only decrease a 3-hour battery life by approximately 2.7 minutes, trivial when compared with the decrease in battery life when running a 5-W PC Card.

heat dissipation

A greater concern in delivering 1 A or 5 W is the ability of the host to dissipate the heat generated by the PC Card. For desktop computers the solution is simpler: locate the PC Card cage such that it receives convection cooling from the forced air of the fan. Notebooks and other handheld equipment will not be able to rely on convection, but must rely on conduction of heat away from the PC Card through the rails into the card cage. This is difficult because PC Card/card cage heat transfer is very poor. A typical design scenario would require the PC Card to be held at 60°C maximum with the host platform operating as high as 50°C. Preliminary testing reveals that a PC Card can have a 20°C rise, exceeding the 10°C differential in the example, when dissipating less than 2 W of continuous power. The 60°C temperature was chosen because it is the maximum operating temperature allowable by PC Card specification. Power handling requirements and temperature rises are topics of concern and are currently being addressed by the PCMCIA committee.

overcurrent and over-temperature protection

PC Cards are inherently subject to damage that can result from mishandling. Host systems require protection against short-circuited cards that could lead to power supply or PCB-trace damage. Even systems sufficiently robust to withstand a short circuit would still undergo rapid battery discharge into the damaged PC Card, resulting in the rather sudden and unacceptable loss of system power. This can be particularly frustrating to the consumer who has already experienced problems with shortened battery life due to improper Nicad conditioning or memory effect. Most hosts include fuses for protection. The reliability of fused systems is poor, though, as blown fuses require troubleshooting and repair, usually by the manufacturer. The TPS2201 takes a two-pronged approach to overcurrent protection. First, instead of fuses, sense FETs monitor each of the power outputs. Excessive current generates an error signal that linearly limits the output current, preventing host damage or failure. Sense FETs, unlike sense resistors or polyfuses, have the added advantage that they do not add to the series resistance of the switch and thus produce no additional voltage losses. Second, when an overcurrent condition is detected, the TPS2201 asserts a signal at \overline{OC} that can be monitored by the microprocessor to initiate diagnostics and/or send the user a warning message. In the event that an overcurrent condition persists, causing the IC to exceed its maximum junction temperature, thermal-protection circuitry engages, shutting down all power outputs until the device cools to within a safe operating region.

12-V supply not required

Most PC Card switches use the externally supplied 12-V V_{pp} power for switch-gate drive and other chip functions, requiring that it be present at all times. The TPS2201 offers considerable power savings by using an internal charge pump to generate the required higher voltages from the 5-V V_{DD} supply; therefore, the external 12-V supply can be disabled except when needed for flash-memory functions, thereby extending battery lifetime. Additional power savings are realized by the TPS2201 during a software shutdown, in which quiescent current drops to a maximum of 1 μ A.

voltage transitioning requirement

PC Cards, like portables, are migrating from 5 V to 3.3 V to minimize power consumption, optimize board space, and increase logic speeds. The TPS2201 is designed to meet all combinations of power delivery as currently defined in the PCMCIA standard. The latest protocol accommodates mixed 3.3-V/5-V systems by first powering the card with 5 V, then polling it to determine its 3.3-V compatibility. The PCMCIA specification requires that the



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APPLICATION INFORMATION

voltage transitioning requirement (continued)

capacitors on 3.3-V compatible cards be discharged to below 0.8 V before applying 3.3-V power. This ensures that sensitive 3.3-V circuitry is not subjected to any residual 5-V charge and functions as a power reset. The TPS2201 offers a selectable V_{CC} and V_{PP} ground state, per PCMCIA 3.3-V/5-V switching specifications, to fully discharge the card capacitors while switching between V_{CC} voltages.

output ground switches

Several PCMCIA power-distribution switches on the market do not have an active-grounding FET switch. These devices do not meet the PC Card specification requiring a discharge of V_{CC} within 100 ms. PC Card resistance can not be relied on to provide a discharge path for voltages stored on PC Card capacitance because of possible high-impedance isolation by power-management schemes. A method commonly shown to alleviate this problem is to add to the switch output an external $100 \text{ k}\Omega$ resistor in parallel with the PC Card. Considering that this is the only discharge path to ground, a timing analysis will reveal that the RC time constant delays the required discharge time to over 2 seconds. The only way to ensure timing compatibility with PC Card standards is to use a power-distribution switch that has an internal ground switch, like that of the TPS22xx family, or add an external ground FET to each of the output lines with the control logic necessary to select it.

In summary, the TPS2201 is a complete single-chip dual-slot PC Card power interface. It meets all currently defined PCMCIA specifications for power delivery in 5-V, 3.3-V, and mixed systems, and offers a serial controller interface. The TPS2201 offers functionality, power savings, overcurrent and thermal protection, and fault reporting in one 30-pin SSOP surface-mount package for maximum value added to new portable designs.

power supply considerations

The TPS2201 has multiple terminals for each of its 3.3 V, 5 V, and 12 V power inputs and for the switched V_{CC} outputs. Any individual terminal can conduct the rated input or output current. Unless all terminals are connected in parallel, the series resistance is significantly higher than that specified, resulting in increased voltage drops and lost power. Both 12 V inputs must be connected for proper V_{pp} switching; it is recommended that all input and output power terminals be paralleled for optimum operation. The V_{DD} input lead must be connected to the 5V input leads.

Although the TPS2201 is fairly immune to power input fluctuations and noise, it is generally considered good design practice to bypass power supplies typically with a 1-µF electrolytic or tantalum capacitor paralleled by a 0.047- μ F to 0.1- μ F ceramic capacitor. It is strongly recommended that the switched V_{CC} and V_{pp} outputs be bypassed with a 0.1-µF or larger capacitor; doing so improves the immunity of the TPS2201 to electrostatic discharge (ESD). Care should be taken to minimize the inductance of PCB traces between the TPS2201 and the load. High switching currents can produce large negative-voltage transients, which forward biases substrate diodes, resulting in unpredictable performance.

The TPS2201, unlike other PC Card power-interface switches, does not use the 12-V power supply for switching or other chip functions. Instead, an internal charge pump generates the necessary voltage from V_{DD} , allowing the 12-V input supply to be shut down except when the $V_{
m DD}$ programming or erase voltage is needed. Careful system design making use of this feature reduces power consumption and extends battery lifetime.

The 3.3-V power input should not be taken higher than the 5-V input. Doing so, though nondestructive, results in high current flow into the device, and could result in abnormal operation. In any case, this occurrence indicates a malfunction of one input voltage or both, which should be investigated.

Similarly, no terminal should be taken below -0.3 V; forward biasing the parasitic-substrate diode results in substrate currents and unpredictable performance.



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overcurrent and thermal protection

The TPS2201 uses sense FETs to check for overcurrent conditions in each of the V_{CC} and V_{pp} outputs. Unlike sense resistors or polyfuses, these FETs do not add to the series resistance of the switch; therefore, voltage and power losses are reduced. Overcurrent sensing is applied to each output separately. When an overcurrent condition is detected, only the power output affected is limited; all other power outputs continue to function normally. The \overline{OC} indicator, normally a logic high, is a logic low when any overcurrent condition is detected, providing for initiation of system diagnostics and/or sending a warning message to the user.

During power up, the TPS2201 controls the rise time of the V_{CC} and V_{pp} outputs and limits the current into a faulty card or connector. If a short circuit is applied after power is established (e.g., hot insertion of a bad card), current is initially limited only by the impedance between the short and the power supply. In extreme cases, as much as 10 A to 15 A may flow into the short before the current limiting of the TPS2201 engages. If the V_{CC} or V_{pp} outputs are driven below ground, the TPS2201 may latch nondestructively in an off state. Cycling power will reestablish normal operation.

Overcurrent limiting for the V_{CC} outputs is designed to engage if powered up into a short in the range of 0.75 A to 1.9 A, typically at about 1.3 A; the V_{pp} outputs limit from 120 mA to 400 mA, typically around 200 mA. The protection circuitry acts by linearly limiting the current passing through the switch, rather than initiating a full shutdown of the supply. Shutdown occurs only during thermal limiting.

Thermal limiting prevents destruction of the IC from overheating when the package power-dissipation ratings are exceeded. Thermal limiting, disables all power outputs (both A and B slots) until the device has cooled.

calculating junction temperature

The switch resistance, $r_{DS(on)}$, is dependent on the junction temperature, T_J , of the die. The junction temperature is dependent on both $r_{DS(on)}$ and the current through the switch. To calculate T_J , first find $r_{DS(on)}$ from Figures 16, 17, and 18 using an initial temperature estimate about 50°C above ambient. Then calculate the power dissipation for each switch, using the formula:

$$P_D = r_{DS(on)} \cdot I^2$$

Next, sum the power dissipation and calculate the junction temperature:

$$T_{J} = (\Sigma P_{D} \cdot R_{\theta, JA}) + T_{A}, R_{\theta, JA} = 108^{\circ}C/W$$

Compare the calculated junction temperature with the initial temperature estimate. If they are not within a few degrees of each other, reiterate using the calculated temperature as the initial estimate.

logic input and outputs

The TPS2201 was designed to be compatible with most popular PCMCIA controllers and current PCMCIA and JEIDA standards. However, some controllers require slightly counterintuitive connections to achieve desired output states. The TPS2201 control logic inputs A_VCC3, A_VCC5, B_VCC3 and B_VCC5 are defined active low (see Figure 23 and control-logic table). As such, they are directly compatible with the Cirrus Logic CL-PD6720 controller's logic outputs (see Figure 24). The TPS2201 separate V_{pp} power good indicators can be ORed together to provide a single input to the Cirrus controller.

APPLICATION INFORMATION

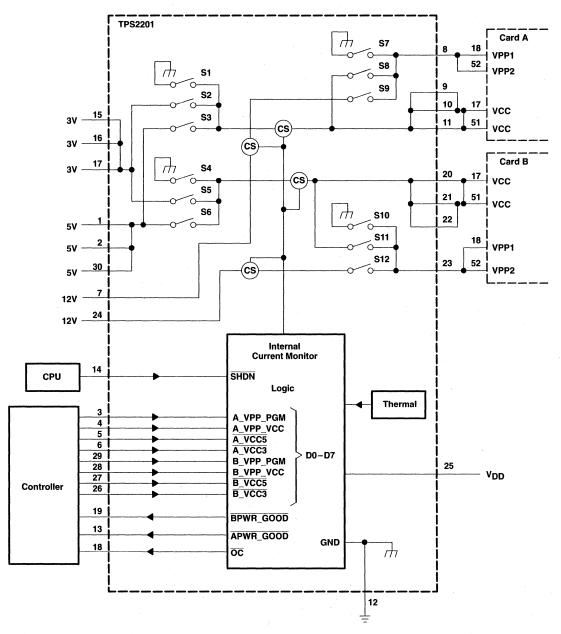


Figure 23. Internal Switching Matrix



TPS2201, TPS2201Y DUAL-SLOT PC CARD POWER-INTERFACE SWITCHES FOR PARALLEL PCMCIA CONTROLLERS SLVS094B - AUGUST 1994 - REVISED AUGUST 1995

APPLICATION INFORMATION

TPS2201 control logic

AVPP

CONTROL SIGNALS			INTE	OUTPUT		
SHDN	A_VPP_PGM	A_VPP_VCC	S7 S8 S9		VAVPP	
1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	vcc†
1	1	0	OPEN	OPEN	CLOSED	VPP(12 V)
1	1	1	OPEN	OPEN	OPEN	Hi-Z
0	X	Х	OPEN	OPEN	OPEN	Hi-Z

BVPP

	CONTROL SIGNALS	3	INTER	OUTPUT		
SHDN	B_VPP_PGM	B_VPP_VCC	S10	S11	S12	VBVPP
. 1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	vcc‡
<u>.</u> 1	1	0	OPEN	OPEN	CLOSED	VPP(12 V)
. 1	1	1	OPEN	OPEN	OPEN	Hi-Z
0	Х	Х	OPEN	OPEN	OPEN	Hi-Z

AVCC

CONTROL SIGNALS			INTER	INTERNAL SWITCH SETTINGS			
SHDN	A_VCC3	A_VCC5	S1	S2	S3	VAVCC	
1	0	0	CLOSED	OPEN	OPEN	0 V	
1	0	1	OPEN	CLOSED	OPEN	3 V	
1	1	0	OPEN	OPEN	CLOSED	5 V	
1	1	1	CLOSED	OPEN	OPEN	0 V	
0	X	X	OPEN	OPEN	OPEN	Hi-7	

BVCC

CONTROL SIGNALS			INTER	OUTPUT		
SHDN	B_VCC3	B_VCC5	S4	S5	S6	VBVCC
1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	3 V
1	1	0	OPEN	OPEN	CLOSED	5 V
1	1	1	CLOSED	OPEN	OPEN	0 V
0	Х	Х	OPEN	OPEN	OPEN	Hi-Z

[†] Output depends on AVCC ‡ Output depends on BVCC

APPLICATION INFORMATION

logic input and outputs (continued)

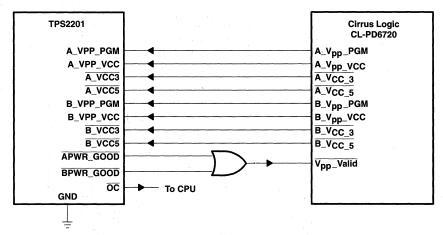


Figure 24. Logic Connections to CL-PD6720

Intel's 82365SLDF controller uses active-high control logic for V_{CC} selection, which requires connecting the 82365SLDF's 3-V control outputs (A_VCC_EN0, B_VCCEN0) to the TPS2201's 5-V control inputs (A_VCC5, B_VCC5) and the 5-V control outputs (AVCC_EN1, B_VCC_EN1) to the 3-V control inputs (A_VCC3, B_VCC3), as illustrated in Figure 25. Examination of the control logic tables on page 16 will confirm that these connections will in fact select the correct output voltage. An alternative approach would be to invert the Intel V_{CC} control logic signals before routing them to the TPS2201.

The separate V_{pp} power-good indicators of the TPS2201 can be connected directly to the Intel controller as shown in Figure 25.

Cirrus Logic defines a (1, 1) on the V_{CC} select lines to be the PC Card no connect state; Intel chose (0, 0) to select this state. As the tables show, either combination switches the V_{CC} outputs to 0 V. The decision to provide 0 V versus a high impedance for the no connect state eliminates potential charging at the switch-to-card interface. Feedback from the PC Card design community favors this approach.

 V_{pp} logic allows for 0-V or high-impedance output for no connect (0, 0) or reserved (1, 1) logic inputs, respectively (refer to AVPP and BVPP control-logic tables on page 16). Both the Cirrus Logic and Intel controllers interface directly with the V_{pp} control inputs of the TPS2201.

The shutdown input of the TPS2201, \overline{SHDN} , when held at a logic low places all V_{CC} and V_{pp} outputs in a high-impedance state and reduces chip quiescent current to 1 μA to conserve battery power.

An overcurrent output (\overline{OC}) is provided to indicate an overcurrent condition in any of the V_{CC} or V_{pp} supplies (see discussion above).

ESD protection

All TPS2201 inputs and outputs incorporate ESD-protection circuitry designed to withstand a 2-kV human-body-model discharge as defined in MIL-STD-883C. The V_{CC} and V_{pp} outputs can be exposed to potentially higher discharges from the external environment through the PC card connector. Bypassing the outputs with 0.1- μ F capacitors protects the devices from discharges up to 10 kV.



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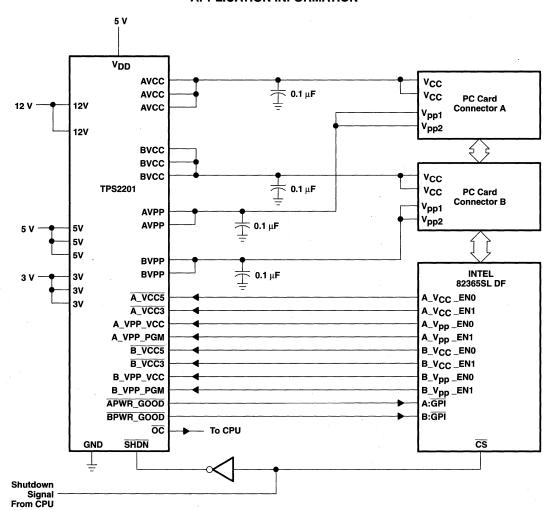
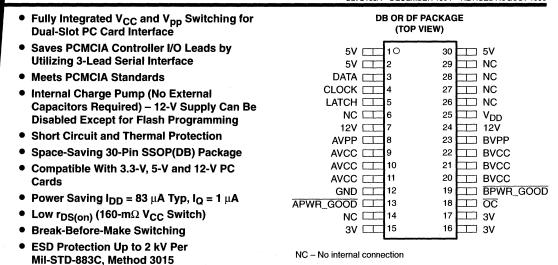


Figure 25. Detailed Operating Circuits Using Intel 82365SLDF Controller

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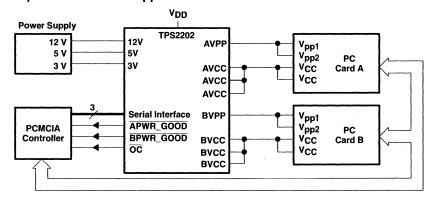


description

The TPS2202 PC Card (PCMCIA) power-interface switch provides an integrated power-management solution for two PC Cards. All of the discrete power MOSFETs, a logic section, current limiting, thermal protection, and power-good reporting for PC Card control are combined on a single integrated circuit (IC), using Texas Instruments LinBiCMOS™ process. The circuit allows the distribution of 3-V, 5-V, and/or 12-V card power by means of a reduced I/O serial interface. The current-limiting feature eliminates the need for fuses, which reduces component count and improves reliability; current-limit reporting can help the user isolate a system fault to a bad card.

The TPS2202 maximizes battery life by using an internal charge pump to generate its own switch-drive voltage. Therefore, the 12-V supply can be powered down and only brought out of standby when flash memory needs to be written to or erased. End equipment for the TPS2202 includes notebook computers, desktop computers, personal digital assistants (PDAs), digital cameras, handiterminals, and bar-code scanners.

typical PC-card power-distribution application



LinBiCMOS is a trademark of Texas Instruments Incorporated.



TPS2202, TPS2202Y DUAL-SLOT PC CARD POWER-INTERFACE SWITCHES FOR SERIAL PCMCIA CONTROLLERS SLVS103A - DECEMBER 1994 - REVISED AUGUST 1995

AVAILABLE OPTIONS

	PACKAGE	CHIP FORM	ĺ	
ТЈ	SHINK SMALL-OUTLINE (DB)	SMALL-OUTLINE (DF)	(Y)	
-40°C to 150°C	TPS2202IDB	TPS2202IDF	TPS2202Y	ĺ

[†]The DF package is only available left-end taped and reeled (indicated by the LE suffix on the device type; e.g., TPS2202IDFLE).

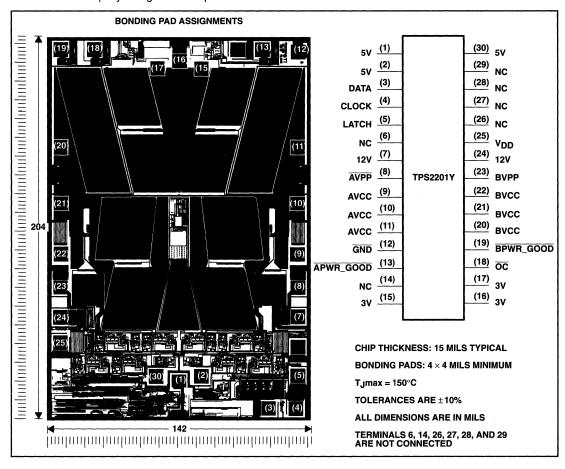
Terminal Functions

TERMI	TERMINAL		
NAME	NO.	1/0	DESCRIPTION
3V	15, 16, 17	I	3-V V _{CC} input for card power
5V	1, 2, 30	ı	5-V V _{CC} input for card power
12V	7, 24	1	12-V VPP input for card power
AVCC	9, 10, 11	0	Switched output that delivers 0 V, 3.3 V, 5 V, or high impedance
AVPP	8	0	Switched output that delivers 0 V, 3.3 V, 5 V, 12 V, or high impedance
APWR_GOOD	13	0	Logic-level power-ready output that stays low as long as AVPP is within limits.
BVCC	20, 21, 22	0	Switched output that delivers 0 V, 3.3 V, 5 V, or high impedance
BVPP	23	0	Switched output that delivers 0 V, 3.3 V, 5 V, 12 V, or high impedance
BPWR_GOOD	19	0	Logic-level power-ready output that stays low as long as BVPP is within limits.
CLOCK	4	1	Logic-level clock for serial data word
DATA	3	1	Logic-level serial data word
GND	12		Ground
LATCH	5	1	Logic-level latch for serial data word
NC	6, 14, 26, 27, 28, 29		No internal connection
<u>oc</u>	18	0	Logic-level overcurrent reporting output that goes low when an overcurrent condition exists.
V _{DD}	25		5-V power to chip

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TPS2202Y chip information

This chip, when properly assembled, displays characteristics similar to the TPS2202. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{DD} 0.3 V to 7 V
Input voltage range for card power: V _{I(5V)} 0.3 V to 7 V
V _{l(3V)}
V _{I(12V)} –0.3 V to 14 V
Logic input voltage ————————————————————————————————————
Continuous total power dissipation
Output current (each card): IO(XVCC) internally limited
IO(xvPP) internally limited
Operating virtual junction temperature range, T _J
Operating free-air temperature range, T _A
Storage temperature range, T _{stg} –55°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR‡ ABOVE TA = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
DB	1024 mW	8.2 mW/°C	655 mW	532 mW
DF	1158 mW	9.26 mW/°C	741 mW	602 mW

^{*} Maximum values are calculated using a derating factor based on R_{0JA} = 108°C/W for the package. These devices are mounted on an FR4 board with no special thermal considerations.

recommended operating conditions

			MIN	MAX	UNIT
Supply voltage, V _{DD}			4.75	5.25	٧
	V _{I(5V)}		0	5.25	٧
Input voltage range, V _I	V _{I(3V)}		0	ν _{I(5V)} †	V
	V _{I(12V)}		0	13.5	٧
Output current, IO	IO(xVCC) at 25°C			1	Α
Output current, 10	IO(xVPP) at 25°C			1 150	mA
Clock frequency, fclock			0	2.5	MHz
Operating virtual junction tempera	ture, Tj		-40	125	°C

 $[\]dagger V_{I(3V)}$ should not be taken above $V_{I(5V)}$.

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electrical characteristics, $T_A = 25^{\circ}C$, $V_{DD} = 5 \text{ V}$ (unless otherwise noted) dc characteristics

PARAME	TED	TEST CONDITIONS	TPS2202			UNIT
PARAME	IICN	TEST CONDITIONS	MIN	TYP	MAX	ONII
	5 V to xVCC				160	mΩ
	3 V to xVCC				225	msz
Switch resistances†	5 V to xVPP				6	
	3 V to xVPP				6	Ω
	12 V to xVPP				1	
Clamp low voltage		Ipp at 10 mA			0.8	٧
Clamp low voltage		ICC at 10 mA			0.8	٧
	Ipp High-impedance state	T _A = 25°C		1	10	μА
Laskana sumant		T _A = 85°C			50	
Leakage current	ICC High-impedance state	T _A = 25°C		1	10	
		T _A = 85°C			50	
January 1997	IDD	VO(AVCC) = VO(BVCC) = 5 V, VO(AVPP) = VO(BVPP) = 12 V		83	150	μΑ
Input current	I _{DD} in shutdown	$V_{O(BVCC)} = V_{O(AVCC)} = V_{O(AVPP)}$ = $V_{O(BVPP)} = high Z$			1	μА
Power-ready threshold, PWR_GOOD			10.72	11.05	11.4	٧
Power-ready hysteresis, PWR_GOOD (12-V mode)				50		mV
Ob and almost a subset of a summer districts	lo(xVCC)	T,j = 85°C,	0.75	1.3	1.9	Α
Short-circuit output-current limit	I _{O(xVPP)}	Output powered up into a short to GND	120	200	400	mA

[†] Pulse-testing techniques maintain junction temperature close to ambient temperature; thermal effects must be taken into account separately.

switching characteristics‡

	DADAMETED	TEST COMPLETION	TPS2202			UNIT		
	PARAMETER	TEST CONDITION	MIN	TYP	MAX	ONII		
Γ.	Output rise time	VO(xVCC)	VO(xVCC)				ms	
Γr	Output rise time	V _{O(x} VPP)			5			
١,,	Output fall time	VO(xVCC)		10			ms	
L"	Output fail time	V _{O(x} VPP)	O(xVPP)		14			
		LATCH↑ to VO(xVPP)	ton		5.8		ms	
ľ			toff		18		1115	
١	Propagation delay (see Figure 1\$)	LATCH [↑] to xVCC (3 V)	ton		5.8		ms	
t _{pd}	Propagation delay (see Figure 13)	LATCHT to XVCC (3 V)	toff		28		1115	
1		LATCH↑ to xVCC (5 V)	ton		4		ms	
		LATOTT TO XVCC (5 V)	toff		30			

[‡] Refer to Parameter Measurement Information

[§] Propagation delays are with $C_L = 100 \mu F$.

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electrical characteristics, T_A = 25°C, V_{DD} = 5 V (unless otherwise noted) (continued)

logic section

PARAMETER	TEST CONDITIONS	TPS2202		UNIT
PARAMETER	TEST CONDITIONS	MIN MAX		
Logic input current			1	μА
Logic input high level		2.7		٧
Logic input low level			0.8	٧
Logic output high level	In 1 mA	V _{DD} -0.4		٧
Logic output low level	I _O = 1 mA		0.4	٧

dc characteristics

54	DAMETER	TEST COMPLETIONS	TPS2202Y MIN TYP MA		1	UNIT
PA	RAMETER	TEST CONDITIONS			MAX	
Lackage summent	Ipp High-impedance sta	ate		1		
Leakage current	I _{CC} High-impedance sta	ate		1		μΑ
Input current	IDD	V _O (AVCC) = V _O (BVCC) = 5 V, V _O (AVPP) = V _O (BVPP) = 12 V		83		μА
Power-ready threshold, PW	R_GOOD			11.05		٧
Power-ready hysteresis, PV	VR_GOOD (12-V mode)			50		mV

switching characteristics†

PARAMETER		TEST COMPLETIONS		TPS2202Y			
İ	PARAMETER	TEST CONDITION	TEST CONDITIONS		TYP	MAX	UNIT
	Output rice time	VO(xVCC)			1.2		ms
Tr Output lise time		V _{O(x} VPP)		5			IIIS
Γ.	Output fall time	VO(xVCC)		V _{O(xVCC)}	10		mo
4	t _f Output fall time			14			ms
		LATOUT 40 V	ton		5.8		mo
ĺ		LATCH↑ to V _{O(xVPP)}	toff		18		ms
١	Propagation delay (see Figure 1 [‡])	LATCH↑ to xVCC	ton		5.8		ms
^t pd		LATCH 1 to XVCC	toff		28		1115
		LATCH↑ to xVCC	ton		4		mo
		LATOHT TO XVCC	toff		30		ms

[†] Refer to Parameter Measurement Information

[‡] Propagation delays are with $C_L = 100 \mu F$.

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PARAMETER MEASUREMENT INFORMATION

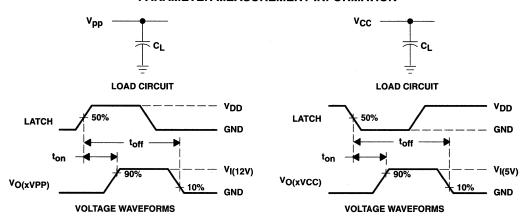
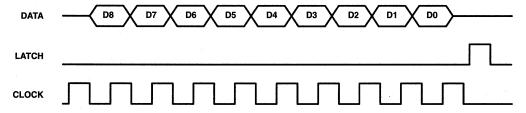


Figure 1. Test Circuits and Voltage Waveforms

Table of Timing Diagrams

	FIGURE
Serial-Interface Timing	2
xVCC Propagation Delay and Rise Times With 1-μF Load, 3-V Switch	3
xVCC Propagation Delay and Fall Times With 1-μF Load, 3-V Switch	4
xVCC Propagation Delay and Rise Times With 100-μF Load, 3-V Switch	5
xVCC Propagation Delay and Fall Times With 100-μF Load, 3-V Switch	6
xVCC Propagation Delay and Rise Times With 1-μF Load, 5-V Switch	7
xVCC Propagation Delay and Fall Times With 1-μF Load, 5-V Switch	- 8
xVCC Propagation Delay and Rise Times With 100-μF Load, 5-V Switch	9
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xVPP Propagation Delay and Rise Times With 1-μF Load, 12-V Switch	11
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xVPP Propagation Delay and Rise Times With 100-μF Load, 12-V Switch	13
xVPP Propagation Delay and Fall Times With 100-μF Load, 12-V Switch	14



NOTE A. Data is clocked in on the a positive leading edge of the clock. The latch should occur before next positive leading edge of the clock. For definition of D0-D8, see control logic table.

Figure 2. Serial-Interface Timing



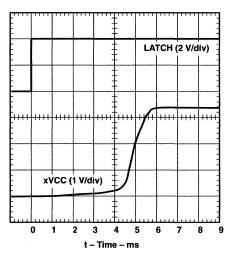


Figure 3. xVCC Propagation Delay and Rise Times With 1-µF Load, 3-V Switch

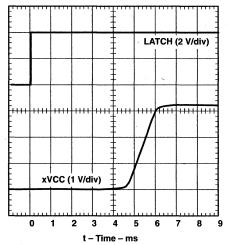


Figure 5. xVCC Propagation Delay and Rise Times With 100-µF Load, 3-V Switch

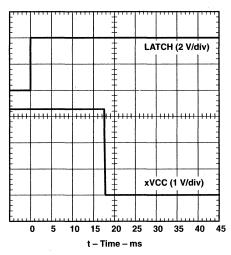


Figure 4. xVCC Propagation Delay and Fall Times With 1-µF Load, 3-V Switch

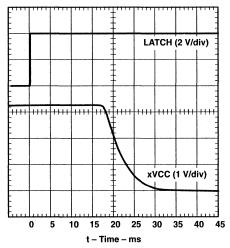


Figure 6. xVCC Propagation Delay and Fall Times With 100-µF Load, 3-V Switch

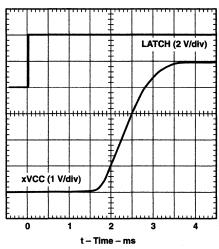


Figure 7. xVCC Propagation Delay and Rise Times With 1-uF Load, 5-V Switch

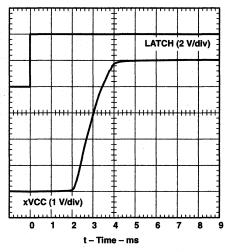


Figure 9. xVCC Propagation Delay and Rise Times With 100-µF Load, 5-V Switch

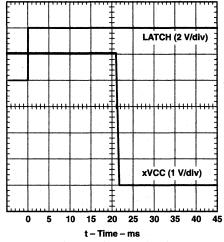


Figure 8. xVCC Propagation Delay and Fall Times With 1-µF Load, 5-V Switch

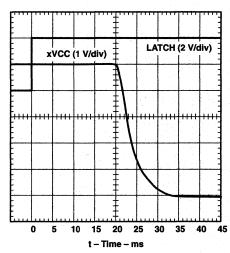


Figure 10. xVCC Propagation Delay and Fall Times With 100-µF Load, 5-V Switch

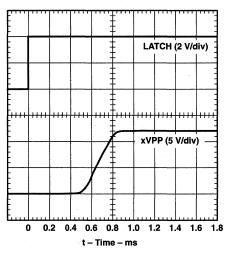


Figure 11. xVPP Propagation Delay and Rise Times With 1-μF Load, 12-V Switch

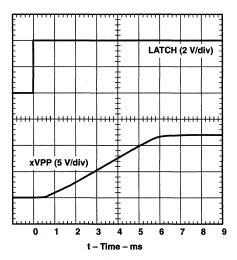


Figure 13. xVPP Propagation Delay and Rise Times With 100- μ F Load, 12-V Switch

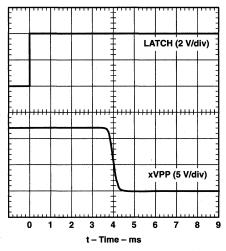


Figure 12. xVPP Propagation Delay and Fall Times With 1-μF Load, 12-V Switch

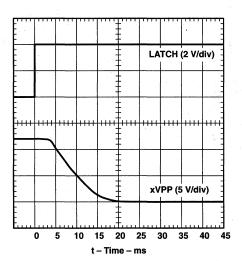


Figure 14. xVPP Propagation Delay and Fall Times With 100-μF Load, 12-V Switch

TYPICAL CHARACTERISTICS†

Table of Graphs

			FIGURE
IDD	Supply current	vs Junction temperature	15
rDS(on)	Static drain-source on-state resistance, 3-V switch	vs Junction temperature	16
rDS(on)	Static drain-source on-state resistance, 5-V switch	vs Junction temperature	17
rDS(on)	Static drain-source on-state resistance, 12-V switch	vs Junction temperature	18
V _{O(x} VCC)	Output voltage, 5-V switch	vs Output current	19
V _{O(xVCC)}	Output voltage, 3-V switch	vs Output current	- 20
хV _{pp}	Output voltage, V _{pp} switch	vs Output current	21
ISC(xVCC)	Short-circuit current, 5-V switch	vs Junction temperature	22
ISC(xVPP)	Short-circuit current, 12-V switch	vs Junction temperature	23

SUPPLY CURRENT JUNCTION TEMPERATURE

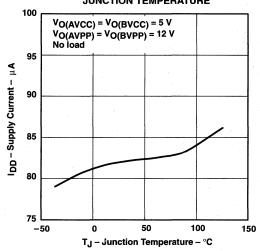


Figure 15

TYPICAL CHARACTERISTICS[†]

3-V SWITCH STATIC DRAIN-SOURCE ON-STATE RESISTANCE

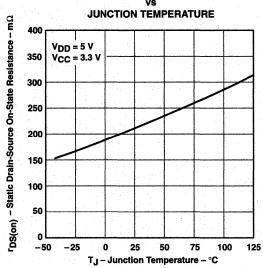


Figure 16

12-V SWITCH STATIC DRAIN-SOURCE ON-STATE RESISTANCE

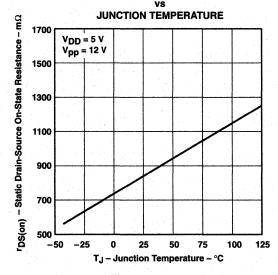


Figure 18

5-V SWITCH STATIC DRAIN-SOURCE ON-STATE RESISTANCE

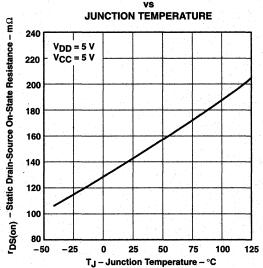


Figure 17

5-V SWITCH **OUTPUT VOLTAGE**

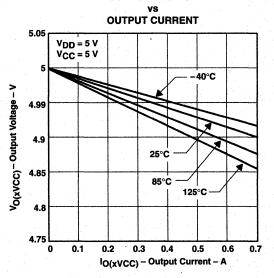
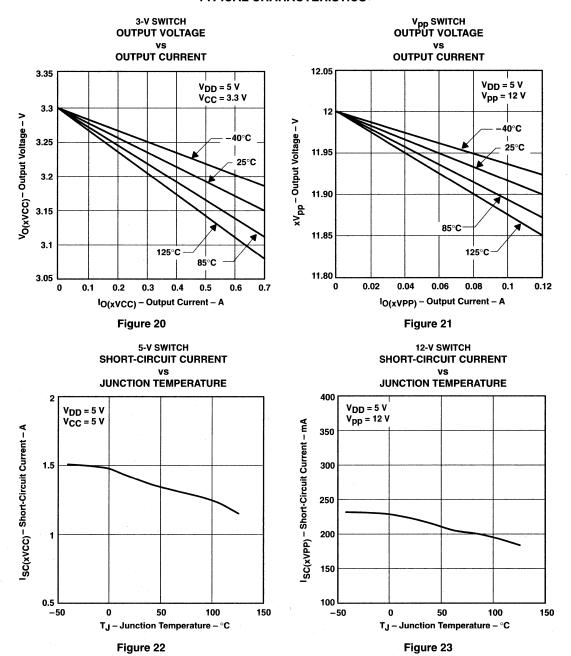


Figure 19

†t = pulse tested



TYPICAL CHARACTERISTICS[†]



† t = pulse tested

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APPLICATION INFORMATION

overview

PC Cards were initially introduced as a means to add EEPROM (flash memory) to portable computers with limited on-board memory. The idea of add-in cards quickly took hold: modems, wireless LANs, GPS systems, multimedia, and hard-disk versions were soon available. As the number of PC Card applications grew, the engineering community quickly recognized the need for a standard to ensure compatibility across platforms. To this end, the PCMCIA (Personal Computer Memory Card International Association) was established and was comprised of members from leading computer, software, PC card, and semiconductor manufacturers. One key goal was to realize the concept of plug and play - cards and hosts from different vendors should be compatible and able to communicate with one another transparently.

PC Card power specification

System compatibility also means power compatibility. The most current set of specifications (PC Card Standard) set forth by the PCMCIA committee states that power is to be transferred between the host and the card through eight of the PC Card connector's 68 pins. This power interface consists of two V_{CC} , two V_{pp} , and four ground pins. Multiple V_{CC} and ground pins minimize connector-pin and line resistance. The two V_{pp} pins were originally specified as separate signals but are commonly tied together in the host to form a single node to minimize voltage losses. Card primary power is supplied through the V_{CC} pins; flash-memory programming and erase voltage is supplied through the V_{DD} pins. As each pin is rated to 0.5 A, V_{CC} and V_{DD} can theoretically supply up to 1 A, assuming equal pin resistance and no pin failure. A conservative design would limit current to 500 mA. Some applications, however, require higher V_{CC} currents; disk drives, for example, may need as much as 750-mA peak current to create the initial torque necessary to spin up the platter. Vpp currents, on the other hand, are defined by flash-memory programming requirements, typically under 120 mA.

future power trends

The 1-A physical-pin current alluded to in the PC Card specification has caused some host-system engineers to believe they are required to deliver 1 A within the voltage tolerance of the card. Future applications, such as RF cards, could use the extra power for their radio transmitters. The 5 W needed for these cards will require very robust power supplies and special cooling considerations. The limited number of host sockets that will be able to support them makes the market for these high-powered PC Cards uncertain. The vast majority of the cards require less than 600 mA continuous current and the trend is towards even lower-powered PC Cards that will assure compatibility with a greater number of host systems. Recognizing the need for power derating, an adhoc committee of the PCMCIA is currently working to limit the amount of steady-state dc current to the PC Card to something less than the currently implied 1 A. If a system is designed to support 1 A, then the switch r_{DS(on)}, power supply requirements, and PC Card cooling need to be carefully considered.

designing around 1-A delivery

Delivering 1 A means minimizing voltage (and power) losses across the PC Card power interface, which requires that designers trade off switch resistance and the cost associated with large-die (low rDS(on)) MOSFET transistors. The PC Card standard requires that 5 V ±5%, or 3.3 V ±0.3 V be supplied to the card. The approximate 10% tolerance for the 3.3-V supply makes the 3.3-V r_{DS(on)} less critical than the 5-V switch. A conservative approach is to allow 2% for voltage-regulator tolerance and 1% for etch- and terminal-resistance drops, which leaves 2% (100 mV) voltage drop for the 5-V switch, and at least 6% (198 mV) for the 3.3-V switch.

Calculating the r_{DS(on)} necessary to support a 100 mV or 198 mV switch loss, using R = E/I and setting I = 1 A, the 5-V and 3.3-V switches would need to be 100 m Ω and 198 m Ω respectively. One solution would be to pay for a more expensive switch with lower $r_{DS(on)}$. A second, less expensive approach is to increase the headroom of the power supply-for example, to increase the 5-V supply 1.5% or to 5.075 ±2%. Working through the numbers once more, the 2% for the regulator plus 1 % for etch and terminal losses leaves 97% or 4.923 V.



TPS2202, TPS2202Y DUAL-SLOT PC CARD POWER-INTERFACE SWITCHES FOR SERIAL PCMCIA CONTROLLERS

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designing around 1-A delivery (continued)

The allowable voltage loss across the power distribution switch is now 4.923 V minus 4.750 V or 173 mV. Therefore, a switch with 173 m Ω or less could deliver 1 A or greater. Setting the power supply high is a common practice for delivering voltages to allow for system switch, connector, and etch losses and has a minimal effect on overall battery life. In the example above, setting the power supply 1.5% high would only decrease a 3-hour battery life by approximately 2.7 minutes, trivial when compared with the decrease in battery life when running a 5-W PC Card.

heat dissipation

A greater concern in delivering 1 A or 5 W is the ability of the host to dissipate the heat generated by the PC Card. For desktop computers the solution is simpler: locate the PC Card cage such that it receives convection cooling from the forced air of the fan. Notebooks and other handheld equipment are not be able to rely on convection, but must rely on conduction of heat away from the PC Card through the rails into the card cage. This is difficult because PC Card/card cage heat transfer is very poor. A typical design scenario would require the PC Card to be held at 60°C maximum with the host platform operating as high as 50°C. Preliminary testing reveals that a PC Card can have a 20°C rise, exceeding the 10°C differential in the example, when dissipating less than 2 W of continuous power. The 60°C temperature was chosen because it is the maximum operating temperature allowable by PC Card specification. Power handling requirements and temperature rises are topics of concern and are currently being addressed by the PCMCIA committee.

overcurrent and over-temperature protection

PC Cards are inherently subject to damage that can result from mishandling. Host systems require protection against short-circuited cards that could lead to power supply or PCB-trace damage. Even systems sufficiently robust to withstand a short circuit would still undergo rapid battery discharge into the damaged PC Card, resulting in the rather sudden and unacceptable loss of system power. This can be particularly frustrating to the consumer who has already experienced problems with shortened battery life due to improper Nicad conditioning or memory effect. Most hosts include fuses for protection. The reliability of fused systems is poor, though, as blown fuses require troubleshooting and repair, usually by the manufacturer. The TPS2202 takes a two-pronged approach to overcurrent protection. First, instead of fuses, sense FETs monitor each of the power outputs. Excessive current generates an error signal that linearly limits the output current, preventing host damage or failure. Sense FETs, unlike sense resistors or polyfuses, have the added advantage that they do not add to the series resistance of the switch and thus produce no additional voltage losses. Second, when an overcurrent condition is detected, the TPS2202 asserts a signal at \overline{OC} that can be monitored by the microprocessor to initiate diagnostics and/or send the user a warning message. In the event that an overcurrent condition persists, causing the IC to exceed its maximum junction temperature, thermal-protection circuitry engages, shutting down all power outputs until the device cools to within a safe operating region.

12-V supply not required

Most PC Card switches use the externally supplied 12-V V_{pp} power for switch-gate drive and other chip functions, requiring that it be present at all times. The TPS2202 offers considerable power savings by using an internal charge pump to generate the required higher voltages from the 5-V V_{DD} supply; therefore, the external 12-V supply can be disabled except when needed for flash-memory functions, thereby extending battery lifetime. Additional power savings are realized by the TPS2202 during a software shutdown, in which quiescent current drops to a maximum of 1 μ A.

voltage transitioning requirement

PC Cards, like portables, are migrating from 5 V to 3.3 V to minimize power consumption, optimize board space, and increase logic speeds. The TPS2202 is designed to meet all combinations of power delivery as currently defined in the PCMCIA standard. The latest protocol accommodates mixed 3.3-V/5-V systems by first powering the card with 5 V, then polling it to determine its 3.3-V compatibility. The PCMCIA specification requires that the



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voltage transitioning requirement (continued)

capacitors on 3.3-V compatible cards be discharged to below 0.8 V before applying 3.3-V power. This ensures that sensitive 3.3-V circuitry is not subjected to any residual 5-V charge and functions as a power reset. The TPS2202 offers a selectable V_{CC} and V_{PP} ground state, in accordance with PCMCIA 3.3-V/5-V switching specifications, to fully discharge the card capacitors while switching between V_{CC} voltages.

output ground switches

Several PCMCIA power-distribution switches on the market do not have an active-grounding FET switch. These devices do not meet the PC Card specification requiring a discharge of V_{CC} within 100 ms. PC Card resistance can not be relied on to provide a discharge path for voltages stored on PC Card capacitance because of possible high-impedance isolation by power-management schemes. A method commonly shown to alleviate this problem is to add to the switch output an external 100 k Ω resistor in parallel with the PC Card. Considering that this is the only discharge path to ground, a timing analysis will reveal that the RC time constant delays the required discharge time to over 2 seconds. The only way to ensure timing compatibility with PC Card standards is to use a power-distribution switch that has an internal ground switch, like that of the TPS22xx family, or add an external ground FET to each of the output lines with the control logic necessary to select it.

In summary, the TPS2202 is a complete single-chip dual-slot PC Card power interface. It meets all currently defined PCMCIA specifications for power delivery in 5-V, 3.3-V, and mixed systems, and offers a serial controller interface. The TPS2202 offers functionality, power savings, overcurrent and thermal protection, and fault reporting in one 30-pin SSOP surface-mount package for maximum value added to new portable designs.

power supply considerations

The TPS2202 has multiple terminals for each of its 3.3 V, 5 V, and 12 V power inputs and for the switched $V_{\rm CC}$ outputs. Any individual terminal can conduct the rated input or output current. Unless all terminals are connected in parallel, the series resistance is significantly higher than that specified, resulting in increased voltage drops and lost power. Both 12 V inputs must be connected for proper V_{pp} switching; it is recommended that all input and output power terminals be paralleled for optimum operation. The VDD input lead must be connected to the 5V input leads.

Although the TPS2202 is fairly immune to power input fluctuations and noise, it is generally considered good design practice to bypass power supplies typically with a 1-µF electrolytic or tantalum capacitor paralleled by a 0.047-μF to 0.1-μF ceramic capacitor. It is strongly recommended that the switched V_{CC} and V_{pp} outputs be bypassed with a 0.1-µF or larger capacitor; doing so improves the immunity of the TPS2202 to electrostatic discharge (ESD). Care should be taken to minimize the inductance of PCB traces between the TPS2202 and the load. High switching currents can produce large negative-voltage transients, which forward biases substrate diodes, resulting in unpredictable performance.

The TPS2202, unlike other PC Card power-interface switches, does not use the 12-V power supply for switching or other chip functions. Instead, an internal charge pump generates the necessary voltage from V_{DD}, allowing the 12-V input supply to be shut down except when the V_{DD} programming or erase voltage is needed. Careful system design making use of this feature reduces power consumption and extends battery lifetime.

The 3.3-V power input should not be taken higher than the 5-V input. Doing so, though nondestructive, results in high current flow into the device, and could result in abnormal operation. In any case, this occurrence indicates a malfunction of one input voltage or both, which should be investigated.

Similarly, no terminal should be taken below -0.3 V; forward biasing the parasitic-substrate diode results in substrate currents and unpredictable performance.



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overcurrent and thermal protection

The TPS2202 uses sense FETs to check for overcurrent conditions in each of the V_{CC} and V_{pp} outputs. Unlike sense resistors or polyfuses, these FETs do not add to the series resistance of the switch; therefore, voltage and power losses are reduced. Overcurrent sensing is applied to each output separately. When an overcurrent condition is detected, only the power output affected is limited; all other power outputs continue to function normally. The \overline{OC} indicator, normally a logic high, is a logic low when any overcurrent condition is detected, providing for initiation of system diagnostics and/or sending a warning message to the user.

During power up, the TPS2202 controls the rise time of the V_{CC} and V_{pp} outputs and limits the current into a faulty card or connector. If a short circuit is applied after power is established (e.g., hot insertion of a bad card), current is initially limited only by the impedance between the short and the power supply. In extreme cases, as much as 10 A to 15 A may flow into the short before the current limiting of the TPS2202 engages. If the V_{CC} or V_{pp} outputs are driven below ground, the TPS2202 may latch nondestructively in an off state. Cycling power reestablishes normal operation.

Overcurrent limiting for the V_{CC} outputs is designed to engage if powered up into a short in the range of 0.75 A to 1.9 A, typically at about 1.3 A; the V_{pp} outputs limit from 120 mA to 400 mA, typically around 200 mA. The protection circuitry acts by linearly limiting the current passing through the switch, rather than initiating a full shutdown of the supply. Shutdown occurs only during thermal limiting.

Thermal limiting prevents destruction of the IC from overheating when the package power-dissipation ratings are exceeded. Thermal limiting, disables all power outputs (both A and B slots) until the device has cooled.

calculating junction temperature

The switch resistance, $r_{DS(on)}$, is dependent on the junction temperature, T_J , of the die. The junction temperature is dependent on both $r_{DS(on)}$ and the current through the switch. To calculate T_J , first find $r_{DS(on)}$ from Figures 16, 17, and 18 using an initial temperature estimate about 50°C above ambient. Then calculate the power dissipation for each switch, using the formula:

$$P_D = r_{DS(on)} \cdot I^2$$

Next, sum the power dissipation and calculate the junction temperature:

$$T_J = (\Sigma P_D \cdot R_{\theta JA}) + T_A, R_{\theta JA} = 108^{\circ}C/W$$

Compare the calculated junction temperature with the initial temperature estimate. If they are not within a few degrees of each other, reiterate using the calculated temperature as the initial estimate.

logic input and outputs

The serial interface consists of DATA, CLOCK, and LATCH leads. The data is clocked in on the positive leading edge of the clock (see Figure 2). The 9-bit (D0 through D8) serial data word is loaded during the positive edge of the latch signal. The latch signal should occur before the next positive leading edge of the clock.

The shutdown bit of the data word places all V_{CC} and V_{pp} outputs in a high-impedance state and reduces chip quiescent current to 1 μ A to conserve battery power.

The TPS2202 serial interface is designed to be compatible with serial-interface PCMCIA controllers and current PCMCIA and JEIDA standards.

An overcurrent output (\overline{OC}) is provided to indicate an overcurrent condition in any of the V_{CC} or V_{pp} outputs, as previously discussed.



APPLICATION INFORMATION

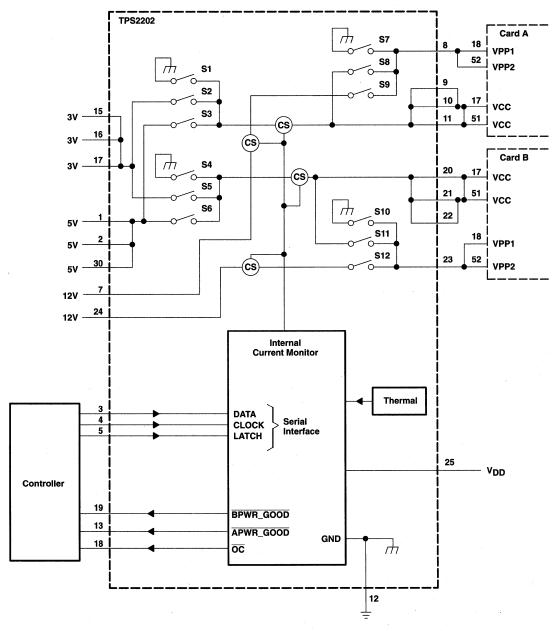


Figure 24. Internal Switching Matrix



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TPS2202 control logic

AVPP

CONTROL SIGNALS			INTER	OUTPUT		
D8 SHDN	D0 A_VPP_PGM	D1 A_VPP_VCC	S 7	S8	S9	VAVPP
1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	vcct
1	1	0	OPEN	OPEN	CLOSED	VPP(12 V)
1	1	1	OPEN	OPEN	OPEN	Hi-Z
0	Х	Х	OPEN	OPEN	OPEN	Hi-Z

BVPP

CONTROL SIGNALS			INTER	OUTPUT		
D8 SHDN	D4 B_VPP_PGM	D5 B_VPP_VCC	S10	S11	S12	VBVPP
1	0	0	CLOSED	OPEN	OPEN	0 V
- 1	0	1	OPEN	CLOSED	OPEN	vcc‡
1	1	0	OPEN	OPEN	CLOSED	VPP(12 V)
1	1	. 1	OPEN	OPEN	OPEN	Hi-Z
0	Х	Х	OPEN	OPEN	OPEN	Hi-Z

AVCC

	CONTROL SIGNALS	3	INTER	OUTPUT		
D8 SHDN	D3 A_VCC3	D2 A_VCC5	S1	S2	S3	VAVCC
1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	3 V
. 1 .	1	0	OPEN	OPEN	CLOSED	5 V
1	1	1	CLOSED	OPEN	OPEN	0 V
0	X	Х	OPEN	OPEN	OPEN	Hi-Z

BVCC

	CONTROL SIGNALS			INTERNAL SWITCH SETTINGS			
D8 SHDN	D6 B_VCC3	D7 B_VCC5	S4	S5	S6	VBVCC	
1	0	0	CLOSED	OPEN	OPEN	0 V	
1	0	1	OPEN	CLOSED	OPEN	3 V	
1	1	0	OPEN	OPEN	CLOSED	5 V	
1	1	1	CLOSED	OPEN	OPEN	0 V	
0	Х	X	OPEN	OPEN	OPEN	Hi-Z	

[†] Output depends on AVCC

ESD protection

All TPS2202 inputs and outputs incorporate ESD-protection circuitry designed to withstand a 2-kV human-body-model discharge as defined in MIL-STD-883C, Method 3015. The V_{CC} and V_{pp} outputs can be exposed to potentially higher discharges from the external environment through the PC Card connector. Bypassing the outputs with 0.1- μ F capacitors protects the devices from discharges up to 10 kV.



[‡] Output depends on BVCC

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APPLICATION INFORMATION

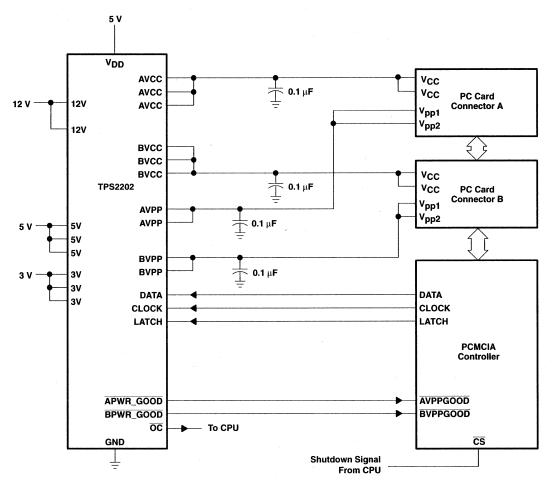


Figure 25. Detailed Interconnections and Capacitor Recommendations

TPS2202AI DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH RESET FOR SERIAL PCMCIA CONTROLLER

SLVS123 - SEPTEMBER 1995

 Fully Integrated V_{CC} and V_{pp} Switching for Dual-Slot PC Card™ Interface 	DF OR DB PACKAGE (TOP VIEW)			
 P²C[™] 3-Lead Serial Interface Compatible With CardBus[™] Controllers 	5V1O 5V2	30		
Meets PC Card Standards	DATA 🖂 3	28 NC		
 RESET Allows System Initialization of PC 	CLOCK4	27 NC		
Cards	LATCH5	26 NC		
12-V Supply Can Be Disabled Except	RESET 6	25 V _{DD}		
During 12-V Flash Programming	12V7	24 12V		
	AVPP ==== 8	23 BVPP		
 Short Circuit and Thermal Protection 	AVCC □□ 9	22 BVCC		
 Space-Saving 30-Pin SSOP (DB) Package 	AVCC 10	21 D BVCC		
 Compatible With 3.3-V, 5-V and 12-V PC 	AVCC 11	20 BVCC		
Cards	GND 🖂 12	19 BPWR_GOOD		
	APWR_GOOD 13	18 <u>OC</u>		
 Power Saving I_{DD} = 83 μA Typ, I_Q = 1 μA 	RESET 14	17 ==== 3.3V		
 Low r_{DS(on)} (160-mΩ V_{CC} Switch) 	3.3V15	16 3.3V		

NC - No internal connection

description

Break-Before-Make Switching

The TPS2202AI PC Card power-interface switch provides an integrated power-management solution for two PC Cards. All of the discrete power MOSFETs, a logic section, current limiting, thermal protection, and power-good reporting for PC Card control are combined on a single integrated circuit (IC), using the Texas Instruments LinBiCMOS™ process. The circuit allows the distribution of 3.3-V, 5-V, and/or 12-V card power by means of the P²C (PCMCIA Peripheral-Control) Texas Instruments nonproprietary serial interface. The current-limiting feature eliminates the need for fuses, which reduces component count and improves reliability. Current-limit reporting can help the user isolate a system fault to a specific card.

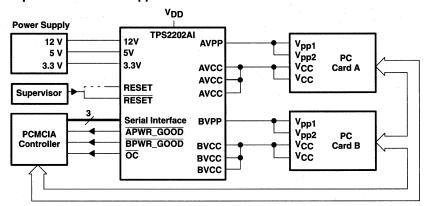
The TPS2202Al incorporates a reset function, selectable by one of two inputs, to help alleviate system errors. The reset function enables PC Card initialization concurrent with host platform initialization, allowing a system reset. Reset is accomplished by grounding the V_{CC} and V_{pp} (flash-memory programming voltage) outputs, which discharges residual card voltage.

End equipment for the TPS2202Al includes notebook computers, desktop computers, personal digital assistants (PDAs), digital cameras, handiterminals, and bar-code scanners. The TPS2202Al is only available taped and reeled (either TPS2202AIDFLE or TPS2202AIDBLE).

LinBiCMOS and P²C are trademarks of Texas Instruments Incorporated.
PC Card and CardBus are trademarks of PCMCIA (Personal Computer Memory Card International Association).



typical PC card power-distribution application



Terminal Functions

TERMINAL		1/0	DECODIDATION
NAME	NO.	1/0	DESCRIPTION
3.3V	15, 16, 17	ı	3.3-V V _{CC} input for card power
5V	1, 2, 30	I	5-V V _{CC} input for card power
12V	7, 24	1.	12-V V _{pp} input for card power
AVCC	9, 10, 11	0	Switched output that delivers 3.3 V, 5 V, low or high impedance to card
AVPP	8	0	Switched output that delivers 3.3 V, 5 V, 12 V, low or high impedance to card
APWR_GOOD	13	0	Logic-level power-ready output that stays low as long as AVPP is within limits
BVCC	20, 21, 22	0	Switched output that delivers 3.3 V, 5 V, low or high impedance
BVPP	23	0	Switched output that delivers 3.3 V, 5 V, 12 V, low or high impedance
BPWR_GOOD	19	0	Logic-level power-ready output that remains low as long as BVPP is within limits
CLOCK	4	1	Logic-level clock for serial data word
DATA	3	1	Logic-level serial data word
GND	12		Ground
LATCH	5	1.5	Logic-level latch for serial data word
NC	26, 27, 28, 29		No internal connection
<u>oc</u>	18	0	Logic-level overcurrent reporting output that goes low when an overcurrent condition exists
RESET	6	1	Logic-level RESET input active high. Do not connect if terminal 14 is used.
RESET	14	1	Logic-level RESET input active low. Do not connect if terminal 6 is used.
V_{DD}	25	1	5-V power to chip

TPS2202AI DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH RESET FOR SERIAL PCMCIA CONTROLLER

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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{DD}	
Input voltage range for card power: V _{I(5V)}	0.3 V to 7 V
	–0.3 V to V _{I(5V)}
V _{I(12V)}	–0.3 V to 14 V
Logic input voltage	–0.3 V to 7 V
Continuous total power dissipation	
Output current (each card): I _{O(xVCC)}	internally limited
	internally limited
Operating virtual junction temperature range, T _J	–40°C to 150°C
Operating free-air temperature range, T _A	
Storage temperature range, T _{stq}	–55°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR‡ ABOVE TA = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
DF	1158 mW	9.26 mW/°C	741 mW	602 mW
DB	1024 mW	8.2 mW/°C	655 mW	532 mW

[‡] These devices are mounted on an FR4 board with no special thermal considerations.

recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V _{DD}		4.75	5.25	V
	V _{I(5V)}	0	5.25	٧
Supply voltage, V _{DD} Input voltage range, V _I Output current Clock frequency	V _I (3.3V)	. 0	V _{I(5V)} §	V
	V _{I(12V)}	0	13.5	V
Output ourrant	IO(xVCC) at 25°C		. 1	Α
Output current	VI(5V)	150	mA	
Clock frequency		0	2.5	MHz
Operating virtual junction temperature, T _J		-40	125	°C

[§] V_{I(3.3V)} should not be taken above V_{I(5V)}.

TPS2202AI DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH RESET FOR SERIAL PCMCIA CONTROLLER

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electrical characteristics, $T_A = 25^{\circ}C$, $V_{DD} = 5 \text{ V}$ (unless otherwise noted)

dc characteristics

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
		5 V to xVCC				160	mΩ	
		3.3 V to xVCC				225	11152	
	Switch resistances†	5 V to xVPP				6		
		3.3 V to xVPP				6	Ω	
1 1		12 V to xVPP				1	7	
V _{O(xVPP)}	Clamp low voltage		I _{pp} at 10 mA			0.8	٧	
V _O (xVCC)	Clamp low voltage		ICC at 10 mA			0.8	V	
		I _{DD} High-impedance	T _A = 25°C		1	10		
		state		T _A = 85°C			50	
likg	Leakage current ICC High-impedance	T _A = 25°C		1	10	μА		
		state	T _A = 85°C			50		
	Innut our ont	IDD Supply current	VO(AVCC) = VO(BVCC) = 5 V, VO(AVPP) = VO(BVPP) = 12 V		83	150	μА	
11	Input current	I _{DD} Supply current in shutdown	$V_{O(BVCC)} = V_{O(AVCC)} = V_{O(AVPP)}$ = $V_{O(BVPP)} = Hi-Z$			1	μА	
	Power-ready threshold, PWR_GOOD			10.72	11.05	11.4	٧	
	Power-ready hysteresis, PWR_GOOD	12-V mode			50		mV	
	Short-circuit output-	IO(xVCC)	Т _J = 85°С,	0.75	1.3	1.9	Α	
	current limit	I _{O(xVPP)}	Output powered up into a short to GND	120	200	400	mA	

[†] Pulse-testing techniques are used to maintain junction temperature close to ambient temperature; thermal effects must be taken into account separately.

logic section

PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
Logic input current			1	μΑ
Logic input high level		2		V
Logic input low level			0.8	V
Logic output high level	1 - 1 - 1	V _{DD} -0.4		V
Logic output low level	I _O = 1 mA		0.4	V
Logic input minimum pulse width		1		μs

DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH RESET FOR SERIAL PCMCIA CONTROLLER

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switching characteristics†

	PARAMETER	TEST CONDITION	IS	MIN	TYP N	/AX	UNIT
	Output rise times	VO(xVCC)	VO(xVCC)				
tr	Output lise times	V _{O(x} VPP)		5			mo
٠.	Output fall times				10		ms
tf	Odiput fair times	V _{O(xVPP)}	14				
		LATOUT 1- W	ton		5.8		ms
		LATCH↑ to V _{O(xVPP)}	toff		18		ms
	Propagation delay (see Figure 1‡)	1.4TOUT	ton		5.8		ms
^t pd	Propagation delay (see Figure 1+)	LATCH↑ to xVCC (3 V)	toff		28		ms
		LATCH↑ to xVCC (5 V)	ton		4		ms
		LATORI (0 XVCC (5 V)	toff		30		ms

[†] Refer to Parameter Measurement Information

[‡] Propagation delays are with C_L = 100 μF .

PARAMETER MEASUREMENT INFORMATION

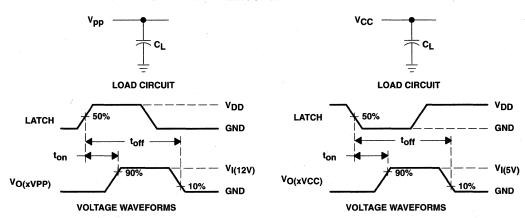
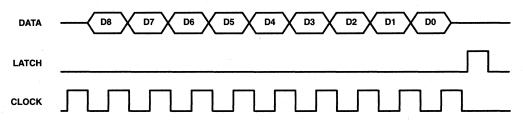


Figure 1. Test Circuits and Voltage Waveforms

Table of Timing Diagrams

	FIGURE
Serial-Interface Timing	2
xVCC Propagation Delay and Rise Time With 1-μF Load, 3.3-V Switch	3
xVCC Propagation Delay and Fall Time With 1-μF Load, 3.3-V Switch	4
xVCC Propagation Delay and Rise Time With 100-μF Load, 3.3-V Switch	5
xVCC Propagation Delay and Fall Time With 100-μF Load, 3.3-V Switch	6
xVCC Propagation Delay and Rise Time With 1-μF Load, 5-V Switch	7
xVCC Propagation Delay and Fall Time With 1-μF Load, 5-V Switch	8
xVCC Propagation Delay and Rise Time With 100-μF Load, 5-V Switch	9
xVCC Propagation Delay and Fall Time With 100-μF Load, 5-V Switch	10
xVPP Propagation Delay and Rise Time With 1-μF Load, 12-V Switch	11
xVPP Propagation Delay and Fall Time With 1-μF Load, 12-V Switch	12
xVPP Propagation Delay and Rise Time With 100-μF Load, 12-V Switch	13
xVPP Propagation Delay and Fall Time With 100-μF Load, 12-V Switch	14



NOTE A. Data is clocked in on the positive leading edge of the clock. The latch should occur before next positive leading edge of the clock. For definition of D0 to D8, see the control logic table.

Figure 2. Serial-Interface Timing



PARAMETER MEASUREMENT INFORMATION

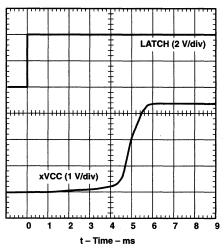


Figure 3. xVCC Propagation Delay and Rise Time With 1- μ F Load, 3.3-V Switch

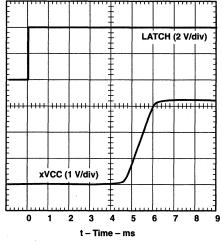


Figure 5. xVCC Propagation Delay and Rise Time With 100-µF Load, 3.3-V Switch

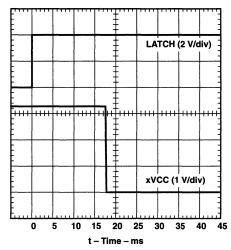


Figure 4. xVCC Propagation Delay and Fall Time With 1- μ F Load, 3.3-V Switch

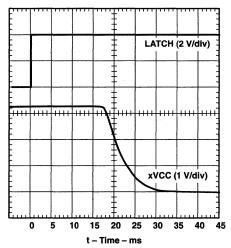


Figure 6. xVCC Propagation Delay and Fall Time With 100-µF Load, 3.3-V Switch

PARAMETER MEASUREMENT INFORMATION

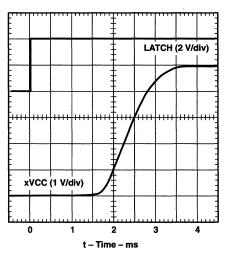


Figure 7. xVCC Propagation Delay and Rise Time With 1- μ F Load, 5-V Switch

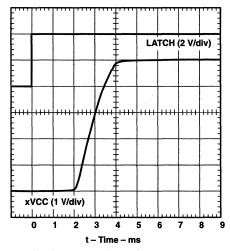


Figure 9. xVCC Propagation Delay and Rise Time With 100-μF Load, 5-V Switch

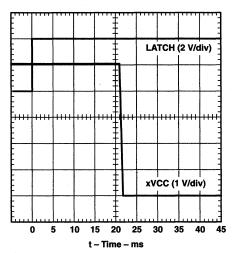


Figure 8. xVCC Propagation Delay and Fall Time With 1-μF Load, 5-V Switch

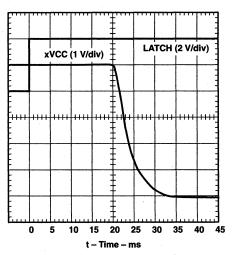


Figure 10. xVCC Propagation Delay and Fall Time With 100-μF Load, 5-V Switch

PARAMETER MEASUREMENT INFORMATION

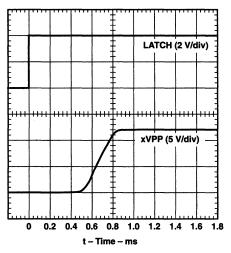


Figure 11. xVPP Propagation Delay and Rise Time With 1- μ F Load, 12-V Switch

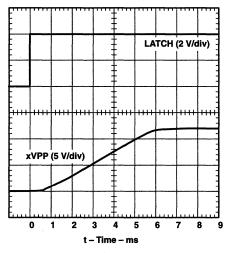


Figure 13. xVPP Propagation Delay and Rise Time With 100- μ F Load, 12-V Switch

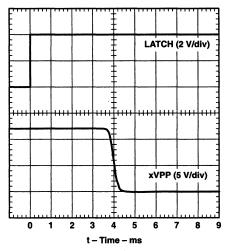


Figure 12. xVPP Propagation Delay and Fall Time With 1-µF Load, 12-V Switch

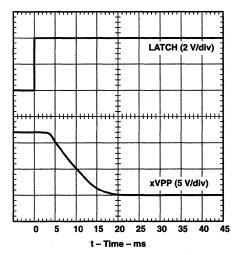


Figure 14. xVPP Propagation Delay and Fall Time With 100-μF Load, 12-V Switch

TYPICAL CHARACTERISTICS†

Table of Graphs

			FIGURE
IDD	Supply current	vs Junction temperature	15
rDS(on)	Static drain-source on-state resistance, 3-V switch	vs Junction temperature	16
rDS(on)	Static drain-source on-state resistance, 5-V switch	vs Junction temperature	17
rDS(on)	Static drain-source on-state resistance, 12-V switch	vs Junction temperature	18
VO(xVCC)	Output voltage, 5-V switch	vs Output current	19
VO(xVCC)	Output voltage, 3.3-V switch	vs Output current	20
xV _{pp}	Output voltage, V _{pp} switch	vs Output current	21
ISC(xVCC)	Short-circuit current, 5-V switch	vs Junction temperature	22
ISC(xVPP)	Short-circuit current, 12-V switch	vs Junction temperature	23

SUPPLY CURRENT

JUNCTION TEMPERATURE

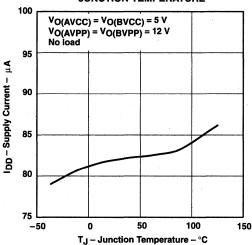


Figure 15

5-V SWITCH

STATIC DRAIN-SOURCE ON-STATE RESISTANCE **JUNCTION TEMPERATURE**

TYPICAL CHARACTERISTICS†

3.3-V SWITCH STATIC DRAIN-SOURCE ON-STATE RESISTANCE

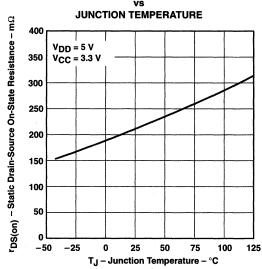


Figure 16

 $V_{DD} = 5 V$ V_{CC} = 5 V 220 200

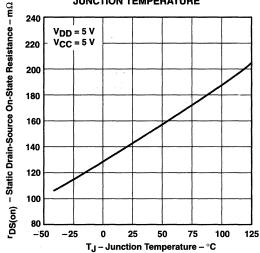


Figure 17

12-V SWITCH STATIC DRAIN-SOURCE ON-STATE RESISTANCE

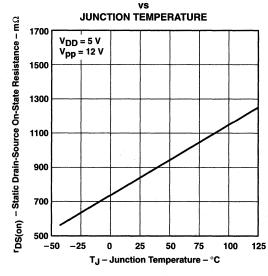


Figure 18

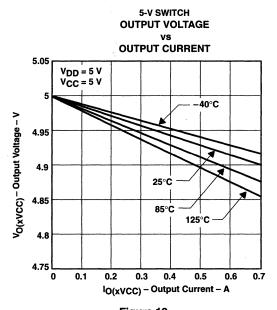
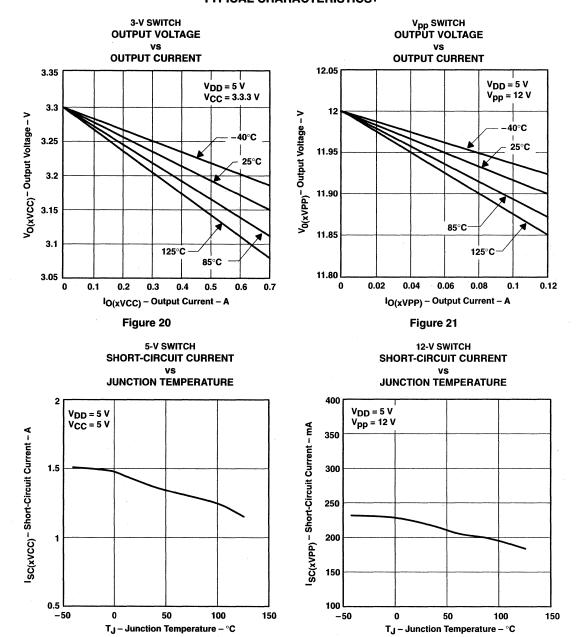


Figure 19

 $[\]dagger t = pulse tested$

TYPICAL CHARACTERISTICS†



t = pulse tested

Figure 22



Figure 23

APPLICATION INFORMATION

overview

PC Cards were initially introduced as a means to add EEPROM (flash memory) to portable computers with limited on-board memory. The idea of add-in cards quickly took hold; modems, wireless LANs, GPS systems, multimedia, and hard-disk versions were soon available. As the number of PC Card applications grew, the engineering community quickly recognized the need for a standard to ensure compatibility across platforms. To this end, the PCMCIA (Personal Computer Memory Card International Association) was established, comprised of members from leading computer, software, PC card, and semiconductor manufacturers. One key goal was to realize the "plug and play" concept. Cards and hosts from different vendors should be compatible – able to communicate with one another transparently.

PC Card power specification

System compatibility also means power compatibility. The most current set of specifications (PC Card Standard) set forth by the PCMCIA committee states that power is to be transferred between the host and the card through eight of the PC Card connector's 68 terminals. This power interface consists of two V_{CC} , two V_{pp} , and four ground terminals. Multiple V_{CC} and ground terminals minimize connector-terminal and line resistance. The two V_{pp} terminals were originally specified as separate signals but are commonly tied together in the host to form a single node to minimize voltage losses. Card primary power is supplied through the V_{CC} terminals; flash-memory programming and erase voltage is supplied through the V_{pp} terminals. As each terminal is rated to 0.5 A, V_{CC} and V_{pp} can theoretically supply up to 1 A, assuming equal terminal resistance and no terminal failure. A conservative design would limit current to 500 mA. Some applications, however, require higher V_{CC} currents. Disk drives, for example, may need as much as 750-mA peak current to create the initial torque necessary to spin up the platter. V_{pp} currents, on the other hand, are defined by flash-memory programming requirements, typically under 120 mA.

future power trends

The 1-A physical-terminal current alluded to in the PC Card specification has caused some host-system engineers to believe they are required to deliver 1 A within the voltage tolerance of the card. Future applications, such as RF cards, could use the extra power for their radio transmitters. The 5 W required for these cards require very robust power supplies and special cooling considerations. The limited number of host sockets that are able to support cards makes the market for these high-powered PC Cards uncertain. The vast majority of the cards require less than 600 mA continuous current and the trend is towards even lower powered PC Cards that assure compatibility with a greater number of host systems. Recognizing the need for power derating, an ad hoc committee of the PCMCIA is currently working to limit the amount of steady-state dc current to the PC Card to something less than the currently implied 1 A. When a system is designed to support 1 A, the switch $r_{DS(on)}$, power-supply requirements, and PC Card cooling need to be carefully considered.

designing around 1-A delivery

Delivering 1 A means minimizing voltage and power losses across the PC Card power interface, which requires that designers trade off switch resistance and the cost associated with large-die (low $r_{DS(on)}$) MOSFET transistors. The PC Card standard requires that 5 V $\pm 5\%$ or 3.3 V ± 0.3 V be supplied to the card. The approximate 10% tolerance for the 3.3-V supply makes the 3.3-V $r_{DS(on)}$ less critical than the 5-V switch. A conservative approach is to allow 2% for voltage-regulator tolerance and 1% for etch- and pin-resistance drops, which leaves 2% (100 mV) for voltage drop at the 5-V switch and at least 6% (198 mV) for the 3.3-V switch.

Calculating the $r_{DS(on)}$ necessary to support a 100 mV or 198 mV switch loss, using R = E/I and setting I = 1 A, the 5-V and 3.3-V switches would need to be 100 m Ω and 198 m Ω respectively. One solution would be to pay for a more expensive switch with lower $r_{DS(on)}$. A second, less expensive approach is to increase the headroom of the power supply—for example, to increase the 5 V supply 1.5% or to 5.075 $\pm 2\%$. Working through the numbers once more, the 2% for the regulator plus 1 % for etch and terminal losses leaves 97% or 4.923 V. The allowable



APPLICATION INFORMATION

designing around 1-A delivery (continued)

voltage loss across the power distribution switch is now 4.923 V minus 4.750 V or 173 mV. Therefore, a switch with 173 m Ω or less could deliver 1 A or greater. Setting the power supply high is a common practice for delivering voltages to allow for system switch, connector, and etch losses. This practice has a minimal effect on overall battery life. In the example above, setting the power supply 1.5% high would only decrease a 3-hour battery life by approximately 2.7 minutes, trivial when compared with the decrease in battery life when running a 5-W PC Card.

heat dissipation

A greater concern in delivering 1 A or 5 W is the ability of the host to dissipate the heat generated by the PC Card. For desktop computers the solution is simpler: locate the PC Card cage such that it receives convection cooling from the forced air of the fan. Notebooks and other handheld equipment will not be able to rely on convection, but on conduction of heat away from the PC Card through the rails into the card cage. This is difficult because PC Card/card cage heat transfer is very poor. A typical design scenario would require the PC Card to be held at 60°C maximum with the host platform operating as high as 50°C. Preliminary testing reveals that a PC Card can have a 20°C rise, exceeding the 10°C differential in the example, when dissipating less than 2 W of continuous power. Sixty degrees centigrade was chosen because it is the maximum operating temperature allowable by PC Card specification. Power handling requirements and temperature rises are topics of concern and are currently being addressed by the PCMCIA committee.

overcurrent and over-temperature protection

PC Cards are inherently subject to damage that can result from mishandling. Host systems require protection against short-circuited cards that could lead to power supply or PCB-trace damage. Even systems sufficiently robust to withstand a short circuit would still undergo rapid battery discharge into the damaged PC Card, resulting in the rather sudden and unacceptable loss of system power. This can be particularly frustrating to the consumer who has already experienced problems with shortened battery life due to improper Nicad conditioning or memory effect. Most hosts include fuses for protection. The reliability of fused systems is poor though, as blown fuses require troubleshooting and repair, usually by the manufacturer.

The TPS2202Al takes a two-pronged approach to overcurrent protection. First, instead of fuses, sense FETs monitor each of the power outputs. Excessive current generates an error signal that linearly limits the output current, preventing host damage or failure. Sense FETs, unlike sense resistors or polyfuses, have an added advantage in that they do not add to the series resistance of the switch and thus produce no additional voltage losses. Second, when an overcurrent condition is detected, the TPS2202Al asserts a signal at \overline{OC} that can be monitored by the microprocessor to initiate diagnostics and/or send the user a warning message. In the event that an overcurrent condition persists, causing the IC to exceed its maximum junction temperature, thermal-protection circuitry activates, shutting down all power outputs until the device cools to within a safe operating region.

12-V supply not required

Most PC Card switches use the externally supplied 12-V V_{pp} power for switch-gate drive and other chip functions, which requires that power be present at all times. The TPS2202AI offers considerable power savings by using an internal charge pump to generate the required higher voltages from the 5-V V_{DD} supply; therefore, the external 12-V supply can be disabled except when needed for flash-memory functions, thereby extending battery lifetime. Additional power savings are realized by the TPS2202AI during a software shutdown in which quiescent current drops to a maximum of 1 μ A.



APPLICATION INFORMATION

voltage transitioning requirement

PC Cards, like portables, are migrating from 5 V to 3.3 V to minimize power consumption, optimize board space, and increase logic speeds. The TPS2202AI is designed to meet all combinations of power delivery as currently defined in the PCMCIA standard. The latest protocol accommodates mixed 3.3-V/5-V systems by first powering the card with 5 V, then polling it to determine its 3.3-V compatibility. The PCMCIA specification requires that the capacitors on 3.3-V-compatible cards be discharged to below 0.8 V before applying 3.3-V power. This ensures that sensitive 3.3-V circuitry is not subjected to any residual 5-V charge and functions as a power reset. The TPS2202AI offers a selectable $V_{\rm CC}$ and $V_{\rm pp}$ ground state, in accordance with PCMCIA 3.3-V/5-V switching specifications, to fully discharge the card capacitors while switching between $V_{\rm CC}$ voltages.

output ground switches

Several PCMCIA power-distribution switches on the market do not have an active-grounding FET switch. These devices do not meet the PC Card specification requiring a discharge of V_{CC} within 100 ms. PC Card resistance can not be relied on to provide a discharge path for voltages stored on PC Card capacitance because of possible high-impedance isolation by power-management schemes. A method commonly shown to alleviate this problem is to add to the switch output an external $100 \text{ k}\Omega$ resistor in parallel with the PC Card. Considering that this is the only discharge path to ground, a timing analysis will reveal that the RC time constant delays the required discharge time to more than 2 seconds. The only way to ensure timing compatibility with PC Card standards is to use a power-distribution switch that has an internal ground switch, like that of the TPS22xx family, or add an external ground FET to each of the output lines with the control logic necessary to select it.

In summary, the TPS2202AI is a complete single-chip dual-slot PC Card power interface. It meets all currently defined PCMCIA specifications for power delivery in 5-V, 3.3-V, and mixed systems, and offers a serial controller interface. The TPS2202AI offers functionality, power savings, overcurrent and thermal protection, and fault reporting in one 30-pin SSOP surface-mount package for maximum value added to new portable designs.

power supply considerations

The TPS2202Al has multiple pins for each of its 3.3-V, 5-V, and 12-V power inputs and for the switched V_{CC} outputs. Any individual pin can conduct the rated input or output current. Unless all pins are connected in parallel, the series resistance is significantly higher than that specified, resulting in increased voltage drops and lost power. Both 12-V inputs must be connected for proper V_{pp} switching; it is recommended that all input and output power pins be paralleled for optimum operation. The V_{DD} input lead must be connected to the 5-V input leads.

Although the TPS2202AI is fairly immune to power input fluctuations and noise, it is generally considered good design practice to bypass power supplies typically with a 1- μ F electrolytic or tantalum capacitor paralleled by a 0.047- μ F to 0.1- μ F ceramic capacitor. It is strongly recommended that the switched V_{CC} and V_{pp} outputs be bypassed with a 0.1- μ F or larger capacitor; doing so improves the immunity of the TPS2202AI to electrostatic discharge (ESD). Care should be taken to minimize the inductance of PCB traces between the TPS2202AI and the load. High switching currents can produce large negative-voltage transients, which forward biases substrate diodes, resulting in unpredictable performance.

The TPS2202AI, unlike other PC Card power-interface switches, does not use the 12-V power supply for switching or other chip functions. Instead, an internal charge pump generates the necessary voltage from V_{DD} , allowing the 12-V input supply to be shut down except when the V_{pp} programming or erase voltage is needed. Careful system design using this feature reduces power consumption and extends battery lifetime.

The 3.3-V power input should not be taken higher than the 5-V input. Though doing so is nondestructive, this results in high current flow into the device and could result in abnormal operation. In any case, this occurrence indicates a malfunction of one input voltage or both which should be investigated.

Similarly, no pin should be taken below -0.3 V; forward biasing the parasitic-substrate diode results in substrate currents and unpredictable performance.



APPLICATION INFORMATION

RESET or RESET inputs

To ensure that cards are in a known state after power brownouts or system initialization, the PC Cards should be reset at the same time as the host by applying a low impedance to the V_{CC} and V_{pp} terminals. A low-impedance output state allows discharging of residual voltage remaining on PC Card filter capacitance, permitting the system (host and PC Cards) to be powered up concurrently. The RESET or RESET input will close internal switches S1, S4, S7, and S10 with all other switches left open (see TPS2202Al control-logic table). The TPS2202AI remains in the low-impedance output state until the signal is deasserted and further data is clocked in and latched. RESET or RESET is provided for direct compatibility with systems that use either an active-low or active-high reset voltage supervisor. The unused pin is internally pulled up or down and should be left unconnected.

overcurrent and thermal protection

The TPS2202AI uses sense FETs to check for overcurrent conditions in each of the V_{CC} and V_{DD} outputs. Unlike sense resistors or polyfuses, these FETs do not add to the series resistance of the switch; therefore, voltage and power losses are reduced. Overcurrent sensing is applied to each output separately. When an overcurrent condition is detected, only the power output affected is limited; all other power outputs continue to function normally. The OC indicator, normally a logic high, is a logic low when any overcurrent condition is detected, providing for initiation of system diagnostics and/or sending a warning message to the user.

During power up, the TPS2202Al controls the rise time of the V_{CC} and V_{pp} outputs and limits the current into a faulty card or connector. If a short circuit is applied after power is established (e.g., hot insertion of a bad card), current is initially limited only by the impedance between the short and the power supply. In extreme cases, as much as 10 A to 15 A may flow into the short before the current limiting of the TPS2202Al engages. If the V_{CC} or V_{pp} outputs are driven below ground, the TPS2202AI may latch nondestructively in an off state. Cycling power will reestablish normal operation.

Overcurrent limiting for the V_{CC} outputs is designed to activate if powered up, into a short in the range of 0.75 A to 1.9 A, typically at about 1.3 A. The V_{DD} outputs limit from 120 mA to 400 mA, typically around 200 mA. The protection circuitry acts by linearly limiting the current passing through the switch rather than initiating a full shutdown of the supply. Shutdown occurs only during thermal limiting.

Thermal limiting prevents destruction of the IC from overheating if the package power-dissipation ratings are exceeded. Thermal limiting disables all power outputs (both A and B slots) until the device has cooled.

calculating junction temperature

The switch resistance, $r_{DS(on)}$, is dependent on the junction temperature, T_J , of the die. The junction temperature is dependent on both rDS(on) and the current through the switch. To calculate TJ, first find rDS(on) from Figures 16, 17, and 18 using an initial temperature estimate about 50°C above ambient. Then calculate the power dissipation for each switch, using the formula:

$$P_D = r_{DS(on)} \times I^2$$

Next, sum the power dissipation and calculate the junction temperature:

$$T_J = (\Sigma P_D \times R_{\theta JA}) + T_A, R_{\theta JA} = 108^{\circ}C/W$$

Compare the calculated junction temperature with the initial temperature estimate. If the temperatures are not within a few degrees of each other, recalculate using the calculated temperature as the initial estimate.



DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH RESET FOR SERIAL PCMCIA CONTROLLER

SLVS123 - SEPTEMBER 1995

APPLICATION INFORMATION

logic input and outputs

The serial interface consists of DATA, CLOCK, and LATCH leads. The data is clocked in on the positive leading edge of the clock (see Figure 2). The 9-bit (D0 through D8) serial data word is loaded during the positive edge of the latch signal. The latch signal should occur before the next positive leading edge of the clock.

The shutdown bit of the data word places all V_{CC} and V_{pp} outputs in a high-impedance state and reduces chip quiescent current to 1 μ A to conserve battery power.

The TPS2202AI serial interface is designed to be compatible with serial-interface PCMCIA controllers and current PCMCIA and Japan Electronic Industry Development Association (JEIDA) standards.

An overcurrent output (\overline{OC}) is provided to indicate an overcurrent condition in any of the V_{CC} or V_{pp} outputs as previously discussed.



APPLICATION INFORMATION

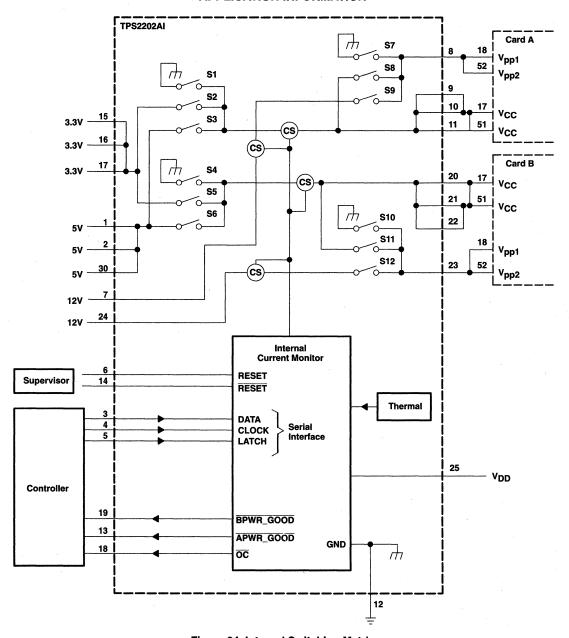


Figure 24. Internal Switching Matrix



APPLICATION INFORMATION

TPS2202Al control logic

AVPP

CONTROL SIGNALS			INTERNAL SWITCH SETTINGS			OUTPUT
D8 SHDN	D0 A_VPP_PGM	D1 A_VPP_VCC	S 7	S8	S9	VAVPP
1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	vcc†
1	1	0	OPEN	OPEN	CLOSED	VPP(12 V)
1	1	1	OPEN	OPEN	OPEN	Hi-Z
- 0	X	Х	OPEN	OPEN	OPEN	Hi-Z

BVPP

CONTROL SIGNALS			INTE	INTERNAL SWITCH SETTINGS			
D8 SHDN	D4 B_VPP_PGM	D5 B_VPP_VCC	S10	S11	S12	VBVPP	
1	0	0	CLOSED	OPEN	OPEN	0 V	
1	0	1	OPEN	CLOSED	OPEN	vcc‡	
1	1	0	OPEN	OPEN	CLOSED	VPP(12 V)	
1 .	1	· 1	OPEN	OPEN	OPEN	Hi-Z	
0	Х	Х	OPEN	OPEN	OPEN	Hi-Z	

AVCC

CONTROL SIGNALS			INTERNAL SWITCH SETTINGS			OUTPUT	
D8 SHDN	D3 A_VCC3	D2 A_VCC5	S1	S2	S3	VAVCC	
1	0	0	CLOSED	OPEN	OPEN	0 V	
1	0	1	OPEN	CLOSED	OPEN	3.3 V	
1	1	0	OPEN	OPEN	CLOSED	5 V	
1	1	1	CLOSED	OPEN	OPEN	0 V	
0	Х	Х	OPEN	OPEN	OPEN	Hi-Z	

BVCC

	CONTROL SIGNAL	S	INTERNAL SWITCH SETTINGS			OUTPU
D8 SHDN	D6 B_VCC3	D7 B_VCC5	S4	S5	S6	VBVCC
1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	3.3 V
. 1	1	0	OPEN	OPEN	CLOSED	5 V
, 1	1	1	CLOSED	OPEN	OPEN	0 V
0	Х	Х	OPEN	OPEN	OPEN	Hi-Z

[†] Output depends on AVCC

ESD protection

All TPS2202Al inputs and outputs incorporate ESD-protection circuitry designed to withstand a 2-kV human-body-model discharge as defined in MIL-STD-883C, Method 3015. The V_{CC} and V_{pp} outputs can be exposed to potentially higher discharges from the external environment through the PC Card connector. Bypassing the outputs with 0.1-µF capacitors protects the devices from discharges up to 10 kV.



[‡] Output depends on BVCC

APPLICATION INFORMATION

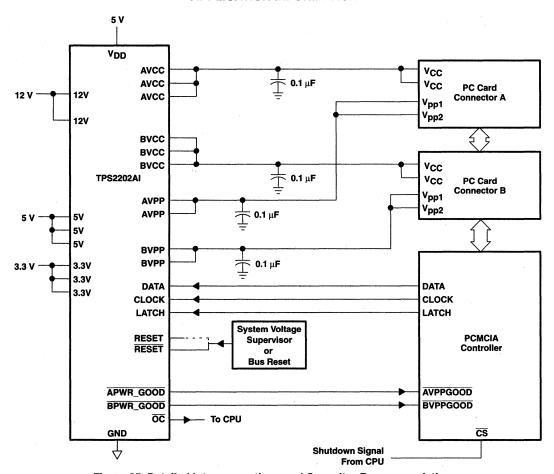


Figure 25. Detailed Interconnections and Capacitor Recommendations

TPS22051 DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH SUSPEND MODE FOR PARALLEL PCMCIA CONTROLLER

SLVS128 - OCTOBER 1995

 Fully Integrated V_{CC} and V_{pp} Switching for Dual-Slot PC Card™ Interface 	DF or DB P (TOP V	
Suspend Mode (3.3 V only)	5V10	30 5V
 Compatible With Controllers From Cirrus, 	5V2	29 B_VPP_PGM
Intel, and Texas Instruments	A_VPP_PGM3	28 B_VPP_VCC
Meets PCMCIA Standards	A_VPP_VCC4	27 B_VCC5
Internal Charge Pump (No External	A_VCC55	26 B_VCC3
Capacitors Required) – 12-V Supply Can Be	A_VCC3 C	25 🞞 NC
Disabled Except for Programming	12V 🖂 7	24 🞞 12V
	AVPP 🖂 8	23 BVPP
 Short Circuit and Thermal Protection 	AVCC □□□9	22 BVCC
 SSOP (30) Package Less than 2 mm High 	AVCC 10	21 BVCC
Compatible With 3.3-V. 5-V and 12-V PC	AVCC 🖂 11	20 BVCC
Cards	GND □□□ 12	19 . NC
	NC 13	18 🞞 <u>ōc</u>
 Power Saving I_{DD} = 83 μA Typ, I_Q = 1 μA 	SHDN 🗆 14	17 3.3V
• Low $r_{DS(on)}$ (150-m Ω 5-V Switch; 200-m Ω 3.3-V Switch)	3.3V15	16 3.3V

NC - No Internal Connection

description

Break-Before-Make Switching

The TPS2205 PC Card (PCMCIA) power interface switch provides an integrated power-management solution for two PC Cards. All of the discrete power MOSFETs, a logic section, current limiting and reporting, and thermal protection for PC Card control are combined on a single integrated circuit (IC), using the Texas Instruments LinBiCMOS™ process. The circuit allows the distribution of 3.3-V, 5-V and/or 12-V card power and is compatible with most PCMCIA controllers. The suspend mode allows the TPS2205 to operate off of 3.3-V input pins during modem or pager operations. The current-limiting feature eliminates the need for fuses, which reduces component count and improves reliability; current-limit reporting can help the user isolate a system fault to a bad card.

The TPS2205 maximizes battery life by generating its own switch-drive voltage using an internal charge pump. Therefore, the 12-V supply can be powered down and only brought out of standby when flash memory needs to be written to or erased. End equipment for the TPS2205 includes notebook computers, desktop computers, personal digital assistants (PDAs), digital cameras, handiterminals, and bar-code scanners.

The TPS2205I is only available in the DB package, left-end taped and reeled (indicated by the LE suffix on the device type; when ordering, specify TPS2205IDBLE).

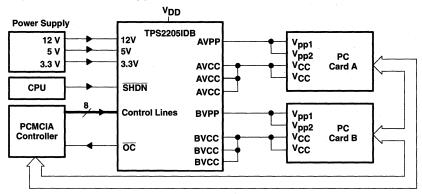
LinBiCMOS is a trademark of Texas Instruments Incorporated. PC Card is a trademark of PCMCIA (Personal Computer Memory Card International Association).



TPS2205I DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH SUSPEND MODE FOR PARALLEL PCMCIA CONTROLLER

SLVS128 - OCTOBER 1995

typical PC Card power distribution application



absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{DD}	0.3 V to 7 V
Input voltage range for card power: V _{I(5V)}	0.3 V to 7 V
V _{I(3.3V)}	–0.3 V to V _{I(5V)}
V _{I(12V)}	0.3 V to 14 V
Logic input voltage	
Continuous total power dissipation	See Dissipation Rating Table
Output current (each card): I _{O(xVCC)}	internally limited
I _{O(xVPP)}	internally limited
Operating virtual junction temperature range, T.J	40°C to 150°C
Operating free-air temperature range, T _A	40°C to 85°C
Storage temperature range, T _{stq}	–55°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR [‡] ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
DF	1158 mW	9.26 mW/°C	741 mW	602 mW
DB	1024 mW	8.2 mW/°C	655 mW	532 mW

[‡]These devices are mounted on an FR4 board with no special thermal considerations.

TPS2205I DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH SUSPEND MODE FOR PARALLEL PCMCIA CONTROLLER SLVS128 – OCTOBER 1995

Terminal Functions

TERMI	NAL		DECODIFICAL
NAME	NO.	1/0	DESCRIPTION
A_VCC3	6	ı	Logic input that controls voltage on AVCC (see control-logic table)
A_VCC5	5	ı	Logic input that controls voltage on AVCC (see control-logic table)
A_VPP_PGM	3	1	Logic input that controls voltage on AVPP (see control-logic table)
A_VPP_VCC	4	1	Logic input that controls voltage on AVPP (see control-logic table)
AVCC	9, 10, 11	0	Switched output that delivers 0 V, 3.3 V, 5 V, or high impedance
AVPP	8	0	Switched output that delivers 0 V, 3.3 V, 5 V, 12 V, or high impedance
B_VCC3	26	1	Logic input that controls voltage on BVCC (see control-logic table)
B_VCC5	27	1	Logic input that controls voltage on BVCC (see control-logic table)
B_VPP_PGM	29	ı	Logic input that controls voltage on BVPP (see control-logic table)
B_VPP_VCC	28	1	Logic input that controls voltage on BVPP (see control-logic table)
BVCC	20, 21, 22	0	Switched output that delivers 0 V, 3.3 V, 5 V, or high impedance
BVPP	23	0	Switched output that delivers 0 V, 3.3 V, 5 V, 12 V, or high impedance
SHDN	14	ı	Logic input that shuts down the TPS2205 and set all power outputs to high-impedance state
<u>oc</u>	18	0	Logic-level overcurrent reporting output that goes low when an overcurrent condition exists
V _{DD}	25		5-V power to chip
GND	12		Ground
3.3V	15, 16, 17		3.3-V V _{CC} in for card power
5V	1, 2, 30	1	5-V V _{CC} in for card power
12V	7, 24	ı	12-V VPP in for card power
NC	13,19		

recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V _{DD}		TBD	TBD	٧
Input voltage range, V _I	V _{I(5 V)}	0	5.25	٧
	V _{I(3.3 V)}	0	ν _{I(5 V)} †	٧
	V _{I(12 V)}	0	0 5.25	٧
0	IO(xVCC) at 25°C		1	Α
Output current	IO(xVPP) at 25°C		150	mA
Operating virtual junction tempe	perating virtual junction temperature, T,I			°C

[†] V_{I(3 V)} should not be taken above V_{I(5 V)}.

TPS2205I DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH SUSPEND MODE FOR PARALLEL PCMCIA CONTROLLER SLVS128 – OCTOBER 1995

electrical characteristics, $T_A = 25^{\circ}C$, $V_{DD} = 5 \text{ V}$ (unless otherwise noted)

dc characteristics

	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
		5 V to xVCC			150		mΩ
		3.3 V to xVCC			200		mΩ
	Switch resistances	3.3 V to xVCC	Suspend mode		500		mΩ
	Switch resistances	5 V to xVPP				6	
		3.3 V to xVPP				6	Ω
		12 V to xVPP				- 1	
V _{O(xVPP)}	Clamp low voltage		I _{pp} at 10 mA			0.8	٧
VO(xVCC)	Clamp low voltage	1	I _{CC} at 10 mA			0.8	٧
Lastra a summah		Ipp High-impedance	T _A = 25°C		1	10	
	state	T _A = 85°C			50		
	Leakage current	I _{CC} High-impedance state	T _A = 25°C	1 10		μΑ	
			T _A = 85°C			50	
	lanut ausmant	IDD Supply current	VO(AVCC) = VO(BVCC) = 5 V, VO(AVPP) = VO(BVPP) = 12 V		83	150	μΑ
	Input current	IDD Supply current in shutdown	$V_{O(BVCC)} = V_{O(AVCC)} = V_{O(AVPP)}$ = $V_{O(BVPP)} = high Z$			1	μΑ
	Power-ready threshold, PWR_GOOD			10.72	11.05	11.4	٧
	Power-ready hysteresis, PWR_GOOD	12-V mode			50		mV
	Short-circuit output-	lo(xVCC)	T. 0500 Outside headed to OND	1			Α
	current limit	IO(xVPP)	T _J = 85°C, Output shorted to GND	120	200	400	mA

TPS2205I DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH SUSPEND MODE FOR PARALLEL PCMCIA CONTROLLER SLVS128 - OCTOBER 1995

electrical characteristics, $T_A = 25$ °C, $V_{DD} = 5$ V (unless otherwise noted) (continued)

logic section

	PARAMETER		TEST CONDITIONS	MIN	MAX	UNIT
Logic input current					1	μА
Logic input high level				2		V
Logic input low level					0.8	٧
Logic output high level			1- 44	V _{DD} -0.4		٧
Logic output low level			I _O = 1 mA		0.4	· V

switching characteristics†

PARAMETER	TEST CONDITIONS		MIN	TYP	MAX	UNIT
	V _{O(xVCC)} rise time			1.2		ms
t _r , t _f Output rise and fall times	VO(xVCC) fall time	V _{O(xVCC)} fall time		10		ms
	VO(xVPP) rise time			5		ms
	VO(xVPP) fall time			14		ms
	,	ton		5.8		ms
	V _{I(x_VPP_PGM)} to V _{O(xVPP)}	toff		18		ms
	+ + + + + + + + + + + + + + + + + + +	ton		5.8		ms
t _{pd} Propagation delay (see Figure 1‡)	VI(x_VCC3) to xVCC	toff		28		ms
	Vive to vive	ton		4		ms
	V _I (x_VCC5) to xVCC	toff		30		ms

[†] Refer to Parameter Measurement Information

[‡] Rise and fall times are with $C_L = 100 \mu F$.

TPS2205I DUAL-SLOT PC CARD POWER-INTERFACE SWITCH WITH SUSPEND MODE FOR PARALLEL PCMCIA CONTROLLER

SLVS128 - OCTOBER 1995

APPLICATION INFORMATION

TPS2205 control logic

AVPP

CONTROL SIGNALS		INTERNAL SWITCH SETTINGS			OUTPUT	
SHDN	A_VPP_PGM	A_VPP_VCC	S 7	S8	S9	VAVPP
1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	vcct
1	1	0	OPEN	OPEN	CLOSED	VPP(12 V
1	1	1	OPEN	OPEN	OPEN	Hi-Z
0	X	Х	OPEN	OPEN	OPEN	Hi-Z

BVPP

	CONTROL SIGNALS		INTERNAL SWITCH SETTINGS			OUTPUT	
SHDN	B_VPP_PGM	B_VPP_VCC	S10	S11	S12	VBVPP	
1	0	0	CLOSED	OPEN	OPEN	0 V	
1	0	1	OPEN	CLOSED	OPEN	vcc‡	
1	1	0	OPEN	OPEN	CLOSED	VPP(12 V)	
1	1	1	OPEN	OPEN	OPEN	Hi-Z	
0	X	X	OPEN	OPEN	OPEN	Hi-Z	

AVCC

CONTROL SIGNALS		INTERNAL SWITCH SETTINGS			OUTPUT	
SHDN	A_VCC3	A_VCC5	S1	S2	S3	VAVCC
1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	3 V
1.	1	0	OPEN	OPEN	CLOSED	5 V
1	1	1	CLOSED	OPEN	OPEN	0 V
0	X	Х	OPEN	OPEN	OPEN	Hi-Z

BVCC

C	CONTROL SIGNALS	3	INTER	NAL SWITCH SET	OUTPUT	
SHDN	B_VCC3	B_VCC5	S4	S5	S6	VBVCC
1	0	0	CLOSED	OPEN	OPEN	0 V
1	0	1	OPEN	CLOSED	OPEN	3 V
1	1	0	OPEN	OPEN	CLOSED	5 V
1	1	1	CLOSED	OPEN	OPEN	0 V
0	X	X	OPEN	OPEN	OPEN	Hi-Z

[†]Output depends on AVCC



[‡]Output depends on BVCC

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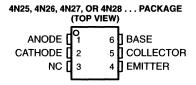
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SOES020 - SEPTEMBER 1978 - REVISED OCTOBER 1995

COMPATIBLE WITH STANDARD TTL INTEGRATED CIRCUITS

- **Gallium-Arsenide-Diode Infrared Source** Optically Coupled to a Silicon npn **Phototransistor**
- High Direct-Current Transfer Ratio
- **High-Voltage Electrical Isolation** 2.5-kV, 1.5-kV, or 0.5-kV Rating
- Plastic Dual-Inline Package
- High-Speed Switching $t_r = 2 \mu s$, $t_f = 2 \mu s$ Typical



NC - No internal connection

absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)†

Peak input-to-output voltage‡:	4N26, 4N27	± 2.5 kV ± 1.5 kV ± 0.5 kV
Collector-base voltage‡	· · · · · · · · · · · · · · · · · · ·	70 V
Collector-emitter voltage‡ (see	Note 1)	30 V
Emitter-collector voltage‡	· · · · · · · · · · · · · · · · · · ·	7 V
Emitter-base voltage	· · · · · · · · · · · · · · · · · · ·	
Input-diode reverse voltage‡		3 V
Input-diode continuous forward	current at (or below) 25°C free-air ten	nperature [‡] (see Note 2) 80 mA
Input-diode peak forward curre	nt^{\ddagger} ($t_{w} = 300 \mu s$, duty cycle = 2 %)	3 A
Continuous power dissipation a	t (or below) 25°C free-air temperature	. ‡:
Infrared-emitting diode (se	ee Note 3)	150 mW
Phototransistor (see Note	3)	150 mW
Total, infrared-emitting did	de plus phototransistor (see Note 4)	250 mW
Storage temperature range, T _{sto}	,‡	–55°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[‡] JEDEC registered data. This data sheet contains all applicable JEDEC-registered data in effect at the time of publication.

NOTES: 1. This value applies when the base-emitter diode is open-circulated. 2. Derate linearly to 100 °C free-air temperature at the rate of 1.33 mA/°C.

^{3.} Derate linearly to 100 °C free-air temperature at the rate of 2 mW/°C.

^{4.} Derate linearly to 100 °C free-air temperature at the rate of 3.33 mW/°C.

electrical characteristics at 25°C free-air temperature (unless otherwise noted)

	ADAMETED	TEGT COMPITIONS	41	N25, 4N2	:6	4N	27, 4N2	8	
,	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
V _{(BR)CBO} †	Collector-base breakdown voltage	I _C = 100 μA, I _E = 0, I _F = 0	70			70			٧
V _{(BR)CEO} †	Collector-emitter breakdown voltage	I _C =1 mA, I _B = 0, I _F = 0	30			30			٧
V _(BRECO) †	Emitter-collector breakdown voltage	I _E = 100 μA, I _B = 0, I _F = 0	7			7			٧
ı _R †	Input diode static reverse current	V _R = 3 V			100			100	μΑ
IC(on)†	On-state collector current (phototransistor operation)	V _{CE} = 10 V, I _B = 0, I _F = 10 mA	2	5		1	3		mA
IC(on)	On-state collector current (phototransistor operation)	V _{CB} = 10 V, I _E = 0, I _F = 10 mA		20			20		μΑ
IC(off) [†]	Off-state collector current (phototransistor operation)	V _{CE} = 10 V, I _B = 0, I _F = 0		1	50		1	50	nA.
IC(off)†	Off-state collector current (photodiode operation)	V _{CB} = 10 V, I _E = 0, I _F = 0		0.1	20		0.1	20	nA
V _F †	Input diode static forward voltage	IF = 10 mA		1.25	1.5		1.25	1.5	٧
V _{CE(sat)} †	Collector-emitter saturation voltage	I _C = 2 mA, I _B = 0, I _F = 50 mA		0.25	0.5		0.25	0.5	٧
rio	Input-to-output internal resistance	V _{in-out} = ±2.5 kV for 4N25, ±1.5 kV for 4N26, 4N27, ±0.5 kV for 4N28, See Note 5	10 ¹¹	10 ¹²		10 ¹¹	10 ¹²	2 2	Ω
C _{io}	Input-to-output capacitance	V _{in-out} = 0, f = 1 MHz, See Note 5		1			1		pF

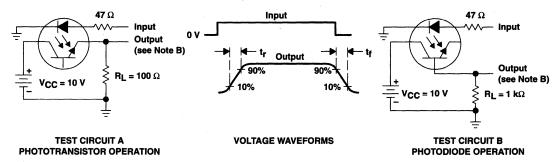
[†] JEDEC registered data

NOTE 5: These parameters are measured between both input diode leads shorted together and all the phototransistor leads shorted together.

switching characteristics

	PAR	PARAMETER TEST CONDITIONS				MAX	UNIT
tr	Rișe time	Phototransistor operation	$V_{CC} = 10 \text{ V}, \text{ IB} = 0, \text{ IC(on) } 2 \text{ mA}$		2		
tf	Fall time	Filototransistor operation	$R_L = 100 \Omega$, See Test Circuit A of Figure 1		2		μs
t _r	Rise time	Photodiada aparation	V _{CC} = 10 V, I _E = 0, I _{C(on)} 20 μA		1		
tf	Fall time	- Photogloge operation I	$R_L = 1 \text{ k}\Omega$, See Test Circuit B of Figure 1		1		μs

PARAMETER MEASUREMENT INFORMATION

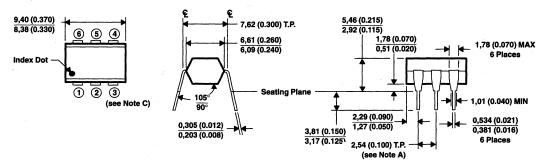


NOTES: A. The input waveform is supplied by a generator with the following characteristics: $Z_0 = 50 \ \Omega$, $t_r \le 15 \ ns$, duty cycle $\approx 1\%$.

B. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \le 12$ ns, $R_{in} \ge 1$ M Ω , $C_{in} \le 20$ pF.

MECHANICAL INFORMATION

The package consists of a gallium-arsenide infrared-emitting diode and an npn silicon phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case can withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



NOTES: A. Leads are within 0,13 (0.005) radius of true position (T.P.) with maximum material condition and unit installed.

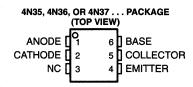
- B. Pin 1 identified by index dot.
- C. Terminal connections:
 - 1. Anode (part of the infrared-emitting diode)
 - 2. Cathode (part of the infrared-emitting diode)
 - 3. No internal connection
 - 4. Emitter (part of the phototransistor)
 - 5. Collector (part of the phototransistor)
 - 6. Base (part of the phototransistor)
- D. The dimensions given fall within JEDEC MO-001 AM dimensions.
- E. All linear dimensions are given in millimeters and parenthetically given in inches.

Figure 1. Mechanical Information



COMPATIBLE WITH STANDARD TTL INTEGRATED CIRCUITS

- Gallium-Arsenide-Diode Infrared Source Optically Coupled to a Silicon npn Phototransistor
- High Direct-Current Transfer Ratio
- High-Voltage Electrical Isolation 1.5-kV, 2.5-kV, or 3.55-kV Rating
- Plastic Dual-In-Line Package
- High-Speed Switching t_r = 7 μs, t_f = 7 μs Typical
- Typical Applications Include Remote Terminal Isolation, SCR and Triac Triggers, Mechanical Relays and Pulse Transformers



NC - No internal connection

absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)†‡

Input-to-output peak voltage (8-ms half sine wave):	4N35	3.55 kV
	4N36	2.5 kV
	4N37	1.5 kV
Input-to-output root-mean-square voltage (8-ms half	sine wave): 4N35	2.5 kV
	4N36	
	4N37	
Collector-base voltage		
Collector-emitter voltage (see Note 1)		
Emitter-base voltage	***************************************	7 V
Input-diode reverse voltage		6 V
Input-diode forward current: Continuous		
Phototransistor continuous collector current		
		100 111A
Continuous total power dissipation at (or below) 25°C		100\\
Infrared-emitting diode (see Note 2)		
Phototransistor (see Note 3)		. 300 mw
Continuous power dissipation at (or below) 25°C lead	· · · · · · · · · · · · · · · · · · ·	
Infrared-emitting diode (see Note 4)		
Phototransistor (see Note 5)		
Operating temperature range, T _A		
Storage temperature range, T _{stg}	55°	C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 1	10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. This value applies when the base-emitter diode is open-circulated.

- 2. Derate linearly to 100 °C free-air temperature at the rate of 1.33 mW/°C.
- 3. Derate linearly to 100 °C free-air temperature at the rate of 4 mW/°C.
- Derate linearly to 100 °C lead temperature at the rate of 1.33 mW/°C. Lead temperature is measured on the collector lead 0.8 mm (1/32 inch) from the case.
- 5. Derate linearly to 100°C lead temperature at the rate of 6.7 mW/°C.



[‡] JEDEC registered data. This data sheet contains all applicable registered data in effect at the time of publication.

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electrical characteristics at 25°C free-air temperature (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP MA	X UNIT
V _(BR) CBO	Collector-base breakdown voltage	$I_C = 100 \mu\text{A}, I_E = 0, \qquad I_F = 0$	70†		V
V(BR)CEO	Collector-emitter breakdown voltage	$I_C = 10 \text{ mA}, I_B = 0, I_F = 0$	30†		V
V _{(BR)EBO}	Emitter-base breakdown voltage	I _E = 100 μA, I _C = 0, I _F = 0	7†	and Nacid	V
l _R	Input diode static reverse current	V _R = 6 V		1(t μA
l _{IO}	Input-to-output current	V _{IO} = rated peak value, t = 8 ms		1(0 mA
٠		V _{CE} = 10 V, I _F = 10 mA, I _B = 0	10†		
IC(on)	On-state collector current	V _{CE} = 10 V, I _F = 10 mA, I _B = 0, T _A = -55°C	4†		mA
		VCE = 10 V, IF = 10 mA, IB = 0, T _A = 100°C	4†		
		V _{CE} = 10 V, I _F = 0, I _B = 0		1 5	0 nA
IC(off)	Off-state collector current	V _{CE} = 30 V, I _F = 0, I _B = 0, T _A = 100°C		500	it μA
hFE	Transistor Static Forward Current Transfer Ratio	V _{CE} = 5 V, I _C = 10 mA, I _F = 0		500	
		IF = 10 mA	0.8†	1.5	it
VF	Input diode static forward voltage	I _F = 10 mA, T _A = -55°C	0.9†	1.7	† v
		I _F = 10 mA, T _A = 100°C	0.7†	1.4	.†
V _{CE(sat)}	Collector-emitter saturation voltage	I _B = 0 mA, I _F = 10 mA,		0.3	t v
rio	Input-to-output internal resistance	V _{IO} = 500 V, See Note 6	1011†		Ω
C _{io}	Input-to-output capacitance	V _{IO} = 0, f = 1 MHz, See Note 6		1 2.5	pF

[†]JEDEC registered data

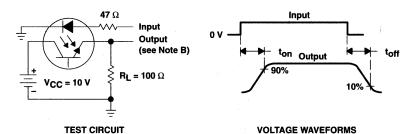
NOTE 6: These parameters are measured between both input-diode leads shorted together and all the phototransistor leads shorted together.

switching characteristics at 25°C free-air temperature†

	PARAMETER	TEST	CONDITIONS	MIN	TYP	MAX	UNIT
ton	Time-on time	V _{CC} = 10 V,	$I_{C(on)} = 2 \text{ mA},$			10	
toff	Turn-off time	$R_L = 100 \Omega$,	See Figure 1			10	μs

[†] JEDEC registered data

PARAMETER MEASUREMENT INFORMATION



NOTES: A. The input waveform is supplied by a generator with the following characteristics: $Z_0 = 50 \Omega$, $t_f \le 15$ ns, duty cycle $\approx 1\%$ $t_W = 100 \mu s$.

B. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \le 12$ ns, $R_{in} \ge 1$ M Ω , $C_{in} \le 20$ pF

Figure 1. Switching Times

TYPICAL CHARACTERISTICS

OFF-STATE COLLECTOR CURRENT FREE-AIR TEMPERATURE 10,000 V_{CE} = 10 V 4,000 IC(off) - Off-State Collector Current - nA $l_B = 0$ IF = 0 1,000 400 100 40 10 0.4 0.1 10 40 50 90 T_A - Free-Air Temperature - °C

Figure 2

TRANSISTOR STATIC FORWARD CURRENT TRANSFER RATIO (NORMALIZED)

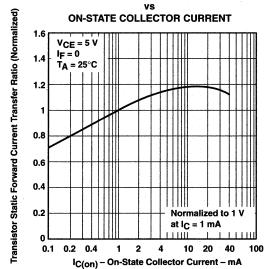


Figure 3

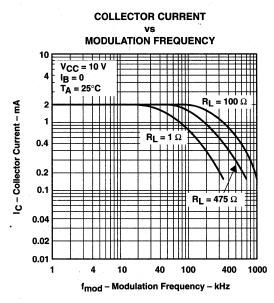


Figure 4

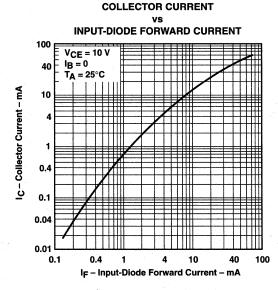


Figure 6

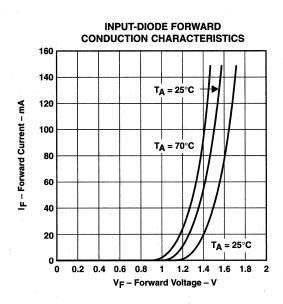
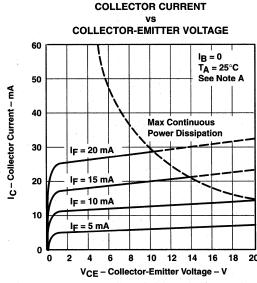


Figure 5



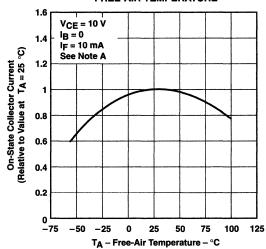
NOTE A. Pulse operation of input diode is required for operation beyond limits shown by dotted lines.

Figure 7



ON-STATE COLLECTOR CURRENT (RELATIVE TO VALUE AT 25°C)

FREE-AIR TEMPERATURE

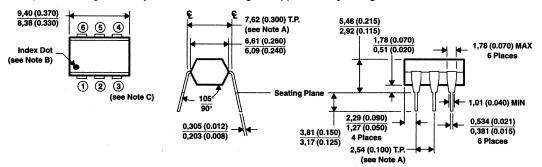


NOTE A. These parameters were measured using pulse techniques, $t_W=1$ ms, duty cycle ≤ 2 %.

Figure 8

MECHANICAL INFORMATION

The package consists of a gallium-arsenide infrared-emitting diode and an npn silicon phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case can withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high humidity conditions. Unit weight is approximately 0.52 grams.



- NOTES: A. Leads are within 0,13 (0.005) radius of true position (T.P.) with maximum material condition and unit installed.
 - B. Pin 1 identified by index dot.
 - C. Terminal connections:
 - 1. Anode (part of the infrared-emitting diode)
 - 2. Cathode (part of the infrared-emitting diode)
 - 3. No internal connection
 - 4. Emitter (part of the phototransistor)
 - 5. Collector (part of the phototransistor)
 - 6. Base (part of the phototransistor)
 - D. The dimensions given fall within JEDEC MO-001 AM dimensions.
 - E. All linear dimensions are given in millimeters and parenthetically given in inches.

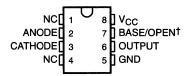
Figure 9. Mechanical Information



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- Compatible with TTL Inputs
- High-Speed Switching 1 Mbit/s Typ
- Bandwidth ... 2 MHz Typ
- High Common-Mode Transient Immunity 1000 V/µs Typ
- High-Voltage Electrical Insulation ... 3000 VDC Min
- Open-Collector Output
- UL Recognized ... File Number 65085

6N135, 6N136, OR HCPL4502 PACKAGE (TOP VIEW)



† Terminal 7 is BASE on the 6N135 and 6N136 and OPEN on the HCPL4502

NC - No internal connection

description

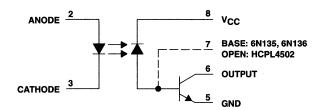
These high-speed optocouplers are designed for use in analog or digital interface applications that require high-voltage isolation between the input and output. Applications include line receivers that require high common-mode transient immunity, and analog or logic circuits that require input-to-output electrical isolation.

The 6N135, 6N136, and HCPL4502 optocouplers each consists of a light-emitting diode and an integrated photon detector composed of a photodiode and an open-collector output transistor. Separate connections are provided for the photodiode bias and the transistor-collector output. This feature, which reduces the transistor base-to-collector capacitance, results in speeds up to one hundred times that of a conventional phototransistor optocoupler.

The 6N135 is designed for TTL/CMOS, TTL/LSTTL, and wide-band analog applications.

The 6N136 and HCPL4502 are designed for high-speed TTL/TTL applications. The HCPL4502 has no base connection.

schematic



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absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)†‡

Supply and output voltage range, V _{CC and} V _O	
Emitter-base reverse voltage	5 V
Peak input forward current (pulse duration = 1 ms, 50% duty cycle, see Note 1)	50 mA
Peak transient input forward current (pulse duration 1 µs, 300 Hz)	1 A
Average forward input current(see Note 2)	25 mA
Peak output current	16 mA
Average output current	8 mA
Base current	5 mA
Input power dissipation at (or below) 70°C free-air temperature (see Note 3)	45 mW
Output power dissipation at (or below) 70°C free-air temperature (see Note 4)	
Storage temperature range, T _{stq}	55°C to 125°C
Operating free-air temperature range, T _A	55°C to 100°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. Derate linearly above 70°C free-air temperature at the rate of 1.67 mA/°C.

- 2. Derate linearly above 70°C free-air temperature at the rate of 0.83 mA/°C.
- 3. Derate linearly above 70°C free-air temperature at the rate of 1.50 mW/°C.
- 4. Derate linearly above 70°C free-air temperature at the rate of 3.33 mW/°C.

[‡] JEDEC registered data for 6N135 and 6N136

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electrical characteristics over operating free-air temperature range of 0°C to 70°C (unless otherwise noted)

	DADAMETED	TEGT	TEST CONDITIONS		6N135		6N13	6, HCPL4	502	UNIT	
	PARAMETER	IESIC	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNII	
V _F ‡	Input forward voltage	IF = 16 mA,	T _A = 25°C		1.6	1.7		1.6	1.7	٧	
∝VF	Temperature coefficient of forward voltage	IF = 16 mA			-1.8			-1.8		mV/°C	
V _{BR} ‡	Input breakdown voltage	I _R = 10 μA,	T _A = 25°C	5			5			٧	
Vol	Low-level output voltage	V _{CC} = 4.5 V, I _F = 16 mA,	I _{OL} = 1.1 mA		0.1	0.4				٧	
51		I _B = 0	I _{OL} = 2.4 mA					0.1	0.4		
loH‡	H High-level output current H H H H H H H H H H H H H		$V_{CC} = V_{O} = 5.5 \text{ V}$		3	500		3	500	nA	
юн.	riigir iovor output ourroin	T _A = 25°C	V _{CC} = V _O = 15 V		0.01	1		0.01	1	μΑ	
ЮН	High-level output current	V _{CC} = 15 V, I _F = 0,	V _O = 15 V, I _B = 0			50			50	μА	
ICCH [‡]	Supply current, high-level output	V _{CC} = 15 V, I _F = 0, T _A = 25°C	I _O = 0,		0.02	1		0.02	1	μΑ	
ІССН	Supply current, high-level output	V _{CC} = 15 V, I _F = 0,	I _O = 0,			2			2.	μА	
ICCL	Supply current, low-level output	V _{CC} = 15 V, I _F = 16 mA,	IB = 0		40			40		μА	
hFE	Transistor forward current transfer ratio	V _O = 5 V,	I _O = 3 mA		100			100 (6N136 only)	e e		
CTR‡	Current transfer ratio	V _{CC} = 4.5 V, I _F = 16 mA, T _A = 25°C,	V _O = 0.4 V, I _B = 0, See Note 5	7%	18%		19%	24%			
CTR	Current transfer ratio	V _{CC} = 4.5 V, I _F = 16 mA, See Note 5	V _O = 0.5 V, I _B = 0,	5%			15%				
r _{IO}	Input-output resistance	V _{IO} = 500 V, See Note 6	T _A = 25°C,	. ,	1012			1012		Ω	
1 ₁₀ ‡	Input-output insulation leakage current	V _{IO} = 3000 V, T _A = 25°C, See Note 6	t = 5 s, RH = 45%,			1			1	μА	
Ci	Input capacitance	V _F = 0,	f = 1 MHz		60			60		pF	
Cio	Input-output capacitance	f = 1 MHz,	See Note 6		0.6			0.6		pF	

[†] All typical values are at T_A = 25°C. ‡ JEDEC registered data for 6N135 and 6N136

NOTES: 5. Current transfer ratio is defined as the ratio of output collector current I_O to the forward LED input current I_F times 100%.

^{6.} These parameters are measured with terminals 2 and 3 shorted together and terminals 5, 6, 7, and 8 shorted together.

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operating characteristics, $V_{CC} = 5 \text{ V}$, $I_F = 16 \text{ mA}$, $T_A = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER		TEST CONDITIONS	6N135			6N136, HCPL4502			UNIT
		TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNII
BW	Bandwidth (-3 dB)	$R_L = 100 \Omega$, See Note 7	2		2 2				MHz

NOTE 7: Bandwidth is the range of frequencies within which the ac output voltage is not more than 3 dB below the low-frequency value.

switching characteristics at $V_{CC} = 5 \text{ V}$, $I_F = 16 \text{ mA}$, $T_A = 25^{\circ}\text{C}$

DAI	DAMETED	TEST OF	TEST CONDITIONS		6N135			6N136, HCPL4502			
PAI	RAMETER	TEST CONDITIONS		MIN	TYP	MAX	MIN	TYP	MAX	UNIT	
	Propagation delay time,	$R_L = 4.1 kΩ$, See Figure 1	See Note 8,		1	1.5					
tPLH [†] low-to-high-level output	low-to-high-level output	R _L = 1.9 kΩ, See Figure 1	See Note 9,					0.6	0.8	μs	
delav ti	Propagation delay time,	$R_L = 4.1 kΩ$, See Figure 1	See Note 8,		0.7	1.5					
t _{PHL} †	high-to-low-level output	R_L = 1.9 kΩ, See Figure 1	See Note 9,				A .	0.6	0.8 μs		
dV _{CM} (H)	Common-mode input transient immunity, high-level output	$\Delta V_{CM} = 10 \text{ V},$ $R_L = 4.1 \text{ k}\Omega,$ See Figure 2	IF = 0, See Notes 8 and 10,		1000					Miss	
		ΔV_{CM} = 10 V, R _L = 1.9 kΩ, See Figure 2	I _F = 0, See Notes 9 and 10,					-1000		V/μs	
dV _{CM} (L)	Common-mode input transient	$\Delta V_{CM} = 10 \text{ V},$ See Notes 9 and 10,	R_L = 4.1 kΩ, See Figure 2		-1000					V/ua	
dt (L)	(=)	$\Delta V_{CM} = 10 \text{ V},$ See Notes 9 and 10,	R _L = 1.9 kΩ, See Figure 2			-		-1000		V/μs	

† JEDEC registered data for 6N135 and 6N136

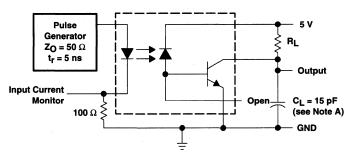
NOTES: 8. The 4.1-k Ω load represents one LSTTL unit load of 0.36 mA and a 6.1-k Ω pullup resistor.

9. The 1.9-k Ω load represents one TTL unit load of 1.6 mA and a 5.6-k Ω pullup resistor.

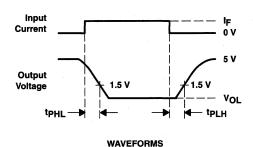
^{10.} Common-mode transient immunity, high-level output, is the maximum rate of rise of the common-mode input voltage that does not cause the output voltage to drop below 2 V. Common-mode input transient immunity, low-level output, is the maximum rate of fall of the common-mode input voltage that does not cause the output voltage to rise above 0.8 V.

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PARAMETER MEASUREMENT INFORMATION



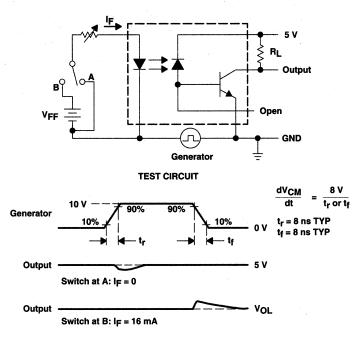
TEST CIRCUIT



NOTE A. CL includes probe and stray capacitance.

Figure 1. Switching Test Circuit and Waveforms

PARAMETER MEASUREMENT INFORMATION



VOLTAGE WAVEFORMS

Figure 2. Transient Immunity Test Circuit and Waveforms

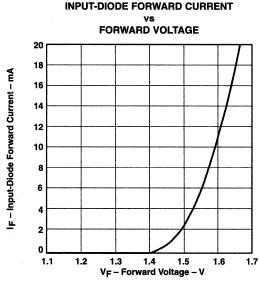


Figure 3

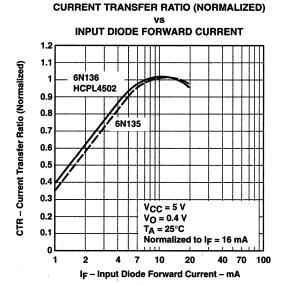
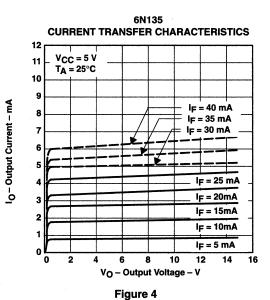


Figure 5



CURRENT TRANSFER RATIO (NORMALIZED)

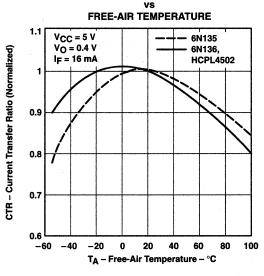


Figure 6

HIGH-LEVEL OUTPUT CURRENT vs FREE-AIR TEMPERATURE 10,000 V_{CC} = 5 V 4000 VO = 5 V IF = 0 IOH - High-Level Output Current - nA 1000 400 100 40 10 0.4 0.1 25 75 100 125 -75 -50 -25 T_A - Free-Air Temperature - °C

Figure 7

FREQUENCY RESPONSE (NORMALIZED) vs

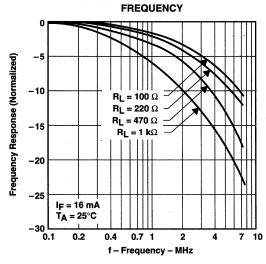


Figure 9

DIFFERENTIAL CURRENT TRANSFER RATIO vs INPUT-DIODE QUIESCENT FORWARD CURRENT

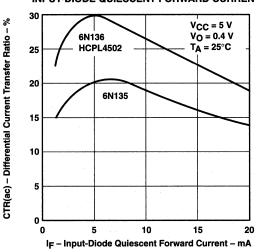


Figure 8

PROPAGATION DELAY TIME

vs FREE-AIR TEMPERATURE

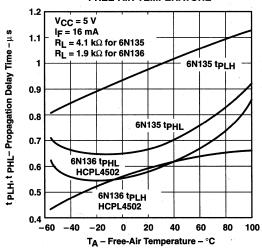
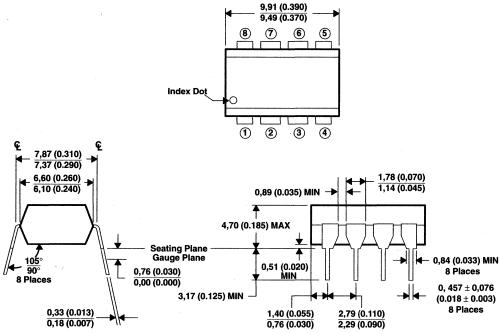


Figure 10

MECHANICAL INFORMATION



NOTES: A. JEDEC registered data. This data sheet contains all applicable registered data in effect at the time of publication.

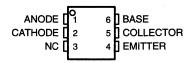
- B. Terminal connections:
 - 1. No internal connection (part of the light-emitting diode)
 - 2. Anode (part of the light-emitting diode)
 - 3. Cathode (part of the light-emitting diode)
 - 4. No internal connection
 - 5. GND (Emitter) (part of the light-emitting diode)
 - 6. Output (part of the detector)
 - 7. Base: 6N135, 6N136 (part of the detector)
 Open: HCPL4502 (part of the detector)
 - 8. V_{CC} (part of the detector)
- C. All linear dimensions are given in millimeters and parenthetically given in inches.

Figure 11. Mechanical Information

COMPATIBLE WITH STANDARD TTL INTEGRATED CIRCUITS

- Gallium Arsenide Diode Infrared Source Optically Coupled to a Silicon npn Phototransistor
- High Direct-Current Transfer Ratio
- Base Lead Provided for Conventional Transistor Biasing
- High-Voltage Electrical Isolation . . . 1.5-kV, or 3.55-kV Rating
- Plastic Dual-In-Line Package
- High-Speed Switching:
 t_r = 5 μs, t_f = 5 μs Typical
- Designed to be Interchangeable with General Instruments MCT2 and MCT2E

MCT2 OR MCT2E . . . PACKAGE (TOP VIEW)



NC - No internal connection

absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)†

Input-to-output voltage: MCT2	± 1.5 kV
MCT2E	± 3.55 kV
Collector-base voltage	70 V
Collector-emitter voltage (see Note 1)	30 V
Emitter-collector voltage	7 V
Emitter-base voltage	7 V
Input-diode reverse voltage	3 V
Input-diode continuous forward current	
Input-diode peak forward current (t _w ≤ 1 ns, PRF ≤ 300 Hz)	3 A
Continuous power dissipation at (or below) 25°C free-air temperature:	
Infrared-emitting diode (see Note 2)	200 mW
Phototransistor (see Note 2)	200 mW
Total, infrared-emitting diode plus phototransistor (see Note 3)	250 mW
Operating free-air temperature range, T _A	
Storage temperature range, T _{stq}	55°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. This value applies when the base-emitter diode is open-circulated.

- 2. Derate linearly to 100 °C free-air temperature at the rate of 2.67 mW/°C.
- 3. Derate linearly to 100 °C free-air temperature at the rate of 3.33 mW/°C.

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electrical characteristics at 25°C free-air temperature (unless otherwise noted)

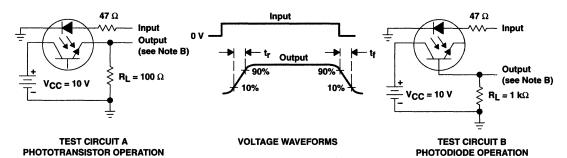
	PARAMETER		TEST	CO	NDITION	S	MIN	TYP	MAX	UNIT
V _{(BR)CBO}	Collector-base breakdown	voltage	I _C = 10 μA,	lE =	0, l _F	= 0	70			٧
V _(BR) CEO	Collector-emitter breakdow	n voltage	I _C =1 mA,	IB=	0, l _F	= 0	30			٧
V(BRECO)	Emitter-collector breakdow	n voltage	IE = 100 μA,	l _B =	0, l _F	= 0	7			٧
^I R	Input diode static reverse of	urrent	V _R = 3 V					10	μА	
I _{C(on)}	On-state collector current	Phototransistor operation	V _{CE} = 10 V,	lB =	0, IF	= 10 mA	2	5		mA
		Photodiode operation	V _{CB} = 10 V,	lE =	0, l _F	= 10 mA		20		μА
IC(off)	Off-state collector current	Phototransistor operation	V _{CE} = 10 V, I _B = 0, I _F = 0 V _{CB} = 10 V, I _E = 0, I _F = 0			1	50	. nA		
_ (/		Photodiode operation			0, l _F	= 0		0.1	20	nA
H _{FE}	Transistor static forward o	errant transfer ratio	V _{CE} = 5 V, I _C = 100 μA,		MCT2			250		
''FE	Transistor static forward current transfer ratio		IE = 0 IC = 100 μA,		MCT2E		100	300		
٧F	Input diode static forward v	oltage	I _F = 20 mA					1.25	1.5	V
V _{CE(sat)}	Collector-emitter saturation	voltage	IC = 2 mA,	l _B =	0, l _F	= 16 mA		0.25	4	٧
rio	Input-to-output internal resistance		V _{in-out} = ±1. ±3. See Note 4		for MCT for MC		10 ¹¹			Ω
C _{io}	Input-to-output capacitance)	V _{in-out} = 0, See Note 4	f = 1	MHz,			1	,	pF

NOTE 4: These parameters are measured between both input diode leads shorted together and all the phototransistor leads shorted together.

switching characteristics

	PAR	AMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _r	Rise time	Dhototronoistor operation	V _{CC} = 10 V, I _{C(on)} = 2 mA,	5			
tf	Fall time	Phototransistor operation	$R_L = 100 \Omega$, See Test Circuit A of Figure 1		5		μs
tr	Rise time	Photodiode operation	V _{CC} = 10 V, I _{C(on)} 20 μA,	-	4		
tf	Fall time	rnotodiode operation	$R_L = 1 \text{ k}\Omega$, See Test Circuit B of Figure 1		ı		μs

PARAMETER MEASUREMENT INFORMATION



NOTES: A. The input waveform is supplied by a generator with the following characteristics: $Z_0 = 50 \Omega$, $t_f \le 15$ ns, duty cycle $\approx 1\%$, $t_W = 100 \mu s$.

B. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \le 12$ ns, $R_{in} \ge 1$ M Ω , $C_{in} \le 20$ pF.

Figure 1. Switching Times

COLLECTOR CURRENT INPUT-DIODE FORWARD CURRENT 100 V_{CE} = 10 V lB = 0 40 T_A = 25°C IC - Collector Current - mA 10 1 0.4 0.1 0.04 0.01 0.1 10 40 100 IF - Input-Diode Forward Current - mA

COLLECTOR-EMITTER VOLTAGE 60 $i_B = 0$ T_A = 25°C See Note A 50 C - Collector Current - mA 40 **Max Continuous Power Dissipation** 30 IF = 40 mA 20 IF = 30 mA IF = 20 mA 10 IF = 20 mA 0 8 10 12 14 16 V_{CE} - Collector-Emitter Voltage - V

COLLECTOR CURRENT

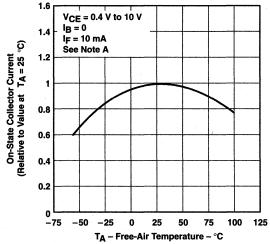
NOTE A. Pulse operation of input diode is required for operation beyond limits shown by dotted lines.

Figure 2

Figure 3

ON-STATE COLLECTOR CURRENT (RELATIVE TO VALUE AT 25°C)

vs FREE-AIR TEMPERATURE



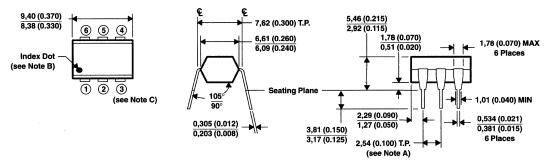
NOTE A. These parameters were measured using pulse techniques, $t_W=1$ ms, duty cycle ≤ 2 %.

Figure 4



MECHANICAL INFORMATION

The package consists of a gallium-arsenide infrared-emitting diode and an npn silicon phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case can withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



- NOTES: A. Leads are within 0,13 (0.005) radius of true position (T.P.) with maximum material condition and unit installed.
 - B. Pin 1 identified by index dot.
 - C. Terminal connections:
 - 1. Anode (part of the infrared-emitting diode)
 - 2. Cathode (part of the infrared-emitting diode)
 - 3. No internal connection
 - 4. Emitter (part of the phototransistor)
 - 5. Collector (part of the phototransistor)
 - 6. Base (part of the phototransistor)
 - D. The dimensions given fall within JEDEC MO-001 AM dimensions.
 - E. All linear dimensions are given in millimeters and parenthetically given in inches.

Figure 5. Mechanical Information

MOC3009 THRU MOC3012 OPTOCOUPLERS/OPTOISOLATORS

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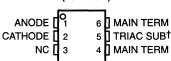
- 250 V Phototriac Driver Output
- Gallium-Arsenide-Diode Infrared Source and Optically Coupled Silicon Traic Driver (Bilateral Switch)
- UL Recognized ... File Number E65085
- High Isolation ... 7500 V Peak
- Output Driver Designed for 115 V ac
- Standard 6-Terminal Plastic DIP
- Directly Interchangeable with Motorola MOC3009, MOC3010, MOC3011, and MOC3012
- Direct Replacements for: TRW Optron OPI3009, C

TRW Optron OPI3009, OPI3010, OPI3011, and OPI3012;

General Instrument MCP3009, MCP3010, MCP3011;

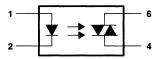
General Electric GE3009, GE3010, GE3011, and GE3012

MOC30209- MOC3012 . . . PACKAGE (TOP VIEW)



† Do not connect this terminal NC – No internal connection

logic diagram



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)†

Input-to-output peak voltage, 5 s maximum duration, 60 Hz (see Note 1)	
Input diode forward current, continuous	
Output repetitive peak off-state voltage	
Output on-state current, total rms value (50-60 Hz, full sine wave): T _A = 25°C	100 mA
$T_A = 70^{\circ}C$	50 mA
Output driver nonrepetitive peak on-state current (tw = 10 ms, duty cycle = 10%, see Figure 10 ms, dut	ure 7) 1.2 A
Continuous power dissipation at (or below) 25°C free-air temperature:	
Infrared-emitting diode (see Note 2)	100 mW
Phototriac (see Note 3)	
Phototriac (see Note 3) Total device (see Note 4)	300 mW
	300 mW 330 mW
Total device (see Note 4)	300 mW 330 mW 40°C to 100°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. Input-to-output peak voltage is the internal device dielectric breakdown rating.
 - 2. Derate linearly to 100°C free-air temperature at the rate of 1.33 mW/°C.
 - 3. Derate linearly to 100°C free-air temperature at the rate of 4 mW/°C.
 - 4. Derate linearly to 100°C free-air temperature at the rate of 4.4 mW/°C.

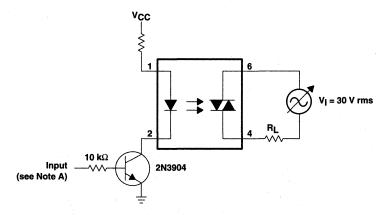
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electrical characteristics at 25°C free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT	
I _R	Static reverse current		V _R = 3 V			0.05	100	μА
٧F	Static forward voltage		IF = 10 mA			1.2	1.5	٧
DRM	Repetitive off-state current, either direction		V _{DRM} = 250 V,	See Note 5		10	100	nA
dv/dt	Critical rate of rise of off-	state voltage	See Figure 1			12		V/μs
dv/dt(c)	Critical rate of rise of cor	nmutating voltage	I _O = 15 mA, See Figure 1			0.15		V/μs
lFT	Input trigger current, either direction	MOC3009	Output supply voltage = 3 V		15	30	mA	
		MOC3010			. 8	15		
		MOC3011			5	10		
		MOC3012				5		
VTM	Peak on-state voltage, e	ither direction	I _{TM} = 100 mA			1.8	3	V
ΙН	Holding current, either direction					100		μА

NOTE 5: Test voltage must be applied within dv/dt rating.

PARAMETER MEASUREMENT INFORMATION



NOTE A. The critical rate of rise of off-state voltage, dv/dt, is measured with the input at 0 V. The frequency of V_{in} is increased until the phototriac just turns on. This frequency is then used to calculate the dv/dt according to the formula:

$$dv/dt = 2 \sqrt{2\pi f V_{in}}$$

The critical rate of rise of commutating voltage, dv/dt(c), is measured by applying occasional 5-V pulses to the input and increasing the frequency of V_{in} until the phototriac stays on (latches) after the input pulse has ceased. With no further input pulses, the frequency of V_{in} is then gradually decreased until the phototriac turns off. The frequency at which turn-off occurs may then be used to calculate the dv/dt(c) according to the formula shown above.

Figure 1. Critical Rate of Rise Test Circuit

EMITTING-DIODE TRIGGER CURRENT (NORMALIZED)

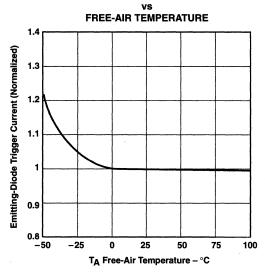


Figure 2

CRITICAL RATE OF RISE OF OUTPUT VOLTAGE OFF-STATE dv/dt AND COMMUTATING dv/dt(c)

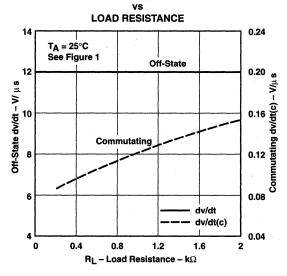


Figure 4

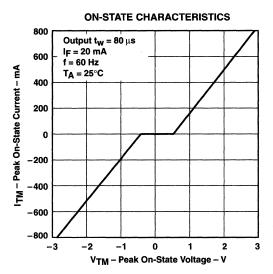


Figure 3

CRITICAL RATE OF RISE OF OUTPUT VOLTAGE OFF-STATE dv/dt AND COMMUTATING dv/dt(c)

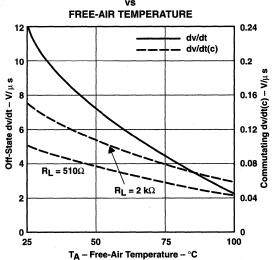
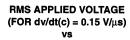


Figure 5



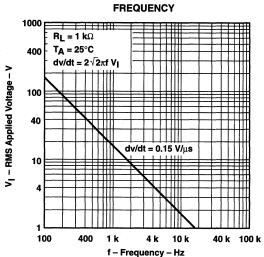


Figure 6

NONREPETITIVE PEAK ON-STATE CURRENT

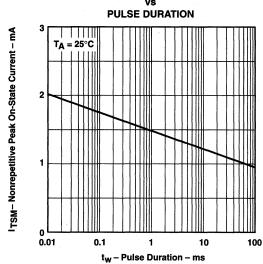


Figure 7

APPLICATIONS INFORMATION

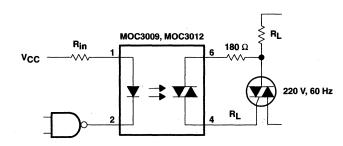


Figure 8. Resistive Load

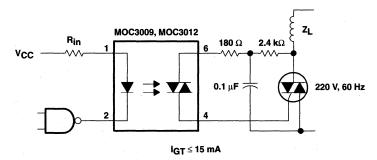


Figure 9. Inductive Load With Sensitive-Gate Triac

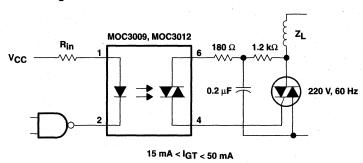
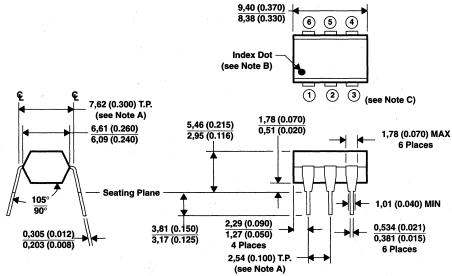


Figure 10. Inductive Load With Nonsensitive-Gate Triac

MECHANICAL INFORMATION

Each device consists of a gallium-arsenide infrared-emitting diode optically coupled to a silicon phototriac mounted on a 6-terminal lead frame encapsulated within an electrically nonconductive plastic compound. The case can withstand soldering temperature with no deformation and device performance characteristics remain stable with operated in high-humidity conditions.



- NOTES: A. Leads are within 0,13 mm (0.005 inch) radius of true position (T.P.) with maximum material condition and unit installed.
 - B. Pin 1 identified by index dot.
 - C. Terminal connections:
 - 1. Anode (part of infrared-emitting diode)
 - 2. Cathode (part of infrared-emitting diode)
 - 3. No internal connection
 - 4. Main terminal (part of phototriac)
 - 5. Triac Substrate (DO NOT connect) (part of phototriac)
 - 6. Main terminal (part of phototriac)
 - D. The dimensions given fall within JEDEC MO-001 AM dimensions.
 - E. All linear dimensions are given in millimeters and parenthetically given in inches.

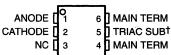
Figure 11. Mechanical Information

MOC3020 THRU MOC3023 OPTOCOUPLERS/OPTOISOLATORS

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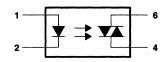
- 250 V Phototriac Driver Output
- Gallium-Arsenide-Diode Infrared Source and Optically-Coupled Silicon Traic Driver (Bilateral Switch)
- UL Recognized ... File Number E65085
- High Isolation ... 7500 V Peak
- Output Driver Designed for 220 V ac
- Standard 6-Terminal Plastic DIP
- Directly Interchangeable with Motorola MOC3020, MOC3021, MOC3022, and MOC3023
- Direct Replacements for:
 - TRW Optron OPI3020, OPI3021, OPI3022, and OPI3023;
 - General Instrument MCP3020, MCP3021, and MCP3022;
 - General Electric GE3020, GE3021, GE3022, and GE3023

MOC3020 - MOC3023 . . . PACKAGE (TOP VIEW)



† Do not connect this terminal NC – No internal connection

logic diagram



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)†

Input-to-output peak voltage, 5 s maximum duration, 60 Hz (see Note 1)	
Input diode reverse voltage	3 V
Input diode forward current, continuous	50 mA
Output repetitive peak off-state voltage	
Output on-state current, total rms value (50-60 Hz, full sine wave): T _A = 25°C	
$T_A = 70^{\circ}C$	50 mA
Output driver nonrepetitive peak on-state current (tw = 10 ms, duty cycle = 10%, see Figu	ure 7) 1.2 A
Continuous power dissipation at (or below) 25°C free-air temperature:	
Continuous power dissipation at (or below) 25°C free-air temperature: Infrared-emitting diode (see Note 2)	100 mW
·	
Infrared-emitting diode (see Note 2)	300 mW
Infrared-emitting diode (see Note 2) Phototriac (see Note 3)	300 mW
Infrared-emitting diode (see Note 2) Phototriac (see Note 3) Total device (see Note 4)	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. Input-to-output peak voltage is the internal device dielectric breakdown rating.
 - 2. Derate linearly to 100°C free-air temperature at the rate of 1.33 mW/°C.
 - Derate linearly to 100°C free-air temperature at the rate of 4 mW/°C.
 Derate linearly to 100°C free-air temperature at the rate of 4.4 mW/°C.



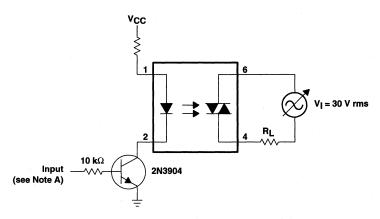
SOES025 - OCTOBER 1986 - REVISED OCTOBER 1995

electrical characteristics at 25°C free-air temperature (unless otherwise noted)

	PARAMETER		TEST C	ONDITIONS	MIN	TYP	MAX	UNIT
IR	Static reverse current		V _R = 3 V			0.05	100	μА
٧ _F	Static forward voltage		I _F = 10 mA			1.2	1.5	V
I(DRM)	Repetitive off-state current, either direction		$V_{(DRM)} = 400 V$	See Note 5		10	100	nΑ
dv/dt	Critical rate of rise of off-state voltage		See Figure 1		.	100		V/μs
dv/dt(c)	Critical rate of rise of commutating voltage		I _O = 15 mA,	See Figure 1		0.15	,	V/μs
I _{FT}	Input trigger current, either direction	MOC3020	Output supply voltage = 3 V		15	30	mA	
		MOC3021			8	15		
		MOC3022			5	10		
		MOC3023			3	5		
Vтм	Peak on-state voltage, either direction		I _{TM} = 100 mA			1.4	3	٧
ŀН	Holding current, either direction					100		μА

NOTE 5: Test voltage must be applied at a rate no higher than 12 V/μs.

PARAMETER MEASUREMENT INFORMATION



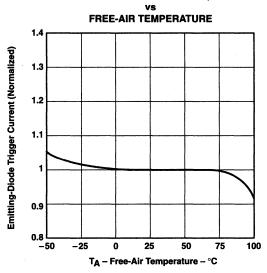
NOTE A. The critical rate of rise of off-state voltage, dv/dt, is measured with the input at 0 V. The frequency of V_{in} is increased until the phototriac turns on. This frequency is then used to calculate the dv/dt according to the formula:

$$dv/dt = 2 \sqrt{2\pi fV_{in}}$$

The critical rate of rise of commutating voltage, dv/dt(c), is measured by applying occasional 5-V pulses to the input and increasing the frequency of V_{in} until the phototriac stays on (latches) after the input pulse has ceased. With no further input pulses, the frequency of V_{in} is then gradually decreased until the phototriac turns off. The frequency at which turn-off occurs may then be used to calculate the dv/dt(c) according to the formula shown above.

Figure 1. Critical Rate of Rise Test Circuit

EMITTING-DIODE TRIGGER CURRENT (NORMALIZED)



ON-STATE CHARACTERISTICS

800
600
I_F = 20 mA
f = 60 Hz
T_A = 25°C

200
-200
-400
-400
-600

Figure 2

Figure 3

V_{TM} - Peak On-State Voltage - V

NONREPETITIVE PEAK ON-STATE CURRENT

-800

-3

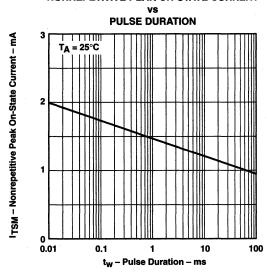


Figure 4

3

APPLICATIONS INFORMATION

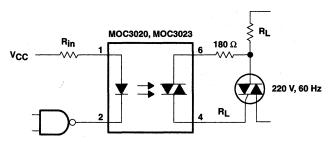


Figure 5. Resistive Load

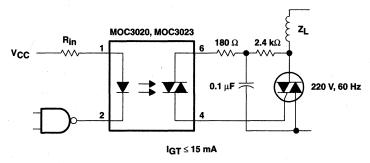


Figure 6. Inductive Load With Sensitive-Gate Triac

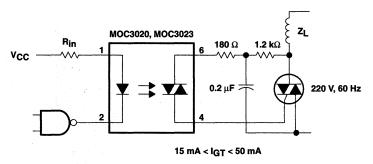
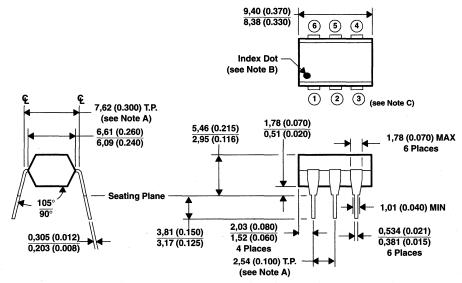


Figure 7. Inductive Load With Nonsensitive-Gate Triac

MECHANICAL INFORMATION

Each device consists of a gallium-arsenide infrared-emitting diode optically coupled to a silicon phototriac mounted on a 6-terminal lead frame encapsulated within an electrically nonconductive plastic compound. The case can withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions.



NOTES: A. Leads are within 0,13 (0.005) radius of true position (T.P.) with maximum material condition and unit installed.

- B. Pin 1 identified by index dot.
- C. Terminal connections:
 - 1. Anode (part of the infrared-emitting diode)
 - 2. Cathode (part of the infrared-emitting diode)
 - 3. No internal connection
 - 4. Main terminal (part of the phototransistor)
 - 5. Triac Substrate (DO NOT connect) (part of the phototransistor)
 - 6. Main terminal (part of the phototransistor)
- D. The dimensions given fall within JEDEC MO-001 AM dimensions.
- E. All linear dimensions are given in millimeters and parenthetically given in inches.

Figure 8. Mechanical Information

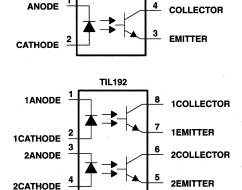
- Gallium-Arsenide-Diode Infrared Source
- Source Is Optically Coupled to Silicon npn **Phototransistor**
- Choice of One, Two, or Four Channels
- **Choice of Three Current-Transfer Ratios**
- High-Voltage Electrical Isolation 3.535 kV Peak (2.5 kV rms)
- Plastic Dual-In-Line Packages
- UL Listed File #E65085

description

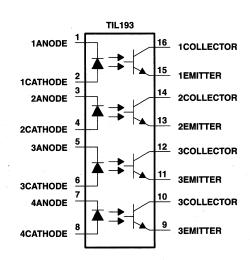
These optocouplers consist of a gallium-arsenide light-emitting diode and a silicon npn phototransistor per channel. The TIL191 has a channel in a 4-terminal package, the TIL192 has two channels in an 8-terminal package, and the TIL193 has four channels in a 16-terminal package. The standard devices, TIL191, TIL192, and TIL193, are tested for a current-transfer ratio of 20% minimum. Devices selected for a current-transfer ratio of 50% and 100% minimum are designated with the suffix A and B respectively.

schematic diagrams

ANODE 1



TIL191



absolute maximum ratings at 25°C free-air (unless otherwise noted)†

· · · · · · · · · · · · · · · · · · ·	
Input-to-output voltage (see Note 1)	. ±3.535 kV peak or dc (±2.5 kV rms)
Collector-emitter voltage (see Note 2)	35 V
Emitter-collector voltage	7 V
Input diode reverse voltage	5 V
Input diode continuous forward current at (or below) 25°C free-air temp	perature
(see Note 3)	50 mA
Continuous total power dissipation at (or below) 25°C free-air tempera	ture:
Phototransistor (see Note 4)	150 mW
Input diode plus phototransistor per channel (see Note 5)	200 mW
Storage temperature range, T _{stq}	–55°C to 125°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. This rating applies for sine-wave operation at 50 Hz or 60 Hz. This capability is verified by testing in accordance with UL requirements.
 - This value applies when the base-emitter diode is open circuited.
 - 3. Derate linearly to 100°C free-air temperature at the rate of 0.67 mA/°C.
 - 4. Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C.
 - 5. Derate linearly to 100°C free-air temperature at the rate of 2.67 mW/°C.



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electrical characteristics 25°C free-air temperature range (unless otherwise noted)

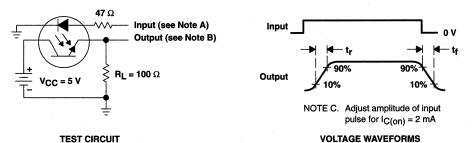
	PARAMETER		TEST CON	DITIONS	MIN	TYP	MAX	UNIT
V _{(BR)CEO}	Collector-emitter breakdown voltage		I _C = 0.5 mA,	lF = 0	35			٧
V(BR)ECO	Emitter-collector breakdown voltage		I _C = 100 μA,	i= 0	7			٧
I _R	Input diode static reverse current		V _R = 5 V				10	μА
IC(off))	Off-state collector current		V _{CE} = 24 V,	lF = 0			100	nA
		TIL191, TIL192, TIL193			20%			
CTR	Current transfer ratio	TIL191A, TIL192A, TIL193A	l _F = 5 mA	V _{CE} = 5 V	50%			
		TIL191B, TIL192B, TIL193B			100%			
٧ _F	Input diode static forward voltage	·	IF = 20 mA				1.4	٧
V _{CE(sat)}	Collector-emitter saturation voltage		IF = 5 mA	I _C = 1 mA			0.4	V
Cio	Input-to-output capacitance		V _{in-out} = 0 mA	f = 1 MHz,	4	1		pF
rio	Input-to-output internal resistance		V _{in-out} = ±1 mA	See Note 6		1011		Ω

NOTE 6: These parameters are measured between all input diode leads shorted together and all phototransistor leads shorted together.

switching characteristics at 25°C free-air temperature

PARAMETER		TEST C	TYP	UNIT	
tr	Rise time	V _{CC} = 5 V,	I _{C(on)} = 2 mA,	6	
tf	Fall time	$R_L = 100 \Omega$,	See Figure 1	6	μs

PARAMETER MEASUREMENT INFORMATION



NOTES: A. The input waveform is supplied by a generator with the following characteristics: $Z_{OUT} = 50 \ \Omega$, $t_r \le 15 \ ns$, $t_W 100 \ \mu s$. B. The output waveform is monitored on a oscilloscope with the following characteristic: $t_T \le 12 \ ns$, $R_{in} \ge 1M \ \mu s$, $C_{in} \le 20 \ pF$.

Figure 1. Switching Times

TYPICAL CHARACTERISTICS

C - Collector Current - mA

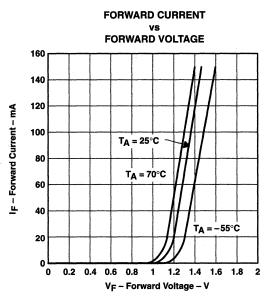
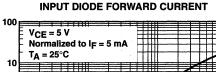


Figure 2

ON-STATE COLLECTOR CURRENT (NORMALIZED)



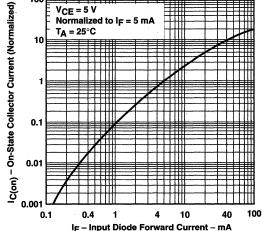


Figure 4

TIL191, TIL192, TIL193 **COLLECTOR CURRENT**

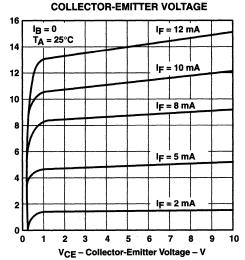


Figure 3

ON-STATE COLLECTOR CURRENT (RELATIVE TO VALUE AT 25°C)

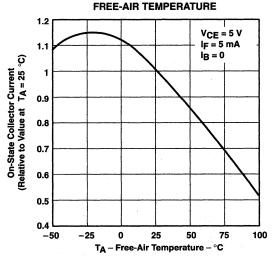


Figure 5

TYPICAL CHARACTERISTICS

COLLECTOR-EMITTER SATURATION VOLTAGE

vs FREE-AIR TEMPERATURE

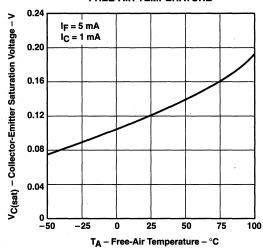


Figure 6

APPLICATION INFORMATION

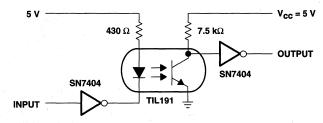
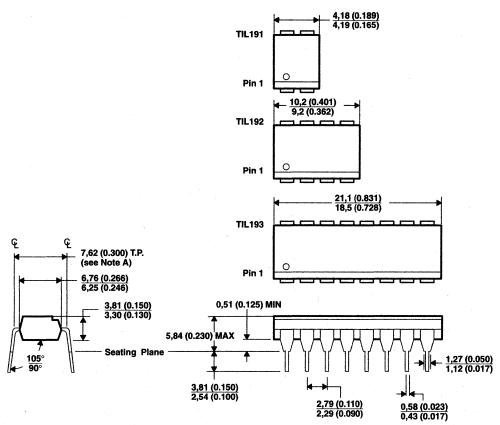


Figure 7

MECHANICAL INFORMATION



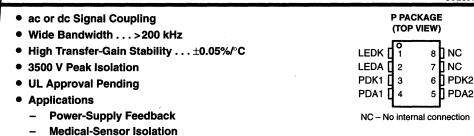
NOTES: A. Each pin centerline is located within 0,25 (0.010) of its true longitudinal position.

B. All linear dimensions are given in millimeters and parenthetically given in inches.

Figure 8. Mechanical Information

TIL300, TIL300A PRECISION LINEAR OPTOCOUPLER

SOES019 - OCTOBER 1995



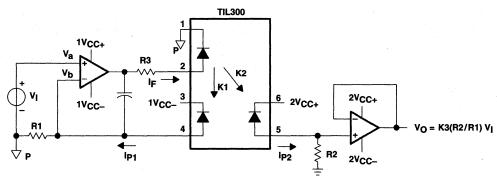
- Opto Direct-Access Arrangement (DAA)

Isolated Process-Control Transducers

description

The TIL300 precision linear optocoupler consists of an infrared LED irradiating an isolated feedback photodiode and an output photodiode in a bifurcated arrangement. The feedback photodiode captures a percentage of the flux of the LED and generates a control signal that can be used to regulate the LED drive current. This technique is used to compensate for the nonlinear time and temperature characteristics of the LED. The output-side photodiode produces an output signal that is linearly proportional to the servo-optical flux emitted from the LED.

A typical application circuit (shown in Figure 1) uses an operational amplifier as the input to drive the LED. The feedback photodiode sources current through R1, which is connected to the inverting input of the input operational amplifier. The photocurrent I_{P1} assumes a magnitude that satisfies the relationship $I_{P1} = V_I/R1$. The magnitude of the current is directly proportional to the LED current through the feedback transfer gain $K1(V_I/R1 = K1 \times I_P)$. The operational amplifier supplies LED current to produce sufficient photocurrent to keep the node voltage V_b equal to node voltage V_a



NOTES: A. K1 is servo current gain, the ratio of the feedback photodiode current (Ip) to the input LED current (Ip), i.e. k1 = Ip1/Ip.

B. K2 is forward gain, the ratio of the output photodiode current (Ip2) to the input LED current (Ip), i.e. K2 = Ip2/Ip.

C. K3 is transfer gain, the ratio of the forward gain to the servo gain, i.e. K3 = K2/K1.

Figure 1. Typical Application Circuit



TIL300, TIL300A PRECISION LINEAR OPTOCOUPLER

SOES019 - OCTOBER 1995

Terminal Functions

TERMINAL		VO	DESCRIPTION
NAME	NO.	100	DESCRIPTION
LEDK	1		LED cathode
LEDA	2		LED anode
PDK1	3		Photodiode 1 cathode
PDA1	4		Photodiode 1 anode
PDA2	5		Photodiode 2 anode
PDK2	6		Photodiode 2 cathode
NC	7		No internal connection
NC	8		No internal connection

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Emitter	
Continuous power dissipation (see Note 1)	
Input LED forward current, I _F	60 mA
Surge current with pulse width < 10 μs	250 mA
Reverse voltage, V _R	5 V
Reverse current, IR	
Detector	
Continuous power dissipation (see Note 2)	50 mW
Reverse voltage, V _R	50 V
Coupler	
Continuous power dissipation (see Note 3)	210 mW
Storage temperature, T _{stq}	–55°C to 150°C
Operating temperature, T _A	
Input-to-output voltage	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	
NOTES: 1. Derate linearly from 25°C at a rate of 2.66 mW/°C.	
2. Derate linearly from 25°C at a rate of 0.66 mW/°C.	
3. Derate linearly from 25°C at a rate of 3.33 mW/°C.	



electrical characteristics at T_A = 25°C

Emitter

PARAMETER VF Forward voltage		CON	CONDITIONS			MAX	UNIT
		I _F = 10 mA			1.25	1.50	٧
	V _F temperature coefficient			T	-2.2		mV/°C
I _R	Reverse current	V _R = 5 V				10	μΑ
t _r	Rise time	I _F = 10 mA,	$\Delta I_F = 2 \text{ mA}$		1		μs
tf	Fall time	I _F = 10 mA,	ΔI _F = 2 mA		1		μs
Cj	Junction capacitance	V _F = 0,	f = 1 MHz		15		pF

Detector

	PARAMETER		CONDITIONS			MAX	UNIT
I _{DK} †	Dark current	V _R = 15 V,	IF = 0			25	nA
	Open circuit voltage	IF = 10 mA			0.5		٧
los	Short circuit current limit	l _F = 10 mA			80		μΑ
Cj	Junction capacitance	V _F = 0,	f = 1 MHz		12		pF

Coupler

	PARAMETER		CONDIT	TIONS	MIN	TYP	MAX	UNIT	
K1‡	Servo current gain		IF = 1 mA	0.3%	0.5%	0.8%			
K1+	Servo current gain		IF = 10 mA	0.5%	0.8%	1.1%			
K2§	Forward current gain			IF = 1 mA	0.3%	0.5%	0.8%		
K28			Detector bias	IF = 10 mA	0.5%	0.8%	1.1%		
		TIL300	voltage = −15 V	IF = 1 mA	0.75	1	1.25		
кз¶	Transfer gain	TILSOO		IF = 10 mA	0.75	1	1.25		
	rransier gain	TIL300A		IF = 1 mA	0.9	1.	1.10		
				I _F = 10 mA	0.9	1	1.10		
	Cain temperature acefficient	K1/K2	1- 10 1		-0.5			%/°C	
	Gain temperature coefficient	K3		iain temperature coefficient K3 IF = 10 mA			±0.005		%/°C
#	T					±0.25%			
∆K3#	Transfer gain linearity		I _F = 1 to 10 mA,	T _A = 0 to 75°C		±0.5%			
BW	Bandwidth		I _F = 10 mA, I _F (MODULATION)	R _L = 50 Ω,	200			kHz	
tr	Rise time		IF = 10 mA, IF(MODULATION)	$R_L = 50 \Omega$,		1.75		μs	
t _f			I _F = 10 mA, I _F (MODULATION)	R _L = 50 Ω,		1.75		μs	
v _{iso} †	Peak Isolation voltage		I _{IO} = 10 μA,	f = 60 Hz	3500			٧	

[†] This symbol is not currently listed within EIA or JEDEC standards for semiconductor symbology.

^{\$\}frac{1}{2}\$ Servo current gain (K1) is the ratio of the feedback photodiode current (Ip1) to the input LED current (Ip) current (Ip), i.e. K1 = Ip1/Ip.

[§] Forward gain (K2 is the ratio of the output photodiode current (Ip2) to the input LED current (Ip), i.e. $K2 = Ip2/I_F$.

Transfer gain (K3) is the ratio of the forward gain to the servo gain, i.e. K3 = K2/K1.

[#] Transfer gain linearity (ΔK3) is the percent deviation of the transfer gain K3 as a function of LED input current (IF) or the package temperature.

TIL3009 THRU TIL3012 OPTOCOUPLERS/OPTOISOLATORS

SOES027 - DECEMBER 1987 - REVISED OCTOBER 1995

- 250-V Phototriac Driver Output
- Gallium-Arsenide-Diode Infrared Source and Optically-Coupled Silicon Triac Driver (Bilateral Switch)
- UL Recognized . . . File Number E65085
- High Isolation . . . 3535 V peak
- Output Driver Designed for 115 V AC
- Standard 6-Pin Plastic DIP

ANODE O 1 6 MAIN TERM CATHODE 2 5 TRIAC SUBT NC 3 4 MAIN TERM

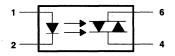
TIL30209- TIL3012 . . . PACKAGE

† Do not connect this terminal NC – No internal connection

description

Each device consists of a gallium-arsenide infrared-emitting diode optically coupled to a silicon phototriac mounted on a 6-pin lead frame encapsulated within an electrically nonconductive plastic compound. The case withstands soldering temperature with no deformation. Device performance characteristics remain stable when operated in high-humidity conditions.

logic diagram



absolute maximum ratings at 25°C free-air (unless otherwise noted)†

Input-to-output peak voltage, 5 s maximum duration, 60 Hz (see Note 1)	
Input diode reverse voltage	
Input diode forward current, continuous	
Output on-state current, total rms value (50-60 Hz, full sine wave):	250 V
T _A = 25°	100 mA
T _A = 70°	50 mA
Output driver nonrepetitive peak on-state current	
(t _w = 10 ms, duty cycle = 10%, see Figure 7)	1.2 mA
Continuous power dissipation at (or below) 25°C free-air temperature:	
Infrared-emitting diode (see Note 2)	100 mW
Phototriac (see Note 3)	300 mW
Total device (see Note 4)	
Operating junction temperature range, T _J	40°C to 100°C
Storage temperature range, T _{stg}	40°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. Input-to-output peak voltage is the internal device dielectric breakdown rating.

- 2. Derate linearly to 100°C free-air temperature at the rate of 1.33 mW/°C.
- 3. Derate linearly to 100°C free-air temperature at the rate of 4 mW/°C.
- 4. Derate linearly to 100°C free-air temperature at the rate of 4.4 mW/°C.



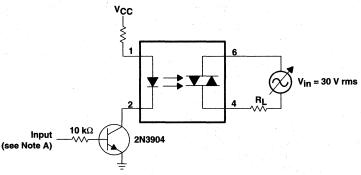
SOES027 - DECEMBER 1987 - REVISED OCTOBER 1995

electrical characteristics 25°C free-air temperature range (unless otherwise noted)

	PARAMETER		TEST COI	NDITIONS	MIN T	ΥP	MAX	UNIT
^I R	IR Static reverse current		V _R = 3 V		0	.05	100	μΑ
٧F	Static forward voltage		I _F = 10 mA		14.5	1.2	1.5	٧
IDRM			V _{DRM} = 250 V,	See Note 5	1.5	10	100	nΑ
dv/dt			See Figure 1			12		V/μs
dv/dt(c)	Critical rate of rise of communication voltage		I _O = 15 mA,	See Figure 1	0	.15		V/μs
		TIL3009	Output supply voltage = 3 V		15	30		
	formers suite and accompany and a state and allowers as an	TIL3010				8	15	4
IFT	Input trigger current either direction	TIL3011			5	10	mA	
		TIL3012					5	
V _{TM}	Peak on-state voltage, either direction	Peak on-state voltage, either direction				1.8	3	V
l _H	Holding current, either direction				- 1	00		μА

NOTE 5: Test voltage must be applied within dv/dt rating.

PARAMETER MEASUREMENT INFORMATION



NOTE A. The critical rate of rise of off-state voltage, dv/dt, is measured with the input of 0 volts. The frequency of Vin is increased until the phototriac turns on. This frequency is then used to calculate the dv/dt according to the following formula:

$$dv/dt = 2\sqrt{2}\pi fV_{in}$$

The critical rate of rise of commutating voltage, dv/dt(c), is measured by applying occasional 5-volt pulses to the input and increasing the frequency of Vin until the phototriac remains on (latches) after the input pulse has ceased. With no further input pulses., the frequency of Vin is then gradually decreased until the phototriac turns off. The frequency at which turn-off occurs can then be used to calculate the dv/dt(c) according to the formula shown above.

Figure 1. CRITICAL RATE OF RISE TEST CIRCUIT

TYPICAL CHARACTERISTICS

EMITTING DIODE TRIGGER CURRENT (NORMALIZED)

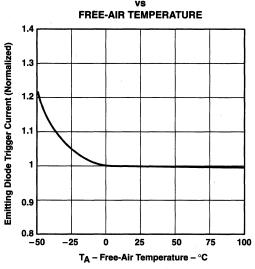


Figure 2

CRITICAL RATE OF RISE OF OUTPUT VOLTAGE OFF-STATE dv/dt AND COMMUTATING dv/dt(c)

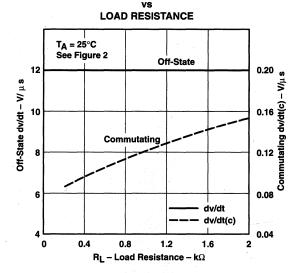


Figure 4

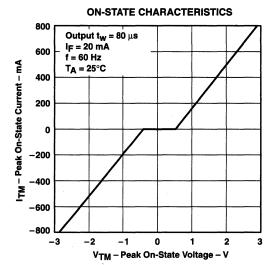


Figure 3

CRITICAL RATE OF RISE OF OUTPUT VOLTAGE OFF-STATE dv/dt AND COMMUTATING dv/dt(c)

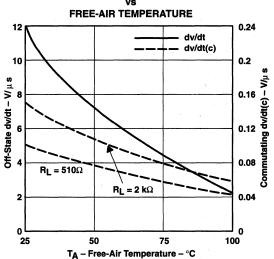
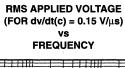


Figure 5

TYPICAL CHARACTERISTICS



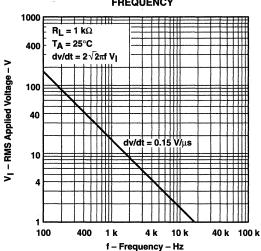
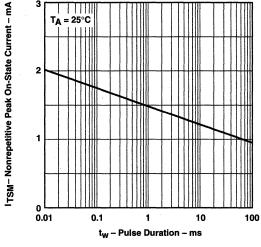


Figure 6

PULSE DURATION T_A = 25°C



NONREPETITIVE PEAK ON-STATE CURRENT

Figure 7

APPLICATION INFORMATION

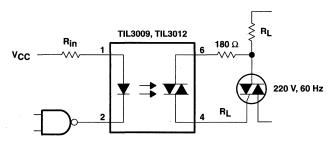


Figure 8. Resistive Load

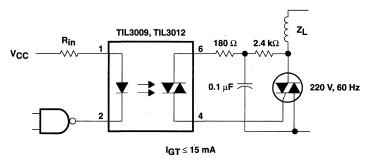


Figure 9. Inductive Load With Sensitive-Gate Traic

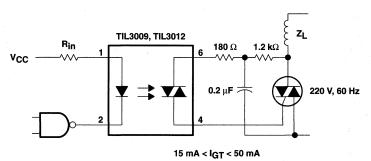
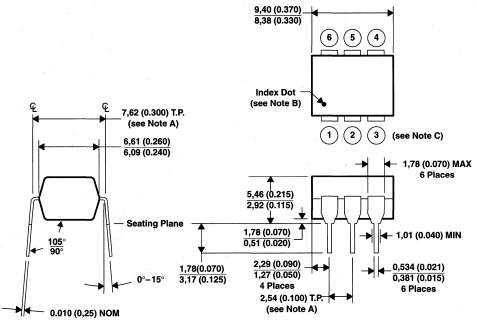


Figure 10. Inductive Load With Nonsensitive-Gate Triac

MECHANICAL INFORMATION



NOTES: A. Leads are within 0.13 mm (0.005 inch) radius of true position (T.P.) with maximum material condition and unit installed.

- B. Pin 1 identified by index dot.
- C. Terminal connections:
 - 1. Anode (part of infrared-emitting diode)
 - 2. Cathode (part of infrared-emitting diode)
 - 3. No internal connection
 - 4. Main terminal (part of phototriac)
 - 5. Triac Substrate (DO NOT connect) (part of phototriac)
 - 6. Main terminal (part of phototriac)
- D. The dimensions given fall within JEDEC MO-001 AM dimensions.
- E. All linear dimensions are given in millimeters and parenthetically given in inches.

Figure 11. Mechanical Information

SOES028 - DECEMBER 1987 - REVISED OCTOBER 1995

- 400-V Phototriac Driver Output
- Gallium-Arsenide-Diode Infrared Source and Optically-Coupled Silicon Triac Driver (Bilateral Switch)
- UL Recognized . . . File Number E65085
- High Isolation . . . 3535 V peak
- Output Driver Designed for 220 V AC
- Standard 6-Pin Plastic DIP

ANODE O 1 6 MAIN TERM CATHODE 2 5 TRIAC SUBT NC 3 4 MAIN TERM

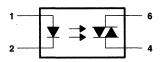
TIL3020 - TIL3023 . . . PACKAGE

† Do not connect this terminal NC – No internal connection

description

Each device consists of a gallium-arsenide infrared-emitting diode optically coupled to a silicon phototriac mounted on a 6-pin lead frame encapsulated within an electrically nonconductive plastic compound. The case withstands soldering temperature with no deformation. Device performance characteristics remain stable when operated in high-humidity conditions.

logic diagram



absolute maximum ratings at 25°C free-air (unless otherwise noted)†

Input-to-output peak voltage, 5 s maximum duration, 60 Hz (see Note 1)		
Input diode reverse voltage		
Input diode forward current, continuous	 	50 mA
Output repetitive peak off-state voltage	 	250 V
Output on-state current, total rms value (50-60 Hz, full sine wave):		
T _A = 25°C	10	00 mA
$T_A = 70$ °C	 	50 mA
	 	OU IIIA
Output driver nonrepetitive peak on-state current		
(t _w = 10 ms, duty cycle = 10%, see Figure 7)	 1	.2 mA
Continuous power dissipation at (or below) 25°C free-air temperature:		
Infrared-emitting diode (see Note 2)	 10	00 mW
Phototriac (see Note 3)		
Total device (see Note 4)		
Operating junction temperature range, T _J	 40°C to	100°C
Storage temperature range, T _{stq}		
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	 	26000
Lead temperature 1,6 mm (1/16 mcn) from case for 10 seconds	 	200.0

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. Input-to-output peak voltage is the internal device dielectric breakdown rating.
 - 2. Derate linearly to 100°C free-air temperature at the rate of 1.33 mW/°C.
 - 3. Derate linearly to 100°C free-air temperature at the rate of 4 mW/°C.
 - 4. Derate linearly to 100°C free-air temperature at the rate of 4.4 mW/°C.



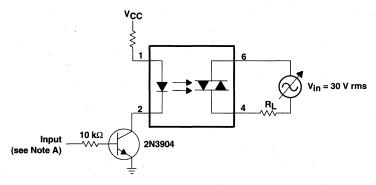
SOES028 - DECEMBER 1987 - REVISED OCTOBER 1995

electrical characteristics 25°C free-air temperature range (unless otherwise noted)

	PARAMETER		TEST CON	NDITIONS	MIN	TYP	MAX	UNIT
I _R	I _R Static reverse current		V _R = 3 V			0.05	100	μА
٧F	static forward voltage		I _F = 10 mA			1.2	1.5	V
IDRM			V _{DRM} = 250 V,	See Note 5		10	100	nA
dv/dt			See Figure 1			100		V/μs
dv/dt(c)	Critical rate of rise of communication voltage		IO = 15 mA,	See Figure 1		0.15		V/μs
		TIL3020	Output supply voltage = 3 V	1	15	30		
l	Input trigger current, either direction	TIL3021			8	15	mA	
^I FT	input trigger current, ettrier direction	TIL3022			5	10	IIIA	
		TIL3023				. 3	5	
V _{TM}			I _{TM} = 100 mA			1.4	3	٧
lΗ						100		μΑ

NOTE 5: Test voltage must be applied at a rate no higher than 12 V/µs.

PARAMETER MEASUREMENT INFORMATION



NOTE A. The critical rate of rise of off-state voltage, dv/dt, is measured with the input of 0 volts. The frequency of V_{in} is increased until the phototriac turns on. This frequency is then used to calculate the dv/dt according to the following formula:

$$dv/dt = 2\sqrt{2}\pi fV_{in}$$

The critical rate of rise of commutating voltage, dv/dt(c), is measured by applying occasional 5-volt pulses to the input and increasing the frequency of V_{in} until the phototriac remains on (latches) after the input pulse has ceased. With no further input pulses,, the frequency of V_{in} is then gradually decreased until the phototriac turns off. The frequency at which turn-off occurs can then be used to calculate the dv/dt(c) according to the formula shown above.

Figure 1. Critical Rate of Rise Test Circuit

TYPICAL CHARACTERISTICS

EMITTING DIODE TRIGGER CURRENT (NORMALIZED)

Figure 2

0.01

0.1

Figure 3

0

V_{TM} - Peak On-State Voltage - V

NONREPETITIVE PEAK ON-STATE CURRENT

-3

-2

PULSE DURATION

Am - transported Points of Control of C

t_w – Pulse Duration – ms Figure 4

1

10

100

3

2

APPLICATION INFORMATION

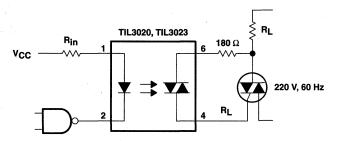


Figure 5. Resistive Load

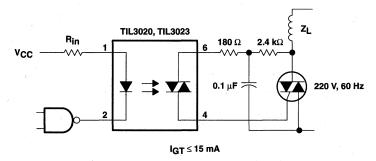


Figure 6. Inductive Load With Sensitive-Gate Traic

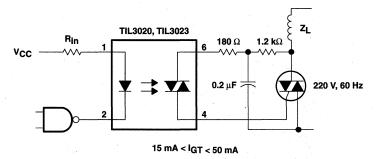
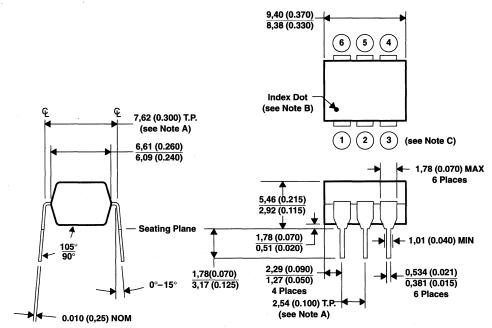


Figure 7. Inductive Load With Nonsensitive-Gate Triac

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MECHANICAL INFORMATION



NOTES: A. Leads are within 0,13 (0.005) radius of true position (T.P.) with maximum material condition and unit installed.

- B. Pin 1 identified by index dot.
- C. Terminal connections:
 - 1. Anode (part of the infrared-emitting diode)
 - 2. Cathode (part of the infrared-emitting diode)
 - 3. No internal connection
 - 4. Main terminal (part of the phototransistor)
 - 5. Triac Substrate (DO NOT connect) (part of the phototransistor)
 - 6. Main terminal (part of the phototransistor)
- D. The dimensions given fall within JEDEC MO-001 AM dimensions.
- E. All linear dimensions are given in millimeters and parenthetically given in inches.

Figure 8. Mechanical Information

- TL431 Precision Programmable Reference and an Optocoupler in a Single Package
- 0.4% Voltage-Reference Tolerance
- Controlled Optocoupler CTRs:

TPS5904

100% to 400%

TPS5904A 150% to 300%

- High Withstand Voltage (WTV), 7500 V Peak for 1 Minute
- UL Recognized File #E65085
- VDE 884 Agency Approval Pending

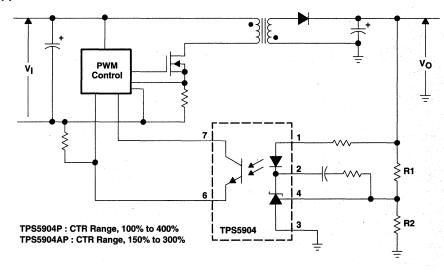
P PACKAGE (TOP VIEW) LED 1 8 NC COMP 2 7 C GND 3 6 E FB 4 5 NC NC - No internal connection

description

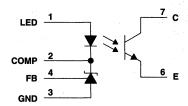
The TPS5904 and TPS5904A opto-isolated feedback amplifiers consist of the industry standard TL431 precision programmable reference with a 0.4% reference voltage tolerance, and an optocoupler. The devices are primarily intended for use as the error-amplifier/reference/isolation-amplifier element in isolated ac-to-dc power supplies and dc-to-dc converters. The optocoupler is a gallium-arsenide (GaAs) light-emitting diode that emits at a wavelength of 940 nm, combined with a silicon phototransistor. The current transfer ratio (CTR) ranges from 100% to 400% in the standard version. The TPS5904A version with a 150%-to-300% CTR is available for higher-performance applications. When using the TPS5904 or TPS5904A, power-supply designers can reduce component count and save space in tightly packaged designs. The tight-tolerance reference eliminates the need for adjustments in many applications.

The TPS5904 and TPS5904A are characterized for operation from -40°C to 100°C. Each device is supplied in an 8-pin DIP package.

typical application



functional block diagram



Terminal Functions

TERMINAL		1/0	DESCRIPTION				
NAME	NO.	100		DESCRIPTION			
С	7		Phototransistor collector				
COMP	2	0	Light-emitting diode and TL431 cathodes				
E	6		Phototransistor emitter				
FB	4	1	Feedback				
GND	3		Ground				
LED	1,	1	Light-emitting diode anode				
NC	5, 8		No connection				

absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)†

Input power dissipation at (or below) T _A = 25°C (see Note 1)	250 mW
Input LED current, I _{I(LED)}	
Input LED voltage, V _{I(LED)}	37 V
Input diode reverse voltage	
Output power dissipation at (or below) T _A = 25°C (see Note 2)	150 mW
Output collector-to-emitter voltage	
Output emitter-to-collector voltage	
Output collector current	
Total continuous power dissipation at (or below) T _A = 25°C (see Note 3)	350 mW
Operating free-air temperature range, T _A	
Storage temperature range, T _{stg}	
Total input-to-output voltage	7.5 kV peak or dc (5.3 kVrms)
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C
Flammability	(see Note 4)

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. Derate linearly from 25°C at a rate of 2.95 mW/°C.
 - 2. Derate linearly from 25°C at a rate of 1.76 mW/°C.
 - 3. Derate linearly from 25°C at a rate of 4.12 mW/°C.
 - Optocoupler total-package flame retardancy is tested to IEC695-2-2 using a flame application time of 30 seconds. Outer mold compound is verified to meet UL 94V-0.



electrical characteristics, $T_A = 25^{\circ}C$ (unless otherwise noted)

input

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
VF	Light-emitting diode forward voltage	VO(COMP) = VI(FB), See Figure 1	I _{I(LED)} = 10 mA,		1.2	1.4	V
I _R	Light-emitting diode reverse current	V _R = 6 V				10	μΑ
V _{ref}	Reference voltage	VO(COMP) = VI(FB), See Figure 1	I _{I(LED)} = 10 mA,	2.49	2.5	2.51	٧
V _{ref(dev)}	Deviation of reference voltage over temperature	V _O (COMP) = V _I (FB), T _A = 25°C to 100°C,	I _{I(LED)} = 10 mA, See Figure 1		25		mV
$\frac{\Delta V_{ref}}{\Delta V_{l(LED)}}$	Ratio of reference voltage change-to- change in input light-emitting-diode voltage	$\Delta V_{I(LED)} = 4 \text{ V to } 37 \text{ V},$ See Figure 2	I _{I(LED)} = 10 mA,		-1.1	-2	mV/V
^I I(FB)	Feedback input current	I _{I(LED)} = 10 mA, See Figure 2	$R3 = 10 \text{ k}\Omega$,		1.5	3	μА
Iref(dev)	Deviation of reference input current over temperature	I _{I(LED)} = 10 mA, T _A = 25°C to 100°C,	R3 = 10 kΩ, See Figure 3		0.5		μΑ
IDRV(min)	Minimum drive current	$V_{O(COMP)} = V_{I(FB)}$	See Figure 1		0.45	1	mA
I _{I(off)}	Off-state input light-emitting-diode current	V _{I(LED)} = 37 V, See Figure 4	$V_{I(FB)} = 0$,		0.18	0.5	μΑ
ız _{ka} ı†	Regulator output impedance	$V_{O(COMP)} = V_{I(FB)}$, $I_{O(COMP)} = 1 \text{ mA to } 50 \text{ mB}$	f≤1 kHz, mA		0.1		Ω

[†] This symbol is not currently listed within EIA or JEDEC standards for semiconductor symbology.

output

	PARAMETER	TEST (CONDITIONS	MIN	TYP	MAX	UNIT
ICEO	Collect dark current	V _{CE} = 35 V,	See Figure 5			100	nA
V _{(BR)ECO}	Emitter-collector voltage breakdown	I _E = 100 μA		7			V

coupler

PARAMETER			TEST CONDITIONS		MIN	TYP	MAX	UNIT
CTD	Current transfer ratio	TPS5904		I _{I(LED)} = 5 mA, See Figure 6	100%		400%	
CTR		TPS5904A VCE			150%		300%	
V _{CE(sat)}	Collector-emitter saturation volta	age	$V_O(COMP) = V_I(FB),$ $I_C = 1 \text{ mA},$	I _{I(LED)} = 10 mA, See Figure 6		0.1	0.2	٧
v _{iso} †	Isolation voltage		I _{IO} = 10 μA, f = 60 H	z	7500			V
Cio	Input to output capacitance		$V_{IO} = 0$, $f = 1 \text{ kH}$	Z		0.6		рF

[†] This symbol is not currently listed within EIA or JEDEC standards for semiconductor symbology.

PARAMETER MEASUREMENT INFORMATION

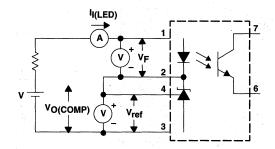


Figure 1. V_{ref} , V_{F} , I_{min} Test Circuit

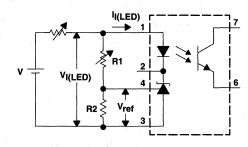


Figure 2. $\Delta V_{ref}/\Delta V_{I(LED)}$ Test Circuit

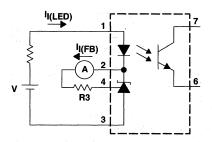


Figure 3. I_{I(FB)} Test Circuit

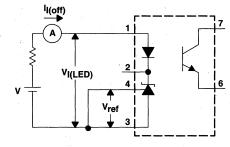


Figure 4. I_{I(off)} Test Circuit

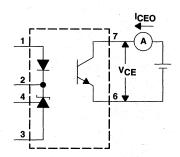


Figure 5. I_{CEO} Test Circuit

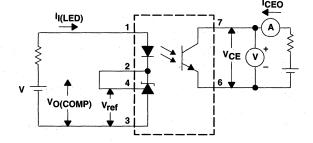


Figure 6. CTR, V_{CE(sat)} Test Circuit

INPUT LIGHT-EMITTING-DIODE CURRENT

TYPICAL CHARACTERISTICS

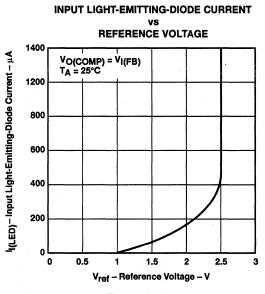


Figure 7

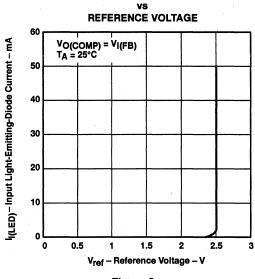


Figure 8

RATIO OF DELTA REFERENCE

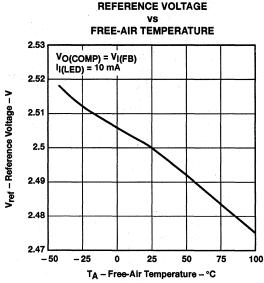


Figure 9

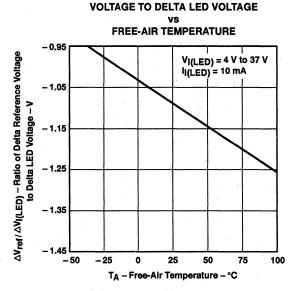


Figure 10

TYPICAL CHARACTERISTICS

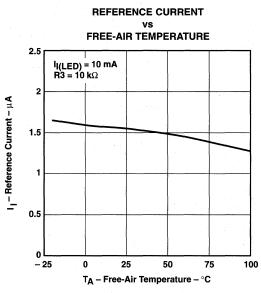
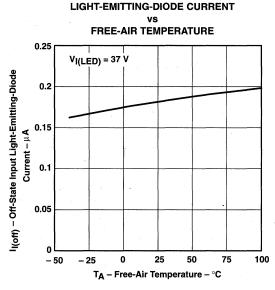


Figure 11

COLLECTOR DARK CURRENT



OFF-STATE INPUT

Figure 12

FREE-AIR TEMPERATURE 10000 V_{CE} = 35 V ICEO - Collector Dark Current - nA 1000 100 10 1 - 50 - 25 75 100 TA - Free-Air Temperature - °C

Figure 13

NORMALIZED CURRENT TRANSFER RATIO RELATIVE TO VALUE AT $T_{\Delta} = 25^{\circ}C$

FREE-AIR TEMPERATURE

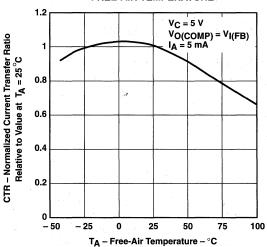
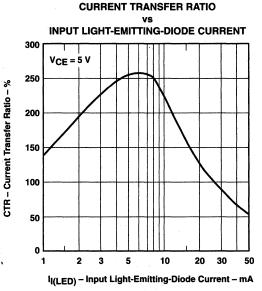


Figure 14

TYPICAL CHARACTERISTICS



COLLECTOR-TO-EMITTER SATURATION VOLTAGE

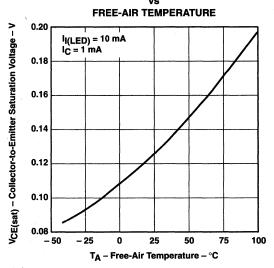


Figure 15

Figure 16

INPUT LIGHT-EMITTING-DIODE FORWARD CURRENT

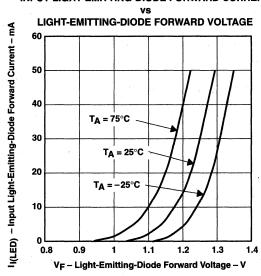


Figure 17

General Information	1
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Supply Voltage Supervisors	5
Power Distribution Switches	6
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TLE2425	Precision Virtual Grounds	8-47
TLE2426	The "Rail Splitter" Precision Virtual Ground	8-61
TPS28xx	Dual High-Speed MOSFET Drivers	8-79
TPS9103	Power Supply For GaAs Power Amplifiers	8-81

- Output Current . . . 100 mA
- Low Loss . . . 1.1 V at 100 mA
- Operating Range . . . 3.5 V to 15 V
- Reference and Error Amplifier for Regulation
- **External Shutdown**
- **External Oscillator Synchronization**
- **Devices Can Be Paralleled**
- Pin Compatible With the LTC1044/7660

description

testing of all parameters

The LT1054 is a monolithic, bipolar, switchedcapacitor voltage converter with regulator. It provides higher output current and significantly lower voltage losses than previously available converters. An adaptive switch drive scheme optimizes efficiency over a wide range of output currents. Total voltage drop at 100-mA output current is typically 1.1 V. This holds true over the full supply voltage range of 3.5 V to 15 V. Quiescent current is typically 2.5 mA.

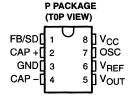
The LT1054 also provides regulation, a feature not previously available in switched-capacitor voltage converters. By adding an external resistive divider, a regulated output can be obtained. This output is regulated against changes in both input voltage and output current. The LT1054 can also be shut down by grounding the feedback terminal. Supply current in shut-down is typically 100 µA.

The internal oscillator of the LT1054 runs at a nominal frequency of 25 kHz. The oscillator terminal can be used to adjust the switching frequency or to externally synchronize the LT1054.

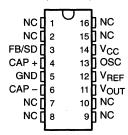
AVAILABLE OPTIONS

	PACKAGE	0		
T _A	SMALL OUTLINE (DW)	PLASTIC DIP (P)	CHIP FORM (Y)	
0°C to 70°C	LT1054CDW	LT1054CP	LT1054Y	
-40°C to 85°C	LT1054IDW	LT1054IP		

The DW package is available taped and reeled. Add the suffix R to the device type, (i.e., LT1054CDWR).

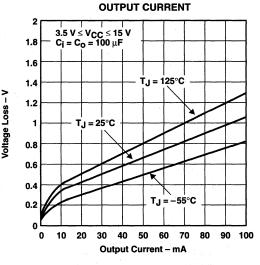


DW PACKAGE (TOP VIEW)



NC - No internal connection

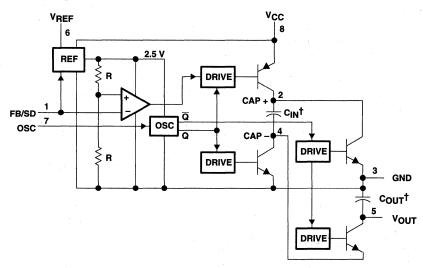
VOLTAGE LOSS



LT1054, TL1054Y SWITCHED-CAPACITOR VOLTAGE CONVERTERS **WITH REGULATOR**

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functional block diagram

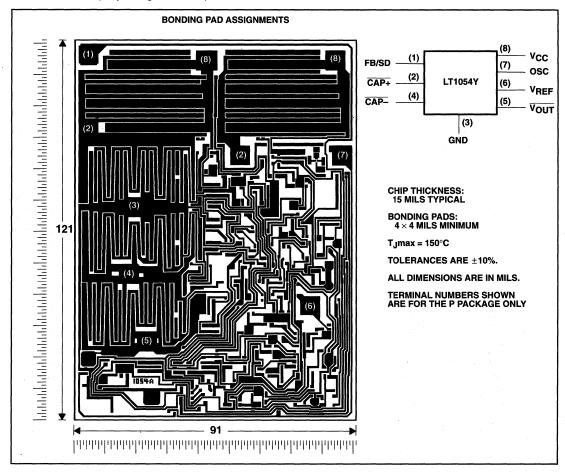


† External capacitors
NOTE A. Terminal numbers shown are for the P package only.

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LT1054Y chip information

This chip, when properly assembled, displays characteristics similar to the LT1054. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



LT1054, TL1054Y SWITCHED-CAPACITOR VOLTAGE CONVERTERS WITH REGULATOR

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)	16 V
Input voltage range, V _I (FB/SD terminal)	
Input voltage range, V _I (OSC terminal)	0 V to V _{ref}
Junction temperature (see Note 2) T _J : LT1054C	125°C
LT1054l	135°C
Operating free-air temperature range, T _A : LT1054C	0°C to 70°C
LT1054l	40°C to 85°C
Storage temperature range, T _{stg}	55°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

			MIN	XAN	UNIT
Supply voltage, V _{CC}	7.5. Tue		3.5	15	V
On and the state of the state o		LT1054C	0	70	°C
Operating free-air temperature range, TA		LT1054I	-40	85	

electrical characteristics over recommended operating conditions (unless otherwise noted)

		TEGT CONDITIONS			LT1054C, LT1054I			UNIT	
-	PARAMETER	IESIC	TEST CONDITIONS		TAT	MIN	TYP‡	MAX	UNII
٧o	Regulated output voltage	$V_{CC} = 7 \text{ V}, T_J = 25^{\circ}\text{C},$	$R_L = 500 \Omega$,	See Note 3	25°C	-4.7	-5	-5.2	V
	Input regulation	V _{CC} = 7 V to 12 V,	$R_L = 500 \Omega$,	See Note 3	Full range		5	25	mV
	Output regulation	V _{CC} = 7 V, See Note 3	R _L = 100 Ω to	500 Ω,	Full range		10	50	mV
	Voltage loss, V _{CC} - V _O	0 0 400 51	lo too Et III		Full range		0.35	0.55	V
(see Note 4)	$C_I = C_O = 100 \mu\text{F tantal}$	ım	I _O = 100 mA	Full range		1.1	1.6	V	
	Output resistance	$\Delta l_O = 10 \text{ mA to } 100 \text{ mA}$	See Note 5	¥	Full range	4.	10	15	Ω
	Oscillator frequency	V _{CC} = 3.5 V to 15 V			Full range	. 15	25	35	kHz
٧.	Deference veltore	L 60 A		1.	25°C	2.35	2.5	2.65	V
V _{ref}	Reference voltage	I(REF) = 60 μA			Full range	2.25		2.75	V
ė.	Maximum switch current				25°C		300		mA
	0		V _{CC} = 3.5 V		Full range	N. T.	2.5	3.5	
ICC	Supply current	IO = 0	V _{CC} = 15 V		Full range		3	4.5	mA
	Supply current in shut-down	V _(FB/SD) = 0 V			Full range		100	150	μА

[†] Full range is 0°C to 70°C for the LT1054C and -40°C to 85°C for the LT1054I.

Output resistance is defined as the slope of the curve (ΔV_O versus ΔI_O) for output currents of 10 mA to 100 mA. This represents the
linear portion of the curve. The incremental slope of the curve will be higher at currents less than 10 mA due to the characteristics
of the switch transistors.



NOTES: 1. The absolute maximum supply voltage rating of 16 V is for unregulated circuits. For regulation mode circuits with V_{OUT} ≤ 15 V, this rating may be increased to 20 V.

^{2.} The devices are functional up to the absolute maximum junction temperature.

[‡] All typical values are at $T_A = 25$ °C.

NOTES: 3. All regulation specifications are for a device connected as a positive-to-negative converter/regulator with R1 = 20 kΩ, R2 = 102.5 kΩ, external capacitor C_{IN} = 10 μF (tantalum), external capacitor C_{OUT} = 100 μF (tantalum) and C1 = 0.002 μF (see Figure 15)

For voltage-loss tests, the device is connected as a voltage inverter, with terminals 1, 6, and 7 unconnected. The voltage losses may
be higher in other configurations. C_{IN} and C_{OUT} are external capacitors.

LT1054, TL1054Y SWITCHED-CAPACITOR VOLTAGE CONVERTERS WITH REGULATOR

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electrical characteristics over recommended operating conditions, $T_A = 25^{\circ}C$ (unless otherwise noted)

PARAMETER		TF0T (TEGT COMPLETIONS			LT1054Y		
		TEST CONDITIONS			MIN	TYP	MAX	UNIT
٧o	Regulated output voltage	$V_{CC} = 7 \text{ V}, T_{J} = 25^{\circ}\text{C},$	$R_L = 500 \Omega$,	See Note 3		-5		V
_	Input regulation	V _{CC} = 7 V to 12 V,	R _L = 500 Ω,	See Note 3		5		mV
	Output regulation	V _{CC} = 7 V, See Note 3	R _L = 100 Ω to	500 Ω,		10		mV
	Voltage loss, V _{CC} - V _O (see Note 4)	0 0 400 54-4-1		I _O = 10 mA		0.35		V
		C _I = C _O = 100 μF tantalum		I _O = 100 mA		1.1		ĺ
	Output resistance	$\Delta I_O = 10$ mA to 100 mA	See Note 5			10		Ω
	Oscillator frequency	V _{CC} = 3.5 V to 15 V				25		kHz
V _{ref}	Reference voltage	I _(REF) = 60 μA				2.5		V
	Maximum switch current					300		mA
100	CC Supply current	$I_{O} = 0$ $V_{CC} = 3.5 \text{ V}$ $V_{CC} = 15 \text{ V}$				2.5		mA
icc						3		IIIA
	Supply current in shut-down	V _(FB/SD) = 0 V				100		μА

NOTES: 3 All regulation specifications are for a device connected as a positive-to-negative converter/regulator with R1 = 20 kΩ, R2 = 102.5 kΩ, external capacitor C_{IN} = 10 μF (tantalum), external capacitor C_{OUT} = 100 μF (tantalum) and C1 = 0.002 μF (see Figure 15).

4 For voltage-loss tests, the device is connected as a voltage inverter, with terminals 1, 6, and 7 unconnected. The voltage losses may be higher in other configurations. C_{IN} and C_{OUT} are external capacitors.

5 Output resistance is defined as the slope of the curve (ΔV_O versus ΔI_O) for output currents of 10 mA to 100 mA. This represents the linear portion of the curve. The incremental slope of the curve will be higher at currents less than 10 mA due to the characteristics of the switch transistors.

TYPICAL CHARACTERISTICS

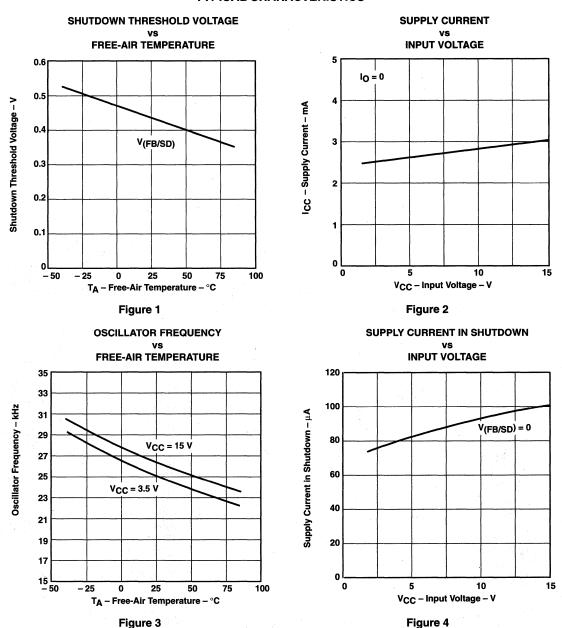
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TYPICAL CHARACTERISTICS†



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS

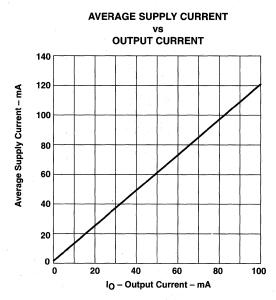


Figure 5

OUTPUT VOLTAGE LOSS

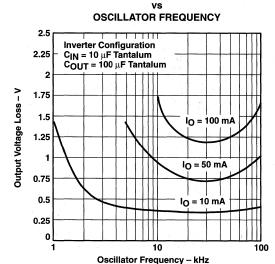


Figure 7

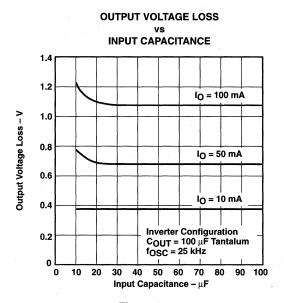


Figure 6

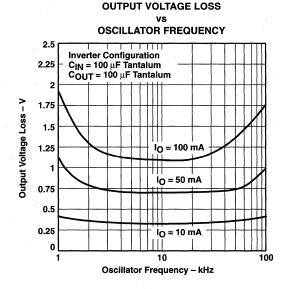
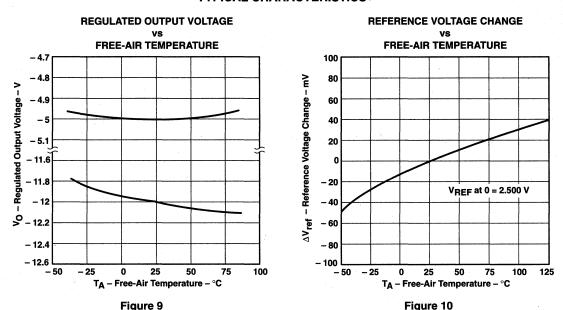


Figure 8



TYPICAL CHARACTERISTICS[†]



† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

PRINCIPLES OF OPERATION

A review of a basic switched-capacitor building block is helpful in understanding the operation of the LT1054. When the switch shown in Figure 11 is in the left position, capacitor C1 charges to the voltage at V1. The total charge on C1 is q1 = C1V1. When the switch is moved to the right, C1 is discharged to the voltage at V2. After this discharge time, the charge on C1 is q2 = C1V2. The charge has been transferred from the source V1 to the output V2. The amount of charge transferred is as shown in equation 1.

$$\Delta q = q1 - q2 = C1(V1 - V2)$$
 (1)

If the switch is cycled f times per second, the charge transfer per unit time (i.e., current) is as shown in equation 2.

$$I = f \times \Delta q = f \times C1(V1 - V2) \tag{2}$$

To obtain an equivalent resistance for a switched-capacitor network, this equation can be rewritten in terms of voltage and impedance equivalence as shown in equation 3.

$$I = \frac{V1 - V2}{(1/fC1)} = \frac{V1 - V2}{R_{EQUIV}}$$

$$V1 \longrightarrow 0$$

$$\downarrow C1 \qquad \downarrow C2 \qquad \downarrow R_L$$
(3)

Figure 11. Switched-Capacitor Building Block



PRINCIPLES OF OPERATION

A new variable, R_{EQUIV} , is defined as $R_{\text{EQUIV}} = 1 \div \text{fC1}$. The equivalent circuit for the switched-capacitor network is as shown in Figure 12. The LT1054 has the same switching action as the basic switched-capacitor building block. Even though this simplification does not include finite switch-on resistance and output-voltage ripple, it provides an insight into how the device operates.

These simplified circuits explain voltage loss as a function of oscillator frequency (see Figure 7). As oscillator frequency is decreased, the output impedance is eventually dominated by the 1/fC1 term and voltage losses rise.

Voltage losses also rise as oscillator frequency increases. This is caused by internal switching losses that occur due to some finite charge being lost on each switching cycle. This charge loss per-unit-cycle, when multiplied by the switching frequency, becomes a current loss. At high frequency, this loss becomes significant and voltage losses again rise.

The oscillator of the LT1054 is designed to run in the frequency band where voltage losses are at a minimum.

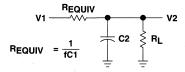


Figure 12. Switched-Capacitor Equivalent Circuit

terminal functions (see functional block diagram)

Supply voltage V_{CC} alternately charges C_{IN} to the input voltage when C_{IN} is switched in parallel with the input supply and then transfers charge to C_{OUT} when C_{IN} is switched in parallel with C_{OUT} . Switching occurs at the oscillator frequency. During the time that C_{IN} is charging, the peak supply current is approximately 2.2 times the output current. During the time that C_{IN} is delivering a charge to C_{OUT} , the supply current drops to approximately 0.2 times the output current. An input supply bypass capacitor supplies part of the peak input current drawn by the LT1054, and averages out the current drawn from the supply. A minimum input supply bypass capacitor of 2 μ F, preferably tantalum or some other low equivalent-series-resistance (ESR) type, is recommended. A larger capacitor is desirable in some cases. An example is when the actual input supply is connected to the LT1054 through long leads or when the pulse currents drawn by the LT1054 might affect other circuits through supply coupling.

In addition to being the output terminal, V_{OUT} is tied to the substrate of the device. Special care must be taken in LT1054 circuits to avoid making V_{OUT} positive with respect to any of the other terminals. For circuits with the output load connected from V_{CC} to V_{OUT} or from some external positive supply voltage to V_{OUT} , an external transistor must be added (see Figure 13). This transistor prevents V_{OUT} from being pulled above GND during start-up. Any small general-purpose transistor such as a 2N2222 or a 2N2219 device can be used. Resistor R1 should be chosen to provide enough base drive to the external transistor so that it is saturated under nominal output voltage and maximum output current conditions.

$$R1 \leq \frac{\left(\left| V_{OUT} \right| \right) \beta}{I_{OUT}} \tag{4}$$



APPLICATION INFORMATION

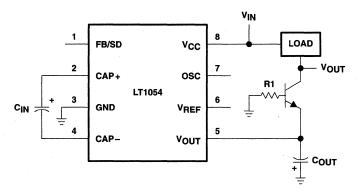


Figure 13. Circuit with Load Connected from V_{CC} to V_{OUT}

The voltage reference (V_{ref}) output provides a 2.5-V reference point for use in LT1054-based regulator circuits. The temperature coefficient (TC) of the reference voltage has been adjusted so that the TC of the regulated output voltage is near zero. As seen in the typical performance curves, this requires the reference output to have a positive TC. This non-zero drift is necessary to offset a drift term inherent in the internal reference divider and comparator network tied to the feedback terminal. The overall result of these drift terms is a regulated output that has a slight positive TC at output voltages below 5 V and a slight negative TC at output voltages above 5 V. For regulator feedback networks, reference output current should be limited to approximately 60 μ A. V_{ref} draws approximately 100 μ A when shorted to ground and does not affect the internal reference/regulator. This terminal can also be used as a pullup for LT1054 circuits that require synchronization.

CAP+ is the positive side of input capacitor C_{IN} and is alternately driven between V_{CC} and ground. When driven to V_{CC} , CAP+ sources current from V_{CC} . When driven to ground, CAP+ sinks current to ground. CAP- is the negative side of the input capacitor and is driven alternately between ground and V_{OUT} . When driven to ground, CAP- sinks current to ground. When driven to V_{OUT} , CAP- sources current from C_{OUT} . In all cases, current flow in the switches is unidirectional, as should be expected when using bipolar switches.

The OSC can be used to raise or lower the oscillator frequency or to synchronize the device to an external clock. Internally, OSC is connected to the oscillator timing capacitor ($C_t \approx 150 \text{ pF}$), which is alternately charged and discharged by current sources of $\pm 7 \mu A$, so that the duty cycle is approximately 50%. The LT1054 oscillator is designed to run in the frequency band where switching losses are minimized. However, the frequency can be raised, lowered, or synchronized to an external system clock if necessary.

The frequency can be increased by adding an external capacitor (C2 in Figure 14) in the range of 5 pF - 20 pF from CAP+ to OSC. This capacitor couples a charge into C_t at the switch transitions. This shortens the charge and discharge time and raises the oscillator frequency. Synchronization can be accomplished by adding an external pullup resistor from OSC to V_{ref} . A 20-k Ω pullup resistor is recommended. An open-collector gate or an NPN transistor can then be used to drive OSC at the external clock frequency as shown in Figure 14.

The frequency can be lowered by adding an external capacitor (C₁ in Figure 14) from OSC to ground. This increases the charge and discharge times, which lowers the oscillator frequency.

APPLICATION INFORMATION

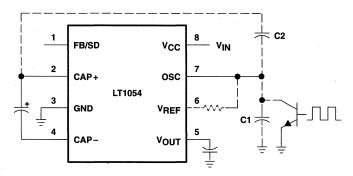


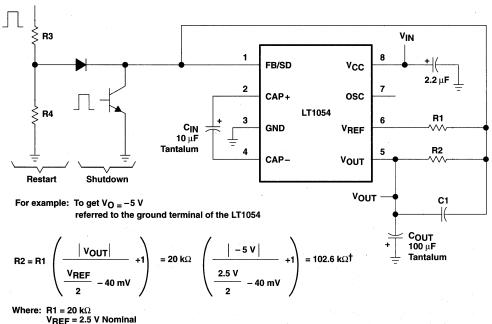
Figure 14. External Clock System

The feedback/shutdown (FB/SD) terminal has two functions. Pulling FB/SD below the shutdown threshold (\approx 0.45 V) puts the device into shutdown. In shutdown, the reference/regulator is turned off and switching stops. The switches are set such that both C_{IN} and C_{OUT} are discharged through the output load. Quiescent current in shutdown drops to approximately 100 μA . Any open-collector gate can be used to put the LT1054 into shutdown. For normal (unregulated) operation, the device will restart when the external gate is shut off. In LT1054 circuits that use the regulation feature, the external resistor divider can provide enough pulldown to keep the device in shutdown until the output capacitor (C_{OUT}) has fully discharged. For most applications where the LT1054 is run intermittently, this does not present a problem because the discharge time of the output capacitor is short compared to the off time of the device. In applications where the device has to start-up before the output capacitor (C_{OUT}) has fully discharged, a restart pulse must be applied to FB/SD of the LT1054. Using the circuit shown in Figure 15, the restart signal can be either a pulse (tp > 100 μ s) or a logic high. Diode coupling the restart signal into FB/SD allows the output voltage to rise and regulate without overshoot. The resistor divider R3/R4 shown in Figure 15 should be chosen to provide a signal level at FB/SD of 0.7 V - 1.1 V.

FB/SD is also the inverting input of the LT1054 error amplifier and, as such, can be used to obtain a regulated output voltage.



APPLICATION INFORMATION



†Choose the closest 1% value

Figure 15. Basic Regulation Configuration

regulation

The error amplifier of the LT1054 drives the pnp switch to control the voltage across the input capacitor (C_{IN}), which determines the output voltage. When the reference and error amplifier of the LT1054 are used, an external resistive divider is all that is needed to set the regulated output voltage. Figure 15 shows the basic regulator configuration and the formula for calculating the appropriate resistor values. R1 should be 20 k Ω or greater because the reference current is limited to $\pm 100~\mu A$. R2 should be in the range of $100~k\Omega$ to $300~k\Omega$. Frequency compensation is accomplished by adjusting the ratio of CIN to COUT.

For best results, this ratio should be approximately 1 to 10. Capacitor C1, required for good load regulation, should be 0.002 µF for all output voltages.

The functional block diagram shows that the maximum regulated output voltage is limited by the supply voltage. For the basic configuration, VOUT referred to the ground terminal of the LT1054, must be less than the total of the supply voltage minus the voltage loss due to the switches. The voltage loss versus output current due to the switches can be found in the typical performance curves. Other configurations, such as the negative doubler can provide higher voltages at reduced output currents.

APPLICATION INFORMATION

capacitor selection

While the exact values of CIN and COUT are non-critical, good-quality low-ESR capacitors, such as solid tantalum are necessary to minimize voltage losses at high currents. For CIN, the effect of the ESR of the capacitor is multiplied by four, since switch currents are approximately two times higher than output current. Losses occur on both the charge and discharge cycle, which means that a capacitor with 1 Ω of ESR for C_{IN} has the same effect as increasing the output impedance of the LT1054 by 4 Ω . This represents a significant increase in the voltage losses. COUT is alternately charged and discharged at a current approximately equal to the output current. The ESR of the capacitor causes a step function to occur in the output ripple at the switch transitions. This step function degrades the output regulation for changes in output load current and should be avoided. A technique used to gain both low ESR and reasonable cost is to parallel a smaller tantalum capacitor with a large aluminum electrolytic capacitor.

output ripple

The peak-to-peak output ripple is determined by the output capacitor and the output current values. Peak-to-peak output ripple is approximated as shown:

$$\Delta V = \frac{I_{OUT}}{2 fC_{OUT}}$$
 (5)

where:

 $\Delta V = p-p \text{ ripple}$

fOSC = oscillator frequency

For output capacitors with significant ESR, a second term must be added to account for the voltage step at the switch transitions. This step is approximately equal to:

$$(2I_{OUT})$$
 (ESR of C_{OUT}) (6)

power dissipation

The power dissipation of any LT1054 circuit must be limited so that the junction temperature of the device does not exceed the maximum junction temperature ratings. The total power dissipation is calculated from two components, the power loss due to voltage drops in the switches, and the power loss due to drive current losses. The total power dissipated by the LT1054 is calculated as shown.

$$P \approx (V_{CC} - |V_{OUT}|) I_{OUT} + (V_{CC}) (I_{OUT}) (0.2)$$
(7)

where both V_{CC} and V_{OLIT} are referenced to ground. The power dissipation is equivalent to that of a linear regulator. Limited power handling capability of the LT1054 packages causes limited output current requirements or steps can be taken to dissipate power external to the LT1054 for large input or output differentials. This is accomplished by placing a resistor in series with CIN as shown in Figure 16. A portion of the input voltage is dropped across this resistor without affecting the output regulation. Since switch current is approximately 2.2 times the output current and the resistor causes a voltage drop when C_{IN} is both charging and discharging, the resistor chosen is as shown:

$$R_X = V_x/(4.4 I_{OUT})$$

$$V_X \approx V_{CC} - [(LT1054 \text{ voltage loss}) (1.3) + |V_{OUT}|]$$
 (8)

and I_{OUT} = maximum required output current. The factor of 1.3 allows some operating margin for the LT1054.



APPLICATION INFORMATION

When using a 12-V to -5-V converter at 100-mA output current, calculate the power dissipation without an external resistor.

$$P = (12 V - | -5 V |) (100 mA) + (12 V) (100 mA) (0.2)$$

$$P = 700 \text{ mW} + 240 \text{ mW} = 940 \text{ mW}$$

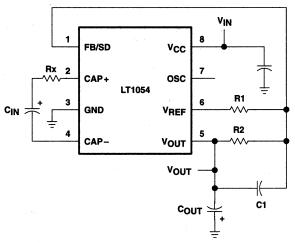


Figure 16. Power-Dissipation-Limiting Resistor in Series with CIN

At $R_{\theta JA}$ of 130°C/W for a commercial plastic device, a junction temperature rise of 122°C is seen. The device exceeds the maximum junction temperature at an ambient temperature of 25°C. To calculate the power dissipation with an external-resistor (R_X), determine how much voltage can be dropped across R_X . The maximum voltage loss of the LT1054 in the standard regulator configuration at 100 mA output current is 1.6 V.

APPLICATION INFORMATION

The resistor reduces the power dissipated by the LT1054 by (4.9 V) (100 mA) = 490 mW. The total power dissipated by the LT1054 is equal to (940 mW - 490 mW) = 450 mW. The junction temperature rise is 58° C. Although commercial devices are functional up to a junction temperature of 125° C, the specifications are tested to a junction temperature of 100° C. In this example, this means limiting the ambient temperature to 42° C. To allow higher ambient temperatures, the thermal resistance numbers for the LT1054 packages represent worst-case numbers with no heat-sinking and still air. Small clip-on heat sinks can be used to lower the thermal resistance of the LT1054 package. Airflow in some systems helps to lower the thermal resistance. Wide PC board traces from the LT1054 leads help to remove heat from the device. This is especially true for plastic packages.

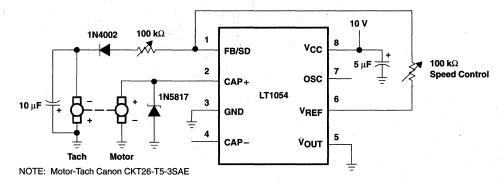


Figure 17. Motor Speed Servo

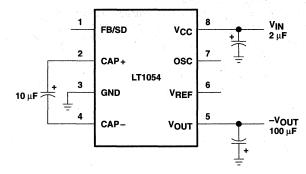
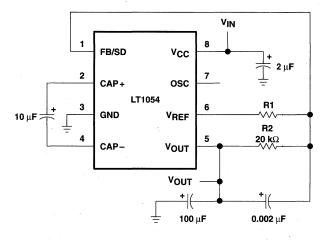


Figure 18. Basic Voltage Inverter



R2 = R1
$$\left(\frac{|V_{OUT}|}{\frac{V_{REF}}{2} - 40 \text{ mV}}\right)^{+1} = 20 \text{ k}\Omega \left(\frac{|V_{OUT}|}{1.21 \text{ V}}\right)^{+1}$$

Figure 19. Basic Voltage Inverter/Regulator

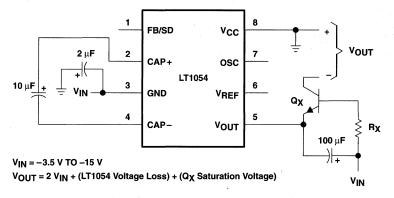


Figure 20. Negative Voltage Doubler

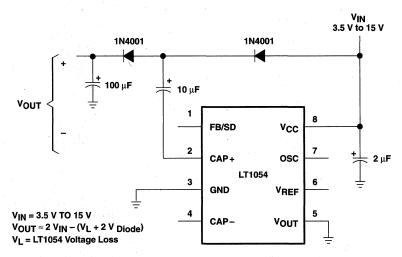
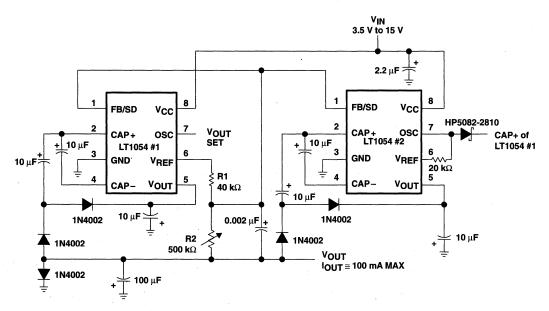


Figure 21. Positive Doubler

APPLICATION INFORMATION



 V_{IN} = 3.5 to 15 V VOUT MAX \approx -2 V_{IN} + [LT1054 Voltage Loss +2 (VDiode)]

R2 = R1
$$\left(\frac{|V_{OUT}|}{\frac{V_{REF}}{2} - 40 \text{ mV}} + 1\right) = R1 \left(\frac{|V_{OUT}|}{1.21 \text{ V}} + 1\right)$$

Figure 22. 100-mA Regulating Negative Doubler

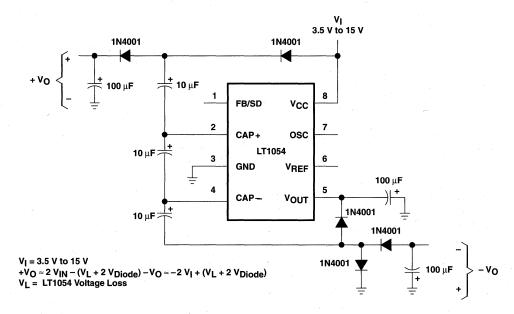


Figure 23. Dual Output Voltage Doubler

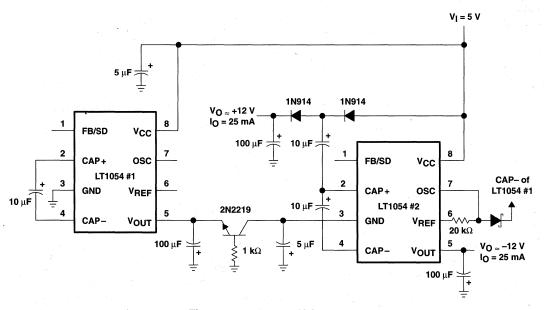


Figure 24. 5-V to ±12-V Converter



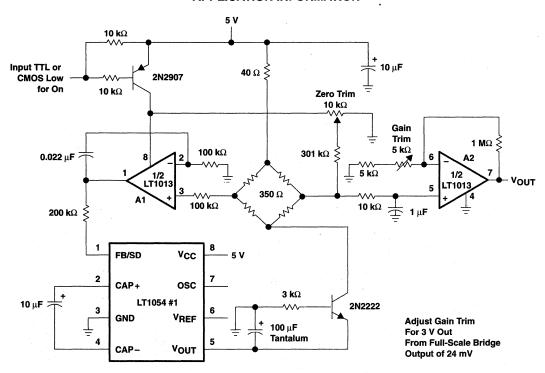


Figure 25. Strain Gage Bridge Signal Conditioner

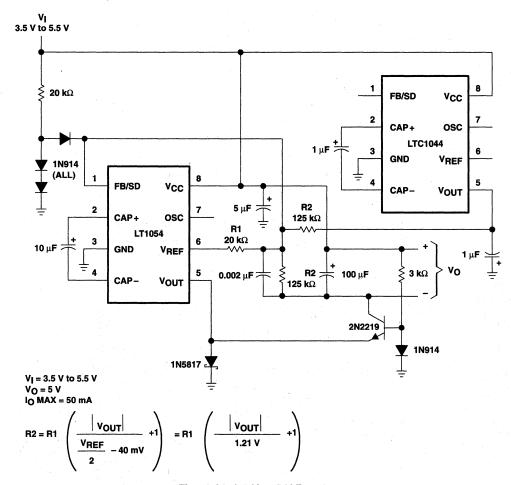
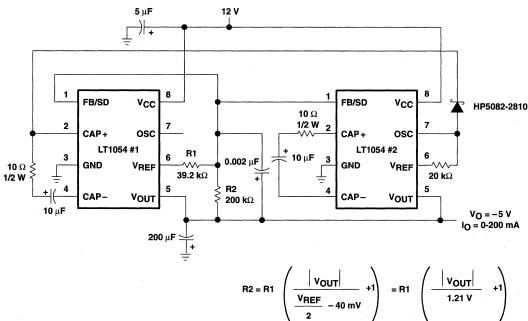


Figure 26. 3.5-V to 5-V Regulator



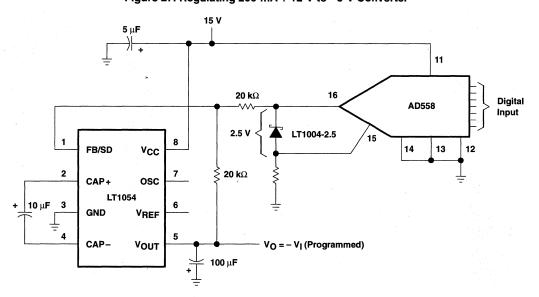


Figure 28. Digitally Programmable Negative Supply

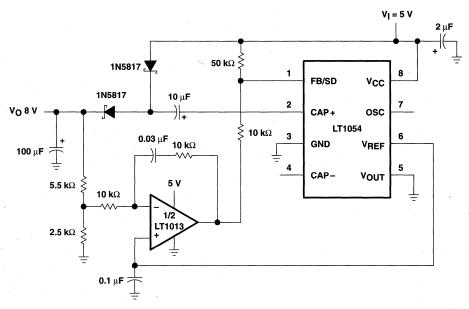


Figure 29. Positive Doubler with Regulation (5-V to 8-V Converter)

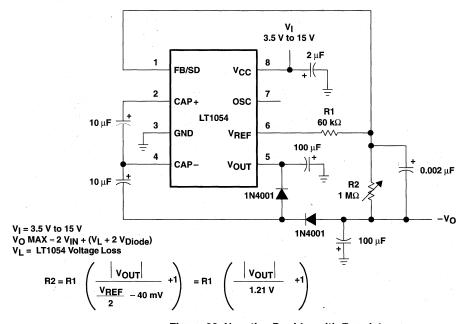


Figure 30. Negative Doubler with Regulator

TL-SCSI285, TL-SCSI285Y FIXED-VOLTAGE REGULATORS FOR SCSI ACTIVE TERMINATION

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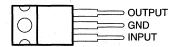


- Fixed 2.85-V Output
- ±1% Maximum Output Tolerance at T_J = 25°C
- 0.7-V Maximum Dropout Voltage
- 620-mA Output Current
- ±2% Absolute Output Variation
- Internal Overcurrent Limiting Circuitry
- Internal Thermal Overload Protection
- Internal Overvoltage Protection

N PACKAGE PW PACKAGE (TOP VIEW) (TOP VIEW) NC 14 🛮 NC 20 L HEAT HEAT NC 2 13 OUTPUT 19 SINK SINK GND 3 12 GND 18 3 GND 1 4 11 T GND 17 GND 5 10 ¶ GND GND 5 16 GND INPUT [15 OUTPUT NC[] 6 9 NPUT исП 8∏ NC 14**П** 13 HEAT HEAT 8 SINK SINK 9 12 NC - No internal connection 11

HEAT SINK – These terminals have an internal resistive connection to ground and should be grounded or electrically isolated.

KC PACKAGE (TOP VIEW)

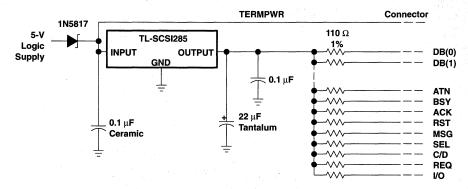


description

The TL-SCSI285 is a low-dropout (0.7-V) fixed-voltage regulator specifically designed for small computer systems interface (SCSI) alternative 2 active signal termination. The TL-SCSI285 0.7-V maximum dropout ensures compatibility with existing SCSI systems while providing a wide TERMPWR voltage range. At the same time the $\pm 1\%$ initial tolerance on its 2.85-V output voltage ensures a tighter line driver current tolerance, thereby increasing system noise margin.

The fixed 2.85-V output voltage of the TL-SCSI285 supports the SCSI alternative 2 termination standard while reducing system power consumption. The 0.7-V maximum dropout voltage brings increased TERMPWR

typical application schematic



AVAILABLE OPTIONS

		CHIP		
TJ	PLASTIC POWER (KC)	PLASTIC DIP (N)	SURFACE MOUNT (PW)†	FORM (Y)
0°C to 125°C	TL-SCSI285KC	TL-SCSI285N	TL-SCSI285PWLE	TL-SCSI285Y

† The PW package is only available left-end taped and reeled.



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description (continued)

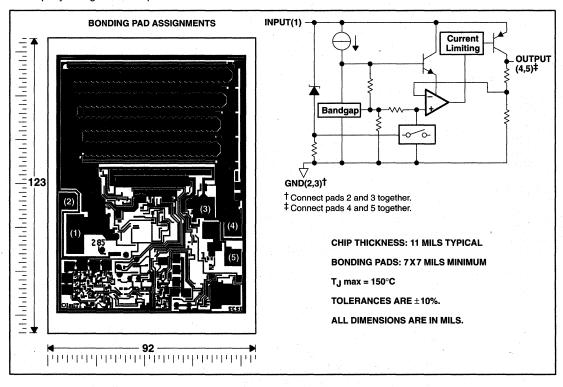
isolation, making the device ideal for battery-powered systems. The TL-SCSI285, with internal current limiting, overvoltage protection, ESD protection, and thermal protection offers designers enhanced system protection and reliability.

When configured as a SCSI active terminator, the TL-SCSI285 low-dropout regulator eliminates the 220- Ω and the 330- Ω resistors required for each transmission line with a passive termination scheme, reducing significantly the continuous system power drain. When placed in series with 110- Ω resistors, the device matches the impedance level of the transmission cable and eliminates reflections.

The TL-SCSI285 is characterized for operation from 0°C to 125°C virtual junction temperature.

TL-SCSI285Y chip information

This chip, when properly assembled, displays characteristics similar to the TL-SCSI285. Thermal compression or ultrasonic bonding can be used on the doped aluminum pads. The chips can be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating virtual junction temperature range (unless otherwise noted)[†]

Continuous input voltage, V ₁	7.5 V
Continuous total dissipation (see Note 1)	
Operating virtual junction temperature range, T _A	–55°C to 150°C
Storage temperature range, T _{stq}	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Refer to Figures 1 and 2 to avoid exceeding the design maximum virtual junction temperature; these ratings should not be exceeded.

Due to variation in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

DISSIPATION RATING TABLE

PACKAGE	POWER RATING	T ≤ 25°C	DERATING FACTOR	T = 70°C	T = 85°C	T = 125°C			
	AT	POWER RATING	ABOVE T = 25°C	POWER RATING	POWER RATING	POWER RATING			
кс	T _A	2000 mW	16.0 mW/°C	1280 mW	1040 mW	400 mW			
	T _C	20000 mW	182.0 mW/°C [†]	11810 mW	9080 mW	1800 mW			
N	T _A	2250 mW	18.0 mW/°C	1440 mW	1170 mW	450 mW			
	T _C	11850 mW	94.8 mW/°C	7584 mW	6162 mW	2370 mW			
PW	T _A	950 mW	7.6 mW/°C	608 mW	494 mW	190 mW			
	T _C	4625 mW	37.0 mW/°C	2960 mW	2405 mW	925 mW			

[†] Derate above 40°C

MAXIMUM CONTINUOUS DISSIPATION

vs FREE-AIR TEMPERATURE 2400 2200 P_D- Maximum Continuous Dissipation – mW 2000 1800 KC 1600 $R_{\theta JA} = 62.5^{\circ}C/W$ 1400 1200 $R_{\theta JA} = 55.6^{\circ}C/W$ 1000 800 600 PW 400 $R_{\theta JA} = 132^{\circ}C/W$ 200 25 75 100 125 150 TA - Free-Air Temperature - °C

Figure 1

MAXIMUM CONTINUOUS DISSIPATION

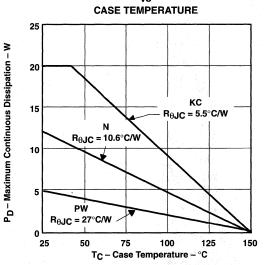


Figure 2

TL-SCSI285, TL-SCSI285Y FIXED-VOLTAGE REGULATORS FOR SCSI ACTIVE TERMINATION

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recommended operating conditions

			MIN	MAX	UNIT
Input voltage, V _I			3.55	5.5	V
0.44	KC and N packages		0	620	
Output current, IO	PW package		0	500	mA
Operating virtual junction temperature range, TJ			0	125	°C

electrical characteristics, $V_I = 4.5 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS†					CSI285KC SCSI285N	
				MIN	TYP	MAX	
Output voltage	IO = 20 mA to 500 mA,	$V_1 = 3.55 \text{ V to } 5.5 \text{ V},$	T _J = 25°C	2.82	2.85	2.88	v
Output voitage	I _O = 500 mA to 620 mA,	$V_{I} = 3.65 \text{ V to } 5.5 \text{ V},$	T _J = 0 to 125°C	2.79		2.91	V
Input regulation	V _I = 3.55 V to 5.5 V				5	15	mV
Ripple rejection	f = 120 Hz, V _{rip}	ole = 1 Vpp			-62		dB
Output regulation	IO = 20 mA to 620 mA				5	30	\/
Output regulation	I _O = 20 mA to 500 mA				5	30	mV
Output noise voltage	f = 10 Hz to 100 kHz				500	- 7	μV
Dropout voltage	IO = 500 mA				- 4	0.7	· v
Dropout voltage	I _O = 620 mA					0.8	V
	I _O = 0				2	5	75.
Bias current	IO = 27 mA, equivalent 1 line	e asserted			3	6	A
	IO = 500 mA, equivalent 18	lines asserted (8 bit)			26	49	mA
	I _O = 620 mA				37	62	3.5

[†] Pulse-testing techniques are used to maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 22.0-μF tantalum capacitor with equivalent series resistance of 1.5 Ω on the output.

electrical characteristics, $V_I = 4.5 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER			TL-S	CSI285	PW	
	TEST CONDITIONS†		MIN	TYP	MAX	UNIT
Output voltage	10 - 20 mA to 500 mA V 2 55 V to 5 5 V	T _J = 25°C	2.82	2.85	2.88	V
Output voltage	$I_O = 20$ mA to 500 mA, $V_1 = 3.55$ V to 5.5 V	T _J = 0 to 125°C	2.79		2.91	٧
Input regulation	V _I = 3.55 V to 5.5 V			5	15	mV
Ripple rejection	f = 120 Hz, V _{ripple} = 1 Vpp			-62		dB
Output regulation	I _O = 20 mA to 500 mA			5	30	mV
Output noise voltage	f = 10 Hz to 100 kHz			500		μV
Dropout voltage	I _O = 500 mA				0.7	٧
	I _O = 0			2	5	
Bias current	IO = 27 mA, equivalent 1 line asserted			3	6	mA
	IO = 500 mA, equivalent 18 lines asserted (8 bit)			26	49	

[†] Pulse-testing techniques are used to maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-µF capacitor across the input and a 22.0-µF tantalum capacitor with equivalent series resistance of 1.5 Ω on the output.



TL-SCSI285, TL-SCSI285Y FIXED-VOLTAGE REGULATORS FOR SCSI ACTIVE TERMINATION

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electrical characteristics, $V_I = 4.5 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$

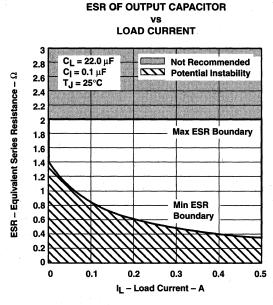
DADAMETED		TL-SCSI285Y		
PARAMETER	TEST CONDITIONS†	MIN TYP MAX	UNIT	
Output voltage	I _O = 20 mA to 500 mA, V _I = 3.55 V to 5.5 V	2.85	V	
Input regulation	V _I = 3.55 V to 5.5 V	5	mV	
Ripple rejection	f = 120 Hz, V _{ripple} = 1 V _{PP} -62			
0 1 1 1 1 1 1 1 1 1	I _O = 20 mA to 620 mA	5	mV	
Output regulation	I _O = 20 mA to 500 mA	5		
Output noise voltage	f = 10 Hz to 100 kHz	500	μV	
	I _O = 0	2		
Bias current	IO = 27 mA, equivalent 1 line asserted	3	mA	
Dias Curreill	IO = 500 mA, equivalent 18 lines asserted (8 bit)	26] ""^	
	I _O = 620 mA	37	1	

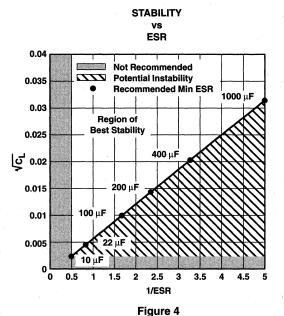
[†] Pulse-testing techniques are used to maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 22.0-μF tantalum capacitor with equivalent series resistance of 1.5 Ω on the output.

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COMPENSATION CAPACITOR SELECTION INFORMATION

The TL-SCSI285 is a low-dropout regulator. This means that the capacitance loading is important to the performance of the regulator because it is a vital part of the control loop. The capacitor value and the equivalent series resistance (ESR) both affect the control loop and must be defined for the load range and the temperature range. Figures 3 and 4 can establish the capacitance value and ESR range for best regulator performance.





Applied Load
Current

Load
Voltage

AVL

Figure 3

TL2217-285, TL2217-285Y FIXED-VOLTAGE REGULATORS FOR SCSI ACTIVE TERMINATION

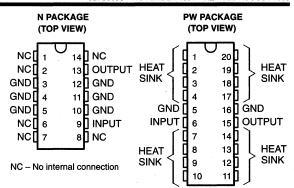
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- Fixed 2.85-V Output
- ±1.5% Maximum Output Tolerance at T_J = 25°
- 1-V Maximum Dropout Voltage
- 500-mA Output Current
- ±3% Absolute Output Variation
- Internal Overcurrent Limiting
- Internal Thermal Overload Protection
- Internal Overvoltage Protection

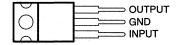
description

The TL2217-285 is a low-dropout (1-V) fixed-voltage regulator specifically designed for small computer systems interface (SCSI) alternative 2 active signal termination. The TL2217-285 1-V maximum dropout ensures compatibility with existing SCSI systems, while providing a wide TERMPWR voltage range. At the same time, the $\pm 1.5\%$ initial tolerance on its 2.85-V output voltage ensures a tighter line driver current tolerance, thereby increasing system noise margin.

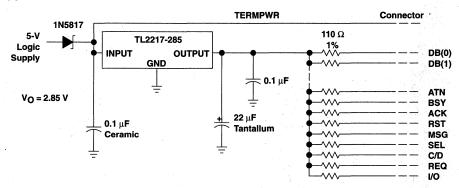


HEAT SINK – These pins have an internal resistive connection to ground and should be grounded or electrically isolated.

KC PACKAGE (TOP VIEW)



typical application schematic



AVAILABLE OPTIONS

ı	-		PACKAGE		CHIP
	TA	PLASTIC POWER (KC)	PLASTIC DIP (N)	SURFACE MOUNT (PW)†	FORM (Y)
1	0°C to 125°C	TL2217-285KC	TL2217-285N	TL22I7-285PWLE	TL2217-285Y

[†]The PW package is only available left-end taped and reeled.



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description (continued)

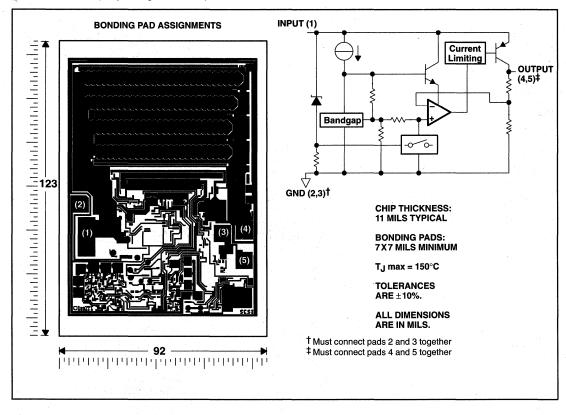
The fixed 2.85-V output voltage of TL2217-285 supports the SCSI alternative 2 termination standard while reducing system power consumption. The 1-V maximum dropout voltage brings increased TERMPWR isolation, making the device ideal for battery-powered systems. The TL2217-285, with internal current limiting, overvoltage protection, ESD protection, and thermal protection, offers designers enhanced system protection and reliability.

When configured as a SCSI active terminator, the TL2217-285 low-dropout regulator eliminates the 220- Ω and 330- Ω resistors required for each transmission line with a passive termination scheme, reducing significantly the continuous system power drain. When placed in series with 110- Ω resistors, the device matches the impedance level of the transmission cable and eliminates reflections.

The TL2217-285 is characterized for operation from 0°C to 125°C virtual junction temperature.

TL2217-285Y chip information

These chips, properly assembled, display characteristics similar to the TL2217-285. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating virtual junction temperature range (unless otherwise noted)†

Continuous input voltage, V ₁	7.5 V
Continuous total power dissipation (see Note 1) See Dissipation F	
Operating virtual junction temperature range, T.J	°C to 150°C
Storage temperature range, T _{stq} –65	°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 60 seconds	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: Refer to Figures 1 and 2 to avoid exceeding the design maximum virtual junction temperature; these ratings should not be exceeded.

Due to variation in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

DISSIPATION RATING TABLE

PACKAGE	POWER RATING AT	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING	
KC	TĄ.	2000 mW	16.0 mW/°C	1280 mW	1040 mW	400 mW	
	T _C †	20000 mW	182.0 mW/°C	14540 mW	11810 mW	4530 mW	
N	TA	2250 mW	18.0 mW/°C	1440 mW	1170 mW	450 mW	
	TC	11850 mW	94.8 mW/°C	7584 mW	6162 mW	2370 mW	
DW	TA	950 mW	7.6 mW/°C	608 mW	494 mW	190 mW	
FVV	TC	4625 mW	37.0 mW/°C	2960 mW	2405 mW	925 mW	
PW							

[†] Derate above 40°C

FREE-AIR TEMPERATURE DISSIPATION DERATING CURVE

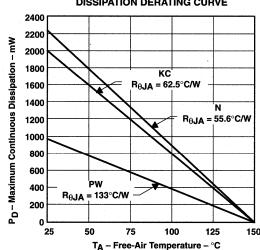


Figure 1

CASE TEMPERATURE DISSIPATION DERATING CURVE

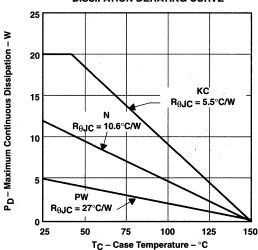


Figure 2

TL2217-285, TL2217-285Y FIXED-VOLTAGE REGULATORS FOR SCSI ACTIVE TERMINATION

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recommeneded operating conditions

	MIN	MAX	UNIT
Input voltage, V _I	3.85	5.5	٧
Output current, IO	0	500	mA
Operating virtual junction temperature range, T _J	0	125	°C

electrical characteristics over recommended operating conditions, $V_I = 4.5 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS†			TL2217-285			UNIT
PARAMETER				MIN	TYP	MAX	UNIT
O. do. d. college	I _O = 20 mA to 500 mA, V _I = 3.85 V to 5.5 V	T _J = 25°C	2.81	2.85	2.89	⊣ ∨	
Output voltage		T _J = 0°C to 125°C	2.765		2.935		
Input voltage regulation	V _I = 3.85 V to 5.5 V				5	15	mV
Ripple rejection	f = 120Hz,	V _{ripple} = 1 V _{PP}			-62		dB
Output voltage regulation	IO = 20 mA to 500 mA				5	30	mV
Output noise voltage	f = 10 Hz to 100 kHz				500	-	μV
Dropout voltage						1	٧
	I _O = 0				2	5	
Bias current	IO = 27 mA, equivalent 1 li	ne asserted			3	6	mA
	I _O = 500 mA, equivalent 1	8 lines asserted (8 bit)			26	49	

[†] Pulse-testing techniques are used to maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1- μ F capacitor across the input and a 22- μ F tantalum capacitor with equivalent series resistance of $1.5~\Omega$ on the output.

electrical characteristics over recommended operating conditions, $V_I = 4.5 \text{ V}$, $I_O = 500 \text{ mA}$, $T_J = 25^{\circ}\text{C}$ (unless otherwise noted)

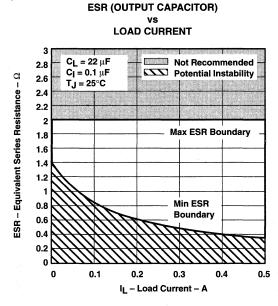
DADAMETED		TL2217-28	TL2217-285Y		
PARAMETER	TEST CONDITIONS†	MIN TYP	MAX	UNIT	
Output voltage	I _O = 20 mA to 500 mA, V _I = 3.85 V to 5.5 V	2.81 2.85	2.89	V	
Input voltage regulation	V _I = 3.85 V to 5.5 V	5	15	mV	
Ripple rejection	f = 120 Hz, V _{ripple} = 1 V _{PP}	-62		dB	
Output voltage regulation	I _O = 20 mA to 500 mA	5	30	mV	
Output noise voltage	f = 10 Hz to 100 kHz	500		μV	
Dropout voltage	I _O = 500 mA		1	V	
	I _O = 0	2	5		
Bias current	IO = 27 mA, equivalent 1 line asserted	. 3	6	mA	
	I _O = 500 mA, equivalent 18 lines asserted (8 bit)	26	49		

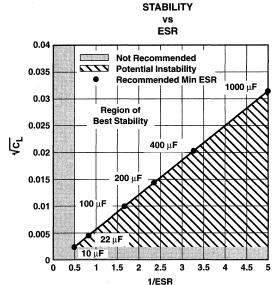
[†] Pulse-testing techniques are used to maintain the virtual junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.1-μF capacitor across the input and a 22-μF tantalum capacitor with equivalent series resistance of 1.5 Ω on the output.

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COMPENSATION CAPACITOR SELECTION INFORMATION

The TL2217-285 is a low-dropout regulator. This means that the capacitance loading is important to the performance of the regulator because it is a vital part of the control loop. The capacitor value and the equivalent series resistance (ESR) both affect the control loop and must be defined for the load range and the temperature range. Figures 3 and 4 can be used to establish the capacitance value and ESR range for best regulator performance.





Applied Load
Current

Load
Voltage

AVL

Figure 3

Figure 4

TL2218-285, TL2218-285Y **EXCALIBUR CURRENT-MODE SCSI TERMINATOR**

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□ GND

available features **PW PACKAGE** (TOP VIEW) **Fully Integrated 9-Channel SCSI Termination** TERMPWR □ TERMPWR No External Components Required NC 2 19 DISABLE NC \square 3 18 NC Maximum Allowed Current Applied at First 4 17 **High-Level Step** D0 =D8 16 D1 D7 6-pF Typical Power-Down Output 6 15 NC Capacitance 14 D3 D6 Wide V_{term}[†] (Termination Voltage) Π4 13 D5 Operating Range, 3.5 V to 5.5 V 9 12 NC NC **TTL-Compatible Disable Feature** 10 11

NC - No internal connection

GND

description

Compatible With Active Negation

Thermal Regulation

The TL2218-285 is a current-mode 9-channel monolithic terminator specially designed for single-ended small-computer-systems-interface (SCSI) bus termination. A user-controlled disable function is provided to reduce standby power. No impedance-matching resistors or other external components are required for its operation as a complete terminator.

The device operates over a wide termination-voltage (V_{term}†) range of 3.5 V to 5.5 V, offering an extra 0.5 V of operating range when compared to the minimum termination voltage of 4 V required by other integrated active terminators. The TL2218-285 functions as a current-sourcing terminator and supplies a constant output current of 23 mA into each asserted line. When a line is deasserted, the device senses the rising voltage level and begins to function as a voltage source, supplying a fixed output voltage of 2.85 V. The TL2218-285 features compatibility with active negation drivers and has a typical sink current capability of 20 mA.

The TL2218-285 is able to ensure that maximum current is applied at the first high-level step. This performance means that the device should provide a first high-level step exceeding 2 V even at a 10-MHz rate. Therefore, noise margins are improved considerably above those provided by resistive terminators.

A key difference between the TL2218-285 current-mode terminator and a Boulay terminator is that the TL2218-285 does not incorporate a low dropout regulator to set the output voltage to 2.85 V. In contrast with the Boulay termination concept, the accuracy of the 2.85 V is not critical with the current-mode method used in the TL2218-285 because this voltage does not determine the driver current. Therefore, the primary device specifications are not the same as with a voltage regulator but are more concerned with output current.

The DISABLE terminal is TTL compatible and must be taken low to shut down the outputs. The device is normally active, even when DISABLE is left floating. In the disable mode, only the device startup circuits remain active, thereby reducing the supply current to just 500 µA. Output capacitance in the shutdown mode is typically 6 pF.

The TL2218-285 has on-board thermal regulation and current limiting, thus eliminating the need for external protection circuitry. A thermal regulation circuit that is designed to provide current limiting, rather than an actual thermal shutdown, is included in the individual channels of the TL2218-285. When a system fault occurs that leads to excessive power dissipation by the terminator, the thermal regulation circuit causes a reduction in the asserted-line output current sufficient to maintain operation. This feature allows the bus to remain active during a fault condition, which permits data transfer immediately upon removal of the fault. A terminator with thermal shutdown does not allow for data transfer until sufficient cooling has occurred. Another advantage offered by the TL2218-285 is a design that does not require costly laser trimming in the manufacturing process.

The TL2218-285 is characterized for operation over the virtual junction temperature range of 0°C to 125°C.

† This symbol is not presently listed within EIA/JEDEC standards for letter symbols.



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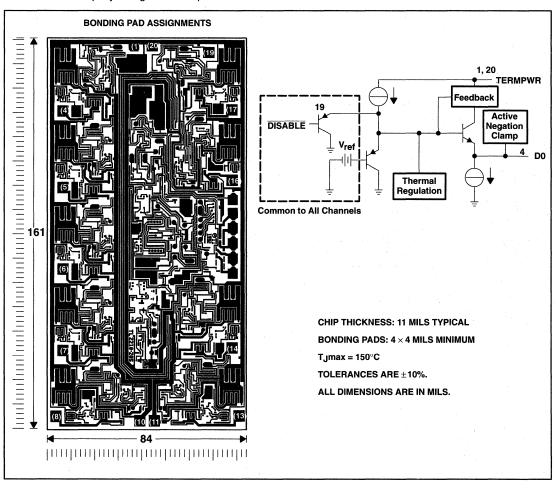
AVAILABLE OPTIONS

TJ		SURFACE MOUNT (PW)†	CHIP FORM (Y)
ſ	0°C to 125°C	TL2218-285PWLE	TL2218-285Y

[†] The PW package is only available left-end taped and reeled.

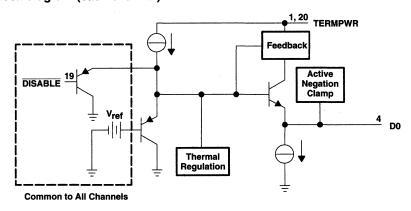
TL2218-285Y chip information

This chip, when properly assembled, displays characteristics similar to the TL2218-285. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



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functional block diagram (each channel)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted) (see Figures 1, 2, and 3)†

Continuous termination voltage	10 V
Continuous output voltage range	0 V to 5.5 V
Continuous disable voltage range	0 V to 5.5 V
Continuous total power dissipation	See Dissipation Rating Table
Operating virtual junction temperature range, T _J	–55°C to 150°C
Storage temperature range, T _{stq}	60°C to 150°C
Lead temperature 1.6 mm (1/16 inch) from case for 10 se	econds 260°C

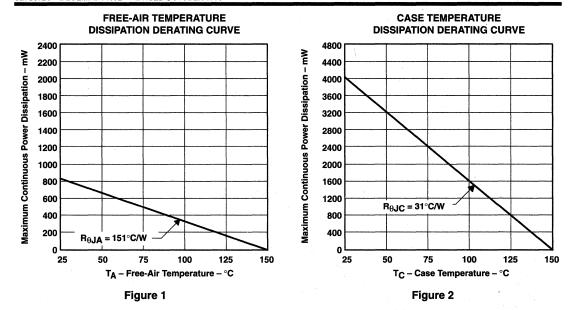
[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	POWER RATING AT	T ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T = 25°C	T = 70°C POWER RATING	T = 85°C POWER RATING	T = 125°C POWER RATING
	TA	828 mW	6.62 mW/°C	530 mW	430 mW	166 mW
PW	TC	4032 mW	32.2 mW/°C	2583 mW	2100 mW	812 mW
	TL [‡]	2475 mW	19.8 mW/°C	1584 mW	1287 mW	495 mW

[‡] R_{B.J.L} is the thermal resistance between the junction and device lead. To determine the virtual junction temperature (T.J) relative to the device lead temperature, the following calculations should be used: $T_J = P_D \times R_{\theta JL} + T_L$, where P_D is the internal power dissipation of the device and T_L is the device lead temperature at the point of contact to the printed wiring board. R_{0,JL} is 50.5°C/W.

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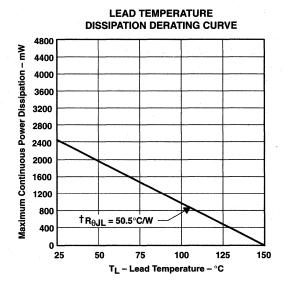


Figure 3



[†] $R_{\theta,JL}$ is the thermal resistance between the junction and device lead. To determine the virtual junction temperature (T_J) relative to the device lead temperature, the following calculations should be used: $T_J = P_D \times R_{\theta,JL} + T_L$, where P_D is the internal power dissipation of the device, and T_L is the device lead temperature at the point of contact to the printed wiring board. $R_{\theta,JL}$ is 50.5°C/W.

TL2218-285, TL2218-285Y EXCALIBUR CURRENT-MODE SCSI TERMINATOR

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recommended operating conditions

	MIN	MAX	UNIT
Termination voltage	3.5	5.5	V
High-level disable input voltage, VIH	2	V _{term}	V
Low-level disable input voltage, V _{IL}	0	0.8	٧
Operating virtual junction temperature, T _J	0	125	°C

electrical characteristics, V_{term} = 4.75 V, V_{O} = 0.5 V, T_{J} = 25°C

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output high voltage		2.5	2.85		V
	All data lines open		9		A
	All data lines = 0.5 V		228		mA
	DISABLE = 0 V		500		μΑ
Output current		-20.5	-23	-24	mA
Disable input surrent (see Note 1)	DISABLE = 4.75 V			1	
Disable input current (see Note 1)	DISABLE = 0 V	1 1 4		600	μΑ
Output leakage current	DISABLE = 0 V		100		nA
Output capacitance, device disabled	V _O = 0 V, 1 MHz		6		pF
Termination sink current, total	V _O = 4 V		20		mA

NOTE 1: When DISABLE is open or high, the terminator is active.

TL2218-285, TL2218-285Y **EXCALIBUR CURRENT-MODE SCSI TERMINATOR**

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THERMAL INFORMATION

The need for smaller surface-mount packages for use on compact printed-wiring boards (PWB) causes an increasingly difficult problem in the area of thermal dissipation. In order to provide the systems designer with a better approximation of the junction temperature rise in the thin-shrink small-outline package (TSSOP), the junction-to-lead thermal resistance ($R_{B,H}$) is provided along with the more typical values of junction-to-ambient and junction-to-case thermal resistances, $R_{\theta JA}$ and $R_{\theta JC}$.

 $R_{0,H}$ is used to calculate the device junction temperature rise measured from the leads of the unit. Consequently, the junction temperature is dependent upon the board temperature at the leads, $R_{\theta,JL}$, and the internal power dissipation of the device. The board temperature is contingent upon several variables, including device packing density, thickness, material, area, and number of interconnects. The $R_{B, \parallel}$ value depends on the number of leads connecting to the die-mount pad, the lead-frame alloy, area of the die, mount material, and mold compound. Since the power level at which the TSSOP can be used is highly dependent upon both the temperature rise of the PWB and the device itself, the systems designer can maximize this level by optimizing the circuit board. The junction temperature of the device can be calculated using the equation $T_J = (P_D \times R_{\theta JL}) + T_L$ where $T_J =$ junction temperature, $P_D =$ power dissipation, $R_{\theta JL}$ = junction-to-lead thermal resistance, and T_L = board temperature at the leads of the unit.

The values of thermal resistance for the TL2218-285 PW are as follows:

The	rmal Resistance	Typical Junction Rise
	$R_{ heta JA}$	151°C/W
	$R_{\theta JC}$	31 °C/W
	$R_{ hetaJL}$	50.5°C/W

TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
Ю	Output current	vs Input voltage	4
V _O	Output voltage	vs Input voltage	5
Ю	Output current	vs Junction temperature	6
VΟ	Output voltage	vs Junction temperature	7

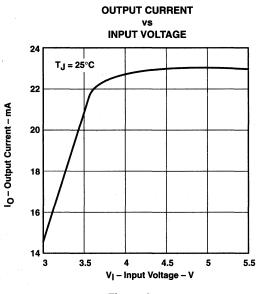


Figure 4

25

20

15

10

5

0

25

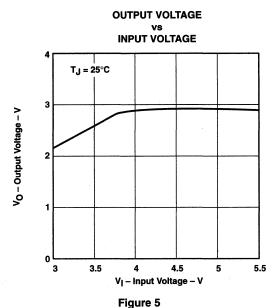
IO - Output Current - mA

OUTPUT CURRENT

JUNCTION TEMPERATURE

V_{term} = 4.75 V

 $T_A = T_J$





 T_J – Junction Temperature – °C Figure 6

50

75

100

125

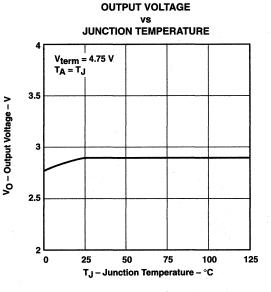


Figure 7

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- 2.5-V Virtual Ground for 5-V/GND Analog Systems
- Self-Contained in Small-Outline, Dual-In-Line or 3-Terminal TO-226AA Packages
- High Output-Current Capability Sink or Source . . . 20 mA Typ
- Micropower Operation . . . 170 μA Typ,

description

In signal-conditioning applications using a single power source, a reference voltage is required for termination of all signal grounds. To accomplish this, engineers have typically used solutions consisting of resistors, capacitors, operational amplifiers, and voltage references. Texas Instruments has eliminated all of those components with one easy-to-use 3-terminal device. That device is the TLE2425 precision virtual ground.

Use of the TLE2425 over other typical circuit solutions gives the designer increased dynamic signal range, improved signal-to-noise ratio, lower distortion, improved signal accuracy, and easier interfacing to ADCs and DACs. These benefits are the result of combining a precision micropower voltage reference and a high-performance precision operational amplifier in a single silicon chip. It is the precision and performance of these

Excellent Regulation Characteristics

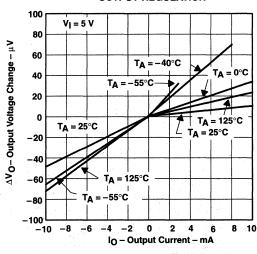
Output Regulation

 $-45 \,\mu\text{V}$ Typ at $I_{O} = 0$ to $-10 \,\text{mA}$

+15 µV Typ at IO = 0 to +10 mA

- Input Regulation = 1.5 μV/V Typ
- Low-Impedance Output . . . 0.0075 Ω Typ
- Macromodel included

OUTPUT REGULATION



two circuit functions together that yield such dramatic system-level performance.

The TLE2425 improves input regulation as well as output regulation and, in addition, reduces output impedance and power dissipation in a majority of virtual-ground-generation circuits. Both input regulation and load regulation exceed 12 bits of accuracy on a single 5-V system. Signal-conditioning front ends of data acquisition systems that push 12 bits and beyond can use the TLE2425 to eliminate a major source of system error.

The TLE2425C is characterized for operation from 0°C to 70°C. The TLE2425I is characterized for operation from –40°C to 85°C. The TLE2425M is characterized for operation over the full military temperature range of –55°C to 125°C.

AVAILABLE OPTIONS

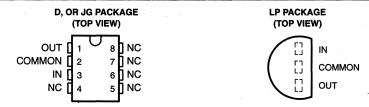
	PA			
TA SMALL OUTLINE (D)		CERAMIC DIP (JG)	PLASTIC TO-226AA (LP)	CHIP FORM (Y)
0°C to 70°C	TLE2425CD	-	TLE2425CD	TLE2425Y
-40°C to 85°C	TLE2425ID		TLE2425ID	_
-55°C to 125°C	TLE2425MD	TLE2425MD	TLE2425MD	-

† The D and LP packages are available taped and reeled in the commercial temperature range only. Add R suffix to the device type (e.g., TLE2425CDR). The chip form is tested at 25°C.



TLE2425, TLC2425Y PRECISION VIRTUAL GROUNDS

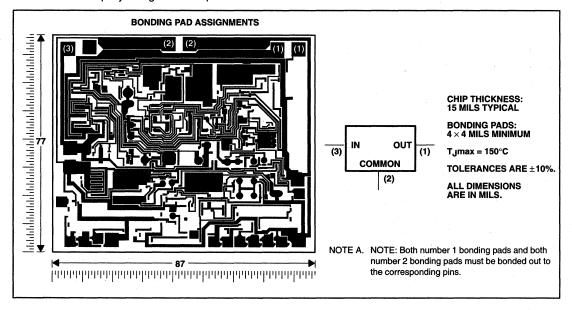
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NC - No internal connection

TLE2425Y chip information

This chip, properly assembled, displays characteristics similar to the TLE2425C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chip may be mounted with conductive epoxy or a gold-silicon preform.



TLE2425, TLE2425Y PRECISION VIRTUAL GROUNDS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Continuous input voltage, V _I		
Output current, IO		±80 mA
Duration of short-circuit current at (or belo	ow) 25°C (see Note 1)	unlimited
Continuous total power dissipation		
Operating free-air temperature range, TA:	C-suffix	0°C to 70°C
	I-suffix	–40°C to 85°C
	M-suffix	–55°C to 125°C
Storage temperature range, T _{sta}		65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) fron		
Lead temperature 1.6 mm (1/16 inch) fron	n case for 60 seconds: JG or LP page	kage 300°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mV	5.8 mW/°C	464 mW	377 mW	145 mW
JG	1050 mV	8.4 mW/°C	672 mW	546 mW	210 mW
LP	775 mV	6.2 mW/°C	496 mW	403 mW	155 mW

recommended operating conditions

	C-SUFFIX		I-SU	FFIX	M-SU	FFIX	LINUT
	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
Input voltage, V _I	4	40	4	40	4	40	٧
Operating free-air temperature, TA	0	70	-40	85	-55	125	°C

NOTE 1: The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

TLE2425, TLC2425Y PRECISION VIRTUAL GROUNDS

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electrical characteristics at specified free-air temperature, $V_I = 5 \text{ V}$, $I_O = 0$ (unless otherwise noted)

DADAMETED	TEST OO	TEST CONDITIONS		Т	LINIT		
PARAMETER	IEST COM	IDITIONS	T _A †	MIN	TYP	MAX	UNIT
Output voltage			25°C	2.48	2.5	2.52	v
Output voltage			Full range	2.47		2.53	ľ
Temperature coefficient of output voltage			25°C		20		ppm/°C
Rice augment	I _O = 0		25°C		170	250	
Bias current	IO = 0		Full range			250	μA
	V _I = 4.5 V to 5.5 V		25°C		1.5	20	μV
Input voltage regulation	V = 4.5 V 10 5.5 V		Full range			25	μν
	V _I = 4 V to 40 V		25°C		1.5	20	μV/V
	V = 4 V to 40 V		Full range			25	μν/ν
Ripple rejection	f = 120 Hz,	$\Delta V_{I(PP)} = 1 V$	25°C		80	:	dB
Output voltage regulation (source current)‡	I _O = 0 to -10 mA		25°C	-160	-45	160	
			`Full range	-250		250	μV
	$I_0 = 0 \text{ to } -20 \text{ mA}$		25°C	-450	-150	450	
	- 0 to 10 mA		25°C	-160	15	160	
Output voltage regulation (sink current)‡	I _O = 0 to 10 mA		Full range	-250		250	μV
	I _O = 0 to 20 mA		25°C	-235	65	235	1
Long-term drift of output voltage	$\Delta t = 1000 \text{ h},$	Noncumulative	25°C		15	11 1	ppm
Output impedance			25°C		7.5	22.5	mΩ
Short-circuit output current (sink current)	V _O = 5 V		0500	30	55		
Short-circuit output current (source current)	V _O = 0		25°C	-30	-50		mA
Output noise voltage, rms	f = 10 Hz to 10 kHz	:	25°C		100		μV
	V _O to 0.1%,	C _L = 0			110		. To
Output valtage response to sutput surrent step	$I_0 = \pm 10 \text{ mA}$	C _L = 100 pF	25°C		115		
Output voltage response to output current step	V _O to 0.01%,	C _L = 0	25.0		180		μs
No. 1	$I_O = \pm 10 \text{ mA}$	C _L = 100 pF			180		
Output voltage response to input voltage step	V _I = 4.5 to 5.5 V,	o 5.5 V, V _O to 0.1%			12		
Output voltage response to input voltage step	V _I = 4.5 to 5.5 V,	V _O to 0.01%	25°C		30		μs
Output voltage turn on recognice	V _I = 0 to 5 V,	V _O to 0.1%	25°C		125		
Output voltage turn-on response	V _I = 0 to 5 V,	V _O to 0.01%	25.0		210		μs

[†] Full range is 0°C to 70°C.

[‡] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

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electrical characteristics at specified free-air temperature, $V_1 = 5 \text{ V}$, $I_0 = 0$ (unless otherwise noted)

PARAMETER	TEAT 001	IDITIONO	-+	Т	LE2425		UNIT
PARAMETER	TEST CO	NUTTIONS	TAT	MIN	TYP	MAX	UNII
Output voltage			25°C	2.48	2.5	2.52	v
Output voitage			Full range	2.47		2.53	, v
Temperature coefficient of output voltage			25°C		20		ppm/°(
Dies surrent	1- 0		25°C		170	250	
Bias current	IO = 0		Full range			250	μA
	V- 45V+055V		25°C		1.5	20	
land to selle and translation	$V_{I} = 4.5 \text{ V to } 5.5 \text{ V}$		Full range			75	μV
Input voltage regulation	V 4.V += 40.V	:	25°C		1.5	20	
	V _I = 4 V to 40 V		Full range			75	μV/V
Ripple rejection	f = 120 Hz,	ΔV _{I(PP)} = 1 V	25°C		80		dB
	1. Ot- 101	· · · · · · · · · · · · · · · · · · ·	25°C	-160	-45	160	
Output voltage regulation (source current)‡	$I_{O} = 0 \text{ to } -10 \text{ mA}$		Full range	-250		250	μV
	$I_0 = 0 \text{ to } -20 \text{ mA}$		25°C	-450	-150	450	
	I _O = 0 to 8 mA		25°C	-160	15	160	
Output voltage regulation (sink current)‡			Full range	-250		250	μV
	I _O = 0 to 20 mA		25°C	-235	65	235	
Long-term drift of output voltage	$\Delta t = 1000 \text{ h},$	Noncumulative	25°C		15		ppm
Output impedance			25°C		7.5	22.5	mΩ
Short-circuit output current (sink current)	V _O = 5 V		0500	30	55		
Short-circuit output current (source current)	V _O = 0		25°C	-30	-50		mA
Output noise voltage, rms	f = 10 Hz to 10 kHz		25°C		100		μV
	V _O to 0.1%,	C _L = 0			110		
0.4-4-4-4-4-4-4-4-4-4-4-4-4-4-4-4-4-4-4-	$I_0 = \pm 10 \text{ mA}$	C _L = 100 pF	0500		115		
Output voltage response to output current step	V _O to 0.01%,	C _L = 0	25°C		180		μs
	$I_0 = \pm 10 \text{ mA}$	C _L = 100 pF			180		
Output valtage vacanana to invut valtage at a	V _I = 4.5 to 5.5 V,	V _O to 0.1%	0500		12		
Output voltage response to input voltage step	V _I = 4.5 to 5.5 V,	V _O to 0.01%	25°C		30	A 15	μs
0.44	V _I = 0 to 5 V,	V _O to 0.1%	0500		125		
Output voltage turn-on response	V _I = 0 to 5 V,	V _O to 0.01%	25°C		210		μs

[†] Full range is -40°C to 85°C.

[‡] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

TLE2425, TLC2425Y PRECISION VIRTUAL GROUNDS

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electrical characteristics at specified free-air temperature, $V_I = 5 \text{ V}$, $I_O = 0$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS		TAT	T	UNIT			
PARAMETER	IESI COI	TEST CONDITIONS		MIN	TYP	MAX	UNIT	
Output voltage				2.48	2.5	2.52	V	
Output voitage	·		Full range	2.47		2.53	V	
Temperature coefficient of output voltage			25°C		20		ppm/°C	
Bias current	I _O = 0		25°C		170	250		
Dias current	10 = 0	IO = 0				250	μА	
	V _I = 4.5 V to 5.5 V		25°C		1.5	20	μV	
Input voltage regulation	V = 4.5 V to 5.5 V		Full range			100	μν	
input voltage regulation	V _I = 4.5 V to 40 V		25°C		1.5	20	μV/V	
	V = 4.5 V 10 40 V		Full range			100	μν/ν	
Ripple rejection	f = 120 Hz,	$\Delta V_{I(PP)} = 1 V$	25°C		80		dB	
	I _O = 0 to -10 mA		25°C	-160	-45	160		
Output voltage regulation (source current)‡			Full range	-250		250	μV	
	$I_0 = 0 \text{ to } -20 \text{ mA}$		25°C	-450	-150	450		
	I _O = 0 to 3 mA		25°C	-160	15	160		
Output voltage regulation (sink current)‡			Full range	-250		250	μV	
	I _O = 0 to 20 mA		25°C	-235	65	235		
Long-term drift of output voltage	$\Delta t = 1000 \text{ h},$	Noncumulative	25°C		15		ppm	
Output impedance		1	25°C		7.5	22.5	mΩ	
Short-circuit output current (sink current)	V _O = 5 V		25°C	30	55		mA	
Short-circuit output current (source current)	V _O = 0		25 C	-30	-50		IIIA	
Output noise voltage, rms	f = 10 Hz to 10 kHz	4	25°C		100		μV	
	V _O to 0.1%,	C _L = 0			110			
Output voltage response to output current step	$I_O = \pm 10 \text{ mA}$	C _L = 100 pF	25°C		115			
Output voltage response to output current step	V _O to 0.01%,	CL = 0	250		180		μs	
	$I_O = \pm 10 \text{ mA}$	C _L = 100 pF			180			
Output voltage response to input voltage step	$V_{\parallel} = 4.5 \text{ to } 5.5 \text{ V},$	V _O to 0.1%	25°C		12		116	
Cutput voltage response to input voltage step	V _I = 4.5 to 5.5 V, V _O to 0.01%		23 0		30		μs	
Output voltage turn-on response	V _I = 0 to 5 V,	V _O to 0.1%	25°C		125			
Output voitage turn-orr response	$V_{I} = 0 \text{ to } 5 \text{ V},$	V _O to 0.01%	250		210		μs	

[†] Full range is -55°C to 125°C.

[‡] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

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electrical characteristics V_I = 5 V, I_O = 0, T_A = 25°C (unless otherwise noted)

DARAMETER		TEST CONDITIONS			TLE2425Y			
PARAMETER	TEST CONDITI				MAX	UNIT		
Output voltage				2.5		٧		
Temperature coefficient of output voltage				20		ppm/°C		
Bias current	I _O = 0			170		μΑ		
languit volta de versulation	V _I = 4.5 V to 5.5 V			1.5		μV		
Input voltage regulation	V _I = 4 V to 40 V			1.5		μV/V		
Ripple rejection	f = 120 Hz,	$\Delta V_{I(PP)} = 1 V$		80		dB		
0.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4.4	I _O = 0 to -10 mA			-45		/		
Output voltage regulation (source current)†	I _O = 0 to -20 mA			-150		μV		
0.4-4-14	IO = 0 to 10 mA	I _O = 0 to 10 mA		15		μV		
Output voltage regulation (sink current)†	I _O = 0 to 20 mA	I _O = 0 to 20 mA			65			
Output impedance				7.5		mΩ		
Short-circuit output current (sink current)	V _O = 5 V			55		mA		
Short-circuit output current (source current)	V _O = 0			-50		IIIA		
Output noise voltage, rms	f = 10 Hz to 10 kHz			100		μV		
	V- t- 0.19/ I- 1.10 mA	C _L = 0		110				
Output voltage response to output current step	V_O to 0.1%, $I_O = \pm 10 \text{ mA}$	C _L = 100 pF	115					
Output voltage response to output current step	V- 4- 0.019/ I- 1.10 mA	C _L = 0		180		μs		
	V_O to 0.01%, $I_O = \pm 10$ mA	C _L = 100 pF	180					
Output voltage response to input voltage stars	V _I = 4.5 to 5.5 V,	V _O to 0.1%		12				
Output voltage response to input voltage step	V _I = 4.5 to 5.5 V,	V _O to 0.01%		30		μs		
Output valtage turn on reconces	V _I = 0 to 5 V,	V _O to 0.1%		125				
Output voltage turn-on response	V _I = 0 to 5 V,	V _O to 0.01%		210		μs		

[†] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.



Table Of Graphs

		FIGURE
Output voltage	Distribution	1
Output voltage	vs Free-air temperature	2
Output voltage hysteresis	vs Free-air temperature	3
Innut his surrent	vs Input voltage	4
Input bias current	vs Free-air temperature	5
Input voltage regulation		6
Ripple rejection	vs Frequency	7
Output voltage regulation		8
Output impedance	vs Frequency	9
Short-circuit output current	vs Free-air temperature	10
Spectral noise voltage density	vs Frequency	11
Wide-band noise voltage	vs Frequency	12
Output voltage change with current step	vs Time	13
Output voltage change with voltage step	vs Time	14
Output voltage power-up response	vs Time	15
Output current	vs Load capacitance	16

OUTPUT VOLTAGE

TYPICAL CHARACTERISTICS†

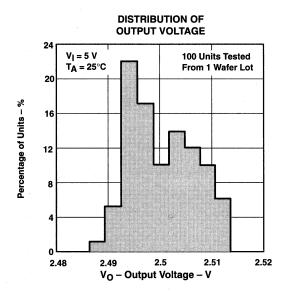


Figure 1

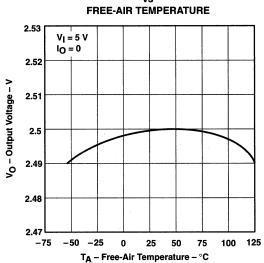


Figure 2

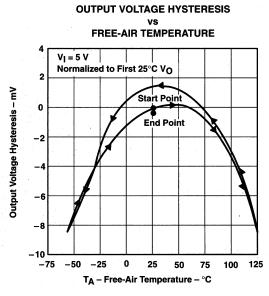


Figure 3

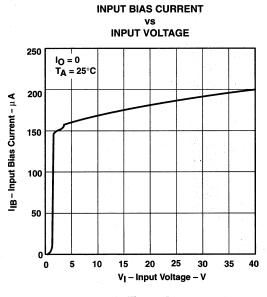


Figure 4

[†] Data at high and low temperatures are applicable within rated operating free-air temperature ranges of the various devices.



INPUT BIAS CURRENT FREE-AIR TEMPERATURE 172 $V_1 = 5 V$ IO = 0168 IB - Input Bias Current - μA 166 164 162 160 158 156 154 152 150 100 -75 -50 25 50 75

INPUT VOLTAGE REGULATION

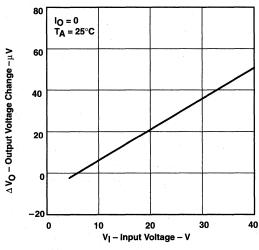
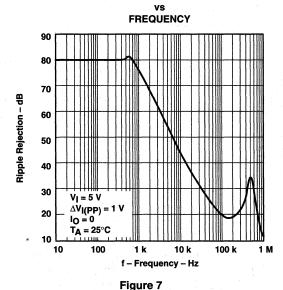


Figure 5



T_A - Free-Air Temperature - °C



OUTPUT VOLTAGE REGULATION

Figure 6

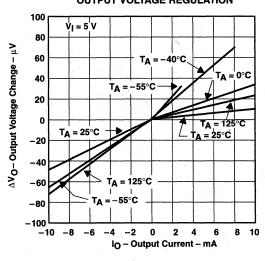


Figure 8

† Data at high and low temperatures are applicable within rated operating free-air temperature ranges of the various devices.



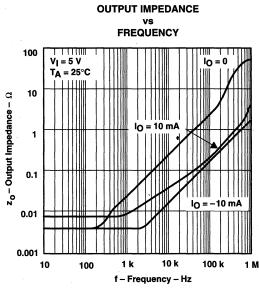


Figure 9

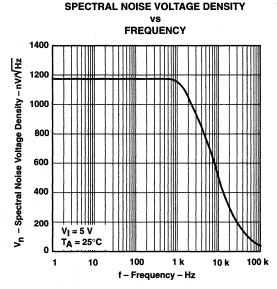


Figure 11

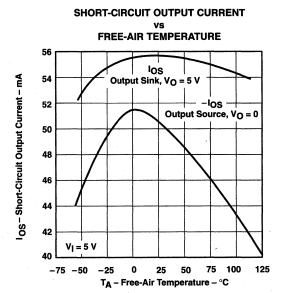


Figure 10

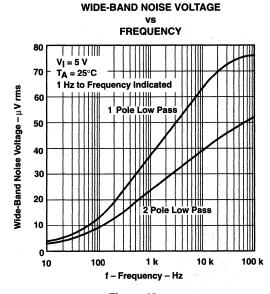


Figure 12

OUTPUT VOLTAGE RESPONSE TO OUTPUT CURRENT STEP TIME 1.5 V $V_1 = 5 \text{ V}$ ∆Vo - Change In Output Voltage - mV C_L = 100 pF TA = 25°C 0.1% 0.01% **VO Response** 0.01% -2 10 mA 0.1% Io Step 0 -10 mA -1.5 \ 0 150 300 450 600 750 900 1050 t - Time - μs

Figure 13

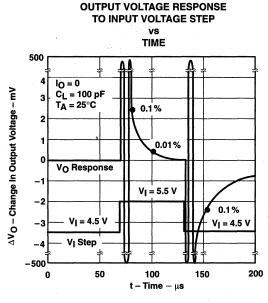


Figure 14

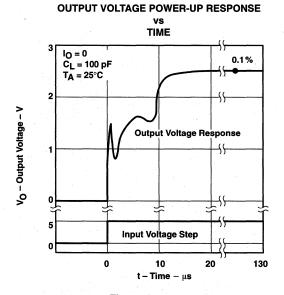


Figure 15

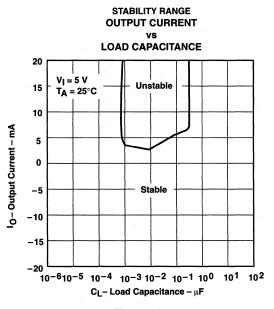


Figure 16



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macromodel information

```
* TLE2425 OPERATIONAL AMPLIFIER "MACROMODEL" SUBCIRCUIT
CREATED USING PARTS RELEASE 4.03 ON 08/21/90 AT 13:51
REV (N/A) SUPPLY VOLTAGE: 5 V
CONNECTIONS: INPUT

COMMON

OUTPUT

SUBCKT TLE2425 3 4 5
```

```
OPAMP SECTION
C1
       11 12 21.66E-12
C2
        6
          7
             30.00E-12
C3
       87 0
              10.64E-9
CPSR
       85 86 15.9E-9
       81 82 DX
DCM+
DCM-
       83 81 DX
DC
        5
         53 DX
DE
       54 5
             DX
DLN
       92 90 DX
DLP
       90 91
             DX
DP
        4 3
             DX
ECMR
       84 99
             (2,99) 1
EGND
       99 0
              POLY(2)
                        (3,0) (4,0) 0
EPSR
       85 0
              POLY(1)
                        (3,4) -16.22E-6 3.24E-6
              POLY(1)
                        (88,0) 120E-6 1
ENSE
       89 2
        7 99 POLY(6)
                        VB VC VE VLPVLNVPSR O 74.8E6 -10E6 10E6
FB
                                                                          10E6
-10E6
       74E6
GA
        6 0
             11 12 320.4E-6
10 99 1.013E-9
GCM
        0 6
GPSR
       85 86
             (85,86) 100E-6
              (4,11) 3.204E-4
(4,12) 3.204E-4
GRC1
       4
          11
GRC2
          12
GRE1
       13 10
              (13,10)
                       1.038E-3
GRE2
       14
          10
              (14,10)
                        1.038E-3
HLIM
       90 0
              VLIM 1K
       80 1
             POLY(2)
                        VCM+
HCMR
                               VCM-
                                      0
                                          1E2 1E2
IRP
        3
              146E-6
IEE
        3 10 DC 24.05E-6
              .2E-9
IIO
        2 0
11
       88 0
              1E-21
01
       11 89 13 QX
       12 80 14 QX
Q2
R2
        6
          9
              100.0E3
RCM
       84 81 1K
REE
       10 99 8.316E6
RN1
       87 0
             2.55E8
RN2
       87 88 11.67E3
```

TLE2425C, TLE2425I, TLE2425M PRECISION VIRTUAL GROUNDS

SLOS065B - MARCH 1991 - REVISED AUGUST 1995

macromodel information (continued)

```
RO1
           8 5
                63
   RO2
          7 99 62
          82 99 1.0
   VCM+
   VCM-
          83 99 -2.3
          9 0 DC 0
3 53 DC 1.400
   VВ
   VC
          54 4 DC 1.400
   VE
          7 8 DC 0
91 0 DC 30
   VLIM
   VLP
           0 92 DC 30
   VLN
   VPSR
           0 86 DC 0
           5 2
                1K
   RFB
          30 1
   RIN
                1K
   RCOM
          34 4
                 .1
*REGULATOR SECTION
                20MEG
   RG1
          30 0
   RG2
          30 31 .2
   RG3
          31 35 400K
   RG4
          35 34 411K
31 36 25MEG
   RG5
   HREG
         31 32 POLY(2)
                           VPSET VNSET 0
                                           1E2 1E2
   VREG
         32 33 DC 0V
   EREG
         33 34
                POLY(1)
                           (36, 34)
                                     1.23 1
   VADJ
         36 34 1.27V
   HPSET 37 0
                VREG
                       1.030E3
                DC 20V
   VPSET 38 0
   HNSET 39 0
                VREG
                       6.11E5
   VNSET 40 0
                DC -20V
          4 34 DX
   DSUB
         37 38 DX
   DPOS
   DNNEG 40 39 DX
.MODEL DX D(IS=800.0E-18)
.MODEL QX PNP(IS=800.0E-18 BF=480)
. ENDS
```

SLOS098B - AUGUST 1991 - REVISED AUGUST 1995

- 1/2 V_I Virtual Ground for Analog Systems
- Self-Contained 3-terminal TO-226AA Package
- Micropower Operation . . . 170 μA Typ,
 V_I = 5 V
- Wide V_I Range . . . 4 V to 40 V
- High Output-Current Capability
 - Source . . . 20 mA Typ
 - Sink . . . 20 mA Typ

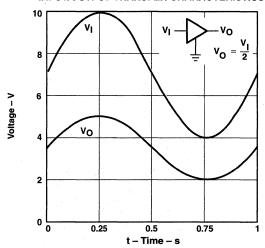
description

In signal-conditioning applications utilizing a single power source, a reference voltage equal to one-half the supply voltage is required for termination of all analog signal grounds. Texas Instruments introduces a precision virtual ground whose output voltage is always equal to one-half the input voltage, the TLE2426 "rail splitter."

The unique combination of a high-performance, micropower operational amplifier and a precision-trimmed divider on a single silicon chip results in a precise V_O/V_I ratio of 0.5 while sinking and sourcing current. The TLE2426 provides a low-impedance output with 20 mA of sink and source capability while drawing less than 280 μ A

- Excellent Output Regulation
 - $-45~\mu\text{V}$ Typ at $I_{\mbox{O}}$ = 0 to $-10~\mbox{mA}$
 - $+15 \mu V$ Typ at $I_0 = 0$ to +10 mA
- Low-Impedance Output . . . 0.0075 Ω Typ
- Noise Reduction Pin (D, JG, and P Packages Only)

INPUT/OUTPUT TRANSFER CHARACTERISTICS



of supply current over the full input range of 4 V to 40 V. A designer need not pay the price in terms of board space for a conventional signal ground consisting of resistors, capacitors, operational amplifiers, and voltage references. The performance and precision of the TLE2426 is available in an easy-to-use, space saving, 3-terminal LP package. For increased performance, the optional 8-pin packages provide a noise-reduction pin. Wtih the addition of an external capacitor (C_{NR}), peak-to-peak noise is reduced while line ripple rejection is improved.

Initial output tolerance for a single 5-V or 12-V system is better than 1% with 3.6% over the full 40-V input range. Ripple rejection exceeds 12 bits of accuracy. Whether the application is for a data acquisition front end, analog signal termination, or simply a precision voltage reference, the TLE2426 eliminates a major source of system error.

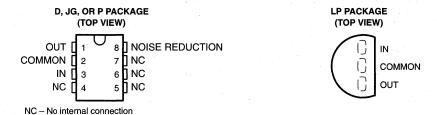
The C-suffix devices are characterized for operation from 0° C to 70° C. The I suffix devices are characterized for operation from -40° C to 85° C. The M suffix devices are characterized over the full military temperature range of -55° C to 125° C.

AVAILABLE OPTIONS

	PA	CKAGED DEVICE	s		
TA	SMALL OUTLINE (D)	INE DIP PLASTIC DIP		CHIP FORM (Y)	
0°C to 70°C	TLE2426CD	<u> </u>	TLE2426CLP	TLE2426CP	
-40°C to 85°C	TLE2426ID	_	TLE2426ILP	TLE2426IP	TLE2426Y
-55°C to 125°C	TLE2426MD	TLE2426MJG	TLE2426MLP	TLE2426MP	1 1 1 1 1 1

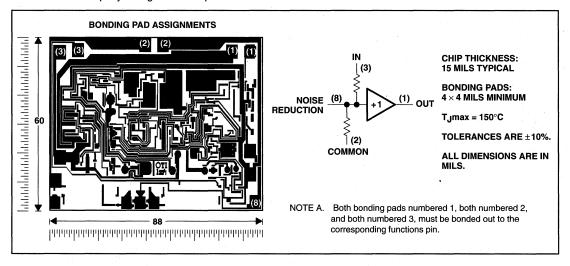
The D and LP packages are available taped and reeled in the commercial temperature range only. Add R suffix to the device type (e. g., TLC2426CDR). Chips are tested at 25°C.





TLE2426Y chip information

This chip, properly assembled, displays characteristics similar to the TLE2426C. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.



absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Continuous input voltage, V _I		
Continuous filter trap voltage		40 V
Output current, I _O		±80 mA
Duration of short-circuit current at (or belo	w) 25°C (see Note 1)	unlimited
Continuous total power dissipation		See Dissipation Rating Table
Operating free-air temperature range, TA:	C suffix	0°C to 70°C
	I suffix	–40°C to 85°C
	M suffix	–55°C to 125°C
Storage temperature range, T _{stq}		–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from		
Lead temperature 1.6 mm (1/16 inch) from	n case for 60 seconds: JG or LP	package 300°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mV	5.8 mW/°C	464 mW	377 mW	145 mW
JG	1050 mV	8.4 mW/°C	672 mW	546 mW	210 mW
LP	775 mV	6.2 mW/°C	496 mW	403 mW	155 mW
P	1000 mV	8.0 mW/°C	640 mW	520 mW	200 mW

recommended operating conditions

	 C SU	FFIX	ISUE	FIX	M SU	FFIX	11807
grand of the second	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
Input voltage, V _I	4	40	4	40	4	40	V
Operating free-air temperature, TA	0	70	-40	85	-55	125	°C

TLE2426, TLE2426Y THE "RAIL SPLITTER" PRECISION VIRTUAL GROUND

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electrical characteristics at specified free-air temperature, $V_I = 5 \text{ V}$, $I_O = 0$ (unless otherwise noted)

DADAMETED	TECT COL	TEST CONDITIONS		- +	T	LE24260	>	UNIT	
PARAMETER	IESI CON	טוווטו	NS .	T _A †	MIN	TYP	MAX	UNIT	
	V ₁ = 4 V				1.98	2	2.02		
Contract contracts	V _I = 5 V			25°C	2.48	2.5	2.52	v	
Output voltage	V _I = 40 V				19.8	20	20.2		
	V _I = 5 V		1	Full range	2.475		2.525		
Temperature coefficient of output volta	ge			Full range		25		ppm/°C	
	N. I. I.		V _I = 5 V	25°C		170	300		
Supply current	No load		V _J = 4 to 40 V	Full range			400	μΑ	
· .				25°C		-45	±160		
Output voltage regulation (sourcing current)	$I_{O} = 0 \text{ to} - 10 \text{ mA}$			Full range			±250	μV	
(Sourcing current)+	$I_0 = 0 \text{ to } -20 \text{ mA}$		·	25°C		-150	±450		
	0.45.40.554	I _O = 0 to 10 mA		25°C		15	±160		
Output voltage regulation sinking current)‡	10 = 0 to 10 mA			Full range			±250	μV	
	$I_O = 0$ to 20 mA			25°C		65	±235		
Output impedance				25°C		7.5	22.5	mΩ	
Noise-reduction impedance				25°C		110		kΩ	
Short-circuit current	Sinking current,		V _O = 5 V	0500	20	26			
Short-circuit current	Sourcing current,		V _O = 0	25°C	-20	-47		mA	
Outrast naise valte as week	f 10 H= 4- 10 HH=		C _{NR} = 0	25°C		120			
Output noise voltage, rms	f = 10 Hz to 10 kHz		C _{NR} = 1 μF	25°C		30		μV	
	V +- 0.40′ l +4		C _L = 0	25°C		290			
0	V_{O} to 0.1%, $I_{O} = \pm 1$	U MA	C _L = 100 pF	25°C	275				
Output voltage current step response	V- +- 0.040/ - - - - - - - - - - - - -	V_{O} to 0.01%, $I_{O} = \pm 10 \text{ mA}$	C _L = 0	0500		400		μs	
	VO 10 0.01%, 10 = ± 11		C _L = 100 pF	25°C		390			
Stan raananaa	$V_1 = 0 \text{ to 5 V}, V_0 \text{ to 0}.$	to 5 V, V _O to 0.1%		25°C		20			
Step response	$V_1 = 0 \text{ to } 5 \text{ V}, V_0 \text{ to } 0.$.01%	C _L = 100 pF	250		160		μs	

[†]Full range is 0°C to 70°C.

[‡] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified free-air temperature, $V_I = 12 \text{ V}$, $I_O = 0$ (unless otherwise noted)

PARAMETER	TEST COMPLETO	NC	T. +	TI	LE24260		UNIT		
PARAMETER	TEST CONDITIO	ons	T _A †	MIN	TYP	MAX	UNII		
	V _I = 4 V			1.98	2	2.02			
Outrost valle as	V _I = 12 V		25°C	5.95	6	6.05	l _v		
Output voltage	V _I = 40 V			19.8	20	20.2	1 '		
	V _I = 12 V		Full range	5.945		6.055	1		
Temperature coefficient of output voltage			Full range		35		ppm/°C		
Cumhi cumant	No load	V _I = 12 V	25°C		195	300			
Supply current	No load	V _I = 4 to 40 V	Full range			400	μΑ		
_	I- 0 to 10 mA		25°C		-45	±160			
Output voltage regulation (sourcing current)‡	I _O = 0 to -10 mA		Full range			±250	μV		
(Sourcing currenty)	I _O = 0 to -20 mA		25°C		-150	±450			
	I _O = 0 to 10 mA		25°C		15	±160			
Output voltage regulation sinking current)‡			Full range			±250	μV		
	I _O = 0 to 20 mA		25°C		65	±235	1		
Output impedance			25°C		7.5	22.5	mΩ		
Noise-reduction impedance			25°C		110		kΩ		
Oh and advantable and and	Sinking current,	V _O = 12 V	0500	20	31				
Short-circuit current	Sinking current, $V_O = 12 V$ Sourcing current, $V_O = 0$	25°C	-20	-70		mA			
Output poins valtage and	f = 10 Hz to 10 kHz	C _{NR} = 0	0500		120				
Output noise voltage, rms	1 = 10 HZ tO 10 KHZ	C _{NR} = 1 μF	25°C		30		μV		
	V . 4- 0.40/ 1	C _L = 0	0500		290				
Output voltage gurrent sten veer	V_O to 0.1%, $I_O = \pm 10 \text{ mA}$	C _L = 100 pF	25°C		275				
Output voltage current step response	V - 4- 0.040/ 1- 140 A	C _L = 0	0500		400		μs		
	V_{O} to 0.01%, $I_{O} = \pm 10 \text{ mA}$	C _L = 100 pF	25°C		390				
01	V _I = 0 to 12 V, V _O to 0.1%	0 100 5	0500		20				
Step response	V _I = 0 to 12 V. V _O to 0.01% C _L = 100 pF		25°C		120		μs		

[†] Full range is 0°C to 70°C.

[‡] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

TLE2426, TLE2426Y THE "RAIL SPLITTER" PRECISION VIRTUAL GROUND

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electrical characteristics at specified free-air temperature, $V_I = 5 \text{ V}$, $I_O = 0$ (unless otherwise noted)

PARAMETER	TEGT COMPLETE	TEST CONDITIONS		Т	LE2426		UNIT
PARAMETER	TEST CONDITIO	ins .	T _A †	MIN	TYP	MAX	UNIT
	V _I = 4 V			1.98	2	2.02	
Outros to a library	V _I = 5 V		25°C	2.48	2.5	2.52	v
Output voltage	V _I = 40 V			19.8	20	20.2	1 '
	V _I = 5 V		Full range	2.47		2.53	1
Temperature coefficient of output voltage			Full range		25		ppm/°C
		V _I = 5 V	25°C		170	300	
Supply current	No load	V _I = 4 to 40 V	Full range			400	μΑ
			25°C		-45	±160	
Output voltage regulation (sourcing current)‡	I _O = 0 to -10 mA		Full range			±250	μV
(sourcing current)+	I _O = 0 to -20 mA		25°C		-150	±450	
	I _O = 0 to 10 mA		25°C		15	±160	
Dutput voltage regulation sinking current)‡	I _O = 0 to 8 mA		Full range			±250	μ٧
	I _O = 0 to 20 mA		25°C		65	±235	
Output impedance			25°C		7.5	22.5	mΩ
Noise-reduction impedance			25°C		110		kΩ
0	Sinking current,	V _O = 5 V	0500	20	26		
Short-circuit current	Sourcing current,	V _O = 0	25°C	-20	-47		mA
0.44	£ : 40 H= 4- 40 HI=	C _{NR} = 0	0500		120		
Output noise voltage, rms	f = 10 Hz to 10 kHz	C _{NR} = 1 μF	25°C		30		μV
	V . 0.40′ L	C _L = 0	0500		290		
	V_{O} to 0.1%, $I_{O} = \pm 10 \text{ mA}$	C _L = 100 pF	25°C		275		
Output voltage current step response	V 1-0.040/ 1 140 4	C _L = 0	0500		400		μs
	V_O to 0.01%, $I_O = \pm 10 \text{ mA}$	C _L = 100 pF	25°C		390		1
Stan washing	V _I = 0 to 5 V, V _O to 0.1%	20					
Step response	V _I = 0 to 5 V, V _O to 0.01%	C _L = 100 pF	pF 25°C		160		μs

[†] Full range is -40°C to 85°C.

[‡] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

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electrical characteristics at specified free-air temperature, V_I = 12 V, I_O = 0 (unless otherwise noted)

DADAMETED	TEST CONDITIONS		- +	Т	LE2426	ı		
PARAMETER	TEST CONDITIO	NS	TΑ [†]	MIN	TYP	MAX	UNIT	
	V _I = 4 V			1.98	2	2.02		
Outrot value	V _I = 12 V		25°C	5.95	6	6.05	v.	
Output voltage	V _I = 40 V			19.8	20	20.2	V	
	V _I = 12 V		Full range	5.935		6.065		
Temperature coefficient of output voltage			Full range		35		ppm/°C	
	1	V _I = 12 V	25°C		195	300		
Supply current	No load	V _I = 4 to 40 V	Full range			400	μА	
			25°C		-45	±160		
Output voltage regulation (sourcing current)	I _O = 0 to –10 mA		Full range			±250	μV	
(Sourcing current)+	I _O = 0 to -20 mA		25°C		-150	±450		
	I _O = 0 to 10 mA		25°C		15	±160		
Output voltage regulation sinking current)‡	I _O = 0 to 8 mA		Full range			±250	μV	
(Sirking current)+	I _O = 0 to 20 mA		25°C		65	±235		
Output impedance			25°C		7.5	22.5	mΩ	
Noise-reduction impedance			25°C		110		kΩ	
Ob and a simulation of the sim	Sinking current,	V _O = 12 V	0500	20	31			
Short-circuit current	Sourcing current,	V _O = 0	25°C	-20	-70		mA	
	f 4011-1-10111-	C _{NR} = 0	0500		120		.,	
Output noise voltage, rms	f = 10 Hz to 10 kHz	C _{NR} = 1 μF	25°C		30		μV	
	1/ 1/ 0/10/ 1 1/10 1	C _L = 0	0500		290		-	
	V_{O} to 0.1%, $I_{O} = \pm 10 \text{ mA}$	C _L = 100 pF	25°C		275			
Output voltage current step response	V_{O} to 0.01%, $I_{O} = \pm 10 \text{ mA}$	C _L = 0	0500		400		μs	
		C _L = 100 pF	25°C		390			
Cton	V _I = 0 to 12 V, V _O to 0.1%	0 100 -			20			
Step response	V _I = 0 to 12 V, V _O to 0.01%	C _L = 100 pF	25°C		120	2.4.	μs	

[†] Full range is -40°C to 85°C.

[‡] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

TLE2426, TLE2426Y THE "RAIL SPLITTER" PRECISION VIRTUAL GROUND

electrical characteristics at specified free-air temperature, $V_I = 5 \text{ V}$, $I_O = 0$ (unless otherwise noted)

DADAMETED	TEST CONDITIONS		- +	T	LE2426	Λ	111117	
PARAMETER	TEST CONDITIO	INS	TA [†]	MIN	TYP	MAX	UNIT	
	V _I = 4 V			1.98	2	2.02		
O. Amarika and Indiana	V _I = 5 V	V _I = 5 V		2.48	2.5	2.52	١.,	
Output voltage	V _I = 40 V		1	19.8	20	20.2	V	
	V _I = 5 V		Full range	2.465		2.535	1	
Temperature coefficient of output voltage			Full range		25		ppm/°C	
0 1	1	V _I = 5 V	25°C		170	300		
Supply current	No load	V _I = 4 to 40 V	Full range			400	μΑ	
			25°C		-45	±160		
Output voltage regulation (sourcing current)‡	I _O = 0 to –10 mA		Full range			±250	μV	
(Sourcing Current)+	I _O = 0 to -20 mA		25°C		-150	±450		
Output voltage regulation (sinking current)‡	I _O = 0 to 10 mA		25°C		15	±160		
	I _O = 0 to 3 mA		Full range			±250	μ۷	
(Sinking current)	I _O = 0 to 20 mA		25°C		65	±235		
Output impedance			25°C		7.5	22.5	mΩ	
Noise-reduction impedance			25°C		110		kΩ	
Short-circuit current	Sinking current,	V _O = 5 V	25°C	20	26			
Short-circuit current	Sourcing current,	V _O = 0	25-0	-20	-47		mA	
Output noise voltage, rms	f 1011= to 10141=	C _{NR} = 0	25°C		120			
Output hoise voltage, mis	f = 10 Hz to 10 kHz	C _{NR} = 1 μF	25.0		30		μV	
	V - t- 0 40′ L 140 4	C _L = 0	0500		290			
Output valle as assument stan assument	V_O to 0.1%, $I_O = \pm 10$ mA	C _L = 100 pF	25°C	275				
Output voltage current step response	V 1-0040/ 1 140-4	C _L = 0	0500		400		μs	
	V_O to 0.01%, $I_O = \pm 10 \text{ mA}$	C _L = 100 pF	25°C		390			
Stop recognic	V _I = 0 to 5 V, V _O to 0.1%	C. 100 = F	25°C		20		. 00	
Step response	V _I = 0 to 5 V, V _O to 0.01%	C _L = 100 pF	250		120		μs	

[†] Full range is -55°C to 125°C.

[‡] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

TLE2426, TLE2426Y THE "RAIL SPLITTER" PRECISION VIRTUAL GROUND SLOS098B - AUGUST 1991 - REVISED AUGUST 1995

electrical characteristics at specified free-air temperature, $V_1 = 12 \text{ V}$, $I_0 = 0$ (unless otherwise noted)

DADAMETED	TEST CONDITIONS		T _A †	T	LE2426	Λ	UNIT	
PARAMETER	TEST CONDITIO	TEST CONDITIONS		MIN	TYP	MAX	UNII	
	V _I = 4 V			1.98	2	2.02		
Outro de calla ca	V _I = 12 V		25°C	5.95	6	6.05	١,,	
Output voltage	V _I = 40 V			19.8	20	20.2	٧	
	V _I = 12 V		Full range	5.925		6.075		
Temperature coefficient of output voltage			Full range		35		ppm/°C	
0		V _I = 12 V	25°C		195	250		
Supply current	No load	V _I = 4 to 40 V	Full range			350	μΑ	
			25°C		-45	±160		
Output voltage regulation (sourcing current)‡	$I_{O} = 0 \text{ to} - 10 \text{ mA}$		Full range			±250	μV	
(sourcing current)+	I _O = 0 to -20 mA		25°C		-150	±450		
_	I _O = 0 to 10 mA		25°C		15	±160	60	
Output voltage regulation sinking current)‡	I _O = 0 to 8 mA		Full range			±250	μV	
	I _O = 0 to 20 mA		25°C		65	±235	5	
Output impedance			25°C		7.5	22.5	mΩ	
Noise-reduction impedance		10.00	25°C		110		kΩ	
Short-circuit current	Sinking current,	V _O = 12 V	25°C	20	31		mA	
Short-circuit current	Sourcing current,	VO = 0	25.0	-20	-70		IIIA	
Output noise voltage, rms	f = 10 Hz to 10 kHz	C _{NR} = 0	25°C		120			
Output noise voltage, mis	1 = 10 HZ 10 10 KHZ	C _{NR} = 1 μF	25.0		30		μV	
	V _O to 0.1%, I _O = ±10 mA	C _L = 0	25°C		290	X		
Output voltage current step response	VO 10 0.176, IO = ± 10 IIIA	C _L = 100 pF	25 0		275			
Output voltage current step response	V_{O} to 0.01%, $I_{O} = \pm 10 \text{ mA}$	C _L = 0	25°C 40		400		μs	
	VO 10 0.01%, IO = ± 10 IIIA	C _L = 100 pF	200	390				
Step response	V _I = 0 to 12 V, V _O to 0.1%	C. = 100 pE	25°C		12		116	
Oreh reshouse	V _I = 0 to 12 V, V _O to 0.01%	☐ C _L = 100 pF	25°C	4	120		μs	

[†] Full range is -55°C to 125°C.

^{\$} Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

TLE2426, TLE2426Y THE "RAIL SPLITTER" PRECISION VIRTUAL GROUND

electrical characteristics at specified free-air temperature, V_I = 5 V, I_O = 0, T_A = 25°C (unless otherwise noted)

DADAMETED	TEST SOLIDITION		TI	E2426	1	
PARAMETER	TEST CONDITION	NS	MIN	TYP	MAX	UNIT
Output voltage	V _I = 5 V			2.5		V
Supply current	No load			170		μА
Outrot veltage very detical (coursing accuracy).	I _O = 0 to -10 mA			-45		
Output voltage regulation (sourcing current)†	I _O = 0 to -20 mA			-150		μV
Output voltage regulation (sinking current)†	I _O = 0 to 10 mA			15		
Output voltage regulation (sinking current)	I _O = 0 to 20 mA	65			μV	
Output impedance				7.5		mΩ
Noise-reduction impedance				110		kΩ
	Sinking current,	V _O = 5 V		26		mA
Short-circuit current	Sourcing current,	V _O = 0		-47		. ma
Output noise voltage, rms	f = 10 Hz to 10 kHz	C _{NR} = 0		120		μV
Output hoise voitage, mis	I = IO HZ tO IO KHZ	C _{NR} = 1 μF		30		μν
	V_{O} to 0.1%, $I_{O} = \pm 10 \text{ mA}$	CL = 0		290		
Output voltage current step response	VO 10 0.1 %, IO = ± 10 IIIA	C _L = 100 pF		275		
Output voitage current step response	V_{O} to 0.01%, $I_{O} = \pm 10 \text{ mA}$	C _L = 0		400	1.0	μs
	VO to 0.01%, 10 = ± 10 IIIA	C _L = 100 pF		390		
Step response	$V_1 = 0 \text{ to } 5 \text{ V}, V_0 \text{ to } 0.1\%$	C _L = 100 pF		20		ue.
Greb response	$V_I = 0 \text{ to } 5 \text{ V}, \qquad V_O \text{ to } 0.01\%$] CL = 100 pr	160		μs	

[†] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.

electrical characteristics at specified free-air temperature, V_{\parallel} = 12 V, I_{O} = 0, T_{A} = 25°C (unless otherwise noted)

	TEST CONDITIONS		TLE2426Y		
PARAMETER			MIN TYP	MAX	UNIT
Output voltage	V _I = 12 V		6		٧
Supply current	No load		195		μΑ
Output voltage regulation (sourcing current)†	I _O = 0 to -10 mA		-45	i de digente y	μV
	I _O = 0 to -20 mA		-150	7.44	
Output voltage regulation (sinking current)†	I _O = 0 to 3 mA		15		μV
	I _O = 0 to 20 mA		65		
Output impedance			7.5		mΩ
Noise-reduction impedance		1 1	110		kΩ
Short-circuit current	Sinking current, V _O = 12 V		31		
	Sourcing current,	V _O = 0	-70		mA
Output noise voltage, rms	f = 10 Hz to 10 kHZ	C _{NR} = 0	120		μV
	T = TO HZ to TO KHZ	C _{NR} = 1 μF	30		
Output voltage current, step response	V_{O} to 0.1%, $I_{O} = \pm 10 \text{ mA}$	CL = 0	290		
	VO 10 0.1%, 10 = ± 10 111A	C _L = 100 pF	275		
	V_{O} to 0.01%, $I_{O} = \pm 10 \text{ mA}$	CL = 0	400		μs
	VO 10 0.01 %, IO = ± 10 IIIA	C _L = 100 pF	390		
Step response	V _I = 0 to 12 V, V _O to 0.1%	Ct = 100 pF	12		μs
	V _I = 0 to 12 V, V _O to 0.01%	C _L = 100 pF	120		

[†] Sample tested. Pulse testing techniques are used to maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately.



Table Of Graphs

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Output voltage error	vs Input voltage	4
Innut him a summer	vs Input voltage	5
Input bias current	vs Free-air temperature	6
Output voltage regulation	vs Output current	7
Output impedance	vs Frequency	8
Chart singuit autout auront	vs Input voltage	9,10
Short-circuit output current	vs Free-air temperature	11,12
Ripple rejection	vs Frequency	13
Spectral noise voltage density	vs Frequency	14
Output voltage response to output current step	vs Time	15
Output voltage power-up response	vs Time	16
Output current	vs Load capacitance	17

TYPICAL CHARACTERISTICS[†]

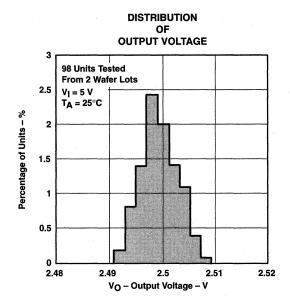


Figure 1

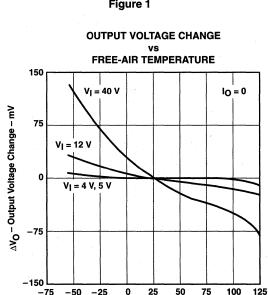


Figure 3

 T_A – Free-Air Temperature – °C

50

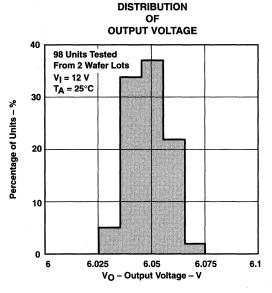
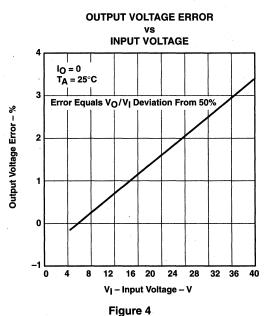


Figure 2



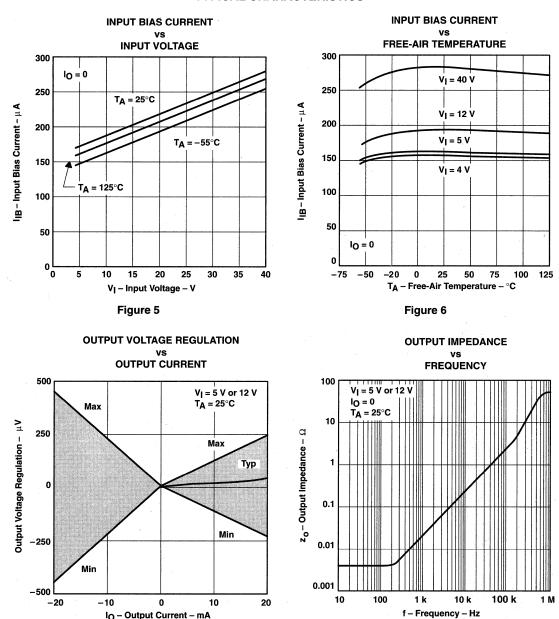
[†] Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.



-75

-50

TYPICAL CHARACTERISTICS[†]



IO - Output Current - mA

Figure 7



Figure 8

[†] Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.

SHORT-CIRCUIT OUTPUT CURRENT vs INPUT VOLTAGE $V_O = GND$ (Output Sourcing) I_{OS} - Short-Circuit Output Current - mA -20 -40 $T_A = -55^{\circ}C$ -60 TA = 125°C TA = 25°C -80 10 15 20 35 40 V_I - Input Voltage - V Figure 9

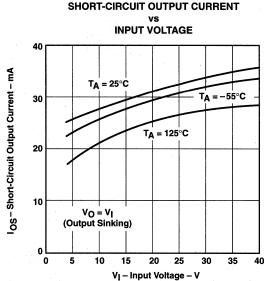
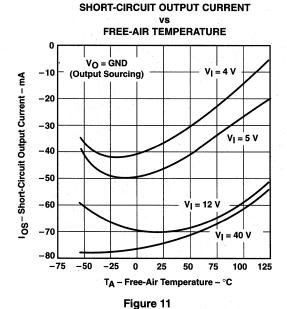


Figure 10



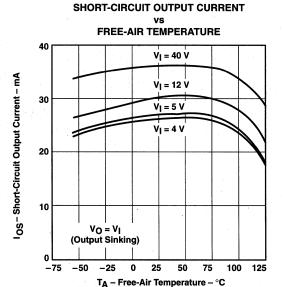
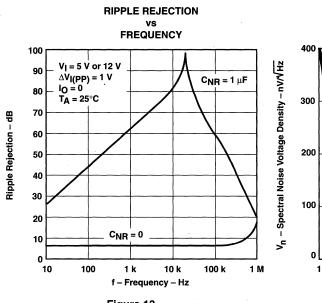


Figure 12

[†] Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.





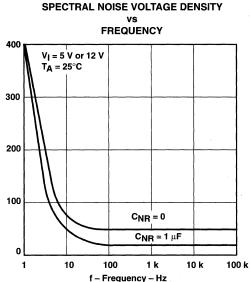


Figure 13



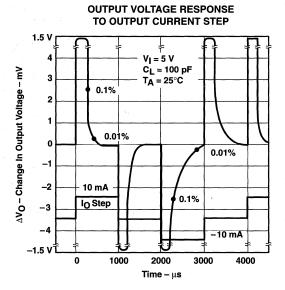


Figure 15

OUTPUT VOLTAGE POWER-UP RESPONSE

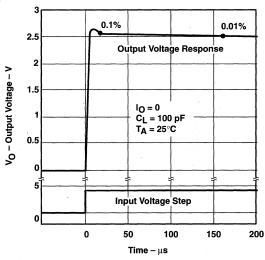


Figure 16



STABILITY RANGE
OUTPUT CURRENT
vs
LOAD CAPACITANCE

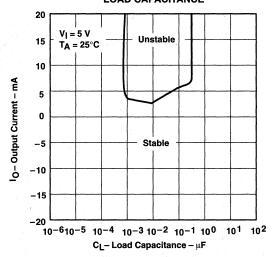


Figure 17

SLOS098B - AUGUST 1991 - REVISED AUGUST 1995

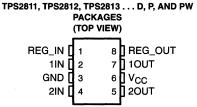
macromodel information

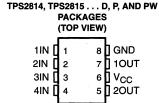
```
C1
          11 12 21.66E-12
   C2
                 30.00E-12
           6
   C3
          87
               0 10.64E-9
          85 86 15.9E-9
   CPSR
   DCM+
          81
              82 DX
   DCM-
          83
             81 DX
   DC
             53 DX
           5
          54
   DE
               5 DX
   DLP
          90
             91 DX
          92
              90 DX
   DLN
   DP
           4
               3
                 DX
   ECMR
          84
             99 (2,99) 1
                            (3,0) (4,0) 0 .5 .5
(3,4) -16.22E-6 3.24E-6
   EGND
          99
               0 POLY(2)
   EPSR
          85
               0 POLY(1)
   ENSE
          89
               2 POLY(1)
                             (88,0) 120E-61
   FΒ
           7
              99
                 POLY(6)
                            VB VC VE VLPVLNVPSR 0 74.8E6 -10E6 10E6 10E6
                                                                                 -10E6 74E6
                 11 12 320.4E-6
   GA
           6
               0
   GCM
           0
               6 10 99 1.013E-9
   GPSR
          85
              86 (85,86)
                            100E-6
                  (4,11) 3.204E-4
   GRC1
           4
              11
   GRC2
           4
              12
                  (4,12) 3.204E-4
   GRE1
          13
              10
                  (13,10)
                            1.038E-3
   GRE2
          14 10 (14,10)
                            1.038E-3
   HLIM
          90
                        1K
               0 VLIM
               1 POLY(2)
   HCMR
          80
                            VCM+
                                   VCM-
                                           0
                                              1E2
                                                      1E2
   IRP
           3
               4 146E-6
   TEE
             10 DC 24.05E-6
           3
   IIO
           2
               0
                  .2E-9
   11
          88
               0 1E-21
              89 13 QX
80 14 QX
   Q1
          11
             80
   Q2
          12
   R2
               9 100.0E3
          84 81 1K
   RCM
   REE
          10 99
                  8.316E6
   RN1
          87
               0
                  2.55E8
   RN2
          87
              88 11.67E3
   RO1
               5 63
           8
              99 62
   RO2
           7
   VCM+
          82
              99 1.0
          83 99 -2.3
   VCM-
   VB.
               0 DC 0
           9
   VC
           3
              53 DC
               53 DC 1.400
4 DC 1.400
   VE
          54
           7
              8 DC 0
0 DC 30
   VLIM
   VLP
          91
              92 DC 30
   VLN
           0
   VPSR
           0 86 DC 0
   RFB
           5
               2 1K
   RIN1
           3
               1 220K
   RIN2
           1
               4 220K
.MODEL DX D(IS=800.OE-18)
.MODEL QX PNP(IS=800.OE-18BF=480)
.ENDS
```

- Industry-Standard Driver Replacement
- 20-ns Max Rise/Fall Times and 30 ns Max Propagation Delay – 1-nF Load
- 2-A Peak Output Current
- 100-μA Supply Current Inputs High or Low
- 4-V to 14-V Driver Supply Voltage Range; Internal Regulator Extends Range to 34 V
- −40°C to 150°C Junction Temperature Operating Range.

description

The TPS2811 series of dual high-speed MOSFET drivers are capable of delivering peak currents of 2 A into highly capacitive loads. This performance is accompanied by supply currents an order of magnitude lower than those of competitive products. The design inherently minimizes shoot-through current.

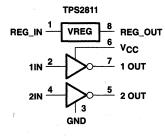


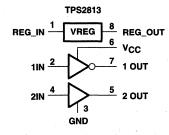


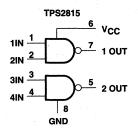
Each of the TPS2811, TPS2812, and TPS2813 drivers include a regulator to allow operation with supply inputs between 14 V and 34 V. The regulator output can be used to power other circuitry, provided power dissipation does not exceed package limitations. Supply voltages below 14 V may be connected directly to V_{CC} , REG_OUT, and REG_IN, or REG_IN can be left open.

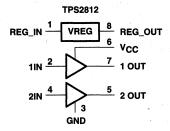
The TPS2811 series are available in 8-pin PDIP, SOIC, and TSSOP packages and operate over a junction temperature range of -40° C to 150°C.

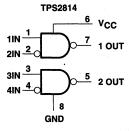
logic diagrams (positive logic)











TPS9103 POWER SUPPLY FOR GaAs POWER AMPLIFIERS

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- On-chip Charge Pump Provides Negative Gate Bias for Depletion-Mode GaAs Power Amplifiers
- Buffered Clock Output to Drive Additional External Charge Pump
- 200-mΩ High-Side Switch With Logic-Compatible Enable Input Controls Supply Voltage to the GaAs Power Amplifier
- Power-Good Circuitry Prevents High-Side Switch Turn-on Until Negative Gate Bias is Present
- Charge Pump Can Be Driven From the Internal Oscillator or An External Clock
- 10-μA Maximum Standby Current
- Low-Profile (1.2-mm Max Height), 20-Pin TSSOP Package

GATE_BIAS 10 20 19 2 19 2 19 2 19 2 19 2 19 2 2 19 2 2 2 2 2 2 2 2 2	U VDD CLK BCLK GND BATT_OUT BATT_OUT BATT_OUT SW_EN OSC_EN EN

description

The TPS9103 is a highly integrated power supply for depletion-mode GaAs power amplifiers (PA) in cellular handsets and other wireless communications equipment. Functional integration and low-profile packaging combine to minimize circuit-board area and component height requirements. The device includes: a p-channel MOSFET, configured as a high-side switch to control the application of power to the PA; a driver for the high-side switch with a logic-compatible input; a charge pump to provide negative gate-bias voltage; and logic to prevent turn-on of the high-side switch until gate bias is present. The high-side switch has a maximum on-state resistance of 200 m Ω .

The TPS9103 is available in a 20-pin TSSOP package and operates over an ambient temperature range of -40°C to 85°C.

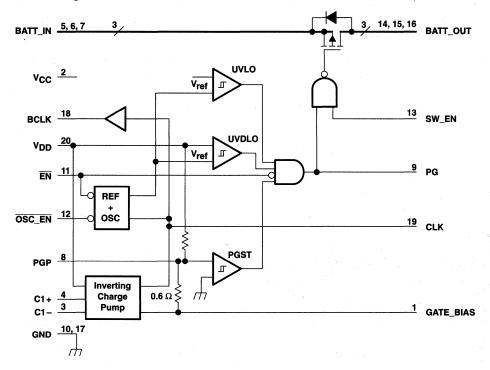
AVAILABLE OPTIONS

	PACKAGED DEVICE	CHIP FORM
 T _A	TSS0P (PW)	(Y)
-40°C to 85°C	TPS9103IPWLE	TPS9103Y

The PW package is only available left-end taped and reeled (indicated by the LE suffix on the device type).



functional block diagram

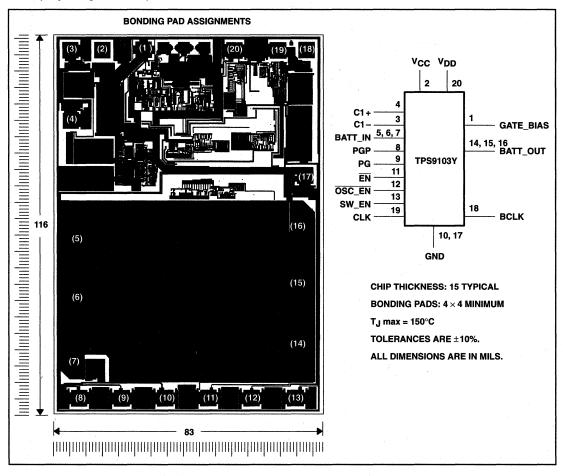


Terminal Functions

TERMINA	AL	
NAME	NO.	DESCRIPTION
GATE_BIAS	1	Negative gate-bias output voltage
Vcc	2	Logic supply voltage
C1-	3	External capacitor connection (inverting charge pump)
C1+	4	External capacitor connection (inverting charge pump)
BATT_IN	5	High-side switch input voltage
BATT_IN	6	High-side switch input voltage
BATT_IN	7	High-side switch input voltage
PGP	8	Program input for power-good threshold
PG	9	Power-good output
GND	10	Ground
EN	11	Chip-enable input
OSC_EN	12	Oscillator-enable input
SW_EN	13	High-side switch enable input
BATT_OUT	14	High-side switch output voltage
BATT_OUT	15	High-side switch output voltage
BATT_OUT	16	High-side switch output voltage
GND	17	Ground
BCLK	18	Buffered clock output
CLK	19	Clock (bidirectional)
V_{DD}	20	Charge-pump supply voltage

TPS9103Y chip information

This chip, when properly assembled, displays characteristics similar to the TPS9103. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)† Supply voltage, V_{CC}, V_{DD} -0.3 V to 7 V Voltage at GATE_BIAS –5.5 V Output current at PG Output current at BCLK Peak output current at BATT_OUT 4 A Junction temperature range, T₁ –40°C to 125°C Storage temperature range, T_{stq} –65°C to 150°C

NOTES: 1. All voltages are with respect to device GND.

2. Differential voltage calculated: IVImaxl + IGATE_BIASI

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	DERATING FACTOR	T _A = 70°C	T _A = 85°C
	POWER RATING	ABOVE T _A = 25°C	POWER RATING	POWER RATING
PW	645 mW	6.5 mW/°C	353 mW	255 mW

recommended operating conditions

	MIN	NOM MAX	UNIT
High-side switch input voltage, at BATT_IN	3	9	V
Supply voltage, V _{CC} , V _{DD}	2.7	5.5	٧
Output voltage, V _{O,} at GATE_BIAS	-2	-5	٧
Continuous output current at GATE_BIAS	0	10	mA
Continuous output current at BATT_OUT	0	1910-91	Α
Charge-pump capacitor value at C1		0.33	μF
External clock frequency at CLK	25	75	kHz
Operating free-air temperature, T _A	-40	85	°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

TPS9103 POWER SUPPLY FOR GaAs POWER AMPLIFIERS

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electrical characteristics over recommended operating free-air temperature range, V_I = 6 V, V_{CC} = V_{DD} = 3.3 V, I(BATT_OUT) = 0.5 A, I(GATE_BIAS) = 2 mA, $\overline{\text{EN}}$ = $\overline{\text{OSC}}_{\overline{\text{EN}}}$ = 0 V, SW_EN = V_{CC}, C1 = 0.33 μF (unless otherwise noted)

charge pump

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output voltage	T _A = 25°C	-3	-3.15	-3.3	V
Output Resistance	V _{CC} = 3.3 V		90		Ω

high-side switch

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
0	T _A = 25°C			200	mΩ
On resistance	$T_A = 25$ °C, $V_{I(BATT_IN)} = 3 \text{ V}$			400	mΩ
Laskasa	$T_A = 25$ °C, $V_{I(BATT_IN)} = 9 \text{ V}$, $SW_EN = 0 \text{ V}$			1	
Leakage current	$T_A = 85$ °C, $V_{I(BATT_IN)} = 9 \text{ V}$, $SW_EN = 0 \text{ V}$			10	μΑ
Delay to output high	SW_EN from 0 V to V _{CC}			2	μs
Delay to output low	SW_EN from V _{CC} to 0 V			2	μs

oscillator

PARAMETE	R TEST CONDITIONS	MIN	TYP	MAX	UNIT
Frequency	T _A = 25°C	45	50	55	kHz
Frequency	V _{CC} = 2.7 V to 5.5 V	40		60	kHz
Duty cycle	V _{CC} = 2.7 V to 5.5 V	40%	50%	60%	

buffered clock output (BCLK)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output Resistance				10	Ω
High-state output voltage	I(BCLK) = 30 mA	V _{CC} -0.3			٧
Low-stage output voltage	I(BCLK) = 30 mA			0.4	, V 1

digital inputs (SW_EN, EN, OSC_EN, CLK)

PARAMETER	TEST CONDITIONS	MIN	TYP MAX	UNIT
High-level input voltage		V _{CC} - 0.3	V _{CC} + 0.3	٧
Low-level input voltage		GND - 0.3	GND + 0.3	٧
Input current		-1	1	μА

power good (PG)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Threshold voltage	See Note 3		$0.60 \times V_{DD}$		V
On-state voltage	I(PG) = 500 μA			0.3	٧
Off-state voltage	I(PG) = -500 μA	V _{CC} -0.3			·V
Delay GATE_BIAS to PG	See Note 4			5	μs

NOTES: 3. Threshold externally adjustable by programming PGP input.

4. Power-good output PG must be logic zero 5 µs after GATE_BIAS drops below threshold; i.e., GATE_BIAS is not negative enough.

power good (PGP)

PARAMETER	TEST CONDITIONS	MIN TYP MAX	UNIT
Input impedance	Agent in the second of the sec	100	kΩ



undervoltage lockout (UVLO)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Start threshold voltage		2.4		2.7	٧
Hysteresis		100			mV

undervoltage lockout (UVDLO)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Start threshold voltage		2.4		2.7	٧
Hysteresis			100		mV

supply current (ICC)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Standby			1	10	μΑ
UVLO	V _{CC} < 2.4 V		30	50	μА
Operating			350	500	μΑ

PRINCIPLES OF OPERATION

functional description

high-side switch and driver (BATT_IN, BATT_OUT, SW_EN)

The high-side switch is a p-channel MOSFET with a maximum on-state resistance of 200 m Ω (V_{I(BATT_IN)} = 6 V and V_{CC} = 3.3 V). The driver pulls the gate of the high-side switch to GATE_BIAS instead of ground to reduce the size of the MOSFET. Gate breakdown considerations limit BATT_IN-to-GATE_BIAS to 15 V. Extremely fast switching times are not required in this application, and the high-side switch/driver is designed to provide 2 μ s maximum switching times with minimum power consumption. The GaAs depletion-mode MOSFETs in the PA are protected from damage at power-up by internal logic that inhibits the driver until negative gate bias is available. The control input SW_EN is compatible with 3-V and 5-V CMOS logic; a logic-high input turns the high-side switch on.

oscillator (OSC EN, CLK)

The internal oscillator drives the charge pump at 50 kHz with a nominal duty cycle of 50% when both the EN and OSC_EN inputs are logic lows. CLK outputs the internal oscillator signal (no buffer). A logic-high input to OSC_EN disables the internal oscillator and allows the charge pump to operate from an external clock connected to CLK.

charge pump (GATE_BIAS, C1+, C1-)

The inverting charge pump generates the negative gate-bias voltage output GATE_BIAS.

chip enable (EN)

A logic high on $\overline{\text{EN}}$ shuts down the internal functions of the TPS9103 and turns the bias system off, reducing the supply current to less than 10 μ A. A logic-low input causes normal operation to resume.

power good (PG, PGP)

PG output is logic low if GATE_BIAS is not in regulation. The high-side switch is disabled and PG is forced to logic low whenever the magnitude of GATE_BIAS is less than $0.6 \times V_{DD}$. A modified threshold for the power-good function can be achieved by programming PGP with an external resistor.



PRINCIPLES OF OPERATION

undervoltage lockout for V_{CC} and V_{DD} (UVLO and UVDLO)

Undervoltage lockout prevents operation at supply voltages too low for proper operation. When UVLO or UVDLO is active, all power-switch drives are forced to the off state and bias is removed from unneeded functions. A minimum 100 mV of hysteresis is built in to minimize cycling on and off because of source impedance loading when the supply voltage is close to the threshold.

buffered clock output (BCLK)

The buffered clock output is a driver of an external charge pump. For more details, please see the application section.

supply input for inverting charge pump (V_{DD})

 V_{DD} is a separate supply input for the inverting charge pump. In normal operation, V_{DD} is connected to V_{CC} . If the negative gate-bias absolute value needs to be larger than V_{CC} (i.e., more negative), then a higher voltage supply needs to be connected to V_{DD} . This can be supplied from an external charge pump driven from BCLK.

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Designing Switching Voltage Regulators with TL494

Application Report



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Abstract

In this application report, the TL494 switching power supply control is discussed in detail. A general overview of the device's architecture presents the primary functions contained in the 16-pin dual-in-line package and its features. An in-depth study of each of the device's primary building blocks highlights the versatility and limitations of the control circuit and gives a thorough understanding of their interrelationship. Applying the control circuit to several basic applications demonstrates the circuits' usefulness and outlines some still unresolved problems.

Introduction

Over the past few years, a series of monolithic integrated circuits for the control of switching power supplies have been introduced. One of these, the TL494, combines many of the features previously requiring several control circuits. The TL494 simplifies many design problems with its unique architecture. It is the purpose of this application report to give the reader a thorough understanding of the TL494, its features, its performance characteristics, and its limitations.

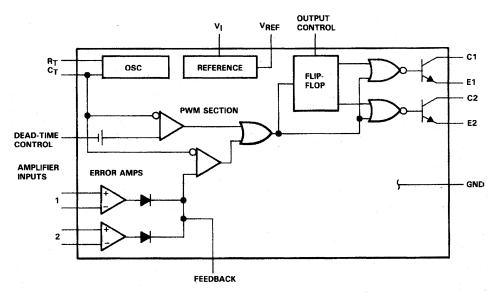


Figure 1. TL494 Block Diagram

The Basic Device

The design of the TL494 not only incorporates the primary building blocks required for the control of a switching power supply but also addresses many basic problems and reduces the amount of additional circuitry required in a total design. Figure 1 shows a block diagram of the TL494.

Principle of Operation

The TL494 is a fixed-frequency pulse-width-modulation (PWM) control circuit. Modulation of output pulses is accomplished by comparison of the sawtooth waveform, created by the internal oscillator on the timing capacitor (C_T), to either of two control signals. The output stage is enabled during that portion of time when the sawtooth voltage is greater than the control signals. As the control signals increase, the period of time the sawtooth input is greater decreases; therefore the output pulse duration decreases. A pulse-steering flip-flop alternately directs the modulated pulse to each of the two output transistors. Figure 2 illustrates the relationship between the pulses and signals.

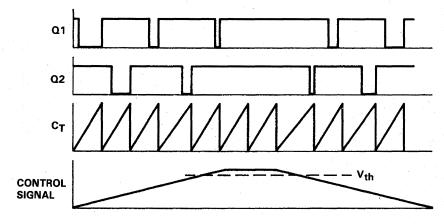


Figure 2. TL494 Modulation Technique

The control signals are derived from two sources: the dead-time (off-time) control circuit and the error amplifier circuit. The dead-time-control input is compared directly by the dead-time-control comparator. This comparator has a fixed 100-mV offset. With the control input biased to ground, the output is inhibited during the portion of time the sawtooth waveform is below 110 mV. This provides a preset dead time of approximately 3%, which is the minimum dead time that can be programmed. The PWM comparator compares the control signal created by the error amplifiers. One function of the error

amplifier is to monitor the output voltage and provide sufficient gain so that millivolts of error at its input will result in a control signal of sufficient amplitude to provide 100% modulation control. The error amplifiers can also be used to monitor the output current and provide current limiting to the load.

5-V Reference Regulator

The TL494 internal 5-V reference regulator is shown in Figure 3. In addition to providing a stable reference, it acts as a preregulator and establishes a stable supply from which the output-control logic, pulse-steering flip-flop, oscillator, dead-time-control comparator, and PWM comparator are powered. The regulator employs a band-gap circuit as its primary reference to maintain a thermal stability of less than 100-mV variation over the operating free-air temperature range of 0 °C to 70 °C. Short-circuit protection is provided to protect the internal circuit from excessive load or short-circuit conditions. Designed primarily as an internal reference and preregulator, 10 mA of load current is available for additional bias circuits. The reference is internally programmed to an initial accuracy of $\pm 5\%$ and maintains a stability of less than 25-mV variation over an input voltage range of 7 V to 40 V. For input voltages less than 7 V, the regulator saturates within 1 V of the input voltage and tracks it, as shown in Figure 4.

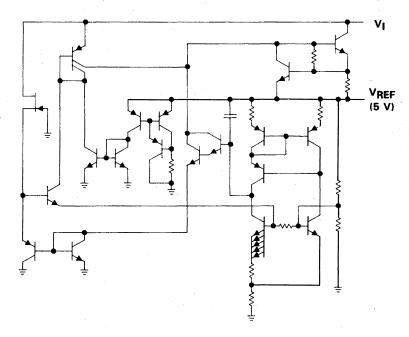


Figure 3. 5-V Reference Regulator

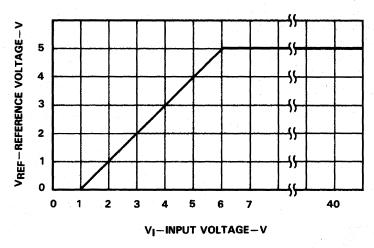


Figure 4. Reference Voltage vs Input Voltage

Oscillator

A schematic of the TL494 internal oscillator is presented in Figure 5. The oscillator provides a positive sawtooth waveform to the dead-time and PWM comparators for comparison to the various control signals.

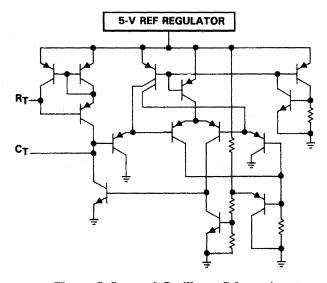


Figure 5. Internal Oscillator Schematic

Operation Frequency

The frequency of the oscillator is programmed by selection of the timing components R_T and C_T. The oscillator charges the external timing capacitor, C_T, with a constant current — the value of which is determined by the external timing resistor, R_T. This produces a linear-ramp voltage waveform. When the voltage across C_T reaches 3 V, it is discharged by the oscillator circuit and the charging cycle is reinitiated. The charging current is determined by the formula:

$$I_{CHARGE} = \frac{3 \text{ V}}{R_{T}}$$

The period of the sawtooth is:

$$t = \frac{3 \text{ V} \cdot \text{C}_T}{\text{I}_{\text{CHARGE}}} \qquad \qquad t = \text{R}_T \cdot \text{C}_T$$

The frequency of the oscillator then becomes:

$$f_{OSC} = \frac{1}{R_T \cdot C_T}$$

The oscillator frequency, however, is only equal to the output frequency for single-ended applications; for push-pull applications, the output frequency is one-half the oscillator frequency:

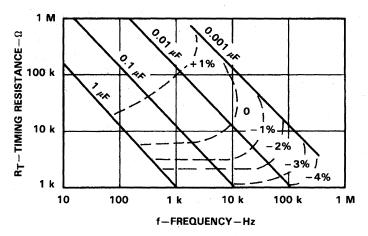
Single-ended applications:
$$f = \frac{1}{R_T \cdot C_T}$$

Push-pull applications:
$$f = \frac{1}{2RT \cdot CT}$$

The oscillator is programmable over a range from 1 kHz to 300 kHz. Practical values for RT and CT range from 1 k Ω to 500 k Ω and 470 pF to 10 μ F, respectively. A plot of the oscillator frequency versus RT and CT is shown in Figure 6. The stability of the oscillator, for free-air temperature variations from 0 °C to 70 °C for various ranges of RT and CT, is also indicated in Figure 6.

Operation Above 150 kHz

At an operation frequency of 150 kHz, the period of the oscillator is 6.67 μ s. The dead time established by the internal offset of the dead-time comparator ($\approx 3\%$ period) yields a blanking pulse of 200 ns. This is the minimum blanking pulse acceptable to assure proper toggling of the pulse-steering flip-flop. For frequencies above 150 kHz, additional



NOTE: The percent of oscillator frequency variation over the 0 °C to 70 °C free-air temperature range is represented by dashed lines.

Figure 6. Oscillator Frequency vs RT/CT

dead time (above 3%) is provided internally to assure proper triggering and blanking of the internal pulse-steering flip-flop. Figure 7 shows the relationship of internal dead time (expressed in percent) provided for various values of R_T and C_T.

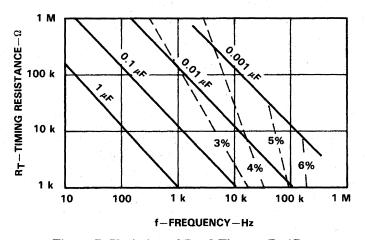


Figure 7. Variation of Dead Time vs RT/CT

Dead-Time-Control/PWM Comparator

The functions of the dead-time-control comparator and the PWM comparator are incorporated in a single comparator circuit, as shown in Figure 8. Since the two functions are totally independent, each function is discussed separately.

Comparator

The comparator is biased from the 5-V reference regulator. This provides isolation from the input supply for improved stability. The input of the comparator does not exhibit any hysteresis, so caution should be observed to protect against false triggering near the threshold. The comparator exhibits a response time of 400 ns from either of the control signal inputs to the output transistors, with only 100-mV overdrive. This assures positive control of the output, within a half cycle, for operation within the recommended 300-kHz range.

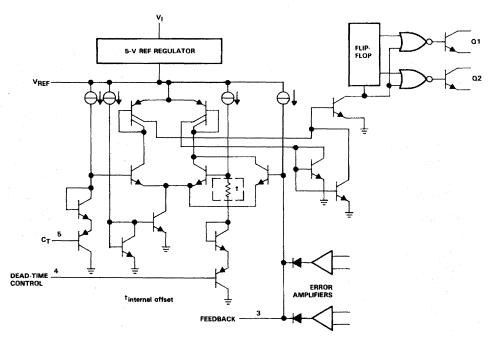


Figure 8. PWM/Dead-Time-Control Comparator

Dead-Time Control

The dead-time-control input provides control of the minimum dead time (off time). The output of the comparator inhibits switching transistors Q1 and Q2 whenever the voltage at its input is greater than the ramp voltage of the oscillator (see Figure 28). An internal offset of 110 mV assures a minimum dead time of $\approx 3\%$ with the dead-time-control input grounded. Additional dead time can be imposed by applying a voltage to the dead-time-control input. This provides a linear control of the dead time from its minimum of 3% to 100% as the input voltage is varied from 0 V to 3.3 V, respectively. With full range control, it allows control of the output from external sources without disrupting the error amplifiers. The dead-time-control input is a relatively high-impedance input (II = $<10~\mu$ A) and should be used where additional control of the output duty cycle is required. The input, however, must be terminated for proper control. An open circuit is an undefined condition.

Pulse-Width Modulation

The comparator also provides modulation control of the output pulse width. For this, the ramp voltage across timing capacitor C_T is compared to the control signal present at the output of the error amplifiers. The timing capacitor input incorporates a series diode which is omitted from the control signal input. This requires the control signal (error amplifier output) to be ≈ 0.7 V greater than the voltage across C_T to inhibit the output logic, and assures maximum duty cycle operation without requiring the control voltage to sink to a true ground potential. The output pulse width varies from 97% of the period to 0 as the voltage present at the error amplifier output varies from 0.5 V to 3.5 V, respectively.

Error Amplifiers

A schematic of the error amplifier circuit is shown in Figure 9. Both high-gain error amplifiers receive their bias from the V_I supply rail. This permits a common-mode input voltage range from -0.3 V to 2 V less than V_I . Both amplifiers behave characteristically of a single-ended single-supply amplifier in that each output is active high only. This allows each amplifier to pull up independently for a decreasing output pulse-width demand. With both outputs ORed together at the inverting input node of the PWM comparator, the amplifier demanding the minimum pulse out dominates. The amplifier outputs are biased low by a current sink to provide maximum pulse width out when both amplifiers are biased off.

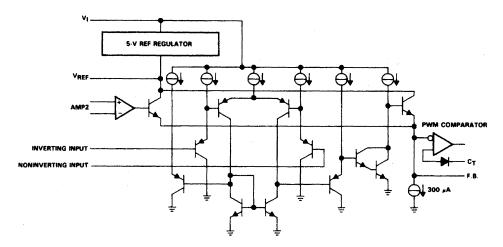


Figure 9. Error Amplifiers

Figure 10 shows the output structure of the amplifiers operating into the 300- μ A current sink. Attention must be given to this node for biasing considerations in gain control and external control interface circuits. Since the amplifier output is biased low only through a current sink (ISINK = 0.3 mA), bias current required by external circuitry into the feedback terminal must not exceed the capability of the current sink, otherwise, the maximum output pulse width will be limited. Figure 11 illustrates the proper biasing techniques for feedback gain control.

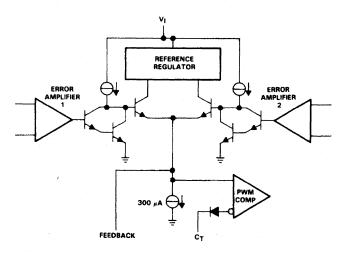
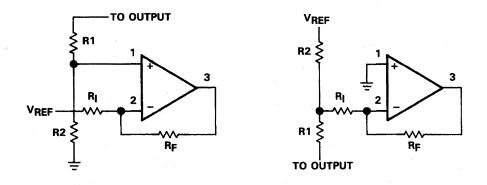


Figure 10. Multiplex Structure of Amplifiers



POSITIVE OUTPUT

NEGATIVE OUTPUT

Figure 11. Error Amplifier Bias Configurations for Controlled Gain Applications

A plot of amplifier transfer characteristics is shown in Figure 12. This illustrates the linear gain characteristics of the amplifiers over the active input range of the PWM comparator (0.5 V to 3.5 V). This is important for overall circuit stability. The open-loop gain of the amplifiers, for output voltages from 0.5 V to 3.5 V, is 60 dB. A Bode plot of the amplifiers' gain characteristics is shown in Figure 13. Both amplifiers exhibit a response time of approximately 400 ns from their inputs to their outputs. Precautions should be taken to minimize capacitive loading of the amplifiers' outputs. Since they employ active pull-up only, the amplifiers' ability to respond to an increasing load demand can be severely degraded by capacitive loads.

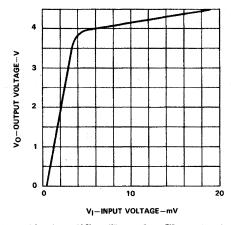


Figure 12. Amplifier Transfer Characteristics

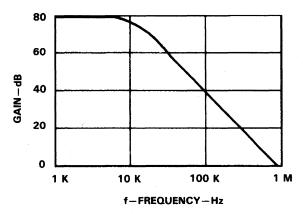


Figure 13. Amplifier Bode Plot

Output-Control Logic

The output-control logic is structured to provide added versatility through external control. Designed for either push-pull or single-ended applications, circuit performance can be optimized by selection of the proper conditions applied to the various control inputs.

Output-Control Input

The output-control input determines whether the output transistors operate in parallel or push-pull fashion. This input is the supply source for the pulse-steering flip-flop, as shown in Figure 14. The output-control input is asynchronous and has direct control over the output, independent of the oscillator or pulse-steering flip-flop. The input condition is intended to be a fixed condition that is defined by the application. For parallel operation, the output-control input must be grounded. This disables the pulse-steering flip-flop and inhibits its outputs. In this mode, the pulses seen at the output of the dead-time-control/PWM comparator are transmitted by both output transistors in parallel. For push-pull operation, the output-control input must be connected to the internal 5-V reference regulator. Under this condition, each of the output transistors is enabled, alternately, by the pulse-steering flip-flop.

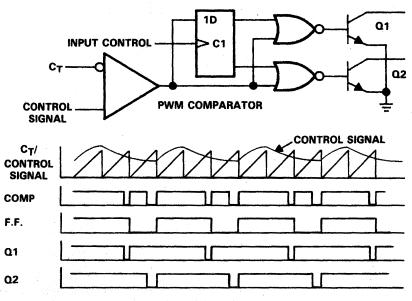


Figure 14. Output-Steering Architecture

Pulse-Steering Flip-Flop

The pulse-steering flip-flop is a positive-edge-triggered D-type flip-flop that changes state synchronously with the rising edge of the comparator output (see Figure 14). The dead time provides blanking during this period to ensure against the possibility of having both outputs on, simultaneously, during the transition of the pulse-steering flip-flop outputs. A schematic of the pulse-steering flip-flop is shown in Figure 15. Since the flip-flop receives its trigger from the output of the comparator, not the oscillator, the output always operates in a push-pull manner. The flip-flop will not change state unless an output pulse occurred in the previous period of the oscillator. This architecture prevents either output from double pulsing, but restricts the application of the control signal sources to dc feedback signals (for additional detail read 'Pulse-Current Limiting' in this application report).

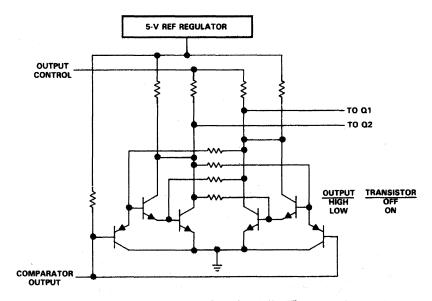


Figure 15. Pulse-Steering Flip-Flop

Output Transistors

There are two output transistors available on the TL494. The output structure is illustrated in Figure 16. Both transistors are configured open collector/open emitter and each is capable of sinking or sourcing up to 200 mA of current. The transistors exhibit a saturation voltage of less than 1.3 V in the common-emitter configuration and less than 2.5 V in the emitter-follower configuration. The outputs are protected against excessive power dissipation to prevent damage but do not employ sufficient current limiting to allow them to be operated as current-source outputs.

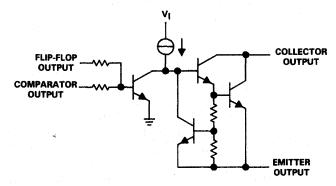


Figure 16. Output Transistor Structure

Applications

Reference Regulator

The internal 5-V reference regulator is designed primarily to provide the internal circuitry with a stable supply rail for varying input voltages. The regulator provides sufficient drive to sustain up to 10 mA of supply current to additional load circuitry. Excessive loading, however, may degrade the performance of the TL494 since the 5-V reference regulator establishes the supply voltage of much of the internal control circuitry.

Current Boosting the 5-V Regulator

Conventional bootstrap techniques for three-terminal regulators, such as the one shown in Figure 17, are not recommended for use on the TL494. Referring to Figure 17: Normally, the bootstrap is programmed by resistor RB so that transistor Q1 turns on as the load current approaches the capability of the regulator. This works quite well where the current in the input (through RB) is determined by the load current. This is not necessarily the case with the TL494. The input current not only reflects the load current but includes the current drawn by the internal control circuit, which is biased from the reference regulator as well as the input rail itself. As a result, the bias of shunt transistor Q1 is not controlled by the load current drawn by the reference regulator.

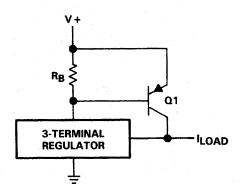


Figure 17. Conventional 3-Terminal Regulator Current-Boost Technique

Figure 18 shows the bootstrapping technique that is preferred for the TL494. This technique provides isolation between any bias-circuit load and the reference regulator output and provides a sufficient amount of supply current without affecting the stability of the internal reference regulator. This technique should be applied for bias circuit drive only since the regulation of the high-current output is solely dependent on the load.

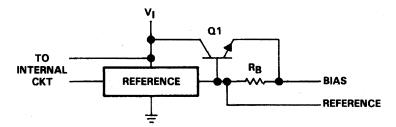


Figure 18. TL494 Reference Regulator Current-Boost Technique

Applications of the Oscillator

The design of the internal oscillator allows a great deal of flexibility in the operation of the TL494 control circuit.

Synchronizing

Synchronizing two or more oscillators in a common system is easily accomplished with the architecture of the TL494 control circuits. Since the internal oscillator is used for no other purpose than creation of the sawtooth waveform on the timing capacitor, the oscillator can be inhibited as long as a compatible sawtooth is provided externally to the timing capacitor terminal. The internal oscillator can be inhibited by terminating the RT terminal to the reference supply output.

Master/Slave Synchronization

For synchronizing two or more TL494s, establish one device as the master and program its oscillator normally. Disable the oscillators of each slave circuit as explained above and use the sawtooth created by the master for each of the slave circuits, tying all C_T pins together as shown in Figure 19.

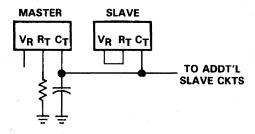


Figure 19. Master/Slave Synchronization

Master Clock Operation

To synchronize the TL494 to an external clock, the internal oscillator can be used as a sawtooth-pulse generator. Program the internal oscillator for a period that is 85% to 95% of the master clock and strobe the internal oscillator through the timing resistor, as shown in Figure 20. Q1 is turned on by a positive pulse applied to its base. This initiates the internal oscillator by grounding R_T and pulls the base of Q2 low. Q1 is latched on through the collector of Q2 and, as a result, the internal oscillator is locked on. As C_T charges, a positive voltage is developed across C1. Q1 forms a clamp on the trigger side of C1. At the completion of the period of the internal oscillator, the timing capacitor is discharged to ground and C1 drives the base of Q1 negative, causing Q1 and Q2 to turn off in turn. With the latch of Q1/Q2 turned off, R_T is open circuited and the internal oscillator is disabled until another trigger pulse is experienced.

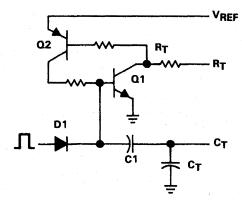


Figure 20. External Clock Synchronization

A common problem when synchronizing the power supply to a system clock occurs during start up. Normally, an additional start-up oscillator is required. Here again, the internal oscillator can be used by modifying the previous circuit slightly, as shown in Figure 21. During power up, when the output voltage is low, Q3 is biased on causing Q1 to stay on and the internal oscillator to behave normally. Once the output voltage has increased sufficiently ($V_O > V_{REF}$ for Figure 21), Q3 is no longer biased on and the Q1/Q2 latch becomes dependent of the trigger signal, as previously discussed.

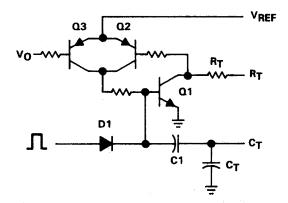


Figure 21. Oscillator Start-Up Circuit

Fail-Safe Operation

With the modulation scheme employed by the TL494 and the structure of the oscillator, the TL494 will inherently turn off if either timing component fails. If timing resistor R_T opens, no current is provided by the oscillator to charge C_T. The addition of a bleeder resistor, as shown in Figure 22, assures the discharge of C_T. With the C_T input at ground, or if C_T short circuits, both outputs are inhibited.

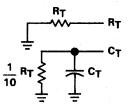
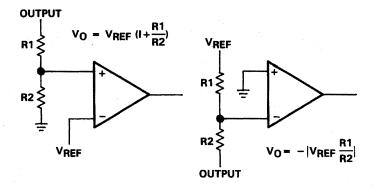


Figure 22. Fail-Safe Protection

Error-Amplifier-Bias Configuration

The design of the TL494 is aligned to employ both amplifiers in a noninverting configuration. Figure 23 illustrates the proper bias circuits for negative and positive output voltages. The gain control circuits, shown previously in Figure 11, can be integrated into the bias circuits.



POSITIVE OUTPUT CONFIGURATION

NEGATIVE OUTPUT CONFIGURATION

Figure 23. Error Amplifier Bias Configurations

Current Limiting

Either amplifier provided on the TL494 can be used for current limiting. Application of either amplifier is limited primarily to load current control. The architecture of the TL494 defines that these amplifiers be used for dc control applications. Both amplifiers have a broad common-mode voltage range which allows direct current sensing at the output voltage rails. Several techniques can be employed for current limiting.

Fold-Back Current Limiting

Figure 24 illustrates the proper bias technique for fold-back current limiting. Initial current limiting occurs when sufficient voltage is developed across R_{CL} to compensate for the base-emitter voltage of Q1 plus the voltage across R1. When current limiting occurs, the output voltage will drop. As the output decays, the voltage across R1 decreases proportionally. This results in less voltage required across R_{CL} to maintain current limiting. The resulting output characteristics are illustrated in Figure 25.

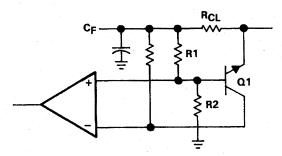


Figure 24. Fold-Back Current Limiting

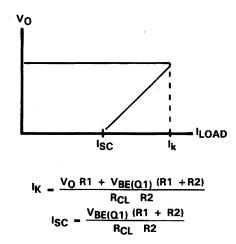
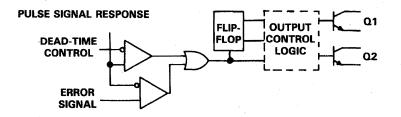


Figure 25. Fold-Back Current Characteristics

Pulse-Current Limiting

The internal architecture of the TL494 is not aligned to accommodate direct pulse-current limiting. The problem arises from two factors: 1. The internal amplifiers do not function as a latch, they are intended for analog applications. 2. The pulse-steering flip-flop sees any positive transition of the PWM comparator as a trigger and toggles its outputs prematurely, i.e., prior to the completion of the oscillator period. As a result, a pulsed control voltage occurring during a normal on time not only causes the output transistors to turn off but also toggles the pulse-steering flip-flop. With the outputs off, the excessive current condition decays and the control voltage returns to the quiescent-error-signal level. When the pulse ends, the outputs are again enabled and the residual on-time pulse appears on the opposite output. The resulting waveforms are shown in Figure 26. The major problem here is the lack of dead-time control. A sufficiently narrow pulse may result in both outputs being on concurrently, depending on the delays of the external circuitry. A condition where insufficient dead time exists is a destructive condition. Pulse-current limiting, therefore, is best implemented externally, as shown Figure 27.

The current in the switching transistors is sensed by RCL. When sufficient current is experienced, the sensing transistor Q1 is forward biased, the base of Q2 is pulled low through Q1, and the dead-time control input is pulled to the 5-V reference. Drive for the base of Q3 is provided through the collector of Q2. Q3 acts as a latch to maintain Q2 in a saturated state when Q1 turns off, as the current decays through RCL. The latch will remain in this state, inhibiting the output transistors, until the oscillator completes its period and discharges CT to 0 V. When this occurs, the Schottky diode, D1, will forward bias and turn off Q3 and Q2, allowing the dead-time control to return to its programmed voltage.



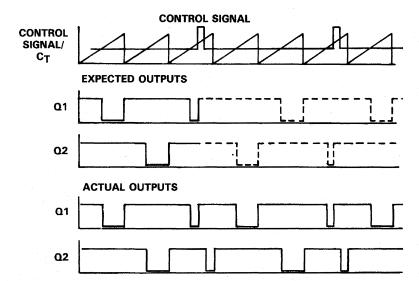


Figure 26. Error Signal Considerations

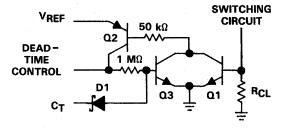


Figure 27. Peak-Current Protection

Applications of the Dead-Time Control

The primary function of the dead-time control is to control the minimum off-time exhibited by the output of the TL494. The dead-time-control input provides control from 5% to 100% dead time, as illustrated in Figure 28.

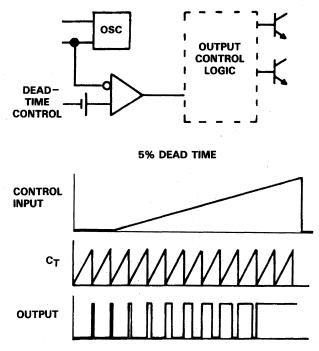


Figure 28. Dead-Time Control Characteristics

The TL494 can therefore be tailored to the specific power transistor switches that are used to assure that the output transistors never experience a common on-time. The bias circuit for the basic function is shown in Figure 29. The dead-time control can be used for many additional control signals.

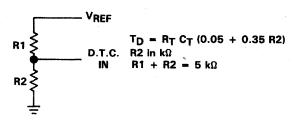


Figure 29. Tailored Dead Time

Soft Start

With the availability of the dead-time control, input implementation of a soft-start circuit is relatively simple; Figure 30 shows one example. Initially, capacitor C_S forces the dead-time-control input to follow the 5-V reference regulator which disables both outputs, i.e., 100% dead time. As the capacitor charges through R_S, the output pulse slowly increases until the control loop takes command. If additional control is to be introduced at this input, a blocking diode should be used to isolate the soft-start circuit. If soft start is desired in conjunction with a tailored dead time, the circuit in Figure 29 can be used with the addition of capacitor C_T across resistor R1.

The use of soft-start protection is recommended. Not only does such circuitry prevent large current surges during power-up, it also protects against any false signals which might be created by the control circuit as power is applied.

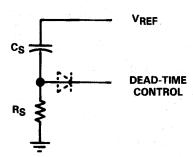


Figure 30. Soft-Start Circuit

Overvoltage Protection

The dead-time control also provides a convenient input for overvoltage protection which may be sensed as an output voltage condition or input protection. Figure 31 employs a TL430 as the sensing element. When the supply rail being monitored increases to the

point that 2.7 V is developed at the driver node of R1 and R2, the TL430 goes into conduction. This forward biases Q1, causing the dead-time control to be pulled up to the reference voltage, disabling the output transistors.

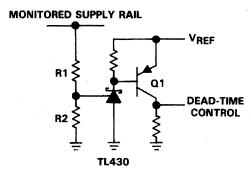


Figure 31. Overvoltage Protection Circuit

Modulation of Turn-Off Transition

Modulation of the output pulse by the TL494 is accomplished by modulating the turn-on transition of the output transistors. The turn-off transition is always concurrent with the falling edge of the oscillator waveform. Figure 32 shows the oscillator output as it is compared to a varying control signal and the resulting output waveforms. If modulation of the turn-off transition is desired, an external negative slope sawtooth, as shown in Figure 33, can be used without degrading the overall performance of the TL494.

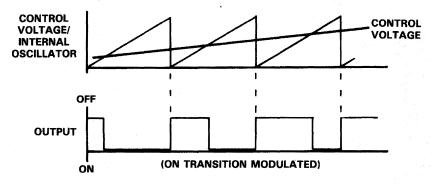


Figure 32. Turn-On Transition

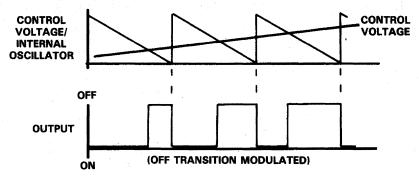


Figure 33. Turn-Off Transition

Designing Switching Voltage Regulators with TL497A

John Spencer

Linear IC Applications Engineer LINEAR PRODUCTS DEPARTMENT

INTRODUCTION

The TL497 represents a revolution in the implementation of a monolithic, highly efficient switching regulator.

Conventional series regulators employ an active element, usually a transistor operating in a linear mode, which functions as a variable resistor. The product of this resistance and the load current create a changing differential voltage required to step down from an unregulated input voltage to a fixed output voltage. In this type of circuit, current requirements defined by the load, must be experienced by the pass element. As the input to output voltage differential or load current requirement increases the power dissipated in the pass element increases proportionally. This power represents a loss to the system and limits the efficiency of series regulators.

The switching regulator, on the other hand, does not operate in the linear mode and is capable of achieving high efficiency power conversion even at large input/output voltage differentials. In the past the complexity of the circuitry required to construct a switching regulator negated the advantage of efficiency gained over series pass regulators. Use of the TL497A, however, eliminates the complex circuit designs previously required and offers marked performance improvements in efficiency over systems using series pass regulators.

PRINCIPLE OF OPERATION

The principle of operation and the method by which voltage conversion at high efficiencies can be achieved using switching regulators can best be demonstrated by analyzing the basic configuration of a step-down switching voltage regulator (Figure 1).

Q1 is the switch transistor which is turned on and off by the regulator's control circuitry at a frequency and duty cycle required to maintain the desired output. Because this transistor is always in the saturated state when it is conducting, or otherwise completely nonconducting, the power dissipated in the switch is much lower than that dissipated in a series regulator whose pass transistor is continuously operated in the linear region. This is the primary contributor to the increased efficiency experienced

Eugene J. Tobaben

Linear IC Applications Engineer
LINEAR PRODUCTS DEPARTMENT

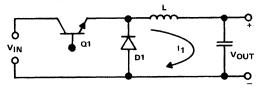


FIGURE 1. Step-Down Switching Voltage Regulator

with a switching voltage regulator. The transfer of energy from the input to the output is achieved through the inductor L. During the time Q1 is on (t_{OR}) the input voltage is applied to the LC filter and the current in the inductor increases. When Q1 is turned off the energy developed in the inductor during the previous half cycle, maintains the current flow to the load through the catch diode D1 and delivers that energy to the load.

The output voltage is determined by the input voltage (V_{IN}) and the duty cycle of the switch Q1.

$$V_{OUT} = V_{IN} \frac{t_{ON}}{T}$$

where $T = t_{ON} + t_{OFF}$

Therefore, by controlling the duty cycle (t_{ON}/T) , changes in the input voltage can be compensated for If V_{IN} increases, the control circuit will cause a corresponding reduction in the duty cycle and thereby maintain a constant V_{OUT} , without increasing the amount of power dissipated internally in the regulator.

THE TL497A

General

The TL497A incorporates on a single monolithic chip all the active functions required in the construction of a Switching Voltage Regulator: a precision 1.22-volt reference, a pulse generator, a high-gain comparator, current limit sense and shut-down circuitry, a catch diode, and a series pass transistor. The TL497A was designed to offer versatility and to optimize the ease of its use in the various step-up, step-down, and voltage inversion applications requiring high efficiency.

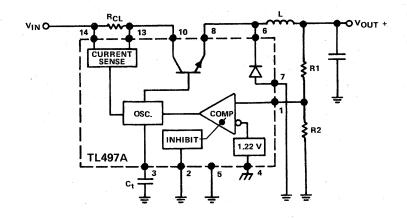


FIGURE 2. TL497A Block Diagram

Programming

A block diagram of the TL497A is shown in Figure 2. The internal 1.22-volt precision band-gap reference is internally connected between the substrate terminal and the inverting input of the high-gain comparator. The output of the circuit is sensed through a resistor ladder network (R1-R2) by the noninverting input of the comparator and is programmed by the resistors R1 and R2 such that the feedback voltage equals the 1.22 volt reference. Thus;

$$V_{OUT} \frac{R2}{R1 + R2} = 1.22 \text{ volts}$$

To keep it simple the voltage across R2 is 1.22 volts. For 1mA programming current R2 becomes 1.22 $K\Omega$. Therefore:

$$R2 = 1.22 \text{ K}\Omega$$

AND CALCULATE R1 = $(V_{OUT} - 1.22) \text{ K}\Omega$

Oscillator

The oscillator is composed of a current pulse generator which charges and discharges the external timing capacitor (Ct) at fixed current rates whenever the feedback voltage is less than 1.22 v. The charging rate is 1/6 that of the discharge rate which results in the voltage waveform shown in Figure 3. The total period of the charge/discharge cycle is determined by the external timing capacitor (Ct) and is constant for all input voltages within the TL497A recommended operating ranges.

The charge/discharge period (T) varies with C_t as shown in Table I.

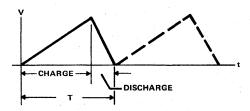


FIGURE 3. Ct Voltage Waveform

The dotted line of Figure 3 shows the timing capacitor waveform under continuous operation conditions. Only under these conditions does T determine the oscillators frequency ($F_{max} = 1/T$). These conditions exist during initial power-up of the system or whenever the comparator indicates the output voltage is less than the desired voltage-out. After the timing capacitor is discharged, the oscillator control circuit will sample the output of the comparator to determine if the output voltage is at a satisfactory level. If the comparator indicates the output is deficient, the current generator will retrigger and the oscillator will go through another Ct charge/discharge cycle; after which it will sample the comparator again and so forth. If on the other hand, the comparator indicates the output voltage is satisfactory, the current generator will be on standby until it is triggered by the comparator as illustrated in Figure 4. The pass transistor is turned "ON" during the charging portion (tc) and turned "OFF" during the discharge portion (tp) and any subsequent standby

Table I. Charge/Discharge Period Vs. Ct

C _t (pF)	200	250	350	400	500	750	1000	1500	2000
Τ (μs)	23	27	32	39	50	70	95	140	230

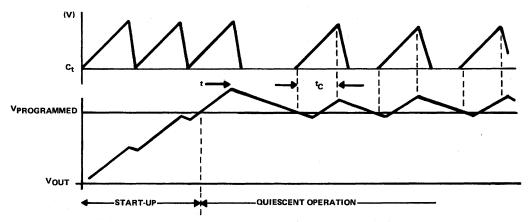


FIGURE 4. Typical C_t Voltage Waveform During Start-Up and Quiescent Operation

Table II. On-Time Vs. Ct

C _t (pF)	200	250	350	400	500	750	1000	1500	2000
to (us)	19	22	26	32	11	56	80	120	190

period after the charge/discharge cycle of C_t . Under these conditions the operating frequency becomes dependent on the load requirement and C_T only determines the ON time (t_{ON}) which remains constant. Thus the duty cycle is modulated by the changing frequency. The on-time of the switching transistor coincides with t_C as shown in Table II.

Current Limiting

Current limiting is accomplished with the current-limit control provided. The voltage developed across the user selected series current limit resistor (RCL) is sensed. When this voltage becomes greater than one VBE drop (0.5 V typically) the current limit circuitry provides an additional current path to charge the timing capacitor. This, in effect, shortens the on-time of the switching transistor and reduces the amount of energy developed in the inductor. This can be observed as an increase in the slope of the charging portion of the charge/discharge cycle of the timing capacitor (Figure 5). With current limiting, saturation of the power inductor may be prevented and soft start-up achieved. If not used, the current limit sense should be tied to VCC+(pin-14).

Pass Transistor

The switching transistor provided in the TL497A is a high-gain device designed to switch up to 500 mA peak using the base drive circuitry provided by the TL497A. Access to the internal base current limiting resistor is made available, however, it is not recommended the base drive circuitry be tampered with. The emitter and collector are brought out also, for user versatility.

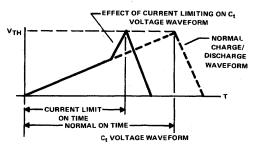


FIGURE 5. Ct Voltage Waveform

Catch Diode

An uncommitted catch diode capable of operating at peak currents to 500 mA is available for commutation and blocking purposes, however, an external diode may be desired for optimum circuit performance.

Enable Circuitry

Shutdown circuitry is provided for external control which allows the user to enable and disable the TL497A by an external TTL logic command. A logic high disables the TL497A and turns off the switching transistor. A logic low enables the TL497A and allows it to operate according to the previous discussion.

DESIGN AND OPERATION of a STEP-DOWN SWITCHING VOLTAGE REGULATOR

The circuit in Figure 6 shows the basic configuration for a step-down switching voltage regulator. A thorough understanding of this circuit is necessary to optimize the design of a step-down switching voltage regulator using the TL497A.

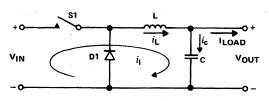


FIGURE 6. Basic Step-Down Regulator

First, define the initial conditions (prior to the closing of S1).

Initial Conditions (t = 0-):

$$V_C = V_{OUT}$$

$$i_{\rm I} = 0$$

When the switch S1 is closed, the current in the inductor and the voltage across the filter capacitor (C) cannot change instantaneously.

at S1 closed (t = 0+):

$$V_C = V_{OUT}$$

$$i\tau = i\tau = 0$$

Writing a loop equation around the circuit

$$V_{in} = R_S i_1 + L \frac{di_1}{dt} + V_c$$

Substituting $i_1 = 0$ and $V_c = V_{out}$ at t = 0+

$$V_{in} = L \frac{di_1}{dt} + V_{out}$$

Therefore
$$\frac{di_1}{dt} = \frac{V_{in} - V_{out}}{L}$$

The current through the inductor (iL) at any given time (t) is

$$I = \frac{V_{in} - V_{out}}{L} t$$

For a constant VIN, VOUT, and L, I varies linearly with t.

The current increases while S1 is closed according to the waveform shown in Figure 7. The peak current in the inductor, therefore, is dependent on the period of time S1 is closed, which is the on-time of the switch (ton).

$$\therefore I_{pk} = \frac{V_{in} - V_{out}}{I} t_{ON}$$

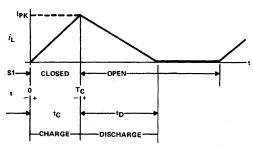


FIGURE 7. Inductor Current Waveform

When S1 opens ($t=t_{C+}$), the current through the inductor is I_{pk} since the current cannot change instantaneously, the voltage across the inductor inverts, and the blocking diode (D1) is forward biased to provide a current path for the discharge of the inductor into the load and filter capacitor. The inductor current then discharges linearly as illustrated in Figure 7.

Prior to S1 open $(t = TC_{-})$

$$i_L = I_{pk}$$

$$V_C = V_{OUT}$$

At S1 open $(t = T_{C+})$

$$i_{L} = I_{pk}$$

$$V_C = V_{OUT}$$

Writing a loop equation for i_1

$$V_f + L \frac{di_1}{dt} + V_C = 0$$

Substituting the conditions at $t = T_{C+}$ and assuming V_f of D1 is 0 V:

$$L \frac{d i_1}{dt} = -V_{OUT}$$

: the current through the inductor for t > TC

$$i_{L} = I_{pk} - \frac{V_{OUT}}{I_{c}} (t - T_{C})$$

The discharge time of the inductor then is that time required for $i_L = 0$. Therefore

$$t_D = \frac{I_{pk}}{V_{OUT}} L$$

Analyzing for a moment the currents at the inductor/capacitor/output node.

$$i_{L} = i_{C} + I_{load}$$

if Iload is considered constant.

$$\Delta i_{\rm C} = \Delta i_{\rm L} = I_{\rm pk}$$

when

$$i_{\text{L}} = I_{\text{load}}$$
; $i_{\text{C}} = 0$

when

$$i_{\rm L} = 0$$
; $i_{\rm C} = -I_{\rm load}$

Thus the inductor and capacitor current waveforms relate to each other as shown in Figure 8.

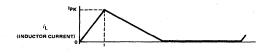




FIGURE 8. Inductor Current and Capacitor Current Waveforms

For the output voltage to remain constant, the net charge delivered to the filter capacitor must be zero. This means that the charge delivered to the capacitor from the inductor must be dissipated in the load. Since the charge developed in the inductor is fixed (constant on time), the time required for the load to dissipate that charge will vary with the load requirements. The actual operating frequency is therefore dependent on the load requirements. The actual frequency can be determined by studying the current waveform of the filter capacitor. The charge delivered to the capacitor and the charge dissipated by the load are equal to the areas under the capacitor current waveform above and below $i_{\rm C}=0$ respectively, as shown in Figures 9 and 10.

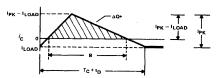


FIGURE 9. Capacitor Current Waveform $(\Delta Q+)$

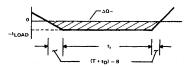


FIGURE 10. Capacitor Current Waveform (ΔQ -)

$$B = \frac{I_{pk} - I_{load}}{I_{pk}} (T_C + t_D)$$

$$\Delta Q + = \frac{1}{2} \frac{(I_{pk} - I_{load})^2}{I_{pk}} (T_C + t_D)$$

$$\Delta Q = [I_{load} t_i] + \frac{1}{2} \left[(T_C + t_D) \right]$$

$$-\frac{I_{pk}-I_{load}}{I_{pk}} (T_C + t_D) \right] I_{load}$$

Setting ΔQ + equal to ΔQ - and solving for t_i

$$t_i = \frac{(I_{pk} - 2I_{load})(T_C + t_D)}{2I_{load}}$$

To determine the frequency of oscillation, total the durations of the previous portions of the regulator's cycle,

$$T = T_C + t_D + t_i$$

$$\therefore T = (T_C + t_D) \frac{1}{2} \frac{I_{pk}}{I_{load}}$$

Knowing the period

frequency =
$$\frac{1}{T}$$

The ΔQ calculations also yield the voltage change experienced by the output capacitor C.

$$\begin{split} V_C = \frac{1}{C} \int i dt \text{ or } \frac{\Delta Q}{C} \\ \Delta V_C = \frac{1}{2C} \frac{(I_{pk} - I_{load})^2}{I_{pk}} \frac{T_C \ V_{IN}}{V_{OUT}} \end{split}$$

Note this accounts for the ripple voltage contributed by the ripple current present in the switching regulator seen by an ideal capacitor. Realistically the capacitor will have an equivalent series resistance (ESR) which establishes the minimum ripple voltage achievable.

$V_{RIPPLE (MIN)} = I_{pk} (ESR)$

When the filter capacitor size has been increased such that $\Delta V_C \simeq V_{RIPPLE}$ (MIN) additional increases in C will net insignificant reduction in V_{RIPPLE} . It is important therefore to employ a filter capacitor with minimal ESR. Note, however, due to its architecture some ripple voltage is required for proper operation of the regulation circuit.

SUMMARY

The previous derivations have assumed that the regulator is operating in the discontinuous mode. This means the inductor current is discontinuous ($I_{I} = 0$). When the load is continually increased, the idle time (t; in Figure 10) decreases to the point where the regulator initiates a charge cycle at or before the complete discharge of the inductor. This condition is called the continuous mode of operation (II never equals 0, $t_i = 0$). In this mode a dc idle current is passed through the inductor. The TL497A is not designed to operate in this mode without special considerations given to the circuit design. To determine the load current where the circuit transforms from the discontinuous mode to the continuous mode of operation, refer to Figure 8. The point of transition occurs, when the inductor starts charging as soon as it completes the previous discharge cycle (t_i = 0). Under these conditions the capacitor current waveform is as shown in Figure 11. Setting $t_i = 0$ and solving for IOUT;

$$I_{OUT} = \frac{I_{pk}}{2}$$

Hence

$$x = \frac{I_{pk}}{2}$$

Where I_X is the load current at which the inductor current is continuous and the regulator enters the continuous mode.

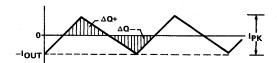


FIGURE 11. Capacitor Current Waveform (Continuous Mode)

Summarizing:

for the step-down switching regulator

Ipk ≥ 2 Iload (for discontinuous operation)

$$L = \frac{V_{IN} - V_{OUT}}{I_{pk}} t_{ON}$$

$$f_0 = \frac{2 I_{load}}{I_{pk}} \frac{V_{OUT}}{T_{ON} V_{IN}}$$

where:

$$t_D = \frac{I_{pk}}{V_{OUT}} L$$

$$t_i = \frac{[I_{pk} - 2I_{load}]}{2I_{load}} \cdot \frac{T_{ON} V_{IN}}{V_{OUT}}$$

$$C = \frac{(I_{pk} - I_{load})^2}{V_{RIPPLE} 2 I_{pk}} \cdot \frac{T_{ON} V_{IN}}{V_{OUT}}$$

A STEP-DOWN SWITCHING REGULATOR DESIGN EXERCISE

with TL497A

A schematic of the basic step-down regulator is shown in Figure 12.

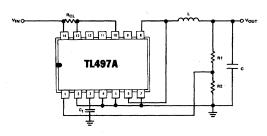


FIGURE 12. Basic Step-Down Regulator

Conditions:

$$V_{IN} = 15 \text{ V}$$

$$V_{OUT} = 5 V$$

$$v_{ripple} < 1.0\%$$

Calculations:

$$I_{pk} \ge 2 I_{load} = 400 \text{ mA}$$

This is the limit condition for discontinuous operation. For design margin, I_{pk} will be designed for 500 mA which is also the limit of the internal pass transistor and catch diode.

$$\therefore I_{pk} \to 500 \text{ mA}$$

$$L = \frac{V_{IN} - V_{OUT}}{I_{pk}} \text{ toN}$$

$$L = \frac{10 \text{ V}}{500 \text{ y } 10^{-3}} \text{ toN}$$

Recommended on-time is; 19 μ s < toN < 150 μ s, thus the range of acceptable inductance is, 380 μ H to 3 mH.

choosing L =
$$390 \mu H$$

$$t_{ON} = \frac{390 \times 10^{-6} \times 500 \times 10^{-3}}{10} = 19.5 \times 10^{-6} \text{ sec.}$$

To program TL497A for 5 VOUT:

$$R2 = 1.2 k\Omega$$
 (fixed)

$$R1 = (5 - 1.2) k\Omega = 3.8 k\Omega$$

To set current limiting:

$$RCL = 0.5/I_{limit}$$

$$R_{CL} = \frac{0.5}{500 \times 10^{-3}} = 1 \Omega$$

For the on-time chosen above, C_t can be approximated;

$$C_t$$
 (pf) $\simeq 12 t_{ON}$ (μs)

$$C_t \simeq 240 \; \text{pf}$$

or it can be selected from Table II, page 5.

To determine Cfilter for desired ripple voltage:

$$C = \frac{(I_{pk} - I_{load})^2}{V_{RIPPLE} 2 I_{pk}} \cdot \frac{T_{ON} V_{IN}}{V_{OUT}}$$

for constant C, VRIPPLE increases as Iload descreases.

$$C = 45 \mu F \text{ (for 200 mA/1\% ripple)}$$

The maximum operating frequency is encountered under maximum load conditions.

$$f_{max} = \frac{2 I_{load} (max)}{I_{pk}} \cdot \frac{V_{OUT}}{T_{ON} V_{IN}}$$

The minimum operating frequency occurs under minimum load conditions.

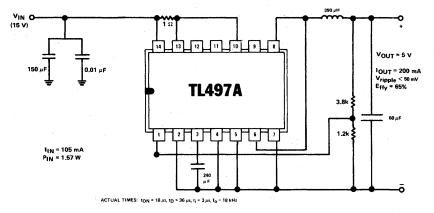
$$f_{min} = f_{max} \frac{I_{load (min)}}{I_{load (max)}}$$

Figure 13 illustrates the regulator with the above values applied to it.

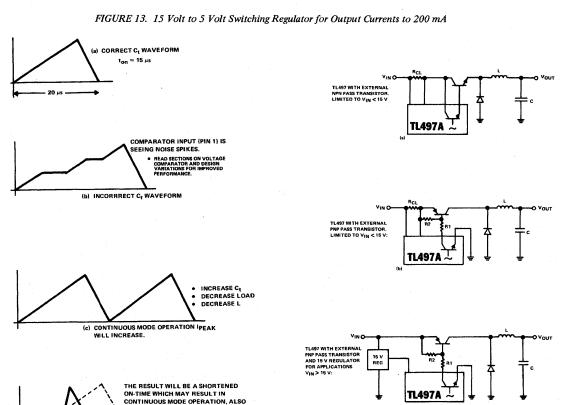
Waveforms at C_t for indication of proper circuit performance are shown in Figure 14.

For peak currents greater than 500 mA, it is necessary to use an external transistor and diode. Several techniques are shown in Figure 15.

Figure 16 shows the TL497A in high-voltage-high-current applications.

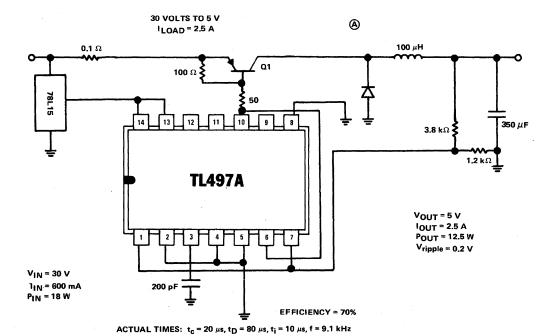


NOTE: 13 μs ON-TIME RESULTS IN 1_{pk} = 433 mA. RECALCULATING t_D,t_i AND f_0 WILL CONCUR WITH ACTUAL TIMES OBSERVED.



(d) CIRCUIT IS CURRENT LIMITING. FIGURE 15. Techniques for Obtaining Peak
FIGURE 14. Circuit Performance Waveforms Currents Greater Than 500 mA

DECREASE R_{CL} INCREASE L DECREASE C_t



(A) THE USE OF THE INTERNAL DIODE (PINS 6 AND 7) TO CLAMP THE FEEDBACK AND PROTECT AGAINST NOISE IS DISCUSSED IN A LATER CHAPTER [DESIGN VARIATIONS FOR IMPROVED PERFORMANCE].

FIGURE 16. TL497A in High-Voltage-High-Current Applications

The advent of logic or gate array devices brings about the need of a good regulated low voltage power supply. These arrays may have up to 800 inverters or gates per array. Normally the power requirements are 20 volts at about 200 mA, per array. The input requirement is usually 5.0 volts. This circuits meets the above requirements at an overall efficiency of 72%.

Figure 18 is another step-down regulator. With an input of from 7V to 12V it has an output of 5 volts at 2.0 amps. The TIP34 is a plastic TO-220 PNP transistor of 10 amp capacity. The IN5187D is a 3.0 amp fast recovery diode.

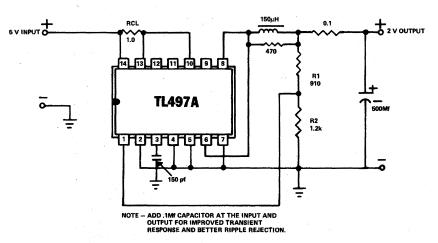


FIGURE 17. TL497A Logic Array Power Supply, Step-Down Circuit

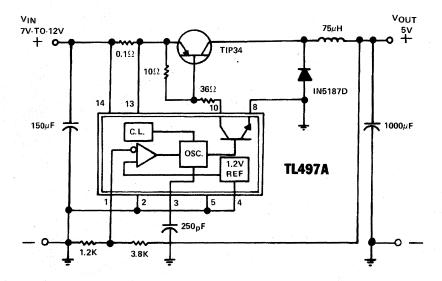


FIGURE 18. Step-Down Regulator

DESIGN AND OPERATION

of a

STEP-UP SWITCHING VOLTAGE REGULATOR

In the step-up regulator, the formulaes change slightly. Note the basic circuit configuration in Figure 19.

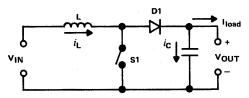


FIGURE 19. Basic Step-UP Regulator Circuit

During the charging cycle (S1 closed) the inductor (L) is charged directly by the input potential.

$$i_{\rm L} = \frac{V_{\rm IN}}{L} t_{\rm C}$$

thus

$$I_{pk} = \frac{V_{IN}}{I_{L}} t_{ON}$$

In the step-up application however, the peak current is not related to the load current as in the previous application. This is attributed to the fact that during the inductor charge cycle the blocking diode D1 is reverse biased and no charge is delivered to the load. The circuit in Figure 19 delivers power to the load only during the discharge cycle of the inductor (when S1 is open). The diode D1 is forward biased and the inductor discharges into the load capacitor. The potential across the inductor during this phase of the charge/discharge cycle is VOUT — VIN. The discharge time of the inductor then becomes:

$$t_D = \frac{I_{pk}}{V_{OUT} - V_{IN}} L$$

To determine the peak current relation to the load current, review the inductor and capacitor current waveforms shown in Figure 20.

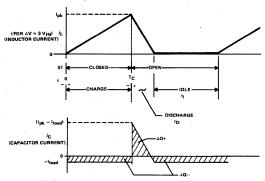


FIGURE 20. Inductor and Capacitor Current Step-Up Regulator

Studying the current waveforms (IL and IC) and recalling $\Delta Q+$ must equal $\Delta Q-$ for the potential across the load capacitor to remain constant, the relation of peak current to load current can be determined. Approaching it as ΔQ is the area under the respective curves, maximum load current for discontinuous operation ($t_i=0$) relates to the peak current as:

$$I_{load} = \frac{I_{pk} t_D}{2 (t_D + t_C)}$$

Peak inductor current can be related to load current by:

$$I_{pk} = \frac{2 I_{load} (t_D + t_C)}{t_D}$$

To ease calculation of I_{pk} without prior calculation of t_{D} , t_{C} and t_{D} may be substituted for by their voltage ratios. Equating the charge/discharge times (t_{C}/t_{D}), it will be noted that the charge to discharge ratio is proportional to the ratio of the input/output differential to input voltage ratio.

$$\frac{t_D}{t_C} = \frac{V_{IN}}{V_{OUT} - V_{IN}}$$

$$t_D = t_C \frac{V_{IN}}{V_{OUT} - V_{IN}}$$

setting tD = 1

$$t_{C} = \frac{V_{OUT} - V_{IN}}{V_{IN}}$$

$$\therefore I_{pk} = 2 I_{load} \left[1 + \frac{V_{OUT} - V_{IN}}{V_{IN}} \right]$$

which reduces to:

$$I_{pk} = 2 I_{load} \frac{V_{OUT}}{V_{TN}}$$

From the capacitor current waveform of Figure 20, the remaining performance factors may be determined.

Setting $\Delta Q+$ equal to $\Delta Q-$ and solving for t_i where $I_{load} < I_{load}(max)$ (t_i is not 0).

$$t_{i} = \frac{I_{pk} t_{D}}{2 I_{load}} - (t_{D} + t_{C})$$

$$V_{\text{ripple}} = \frac{(I_{\text{pk}} - I_{\text{load}})^2}{2 C I_{\text{pk}}} T_{\text{D}}$$

Summarizing:

For the step-up voltage regulator

$$I_{pk} = 2 I_{load} \left[\frac{V_{OUT}}{V_{IN}} \right]$$

$$L = \frac{V_{IN}}{I_{pk}} t_{ON}$$

$$f_0 = \frac{2 I_{load}}{I_{pk} t_D}$$

$$C = \frac{(I_{pk} - I_{load})^2}{V_{ripple} \ 2 \ I_{pk}} \cdot T_D$$

$$T_{D} = t_{ON} \left[\frac{v_{IN}}{v_{OUT} - v_{IN}} \right]$$

A STEP-UP SWITCHING REGULATOR DESIGN EXERCISE with TL497A

Figure 21 is the basic step-up regulator using the TL497A.

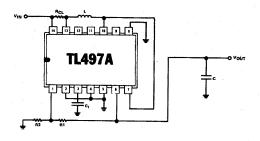


FIGURE 21. Basic Step-Up Regulator Using the TL497A

Conditions:

$$V_{IN} = 5 V$$

$$IOUT = 75 \text{ mA}$$

$$V_{ripple} < 1\%$$

Calculations:

$$I_{pk} \geqslant 2 I_{load} \begin{bmatrix} \overline{V}_{OUT} \\ \overline{V}_{IN} \end{bmatrix}$$

$$I_{pk} \ge 450 \text{ mA}$$

For design margin Ipk → 500 mA

$$L = \frac{V_{IN}}{I_{pk}} t_{ON}$$

$$L = \frac{5}{500 \times 10^{-3}} t_{ON}$$

Recommended on-time is; 19 μ s < to N < 150 μ s, thus the range of acceptable inductance is; 190 μ H to 1.5 mH

choosing
$$L = 200 \mu H$$

$$t_{ON} = 20 \,\mu s$$

To program the TL497:

$$R2 = 1.2 k\Omega$$

$$R1 = (15 - 1.2) k\Omega = 13.8 k\Omega$$

To set the current limiting:

$$R_{CL} = 0.5/I_{limit}$$

$$R_{CL} = \frac{0.5}{500 \times 10^{-3}} = 1 \Omega$$

For on-time chosen above (20 μ s) C_t can be estimated;

$$C_t$$
 (pf) $\simeq 12 t_{ON}$ (μs)

$$C_t \simeq 240 \text{ pF}$$

or it can be selected from Table II, page 5.

To determine Cfilter for desired ripple voltage

$$C = \frac{(I_{pk} - I_{load})^2 T_D}{V_{ripple} 2 I_{pk}}$$

$$t_D = t_{ON} \left[\frac{V_{IN}}{V_{OUT} - V_{IN}} \right] = 10 \,\mu\text{s}$$

$$C = 12.0 \,\mu\text{F}$$

The nominal operating frequency fo is:

$$f_0 = \frac{1}{T} = \frac{2 I_{load}}{I_{pk} T_D}$$

$$f_0 = 30 \text{ kHz}$$

Applying these values to the TL497A results in a schematic as shown in Figure 22.

Figure 23 shows another step-up circuit which will supply 12 volts output at 80 mA with an input of 5 volts.

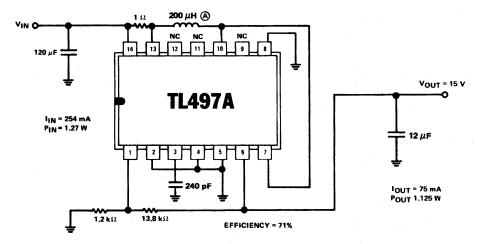


FIGURE 22. 5 Volt to 15 Volt Switching Regulator

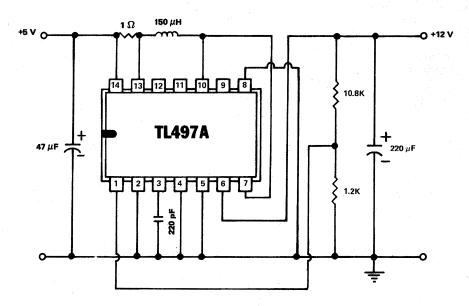


FIGURE 23. TL497A Step-Up Circuit, 5V Input to 12V @ 80mA Output

DESIGN AND OPERATION OF SWITCHING VOLTAGE REGULATOR IN INVERTING CONFIGURATION

The inverting regulator is similar to the step-up regulator in that during the charging cycle of the inductor, the load is isolated from the input. The only difference is in the potential across the inductor during its discharge. This can best be demonstrated by a review of the basic inverting regulator circuit (Figure 24).

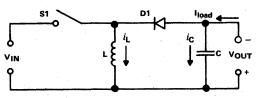


FIGURE 24. Basic Inverting Regulator Circuit

During the charging cycle (S1 closed) the inductor (L) is charged only by the input potential-similar to the step-up configuration.

$$I_{pk} = \frac{V_{IN}}{L} t_{ON}$$

Like the step-up configuration, in the inverting configuration (Figure 25) the input provides no contribution to the load current during the charging cycle and thus the maximum load current for discontinuous operation will be limited by the peak current, in accordance with that observed in the step-up configuration.

$$I_{L \text{ max}} \text{ (discontinuous)} = \frac{I_{pk} t_{D}}{2 (t_{D} + t_{C})}$$

The discharge rate (tD) however differs due to the difference in the potential across the inductor during its discharge which is VOUT.

$$\therefore t_{\mathbf{D}} = \frac{I_{\mathbf{pk}}}{|V_{\mathbf{OUT}}|} L$$

To simplify calculation of Ipk from Iload;

$$I_{pk} = \frac{v_{IN}}{L} t_c = \frac{v_{OUT}}{L} t_D$$

$$\therefore \frac{t_D}{t_C} = \frac{v_{IN}}{v_{OUT}}$$

Substituting this into the expression for I_L max and simplifying;

$$I_{pk} = 2 I_{load} \left(1 + \frac{|V_{OUT}|}{V_{IN}} \right)$$

The current waveforms in the inverting configuration look identical to those demonstrated in the step-up configuration. The same formulaes therefore apply for t_i , $I_{L\ max}$ (discontinuous) and V_{ripple} .

Summarizing:

For the inverting regulator:

$$\begin{split} I_{pk} &\geqslant 2 \; I_{load} \quad \left(1 + \frac{|V_{OUT}|}{V_{IN}}\right) \\ L &= \frac{V_{IN}}{I_{pk}} \; t_{ON} \\ f_0 &= \frac{2 \; I_{load}}{I_{pk} \; t_{D}} \\ C &= \frac{(I_{pk} - I_{load})^2}{V_{ripple} \; 2 \; I_{pk}} \; \cdot \; T_{D} \end{split}$$

where:

$$t_{\rm D} = t_{\rm ON} \frac{v_{\rm IN}}{|v_{\rm OUT}|}$$

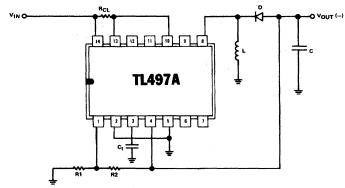


FIGURE 25. Basic Inverting Regulator

AN INVERTING REGULATOR DESIGN EXERCISE with

TL497A

Conditions:

$$V_{IN} = 5 V$$

$$V_{OUT} = -5 V$$

$$IOUT = 100 \text{ mA}$$

Calculations:

$$I_{pk} \ge 2 I_{load} \left(1 + \frac{|V_{OUT}|}{V_{IN}} \right)$$

$$I_{pk} \ge 400 \text{ mA}$$

For design margin $I_{pk} \rightarrow 500 \text{ mA}$

$$L = \frac{V_{IN}}{I_{pk}} t_{ON}$$

$$L = \frac{5}{500 \times 10^{-3}} t_{ON}$$

Recommended on-time: 19 $\mu s < t_{ON} < 150 \mu s$, thus the range of acceptable inductance is; 190 µH to 1.5 MH

choosing
$$L = 200 \mu H$$

$$t_{ON} = 20 \,\mu s$$

To program the TL497:

$$R2 = 1.2 \text{ k}\Omega$$

$$R1 = (5 - 1.2) = 3.8 \text{ k}\Omega$$

To set the current limiting:

$$RCL = 0.5/I_{limit}$$

$$R_{CL} = \frac{0.5}{500 \times 10^{-3}} = 1 \Omega$$

For the ton chosen above (20 μ s) C_t can be estimated;

$$C_t(pf) \simeq 12 t_{ON}(\mu s)$$

$$\therefore C_t = 240 \text{ pF}$$

or it can be selected from Table II, page 5.

To determine Cfilter for desired ripple voltage:

$$C = \frac{(I_{pk} - I_{load})^2}{V_{ripple} 2 I_{pk}} \cdot T_D$$

$$t_{\rm D} = t_{\rm ON} - \frac{v_{\rm IN}}{v_{\rm OUT}} = 20 \, \mu_{\rm S}$$

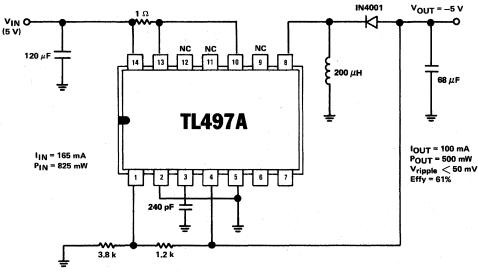
$$C_{filter} = 64 \mu F$$

The nominal operating frequency fo is:

$$f_0 = \frac{2 I_{load}}{I_{pk} T_D}$$

$$f_0 = 20 \text{ kHz}$$

Applying these values to the TL497A will give results as shown in Figure 26.



*NOTE - DO NOT USE INTERNAL DIODE (PINS-6, 7) FOR CATCH DIODE ON AN INVERTING CIRCUIT.

FIGURE 26. +5 Volt to -5 Volt Switching Regulator

SPECIAL TL497A CIRCUITS

The following are several TL497A circuits that do not fall strictly in a step-up or step down category but rather a combination of both types.

Figure 27 is an automotive power supply built to supply 8.5 volts regulated to power a microprocessor board. During low voltage conditions (4 volts) it acts as a step-up circuit producing about 11 volts at the positive side of the 1000 μ F capacitor. When a high voltage

condition exists (15 volts) it acts as a step-down circuit still giving about 11 volts to the capacitor. This 11 volts then is regulated to the desired 8.5 volts by a μ A 7885 3-terminal regulator.

Figure 28 is a dual output circuit producing both a +12V and -12V from a +5 volt input to the supply. While not supplying a large amount of current it will put out about 12 mA of current of each voltage polarity.

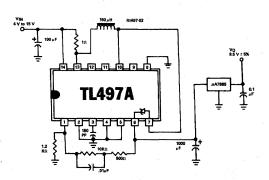


FIGURE 27. 12V To 8.5V Step-Up/Down Circuit

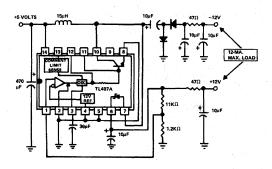
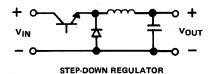


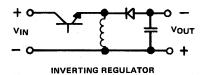
FIGURE 28. TL497A Dual Supply +12 Volts and -12 Volts From +5 Volts

DESIGN VARIATIONS FOR IMPROVED PERFORMANCE

Improving Efficiency

The dominant contribution by the TL497A to the overall efficiency of the switching regulator is the VCE (SAT) of the transistor switch. Recall, the previous sections have considered the switch to be ideal (VCE (SAT) = 0 V), this is not the case in the real world. As the VCE (SAT) increases the circuit efficiency decreases. Consider for a moment the basic architecture of the three applications presented herein (see Figure 29).





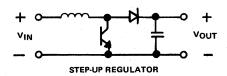


FIGURE 29. Basic Regulator Architectures

Note in all but the step-up regulator the switching transistor is applied to the positive input rail. In these configurations it is impossible to drive the NPN transistor switch into saturation since its base drive circuit resides at a potential lower than its collector potential. Improved performance can be achieved by using an external PNP transistor driven by the internal NPN. (See Figure 30(a, b).)

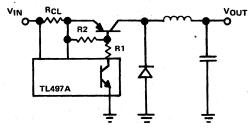
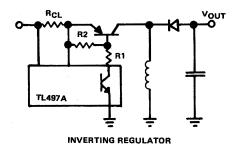


FIGURE 30(a). Step-Down Regulator



$$R1 = \frac{(V_{IN} - 1.5) h_{FE}}{I_{pk}}$$
 $R2 = \frac{10R1}{V_{IN} - 1.5}$

FIGURE 30(b). TL497A With External PNP Switch For Improved Performance

Improving on Time Stability

The on time is determined by the timming capacitor (CT) and its associated circuitry. The on time cycle (charging of CT) is initiated when the voltage at the feedback input (pin 1) is less than 1.2 volts. During the on time as the timming capacitor is being charged to its internally prescribed peak voltage, the error comparator remains active. If during this period the feedback voltage is increased above 1.2 volts, the on-time cycle will be interrupted. This condition can be the result of a noise spike fed back when the switching transistor turns on. The resulting CT waveform is as illustrated in Figure 31.



CORRECT WAVEFORM

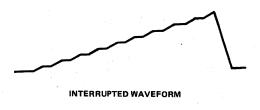
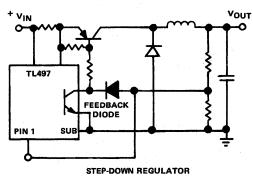
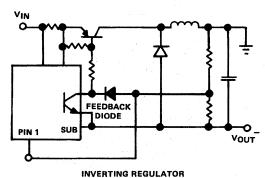


FIGURE 31. CT Waveforms

Note the appearance of the charging ramp of the CT waveform. It can appear as a few easily defined steps or as numerous, almost undetectable, smaller steps. Another evident condition of the presence of this problem is a jittering on time. This severely degrades the efficiency of the converter circuit as power is lost during each transition of the switching transistor. Solution of this problem is quite simple, clamp the feedback node (pin 1) to less than 1.2 volts during the on-time cycle. Figure 32 shows how this can easily be accomplished with the addition of a single feedback diode.





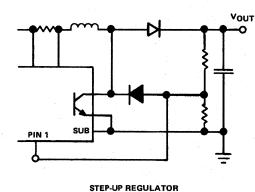


FIGURE 32. Basic Regulator with Feedback Diodes

The function of the feedback diode is simple. When the on-time cycle is initiated, the internal switching transistor turns on. Note that in all three configurations of Figure 32 the emitter of the internal switch is tied to the substrate pin [ground or VOUT (-)]. When the internal switch turns on, the feedback diode is forward biased and the feedback signal is clamped at approximately 0.8 volt $(V_{CE~(SAT)} \sim 0.3 \text{ V}, V_F \sim 0.5 \text{ V})$, which is less than the 1.2 volts reference. Voltage spikes or noise appearing at the output will not be reflected at pin 1 as the diode clamp holds the feedback at 0.8 volt. Thus a clean on-cycle will result. At the conclusion of the on cycle, the internal switch turns off the diode reverse biases and the feedback voltage returns to its voltage prescribed by the resistor ladder and VOUT. If not used as the flyback diode the internal diode is quite satisfactory for this application.

Ringing

An oscilloscope is a must when building a switching power supply with this or any other circuit. It is good to first obtain the correct waveform on the oscillator ramp (pin # 3). (See Figure 32 and Figure 14.) Next look at the switched waveform on the collector of switch (pin 10). See Figure 33. These must be correct or the circuit will not function properly. If ringing is noticed on the switched waveform (pin 10) it can be reduced by placing a 470 to 1000 ohm resistor directly across the inductor to more rapidly dump the coil current when the switch is off.

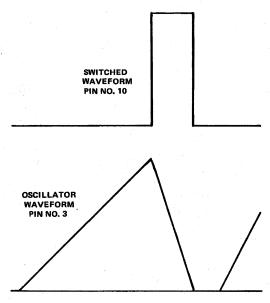


FIGURE 33.

EXTENDED VOLTAGE OPERATION

It is sometimes desirable to operate the TL497A from a voltage higher than the maximum voltage rating of 15.0 volts as per the specification. This may be accomplished with few parts, chiefly a TL783 regulator and a diode as shown in Figure 34. The TL783 output voltage chosen should be lower than the output voltage of the supply. The TL783 will provide a reference voltage to the TL497A until the VOUT comes up. DFB then forward biases, thus supplying the TL497A and shutting back the TL783 regulator. The residual power consumption is only about 5.0 mA in the TL783 circuit.

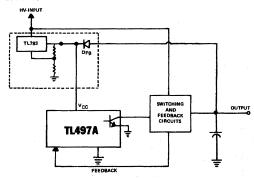
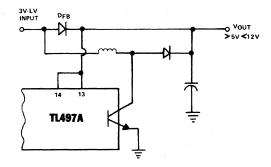


FIGURE 34.

LOW VOLTAGE OPERATION

In some occasions there is a need to operate from a voltage lower than the minimum voltage rating of the TL497A which is 4.5 volts. Since the oscillator will run with less than 3 volts VCC, regulation may be accomplished with a circuit similar to Figure 35. With the application of 3 volts, the diode DFB forward biases furnishing VCC to the oscillator of the TL497A. This causes the switching transistor to operate and steps the voltage up to its designed output. (4.5 V - 15 V) Once VOUT comes up higher than 3.0 volts, DFB is reversed biased and VCC to the TL497A is now furnished by its own output voltage.



NOTE-1 - SINCE ONLY THE OSCILLATOR SECTION WILL FUNCTION ON A 3.0 VOLT SUPPLY, THE RE-MAINDER OF THE CHIP IS INOPERATIVE. THE COMPLETE CIRCUIT WILL FUNCTION WHEN VOUT REACHES ABOUT 4.5 VOLTS.

FIGURE 35.

SWITCHING REGULATOR DESIGN TIPS

The TL497A being a fixed on-time, variable frequency device does not need a "HI-Q" type of inductor.*
"HI-Q" coils are not desirable due to the TL497A's broad frequency range of operation. If the "Q" is too high, excessive ringing will occur on the output pulse. If when using a coil with a typical "Q" of greater than 10 ringing does occur, a shunt resistance may be placed across the coil to dampen the waveform.

While not necessary, it is highly desirable to use a toroid inductor as opposed to a cylindrical wound coil. The toroid type of winding helps to contain the flux closer to the core and reduce the possible radiation from the supply. A typical inductor of $150\,\mu\mathrm{H}$ inductance and capable of handling 0.5 amperes of current would have a D.C. resistance of about 0.6 Ω . Below is a list of possible inductor sources.

Care should be used in placement of parts and routing of ground connections similiar to practices used in constructing R.F. circuits. These technique's will help to prevent unwanted oscillations due to positive feedback or ground loops.

^{*}NOTE: See page 22 for possible inductor sources.

INDUCTOR SOURCES*

Reliability, Inc. P.O. Box 218370 Houston, TX 77218 (713) 492-0550

Coil Craft 1102 Silver Lake Rd. Cary, Ill 60013 (312) 639-2361

Mini-Magnetics 453 Ravendale Dr. Unite E Mountain View, CA 94043 (408) 255-7160

Ferroxcube 5083 Kings Highway Saugerties, N.Y. 12477 (914) 246-2811

Pulse Engineering, Inc. P.O. Box 12235 San Diego, CA 92112 (714) 279-5900 TRW Inductive Products Mr. Austin Profeta 150 Varick St. New York, N.Y. (212) 255-3500

West Coast Magnetics, Inc. 140 San Lazaro Sunnyvale, CA 94086 (408) 733-9853

Microtran Company, Inc. 145 E. Mineola Avenue P.O. Box 236 Valley Stream, N.Y. 11582 (516) 561-6050

Cambion 445 Concord Ave. Cambridge, MA 02138 Telex: 92-1480 (617) 491-5400

South Haven Coil, Inc. P.O. Box 409 Blue Star Highway South Haven, Michigan 49090 AC 616 #637-5201

^{*}Texas Instruments does not endorse or warrant the suppliers referenced.

APPENDIX

Tables 1 and 2 illustrate the operating range of the TL497A without the addition of an external power transistor. Standard inductor values have been used giving maximum operating frequencies (discontinuous mode) in the range 9 kHz - 103 kHz. Worst case figures for transistor on-state voltage, VCE (SAT), and diode forward voltage drop, Vf, have been assumed throughout giving a conservatively rated output current, $I_{\rm O}$ (max), in the majority of cases.

Input Voltage Vin (V)	Output Voltage Vo (V)	Output Current Imax (mA)	Power Transfer Pmax (W)	Feedback Resistors R1 R2	Inductor L (µH)	Timing Capacitor Ct (pF)	Operating Frequency fmax (kHz)
5.0 4.75	6	152 143	0.91	4.8K 1.2K	150	220	18.9
5.0 4.75	12	79 74	0.95	10.8K 1.2K	150	220	33
5.0 4.75	15	64 60	0.96	13,8K 1.2K	150	220	35.7
5.0 4.75	18	53 50	0.95	16,8K 1.2K	150	220	38.5
5.0 4.75	24	40 38	0.96	22.8K 1.2K	150	220	40
5.0 4.75	30	32 30	0.96	28,8K 1.2K	150	220	41.7
5.0 4.75	-5	96 90	0.48	3.8K 1.2K	150	220	30
5.0 4.75	-12	57 54	0.68	10,8K 1.2K	150	220	37
5.0 4.75	-24	34 32	0.82	22.8K 1.2K	150	220	41.7

The following assumptions have been made:

Note: The 30V and -24V supplies will not give the full output in the worst case since the ratio tc/tc + td exceeds the maximum limit of 0.85 defined by the I.C.

Table 1. TL497A Operation from a 5V Supply

Input Voltage V _{in} (V)	Output Voltage Vo (V)	Output Current Imax (mA)	Power Transfer Pmax (W)	Feedback Resistors R1 R2	Inductor L (μΗ)	Timing Capacitor Ct (pF)	Operating Frequency f _{max} (kHz)
12	5	250	1.2	3.8K 1.2K	256	220	22.7
12	10	250	2.5	8.8K 1.2K	73	220	45.5
12	15	180	2.7	13.8K 1.2K	439	220	9.8
12	18	151	2.7	16.8K 1.2K	439	220	16.5
12	24	114	2.7	22.8K 1.2K	439	220	24.9
12	30	91	2,7	28.8K 1.2K	439	220	29.8
12	-5	159	0.8	3.8K 1.2K	439	220	14.5
12	-12	114	1.4	10.8K 1.2K	439	220	24.9
12	-24	76	1.8	22.8K 1.2K	439	220	33.2

Note: Use a standard 220 pF timing capacitor. The assumptions of maximum peak current operation and worst case transistor and diode losses apply.

Table 2. TL497A Operation from a 12V Supply.

^{1.} Power switch operation at maximum peak current. 2. Worst case transistor and diode conduction losses. 3. Use of standard 150 μ H inductor and 220 pF timing capacitor.

Designing With the TL5001 PWM Controller



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ABSTRACT

Electrical and electronic products today are required to be lighter and smaller, use less power, and cost less. Because of these requirements, manufacturers are turning more and more to small high-frequency dc-to-dc converters for power-supply solutions. The TL5001 is a pulse-width-modulation (PWM) control integrated circuit, which with a few external components can be used to implement such converters that can operate at frequencies up to 400 kHz.

INTRODUCTION

The TL5001 integrated circuit incorporates all the PWM-control functions in a compact 8-pin package, including:

- Oscillator/triangle-wave generator
- PWM comparator with adjustable dead-time control input
- Open-collector output-drive transistor
- 1-V temperature-stable reference
- Wide-bandwidth error amplifier
- Short-circuit protection (SCP)
- Undervoltage lockout (UVLO)

In addition, the TL5001 operates over a 40-kHz to 400-kHz frequency range with supply voltages ranging from 3.6 V to 40 V and typically consumes only 1 mA of supply current.

This application report demonstrates the design of three simple step-down (buck) converters. The designs include: two converters operating from 12 V and delivering 5 V at 3 A, 3.3 V at 3 A, and one that operates from 5 V and delivers 3.3 V at 0.75 A, using the TL5001 and a few external components.

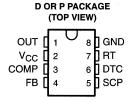
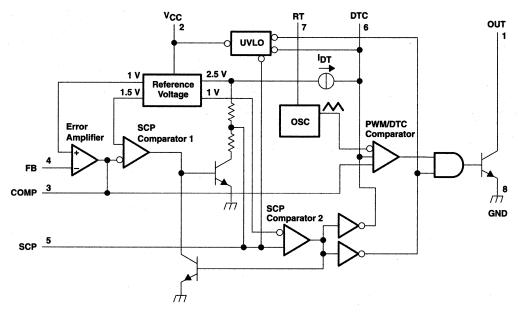


Figure 1. Package Layout



SCP = Short-circuit protection UVLO = Undervoltage lockout protection

Figure 2. Functional Block Diagram

EXAMPLE 1: 12-V to 5-V at 3-A STEP-DOWN CONVERTER

Design Criteria

The schematic of the final design is provided in Figure 8.

Specifications

Input voltage range, V _I	10 V to 15 V
Output voltage, VO	5 V
Output current, IO	
Output ripple voltage	≤50 mV
Regulation	
Efficiency	≥80%
Ambient temperature range, T _A	0°C to 55°C

Surface-mount components should be employed wherever feasible. The dc/dc converter is implemented with a continuous-mode, fixed-frequency-PWM step-down converter operating at 200 kHz.

Duty-Cycle Estimates

Before starting the detailed design, it is useful to estimate the duty cycle, D (ratio of the power-switch conduction time to the period of the operating frequency), for various input voltages. The duty cycle for a step-down converter operating in continuous mode is approximately:

$$D = \frac{V_O + V_d}{V_I - V_{sat}}$$

Where

 V_d = catch-rectifier conduction voltage (assume V_d = 0.6 V) V_{sat} = power-switch conduction voltage (assume V_{sat} = 0.5 V)

The results can be recalculated if actual values are too far from the initial estimate.

The duty cycle for $V_I = 10$, 12, and 15 V is 0.59, 0.49, and 0.39, respectively.

Output Filter

The output filter is a single-stage LC design.

Inductor

Choose the inductance value to maintain continuous-mode operation down to 10% of rated output current.

$$\Delta I_{O} = 2 \times 0.1 \times I_{O(max)} = 2 \times 0.1 \times 3 = 0.6 \text{ A peak-to-peak}$$

The ripple current is simply the product of the inductor voltage and t_{on}, the power-switch conduction time, divided by the inductor value.

$$\Delta I_{O} = \frac{V_{ind} \times t_{on}}{L1} = \frac{V_{ind} DTs}{L1}$$

where Ts = period of the converter operating frequency.

The inductor voltage during t_{on} is the input voltage minus V_{sat} , the power-switch conduction voltage, minus the output voltage. Solving for L1,

L1 =
$$\frac{\left(V_{I} - V_{sat} - V_{O}\right)(D) (t)}{\Delta I_{O}} = \frac{(15 - 0.5 - 5) (0.39) \left(5 \times 10^{-6}\right)}{0.6} = 30.87 \ \mu H$$

Because the core is too large, there are not many off-the-shelf surface-mount devices for this design. A 27-µH inductor (27 turns of 22-gauge magnet wire on a Micrometals T50-26B powdered-iron toroid) was selected because it was readily available.

Output-Filter-Inductor Selection

Magnetic component manufacturers offer a wide range of off-the-shelf inductors suitable for dc/dc converters, some of which are surface mountable. There are many types of inductors available; the most popular core materials are ferrites and powdered iron. Bobbin or rod-core inductors are readily available and inexpensive, but care must be exercised in using them because they are more likely to cause noise problems than are other shapes. Custom designs are also feasible, provided the volumes are sufficently high.

Capacitor

The output capacitor is selected to limit ripple voltage to the level required by the specification. The three elements of the capacitor that contribute to ripple are: equivalent series resistance (ESR), equivalent series inductance (ESL), and capacitance. Normally, in designs of this type, it is necessary to provide a great deal of capacitance to get ESR to acceptable levels. ESL, which can be a problem at high frequencies, can be controlled by choosing low ESL capacitors, limiting lead length (PCB and capacitor), and replacing one large device with several smaller ones connected in parallel.

Assuming all the inductor ripple current flows through the filter capacitor and the ESR is zero, the capacitance needed to limit the ripple to 50 mV peak-to-peak is:

$$C = {\Delta I_O \over 8 \times f_8 \times \Delta V_O} = {0.6 \over (8) (200 \times 10^3) (0.05)} = 7.5 \ \mu F$$

Assuming the capacitance is very large, the ESR needed to limit the ripple to 50 mV peak-to-peak is:

$$ESR = \frac{\Delta V_{O}}{\Delta I_{O}} = \frac{0.05}{0.6} = 83 \text{ m}\Omega$$

Capacitor ripple current is seldom a problem in low-voltage converters unless a large number of devices are paralleled. However, to be on the safe side, the rms current is established as:

$$\Delta I_{O(rms)} = 0.6 \times 0.289 = 0.17 \text{ Arms}$$

The output-filter capacitor(s) should be rated for: at least ten times the calculated minimum capacitance, an ESR 30% to 50% lower than the calculated maximum, a 0.5-Arms-or-greater ripple-current rating at 100 kHz and 85°C, and a 7.5-V or greater voltage rating.

Use one 220- μ F 10-V OS-CON SA-series device, even though it is in a lead-mounted radial package. The ESR is 35 m Ω (at 100 kHz) and the 85°C ripple-current rating is 2.36 Arms. Where package height and/or surface-mount packaging is critical, two solid tantalum-chip 100- μ F 10-V devices with 100-m Ω ESR and 1.1-Arms ripple-current rating from either the AVX TPS series or the Sprague 593D series connected in parallel work well.

Output-Filter-Capacitor Selection

Three capacitor technologies: low-impedance aluminum, organic semiconductor, and solid tantalum, are suitable for low-cost commercial applications such as this one. Low-impedance aluminum electrolytics are the lowest cost and offer high capacitance in small packages, but ESR is higher than the other two and there are currently no surface-mount devices suitable for this application. Organic semiconductor electrolytics, such as the Sanyo OS-CON series, have become very popular for the power-supply industry in recent years. These capacitors offer the best of both worlds – a low ESR that is stable over the temperature range and high capacitance in a small package. Most of the OS-CON units are supplied in lead-mounted radial packages; surface-mount devices are available but much of the size and performance advantage is sacrificed. Solid-tantalum chip capacitors are probably the best choice if a surface-mounted device is an absolute must. Products such as the AVX TPS family and the Sprague 593D family were developed for power-supply applications. These products offer a low ESR that is relatively stable over the temperature range, high ripple-current capability, low ESL, surge-current testing, and a high ratio of capacitance to volume.

Power-Switch Design

The power-switch design includes: selecting the power switch, catch rectifier, and rectifier-snubbing network (if needed), calculating power dissipations and junction temperatures, and ensuring the semiconductors have proper heat sinking.

Power Switch

The design uses a p-channel MOSFET to simplify the drive-circuit design and minimize component count. Based on the preliminary estimate, $r_{DS(on)}$ should be less than 0.5 V \div 3 A = 167 m Ω with a 10-V gate drive and the drain-to-source breakdown voltage appropriate for a 15-V supply. Surface-mount packaging is also desirable.

The IRF9Z34S is a 60-V p-channel MOSFET in a power surface-mount package with $r_{DS(on)} = 140 \text{ m}\Omega$ maximum with a 10-V gate drive.

Power dissipation, which includes both conduction and switching losses, is given by:

$$P_D = I_O^2 \times r_{DS(on)} \times D + 0.5 \times V_I \times I_O \times t_{r+f} \times f_s$$

Where t_{r+f} = total MOSFET switching time (turn-on and turnoff) and $t_{DS(on)}$ is adjusted for temperature.

Assuming the drive circuit is adequate for $t_{r+f} = 100$ ns and the junction temperature is 125°C with a 55°C ambient, the $r_{DS(on)}$ adjustment factor is 1.6.

$$\begin{split} \mathbf{P_D} &= \left(3^2\right)\!(0.14\times 1.6)(0.59) \,+\, (0.5)(10)(3)\!\left(0.1\times 10^{-6}\right)\!\!\left(200\times 10^3\right) \\ \mathbf{P_D} &= 1.19 \,+\, 0.30 \,=\, 1.49 \,\,\mathrm{W} \end{split}$$

Conduction losses are dominant in this application but may not be in others. It is good practice to check dissipation at the extreme limits of input voltage to find the worst case.

The thermal impedance $R_{\theta IA} = 40^{\circ}$ C/W for FR-4 with 2-oz copper and a one-inch-square pattern.

$$T_I = T_A + (R_{\theta IA} \times P_D) = 55 + (40 \times 1.49) = 115$$
°C

Bipolar Versus MOSFET Power Transistors

Each of the three designs presented in this report could be implemented with bipolar or MOSFET transistors as the power switch. Bipolars are inexpensive and can perform well in low-voltage applications such as these, but designing a drive circuit to realize the performance is not a trivial effort. Furthermore, complex base-drive schemes can eliminate much, if not all, of the cost advantage. MOSFETs were selected for this application because the fast switching times required for high-frequency operation are acheived with relatively simple, low-component-count gate drive circuits, and the focus in this report is the controller design.

Catch Rectifier

The catch rectifier conducts when the power switch turns off and provides a path for the inductor current. Important criteria for selecting the rectifier include: fast switching, breakdown voltage, current rating, low-forward voltage drop to minimize power dissipation, and appropriate packaging. Unless the application justifies the expense and complexity of a synchronous rectifier, the best solution for low-voltage outputs is usually a Schottky rectifier.

The breakdown voltage must be 20 V or greater to handle the 15-V input; the current rating must be at least 3 A (normally the current rating will be much higher than the output current because the power limits the number of acceptable devices); and a surface-mount package is extremely desirable.

The 50WQ03F is a 5.5-A, 30-V Schottky in a DPAK, power surface-mount package. Care must be taken to ensure that the rectifier maximum junction temperature is not exceeded. The first step in determining the rectifier junction temperature is to estimate worst-case power dissipation. Neglecting leakage current and assuming the ripple current in the inductor is much less than the output current, the catch-rectifier power dissipation is:

$$P_D = I_O \times V_d \times (1 - D)$$

where V_d is the rectifier conduction drop. Worst-case dissipation occurs at high line where D is minimum. The 50WQ03F has a maximum forward drop of 0.55 V at a forward current of 3 A and a junction temperature of 125° C.

$$P_D = 3 \times 0.55 \times (1 - 0.39) = 1 \text{ W}$$

The thermal impedance $R_{\theta,JA} = 50^{\circ}$ C/W when mounted on FR-4 with 2-oz copper and a one-inch-square pattern.

$$T_I = T_A + (R_{\theta IA} \times P_D) = 55 + (50 \times 1) = 105^{\circ}C$$

Catch-Rectifier Snubber Network

Step-down converters almost universally suffer from ringing on the voltage waveform at the node where the power-switch drain, output inductor, and catch-rectifier cathode connect. The ringing, which results from driving parasitic inductances and capacitances with fast rise-time waveforms, ranges in severity from objectionable to unacceptable depending on component selection and PCB layout. An RC-snubber damping network in parallel with the catch rectifier is by far the simplest way to minimize or eliminate the problem. Since deleting components from a printed-circuit layout is usually easier than adding them, the safest strategy is to include the network in the initial design and delete the components if they prove unnecessary.

The initial design is straightforward, but the PCB layout may necessitate component-value adjustments during the prototype phase. The capacitor value chosen is 4 to 10 times greater than the rectifier junction capacitance; higher values improve the snubbing but dissipate more power. The 50WQ03F has a typical junction capacitance of 180 pF, and a snubber-capacitor value should be between 750 pF and 1.8 nF. Use C8 = 1.2 nF for convenience. Rectifiers normally ring in the range from 1 to 50 MHz. Choose the snubber resistor, R10, for a 50-ns time constant:

R10 =
$$\frac{50 \times 10^{-9}}{\text{C8}}$$
 = $\frac{50 \times 10^{-9}}{1.2 \times 10^{-9}}$ = 41.7 Ω ⇒ Use 43 Ω

Because the capacitor is charged and discharged each cycle, the power dissipation in R10 is:

$$(2)(C8)(V_1^2)\left(\frac{f_s}{2}\right) = (2)(1.2 \times 10^{-9})(15^2)\left(\frac{200 \times 10^3}{2}\right) = 54 \text{ mW}$$

Controller Design

The controller-design procedure involves choosing the components required to program the TL5001 and includes setting the oscillator frequency, the dead-time control voltage, the soft-start timing, and the short-circuit-protection timing. The sense-divider network and loop-compensation designs are also addressed in this section.

Oscillator Frequency

Resistance value R1 is selected to set the oscillation frequency to 200 kHz. Select R1 = 43 k Ω from the graph shown in Figure 3.

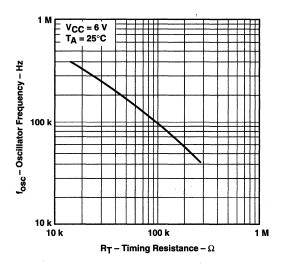


Figure 3. Oscillator Frequency Versus Timing Resistance

Dead-Time Control

Dead-time control provides a minimum period of time during each cycle when the power switch cannot be on; i.e., it limits the duty cycle to some value less than 100%. Even though dead time is not necessary in this application, a small amount is provided to minimize the surge current that would result from a short circuit while the protection circuit is timing out.

The dead time is set by connecting a resistor, R2, between DTC and GND. A constant current I_{DT} flows out of DTC generating a voltage, V_{DT} . I_{DT} is controlled by the current I_T that flows out of RT (this current is normally equal to I_T , but varies slightly with frequency and the peak amplitude of V_{DT}). The maximum duty cycle is 0.59. Typically, the actual duty cycle is set slightly higher to allow for parameter tolerances. For this design, a duty cycle of 0.70 is chosen. See Figure 4 to find the maximum and minimum ramp-voltage levels, $V_{O(100\%)}$ and $V_{O(0\%)}$; R2 is calculated from the following expression (R_{DT} , R_t in $k\Omega$, D in decimal):

R2 = (R1 + 1.25)
$$\left[D \left(V_{O(100\%)} - V_{O(0\%)} \right) + V_{O(0\%)} \right]$$

= (43 + 1.25)[0.7(1.4 - 0.6) + 0.6] = 51.3 kΩ

A value of 51 k Ω is used for R2.

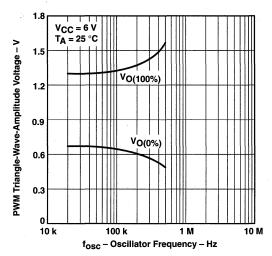


Figure 4. PWM Triangle-Wave-Amplitude Voltage Versus Oscillator Frequency

Soft-Start Timing

Soft start is implemented by adding a capacitor in parallel with the dead-time control resistor, R2. A start-up time of 5 ms is chosen.

C5 =
$$\frac{t_r}{R2} = \frac{5 \times 10^{-3}}{51 \times 10^3} = 0.1 \ \mu F$$

SCP Timing

In normal operation, SCP and the timing capacitor, C4, are clamped to approximately 185 mV. Under short-circuit conditions, C4 is allowed to charge. If the voltage across C4 reaches 1 V, the SCP latch is activated and the converter is shut down. The protection-enable period, t_{pe} , must be longer than the dc/dc converter start-up time, or the converter will never come up. Because the soft start is designed to bring the converter up within 5 ms, t_{pe} = 75 ms should work well. C4 is given by (t_{pe} in s, C4 in μ F);

$$C4 = 12.46 \times t_{pe} = 12.46 \times 0.075 = 0.935 \ \mu F \Rightarrow 1 \ \mu F$$

Output Sense Network

The output sense network is a resistive divider connected between the converter output and ground with the divider output connected to the TL5001 FB terminal (refer to Figure 6). The divider ratio is chosen for a 1-V output (the TL5001 reference voltage) when the converter output is at the desired value.

Establishing the proper divider ratio is critical, but selecting values for the sense network is somewhat arbitrary. Choosing the values too high can result in converter-output-voltage accuracy problems because the error-amplifier input-bias current loads the network. Values that are too low can dissipate too much power, drain too much power from limited power sources such as batteries, or lead to loop-compensation-capacitor values that are too high to be practical. As a rule, a divider current approximately 1000 times greater than the maximum error-amplifier input current is chosen. Resistors with 1% tolerances and low and/or reasonably well-matched temperature coefficients are recommended to minimize the output voltage tolerance.

Because the worst-case TL5001 input bias current is 0.5 μ A, the divider current should be approximately $1000 \times 0.5 \,\mu$ A = 0.5 mA. In regulation, the voltage across R6 is 1 V and the voltage across R5 is $V_O - 1$ V = 4 V.

$$R6 = \frac{1 \text{ V}}{0.5 \text{ mA}} = 2 \text{ k}\Omega$$

$$R5 = \frac{\left(\text{V}_{\text{O}} - 1 \text{ V}\right)}{0.5 \text{ mA}} = \frac{5 - 1}{0.5 \times 10^{-3}} = 8 \text{ k}\Omega$$

Since they are readily available and provide the right divider ratio, $R5 = 7.50 \text{ k}\Omega$ and $R6 = 1.87 \text{ k}\Omega$ are used.

Loop Compensation

The loop-compensation design procedure consists of shaping the error-amplifier frequency response with external components to stabilize the dc/dc converter feedback control loop without destroying the control-loop ability to respond to line and/or load transients. A detailed treatment of dc/dc converter stability analysis and design is well beyond the scope of this report; however, several references on the subject are available. The following is a simplified approach to designing networks to stabilize continuous-mode buck converters that works well when the open-loop gain is below unity at a frequency much lower than the frequency of operation.

Ignoring the error-amplifier frequency response, the response of the pulse-width modulator and power switch operating in continuous mode can be modeled as a simple gain block. The magnitude of the gain is the change in output voltage for a change in the pulse-width-modulator input voltage (error-amplifier COMP voltage). Typically, increasing the COMP voltage from 0.6 V to 1.4 V increases the duty cycle from 0 to 100% and the output voltage from 0 V to approximately 12 V at the nominal input voltage. The gain, A_{PWM} , is:

$$A_{PWM} = \frac{\Delta V_O}{\Delta V_{O(COMP)}} = \frac{(12 - 0)}{(1.4 - 0.6)} = 15 \Rightarrow 24 \text{ dB at nominal input}$$

Similarly, the gain is 22 dB at low line and 25 dB at high line. Converters with wider input ranges, 2:1 or more, need to check for stability at several line voltages to ensure that gain variation does not cause a problem.

The output filter is an LC filter and functions accordingly. The inductor and capacitor produce an underdamped complex-pole pair at the filter resonant frequency and the capacitor ESR (R_s) puts a zero in the response above the resonant frequency. The complex poles are located at:

$$\frac{1}{2 \pi \sqrt{LC}} = \frac{1}{2 \pi \sqrt{\left(27 \times 10^{-6}\right) \left(220 \times 10^{-6}\right)}} = 2.06 \text{ kHz}$$

The zero is located at:

$$\frac{1}{2 \pi R_s C} = \frac{1}{(2 \pi)(0.035)(220 \times 10^{-6})} = 20.7 \text{ kHz}.$$

Figure 5 includes gain and phase plots of the open-loop response (error amplifier not included) obtained from a simple SPICE simulation.

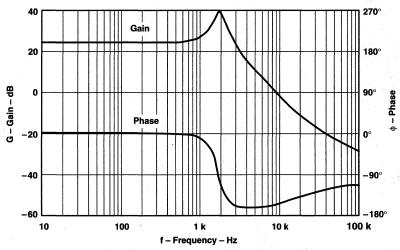


Figure 5. Uncompensated Open-Loop Response

The presence of the complex-pole pair is evident from the resonant peaking in the gain at 2 kHz and the rapid phase transition in the vicinity of 2 kHz. The zero is hard to see in the gain plot but shows up well in the phase response; the complex poles provide -180° of phase shift at 20 kHz and the zero adds 45° for a net of -135° .

Unless the designer is trying to meet an unusual requirement, such as very wide band response, many of the decisions regarding gains, compensation pole and zero locations, and unity-gain bandwidth are largely arbitrary. Generally, the gain at low frequencies is very high to minimize error in the output voltage; compensation zeros are added near the filter poles to correct for the sharp change in phase encountered near the filter-resonant frequency; and an open-loop unity-gain frequency is selected well beyond the filter-resonant frequency but 10% or less than the converter operating frequency. In this instance, a unity-gain frequency (f_T) of approximately 20 kHz is chosen to provide good transient response. Figure 6 shows a standard compensation network chosen for this example.

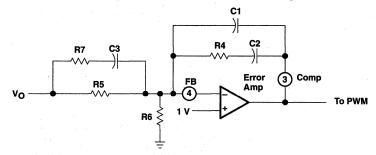


Figure 6. Compensation Network

Assuming an ideal amplifier, the transfer function is:

$$A_{ea}(S) = -\left[\frac{1}{S \text{ R5}(C2 + C1)}\right] \left[\frac{[S(R5 + R7) C3 + 1] (S R4 C2 + 1)}{(S R7 C3 + 1)[S R4 (C1 \parallel C2) + 1]}\right]$$

The integrator gain, $1/[R5 \cdot (C2 + C1)]$, establishes the open-loop unity-gain frequency. The zeros are located at approximately the same frequency as the output-filter poles to compensate for the gain reduction and phase shift. The pole at $1/(2\pi \cdot R7 \cdot C3)$ is positioned at approximately the same frequency as the zero in the output filter to maintain the 20 dB-per-decade roll-off in the gain response. The final pole at $1/(2\pi \cdot R4 \cdot C1 \parallel C2)$ is placed at a frequency between half of the operating frequency and the operating frequency to minimize high-frequency noise at the pulse-width-modulator input. The last pole is not always necessary but should be included in the design until the need is established.

The sum of the gains of the modulator, the LC filter, and the error amplifier is 0 dB at the unity-gain frequency. The gain of the modulator/LC filter at 20 kHz may be calculated or obtained from a bode plot using straight-line approximations or from a simple SPICE simulation. As shown in Figure 5, the modulator/filter gain is -12 dB at 20 kHz.

The compensation network has two zeros at 2 kHz to cancel out the LC filter poles. These two zeros contribute a gain of 40 dB at 20 kHz; therefore, the gain contributed by the compensation-network integrator needs to be -28 dB [0 - (-12 + 40) = -28]. The integrator gain of -28 dB translates to a voltage gain of 0.0398.

$$\frac{1}{(2 \pi)(f_T)(R5)(C2 + C1)} = 0.0398 \text{ (at } f_T = 20 \text{ kHz)}$$

In practice, C2 >> C1,

$$C2 = \frac{1}{(2\pi) \left(f_{T}\right) (R5)(0.0398)} = \frac{1}{(6.28) \left(20 \times 10^{3}\right) \left(7.5 \times 10^{3}\right) (0.0398)} = 0.027~\mu\text{F}$$

R4 is chosen to position a zero at 2 kHz.

R4 =
$$\frac{1}{(2\pi)(f)(C2)}$$
 = $\frac{1}{(6.28)(2 \times 10^3)(0.027 \times 10^{-6})}$ = 2.95 kΩ ⇒ Use 3.0 kΩ

R7 and C3 are chosen to provide a zero, $\rm f_{Z1},$ at 2 kHz and a pole, $\rm f_{P1},$ at 20 kHz.

$$\begin{split} f_{Z1} &= \frac{1}{2\pi (R5 + R7) \ C3} = \frac{1}{[(2\pi)(R5)(C3)] + [(2\pi)(R7)(C3)]} \\ f_{P1} &= \frac{1}{(2\pi) \ (R7) \ (C3)} \end{split}$$

After algebraic manipulation:

$$(2\pi)(R7)(C3) = \frac{1}{f_{\mathbf{p}}}$$

$$C3 = \frac{\frac{1}{f_{\mathbf{Z}}} - \frac{1}{f_{\mathbf{p}}}}{(2\pi)(R5)} = \frac{\left[\frac{1}{2 \times 10^3} - \frac{1}{20 \times 10^3}\right]}{(6.28)(7.5 \times 10^3)} = 0.0096 \ \mu\text{F} \Rightarrow \text{Use C3} = 0.01 \ \mu\text{F}$$

$$R7 = \frac{1}{(2\pi)(f_{\mathbf{p}})(C3)} = \frac{1}{(6.28)(20 \times 10^3)(0.01 \times 10^{-6})} = 796 \ \Omega \Rightarrow \text{Use 820 } \Omega$$

C1 is chosen to provide the pole, f_{P2} , at 100 kHz. Assuming C3 >> C1.

C1 =
$$\frac{1}{(2\pi)(f_{P2})(R4)} = \frac{1}{(6.28)(100 \times 10^3)(3000)} = 531 \text{ pF} \Rightarrow \text{Use } 470 \text{ pF}$$

Results of the compensated-loop response are shown in Figure 7.

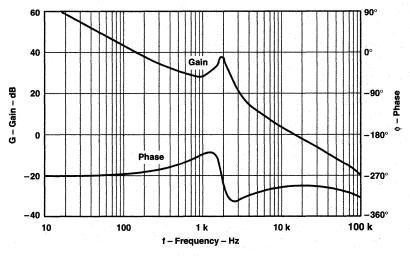
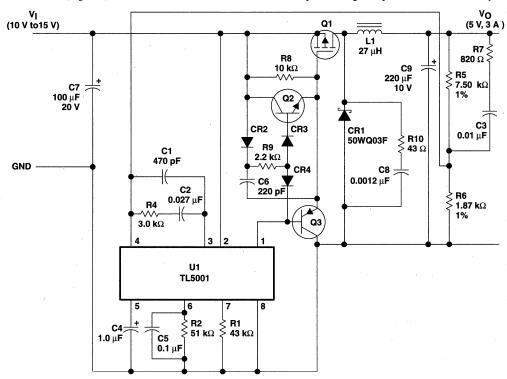


Figure 7. Compensated-Loop Response

Summary

The schematic (Figure 8), bill of materials, and test results for the completed design are provided in this summary.



Q1 - IRF9Z34S

Q2 - PMBT2222APH

Q3 - PMBT2907APH

All diodes are PMBD914PH, unless otherwise specified.

R3 - Not used

Figure 8. 12-V to 5-V at 3-A Converter

Table 1. Example 1: Bill of Materials

REF DES	PART NO.		DESCRIPTION	ON			MFG
U1	TL5001	IC, PWM Controller					Texas Instruments
C1		Capacitor, Ceramic,	470 pF,	50 V,	10%		
C2		Capacitor, Ceramic,	0.027 μ F ,	50 V,	10%		
C3		Capacitor, Ceramic,	0.01 μF,	50 V,	10%		
C4		Capacitor, Tantalum,	1.0 μF,	20 V,	10%		
C5		Capacitor, Ceramic,	0.10 μF,	50 V,	10%		
C6		Capacitor, Ceramic,	220 pF,	50 V,	10%		
C7	20SA100M	Capacitor, Aluminum,	100 μF,	20 V,	20%		Sanyo
C8		Capacitor, Ceramic,	0.0012 μF,	50 V,	10%		
C9	10SA220M	Capacitor, Aluminum,	220 μF,	10 V,	20%		Sanyo
CR1	50WQ03F	Diode, Schottky,	30 V,	5.5 A			International Rectifier
CR2-4	PMBD914PH	Diode, Switching,	100 V,	200 m/	١		
L1	T50-26B	Core, Inductor,	27 μΗ,	27 Turr	ns #22		MicroMetals
Q1	IRF9Z34S	Transistor, MOSFET,	p-ch,	60 V,	18A,	0.14 Ω	International Rectifier
Q2	PMBT2222APH	Transistor, NPN,	30 V,	150 m	\		
Q3	PMBT2907APH	Transistor, PNP,	40 V,	150 m/	١		
R1		Resistor, CF,	43 kΩ,	1/4 W,	5%		
R2		Resistor, CF,	51 kΩ,	1/4 W,	5%		
R4		Resistor, CF,	3.0 kΩ,	1/4 W,	5%	-	
R5		Resistor, MF,	7.50 kΩ,	1/4 W,	1%		
R6		Resistor, MF,	1.87 kΩ,	1/4 W,	1%		
R7		Resistor, CF,	820 Ω,	1/4 W,	5%		
R8		Resistor, CF,	10 kΩ,	1/4 W,	5%		
R9		Resistor, CF,	2.2 kΩ,	1/4 W,	5%		
R10		Resistor, CF,	43 Ω,	1/4 W,	5%		

Table 2. Example 1: Test Results

PARAMETER	TEST (CONDITIONS	MEASUREMENT		
Load regulation	V _I = 12 V,	IO = 0 ~ 3 A	0.4%		
Line regulation	I _O = 1.5 A,	V _I = 10 ~ 15 V	0.4%		
Output ripple (peak-to-peak)	V _I = 12 V,	IO = 3 A	10 mV		
Efficiency	V _I = 12 V,	IO = 3 A	81.7%		

EXAMPLE 2: 12-V to 3.3-V at 3-A STEP-DOWN CONVERTER

Design Criteria

The schematic of the final design is provided in Figure 9. This design is very similar to that in Example 1 and thus much of the detail is not repeated.

Specifications

Input voltage range, V _I	10 V to 15 V
Output voltage, VO	3.3 V
Output current, I _O	0 A to 3 A
Output ripple voltage	≤50 mV
Efficiency	>70%
Ambient temperature range, T _A	0°C to 55°C

Surface-mount components should be employed wherever feasible. The dc/dc converter is implemented with a continuous-mode, fixed-frequency-PWM step-down (buck) topology operating at 200 kHz.

Duty-Cycle Estimates

Estimate the power-switch duty cycle over the range of input voltages using:

$$D = \frac{V_O + V_d}{V_I - V_{sat}}$$

Where

 V_d = catch-rectifier conduction voltage (assume V_d = 0.6 V) V_{sat} = power-switch conduction voltage (assume V_{sat} = 0.5 V)

The results can be recalculated if actual values are too far from the initial estimate.

The duty cycle for $V_I = 10$, 12, and 15 V is 0.41, 0.34, and 0.27, respectively.

Output Filter

The output filter is a single-stage LC design.

Inductor

Choose L1 to limit the peak-to-peak ripple current to 10% of the maximum output current.

$$\Delta I_{O} = 2 \times 0.1 \times I_{O(max)} = 2 \times 0.1 \times 3 = 0.6 \text{ A peak-to-peak}$$

Inductance is given by:

$$L1 = (V_{I} - V_{sat} - V_{O}) \times D \times \frac{t}{\Delta I_{O}}$$

Maximum ripple current occurs at the maximum input voltage. Solving for L1:

L1 =
$$\frac{\left(V_{I} - V_{sat} - V_{O}\right)(D)(t)}{\Delta I_{O}} = \frac{\left(15 - 0.5 - 3.3\right)(0.27)\left(5 \times 10^{-6}\right)}{0.6} = 25.2 \ \mu H$$

For convenience, use the same inductor as in example 1; therefore, $L1 = 27 \mu H$.

Canacitor

Assuming all the inductor ripple current flows through the capacitor and ESR is negligible, calculate the capacitance needed to limit the ripple voltage to 50 mV peak-to-peak.

$$C = \frac{\Delta I_{O}}{8 \times f_{S} \times \Delta V_{O}} = \frac{0.6}{(8)(200 \times 10^{3})(0.05)} = 7.5 \ \mu F$$

Assuming the capacitance is at least 10 times greater than the calculated value, the ESR to limit the ripple to 50 mV peak-to-peak is:

$$ESR = \frac{\Delta V_O}{\Delta I_O} = \frac{0.05}{0.6} = 83 \text{ m}\Omega$$

The rms capacitor-ripple current is:

Capacitor current =
$$0.289 \times \Delta I_{O} = 0.289 \times 0.6 = 0.17$$
 Arms

For convenience, use the same 220- μ F, 10-V, 35- $m\Omega$ OS-CON SA-series device that was used in Example 1. Alternate choices include a 100- μ F, 16-V, 45- $m\Omega$ device in the same family but one case-size smaller, and two of the solid tantalum 100- μ F, 10-V devices described in example 1.

Power-Switch Design

The power-switch design procedure includes selecting the power switch, the catch rectifier, and the rectifier-snubbing network (if needed), calculating power dissipations and junction temperatures, and ensuring the semiconductors have proper heat sinking.

Power Switch

The surface-mount p-channel device used in Example 1 should work in this design also. The IRF9Z34S has a 60-V drain-to-source breakdown and a 140-m Ω maximum $r_{DS(0n)}$ with a 10-V gate drive.

Assume that the worst-case junction temperature is 125°C in a 55°C ambient temperature and the drive circuit provides a 100-ns total switching time (turn-on and turnoff). r_{DS(on)} increases by a factor of 1.6 at 125°C.

$$P_{D} = (3^{2})(0.14 \times 1.6)(0.41) + (0.5)(10)(3)(0.1 \times 10^{-6})(200 \times 10^{3})$$

$$P_{D} = 0.83 + 0.30 = 1.13 \text{ W}$$

The thermal impedance $R_{\theta JA} = 40^{\circ}$ C/W for FR-4 with 2-oz copper and a one-inch-square pattern.

$$T_I = T_A + (R_{\Theta IA} \times P_D) = 55 + (40 \times 1.13) = 100^{\circ}C$$

Catch Rectifier

Since the requirements are so similar, consider the same device used in Example 1, the 50WQ03F. The device is a 5.5-A, 30-V Schottky diode in a DPAK, power surface-mount package.

Worst-case dissipation occurs at high line where D is minimum. The 50WQ03F has a maximum forward drop of 0.55 V at a forward current of 3 A and a junction temperature of 125°C.

$$P_D = 3 \times 0.55 \times (1 - 0.39) = 1 \text{ W}$$

The thermal impedance R_{0JA} = 50°C/W when mounted on FR-4 with 2-oz copper and a one-inch-square pattern.

$$T_I = 55 + (50 \times 1) = 105$$
°C

Catch-Rectifier Snubber Network

The capacitor value chosen is 4 to 10 times greater than the rectifier junction capacitance; higher values improve the snubbing but dissipate more power. The 50WQ03F has a typical junction capacitance of 180 pF, and the snubber-capacitor value should be between 750 pF and 1.8 nF. Use C8 = 1.2 nF for convenience. Rectifiers normally ring in the range from 1 to 50 MHz. Choose the snubber resistor, R10, for a 50-ns time constant:

R10 =
$$\frac{50 \times 10^{-9}}{\text{C8}}$$
 = $\frac{50 \times 10^{-9}}{1.2 \times 10^{-9}}$ = 41.7 Ω \Rightarrow Use 43 Ω

Because the capacitor is charged and discharged each cycle, the power dissipation in R10 is:

$$(2)(C8)(V_1^2)(\frac{f_s}{2}) = (2)(1.2 \times 10^{-9})(15^2)(\frac{200 \times 10^3}{2}) = 54 \text{ mW}$$

Controller Design

The controller-design procedure involves choosing the components required to program the TL5001 and includes setting the oscillator frequency, dead-time control voltage, soft-start timing, and short-circuit-protection timing. The sense-divider network and loop-compensation designs are also addressed in this section.

Oscillator Frequency

Select resistor $R1 = 43 \text{ k}\Omega$ using the graph in Figure 3 to set the oscillator frequency to 200 kHz.

Dead-Time Control

The dead-time-control resistor, R2, is chosen to limit the duty cycle to approximately 0.55, well above the anticipated 0.41 maximum duty cycle. See Figure 4 to find the maximum and minimum ramp-voltage levels, $V_{O(100\%)}$ and $V_{O(0\%)}$. R2 is calculated from the following expression (R_{DT}, R_t in k Ω , D in decimal):

R2 = (R1 + 1.25)
$$\left[D\left(V_{O(100\%)} - V_{O(0\%)}\right) + V_{O(0\%)} \right]$$

where R1 and R2 are in $k\Omega$.

$$R2 = (43 + 1.25)[0.55 (1.4 - 0.6) + 0.6] = 46 \text{ k}\Omega \Rightarrow 47 \text{ k}\Omega$$

Soft-Start Timing

As in Example 1, choose $C5 = 0.1 \mu F$ to bring the output voltage into regulation in approximately 5 ms.

SCP Timing

As in Example 1, choose $C4 = 1.0 \mu F$ to set the protection enable period to approximately 75 ms.

Output Sense Network

The worst-case input bias current for the TL5001 is 0.5 μ A; therefore, the divider current should be approximately $1000 \times 0.5 \ \mu$ A = 0.5 mA. In regulation, the voltage across R6 is 1 V and the voltage across R5 is $V_O - 1 \ V = 2.3 \ V$. Choose R5 = 7.50 k Ω so that the compensation values in Example 1 can be used in this design as well.

$$I_{\text{divider}} = \frac{\left(V_{\text{O}} - 1 \text{ V}\right)}{R5} = \frac{3.3 - 1}{7.5 \times 10^3} = 0.307 \text{ mA}$$

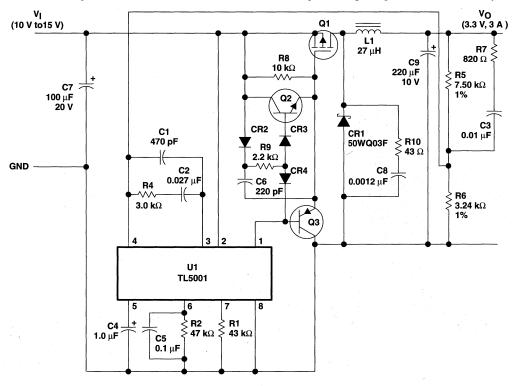
$$R6 = \frac{1 \text{ V}}{0.307 \text{ mA}} = 3.26 \text{ k}\Omega \Rightarrow \text{Use } 3.24 \text{ k}\Omega$$

Loop Compensation

Because the output-filter components, the PWM gain, and R5 are the same as in Example 1, the same compensation design can be used for this application (refer to Example 1 for details).

Summary

The schematic (Figure 9), bill of materials, and test results for the completed design are provided in this summary.



Q1 - IRF9Z34S

Figure 9. 12-V to 3.3-V at 3-A Converter

Q2 - PMBT2222APH

Q3 - PMBT2907APH

All diodes are PMBD914PH, unless otherwise specified.

R3 - Not used

Table 3. Example 2: Bill of Materials

REF DES	PART NO.		DESCRIPTI	ON			MFG
U1	TL5001	IC, PWM Controller					Texas Instruments
C1		Capacitor, Ceramic,	470 pF,	50 V,	10%		
C2		Capacitor, Ceramic,	0.027 μF,	50 V,	10%		
СЗ		Capacitor, Ceramic,	0.01 μF,	50 V,	10%		
C4		Capacitor, Tantalum,	1.0 μF,	20 V,	10%		
C5		Capacitor, Ceramic,	0.10 μ F ,	50 V,	10%		
C6		Capacitor, Ceramic,	220 pF,	50 V,	10%		
C7	20SA100M	Capacitor, Aluminum,	100 μF,	20 V,	20%		Sanyo
C8		Capacitor, Ceramic,	0.0012 μF,	50 V,	10%		
C9	10SA220M	Capacitor, Aluminum,	220 μF,	10 V,	20%		Sanyo
CR1	50WQ03F	Diode, Schottky,	30 V,	5.5 A			International Rectifier
CR2-4	PMBD914PH	Diode, Switching,	100 V,	200 m/	١		
L1	T50-26B	Core, Inductor,	27 μΗ,	27 Turr	ıs #22		MicroMetals
Q1	IRF9Z34S	Transistor, MOSFET,	p-ch,	60 V,	18A,	0.14 Ω	International Rectifier
Q2	PMBT2222APH	Transistor, NPN,	30 V,	150 m/	1		
Q3	PMBT2907APH	Transistor, PNP,	40 V,	150 m/	\		
. R1		Resistor, CF,	43 kΩ,	1/4 W,	5%		
R2		Resistor, CF,	47 kΩ,	1/4 W,	5%		
R4		Resistor, CF,	3.0 kΩ,	1/4 W,	5%		
R5		Resistor, MF,	7.50 kΩ,	1/4 W,	1%		
R6		Resistor, MF,	3.24 kΩ,	1/4 W,	1%		
R7		Resistor, CF,	820 Ω,	1/4 W,	5%		
R8	4	Resistor, CF,	10 kΩ,	1/4 W,	5%		
R9		Resistor, CF,	2.2 kΩ,	1/4 W,	5%		
R10		Resistor, CF,	43 Ω,	1/4 W,	5%		

Table 4. Example 2: Test Results

PARAMETER	TEST	MEASUREMENT	
Load regulation	V _I = 12 V,	I _O = 0 ~ 3 A	0.7%
Line regulation	I _O = 1.5 A,	V _I = 10 ~ 15 A	0.9%
Output ripple (peak-to-peak)	V _I = 12 V,	I _O = 3 A	8 mV
Efficiency	V _I = 12 V,	I _O = 3 A	74.7%

EXAMPLE 3: 5-V to 3.3-V at 0.75-A STEP-DOWN CONVERTER

Design Criteria

The schematic of the final design is provided in Figure 13. Example 1 gives a more detailed explanation of the same design procedure used in this section.

Specifications

Input voltage range, V _I	4.75 V to 5.25 V
Output voltage, VO	3.3 V
Output current, I _O	. 0 A to 0.75 A
Output ripple voltage	≤50 mV
Regulation	1%
Efficiency	>70%
Ambient temperature range, T _A	-20°C to 65°C

Surface-mount components should be employed wherever feasible. The dc/dc converter is implemented with a continuous-mode, fixed-frequency-PWM step-down (buck) converter operating at 200 kHz.

Duty-Cycle Estimates

Estimate the power-switch duty cycle over the range of input voltages using:

$$D = \frac{V_O + V_d}{V_I - V_{sat}}$$

Where

 V_d = catch-rectifier conduction voltage (assume V_d = 0.5 V) V_{sat} = power-switch conduction voltage (assume V_{sat} = 0.25 V)

The results can be recalculated if actual values are too far from the initial estimate.

The duty cycle for $V_I = 4.75$, 5, and 5.25 V is 0.84, 0.80, and 0.76, respectively.

Output Filter

The output filter is a single-stage LC design.

Inductor

Choose L1 to maintain continuous-mode operation to 20% of the rated output current.

$$\Delta I_{O} = 2 \times 0.2 \times I_{O(max)} = 2 \times 0.2 \times 0.75 = 0.3$$
 A peak-to-peak

The inductor value is calculated using

$$L1 = \frac{\left(V_{I} - V_{sat} - V_{O}\right)DTs}{\Delta I_{O}}$$

where Ts is the period of the converter operating frequency.

Maximum ripple current occurs at the maximum input voltage. Solving for L1:

L1 =
$$\frac{(5.25 - 0.25 - 3.3)(0.76)(5 \times 10^{-6})}{0.3}$$
 = 21.5 µH

Use $L1 = 20 \,\mu\text{H}$ (Coiltronics CTX20-1, 1.15 A dc-current rating, surface-mount package). Using the new value for L1, ΔI_O is recalculated:

$$\Delta I_{O} = \frac{\left(V_{I} - V_{sat} - V_{O}\right)DTs}{L1} = \frac{(5.25 - 0.25 - 3.3)(0.76)\left(5 \times 10^{-6}\right)}{20 \times 10^{-6}} = 323 \text{ mA peak-to-peak}$$

Capacitor

Assuming all the inductor ripple current flows through the capacitor and ESR is zero, the capacitance needed to limit the ripple voltage to 50 mV peak-to-peak is:

$$C = \frac{\Delta I_{\mbox{\scriptsize O}}}{8 \times f_{\mbox{\scriptsize s}} \times \Delta V_{\mbox{\scriptsize O}}} = \frac{0.323}{(8) \left(200 \times 10^3\right) (0.05)} = 4.04 \ \mu \mbox{\scriptsize F}$$

If the capacitance is at least ten times greater than the calculated value, the ESR to limit the ripple to 50 mV peak-to-peak is:

ESR =
$$\frac{\Delta V_{O}}{\Delta I_{O}} = \frac{0.05}{0.323} = 155 \text{ m}\Omega$$

Capacitor ripple current is seldom a problem in low-voltage converters unless a large number of devices are paralleled. However, the capacitor current is calculated as follows:

$$I_{rms} = 0.289 \times \Delta I_{O} = 0.289 \times 0.323 = 0.093 \text{ Arms}$$

The output filter capacitor(s) should provide at least ten times the calculated minimum capacitance and an ESR 30% to 50% lower than the calculated maximum to provide some margin for ESL, PCB leads, temperature, and aging. The 200-kHz, 85°C ripple current should be 0.25 Arms or greater, and the voltage rating should be at least 6.3 V.

For this case, a 100- μ F, 10-V tantalum electrolytic with an ESR of 0.100 Ω maximum was chosen.

Power-Switch Design

The power-switch design procedure includes selecting the power switch, the catch rectifier, and the rectifier-snubbing network (if needed); calculating power dissipations and junction temperatures; and ensuring the semiconductors have proper heat sinking.

Power Switch

This design uses a p-channel MOSFET to simplify the drive-circuit design and minimize component count. Based on the preliminary estimate, $r_{DS(on)}$ should be less than 0.25 V + 0.75 A = (333 m Ω) with a 5-V gate drive and a drain-to-source breakdown voltage appropriate for a 5-V supply. A low gate-to-source threshold voltage and surface-mount packaging are also desirable.

The TPS1101D is a 15-V p-channel MOSFET in an SO-8 package with $r_{DS(on)} = 0.19 \text{ m}\Omega$ maximum, with a 4.5-V gate drive.

$$P_D = I_O^2 \times r_{DS(on)} \times D + 0.5 \times V_I \times I_O \times t_{r+f} \times f_S$$

Where t_{r+f} = total MOSFET switching time (turn-on and turnoff) and $r_{DS(on)}$ is adjusted for temperature. Assuming the drive circuit is adequate for t_{r+f} = 100 ns and the junction temperature is 100°C with a 65°C ambient, the adjustment factor is 1.3 and $r_{DS(on)}$ = 1.3 × 0.19 = 0.25.

$$\begin{split} & P_{\rm D} = \left[\left(0.75^2 \right) (0.25) (0.80) \right] + \left[(0.5) (5) (0.75) \left(0.1 \times 10^{-6} \right) \left(200 \times 10^3 \right) \right] \\ & P_{\rm D} = 113 + 38 = 151 \text{ mW} \end{split}$$

The thermal impedance $R_{\theta IA} = 158^{\circ}$ C/W for FR-4 with no special heat-sinking considerations.

$$T_J = T_A + (R_{\theta JA} \times P_D) = 65 + (158 \times 0.151) = 89^{\circ}C$$

Catch Rectifier

The power dissipation in this design is very low because of a relatively low output-current requirement and the high-power-switch duty cycles. Consequently, a small surface-mount Schottky device such as the MBRS 140T3 is more than adequate. The MBRS 140T3 is rated for 1 A of forward current and a 40-V breakdown. The conduction drop, V_d , is 0.35-V at 1-A forward current and a 100°C junction. The power dissipation is:

$$P_D = I_O \times V_d \times (1 - D)$$

 $P_D = 0.75 \times 0.35 \times (1 - 0.76) = 63 \text{ mW}$

In the absence of thermal-impedance data for this package with FR-4 mounting, a reasonable estimate of junction temperature is not practical. However, some assurance can be derived from considering the thermal impedance necessary to limit the junction to 100° C which is comfortably below the 125° C maximum rating. The thermal impedance, $R_{\theta JA}$, needed to raise the junction temperature from the 65° C ambient to 100° C with 63 mW of dissipation is:

$$R_{\theta JA} = \frac{T_J - T_A}{P_D} = \frac{100 - 65}{0.063} = 556^{\circ} \text{C/W}$$

There should be no problem since even signal diodes are in the 300°C to 400°C/W range. Some preliminary testing to establish thermal performance is highly recommended for applications where the margins are lower.

Controller Design

The controller-design procedure involves choosing the components required to program the TL5001 and includes setting the oscillator frequency, dead-time control voltage, soft-start timing, and short-circuit-protection timing. The sense-divider network and loop-compensation designs are also addressed in this section.

Oscillator Frequency

From the graph in Figure 3, choose $R2 = 43 \text{ k}\Omega$ to set the oscillator frequency to 200 kHz.

Dead-Time Control

The maximum duty cycle in this application is 84% and because there is no benefit in limiting the duty cycle a few points below 100%, the dead-time control resistor is omitted.

Soft-Start Timing

The DTC input can be used to soft start the converter even though dead-time control is not implemented. The soft-start capacitor is charged with a constant current approximately equal to the current flowing from the RT terminal. The output voltage should be in regulation by the time C5 has charged to 1.4 V. Choose C5 such that the output voltage comes up in 6 ms.

Charging current =
$$\frac{1}{43} \frac{V}{k\Omega} = 23.3 \mu A$$

C5 = $\frac{\left(23.3 \times 10^{-6}\right)\left(6 \times 10^{-3}\right)}{1.4} = 0.1 \mu F$

SCP Timing

As in Example 1, choose C4 = 1 μ F to set the protection enable period to approximately 75 ms.

Output Sense Network

The worst-case input bias current for TL5001 is 0.5 μ A; therefore, the divider current should be approximately $1000 \times 0.5 \,\mu$ A = 0.5 mA. In regulation, the voltage across R6 is 1 V and the voltage across R5 is V_O – 1 V = 2.3 V. For this design, R5 is set at 7.50 k Ω .

$$I_{\text{divider}} = \frac{\left(V_{\text{O}} - 1 \text{ V}\right)}{R5} = \frac{3.3 - 1}{7.5 \times 10^3} = 0.307 \text{ mA}$$

$$R6 = \frac{1 \text{ V}}{0.307 \text{ mA}} = 3.26 \text{ k}\Omega \Rightarrow \text{Use } 3.24 \text{ k}\Omega$$

Loop Compensation

Refer to Example 1 for more detailed explanation.

The open-loop response without the error amplifier consists of the gain of the PWM/power switch, A_{PWM} , and the output filter response. The gain, A_{PWM} , is:

$$A_{PWM} = \frac{\Delta V_{O}}{\Delta V_{O(COMP)}} = \frac{(5-0)}{(1.4-0.6)} = 6.25 \Rightarrow 15.9 \text{ dB at nominal input}$$

Similarly, the gain is 15.5 dB at low line and 16.3 dB at high line.

The output filter produces an underdamped complex-pole pair at the filter's resonant frequency, and the capacitor ESR puts a zero in the response above the resonant frequency. The complex poles are located at:

$$\frac{1}{2 \pi \sqrt{LC}} = \frac{1}{2 \pi \sqrt{(20 \times 10^{-6})(100 \times 10^{-6})}} = 3.56 \text{ kHz}$$

The zero is located at:

$$\frac{1}{2\pi R_S C} = \frac{1}{(2\pi)(0.1)(100 \times 10^{-6})} = 15.9 \text{ kHz}.$$

Figure 10 includes gain and phase plots of the open-loop response (error amplifier not included) obtained from a simple SPICE simulation.

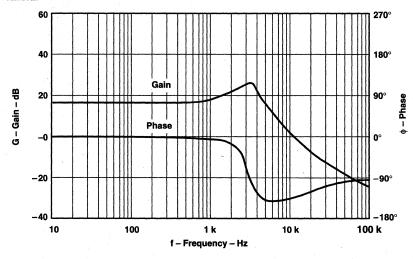


Figure 10. Uncompensated Open-Loop Response

Choose a unity-gain frequency of approximately 20 kHz to provide good transient response. Figure 11 shows a standard compensation network chosen for this example.

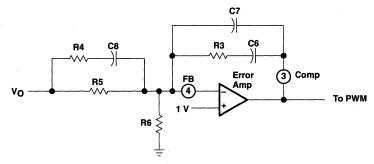


Figure 11. Compensation Network

Assuming an ideal amplifier, the transfer function is:

$$A_{ea}(S) = -\left[\frac{1}{S \ R5(C6 + C7)}\right] \left[\frac{[S(R5 + R4) \ C8 + 1] \ (S \ R3 \ C6 + 1)}{(S \ R4 \ C8 + 1) \left[S \ R3 \ (C6 \parallel C7) + 1\right]}\right]$$

The integrator gain, $1/[R5 \cdot (C6 + C7)]$, is used to set the open-loop unity-gain frequency. The zeros are located at approximately the same frequency as the output-filter poles to compensate for the gain reduction and phase shift. The pole at $1/(2\pi \cdot R4 \cdot C8)$ is positioned at approximately the same frequency as the zero in the output filter to maintain the 20 dB-per-decade roll-off in the gain response. The final pole at $1/(2\pi \cdot R3 \cdot C6 \parallel C7)$ is placed between half the operating frequency and the operating frequency to minimize noise at the pulse-width-modulator input.

The sum of the gains of the modulator, the LC filter, and the error amplifier is $0\,dB$ at the unity-gain frequency. The gain of the modulator/LC filter at $20\,kHz$ may be calculated or obtained from a bode plot using straight-line approximations or from a simple SPICE simulation. As shown in Figure 10, the modulator/LC filter gain is $-8\,dB$ at $20\,kHz$.

The compensation network has two zeros at 3.6 kHz to cancel out the LC filter poles. These two zeros contribute a gain of 29 dB at 20 kHz; therefore, the gain contributed by the compensation-network integrator needs to be -21 dB [0 - (-8 + 29) = -21]. The integrator gain of -21 dB translates to a voltage gain of 0.089.

$$\frac{1}{(2\pi)(f_T)(R5)(C6 + C7)} = 0.089 \text{ (at } f_T = 20 \text{ kHz)}$$

$$C6 = \frac{1}{(2\pi)(f_T)(R5)(0.089)} = \frac{1}{(6.28)(20 \times 10^3)(7.5 \times 10^3)(0.089)} = 0.0119 \text{ } \mu\text{F} \Rightarrow \text{Use } C6 = 0.012 \text{ } \mu\text{F}.$$

R3 is chosen to position a zero at 3.6 kHz.

$$R3 = \frac{1}{(2\pi)(f)(C6)} = \frac{1}{(6.28)(3.6 \times 10^3)(0.012 \times 10^{-6})} = 3.69 \text{ k}\Omega \Rightarrow \text{Use } 3.6 \text{ k}\Omega$$

R4 and C8 are chosen to provide an additional zero, fz, at 3.6 kHz and a pole, fp, at 15.9 kHz.

$$C8 = \frac{\frac{1}{f_Z} - \frac{1}{f_P}}{(2\pi)(R5)} = \frac{\left[\frac{1}{3.6 \times 10^3} - \frac{1}{15.9 \times 10^3}\right]}{(6.28)(7.5 \times 10^3)} = 0.0046 \ \mu\text{F} \Rightarrow \text{Use } C8 = 0.0047 \ \mu\text{F}$$

$$R4 = \frac{1}{(2\pi)(f_P)(C8)} = \frac{1}{(6.28)(15.9 \times 10^3)(0.0047 \times 10^{-6})} = 2.13 \ \text{k}\Omega \Rightarrow \text{Use } 2.0 \ \text{k}\Omega$$

C7 is chosen to provide the pole at 100 kHz. Assuming C6 >> C7,

C7 =
$$\frac{1}{(2\pi)(f_p)(R3)}$$
 = $\frac{1}{(6.28)(100 \times 10^3)(3600)}$ = 442 pF \Rightarrow Use 470 pF

Results of the compensated-system response are shown in Figure 12.

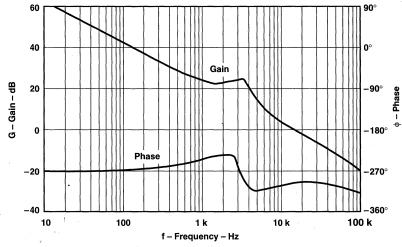
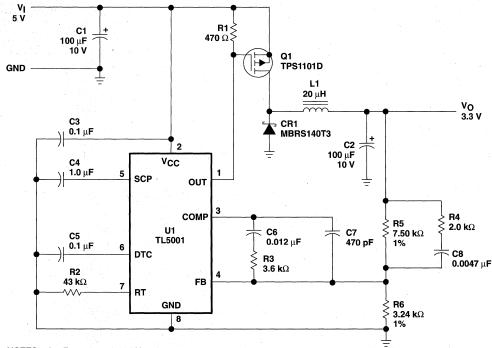


Figure 12. Compensated-Loop Response

Summary

The schematic (Figure 13), bill of materials, and test results for the completed design are provided in this summary.



NOTES: A. Frequency = 200 kHz

- B. Duty cycle = 100% MAX
- C. Soft-start timing = 6 ms
- D. SCP timing = 75 ms

Figure 13. 5-V to 3.3-V/0.75-A Converter

Table 5. Example 3: Bill of Materials

REF DES	PART NO.	Di	DESCRIPTION				
U1	TL5001	IC, PWM Controller				Texas Instruments	
C1, C2	TPSD107M010R0100	Capacitor, Tantalum,	100 μF,	10 V,	20%	AVX	
C4		Capacitor, Ceramic,	1.0 μ F ,	50 V,	10%		
C3, C5		Capacitor, Ceramic,	0.1 μF,	50 V,	10%		
C6		Capacitor, Ceramic,	0.012 μF,	50 V,	10%		
C7		Capacitor, Ceramic,	470 pF,	50 V,	10%		
C8		Capacitor, Ceramic,	0.0047 μF,	50 V,	10%		
CR1	MBRS140T3	Diode, Schottky,	20 V,	1 A	*	Motorola	
L1	CTX20-1	Inductor, Toroid,	20 μΗ			Coiltronics	
Q1	TPS1101D	Transistor, MOSFET,	p-ch,	15 V,	0.19 Ω	Texas Instruments	
R1		Resistor, CF,	470 Ω,	1/4 W,	5%		
R2		Resistor, CF,	43 kΩ,	1/4 W,	5%		
R3		Resistor, CF,	3.6 kΩ,	1/4 W,	5%		
R4		Resistor, CF,	2.0 kΩ,	1/4 W,	5%		
R5		Resistor, MF,	7.50 kΩ,	1/4 W,	1%		
R6		Resistor, MF,	3.24 kΩ,	1/4 W,	1%		

Table 6. Example 3: Test Results

PARAMETER	TEST CONDITIONS	MEASUREMENT
Load regulation	V _I = 5 V, I _O = 0 ~ 750 mA	1.4%
Output ripple (peak-to-peak)	I _O = 750 mA	<20 mV
	$V_1 = 5 \text{ V}$, $I_0 = 750 \text{ mA}$, $Q1 = SIS$	9405 74.4%
Efficiency	V _I = 5 V, I _O = 750 mA, Q1 = TP	S1101 84.1% [†]

[†] The higher efficiency achieved with the TPS1101 is due to lower gate capacitance, which speeds up switching and reduces switching loss.

Appendix A 5-V Prototype-Board Waveforms

The following photos were taken using the 12-V to 5-V prototype breadboard that was designed and documented as presented in the first section of this application report. The results are typical of those seen on the other designs in this paper.

Minimum Dead Time (maximum duty cycle)

The dead time of the output switch was measured with the feedback resistance disconnected.

Vertical: 2 V/div Horizontal: 1 µs/div Coupling: dc

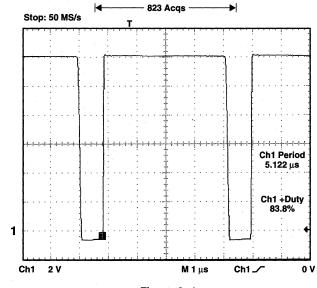


Figure A-1

Output Switch Drain to Ground Voltage

The input of the low-pass output filter is shown in Figure A–2. The high-level voltage is equal to the input voltage minus $V_{DS(on)}$. The low-level voltage is one diode drop below ground.

Vertical: 2 V/div Horizontal: 1 µs/div Coupling: dc

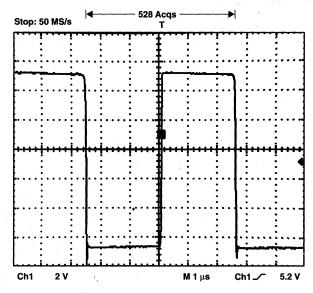


Figure A-2

Output Voltage Rise Time (electronic load)

The soft-start circuit slows the rise of the output voltage to prevent excessive overshoot.

Vertical: 1 V/div Horizontal: 2 ms/div Coupling: dc

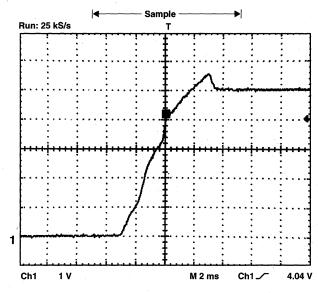


Figure A-3

Output Voltage Rise Time (resistive load)

This photo shows the response to a resistive load.

Vertical: 1 V/div Horizontal: 2 ms/div Coupling: dc

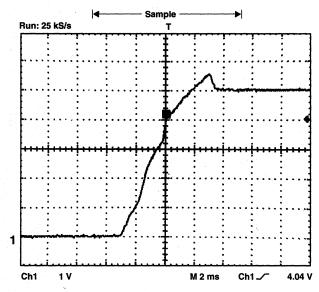
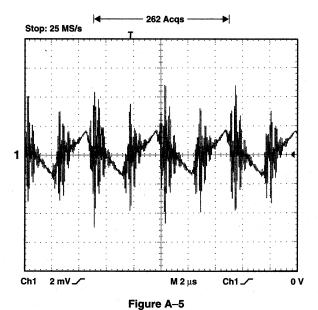


Figure A-4

Output Voltage Ripple

The output ripple is shown in Figure A-5. The triangular-shaped ripple is clearly a function of the ESR of the output capacitor.

Vertical: 2 mV/div Horizontal: 2 μs/div Coupling: ac



Output Dynamic Response

The response of the output to step-load changes is shown in Figure A-6. The electronic load was stepped from 1.5 A to 3 A.

Top Waveform: V_O
Vertical: 100 mV/div

Horizontal: 0.5 ms/div Coupling: ac Bottom Waveform: I_O Vertical: 1 A/div

Horizontal: 0.5 ms/div

Coupling: dc

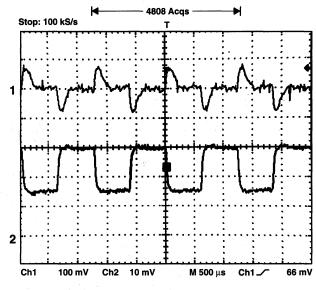


Figure A-6

Acknowledgement

This application report is the synergistic result of many individual efforts. The work involved included characterization of the controller chip; design, breadboarding, and debugging of application examples; and preparation of the report itself. Every effort has been made to provide a document that is useful and understandable to the customer/designer. The following list, though not all inclusive, represents the major contributors to this document:

Co-authors and Engineering

Bill Johnston, Power Supply Systems Engineering Manager Philip Rogers, Power Supply Systems Engineer John Vincent, Vincent Enterprises, Consultant

Documentation

Ron Eberhart, Technical Writer Fran Caldwell, Publications Specialist/Formatter Jim Schrader, Technical Illustrator

Proofreading and Suggestions

Kazu Kudoh, Product Specialist Jeff Hooker, Product Specialist Bob Newton, Product Specialist Rob Saunier, Applications Engineer

Component Selection and PCB Layout Guidelines for Low-Power DC/DC Converters

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Component Selection Guidelines

Due to the wide variation in current levels in the typical power supply, the range of size of the components is usually extensive. Even in low-power dc-to-dc converters the power switch, rectifier, and output capacitor may range from very small surface-mounted parts to D-Pak size. The inductor is usually the largest component in low-power situations and determines the overall size of the supply.

Output-Filter Inductor

The key parameters to consider in selecting an inductor for an output filter application are inductance, continuous and peak current ratings, series resistance (DCR), and packaging. The inductance and current rating requirements are determined during the electrical design and depend heavily on:

- Input and output voltages, output current
- Converter topology
- Operating frequency
- Operating mode (continuous or discontinuous)
- Designer's preference

Inductance decreases as current increases in all inductors, but the slope and frequency onset of this decrease varies depending upon the core material, air gaps, and ac flux. Some inductors hold a relatively constant value out to a point where the inductance suddenly collapses, while others decrease slowly and continually over a wide range. Even within families of cores, the change in inductance over frequency with a change in permeability can be great. Inductance in ferrites is largely unaffected by ac flux. Some iron powder materials are strongly affected by ac flux changes that cause large inductance increases at higher flux levels. To ensure adequate performance, design the inductor for the peak current and at the lowest operating frequency. Pulse width modulator (PWM) tolerances can be 15% or more before considering the external timing component tolerances.

The series resistance (DCR) must be low enough to limit the heat rise to acceptable levels. The resistance of copper increases with temperature and can cause a degenerating condition on the output. Heat rise in inductors is hard to calculate; the easiest way to determine this is to use the manufacturers recommended current ratings at maximum temperature. The DCR may have to be lower than that necessary for heat rise in order to meet the efficiency and regulation specifications at low line.

Core losses are generally low enough that they do not cause a thermal problem in these applications except at high operating frequencies and at high ripple current.

Magnetic component manufacturers offer a wide range of off-the-shelf inductors suitable for dc/dc converters, some of which are surface mountable. There are many types of inductors available; the most popular core materials are ferrites and powdered iron. Bobbin or rod-core inductors are readily available and inexpensive, but care must be exercised in using them because they are more likely to cause noise problems than are other shapes. Custom designs are also feasible, provided the volumes are sufficiently high.

Output-Filter Capacitor

Unless the converter is to be subjected to large load transients, the filter capacitor is chosen to limit the output ripple voltage to specification levels. Most low-power converters utilize single-stage filter designs.

The filter capacitor passes most (ideally all) the ac components of the inductor current and the impedance must be low enough to limit the ripple voltage. The impedance consists of a capacitance in series with a resistance (equivalent series resistance, ESR) and an inductance (equivalent series inductance, ESL), and depending on the capacitor technology, the overall impedance is dominated by either the capacitance or the ESR at the frequencies of interest. Besides impedance, the voltage rating must be greater than the maximum output voltage and the ripple current must be within ratings.

Four capacitor technologies, low-impedance aluminum, organic semiconductor, solid tantalum, and multi-layer ceramic, are suitable for low-cost commercial applications. Low-impedance aluminum electrolytics are the lowest cost and offer high capacitance in small packages, but the ESR is higher than the other three. Organic semiconductor electrolytics, such as the Sanyo OS-CON series, have become very popular for the power-supply industry in recent years. These capacitors offer the best of both worlds — a low ESR that is stable over the temperature range and high capacitance in a small package. Most of the OS-CON units are supplied in lead-mounted radial packages; surface-mount devices are available but some of the size and performance advantage is sacrificed. Solid tantalum chip capacitors and ceramic capacitors are probably the best choices if a surface-mounted device is an absolute must. Products such as the AVX TPS family and the Sprague 593D family were developed for power-supply applications. These products offer a low ESR that is relatively stable over the temperature range, high ripple-current capability, low ESL, surge-current testing, and a high ratio of capacitance to volume.

Now, high-capacitance multilayer-ceramic capacitors are available. These have very low ESR (less than 5 m Ω), but the capacitance tolerance is very broad (typically +80% to -20% and varies with bias). In addition, the larger values (22 μ F and larger) have ESL problems that must be considered in use. The ESR is so low that the resulting zero in the loop response generally can be ignored, but the capacitance is too variable to rely on for the output filter response and should be paralleled with another more stable, higher ESR capacitor. Wide variations in the output capacitance affects the open loop filter poles and makes the power supply more sensitive to external factors. When using 22- μ F or greater ceramic, it is recommended that a 0.47- μ F capacitor or larger be used in parallel to reduce the effects of the internal ESL.

Input-Filter Capacitor

Input filters supply the surge current needed during the power-switch on time. They must supply the current without significant voltage droop for the maximum turn-on time. In addition, the current surge when the input voltage is applied must be considered. Buck and buck-derived configurations have a step function input current waveform with large harmonic content. Boost and flyback regulators have triangular or ramp waveforms. These instantaneous step changes require large surge capability. Low ESR capacitors allow a much greater surge than high-ESR capacitors. Tantalum capacitors do not tolerate this surge and so should not be used in input filter applications. Aluminum electrolytics are excellent here due to their large capacitance-to-volume ratio and surge current capabilities. For surface mount, ceramics work well and their low ESR prevents the input voltage from having a voltage step.

Power Switches

Many converters can be implemented with bipolar or MOSFET transistors as the power switch. Bipolars are inexpensive and can perform well in low-voltage applications, but designing a drive circuit to realize the performance is not a trivial effort. Furthermore, complex base-drive schemes can eliminate much, if not all, of the cost advantage. MOSFETs offer the fast switching times required for high-frequency operation, using relatively simple, low-component-count gate-drive circuits.

Output Rectifiers

The output rectifier is critical to good converter performance. Rectifier conduction losses are generally a significant percentage of the total converter dissipation, and either high-conduction loss or poor-switching performance increases dissipation in other components. The key parameters to consider in selecting the rectifier include the:

- Current rating
- Voltage breakdown
- Forward voltage drop
- Switching speed

- Junction capacitance
- Thermal resistance
- Packaging

After voltage rating, the primary concern is usually power dissipation, either to ensure that the rectifier operates within its junction temperature rating or to optimize the overall converter efficiency. A low forward voltage drop reduces power dissipation that minimizes the use of heatsinks to maintain junction temperature to acceptable levels and optimizes power converter efficiency. Fast switching speeds are essential to minimize dissipation. Schottky rectifiers are popular choices in low-power, low-voltage applications for their characteristic low forward drop and fast switching.

Current rating is a secondary concern for most designs. Typically, the device required to limit dissipation to acceptable levels has a current rating that is a factor of two or more greater than the application requires.

The breakdown voltage rating must at least equal the maximum input voltage in buck converters and the output voltage in boost converters. Some margin for the voltage surges, spikes, and ringing typically encountered in practical applications is also advisable.

Low junction capacitance minimizes component size and power dissipation in snubbing networks.

Rectifiers are readily available in a wide range of packages for both lead and surface mount applications. The surface mount packages tend to perform better than the lead mounts due to the reduced parasitics; however, they are harder to heatsink when external heatsinking is required at higher power levels.

The output rectifier can be replaced with a low R_{DS(on)} MOSFET (synchronous rectifier) in applications where efficiency overrides cost concerns.

Snubber Network

Converters almost universally suffer from ringing on the voltage waveform at the node where the power-switch, output inductor, and rectifier are connected. The ringing results from driving parasitic inductances and capacitances with fast rise-time waveforms and ranges in severity from objectionable to unacceptable depending on component selection and printed-circuit board (PCB) layout. A series RC-snubber network in parallel with the rectifier is the simplest way to minimize the problem. Since deleting components from a PCB layout is usually easier than adding them, the safest strategy is to include the network in the initial design and delete it, if it is not needed.

High frequency ceramic or film capacitors and film resistors should be selected for snubber applications; avoid wire-wound resistors because they tend to be inductive.

PCB Layout Considerations

Electrical design is only half the work in the creation of a reliable power supply. Unlike digital circuits, power circuits handle a broad range of currents — from the microampere control current to the tens (or hundreds) of amperes flowing in the power stage. The production of clean output power with minimal noise depends critically upon PCB layout. Power supply circuits also produce high-frequency signals that may cause many problems within the load or the source if not properly handled. Even though a power supply can operate at 50 kHz to 500 kHz, the switching edges can have rise and fall times in the order of 10 ns or faster, correlating to frequencies of up to 100 MHz. Without proper layout, radiation can be a major problem. Proper layout techniques generally include minimizing high-current loops within the power stage, proper grounding of the control stage, and proper sizing of the traces to adequately handle the peak currents. Ground planes are useful but cannot solve every problem. The control of current flow within the supply is more important.

Magnetic coupling between adjacent circuitry is a major source of noise pickup. The magnetic field produced by a current is proportional to the area of the loop in which it circulates. Thus, noise coupling can be greatly reduced by minimizing the loop areas.

A ground plane is extremely useful in satisfying this goal. On thru-hole boards, a top-surface ground plane with strategic cutouts to control the flow of output currents and control-section currents is ideal. Surface-mount boards usually have minimal top-surface area for a ground plane.

Other points to consider during the PCB layout process are selection of the proper components, separation of the ground plane to reduce cross-conduction, snubbers on the commutation/output rectifiers, proper placement of EMI suppressing components to reduce noise pickup/transmission, and thermal considerations.

Power Stage Considerations

The power stage includes the low-pass output filter, the power switch, and the input filter. It contains very high circulating currents and, therefore, should be given the highest priority when laying out the PCB. Figure 9–1 shows the current paths for a typical buck converter. The charging (forward) current, I₁, flows through the input capacitor, the power switch, and the inductor before splitting between the output capacitor and the load. The inductor discharge (commutating) current, I₂, flows through the commutating diode and the inductor, then to the output capacitor and the load. The peak value of these currents is the same. The paths for these currents should be as short as possible.

The input filter capacitor should be close to the power switch and the commutating rectifier. In buck regulators, the input current waveform from the input capacitor to the power switch is a step function. This contains large harmonics that are difficult to filter out. The closer that the input filter is to the power switch, the less the radiation. Flyback regulators have a ramp input waveform that has a high-frequency trailing edge.

Next in priority, due to its relatively high current level, is the drive circuit for the power stage. It should be placed as close to the power switch as possible. The power switch generally has a large input capacitance associated with its gate. High peak currents achieve the very fast rise and fall times required for high efficiency. If the gate lead trace is longer than approximately 2 inches, a small (approximately 10 Ω) resistor should be placed in the trace near the FET to damp the LC tank formed by the inductance of the trace and the gate capacitance of the FET. Current I_{D1} is the turn-on current that charges the gate capacitance and current I_{D2} is the turn-off current that discharges this capacitance. When using bipolar power switches, base capacitance is not a problem, but the average drive current is much higher, resulting in the same requirement for short current paths.

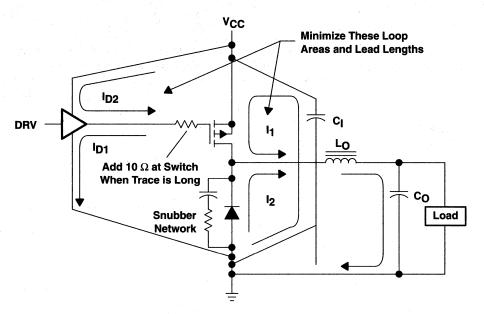


Figure 9-1. Buck Power Stage Layout Considerations

In continuous-mode boost converters, the input current is higher than the output current by the ratio of the output voltage to the input voltage divided by the efficiency. In a 5-V to 15-V, 5-ampere, 90% efficient boost converter, the current through the inductor and power switch is over 16 amps! Discontinuous-mode converters (of any type) have much higher currents than their continuous-mode counterparts.

In converters with high voltages present, such as offline switchers and in some boost or flyback converters, care must be exercised to ensure that proper isolation of the high voltage is done. Various safety standards from safety agencies (such as UL and VDE) specify the required creepage distance between high-voltage points and the user. In some cases, the effects of high-voltage transients (from startup, lightning, or static) must also be considered. Converters operating from the ac mains usually have input EMI filters. To be effective, these filters must be physically located close to the input source and laid out in a very tight configuration noting, however, that the high-voltage transients mentioned previously may be doing their best to try to bypass the filter.

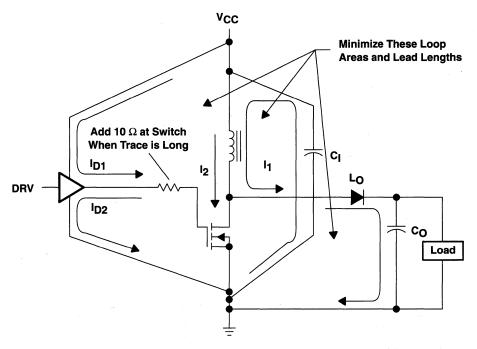


Figure 9–2. Boost Power Stage Layout Considerations

Power stage currents are dependent upon the output requirements, input voltage, and operating mode of the power supply. Figure 9–3 shows the inductor-current waveforms for a continuous-mode and a discontinuous-mode power supply with the same output current and input voltage. The peak current of the discontinuous supply is much higher and varies with duty cycle.

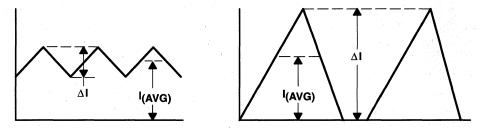


Figure 9-3. Continuous vs. Discontinuous-Mode Inductor Current

Output Stage Considerations

In a Buck regulator, the output-filter capacitor placement is not as critical as the input filter. Output current flows through the output inductor to the load. Additional trace length in this path acts as additional capacitance as long as the power and return traces are physically close to each other. The trace length from the output capacitor to the main output trace should be kept as short as possible. This minimizes the series resistance and inductance between the capacitor and the main trace. In many cases, parallel capacitors are used in the output filter to reduce the equivalent series resistance (ESR). If the capacitors are connected at equal intervals along the output path, the effective ESR of the first capacitor is much lower than the last capacitor. Care must be used in this configuration to make sure that the first capacitor in the string is not overloaded by the higher ripple current that it must conduct.

Discontinuous-mode boost regulators have large current pulses in the output capacitor. Here, the capacitor should be close to the power switch to reduce magnetic radiation.

The ideal configuration on multilayer boards is for the output and return traces to be directly over each other to minimize the enclosed loop inductance and to increase coupling capacitance. This technique can be beneficial when applied to almost any closed signal path. On single-sided boards, the optimum solution is closely-paralleled traces, see Figure 9–4.

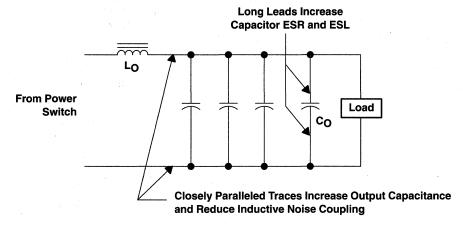


Figure 9-4. Output Layout Considerations

Controller Layout Considerations

Ground connections are very critical in the control stage of a power supply. Any voltage difference between the feedback divider ground and controller ground results in an error in the output voltage. Noise pickup in the sensing circuit is amplified and fed directly to the output. Ideally, the controller supply current should not flow through the feedback path. This is not always possible, though, and the next best choice is to have the controller referenced to the output ground as close as possible. The supply voltage should be bypassed to prevent transient currents from the controller from being propagated across the PCB. The bypass capacitor, $C_{(bp)}$, should be located as close as possible to the controller with short leads to the V_{CC} and ground terminals. Surface-mount chip capacitors mounted next to the controller give the shortest possible routing. Again, current loops should be minimized with parallel traces to reduce noise radiation and pickup.

The feedback path from the low-impedance output through the resistor divider to the high impedance operational amplifier inputs should be as short as possible and should consist of parallel paths to reduce noise pickup. The divider ground point should be close to the output ground, but more importantly, the center point of the divider should be close to the input error amplifier due to its high impedance and noise susceptibility. Sometimes breaking the ground plane into two or more sections with a single common connection point can help in keeping the high output-return current from flowing around or near the controller circuit. This technique can greatly reduce noise pickup by the sensitive controller circuitry.

Many controllers today have the driver stage built in. This compounds the problems of ground currents, especially when the driver does not have its own power ground terminal. It is even more important, in this case, to locate the controller close to the output to reduce the effects of error currents.

In both the cases discussed previously, close to the output does not imply close to the power stage. The switching elements in a modern high-frequency power supply generate large amounts of EMI that can be magnetically coupled into the high-impedance input of the controller. The further away from these elements the controller is, the harder it is for the signals to couple. In the small circuits of today, this is becoming harder to do. If at all possible keep the error amplifier and reference voltage terminals away from the power stage.

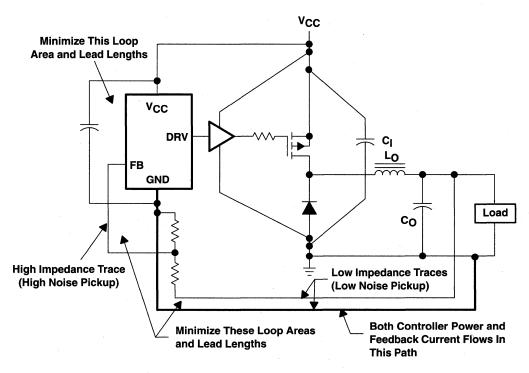


Figure 9-5. Controller Layout Considerations

Trace Width Considerations

Trace widths on a power supply board are a compromise among minimum loop area for noise reduction, maximum trace widths for low IR drops, and available board area. Outside layers of PCBs are generally available with 1-ounce and 2-ounce copper, a reference to the weight of the copper per square foot of board. Inner layers of multilayer boards can have 1/2-ounce copper. One-ounce copper is nominally 1.3435 mils or 0.0013435 inch thick. Wire is generally measured in circular mils. A circular mil is the area of a circle that is 1 mil in diameter. To convert circular mils to square mils, multiply by the factor $\pi/4$. In order to have the same current density as 20-gauge wire (1022 circular mils) using 1-ounce copper, a trace width of 597 mils is required! However, flat traces on a PCB can carry more current than the same amount on copper wire due to the greater surface area of the trace for heat radiation into the air and heat conduction onto the board itself. Good design practice limits the temperature rise on FR4 board to 20°C (MIL-STD-275C). The current flowing through the traces is derated to account for several factors. The recommended derating factors are as shown in Table 9–1.

Table 9–1. Derating Factors

Condition	Current Multiplication Factor		
Tin/lead surface or auto soldering	1.42		
Solder mask or insulating surface	1.18		
Copper thickness ≥ 3 Oz.	1.18		
Base material ≤ 0.031 in.	1.18		

The information in Table 9–2, taken from MIL-STD-275C (commercial equivalent is ANSI/IPC-D-275), shows the maximum derated current to achieve a temperature rise of 20°C or less.

Table 9–2. Maximum Derating Current for $\Delta T_A \leq 20^{\circ}C$

	· · · · · · · · · · · · · · · · · · ·
Trace Width (Inches)	Current (Amps)
0.025	2
0.075	5
0.200	10
0.440	20

The information given in Table 9–2 is the maximum recommended current. The resistance of the trace still needs to be calculated to verify that the voltage drop is satisfactory for the application.

The resistance of a 10-mil trace of one-ounce copper is 502 m Ω per inch. For any given trace width, the resistance is:

$$R = \frac{0.00502L}{WT}$$

Where:

R is the trace resistance in ohms L is the length of the trace in mils W is the width of the trace in mils

T is the copper weight of the board in ounces per square foot

Two useful variations of this formula are:

$$W \ = \ \frac{0.00502\,L}{BT} \quad \text{gives the required width in mils for a desired trace resistance}.$$

$$W \ = \ \frac{0.00502\,\text{LI}}{\text{VT}} \ \text{gives the required width in mils for a desired voltage drop.}$$

Where:

W is the width of the trace in mils
L is the length of the trace in mils
I is the current in amps
V is the voltage drop in volts
T is the copper weight of the board in ounces per square foot

Example:

When a circuit with 10 amps and a 100 mV drop is desired on a 1-inch trace, the trace width is calculated as follows:

$$W = \frac{(0.00502)(1000)(10)}{(0.1)(1)} = 502 \text{ mils using 1-ounce copper}$$

$$W = \frac{(0.00502)(1000)(10)}{(0.1)(2)} = 251 \text{ mils using 2-ounce copper}$$

$$W = \frac{(0.00502)(1000)(10)}{(0.1)(3)} = 167 \text{ mils using 3-ounce copper}$$

As can be seen in the previous example, heavier-weight copper is very useful in power supply circuits. A secondary advantage to heavy copper traces is the heat-sinking ability of copper. This can come into play when calculating the junction temperature (discussed later in this chapter). Generally, the resistance of the circuit traces should be insignificant compared with the rest of the circuit. The power stage of a converter may contain a MOSFET with less than 50 m Ω of on-resistance, an inductor with less than 100 m Ω of dc resistance (DCR) and an output capacitor with 100 m Ω of ESR. The trace resistance for this circuit should be in the order of 25 m Ω (both signal and return path) to meet this requirement.

Thermal Considerations for Surface-Mount Semiconductors

In response to system-miniaturization trends, integrated circuits are being offered in low-profile and fine-pitch surface-mount packages. Implementation of many of today's high-performance devices in these packages requires special attention to power dissipation. Many system-dependent issues such as thermal coupling, airflow, added heat sinks and convection surfaces, and the presence of other heat-generating components affect the power-dissipation limits of a given component.

Three basic approaches for enhancing thermal performance are:

- Improving the power-dissipation capability of the PCB design
- Improving the thermal coupling of the component to the PCB
- · Introducing airflow in the system

Once the power dissipated in each device is calculated, the operating junction temperature must be determined to verify a safe operating environment. Junction temperature is found using the formula:

$$T_{I} = T_{A} + (P_{D} \times R_{A,IA})$$

If the junction temperature is higher than the desired maximum, one of the three approaches listed previously can be used to reduce $R_{\theta JA}$.

Improving the power-dissipation capability generally means adding a thermal conduction plane or heatsink to the PCB. Both choices require extra board space, but can be better than adding multiple or larger devices. Heat flows from warmer surfaces to cooler surfaces. If a naturally cooler surface is available, it would be an ideal heat sink.

Increasing the thermal coupling of the component to the PCB can reduce $R_{\theta JA}$. This can be implemented by the use of thermal compound or soldering of the component to the copper.

The use of forced airflow in low-power converters is generally an undesirable solution due to the added power useage of the fan. Natural convection airflow can be enhanced by the proper placement of the components and any vents that are available. Since warm air rises, vertical surfaces tend to transmit heat to the air better than horizontal surfaces. The hottest devices should be located at the top of the board or toward the output side of the airflow so as to reduce their effect on other components.

If $R_{\theta,JA}$ cannot be reduced to a satisfactory level and power dissipation cannot be reduced, the only other alternative is to select a larger device that can dissipate the power.

Figure 9–6 is an example of a thermally enhanced layout for a surface-mount power package with graphs showing the effects of airflow and thermal conduction planes of various sizes.

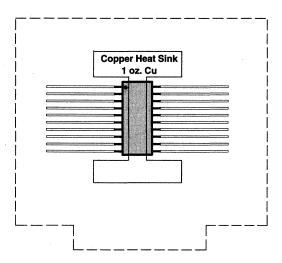
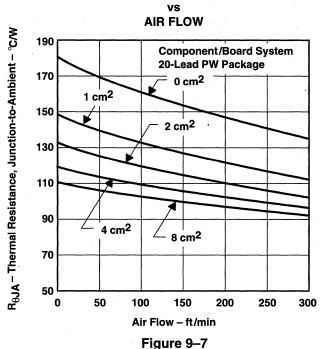


Figure 9-6. Thermally Enhanced PWB Layout (not to scale) for the 20-Pin TSSOP

THERMAL RESISTANCE, JUNCTION-TO-AMBIENT



THERMAL RESISTANCE, JUNCTION-TO-AMBIENT

vs **AIR FLOW** $R_{ heta JA}$ – Thermal Resistance, Junction-to-Ambient – °C/W 190 Component/Board System 20-Lead PW Package 170 **Includes Thermally Conductive** Compound Between Body and Board 150 0 cm² 130 8 cm² 110 4 cm² 2 cm² 1 cm² 90 70 50 50 100 150 200 250 300 Air Flow - ft/min

Example

Figure 9–9 is an example schematic and layout of a dual output regulator using the TL1454 controller chip. Using the techniques discussed in this document resulted in a regulator with very clean outputs that produced little noise.

Note that the top side ground plane (Figure 9–10) is cut into two sections to keep the return currents in the power section from flowing in the control section ground. The common point for the two sections of the ground plane is at the bypass capacitor for the controller chip. This was done because the outputs are located at opposite sides of the board. Usually, the common point should be located as close as possible to the output. Also note the short distance between the power switches Q1 and Q2 (Figure 9–11), the input capacitor C1, and the output capacitors C12 and C13. Heavy traces were used in the power section. The drive circuits were located so as to minimize the distance between the controller and the drive transistors and between the drive transistors and the power switches. In this layout the feedback traces are longer than is usually desired, but with the separated ground planes and low inductance path, this configuration worked very well. A better solution would have the feedback resistors closer to the controller.

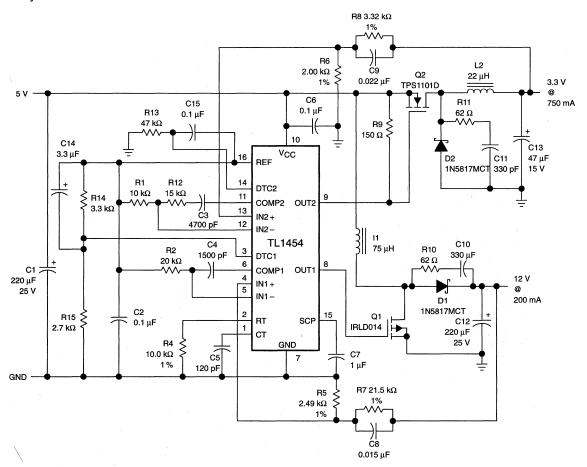


Figure 9-9. Dual Regulator Schematic

Top Side (Ground Plane)

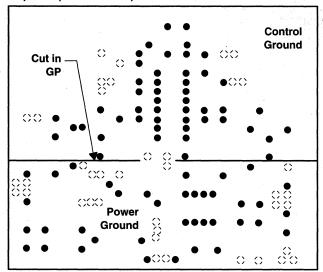


Figure 9-10. Top Side Ground Plane

Bottom Side (Top View With Top Silk Screen)

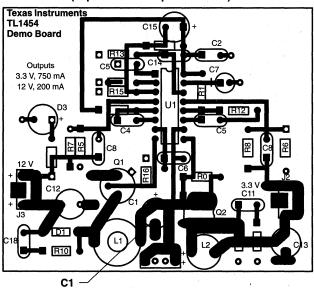


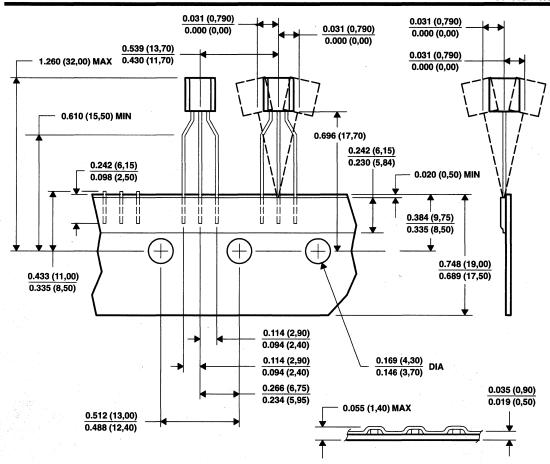
Figure 9–11. Solder Side and Component Layout

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Mechanical Data

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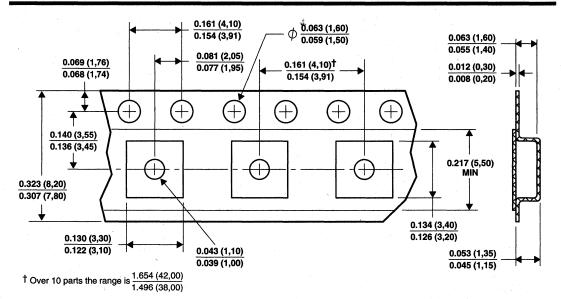
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NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

Figure 10-1. Lead Taping Detail for TO-226-A (TO-92 Package)



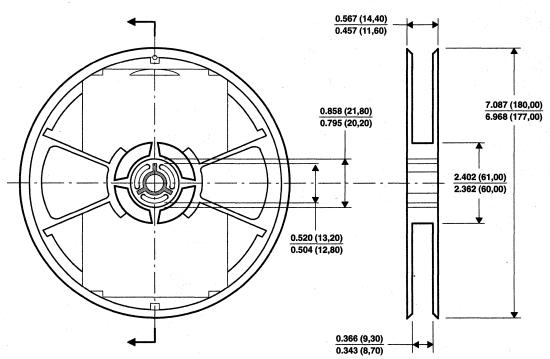
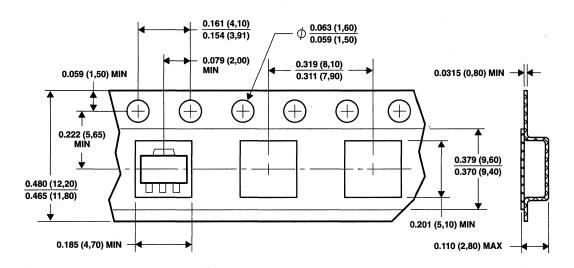


Figure 10-2. Tape and Reel Information For the SOT-23 (DBV Package)





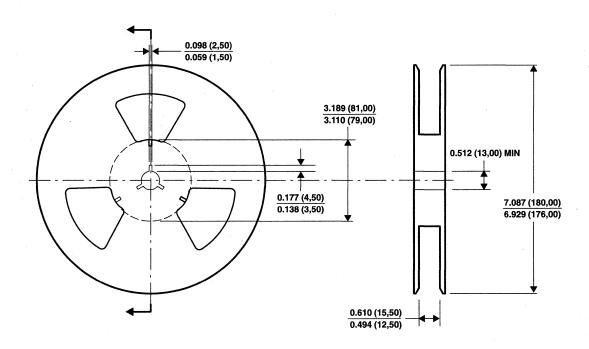


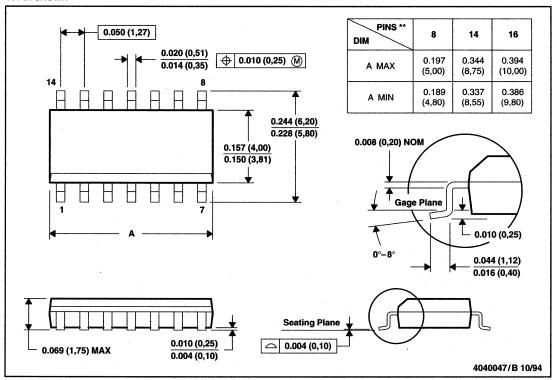
Figure 10-3. Tape and Reel Information For the SOT-89 (PK Package)



D (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PIN SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

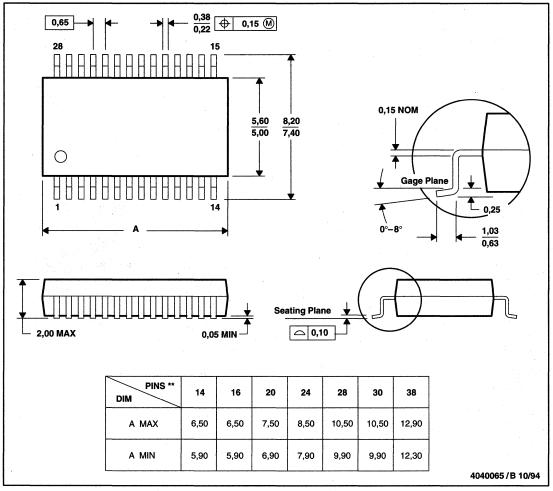
D. Four center pins are connected to die mount pad

E. Falls within JEDEC MS-012

DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

28 PIN SHOWN



NOTES: A. All linear dimensions are in millimeters.

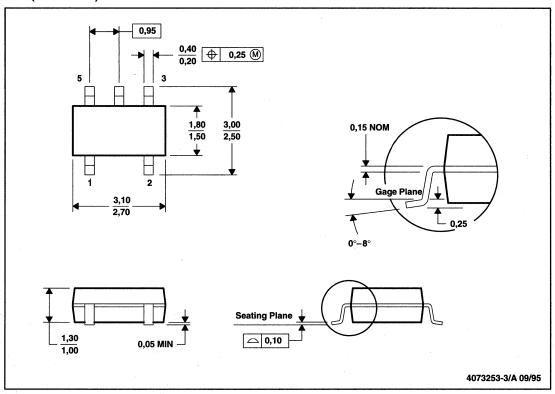
B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE

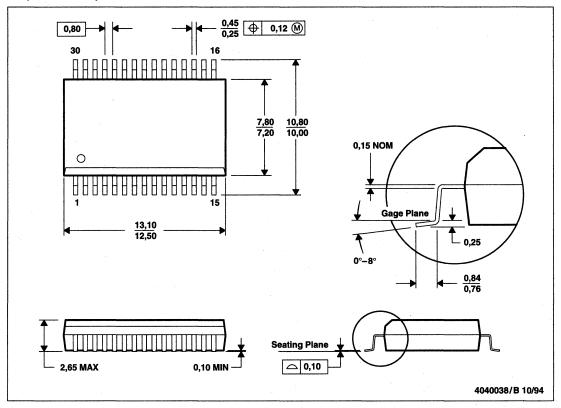


NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.C. Body dimensions include mold flash or protrusion.

DF (R-PDSO-G30)

PLASTIC SMALL-OUTLINE PACKAGE



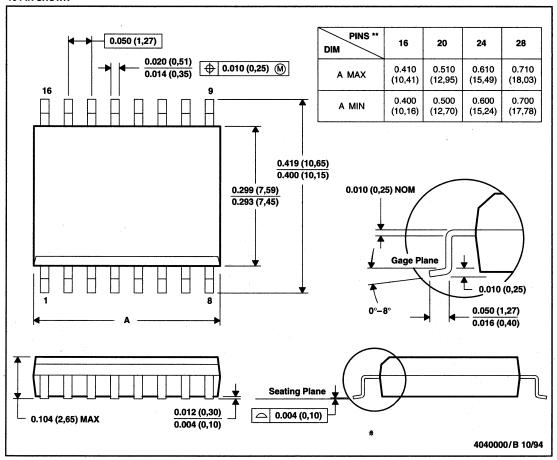
NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

DW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

16 PIN SHOWN



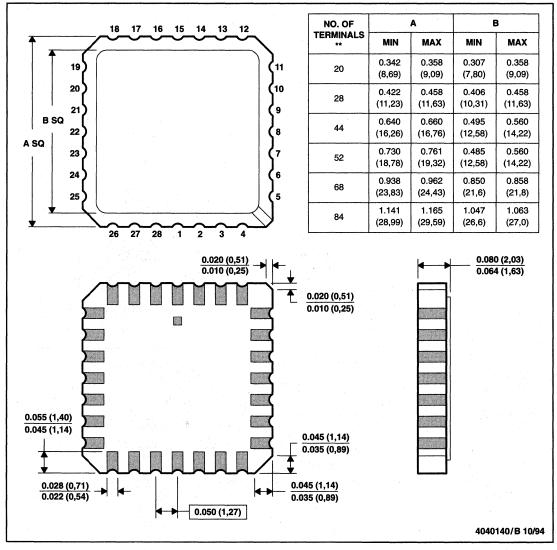
NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013

FK (S-CQCC-N**)

28 TERMINAL SHOWN

LEADLESS CERAMIC CHIP CARRIER



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. This package can be hermetically sealed with a metal lid.

D. The terminals are gold plated.

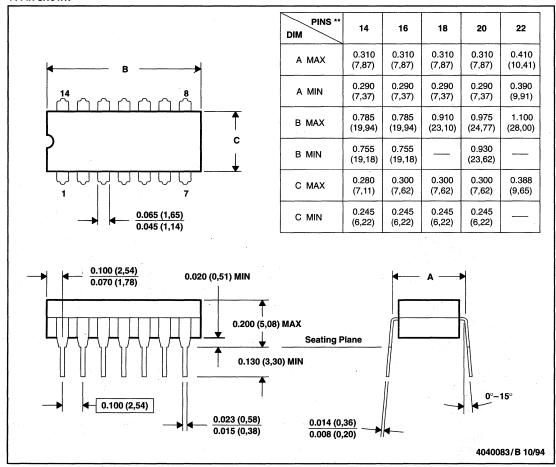
E. Falls within JEDEC MS-004



J (R-GDIP-T**)

14 PIN SHOWN

CERAMIC DUAL-IN-LINE PACKAGE

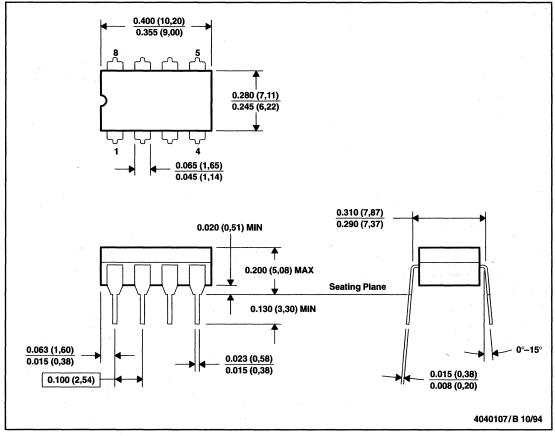


NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only
- E. Falls within MIL-STD-1835 GDIP1-T14, GDIP1-T16, GDIP1-T18, GDIP1-T20, and GDIP1-T22

JG (R-GDIP-T8)

CERAMIC DUAL-IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

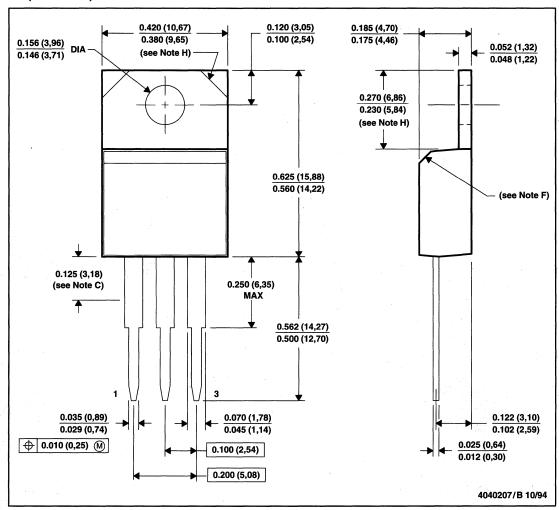
C. This package can be hermetically sealed with a ceramic lid using glass frit.

D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only

E. Falls within MIL-STD-1835 GDIP1-T8

KC (R-PSFM-T3)

PLASTIC FLANGE-MOUNT PACKAGE

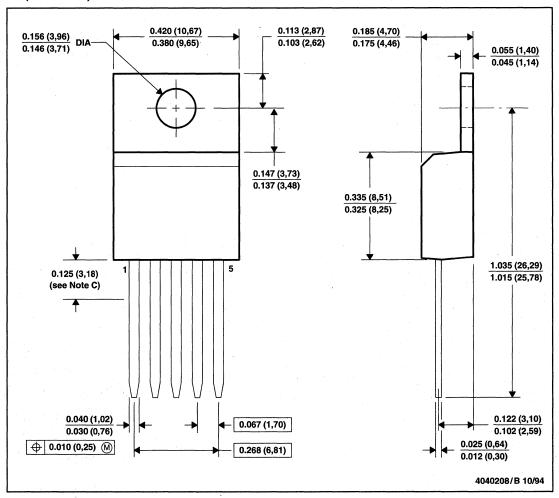


- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Lead dimensions are not controlled within this area.
 - D. All lead dimensions apply before solder dip.
 - E. The center lead is in electrical contact with the mounting tab.
 - F. The chamfer is optional.
 - G. Falls within JEDEC TO-220AB
 - H. Tab contour optional within these dimensions



KC (R-PSFM-T5)

PLASTIC FLANGE-MOUNT PACKAGE



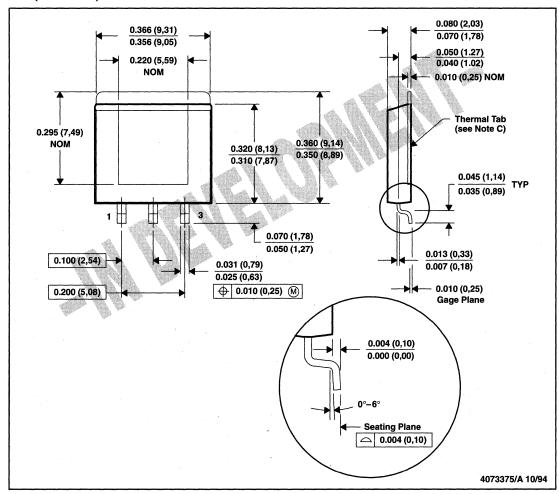
NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

- C. Lead dimensions are not controlled within this area.
- D. All lead dimensions apply before solder dip.
- E. The center lead is in electrical contact with the mounting tab.

KTE (R-PSFM-T3)

PLASTIC FLANGE-MOUNT PACKAGE



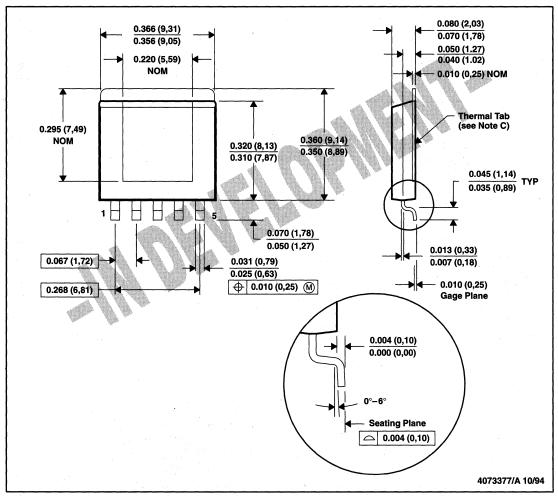
NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. The center lead is in electrical contact with the thermal tab.

KTG (R-PSFM-G5)

PLASTIC FLANGE-MOUNT PACKAGE



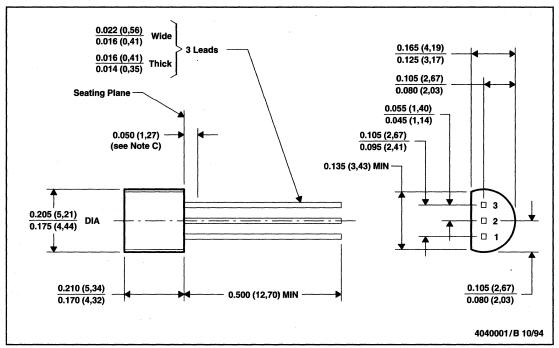
NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. The center lead is in electrical contact with the thermal tab.

LP (O-PBCY-W3)

PLASTIC CYLINDRICAL PACKAGE

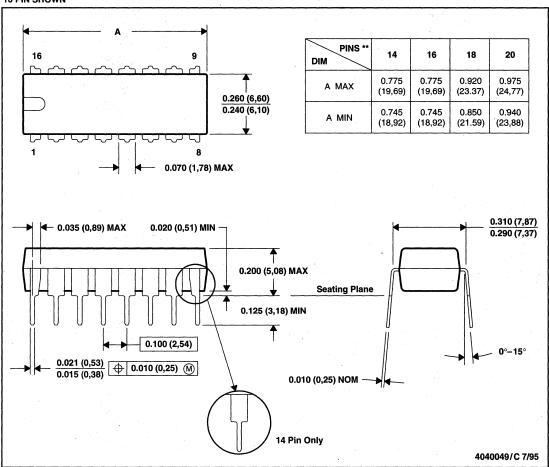


- NOTES: A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Lead dimensions are not controlled within this area.
 - D. Falls within JEDEC TO-226AA (TO-226AA replaces TO-92)

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PIN SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

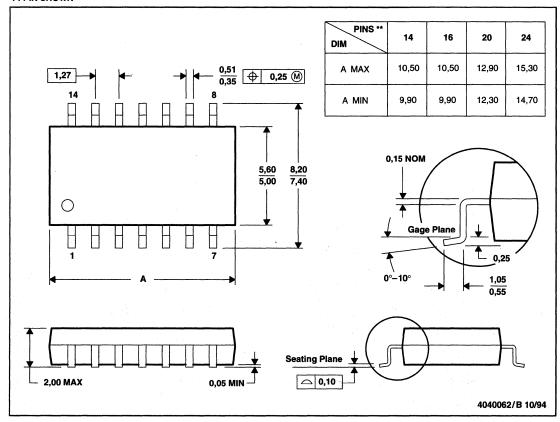
B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-001 (20-pin package is shorter than MS-001)

NS (R-PDSO-G**)

14 PIN SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



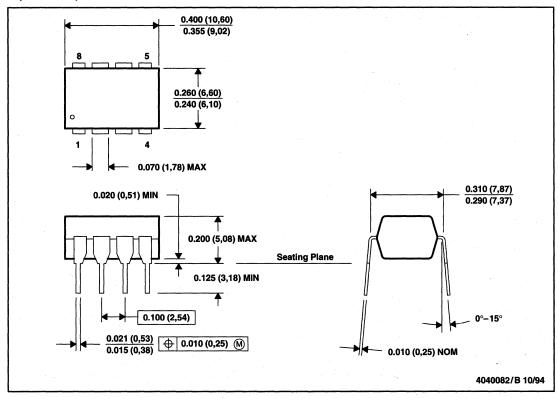
NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE

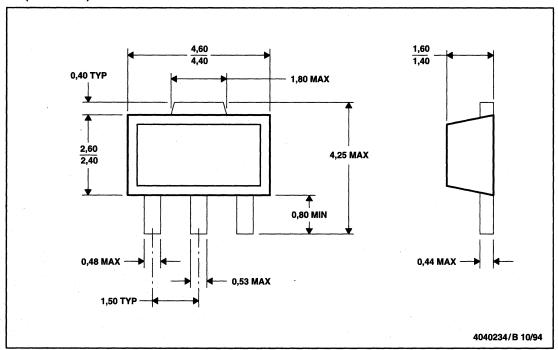


NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001

PK (R-PSSO-F3)

PLASTIC SINGLE-IN-LINE PACKAGE



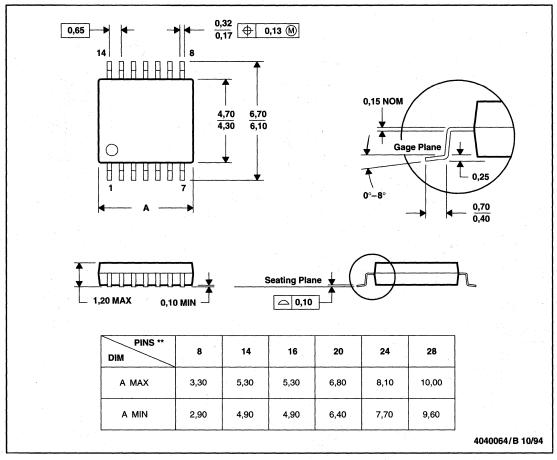
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. The center lead is in electrical contact with the tab.

PW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PIN SHOWN

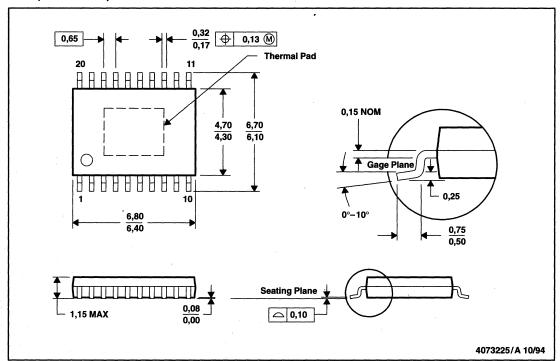


- NOTES: A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.



PWP (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE

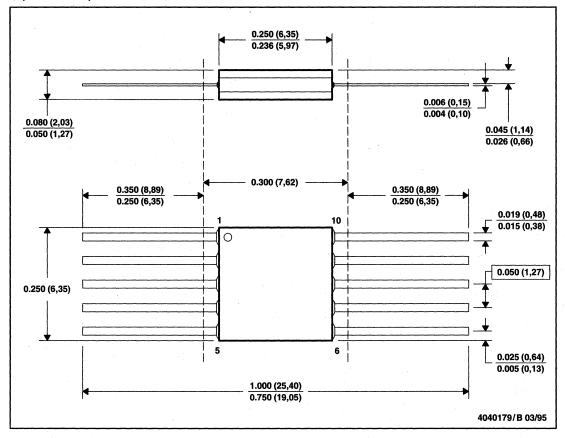


NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. The package thermal performance may be enhanced by bonding the thermal pad to an external thermal plane. The solderable pad is electrically and thermally connected to the backside of the die and leads 1, 2, 9, 10, 11, 12, 19 and 20.

U (S-GDFP-F10)

CERAMIC DUAL FLATPACK



- NOTES: A. All linear dimensions are in inches (millimeters).
 - This drawing is subject to change without notice.
 - C. This package can be hermetically sealed with a ceramic lid using glass frit.

 - D. Index point is provided on cap for terminal identification only.
 E. Falls within MIL STD 1835 GDFP1-F10 and JEDEC MO-092AA

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